



SAMSUNG

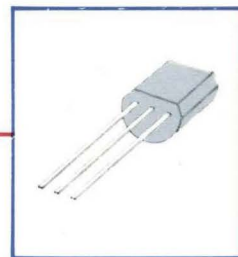
SAMSUNG

Data Book

**Transistor Data Book Vol.1
(Small Signal TR)**

Transistor

VOL.1, 1991



• Small Signal TR

1991

II-1

PRINTED IN KOREA

Circuit diagrams utilizing SAMSUNG products are included as a means of illustrating typical semiconductor applications; consequently, complete information sufficient for construction purposes is not necessarily given. The information has been carefully checked and is believed to be entirely reliable. However, no responsibility is assumed for inaccuracies. Furthermore, such information does not convey to the purchaser of the semiconductor devices described herein any license under the patent rights of SAMSUNG or others. SAMSUNG reserve the right to change device specifications.

SAMSUNG DATA BOOK LIST

- I. Semiconductor Product Guide
- II. Transistor Data Book
 - Vol. 1: Small Signal TR
 - Vol. 2: Bipolar Power TR
 - Vol. 3: TR Pellet
- III. Linear IC Data Book
 - Vol. 1: Audio/CDP/Toy
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 - Vol. 3: Telecom
 - Vol. 4: Industrial
 - Vol. 5: Data Converter IC
- IV. CMOS Consumer IC Data Book
- V. High Speed CMOS Logic Data Book
- VI. MOS Memory Data Book
 - Vol. 1: DRAM/DRAM Module/Video RAM
 - Vol. 2: SRAM/EEPROM/MASK ROM/FIFO
- VII. SFET Data Book
- VIII. MPR Data Book
- IX. LCD Dot Matrix Data Book

TRANSISTOR DATA BOOK

VOLUME 1

KSA Series
KSB Series
KSC Series
KSD Series
KSK Series
KSR Series
2N Series
BC Series
BF Series
MM Series
MPS Series
SS Series

VOLUME 2

KSA Series
KSB Series
KSC Series
KSD Series
BD Series
BU Series
MJD Series
MJE Series
TIP Series
D Series

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NOTES

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Quality and Reliability

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Product Guide

2

Data Sheets

3

Package Dimensions

4

**Samsung Sales Offices and
Manufacturer's Representatives**

5

QUALITY ASSURANCE and RELIABILITY PROGRAM

1. Introduction

Samsung utilizes rigorous qualification and reliability programs to monitor the integrity of its devices. All industry standard (and various non-standard) stresses are run. Testing is done not only to collect data, but also to detect trends and product anomalies, with rectification to take place immediately (if necessary). This protects the customer from receiving discrepant material. Careful attention is given to any manufacturing changes, both through Engineering Change Notices and appropriate reliability stressing.

Items such as particular tests, frequency, sample sizes, acceptance criteria, and methods of stressing are detailed later in this chapter.

2. Policy

Samsung is committed to supplying high-quality semiconductors to its consumers. All product released for general sales has been fully tested and qualified. By meeting or exceeding normal industry standards for reliability, Samsung can confidently supply products to the world that will meet customer applications and reliability standards. Of course special programs can be run for customers who have particular requirements which are considered non-standard.

The quality organization must approve any product before it is officially qualified and distributed. To do this most effectively, fully-functional devices must pass two critical stages prior to sales. Step 1 is product evaluation; step 2 is product qualification. Details are listed below.

3. Scope

Pass/Fail criteria are established by the quality assurance organization. All products have specifications which apply to them regarding reliability stressing, periodical monitoring, and final lot disposition.

The quality department is responsible for investigating mass-produced product for discrepancies, and enforcing corrective actions. All outgoing product goes through "QA-gating", where tests particularly critical to the product are accomplished. Only when quality assurance approves a device, either through qualification or gating acceptance, is it released. Fundamental "no-rework" policies ensure only highly reliable material leaves the factory. Testing is done to MIL-STD 883 and MIL-STD 750 standards, with sampling done in accordance with MIL-STD 19500E and MIL-STD 105D. Samsung also has internal specifications where its requirements exceed those of MIL-STDs.

4. Qualification Procedures

Procedures to qualify devices are listed below. There are both general and product-specific requirements. Procedures are detailed for new products, die-only qualifications, and package-only qualifications. The latter two are for products and/or packages already qualified, but where there is room for further product optimization.

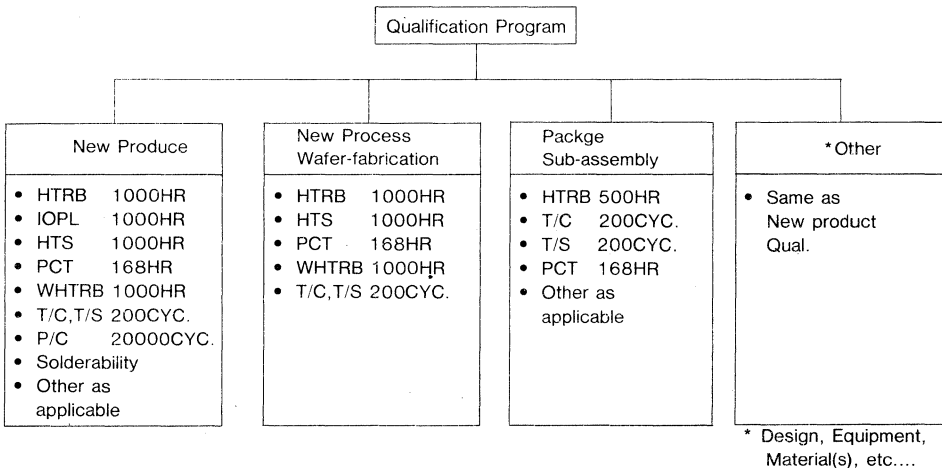


Fig. 1. Qualification Programs.

QUALITY ASSURANCE and RELIABILITY PROGRAM

4.1 New product qualification test items

No.	Test Item	Test Condition	Sample Size	LTPD	ACC. No	Reference Method	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\max)$ $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	10	1		48HR for PRT
2	High Temperature Storage (HTS)	$T_a = T_j(\max)$ 1000HRS	45	10	1		
3	Operating Life (OPL)	$T_a = 25^\circ\text{C}$ $P_c = P_c(\max)$ 1000HRS	45	10	1	MIL-STD-750 1026.3	For Small-Signal Device
4	Intermittent OPL (IOPL)	$T_a = 25^\circ\text{C}$ $P_c = P_c(\max)$ 2min/2min On/Off 1000HRS	45	10	1	MIL-STD-750 1036.3	
5	Power Cycle (P/C)	$\Delta T_j = 125^\circ\text{C}$ 45Sec/90Sec On/Off 20000CYC.	45	10	1		For PWR TR,
6	Pressure Cooker Test (PCT)	$T_a = 121^\circ\text{C} \pm 2^\circ\text{C}$ RH=100% 15PSIG 168HRS	45	10	1		48HR for PRT
7	Wet High Temperature Reverse Bias (WHTRB)	$T_a = 85^\circ\text{C}$, RH=85% $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	10	1		
8	Thermal Shock (T/S)	$-65^\circ\text{C} \leftrightarrow 150^\circ\text{C}$ (Liquid) 5min, <10Sec, 5min 200 Cycles	45	10	1	MIL-STD-883 1011	
9	Temperature Cycle (T/C)	$-65^\circ\text{C} \leftrightarrow 150^\circ\text{C}$ 10min, 10min 200 Cycles	45	10	1	MIL-STD-883 1011	
10	Solder Heat Resistance (S/H)	$T_a = 260^\circ\text{C} \pm 5^\circ\text{C}$ $t = 10 \pm 1\text{Sec}$ (once with flux)	10	N/A	0	MIL-STD-750 2031	
11	Solderability	$T_a = 260^\circ\text{C} \pm 5^\circ\text{C}$ $t = 5 \pm 0.5\text{ sec}$ Reject is >10% uncovered surface	10	N/A	0	MIL-STD-883 2003	
12	Salt Atmosphere	$T_a = 35^\circ\text{C}$, 5% NaCl 24HRS	10	N/A	0	MIL-STD-883 1009A	
13	Mechanical Shock	1500G, 05ms 3 Times Each direction of X,Y and Z Axis	10	N/A	0	MIL-STD-750 2016	For Hermetic
14	Vibration	20G, 3Axis $f = 100$ to 2000 cps for 4min, 4 cycles	10	N/A	0	MIL-STD-883 2007	For Hermetic
15	Constant Acceleration	2000G X,Y,Z Axis 1 min for each Axis	10	N/A	0	MIL-STD-883 2001	For Hermetic
16	ESD (Human Body Model)	R=1.5k Ω C=100pF 5 Discharge $V \geq \pm 1500\text{V}$	5	N/A	0	MIL-STD-883 3015	

Note: •SOT-23 PKG, TO-92S PKG, AI Wire Device: PCT 96HR

•N/A: Not available

QUALITY ASSURANCE and RELIABILITY PROGRAM

4.2 New process, wafer fabrication qualification

No	Test Item	Test Condition	Sample Size	LTPD	ACC No
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\text{max})$ $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	10	1
2	High Temperature Storage (HTS)	$T_a = T_j(\text{max})$ 1000HRS	45	10	1
3	Pressure Cooker Test (PCT)	$T_a = 121^\circ\text{C} \pm 2^\circ\text{C}$ RH=100% 15 PSIG 168HRS	45	10	1
4	Wet High Temperature Reverse Bias (WHTRB)	$T_a = 85^\circ\text{C}$, RH=85% $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	10	1
5	Thermal Shock (T/S)	$-65^\circ\text{C} \rightleftharpoons 150^\circ\text{C}(\text{Liquid})$ 5min, <10sec, 5min 200 cycles	45	10	1
6	Temperature Cycle (T/C)	$-65^\circ\text{C} \rightleftharpoons 150^\circ\text{C}$ 10min, 10min 200 Cycles	45	10	1

4.3 Package Sub-Assembly Qualification

No	Test Item	Test Condition	Sample Size	LTPD	ACC No	Notes
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\text{max})$ $V_{CB} = V_{CBO} \times 0.8$ 500HRS	45	10	1	
2	Temperature Cycle (T/C)	$-65^\circ\text{C} \rightleftharpoons 150^\circ\text{C}$ 10min, 10min 200 CYCLES	45	10	1	
3	Pressure Cooker Test (PCT)	$T_a = 121^\circ\text{C} \pm 2^\circ\text{C}$ RH=100%, 15PSIG 168HRS	45	10	1	
4	Thermal Shock (T/S)	$-65^\circ\text{C} \rightleftharpoons 150^\circ\text{C}(\text{Liquid})$ 5min, <10sec, 5min 200 CYCLES	45	10	1	
5	Solder Heat Resistance (S/H)	$260^\circ\text{C} \pm 5^\circ\text{C}$ 10 ± 1 sec Once without Flux	10	N/A	0	
6	Vibration (Variable-Frequency)	100~2000~100Hz 20G, 5min, 5Times, X,Y,Z	10	N/A	0	
7	Mechanical Shock (M/S)	1500G, 0.5ms 3 Times, X,Y,Z	10	N/A	0	
8	Constant Acceleration	20000G X,Y,Z Axis 1 min for each Axis	10	N/A	0	

Note) • N/A: not available

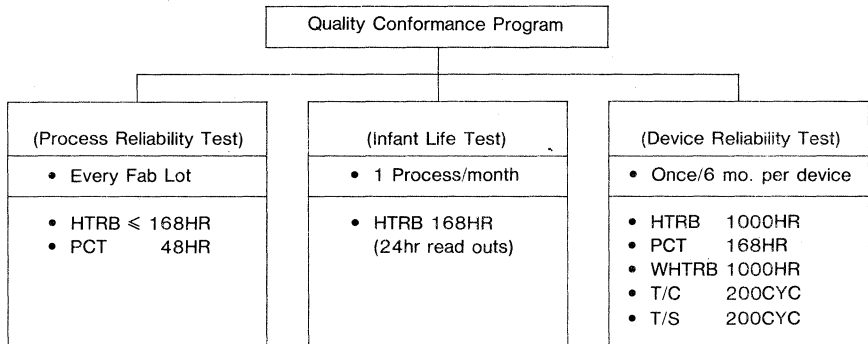
QUALITY ASSURANCE and RELIABILITY PROGRAM

5. Product Reliability (Quality Conformance) Monitors

Samsung implements periodic testing to monitor the ongoing reliability of its products. A subset of stresses used for qualification are run; they are seen as most critical for basic device reliability. Formally this is known as the Device Reliability Test System, or simply as DRT.

Lot-by-lot infant mortality reliability testing is also accomplished at Samsung. The purpose of this is to verify process integrity in a full QA step. Formally this is known as Process Reliability Testing, or more simply as PRT. Normally a short term accelerated lifestest and package reliability test are done, although exceptions are made in the case of special devices.

Although Samsung scrupulously utilizes statistical controls throughout its production process, DRT and PRT serve as confirmation that indeed the customer does receive only high-grade units. The tables on the following give details of DRT and PRT processing.



Note: Test descriptions given on following pages.

Fig. 2. Quality Conformance Program

(PRT/DRT Product Stress Methodologies)

1. PRT (Process Reliability Test)

Frequency: Every outgoing lot

No.	Test Item	Test Condition	Sample Size	LTPD	Accept. No.	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\text{max})$ $V_{CB} = V_{CBO} \times 0.8$ 168HR max	45	10	1	
2	Pressure Cooker Test (PCT)	$T_a = 121^\circ\text{C} \pm 2^\circ\text{C}$ 100% RH, 15PSIG 48HR	45	10	1	

2. ILT (Infant Life Test) Frequency: 1 Process/month

No.	Test Item	Test Condition	Sample Size	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\text{max})$ $V_{CB} = V_{CBO} \times 0.8$ 168HR	300	for Discrete

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3. DRT (Device Reliability Test)

No.	Test Item	Test Condition	Sample Size	LTPD*	Accept. No.	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\text{max})$ $V_{CB} = V_{CBO} \times 0.8$ 1000HRS	45	5 10	0 1	
2	Pressure Cooker Test (PCT)	$T_a = 121^\circ\text{C} \pm 2^\circ\text{C}$ RH=100%, 15PSIG 168HRS	45	5 10	0 1	
3	Wet High Temperature Reverse Bias (WHTRB)	$T_a = 85^\circ\text{C}$, RH=85% $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	5 10	0 1	
4	Temperature Cycle (T/C)	$-65^\circ\text{C} \approx 150^\circ\text{C}$ 10min, 10min 200 Cycles	45	5 10	0 1	
5	Thermal Shock (T/S)	$-65^\circ\text{C} \leftrightarrow 150^\circ\text{C}(\text{Liquid})$ 5min, <10sec, 5min 200 Cycles	45	5 10	0 1	

* LTPD 5: S Grade Units LTPD 10: A,B Grade Units.

6. Reliability Tests

The test run by the quality department are accelerated tests, serving to model "real world" applications through boosted temperatures, voltages, and/or humidities. Accelerated conditions are used to derive device knowledge through means quicker than that of typical application situations. These accelerated conditions are then used to assess differing failure rate mechanisms that correlate directly with ambient conditions. Following are summaries of various stresses (and their conditions) run by Samsung on discrete and integrated devices.

High Temperature Reverse Bias (80% max. V_{CBO} , 150°C , static)

For this test, device integrity is checked through stressing of the main blocking junction at an elevated temperature and voltage. Overall product stability is investigated through leakage current monitoring; low leakage indicates good integrity.

Intermittent Operating Life (P_{MAX} , 25°C , 2 min on/2 min off)

This test is normally applied to scrutinize die bond thermal fatigue. A stressed device undergoes an "on" cycle, where there is thermal heating due to power dissipation, and an "off" cycle, where there is thermal cooling due to lack of inputted power. Die attach (between die and package) and bond attach (between wire and die) are the critical areas of concern.

Wet High Temperature Reverse Bias (80% max. V_{CBO} , 85°C , 85% R.H., static) or ($V_{CB} = V_{CC}(\text{typ})$, 85°C , 85% R.H., static)

Wet High Temperature Reverse Bias Test is used to accelerate failure mechanisms by applying static bias on alternate pins at high temperature and humidity ambient ($85^\circ\text{C}/85\% \text{ R.H.}$). This test checks for resistance to moisture penetration by using an electrolytic principle to accelerate corrosive mechanisms.

Pressure Cooker Test (Unbiased, 121°C , 15 PSIG, 100% R.H.)

The Pressure Cooker Test checks for resistance to moisture penetration. A highly pressurized vessel is used to force water (thereby promoting corrosion) into packaged devices located within the vessel.

High Temperature Storage (Unbiased, 150°C)

High Temperature Storage is utilized to test for both package and die weaknesses. For example, sensitivities to ionic contamination and bond integrity are closely scrutinized.

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Temperature Cycling (Unbiased, -65°C to $+150^{\circ}\text{C}$, air)

This stress uses a chamber with alternating temperatures of -65°C and $+150^{\circ}\text{C}$ (air ambient) to thermally cycle devices within it. No bias is applied. The cycling checks for mechanical integrity of the packaged device, in particular bond wires and die attach, along with metal/polysilicon microcracks.

Thermal Shock (Unbiased, -65°C to $+150^{\circ}\text{C}$, liquid)

This stress uses a chamber with alternating temperatures of -65°C to $+150^{\circ}\text{C}$ (liquid ambient) to thermally cycle devices within it. No bias is applied. The cycling is very rapid, and primarily checks for die/package compatibility.

Resistance to Solder Heat (Unbiased, 260°C , 10 sec)

Solder Heat Resistance is performed to establish that devices can withstand the thermal effects of solder dip, soldering iron, or solder wave operations.

Mechanical Shock (Unbiased, 1500g, Pulse=0.5msec)

This test determines the suitability of a device to be used in equipment where mechanical "shocks" may occur. Such shocks result from sudden or abrupt changes produced by rough (non-standard) handling, transportation, or field operations.

Variable Frequency Vibration (Unbiased, Range=100 to 2000 Hz)

Variable Frequency Vibration is done to model the effects of differential vibration in the specified range. Die attach and bonding integrity are particularly stressed, testing the mechanical soundness of device packaging.

Constant Acceleration (Unbiased, 10kg to 20kg)

This is an accelerated test designed to indicate types or modes of structural and mechanical weaknesses not necessarily detectable in Mechanical Shock and Variable Frequency Vibration stressing.

7. Failure criteria

Parameter	Symbol	Unit	SCOPE	Min.	Max.
Collector Cut-off Current	I_{CBO}	μA	COMMON	—	USL \times 2
Emitter Cut-off Current	I_{CEO}	μA	COMMON	—	USL \times 2
H _{FE} Variation Ratio	H _{FE}	—	H _{FE} (min) $<$ 500	I.V. \times 0.8	I.V. \times 1.2
		—	H _{FE} (min) \geq 500	I.V. \times 0.7	I.V. \times 1.3
		—	H _{FE} (min) \geq 1000	I.V. \times 0.6	I.V. \times 1.4
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	mV	COMMON	LSL	USL
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	mV	COMMON	LSL	USL
Thermal, Resistance	ΔV_{BE}	mV	Power	LSL	USL
Noise	N_F, N_V	dB	Low Noise	—	USL \times 1.5

Note 1) USL: Upper Specification Limit 2) LSL: Lower Specification Limit 3) I.V.: Initial Value

8. Relative Stress Comparisons

Many stresses are run at Samsung on many different devices. Through both theoretical and actual results, it was clearly determined which stresses were most effective. Also established were the stresses which weren't fully effective.

Comparisons have been made on the basis of defects able to be determined, efficiency in detection, and cost. For the reader's benefit, Samsung provides the results of its conclusions on the following pages.

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Comparison of Reliability Test Methods

Test Method	Defect	Effectiveness	Cost	Remarks
Internal Visual Inspection	Lead Structure Metallization Oxide Film Foreign Particles Die Bond Wire Bond Contamination Corroded Substrate	Good	Slightly Inexpensive to Moderate	This method of screening must be performed for high reliability devices. Cost is affected by the degree of visual inspection
Infrared ray	Design(thermal)	Very Good	Expensive	For use in design evaluation only
Radiography	Die Bond Lead Structure(Gold) Foreign Particles Manufacturing (Gross Error) Seal Package Contamination	Extremely Good Good Good Good Good Good Good	Moderate	Advantage to using this screening method lies in the ability to test die frame/ header bonding, and to be able to perform inspection after sealing. However, some materials being transparent to X-rays (for example, Al and Si) are not able to be analyzed. The use of the complex test system results in cost six times that of visual inspection.
High Temperature Storage	Electrical stability Metallization Bulk Silicon Corrosion	Good	Very Inexpensive	This is a highly desirable screening method
Temperature Cycling	Package Seal Die Bond Wire Bond Cracked Substrate Thermal Mismatching	Good	Very Inexpensive	This screening method is one of the most effective for use
Thermal Shock	Package Seal Die Bond Wire Bond Cracked Substrate Thermal Mismatching	Good	Inexpensive	While this screening method is similar to temperature cycling, it enables high stress levels as well. It is probably equal to the temperature cycling method.
Constant Acceleration	Lead Structure Die Bond Wire Bond Cracked Substrate	Good	Moderate	Doubt exists as to the effectiveness of screening aluminum wires with stress levels in the range of 0~20,000 G
Shock (Without Monitoring)	Lead Structure	Fairly Poor	Moderate	Drop shock testing is thought to be inferior to constant acceleration methods. However, the pneumatic shock test is more effective. Shock test is a destructive test method.
Shock (With Monitoring)	Particles Intermittent Short Intermittent Open	Fairly Poor Fairly Good Fairly Good	Expensive	Visual inspection or radiography is more desirable for detection of particles

1

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Comparison of Reliability Test Methods (continued)

Test Method	Defect	Effectiveness	Cost	Remarks
Vibration Fatigue	Lead Structure Package Die Bond Wire Bond Cracked Substrate	Fairly Poor	Expensive	This test is destructive and without merit.
Variable Frequency Vibration (Without Monitoring)	Package Die Bond Wire Bond Substrate	Fairly Poor	Expensive	
Variable Frequency Vibration (Without Monitoring)	Foreign Particles Lead Structure Intermittent Open	Fairly Good Good Good	Very Expensive	The effectiveness of the method for detecting particles depends on the type of particle
Random Vibration (Without Monitoring)	Package Die Bond Wire Bond Substrate	Good	Expensive	This screening method is more effective than variable frequency vibration (without monitoring), when used with equipment intended for space vehicle operation, although it is more expensive.
Random Vibration (With Monitoring)	Foreign Particle Lead Structure Intermittent Open	Fairly Good Good Good	Very Expensive	This is one of the most expensive screening methods
Vibrational Noise	Foreign Particles	Good	Expensive	
Radioisotope Leak Test	Package Seal	Good	Moderate	This screening method is effective for detecting leakage in the range $10E6 \sim 10E12$ atm. ml/sec
Helium Leak Test	Package Seal	Good	Moderate	This screening method is effective for detecting leak in the range $10E6 \sim 10E12$ atm. ml/sec
Gross Leak Test	Package Seal	Good	Inexpensive	Effectiveness is dependent upon volume. Testing is possible for detecting leaks above $10E-3$ atm. ml/sec.
High Voltage Test	Oxide Film	Good	Inexpensive	Effectiveness Depends on structure
Insulation Resistance	Lead Structure Metallization Contamination	Fairly Good	Inexpensive	
Intermittent Operation	Metallization Bulk Silicon Oxide Film Inversion/Channeling Design Parameter Drift Contamination	Good	Expensive	Probably about the same as AC operating life

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Test Method	Defect	Effectiveness	Cost	Remarks
AC Operation	Metallization Bulk Silicon Oxide Film Inversion/Channeling Design Parameter Drift Contamination	Very Good	Expensive	
DC Operation	Basically the Same as Intermittent Operation	Good	Expensive	The AC operation life method is more effective for any failure mechanism
High Temperature AC Operation	Same as AC Operation Life Test	Extremely Good	Very Expensive	Failures are accelerated by temperature. This is probably the most expensive and one of the most effective screening methods.
High Temperature Reverse Bias	Inversion /Channeling	Fairly Poor	Expensive	

1

9. Reliability Test Results

Extensive test results have been compiled through long term reliability monitoring (DRT) of devices. Current and historical data is entered into Samsung's Reliability Network, SRN. Thus, past performance of a device or its family, assembly evaluation results, manufacturing change reliability results, etcetera, can all be seen via computer through SRN.

Results included in this manual are representative of products stressed, and contain data from the past year. Data is summarized from both die and package tests, on five critical stresses. Failure rates for long term life testing are in FITs, which are calculated using Arrhenius' Equation. (Arrhenius' Equation is summarized in the Appendix section). Samsung's failure rates are well below 50 FITs, which is acknowledged by customers and competitors alike as among the industry's elite.

9.1 Long Term Life Test Results (KSC945, KSD288)

Family	Test Item	Steady State Operation Life			High Temperature Storage Life		
	Test Condition	$T_a = T_j(\text{max.})$ $V_{CB} = V_{CBO} \times 0.8$ 1000 HRS			$T_a = 125^\circ\text{C}, 150^\circ\text{C}$ 1000 HRS		
	Device	Number of Samples	Number of Failures	Failure Rate (FIT)	Number of Samples	Number of Failures	Failure Rate (FIT)
TR	KSC945	870	0	1	765	0	1
	KSD288	540	0	1	360	0	1

Note 1) FIT: Failure in time or failure unit; represents the number of failures expected per 10^9 (one billion) device hours (at 55°C).

2) TR: Transistor

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9.2 Environmental Test Results

Family	Test Item	High Temp/High Humidity			Pressure Cooker			Thermal Shock		
	Test Condition	See 4.1			See 4.1			85°C, 85% R.H., $V_{CBO} \times 0.8$		
	Device	Number of Samples	Number of Failures	Failure Rate (%1 1KHRS)	Number of Samples	Number of Failure	Failure Rate (%1 168HRS)	Number of Samples	Number of Failures	Failure Rate (%1 200CYC)
TR	KSC945	514	0	0.0	615	0	0.0	507	0	0.0
	KSD288	225	0	0.0	405	0	0.0	576	1	0.17

10. Product Outgoing Quality Levels

The quality of Samsung products reaching customers has improved steadily over the years. Nearly on order of magnitude reduction in outgoing product PPM levels has been achieved from 1987-90. Results can be seen below.

Average Outgoing Quality, or AOQ, is measured by the Quality Assurance Department. Prior to release, product is sampled according to MIL-STD 105D. Both electrical and visual/mechanical inspections occur. If inspection standards are met, product is approved for sales. Depending on the nature of the failure(s), rejected samples can cause an entire lot to be 100% tested and/or inspected, re-worked to screen out defective devices, or scrapped.

Electrical testing is typically done to product specification limits, guardbanded by a fixed percentage. Visual/mechanical inspection is performed to check for key package, marking, and lead parameters. (More extensive details are provided in Chapter 3, Assembly process control)

Although Samsung's AOQ levels are acceptable, efforts are constantly underway to reduce the figures (thereby increasing outgoing quality).

Samsung Product Electrical AOQ Levels

(in PPM)

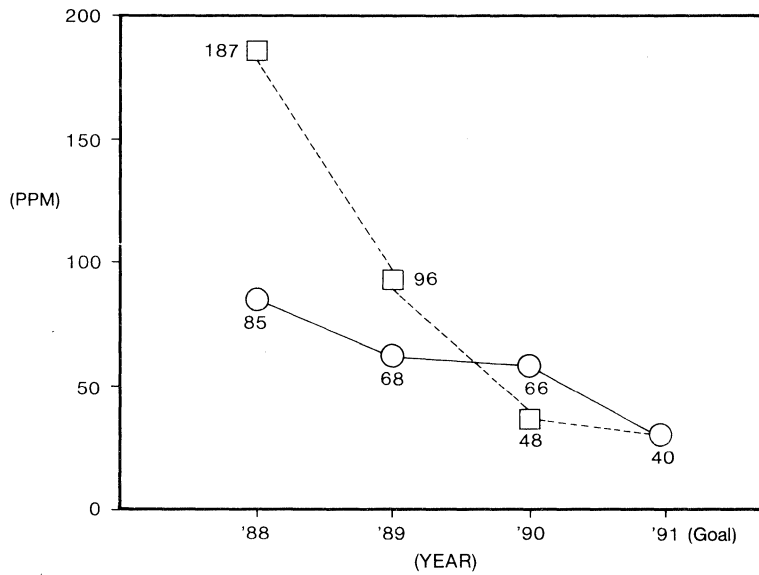
Product Family	1988	1989	1990	1991 (Goal)
Small-Signal Transistor	42	23	16	15
Power Transistor	103	39	23	15

Samsung Product Visual/Mechanical AOQ Levels

(in PPM)

Product Family	1988	1989	1990	1991 (Goal)
Small Signal Transistor	43	45	50	25
Power Transistor	84	57	25	25

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Note: Total=Electrical + Visual/Mechanical
S/S TR=Small Signal Transistor
PWR TR=Power Transistor

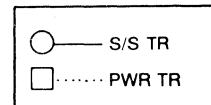
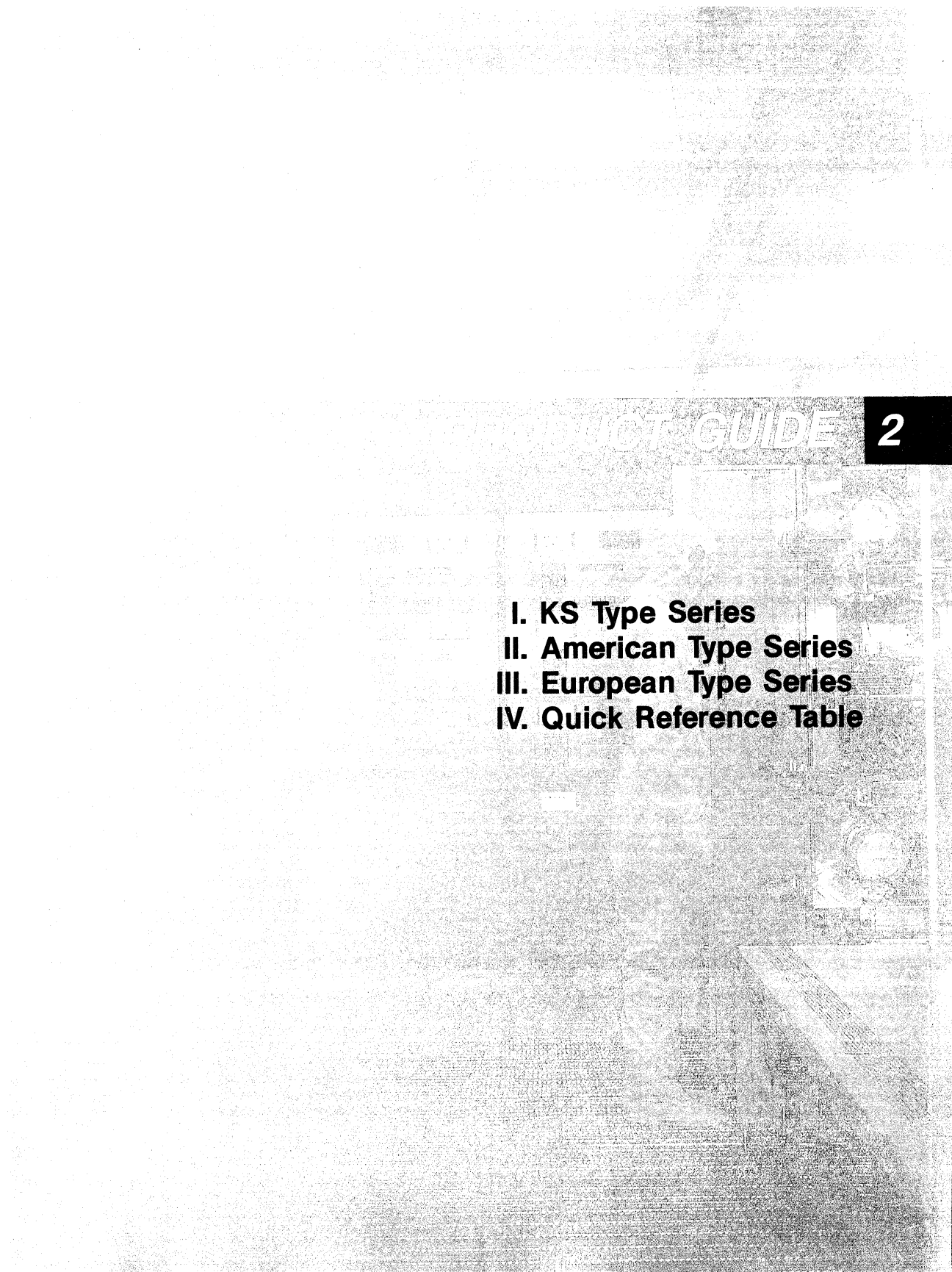


Fig. 3. Total AOQ Levels

NOTES

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- 
- I. KS Type Series**
 - II. American Type Series**
 - III. European Type Series**
 - IV. Quick Reference Table**

I. KS Type Series

- 1. Small Signal Transistors.**
- 2. Power Transistors.**

1. SMALL SIGNAL TRANSISTORS

1-1. General Purpose Transistors

1.1.1 SOT-23 Type Transistors

Device and Polarity (Marking)		V _{CEO} (V)	I _c (A)	Condition				h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	MAX		
KSC1623(C1X)	KSA812(D1X)	50	0.1	6	1	90	600	100	10	0.3	1	6	10	250			
KSC2859(E1X)	KSA1182(F1X)	30	0.5	1	100	70	240	100	10	0.25		6	20	200			
KSC3256(K1X)	KSA1298(J1X)	25	0.8	1	100	100	320	500	20	0.4		5	10	120			

1.1.2 TO-92S Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition				h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	TYP	MAX	TYP	MAX	V _{CE} (V)	I _c (mA)	MIN	TYP
KSD1021	KSA1378 KSB810 KSB811	30	1	1	100	70	400	1000	100		0.5		1.2	6	10	130	
		25	0.3	1	50	70	400	300	30	0.35	0.6		1.3				
		25	0.7	1	100	70	400	700	70	0.25	0.4	0.95	1.2	6	10	50	160
KSC3488 KSD1020	KSA1150	25	0.3	1	50	70	400	300	30	0.14	0.4						
		25	0.7	1	100	70	400	700	70	0.2	0.4	0.95	1.2	6	10	50	170
KSC2710		20	0.5	1	100	40	400	500	50	0.3	0.4	1	1.3	6	10		

1.1.3 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition				h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	MAX		
KSC2003	KSA954	80	0.3	1	50	90	400	300	30	0.6	1.2	6	10	50	100		
KSD1616A	KSB1116A	60	1	2	100	135	400	1000	50	0.3	1.2	2	100	70			
KSC1008	KSA708	60	0.7	2	50	40	240	500	50	0.7	1.1	10	50	50			
KSC2002	KSA953	60	0.3	1	50	90	400	300	30	0.6	1.2	6	10	50	100		
KSD1616	KSB1116	50	1	2	100	135	400	1000	50	0.3	1.2	2	100	70	100		
KSC815	KSA539	45	0.2	1	0.05	40	240	150	15	0.5	1.2						
KSD471A		30	1	1	100	70	400	1000	100	0.5	1.2	6	10	130			
KSC839		30	0.1	12	2	40	400	10	1	0.4		10	1	80	200		
	KSB564A	25	1	1	100	70	400	1000	100	0.5	1.2	6	10	110			
KSD227	KSA642	25	0.3	1	50	70	400	300	30	0.6							
KSC184	KSA542	25	0.05	6	1	40	400	20	2	0.3		6	1	100			
KSD261	KSA643	20	0.5	1	100	40	400	500	50	0.4	1.3						
KSD5041		20	5	2	500	180	600	3000	100	1.0		6	50	150			
KSC5019		10	2	1	500	140	600	2000	50	0.5		1	500	150			
SS9014	SS9015	45	0.1	5	1	60	1000	100	5	0.3	1.0	5	10	150	270		
SS9011		30	0.03	5	1	28	198	10	1	0.3		5	1	150	370		
SS8055	SS8550	25	1.5	1	100	85	300	800	80	0.5	1.2	10	50	100	190		
SS9013	SS9012	20	0.5	1	50	64	202	500	50	0.6	1.2						

1.1.4 TO-92L Type Transistor

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition				h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	MAX		
KSC2331	KSA931	60	0.7	2	50	40	240	500	50	0.7	1.2	10	50	100			
KSC2328A	KSA928A	30	2	2	500	100	320	1500	30	2.0		2	500	50	120		
KSC2500		10	2	1	500	140	600	2000	50	0.5		1	500	150			

2

1.2 Low Noise Transistors

1.2.1 TO-92S Type Transistor

Device and Polarity		NF(dB)		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition V _{CE(sat)}			Condition		f _T (MHz)	
NPN	PNP	MAX	Condition Frequency			(V)	(mA)	MIN	MAX	I _c (mA)	I _b (mA)	(V)	MAX	V _{CE} (V)	I _c (mA)	MIN
KSC2785	KSA1175	6	Audio	50	0.15	6	1	40	700	100	10	0.3	6	10		180
		4	Audio	50	0.15	6	1	40	700	100	10	0.3	6	10		300

1.2.2 TO-92 Type Transistors

Device and Polarity		NF(dB)		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition V _{CE(sat)}						
NPN	PNP	MAX	Condition Frequency			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _b (mA)	(V)	MAX	V _{CE} (V)	I _c (mA)	(V)
KSC945	KSA733	4	Audio	50	0.15	6	1	40	700	100	10	0.3				
KSC1222		**40	Audio	45	0.05	3	0.5	120	1000	20	2	0.3				
KSC900		**30	Audio	25	0.05	3	0.5	120	1000	20	2	0.2				

Audio=10Hz to 15.7KHz
 *=MAX, **=Noise Level

1.3. RF/VHF/UHF Amplifier Transistors

1.3.1 SOT-23 Type Transistors

Device (Marking) NPN	Condition		f _T (MHz)		V _{CEO} (V)	C _{be} (pF)	G _{be} (dB)	Condition		h _{FE}		NF(dB)		I _{agc} Condition	
	V _{CE} (V)	I _c (mA)	MIN	TYP				V _{CE} (V)	I _c (mA)	MIN	MAX	MAX	Condition f(MHz)	(mA)	Reduction (dB)
KSC2734(H8Z)	10	10	1400	3500	1.5	12		10	5	20	200				
KSC3120(H9Z)	10	2	1500	2400	#0.9	15	\$12	10	5	40	200	*8	800		
KSC2759(H6X)	10	5	1250	2000	1.3	14	\$10	10	5	40	180				
KSC3123(HAX)	10	5	900	1400	#0.5	20	\$20	10	5	60	240	5.5	200		
KSC2757(H3X)	10	5	800	1100	1.5	15		10	5	60	240				
KSC2758(H4Z)	10	3	750	1000	0.8	25	14	10	3	60	240	4.5	900	11	30
KSC2756(H2X)	10	5	500	850	#0.5	20	\$15	10	5	60	240	*6.5	200		
KSC2755(H1X)	10	3	400	600	#0.5	30	20	10	3	60	240	3	200		
KSC2223(H5X)	6	1	400	600	*1	20		6	1	40	180	*3	100		
KSC3125(A1Z)	10	10	250	600	1.6	25		10	10	20	200				
KSC2715(B1X)	10	1	100		3.2	30	27	12	2	40	240				

1.3.2 TO-92 Type Transistors

Device (Marking) NPN	Condition		f _T (MHz)		C _{ob} (pF)	V _{CEO} (V)	G _{pe} (dB)	Condition		h _{FE}		NF(dB)		I _{agc} Condition Gain	
	V _{CE} (V)	I _c (mA)	MIN	TYP				V _{CE} (V)	I _c (mA)	MIN	MAX	MAX	Condition f(MHz)	(mA)	Reduction (dB)
MPS5179	6	5	900	2000	@1	12	15	1	3	25	250	4.5	200		
MPSH17	10	5	800		@0.9	15	*24	10	5	25	250	6	200		
MPSH11	10	4	650		@0.7	25		10	4	60					
MPSH10	10	4	650		@0.7	25		10	4	60					
MPSH24	10	8	400	620	@0.36	30	\$19	10	8	30					
MPSH20	10	4	400	620	@0.65	30	\$18	10	4	25					

*=TYP, #=Cre, @=Ccb, \$=Gce.

1.4 High Voltage Transistors

1.4.1 SOT-23 Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Conition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	TYP
MMBTA42(1D)	MMBTA92(2D)	300	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MMBTA43(1E)	MMBTA93(2E)	200	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
	MMBT5401(2L)	150	0.5	5	10	60	240	50	5	0.5	1	10	10	100	
MMBT5550(1F)		140	0.6	5	10	60	250	50	5	0.25	1.2	10	10	100	

1.4.2 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Conition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	TYP
2N6517	2N6520	350	0.5	10	30	200	30	3	0.5	0.9	20	10	40		
2N6516	2N6519	300	0.5	10	30	45	270	30	3	0.5	0.9	20	10	40	
2N6515	2N6518	250	0.5	10	30	50	300	30	3	0.5	0.9	20	10	40	
2N5551		160	0.6	5	10	80	250	50	6	0.2	1.0	10	10	100	
	2N5401	150	0.6	5	10	60	240	50	5	0.5	1.0	10	10	100	
2N5550		140	0.6	5	10	60	250	50	5	0.25	1.2	10	10	100	
	2N5400	120	0.6	5	10	40	180	50	5	0.5	1.0	10	10	100	
MPSA44		400	0.3	10	10	50	200	10	1	0.5	0.75				
MPSA45		350	0.3	10	10	50	200	10	1	0.5	0.75				
MPSA42	MPSA92	300	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MPSA43	MPSA93	200	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MPSL01		120	0.05	6	1	200	800	10	1	0.3		6	1	50	100
	MPSL51	100	0.6	5	50	40	250	50	5	0.3	1.2	10	10	50	

1.4.3. TO-92L Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	TYP
KSC2330		300	0.1	10	20	40	240	10	1	0.5		30	10	50	
KSC2383	KSA1013	160	1	5	200	60	320	500	50	1.5		5	200	15	50
KSC2310	KSA910	150	0.05	5	10	40	240	10	1	0.8		30	10	100	
KSC2316	KSA916	120	0.8	5	100	80	240	500	50	1.0		5	100	120	

2

1.5. Digital Transistors

1.5.1 SOT-23 Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _C	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)
NPN	PNP	KΩ	KΩ	(V)	(mA)	V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	TYP	MAX	V _{CE} (V)	I _C (mA)	TYP
KSR1101	KSR2101	4.7	4.7	50	100	5	10	20		10	0.5	0.1	0.3	10	5	250/200
KSR1102	KSR2102	10	10	50	100	5	4	30		10	0.5	0.1	0.3	10	5	250/200
KSR1103	KSR2103	22	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1104	KSR2104	47	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1105	KSR2105	4.7	10	50	100	5	5	30		10	0.5	0.1	0.3	10	5	250/200
KSR1106	KSR2106	10	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1107	KSR2107	22	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1108	KSR2108	47	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1109	KSR2109	4.7		40	100	5	5	100	600	10	1	0.1	0.3	10	5	250/200
KSR1110	KSR2110	10		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1111	KSR2111	22		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1112	KSR2112	47		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1113	KSR2113	2.2	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1114	KSR2114	4.7	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200

1.5.2 TO-92S Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _C	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)
NPN	PNP	KΩ	KΩ	(V)	(mA)	V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	TYP	MAX	V _{CE} (V)	I _C (mA)	TYP
KSR1201	KSR2201	4.7	4.7	50	100	5	10	20		10	0.5	0.1	0.3	10	5	250/200
KSR1202	KSR2202	10	10	50	100	5	4	30		10	0.5	0.1	0.3	10	5	250/200
KSR1203	KSR2203	22	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1204	KSR2204	47	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1205	KSR2205	4.7	10	50	100	5	5	30		10	0.5	0.1	0.3	10	5	250/200
KSR1206	KSR2206	10	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1207	KSR2207	22	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1208	KSR2208	47	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1209	KSR2209	4.7		40	100	5	5	100	600	10	1	0.1	0.3	10	5	250/200
KSR1210	KSR2210	10		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1211	KSR2211	22		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1212	KSR2212	47		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1213	KSR2213	2.2	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1214	KSR2214	4.7	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200

1.5.3. TO-92 Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _C	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)
NPN	PNP	KΩ	KΩ	(V)	(mA)	V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	TYP	MAX	V _{CE} (V)	I _C (mA)	TYP
KSR1001	KSR2001	4.7	4.7	50	100	5	10	20		10	0.5	0.1	0.3	10	5	250/200
KSR1002	KSR2002	10	10	50	100	5	5	30		10	0.5	0.1	0.3	10	5	250/200
KSR1003	KSR2003	22	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1004	KSR2004	47	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1005	KSR2005	4.7	10	50	100	5	5	30		10	0.5	0.1	0.3	10	5	250/200
KSR1006	KSR2006	10	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1007	KSR2007	22	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1008	KSR2008	47	22	50	100	5	5	56		10	0.5	0.1	0.3	10	5	250/200
KSR1009	KSR2009	4.7		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1010	KSR2010	10		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1011	KSR2011	22		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1012	KSR2012	47		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1013	KSR2013	2.2	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200
KSR1014	KSR2014	4.7	47	50	100	5	5	68		10	0.5	0.1	0.3	10	5	250/200

1.6 JUNCTION FETS

1.6.1 SOT-23 Type J-FET

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{SS} (mA)			g _m (mS)			Condition			V _{GS(OFF)}	
				MIN	MAX	V _{DS} (V)	MIN	TYP	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX	
KSK123	20	2	200	0.13	0.47	4.5	0.9	1.6	4.5					
KSK211	18	10	200	1	10	10		9	10	10	10		0.4	4

1.6.2 TO-92S Types J-FET

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{SS} (mA)			g _m (mS)			Condition			V _{GS(OFF)}	
				MIN	MAX	V _{DS} (V)	MIN	TYP	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX	
KSK653	12	2	20	0.04	0.8	4.5	0.3	0.5	4.5					
KSK161	18	10	200	1	10	10		9	10	10	1		0.4	4
KSK596	20	10	100	0.1	0.8	5	0.4	1.2	5	5	1			1.5

1.6.3 TO-92 Type J-FET

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{SS} (mA)			g _m (mS)			Condition			V _{GS(OFF)}	
				MIN	MAX	V _{DS} (V)	MIN	TYP	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX	
KSK30	50	10	100	0.3	6.5	10	1.2		10	10	0.1		0.4	5
KSK117	50	10	300	0.6	14	10	4	15	10	10	0.1		0.2	1.5

1.6.4 SOT-143 Type MOS FET (Dual Gate)

DEVICE	V _{DS} (V)	I _D (mA)	P _D (mW)	I _{SS} (mA)			g _m (mS)		C _{IS} (pF)		C _{RS} (pF)		NF(dB)(200MHz)	
				MIN	MAX	V _{DS} (V)	MIN	TYP	TYP	MAX	TYP	MAX	TYP	MAX
*KSK5043	15	30	150	0	6	6	13	20	4.25	5.5	0.03	0.05	1.4	2.8
*KSD5044	15	30	150	0	6	6		17	2			0.03	3.2	

*: Under Development

2. POWER TRANSISTORS

2-1. General Purpose Transistors

2.1.1 TO-126 Type Transistors

I _C (A)	V _{CEO} (V)	Device Type		Condition				h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _C (W)
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _C (A)	MIN	TYP		
0.1	180	KSC2682	KSA1142	5	0.01	100	320	0.05	0.005	0.16	0.5	10	0.02		180	8	
	200	KSC3502		10	0.01	40	320	0.02	0.002		0.6	30	0.01		150	5	
	300	KSC3503	KSA1386	10	0.01	40	320	0.02	0.002		0.6	30	0.01		150	7	
0.2	300	KSC2688		10	0.01	40	250	0.05	0.005		1.5	30	0.01	50	80	10	
		1.2	120	KSC2690	KSA1220	5	0.3	60	320	1	0.2	0.4	0.7	5	0.2	155	20
	160	KSC2690A	KSA1220A	5	0.3	60	320	1	0.2	0.4	0.7	5	0.2	155	20		
3	30	KSD882	KSB772	2	1	60	400	2	0.2	0.3	0.5	5	0.1		80	10	
	45	KSD794	KSB744	5	0.5	60	320	1.5	0.15	0.5	2	5	0.1		45	10	
	60	KSD794A	KSB744A	5	0.5	60	320	1.5	0.15	0.5	2	5	0.1		45	10	
5	60	KSD1691	KSB1151	1	2	100	400	2	0.2	0.1	0.3					20	

2.1.2 D-PACK Type Transistors

I _c (A)	V _{CE0} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)			MIN	TYP
0.5	400	KSC5054		5	0.05	20	80	0.3	0.06		1				10		
2	50	KSC3076	KSA1241	2	0.5	70	240	1	0.05		0.5	2	0.5	100	10		
	400	KSC3233		5	0.1	20		1	0.2		1			20	20		
3	30	KSC3073	KSA1243	2	0.5	70	240	2	0.2		0.8	2	0.5	100	15		
	60	KSD1221	KSB906	5	0.5	60	300	3	0.3	0.4	1	5	0.5	3	20		
5	20		KSA1242	2	0.5	100	320	4	0.1		1	2	0.5	180	10		
	50	KSC3074	KSA1244	1	1	70	240	3	0.15		0.5	4	1	60	20		

2.1.3 TO-220 Type Transistors

I _c (A)	V _{CE0} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)			MIN	TYP
0.2	300	KSC1507		1	0.01	40	240	0.05	0.005		2	30	0.01	40	80	15	
1.5	150	KSC2073	KSA940	10	0.5	40	140	0.5	0.05		1.5	10	0.5	4	25		
2	150	KSD401	KSB546	10	0.4	40	240					10	0.4	5	25		
3	30	KSC1173	KSA473	5	0.5	70	240	2	0.2	0.3	0.8	2	0.5	100	10		
	55	KSD288	KSA614	5	0.5	40	240	1	0.1	0.15	0.5			25	25		
	60	KSD880	KSB834	5	0.5	60	220	3	0.3	0.5		5	0.5	9	30		
4	60	KSC2233		5	1	30	150	4	0.4		1	5	0.5	10	40		
	80	KSD526	KSB5960	5	0.5	40	240	3	0.3	1	1.7	5	0.5	3	30		
5	60	KSD73		10	2	70	240	5	0.5		2	10	0.3	20	30		
	70	KSD362		5	5	20	140	5	0.5		1	5	0.5	10	40		
	100	KSC2517		5	2	40	200	3	0.3		0.5			30	30		
6	120	KSD363		5	1	40	240	1	0.4		1	5	0.5	10	40		
7	60	KSD568	KSB707	1	3	40	200	5	0.5		0.5			40	40		
	80	KSD569	KSB708	1	3	40	200	5	0.5		0.5			40	40		
	100	KSC2334	KSA1010	5	3	40	200	5	0.5		0.6			40	40		

2.1.4 TO-220F Type Transistors

I _c (A)	V _{CE0} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)			MIN	TYP
1.5	150	KSC3296	KSA1304	10	0.5	40	140	0.5	0.05		1.5	10	0.5	4	20		
3	60	KSD1406	KSB1015	3	0.3	60	300	3	0.3		1	5	0.5	9	25		
	60	KSD2012	KSB1366	5	0.5	100	320	2	0.2		1	5	0.5	9	25		
4	80	KSD1408	KSB1017	5	0.5	40	240	3	0.3		1.5	5	0.5	9	25		
5	70	KSD1362	KSA1614	5	5	20	140	5	0.5		1	5	0.5	10	20		
7	60	KSD1588	KSB1097	1	3	40	200	5	0.5		0.5			20	20		

2.2 Darlington Transistors

IC (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}			Condition		V _{CE(sat)} (V)		P _C (W)	Package
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	TYP	MAX	I _C (A)	I _B (A)	MIN	MAX		
1.5	60	KSD985	KSB794	2	1	2K		30K	1	0.001		1.5	10	TO-126
	80	KSD986	KSD795	2	1	2K		30K	1	0.001		1.5	10	TO-126
3	40	KSD1222	KSB907	2	1	2K			2	0.004		1.5	15	D-PACK
	60	*KSC1983		4	0.5	500			2	0.05		1	30	TO-220
	60	*KSD1273		4	0.5	500		2.5K	2	0.05		1	40	TO-220F
	60	*KSD1943		4	0.5	400		2K	2	0.05		1.5	30	TO-220
	60	*KSD1944		4	0.5	400		2K	2	0.05		1.5	30	TO-220F
	100	KSD1692	KSB1149	2	1.5	2K		20K	1.5	0.015		1.2	15	TO-126
4	275	KSD5018							3	0.02		1.5	40	TO-220
5	100	KSD560	KSB601	2	3	2K	6K	15K	3	0.003		1.5	30	TO-220
	100	KSD1589	KSB1098	2	3	2K	6K	15K	3	0.003		1.5	30	TO-220F
15	50	*KSC5047		5	5	80			5	0.12		0.5	100	TO-3P

*: high β

2.3 Switching Transistors

V _{CEO} (V)	I _C (A)	(NPN)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Switching Time			P _C (W)	Package
			V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	t _{on} (us)	t _{stg} (us)	t _r (us)		
400	0.5	KSA1156	5	0.01	30	200	0.1	0.01		1	1	4	1	10	TO-126(PNP)
		KSC2752	5	0.05	30	80	0.3	0.06		1	1	2.5	1	10	TO-126
	2	KSC2333	5	0.1	20	80	0.5	0.1		1	1	2.5	1	15	TO-220
		KSC3569	5	0.1	20	80	0.5	0.1		1	1	2.5	1	15	TO-220F
	5	KSC2518	5	0.5	20	80	2	0.4		1	1	2.5	0.7	40	TD-220
	7	KSC2335	5	1	20	80	3	0.6		1	1	2.5	1	40	TO-220
		KSC3158	5	1	20	80	3	0.6		1	1	2.5	1	40	TO-220F
10	KSC2749	5	1	15	80	6	1.2		1	1	2.5	0.7	100	TO-3P	
15	KSC2751	5	2	15	80	10	2	0.3	1	1	2.5	0.7	120	TO-3P	
500	3	KSC5020	5	0.3	15	50	1.5	0.3		1	0.5	3	0.3	40	TO-220
		KSC5060	5	0.3	15	50	1.5	0.3		1	0.5	3	0.3	40	TO-220
	4	KSC5022	5	0.3	15	50	1.5	0.3		1	0.5	3	0.3	60	TO-3P
	5	KSC5021	5	0.6	15	50	3	0.6		1	0.5	3	0.3	50	TO-220
		KSC5061	5	0.6	15	50	3	0.6		1	0.5	3	0.3	50	TO-220
	7	KSC5023	5	0.6	15	50	3	0.6		1	0.5	3	0.3	80	TO-3P
	10	KSC5024	5	0.8	15	50	4	0.8		1	0.5	3	0.3	90	TO-3P
15	KSC5025	5	1.2	15	50	6	1.2		1	0.5	3	0.3	100	TO-3P	
800	1.5	KSC5026	5	0.1	10	40	0.75	0.15		2	0.5	3	0.3	40	TO-220
	3	KSC5027	5	0.2	10	40	1.5	0.3		2	0.5	3	0.3	50	TO-220
		KSC5028	5	0.2	10	40	1.5	0.3		2	0.5	3	0.3	80	TO-3P
	4.5	KSC5029	5	0.3	10	40	2	0.4		2	0.5	3	0.3	100	TO-3P
	6	KSC5030	5	0.4	10	40	3	0.6		2	0.5	3	0.3	100	TO-3P
	8	KSC5031	5	0.6	10	40	4	0.8		2	0.5	3	0.3	140	TO-3P
	12	KSC3552	5	0.8	10	40	6	1.2		2	0.5	3	0.3	150	TO-3P

2.4 Horizontal Deflection Output Transistors

2.4.1 TO-3P Type Transistors

V _{CBO} (V)	V _{CEO} (V)	I _c (A)	Device (NPN)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Switching Time			P _c (W)	COMMENT
				V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	t _{on} (us)	t _{stg} (us)	t _f (us)		
1500	800	2.5	KSD5000	5	0.5	8		2	0.6		8			0.4	80	Built in Damper Diode
		3.5	KSD5001	5	0.5	8		2.5	0.8		8			0.4	80	
		5	KSD5002	5	1	8		4	0.8		8			0.4	120	
		6	KSD5003	5	1	8		5	1		8			0.4	120	
		2.5	KSD5004	5	0.5	8		2	0.6		8			0.4	80	
		3.5	KSD5005	5	0.5	8		2.5	0.8		8			0.4	80	
		5	KSD5006	5	1	8		4	0.8		5			0.4	120	
6	KSD5007	5	1	8		5	1		5			0.4	120			

2.4.2 TO-3PF Type Transistors

V _{CBO} (V)	V _{CEO} (V)	I _c (A)	Device (NPN)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Switching Time			P _c (W)	COMMENT
				V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	t _{on} (us)	t _{stg} (us)	t _f (us)		
1500	800	2.5	KSD5010	5	0.5	8		2	0.6		8			0.4	50	Built in Damper Diode
		3.5	KSD5011	5	0.5	8		2.5	0.8		8			0.4	50	
		5	KSD5012	5	1	8		4	0.8		8			0.4	60	
		6	KSD5013	5	1	8		5	1		8			0.4	60	
		2.5	KSD5014	5	0.5	8		2	0.6		8			0.4	50	
		3.5	KSD5015	5	0.5	8		2.5	0.8		8			0.4	50	
		5	KSD5016	5	1	8		4	0.8		5			0.4	60	
6	KSD5017	5	1	8		5	1		5			0.4	60			

II. American Type Series

- 1. Small Signal Transistors**
- 2. Power Transistors**

1. SMALL SIGNAL TRANSISTORS

1-1. General Purpose Transistors

1.1.1 SOT-23 Type Transistors

Device and Polarity (Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE(sat)}	V _{BE(sat)} (V)	Condition		f _T (MHz)
NPN	PNP			V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)			MAX	MAX	
MMBTA06(1G)	MMBTA56(2G)	80	0.5	1	100	50		100	10	0.25		2	10	100
	MMBT2907A(2F)	60	0.6	10	150	100	300	500	50	1.6	2.6	20	50	200
MMBTA05(1H)	MMBTA55(2H)	60	0.5	1	100	50		100	10	0.25		2	10	100
	MMBA811C5(C5)	45	0.05	3	0.5	135	270	20	2	0.3		6	1	75
	MMBA811C6(C6)	45	0.05	3	0.5	200	400	20	2	0.3		6	1	75
	MMBA811C7(C7)	45	0.05	3	0.5	300	600	20	2	0.3		6	1	75
	MMBA811C8(C8)	45	0.05	3	0.5	450	900	20	2	0.3		6	1	75
MMBT2222A(1P)	MMBT2907(2B)	40	0.6	10	150	100	300	500	50	1.6	2.6	20	20	300
	MMBT4403(2T)	40	0.6	10	150	100	300	500	50	1.6	2.6	20	50	200
MMBT4401(2X)	MMBT4403(2T)	40	0.6	1	150	100	300	500	50	0.75	1.2	10	10	250
MMBT3903(1Y)		40	0.2	1	10	50	150	50	5	0.3	0.95	20	10	250
MMBT3904(1A)	MMBT3906(2A)	40	0.2	1	10	100	300	50	5	0.3	0.95	20	10	300
MMBC1623L3(L3)	MMBA812M3(M3)	40	0.1	6	1	60	120	30	3	0.5				
MMBC1623L4(L4)	MMBA812M4(M4)	40	0.1	6	1	90	180	30	3	0.5				
MMBC1623L5(L5)	MMBA812M5(M5)	40	0.1	6	1	135	270	30	3	0.5				
MMBC1623L6(L6)	MMBA812M6(M6)	40	0.1	6	1	200	400	30	3	0.5				
MMBC1623L7(L7)	MMBA812M7(M7)	40	0.1	6	1	300	600	30	3	0.5				
MMBTA20(1C)	MMBTA70(2C)	40	0.1	10	5	40	400	10	1	0.25		10	5	125
MMBC1622D6(D6)		35	0.1	3	0.5	200	400	100	10	0.3		6	1	100
MMBC1622D7(D7)		35	0.1	3	0.5	300	600	100	10	0.3		6	1	100
MMBC1622D8(D8)		35	0.1	3	0.5	450	900	100	10	0.3		6	1	100
MMBT2222(1B)		30	0.6	10	150	100	300	500	50	1.6	2.6	20	20	200
MMBT4123(5B)	MMBT4125(ZD)	30	0.2	1	2	50	150	50	5	0.3	0.95	20	10	250
MMBT4124(ZC)	MMBT4126(C3)	25	0.2	1	2	120	360	50	5	0.3	0.95	20	10	300
MMBC1009F1(F1)		25	0.05	3	0.5	30	60	10	1	0.3		6	1	150
MMBC1009F2(F2)		25	0.05	3	0.5	40	80	10	1	0.3		6	1	150
MMBC1009F3(F3)		25	0.05	3	0.5	60	120	10	1	0.3		6	1	150
MMBC1009F4(F4)		25	0.05	3	0.5	90	180	10	1	0.3		6	1	150
MMBC1009F5(F5)		25	0.05	3	0.5	135	270	10	1	0.3		6	1	150

1.1.2 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE(sat)}	V _{BE(sat)} (V)	Condition		f _T (MHz)
NPN	PNP			V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)			MAX	MAX	
2N4400	2N4402	40	0.6	1	150	50	150	500	50	0.75	1.2	10	20	200
2N4401	2N4403	40	0.6	1	150	100	300	500	50	0.75	1.2	10	20	200
2N3903	2N3905	40	0.2	1	10	50	150	50	5	0.3	0.95	20	10	250
2N3904	2N3906	40	0.2	1	10	100	300	50	5	0.3	0.95	20	10	300
MPS8099	MPS8599	80	0.5	5	1	100	300	100	10	0.3		5	10	150
MPSA06	MPSA56	80	0.5	1	100	50		100	10	0.25		2	10	100
MPS8098	MPS8598	60	0.5	5	1	100	300	100	10	0.3		5	10	150
MPSA05	MPSA55	60	0.5	5	100	50		100	10	0.25		2	10	100
MPS6602		40	1	1	500	50		1000	100	0.6		10	50	100
MPS2222A	MPS2907	40	0.6	10	150	100	300	500	50	1.6	2.6	20	20	300
MPS6513	MPS6517	40	0.1	10	2	90	180	50	5	0.5				
MPSA10		40	0.1	10	5	40	400					10	5	125
MPSA20	MPSA70	40	0.1	10	5	40	400					10	5	125
MPS2222		30	0.6	10	150	100	300	500	50	1.6	2.6	20	20	250
MPS3704		30	0.6	2	50	100	300	100	5	0.6		2	50	100
MPS3705	MPS3703	30	0.6	2	50	30	150	50	5	0.25		5	50	100
MPS6601	MPS6651	25	1	1	500	50		1000	100	0.6		10	50	100
	MPS3702	25	0.6	5	50	60	300	50	5	0.25		5	50	100
MPS6560	MPS6562	25	0.5	1	500	50	200	500	50	0.5		10	10	60
MPS5172		25	0.1	10	10	100	500	10	1	0.25		5	2	120

2

1.2 Low Noise Transistors

1.2.1 SOT-23 Type Transistors

Device and Polarity (Marking)		NF(dB)		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)
NPN	PNP	MAX	Condition Frequency			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	I _c (mA)
MMBT6428(1K)	MMBT5086(2P) MMBY5087(2Q)	4	Audio	50	0.2	5	0.1	250	650	100	5	0.6
MMBT6429(1L)		4	Audio	45	0.2	5	0.1	500	1250	100	5	0.6
MMBT2484(1U)		3	Audio	60	0.05	5	1	250		1	0.1	0.35
MMBT5088(1Q)		3	Audio	50	0.05	5	0.1	150	500	10	1	0.3
MMBT5089(1R)		3	Audio	30	0.05	5	0.1	300	900	10	1	0.5
		2	Audio	50	0.05	5	0.1	250	800	10	1	0.3
		2	Audio	25	0.05	5	0.1	400	1200	10	1	0.5

1.2.2 TO-92 Type Transistors

Device and Polarity		NF(dB)		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)
NPN	PNP	MAX	Condition Frequency			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	I _c (mA)
2N6428	2N4125 2N4124 2N5086 2N5087	6	Audio	50	0.2	5	0.1	250	650	100	5	0.6
2N4123		6	Audio	30	0.2	1	2	50	150	50	5	0.3
2N4124		5	Audio	30	0.2	1	2	50	150	50	5	0.4
		5	Audio	25	0.2	1	2	120	360	50	5	0.3
2N5088		4	Audio	25	0.2	1	2	120	360	50	5	0.4
		3	Audio	50	0.05	5	0.1	150	500	10	1	0.3
2N5089		3	Audio	30	0.05	5	0.1	300	900	10	1	0.5
		2	Audio	50	0.05	5	0.1	250	800	10	1	0.3
2N5209		2	Audio	25	0.05	5	0.1	400	1200	10	1	0.5
2N5210		*2	Audio	50	0.05	5	0.1	100	300	10	1	0.7
2N6428A		*4	Audio	50	0.2	5	0.1	200	600	10	1	0.7
				Audio	50	0.2	5	0.1	250	650	100	5
MPS4249	MPS4249	3	Audio	60		5	0.1	100	300	10	0.5	0.25
	MPS6520	3	Audio	25	0.1	10	2	200	400	50	5	0.5
MPS6521		3	Audio	25	0.1	10	2	200	400	50	5	0.5
	MPS6523	3	Audio	25	0.1	10	2	300	600	50	5	0.5
	MPS4250A	3	Audio	25	0.1	10	2	300	600	50	5	0.5
	MPS4250A	2	Audio	60		5	0.1	250	700	10	0.5	0.25
	MPS4250	2	Audio	40		5	0.1	250	700	10	0.5	0.25

Audio=10Hz to 15.7KHz, * =Max, ** =Noise Level

1.3. RF/VHF/UHF Amplifier Transistors

1.3.1 SOT-23 Type Transistors

Device (Marking)	Condition		f _T (MHz)		C _{ob} (pF)	V _{CEO} (V)	G _{pe} (dB)	Condition		h _{FE}		NF (dB)		I _{agc} Condition	
	V _{CE} (V)	I _c (mA)	MIN	TYP				MAX	V _{CE} (V)	I _c (mA)	MIN	MAX	MAX	Condition f(MHz)	Reduction (dB)
MMBR5179(7H)	6	5	900	2000	@1	12	15	1	3	25	250	4.5	200		
MMBTH10(3E)	10	4	650		@0.7	25		10	4	60					
MMBTH24(3A)	10	8	400	620	@0.36	30	\$19	10	8	30					

* =TYP, #Cre, @ =Ccb, \$ =Gce, & =Gcb

1.3.3 TO-92 Type Transistors

Device (Marking) NPN	Condition		f _T (MHz)		Cob (pF) MAX	V _{CEO} (V)	Gpe (dB) MIN	Condition		h _{FE}		NF (dB)		I _{agc} Condition Gain	
	V _{CE} (V)	I _C (mA)	MIN	TYP				V _{CE} (V)	I _C (mA)	MIN	MAX	MAX	Condition f(MHz)	MAX	Reduction (dB)
MPS5179	6	5	900	2000	@1	12	15	1	3	25	250	4.5	200		
MPSH17	10	5	800		@0.9	15	*24	10	5	25	250	6	200		
MPSH11	10	4	650		@0.7	25		10	4	60					
MPSH10	10	4	650		@0.7	25		10	4	60					
MPSH24	10	8	400	620	@0.36	30	\$19	10	8	30					
MPSH20	10	4	400	620	@0.65	30	\$18	10	4	25					

*=TYP, #=Cre, @=Ccb, \$=Gce.

1.4 High Voltage Transistors

1.4.1 SOT-23 Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Conition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
MMBTA42(1D)	MMBTA92(2D)	300	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MMBTA43(1E)	MMBTA93(2E)	200	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
	MMBT5401(2L)	150	0.5	5	10	60	240	50	5	0.5	1	10	10	100	
MMBT5550(1F)		140	0.6	5	10	60	250	50	5	0.25	1.2	10	10	100	

1.4.2 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Conition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
2N6517	2N6520	350	0.5	10	30	30	200	30	3	0.5	0.9	20	10	40	
2N6516	2N6519	300	0.5	10	30	45	270	30	3	0.5	0.9	20	10	40	
2N6515	2N6518	250	0.5	10	30	50	300	30	3	0.5	0.9	20	10	40	
2N5551		160	0.6	5	10	80	250	50	6	0.2	1.0	10	10	100	
2N5550	2N5401	150	0.6	5	10	60	240	50	5	0.5	1.0	10	10	100	
		140	0.6	5	10	60	250	50	5	0.25	1.2	10	10	100	
	2N5400	120	0.6	5	10	40	180	50	5	0.5	1.0	10	10	100	
MPSA44		400	0.3	10	10	50	200	10	1	0.5	0.75				
MPSA45		350	0.3	10	10	50	200	10	1	0.5	0.75				
MPSA42	MPSA92	300	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MPSA43	MPSA93	200	0.5	10	30	40		20	2	0.5	0.9	20	10	50	
MPSL01		120	0.05	6	1	200	800	10	1	0.3		6	1	50	
	MPSL51	100	0.6	5	50	40	250	50	5	0.3	1.2	10	10	50	

1.5 Darlington Transistors

1.5.1 SOT-23 Type Transistors

Device and Polarity		V _{CBO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Conition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
MMBT6427(1V)		40	0.5	5	100	20K	200K	500	0.5	1.5	2				
MMBTA13(1M)		30	0.3	5	100	10K		100	0.1	1.5		5	10	125	
MMBTA14(1N)		30	0.3	5	100	10K		100	0.1	1.5		5	10	125	
	MMBTA63(2U)	30	0.5	5	100	10K		100	0.1	1.5	5	10	125		
	MMBTA64(2V)	30	0.5	5	100	10K		100	0.1	1.5	5	10	125		

*: V_{CEO}

1.5.2 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX	MAX	V _{CE} (V)	I _c (mA)	MIN	TYP
MPSA27	MPSA77	60	0.5	5	100	10K		100	0.1	1.5					
MPSA26		60	0.5	5	100	10K		100	0.1	1.5					
2N6427	MPSA76	50	0.5	5	100	10K		100	0.1	1.5					
		40	0.5	5	100	10K	200K	500	0.5	1.5	2				
MPSA25	MPSA75	40	0.5	5	100	10K		100	0.1	1.5					
MPSA14	MPSA64	40	0.5	5	100	10K		100	0.1	1.5		5	10	125	
MPSA13	MPSA63	30	0.5	5	100	20K		100	0.1	1.5		5	10	125	
MPSA12	MPSA62	20	0.5	5	10	20K		10	0.01	1					

2. POWER TRANSISTORS

2.1.1 TO-126 Type Transistors

I _c (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)		
0.5	300	MJE340	MJE350	10	0.05	30	240								20
3	40	MJE180	MJE170	1	0.1	50	250	3	0.6		1.7	10	0.1	50	12.5
	60	MJE181	MJE171	1	0.1	50	250	3	0.6		1.7	10	0.1	50	12.5
	80	MJE182	MJE172	1	0.1	50	250	3	0.6		1.7	10	0.1	50	12.5
5	25	MJE200	MJE210	1	2	45	180	2	0.2		0.75	10	0.1	65	15

2.1.2 D-PACK Type Transistors

I _c (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)		
0.5	300	MJD340	MJD350	10	0.05	30	340								
1	40	MJD29	MJD30	4	1	15	75	1	0.125		0.8	10	0.2	3	15
	100	MJD29C	MJD30C	4	1	15	75	1	0.125		0.7	10	0.2	3	15
	250	MJD47		10	0.3	30	150	1	0.2		1	10	0.2	10	15
	400	MJD50		10	0.3	30	150	1	0.2		1	10	0.2	10	15
3	40	MJD31	MJD32	4	3	10	50	3	0.375		1.2	10	0.5	3	15
	100	MJD31C	MJD32C	4	3	10	50	3	0.375		1.2	10	0.5	3	15
5	25	MJD200	MJD210	1	2	45	180	2	0.2		0.75	10	0.1	65	12.5
6	100	MJD41C	MJD42C	4	3	15	75	6	0.6		1.5	10	0.5	3	20
8	80	MJD44H11	MJD45H11	1	2	60		8	0.4		1	10	0.5	50	20
10	60	MJD3055	MJD2955	4	4	20	100	4	0.4		1.1	10	0.5	2	20

2.1.3 TO-220 Type Transistors

I _c (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)	P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)		
1	40	TIP29	TIP30	4	1	15	75	1	0.125		0.7	10	0.2	3	30
	60	TIP29A	TIP30A	4	1	15	75	1	0.125		0.7	10	0.2	3	30
	80	TIP29B	TIP30B	4	1	15	75	1	0.125		0.7	10	0.2	3	30
	80	TIP29B	TIP30B	4	1	15	75	1	0.125		0.7	10	0.2	3	30
	100	TIP29C	TIP30C	4	1	15	75	1	0.125		0.7	10	0.2	3	30
	250	TIP47		10	0.3	30	150	1	0.2		0.1	10	0.2	10	40
	300	TIP48		10	0.3	30	150	1	0.2		0.1	10	0.2	10	40
	400	TIP50		10	0.3	30	150	1	0.2		0.1	10	0.2	10	40

2.1.3 TO-220 Type Transistors

Ic (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)		P _C (W)
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _C (A)	MIN	TYP	
3	40	TIP31	TIP32	4	3	10	50	3	0.375		1.2	10	0.5	3		40
	60	TIP31A	TIP32A	4	3	10	50	3	0.375		1.2	10	0.5	3		40
	80	TIP31B	TIP32B	4	3	10	50	3	0.375		1.2	10	0.5	3		40
	100	TIP31C	TIP32C	4	3	10	50	3	0.375		1.2	10	0.5	3		40
6	40	TIP41	TIP42	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	60	TIP41A	TIP42A	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	80	TIP41B	TIP42B	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	100	TIP41C	TIP42C	4	3	15	75	6	0.6		1.5	10	0.5	3		65
10	60	MJE3055T	MJE2955T	4	4	20	100	4	0.4		1.1	10	0.5	2		75
	80	D44H	D45H	1	2	60		8	0.4		1	10	0.5		40	50

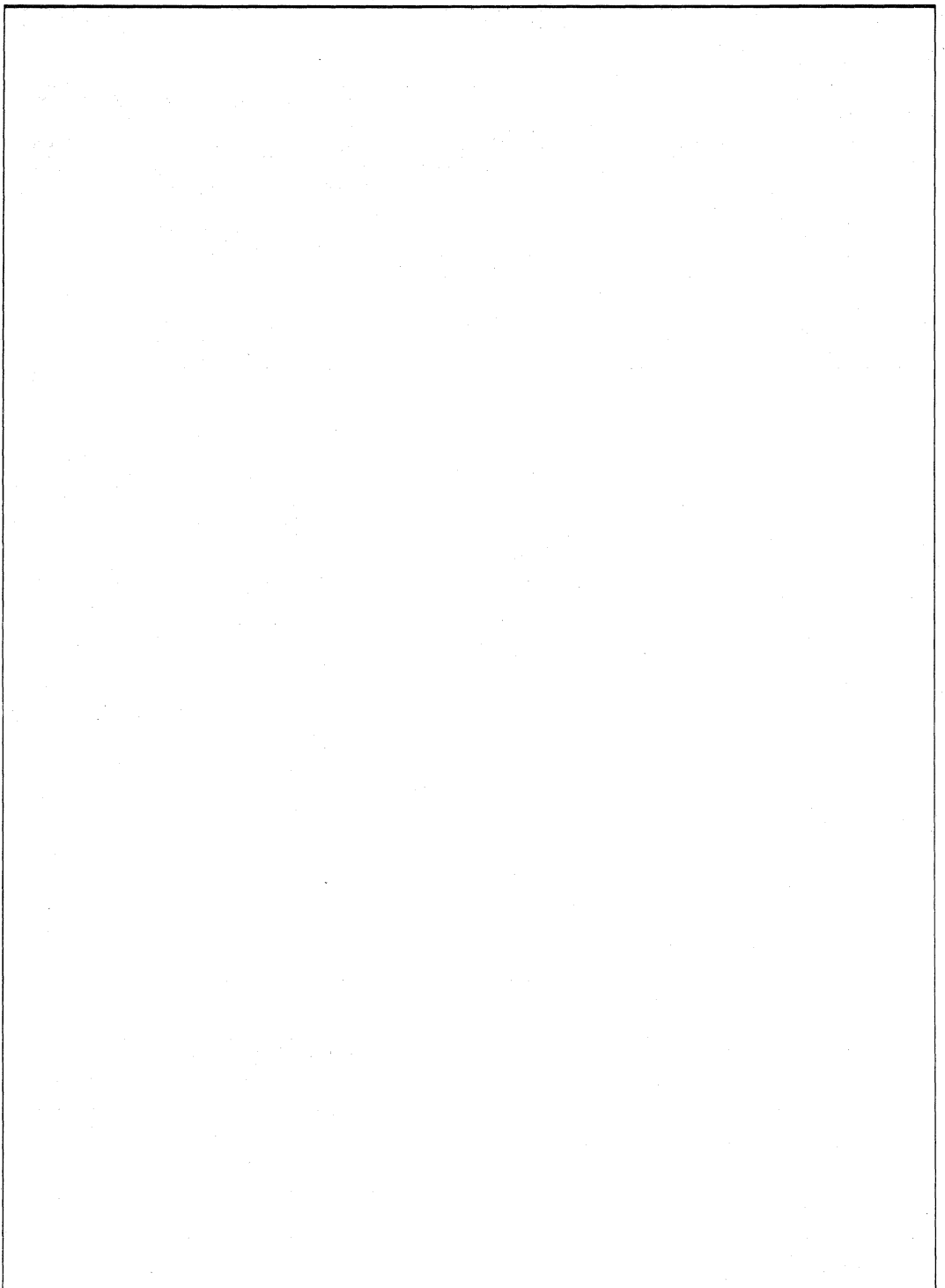
2.2 Darlington Transistors

IC (A)	V _{CEO} (V)	Device Type		Condition		h _{FE}			Condition		V _{CE(sat)} (V)		P _C (W)	Package
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	TYP	MAX	I _C (A)	I _B (A)	MIN	MAX		
2	60	TIP110	TIP115	4	2	500			2	0.008		2.5	50	TO-220
	80	TIP111	TIP116	4	2	500			2	0.008		2.5	50	TO-220
	100	TIP112	TIP117	4	2	500			2	0.008		2.5	50	TO-220
	100	MJD112	MJD117	3	2	1K		12K	2	0.008		2	20	D-PACK
4	60	MJE800	MJE700	3	1.5	750			1.5	0.03		2.5	40	TO-126
	60	MJE801	MJE701	3	2	750			2	0.04		2.8	40	TO-126
	80	MJE802	MJE702	3	1.5	750			1.5	0.03		2.5	40	TO-126
	80	MJE803	MJE703	3	2	750			2	0.04		2.8	40	TO-126
5	60	TIP120	TIP125	3	3	1K			3	0.012		2	65	TO-220
	80	TIP121	TIP126	3	3	1K			3	0.012		2	65	TO-220
	100	TIP122	TIP127	3	3	1K			3	0.012		2	65	TO-220
8	6	TIP100	TIP105	4	3	1K		20K	3	0.006		2	80	TO-220
	80	TIP101	TIP106	4	3	1K		20K	3	0.006		2	80	TO-220
	100	TIP102	TIP107	4	3	1K		20K	3	0.006		2	80	TO-220
	100	MJD122	MJD127	4	4	1K		12K	4	0.016		2	20	D-PACK
10	60	TIP140	TIP145	4	5	1K			5	0.01		2	125	TO-3P
	60	TIP140T	TIP145T	4	5	1K			5	0.01		2	80	TO-220
	60	TIP140F	TIP145F	4	5	1K			5	0.01		2	60	TO-3PF
	80	TIP141	TIP146	4	5	1K			5	0.01		2	125	TO-3P
	80	TIP141T	TIP146T	4	5	1K			5	0.01		2	80	TO-220
	80	TIP141F	TIP146F	4	5	1K			5	0.01		2	60	TO-3PF
	100	TIP142	TIP147	4	5	1K			5	0.01		2	125	TO-3P
	100	TIP142T	TIP147T	4	5	1K			5	0.01		2	80	TO-220
	100	TIP142F	TIP147F	4	5	1K			5	0.01		2	60	TO-3PF

2.3 Switching Transistors

V _{CEO} (V)	I _C (A)	Device Type (NPN)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Switching Time			P _C (W)	Package
			V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	t _{on} (us)	t _{stg} (us)	t _f (us)		
300	4	MJE13004	5	2	8	40	2	0.5		0.6	0.8	3	0.7	75	TO-220
	8	MJE13006	5	5	5	30	5	1		2	0.8	3	0.7	80	TO-220
	12	MJE13008	5	8	6	30	8	1.6		1.5	0.8	3	0.7	100	TO-220
400	4	MJE13005	5	1	10	60	1	0.2		0.5	0.8	3	0.7	75	TO-220
	8	MJE13007	5	2	8	60	2	0.4		1	0.8	3	0.7	80	TO-220
	12	MJE13009	5	5	8	40	5	1		1	0.8	3	0.7	100	TO-220

NOTES



III. European Type Series

- 1. Small Signal Transistors.**
- 2. Power Transistors.**

1. SMALL SIGNAL TRANSISTORS

1-1. General Purpose Transistors

1.1.1 SOT-23 Type Transistors

Device and Polarity (Marking)		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} MAX	V _{BE(sat)} (V) MAX	Condition		f _T (MHz)			
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)			V _{CE} (V)	I _c (mA)	MIN	MAX		
BCW71(K1) BCW72(K2) BCX70G(AG) BCX70H(AH) BCX70J(AJ) BCX70K(AK)	BCW70(H2)	45	0.1	5	2	215	500	10	0.5	0.3		5	10		300		
		45	0.1	5	2	110	220	50	2.5								
		45	0.1	5	2	100	450	50	2.5								
		45	0.1	5	2	120	220	50	1.25							0.55	1.05
		45	0.1	5	2	180	310	50	1.25							0.55	1.05
		45	0.1	5	2	250	460	50	1.25							0.55	1.05
	BCX71G(BG) BCX71H(BH) BCX71J(BJ) BCX71K(BK)		45	0.1	5	2	380	630	50	1.25	0.55	1.05	5	10	125		
			45	0.1	5	2	120	220	50	1.25	0.55	1.05					
			45	0.1	5	2	180	310	50	1.25	0.55	1.05					
			45	0.1	5	2	250	450	50	1.25	0.55	1.05					
			45	0.1	5	2	380	630	50	1.25	0.55	1.05					
			45	0.1	5	2	420	800	10	0.5	0.3						
BCW60A(AA) BCW60B(AB) BCW60C(AC) BCW60D(AD)	BCW61A(BA) BCW61B(BB) BCW61C(BC) BCW61D(BD)	32	0.1	5	2	120	220	50	1.25	0.55	1.05	5	10	125			
		32	0.1	5	2	180	310	50	1.25	0.55	1.05	5	10	125			
		32	0.1	5	2	250	460	60	1.25	0.55	1.05	5	10	125			
		32	0.1	5	2	380	630	50	1.25	0.55	1.05	5	10	125			
BCW29(C1) BCW30(C2) BCW31(D1) BCW32(D2) BCW33(D3)	BCW29(C1) BCW30(C2)	20	0.1	5	2	120	260	10	0.5	0.3							
		20	0.1	5	2	215	500	10	0.5	0.3							
		20	0.1	5	2	110	220	10	0.5	0.3							
		20	0.1	5	2	200	450	10	0.5	0.3							
20	0.1	5	2	420	800	10	0.5	0.3									

TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} MAX	V _{BE(sat)} (V) MAX	Condition		f _T (MHz)	
NPN	PNP			V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)			V _{CE} (V)	I _c (mA)	MIN	MAX
BC639	BC640	80	1	2	150	40	250	500	50	0.5	0.83	5	10		100
BC546	BC556	65	0.1	5	2	110	800	10	0.5	0.25		5	10		300
BC637	BC638	60	1	2	150	40	250	500	50	0.5		5	10		100
BC635	BC636	45	1	2	150	40	250	500	50	0.5		5	10		100
BC237	BC307	45	0.1	5	2	120	800	10	0.5	0.2		5	10	150	
BC337	BC327	45	0.1	5	2	100	630	500	50	0.7		5	10		100
BC547	BC557	45	0.1	5	2	110	800	10	0.5	0.25		5	10		300
BC550	BC560	45	0.1	5	2	110	800	10	0.5	0.25		5	10		300

2. POWER TRANSISTORS

2.1.1 TO-126 Type Transistors

I _c (A)	V _{CE0} (V)	Device Type		Condition				h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)		P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP			
																MIN	TYP	
0.5	250	BD157		10	0.05	30	240	0.025			2.5						20	
	300	BD158		10	0.05	30	240	0.25	0.025	2.5						20		
	350	BD159		10	0.05	30	240	0.25	0.025	2.5						20		
1.5	45	BD135	BD136	2	0.15	40	250	0.5	0.05		0.5						13	
	60	BD137	BD138	2	0.15	40	250	0.5	0.05		0.5						13	
	80	BD139	BD140	2	0.15	40	250	0.5	0.05		0.5						13	
2	45	BD375	BD376	2	0.15	40	375	1	0.1		1						25	
	45	BD233	BD234	2	1	25		1	0.1		0.6	10	0.25	3			25	
	60	BD377	BD378	2	0.15	40	375	1	0.1		1						25	
	60	BD235	BD236	2	1	25		1	0.1		0.6	10	0.25	3			25	
	80	BD379	BD380	2	0.15	40	375	1	0.1		1						25	
	80	BD237	BD238	2	1	25		1	0.1		0.6	10	0.25	3			25	
3	45	BD175	BD176	2	0.15	40		1	0.1		0.8	10	0.25	3			30	
	60	BD177	BD178	2	0.15	40		1	0.1		0.8	10	0.25	3			30	
	80	BD179	BD180	2	0.15	40		1	0.1		0.8	10	0.25	3			30	
4	22	BD433	BD434	1	0.5	85		2	0.2		0.5	1	0.25	3			36	
	32	BD435	BD436	1	0.5	85		2	0.2		0.5	1	0.2	3			36	
	45	BD437	BD438	1	0.5	85		2	0.2		0.6	1	0.25	3			36	
	60	BD439	BD440	1	0.5	40		2	0.2		0.8	1	0.25	3			36	
	80	BD441	BD442	1	0.5	40		2	0.2		0.8	1	0.25	3			36	

2.1.2 TO-220 Type Transistors

I _c (A)	V _{CE0} (V)	Device Type		Condition				h _{FE}		Condition		V _{CE(sat)} (V)		Condition		f _T (MHz)		P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP			
																MIN	TYP	
2	45	BD239	BD240	4	1	15		1	0.1		0.7	10	0.2	3			30	
	60	BD239A	BD240A	4	1	15		1	0.1		0.7	10	0.2	3			30	
	80	BD239B	BD240B	4	1	15		1	0.1		0.7	10	0.2	3			30	
	100	BD239C	BD240C	4	1	15		1	0.1		0.7	10	0.2	3			30	
3	45	BD241	BD242	4	3	10		3	0.6		1.2	10	0.5	3			40	
	60	BD241A	BD242A	4	3	10		3	0.6		1.2	10	0.5	3			40	
	80	BD241B	BD242B	4	3	10		3	0.6		1.2	10	0.5	3			40	
	100	BD241C	BD242C	4	3	10		3	0.6		1.2	10	0.5	3			40	
6	45	BD243	BD244	4	3	15		6	1		1.5	10	0.5	3			65	
	60	BD243A	BD244A	4	3	15		6	1		1.5	10	0.5	3			65	
	80	BD243B	BD244B	4	3	15		6	1		1.5	10	0.5	3			65	
	100	BD243C	BD244C	4	3	15		6	1		1.5	10	0.5	3			65	
7	150	BU407						5	0.5		1	10	0.5	10			60	
	150	BU407H						5	0.8		1	10	0.5	10			60	
	200	BU406						5	0.5		1	10	0.5	10			60	
	200	BU406H						5	0.8		1	10	0.5	10			60	
	200	BU408						6	1.2		1	10	0.5	10			60	
8	45	BD533	BD534	2	2	30	100	2	0.2		0.8	5	0.5	3			50	
	60	BD535	BD536	2	2	30	100	2	0.2		0.8	5	0.5	3			50	
	80	BD537	BD538	2	2	30	100	2	0.2		0.8	5	0.5	3			50	

2.2 Darlington Transistors

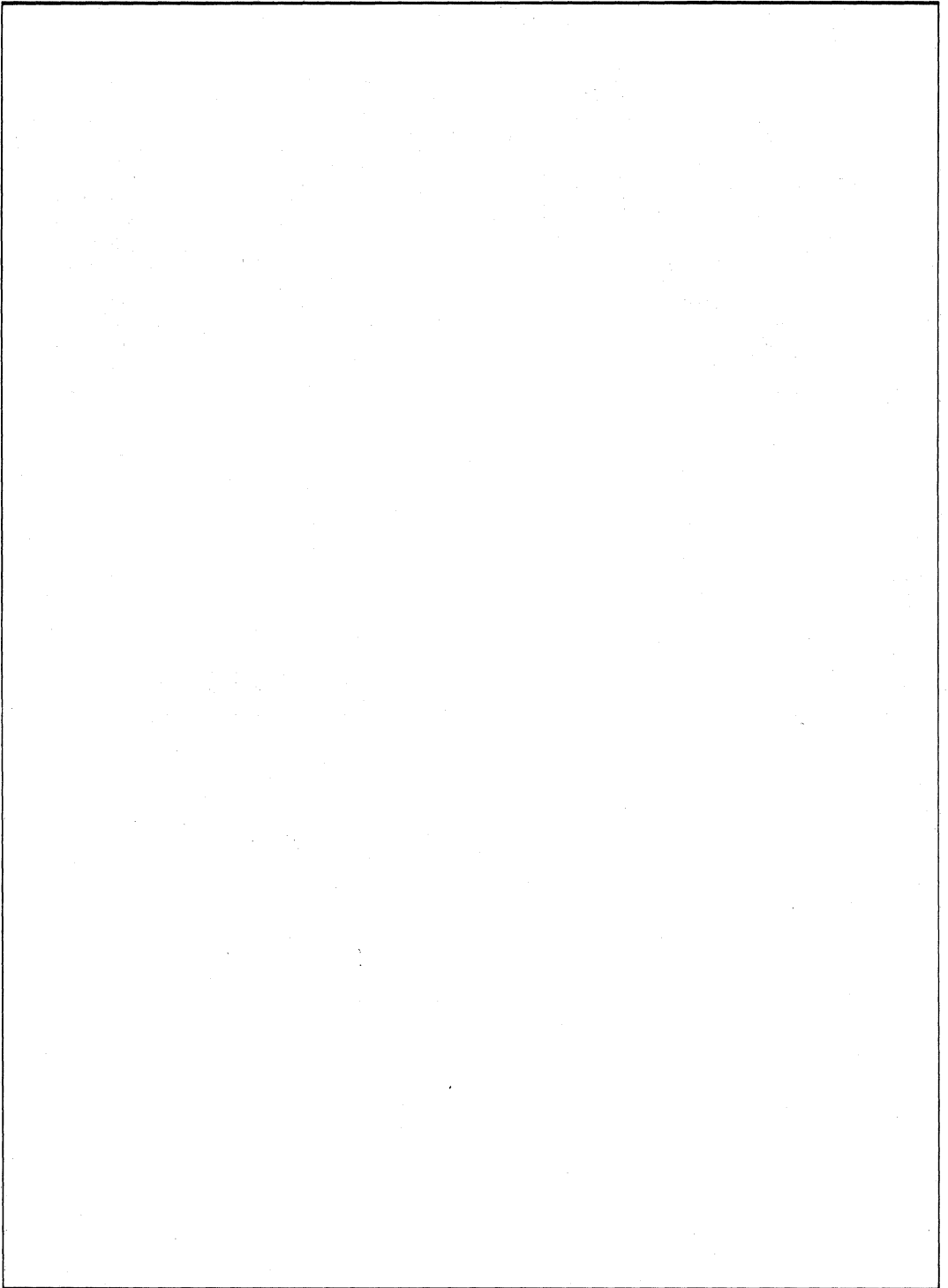
IC (A)	V _{CEO} (V)	Device Type		Condition			h _{FE}			Condition		V _{CE(sat)} (V)		P _C (W)	Package
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	TYP	MAX	I _C (A)	I _B (A)	MIN	MAX			
6	45	BDW23	BDW24	3	2	750		20K	2	0.008		2	50	TO-220	
	60	BDW23A	BDW24A	3	2	750		20K	2	0.008		2	50	TO-220	
	80	BDW23B	BDW24B	3	2	750		20K	2	0.008		2	50	TO-220	
	100	BDW23C	BDW24C	3	2	750		20K	2	0.008		2	50	TO-220	
8	45	BDX53	BDM54	3	3	750			3	0.012		2.5	60	TO-220	
	60	BDX53A	BDM54A	3	3	750			3	0.012		2.5	60	TO-220	
	80	BDX53B	BDM54B	3	3	750			3	0.012		2.5	60	TO-220	
	100	BDX53C	BDM54C	3	3	750			3	0.012		2.5	60	TO-220	
	150	BU807							5	0.05		1.5	60	TO-220	
	200	BU806							5	0.05		1.5	60	TO-220	
10	45	BDX33	BDX34	3	4	750			4	0.008		2.5	70	TO-220	
	60	BDX33A	BDX34A	3	4	750			4	0.008		2.5	70	TO-220	
	80	BDX33B	BDX34B	3	3	750			3	0.006		2.5	70	TO-220	
	100	BDX33C	BDX34C	3	3	750			3	0.006		2.5	70	TO-220	
12	45	BDX93	BDX94	3	5	754		20K	5	0.02		2	80	TO-220	
	60	BDX93A	BDX94A	3	5	754		20K	5	0.02		2	80	TO-220	
	60	BDV65	BDV64	4	5	1K			5	0.02		2	125	TO-3P	
	80	BDX93B	BDX94B	3	5	754		20K	5	0.02		2	80	TO-220	
	80	BDV65A	BDV64A	4	5	1K			5	0.02		2	125	TO-3P	
	100	BDX93C	BDX94C	3	5	754		20K	5	0.02		2	80	TO-220	
	100	BDV65B	BDV64B	4	5	1K			5	0.02		2	125	TO-3P	

2.3 Switching Transistors

V _{CEO} (V)	I _C (A)	(NPN)	Condition		h _{FE}		Condition		V _{CE(sat)} (V)		Switching Time			P _C (W)	Package
			V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	t _{on} (us)	t _{stg} (us)	t _f (us)		
375	5	*BU426	5	0.6		60	2.5	0.5		1.5	0.5	3.5	0.5	113	TO-3P
400	5	*BUT11	5	2	5		3	0.6		1.5	1	4	0.8	100	TO-220
	5	*BUW11	5	2	5		3	0.6		1.5	1	4	0.8	113	TO-3P
	6	*BU426A	5	0.6		60	2.5	0.5		1.5	0.5	3.5	0.5	113	TO-3P
	8	*BUW12	5	3	5		6	1.2		1.5	1	4	0.8	125	TO-3P
	9	*BUV47	5	5	5		9	3		3	0.8	2.5	0.8	120	TO-3P
	15	*BUV48	5	10	5		12	2.4		5	1	3	0.8	100	TO-3P
450	5	**BUT11A	5	2	5		2.5	0.5		1.5	1	4	0.8	100	TO-220
	5	**BUW11A	5	2	5		2.5	0.5		1.5	1	4	0.8	113	TO-3P
	8	**BUW12A	5	3	5		6	1.2		1.5	1	4	0.8	125	TO-3P
	9	**BUV47A	5	5	5		8	2.5		3	0.7	3	0.8	120	TO-3P
	15	**BUV48A	5	10	5		15	3		5	1	3	0.8	150	TO-3P
600	15	***BUV48B	5	10	5		10	4		5	1	3	0.7	150	TO-3P
700	15	***BUV48C	5	10	5		10	4		5	1	3	0.7	150	TO-3P

*: BV_{CES} 850V, **: BV_{CES} 1000V, ***: BV_{CES} 1200V

NOTES



IV. Quick Reference Table

3. QUICK REFERENCE TABLE (APPLICATION)

3.1 Audio Equipment

Application		Package	SOT-23	TO-92	TO-92L	TO-126	TO-220	TO-220F
FM	RM AMP		KSC2223	KSC1674				
	Mix, Conv		KSC2223	KSC1674				
	Local Osc		KSC2223	KSC1674, KSC1675				
	IF		KSC2715	KSC1674, KSC1675				
AM	RF		KSC1623	KSC945, KSC815				
	Conv Osc		KSC2715	KSC1675, KSC945				
	IF		KSC2715	KSC838 KSC1675, KSC945 KSC838				
Diff Amp	10W		KSA812, KSC1623	KSA733, KSC945				
	20W		KSA812, KSC1623	KSA733, KSC945				
	25W		KSA812, KSC1623	KSA733, KSC945				
	30W		KSA812, KSC1623	KSA733, KSC945				
	35W		KSA812, KSC1623	KSA733, KSC945				
	40W			KSA992, KSC1845				
	50W			KSA992, KSC1845				
	60W			KSA991, KSC1845				
	80W			KSA992, KSC1845				
	100W			KSA992, KSC1845				
	150W			KSA992, KSC1845				
Pre Driver	20W			KSA954, KSC2003				
	25W			KSA954, KSC2003				
	30W				KSA910, KSC2310			
	35W				KSA910, KSC2310			
	40W				KSA910, KSC2310			
	50W				KSA910, KSC2310			
	60W				KSA910, KSC2310			
	80W				KSA910, KSC2310			
	100W				KSA910, KSC2310			
	150W					KSA1112, KSC2668		
20W					KSA1142, KSC2682			
					KSA1142, KSC2682			
Driver	3W			KSA642, KSD227				
	5W			KSA642, KSD227				
	10W			KSA954, KSC2003				
	20W			KSA954, KSC2003				
	25W			KSA954, KSC2003				
	30W			KSA954, KSC2003				
	40W				KSA916, KSC2316			
	50W				KSA916, KSC2316			
	60W					KSA1220, KSC2690		
	80W					KSA1220, KSC2690		
					KSA1220A, KSC2690A			
Output	3W				KSA928A, KSC2328A			
	5W					KSB772, KSD882		
	20W					KSB744, KSD794		
							KSB834, KSD880	
							KSA614, KSD288	KSA1614
							KSB596, KSD526	KSB1015, KSD1406
	25W					TIP41C, TIP42C	KSB1017, KSD1408	
	30W					TIP41C, TIP42C		
	35W					TIP41C, TIP42C		

2

3.2 Video Equipment

Application		Package	Color TV	B/W TV	
Tuner	VHF	RF	SOT-23	KSC2755	KSC2755
			TO-92		KSC1393
		MIX	SOT-23	KSC2756, KSC3123	KSC2756, KSC3123
			TO-92	KSC1393, MPSH24	KSC1394, MPSH24
	UHF	SOT-23	KSC2757, KSC2759, KSC3120, MMBR5179	KSC2757, KSC2759, KSC3120, MMBR5179	
		TO-92	KSC1730, MPS5179, MPSH10	KSC1730, MPS5179, MPSH10	
	UHF	RF	SOT-23	KSC2758	KSC2758
		MIX	SOT-23	KSC2758	KSC2758
		SOT-23	KSC2757, KSC2759, KSC3120, MMBR5179	KSC2757, KSC2759, KSC3120, MMBR5179	
		TO-92	KSC1730, MPS5179, MPSH10	KSC1730, MPS5179, MPSH10	
Video Chroma	Output	TO-92	KSA643, KSA733	KSA733, KSC945	
		TO-92L	KSC2330, KSC2340	KSC2330, KSC2340	
		TO-126	KSC2688		
		TO-220		KSC1507	
Vertical Deflection	OSC	TO-92		KSA733, KSC945	
	Driver	TO-92		KSA642, KSA643, KSD227, KSD261	
		TO-92L	KSC2310, KSA910		
	Output	TO-92L		KSC2328A, KSA928A	
		TO-126	KSA1220A, KSC2690A	KSA1220A, KSC2690A, KSB772, KSD882	
		TO-220	KSB546, KSD401, KSA940, KSC2073	KSD880, KSD288, KSA614, KSB834	
		TO-220F	KSC3296, KSA1307	KSA1614, KSB1015, KSD1406	
Sound	Output	TO-92		KSD261, KSB564, KSB1116, KSA643, KSD471, KSD1616	
		TO-92L	KSC2383, KSA1013	KSC2328A, KSA928A	
		TO-126	KSA1220A, KSC2690A		
		TO-220	KSB546, KSD401, KSA940, KSC2073		
		TO-220F	KSA1304, KSC3296		
AGC		TO-92	KSC945, KSA733	KSC945, KSA733	
Sync Separator		TO-92	KSC945, KSA733	KSC945, KSA733	
Horizontal Deflection	OSC	TO-92	KSC945, KSA733	KSC945, KSA733	
	Driver	TO-92L	KSC2330, KSC2316, KSA916		
		Output	TO-220		KSD362, KSD73
		TO-220F		KSD1362	
		TO-3P	KSD5000, KSD5001, KSD5002, KSD5003, KSD5004, KSD5006, KSD5007		
		TO-3PF	KSD5010, KSD5011, KSD5012, KSD5013, KSD5014, KSD5015, KSD5016, BU508DF, BU508D		
Series Regulator	Error Amp	TO-92		KSA733, KSC945	
		TO-92L	KSC2310, KSA910		
	Driver	TO-92		KSA733, KSC945	
		TO-92L	KSC2310, KSA910		
	Output	TO-126		KSB772, KSD882	
		TO-220	KSD560	KSD288, KSD880, KSB834, KSA614	
	TO-220F	KSD1589	KSA1614, KSB1015, KSD1406		
Switching Regulator	Driver	TO-92	KSD471A, KSB564A, KSD261, KSA643	KSD471A, KSB564A, KSD261, KSA643	
	Output	TO-3P	KSD5006, KSD5007	KSD5006, KSD5007	

SOT-23 TYPE

I _c V _{CEO}	20mA	30mA	50mA	70mA	0.1A	0.2A	0.3A	0.5A	0.6A	0.8A	10mA
12V			MMBR5179	KSC2753							
14V			KSC2734 KSC2759								
15V			KSC3120 KSC2757								
20V	KSC2223	KSC2756	KSC3123		BCW29 33						(12mA) KSK123
25V	KSC2758		KSC3125 MMBT5089 MMBC1009F1-5		MMBTH10	MMBTA4124 MMBTA4126				KSA1298 KSC3265	
30V	KSC2755		KSC2715 MMBT5088		MMBTH24 MMBTA4125	MMBTA4123 MMBTA14	MMBTA13 KSC2859 MMBTA63 MMBTA64	KSA1182	MMBT2222		
32A					BCW60A-D BCW61A-D						
35V					MMBC1622D6-8						
40V					MMBA812M3-7 MMBC1623L3-7 MMBTA20 MMBTA70 KSR1109-12 KSR2109-12	MMBT3903 MMBT3904 MMBT3906		MMBT6427	MMBT2222A MMBT2907 MMBT4401 MMBT4403		
45V			MMBA811C5-8		BCW69-72 BCW70G-K BCW71G-K	MMBT6429					
50V			MMBT5086 MMBT5087		KSA812 KSC1623 KSR1101-8 KSR2101-8 KSR1113/4 KSR2113/4	MMBT6428					
60V			MMBT2484					MMBTA05 MMBTA55	MMBT2907A		
80V								MMBTA06 MMBTA56			
140V									MMBT5550		
150V								MMBT5401			
200V								MMBTA43 MMBTA93			
300V								MMBTA42 MMBTA92			

2

TO-92S, TO-92 & TO-92L TYPE (V_{CEO}: 12V-60V)

V _{CEO} I _c	12V	15V	20V	25V	30V	35V	40V	45V	50V	60V
10mA			KSK596							
20mA	KSK65 (2mA)	KSC1395	KSK161(10mA) KSK211(10mA) KSC1674 KSC2786	KSC1070	KSC1393 KSC1394				KSK117 (10mA) KSK30 (10mA)	
25mA			SS9016							
30mA			KSC1187		SS9011 KSC838 KSC2669					
50mA	MPS5179	KSC1730 SS9018		KSA542 KSC184 KSC2787 KSC388 KSC900 2N5089	2N5088 KSC1675			KSC1222	KSA640 2N5087 2N5209 2N5210	2N5086
0.1A		MPSH17		MPS5172 MPS6520 MPS6521 MPS6522 MPS6523 MPSH10 MPSH11	KSC839 KSC921 MPSH20 MPSH24		MPS6513 MPS6517 MPSA10 MPSA20 MPSA70 KSR1009-12 KSR2009-12 KSR1209-12 KSR2209-12	SS9014 SS9015	KSR1201-8 KSR1213/4 KSR2201-8 KSR2213/4 KSR1001-8 KSR2001-8 KSR1013/4 KSR2013/4	
0.15A							MPS4250		KSA1175 KSC2785 KSA733 KSC945	MPS4250A MPS4249
0.2A				2N4124 2N4126	2N4123 2N4125		2N3903 2N3904 2N3905 2N3906 MPS8097	KSA539 KSC815	2N6428 2N6428A	
0.3A				KSC3488 KSA1378 KSA642 KSD227						KSA953 KSC2002
0.5A			MPSA12 MPSA62 KSA643 KSD261 SS9012 SS9013 KSA1150 KSC2710	MPS6560 MPS6562	MPSA13 MPSA14 MPSA63 MPSA64		2N6427 MPSA25 MPSA75		MPSA26 MPSA76	MPS8098 MPS8598 MPSA05 MPSA55 MPSA27 MPSA77
0.6A			MPS3706	MPS3702	MPS2222 MPS3703 MPS3704 MPS3705		2N4400 2N4401 2N4402 2N4403 MPS2222A MPS2907			MPS2907A
0.7A				KSB810 KSB811						KSA708 KSC1008 KSA931 KSC2331

TO-92S, TO-92 & T-92L TYPE (Continued)

V _{CEO} I _c	12V	15V	20V	25V	30V	35V	40V	45V	50V	60V
0.8A										
1A				KSB564A KSB811 MPS6601 MPS6651	KSD1021 KSD471A		MPS6602		KSB1116 KSD1616	KSB116A KSD1616A
1.5A				SS8050 SS8550						
2A	(10V) KSC2500 KSD5019				KSA928A KSC2328A					
5A			KSD5041							

TO-92S, TO-92 & TO-92L Type (V_{CEO}: 80V-400V)

V _{CEO} I _c	80V	100V	120V	140V	150V	160V	200V	250V	300V	350V	400V
20mA											
25mA											
30mA											
50mA			KSA992 KSC1845 KSA1174 KSC2874		KSA910 KSC2310						
0.1mA									KSC1506 KSC2330		
0.15A			MPSL01								
0.2A											
0.3A	KSA954 KSC2003									MPSA45	MPSA44
0.5A	MPS8099 MPS8599 MPSA06 MPSA56						MPSA43 MPSA93	2N6515 2N6518	2N6519 MPSA92 2N6516 MPSA42	2N6517 2N6520	KSA1625
0.6A		MPSL51	2N5400	2N5550	2N5551						
0.7A				KSC1009	KSA709						
0.8A			KSA916 KSC2316								
1A						KSA1013 KSC2383					
1.5A											
2A											

2

D-PACK & TO-126 Type (V_{CEO}: 25V-400V)

V _{CEO} I _c	20V	25V	30V	40V	45V	50V	60V	80V	100V	120V	150V/160V	180V	220V	250V	300V	400V
0.1A												KSC2682 KSA1142	KSC3602		KSA1381 KSC3503	
0.15A																
0.2A															KSC2688	
0.3A																
0.5A														BD157	MJD340 MJD350 BD158 BD159 MJE340 MJE350	KSC2752 KSA1156 KSC5054
1A				MJD29 MJD30					MJD29C MJD30C							
1.2A										KSC2690 KSA1220	KSC2690A KSA1220A					
1.5A				BD135 BD136		BD138 KSB794 BD137	KSD986 KSB795 BD139 BD140									
2A				BD233 BD378	KSA1241 KSC3076	BD377 BD237 BD235 BD236	BD379 BD237 BD238 BD380	MJD112 MJD117		KSD1033 KSB768						KSC3233
3A			KSD882 KSB772 KSC3073 KSA1243	MJE170 MJE180 MJD31 MJD32	KSD794 KSB744 BD175 BD176	KSD794A KSB744A MJE171 MJE181 BD177 BD178 KSD1221 KSB906	MJE172 MJE182 BD179 BD180	KSD1692 KSB1149 MJD31C MJD32C								
4A		BD433 BD434	BD435 BD436		BD437 BD438 BD675 BD675A BD676 BD676A	MJE700 MJE701 BD677 BD677A BD678 BD678A MJE800 MJE801 BD439 BD440	MJE702 MJE703 BD679 BD679A BD680 BD680A MJE802 MJE803 BD441 BD442 KSD1222 KSB907	BD681 BD682	BD683 BD684							
5A	A1242	MJD200 MJD210				KSA1244 KSC3076	KSD1691 KSB1151		MJD122 MJD127							
6A									MJD41C MJD42C							
10A							MJD2955 MJD3055									

TO-220 TYPE

V _{CEO} I _c	30V	40V	45V	55V	60V	70V	80V	100V	120V	150V	200V	250V	300V	350V	400V	450V	500V	800V
0.2													KSC1507					
1		TIP29 TIP30			TIP29A TIP30A		TIP29B TIP30B	TIP29C TIP30C				TIP47	TIP48	TIP49	TIP50			
1.5										KSC2073 KSA940								KSC5026
2A			BD239 BD240		TIP110 TIP115 BD239A BD240A		TIP111 TIP116 BD239B BD240B	TIP112 TIP117 BD239C BD240C		KSD41 KSB546					KSC2333 BUX34			
3A	KSC1173 KSA473	TIP31 TIP32	BD241 BD242	KSD288 KSA614	TIP31A TIP32A KSD880 KSB834 KSC1983 BD241A BD242A KSC1943		TIP31B TIP32B BD241B BD242B	TIP31C TIP32C BD241C BD242C									KSC5020 KSC5060	KSC5027
4A					KSC2223		KSD526 KSB596						KSD5018 MJE 13004		MJE 13005			
5A					KSD73 TIP120 TIP125	KSD362	TIP121 TIP126	KSC2517 TIP122 TIP127 KSB601 KSD560							KSC2518 BUT11	BUT11A	KSC5021 KSC5061	
6		TIP41 TIP42	BDW23 BDW24 BD243 BD244		TIP41A TIP42A BDW23A BDW24A BD243A BD244A		TIP41B TIP42B BUW23B BUW24B BD243B BD244B	TIP41C TIP42C BD243C BD244C BDW23C BDW24C	KSD363						KSC2335			
7					KSD568 KSB707		KSD569 KSB708	KSC2334 KSA1010		BU407 BU407H	BU406 BU406H BU408							
8			BDX53 BDX54 BD533 BD534		TIP100 TIP105 BDX53A BDX54A BD535 BD536		TIP101 TIP106 BDX53B BDX54B BD537 BD538	TIP102 TIP107 BDX53C BDX54C		BU807	BU806		MJE 5740 MJE 13006	MJE 5741	MJE 5742 MJE 13007			
10			BDX33A BDX34A		MJE3055T MJE2955T TIP140T TIP145T BDX33A BDX34A		TIP141T TIP146T BDX33B BDX34B D44H D45H	TIP142T TIP147T BDX33C BDX34C										
12			BDW93 BDW94		BDW93A BDW94A		BDW93B BDW94B	BDW93C BDW94C						MJE 13008	MJE 13009			

TO-220F TYPE

V _{CEO} I _c	40V	50V	55V	60V	70V	80V	100V	150V	400V
1.5								C3296 A1304	
2									C3569
3	D1413 B1023		A1614	D1406,D2012 B1015,B1366 D1273, D1944					
4						D1408 B1017			
5					D1362		D1589 B1098		
7		D1417,B1022		D1588 B1097					C3158

TO-3P & TO-3PF TYPE

I _c V _{CEO}	2.5A	3A	3.5A	4A	4.5A	5A	6A	7A	8A	9A	10A	12A	15A
50													KSC5047
375							BU426						
400						BUW11	BU426A		BUW12	BUV47	KSC2749		KSC2751 BUV48
450						BUT11A BUW11A			BUW12A	BUV47A			BUV48A
500				KSC5022				KSC5023			KSC5024		KSC5025
600													BUV48B
700						BU508A BU508D BU508AF BU508DF							BUW48C
80	KSD5000 KSD5004 KSD5010 KSD5014	KSC5028	KSD5000 KSD5005 KSD5011 KSD5012		KSC5029	KSD5002 KSD5006 KSD5012 KSD5016	KSC5030 KSD5003 KSD5007 KSD5013 KSD5017		KSC5031			KSC3552	



DATA SHEETS 3

1. KSA Series
2. KSB Series
3. KSC Series
4. KSD Series
5. KSK Series
6. KSR Series
7. 2N Series
8. BC Series
9. BF Series
10. MM Series
11. MPS Series
12. SS Series

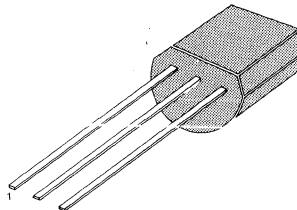
LOW FREQUENCY AMPLIFIER

- Complement to KSC815
- Collector-Base Voltage $V_{CBO} = -60V$
- Collector Dissipation $P_C = 400mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 60	V
Collector-Emitter Voltage	V_{CEO}	- 45	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 200	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

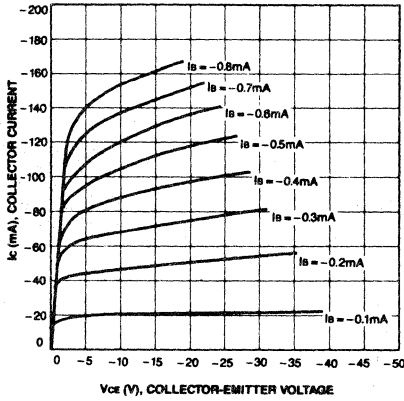
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -45V, I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -50mA$	40		240	
Base-Emitter On Voltage	$V_{BE} (on)$	$V_{CE} = -1V, I_C = -10mA$	- 0.60	- 0.65	- 0.90	V
Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = -150mA, I_B = -15mA$		- 0.25	- 0.5	V
Base-Emitter Saturation Voltage	$V_{BE} (sat)$	$I_C = -150mA, I_B = -15mA$		- 0.9	- 1.2	V

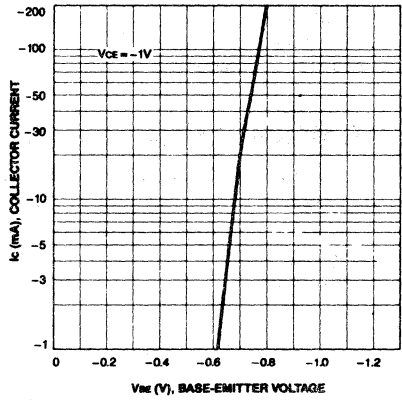
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

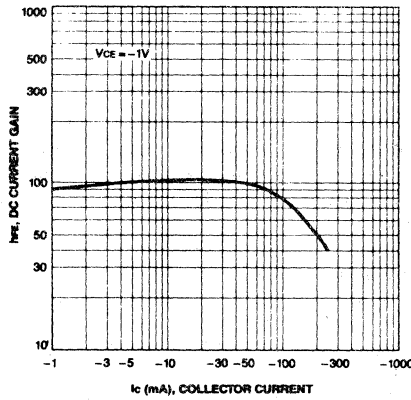
STATIC CHARACTERISTIC



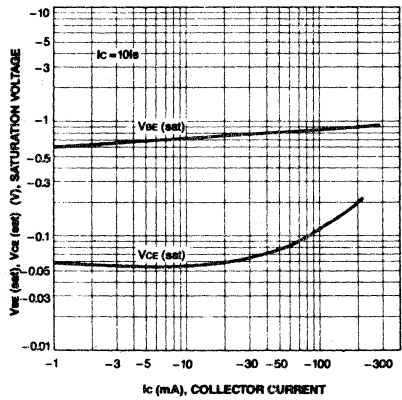
BASE-EMITTER ON VOLTAGE



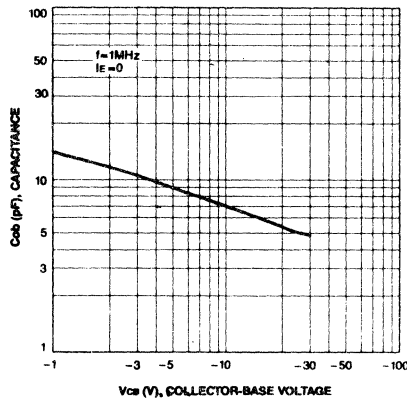
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

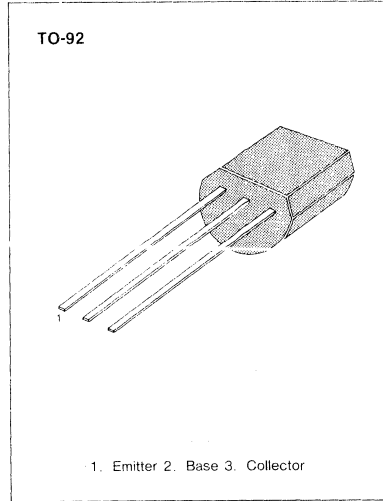


LOW FREQUENCY AMPLIFIER

- Collector-Base Voltage $V_{CBO} = -30V$
- Low Collector-Emitter Saturation Voltage $V_{CE(sat)} = -0.15V$ (TYP)
- Complement to KSC184

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 30	V
Collector-Emitter Voltage	V_{CEO}	- 25	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



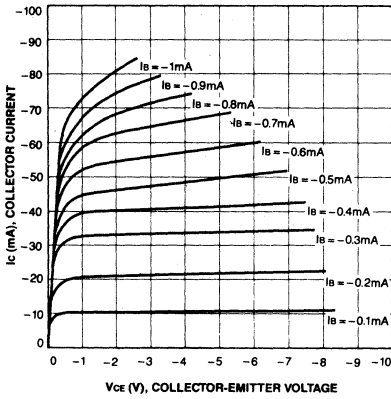
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25V, I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -20mA, I_B = -2mA$		- 0.15	- 0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6V, I_C = -1mA$		- 0.65	- 1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -1mA$		100		MHz
Output Capacitance	Cob	$V_{CB} = -6V, I_E = 0$ $f = 1MHz$		2.5		pF

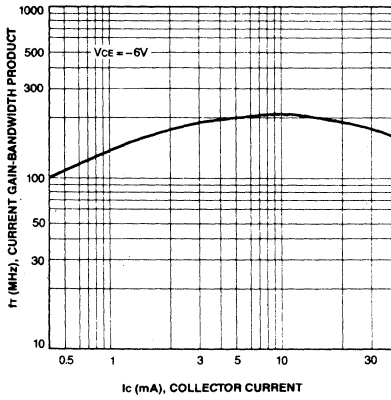
h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

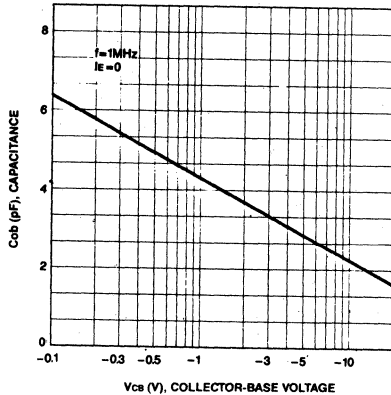
STATIC CHARACTERISTIC



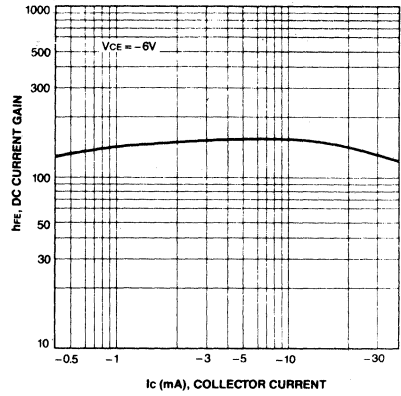
CURRENT GAIN-BANDWIDTH PRODUCT



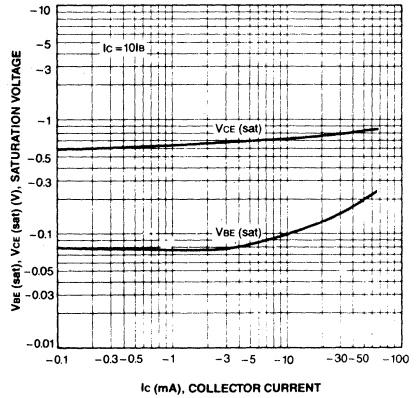
COLLECTOR OUTPUT CAPACITANCE



DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



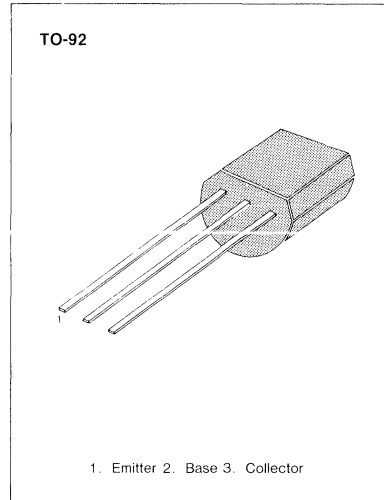
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSD227
- Collector Dissipation $P_c = 400\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 30	V
Collector-Emitter Voltage	V_{CEO}	- 25	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current (DC)	I_C (DC)	- 300	mA
Collector Current (pulse)	I_C (pulse)*	- 500	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* $PW \leq 10\text{ms}$, duty cycle $\leq 50\%$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

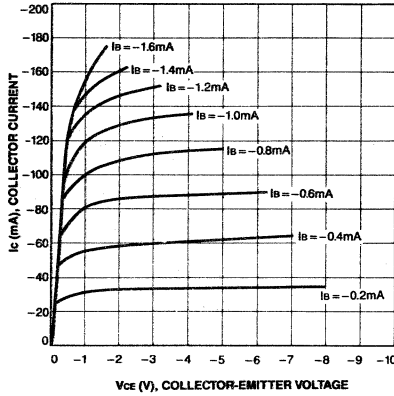
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}$, $I_E = 0$	- 30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}$, $I_B = 0$	- 25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}$, $I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}$, $I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}$, $I_C = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}$, $I_C = -50\text{mA}^*$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -300\text{mA}$, $I_B = -30\text{mA}^*$		- 0.35	- 0.6	V

* Pulse Test: $PW \leq 350\mu\text{s}$, duty cycle $\leq 2\%$

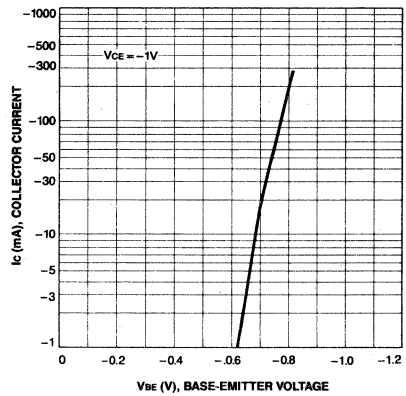
h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

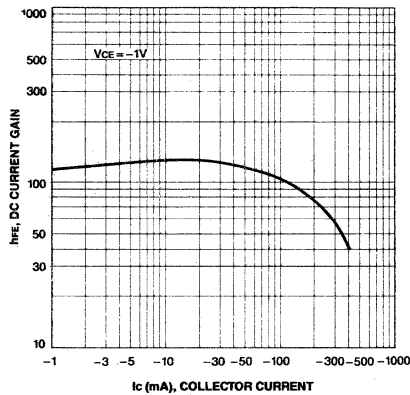
STATIC CHARACTERISTIC



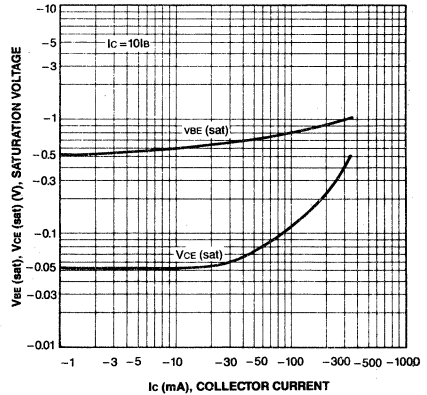
BASE-EMITTER ON VOLTAGE



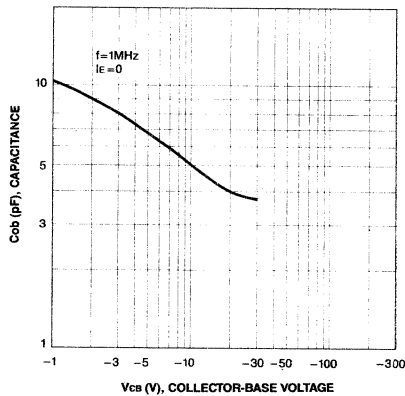
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



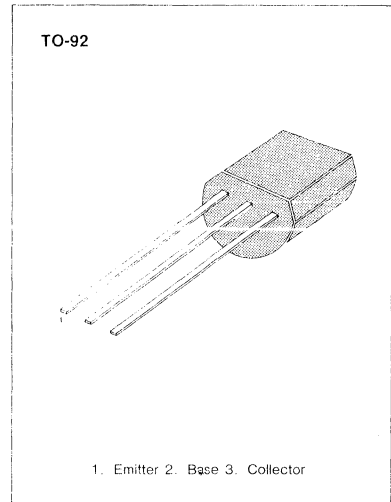
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSD261
- Collector Dissipation $P_C = 500\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-20	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C (DC)	-500	mA
Collector Current (pulse)*	I_C (pulse)*	-700	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* $PW \leq 10\text{mS}$, duty Cycle $\leq 50\%$.

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

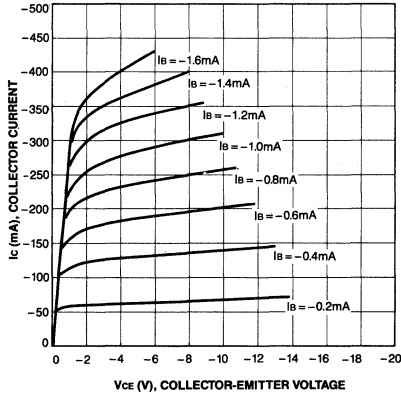
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}$, $I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}$, $I_B = 0$	-20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}$, $I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}$, $I_E = 0$			-200	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}$, $I_C = 0$			-200	nA
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}$, $I_C = -100\text{mA}^*$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -500\text{mA}$, $I_B = -50\text{mA}^*$		-0.3	-0.4	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = -500\text{mA}$, $I_B = -50\text{mA}^*$		-1.0	-1.3	V

* Pulse Test: $PW = 350\mu\text{s}$, duty cycle = 2%

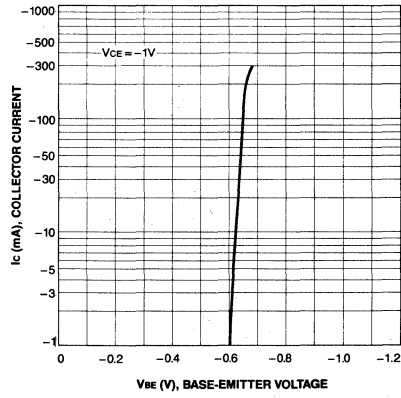
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

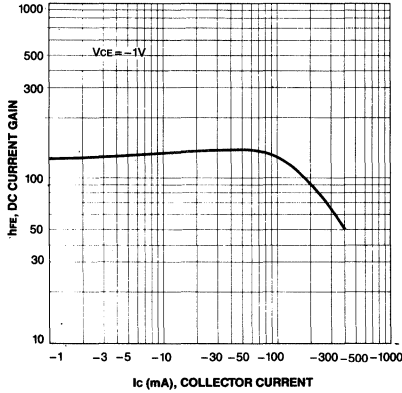
STATIC CHARACTERISTIC



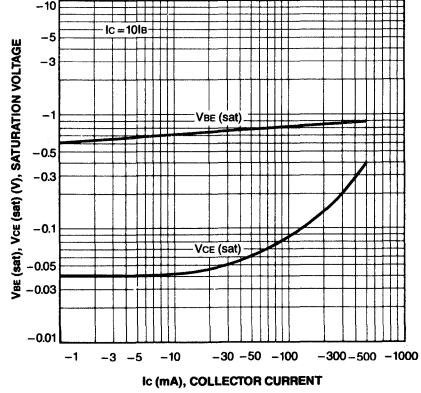
BASE-EMITTER ON VOLTAGE



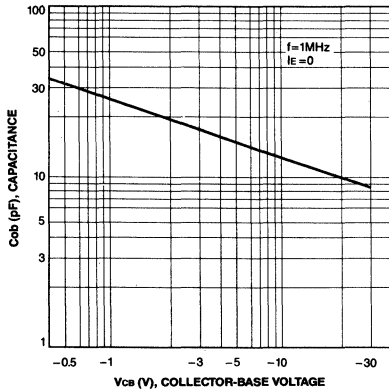
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



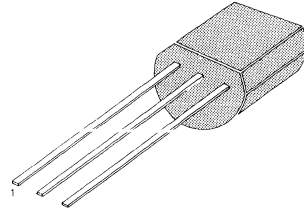
LOW FREQUENCY AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSC1008
- Collector-Base Voltage $V_{CBO} = -80V$
- Collector Dissipation $P_C = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 80	V
Collector-Emitter Voltage	V_{CEO}	- 60	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_C	- 700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 - 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

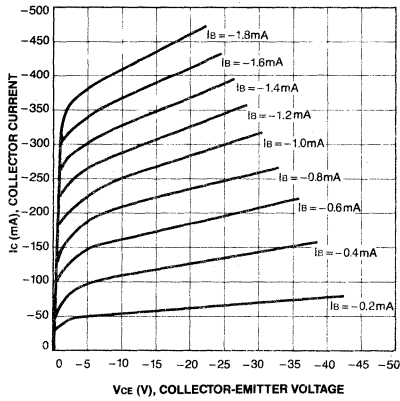
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -500mA, I_B = -50mA^*$		- 0.3	- 0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -500mA, I_C = -50mA$		- 0.9	1.1	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$		50		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		13		pF

* Pulse Test: $PW \leq 350\mu s$, duty cycle $\leq 2\%$

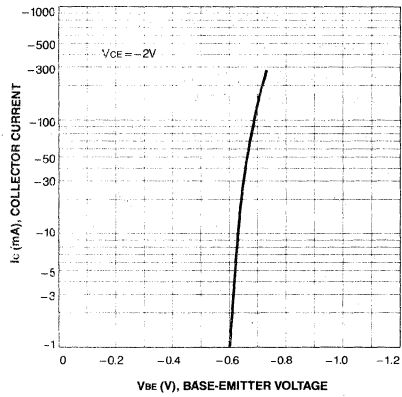
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

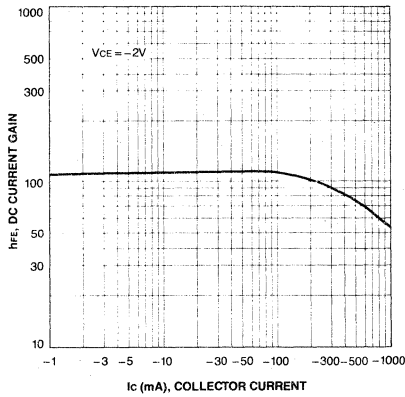
STATIC CHARACTERISTIC



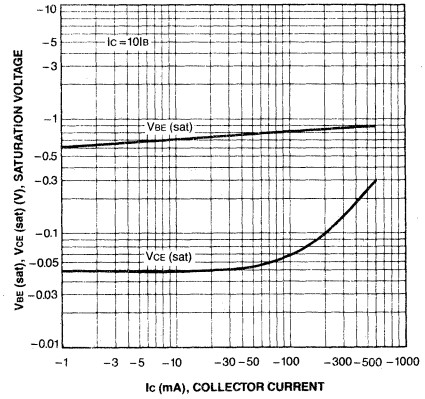
BASE-EMITTER ON VOLTAGE



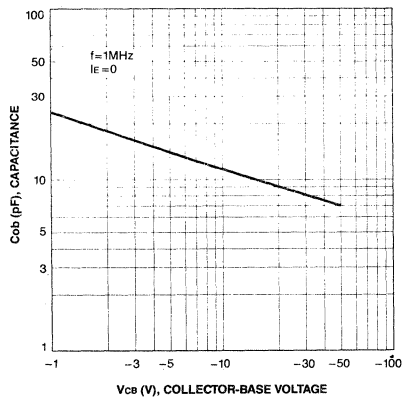
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

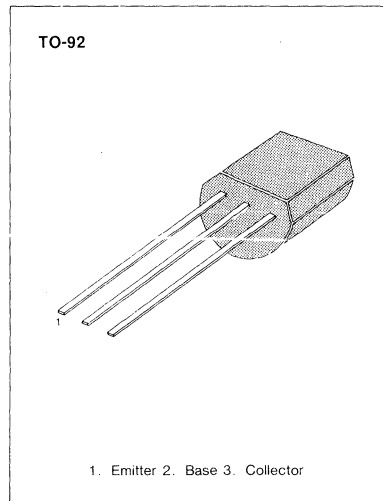


HIGH VOLTAGE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = -160V$
- Collector Dissipation $P_C = 800mW$
- Complement to KSC1009

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-160	V
Collector-Emitter Voltage	V_{CEO}	-150	V
Emitter-Base Voltage	V_{EBO}	-8	V
Collector Current	I_C	-700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

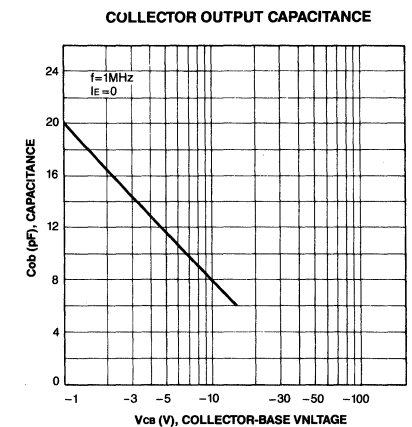
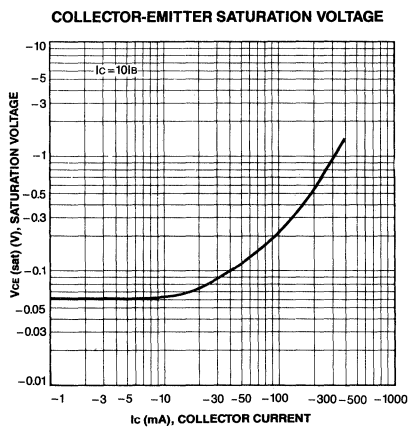
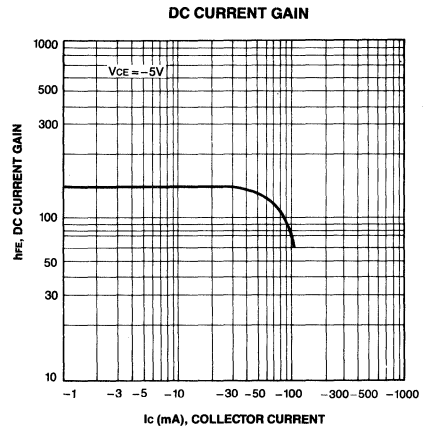
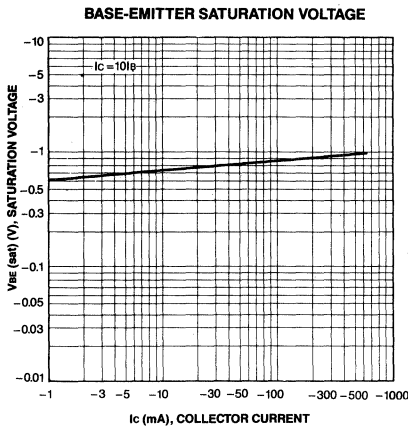
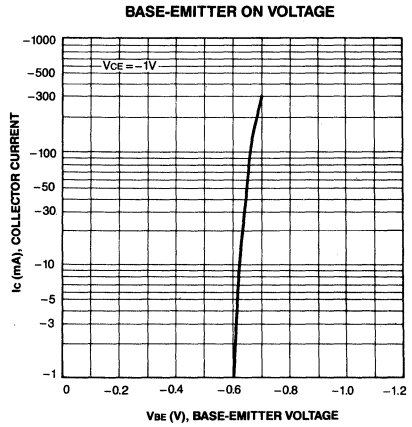
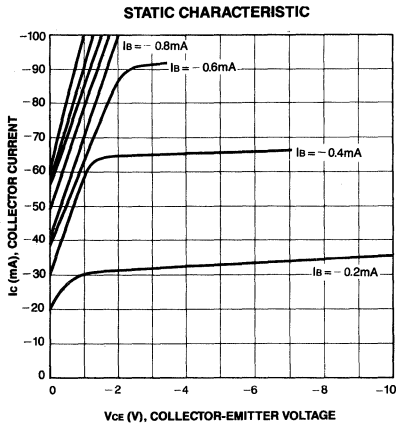
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-160			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -100V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -200mA, I_B = -20mA^*$		-0.3	-0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -200mA, I_B = -20mA^*$		-0.9	-1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$		50		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			10	pF

* pulse measured $PW \leq 350\mu s$, duty cycle $\leq 2\%$

 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

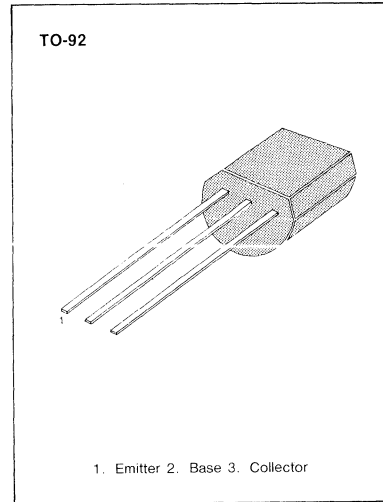


LOW FREQUENCY AMPLIFIER

- Complement to KSC945
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

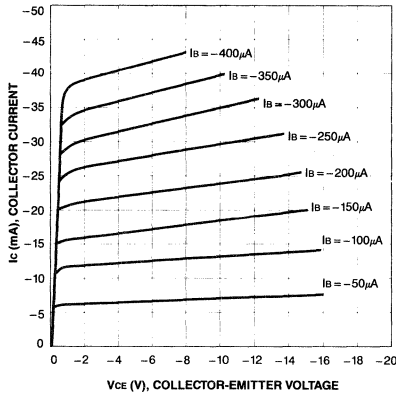
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	40		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6V, I_C = -1mA$	-0.50	-0.62	-0.80	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$	50	180		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		2.8		pF
Noise Figure	NF	$V_{CE} = -6V, I_C = -0.3mA$ $f = 100Hz, R_S = 10K\Omega$		6.0	20	dB

h_{FE} CLASSIFICATION

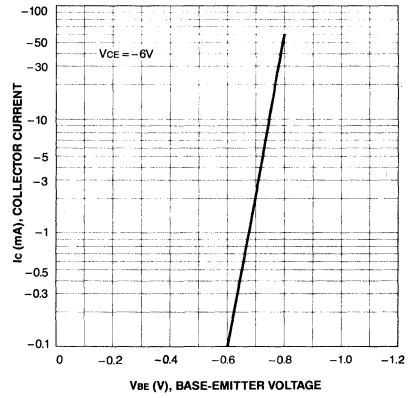
Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700

3

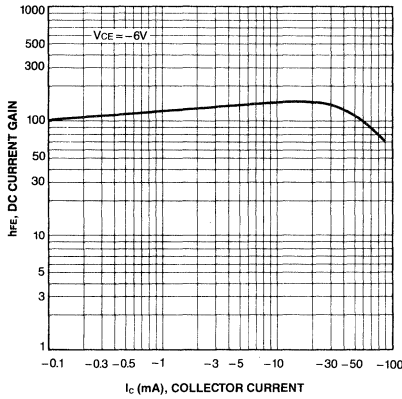
STATIC CHARACTERISTIC



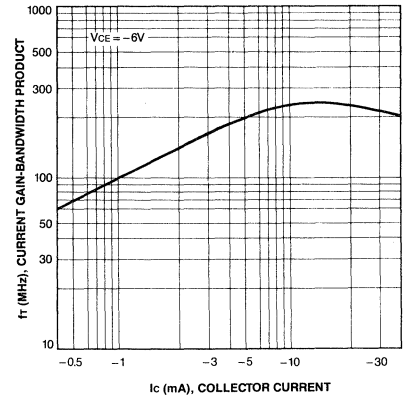
BASE-EMITTER ON VOLTAGE



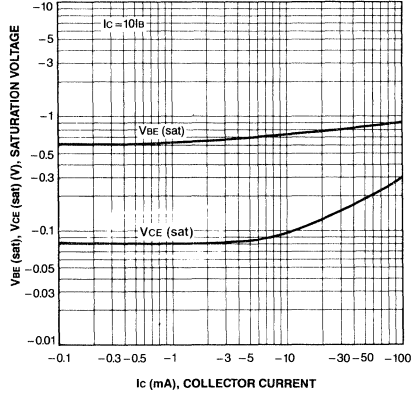
DC CURRENT GAIN



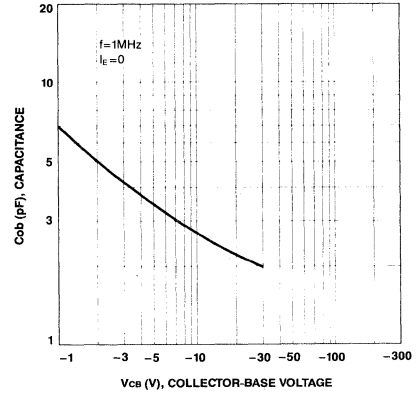
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

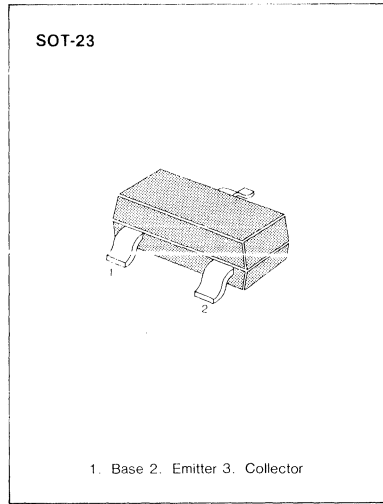


LOW FREQUENCY AMPLIFIER

- Complement to KSC1623
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



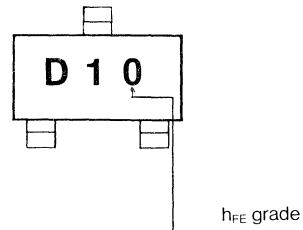
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	90	200	600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = -1mA, V_{CE} = -6V$	-0.55	-0.62	-0.65	V
Current Gain-Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -6V$		180		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		4.5		pF

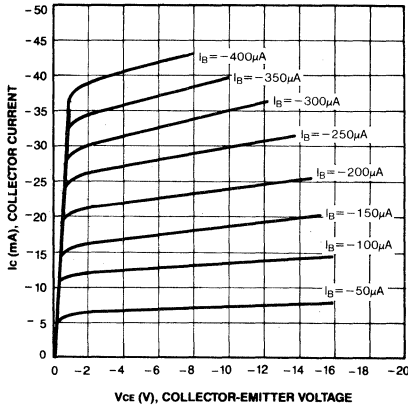
h_{FE} CLASSIFICATION

Classification	O	Y	G	L
h_{FE}	90-180	135-270	200-400	300-600

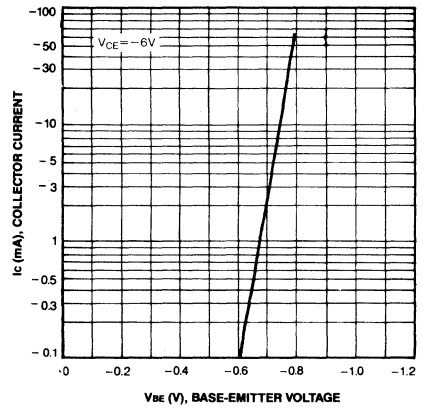
Marking



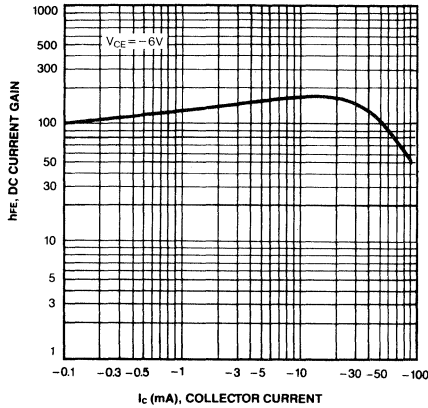
STATIC CHARACTERISTIC



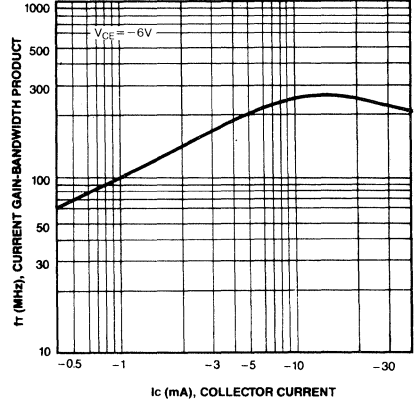
BASE-EMITTER ON VOLTAGE



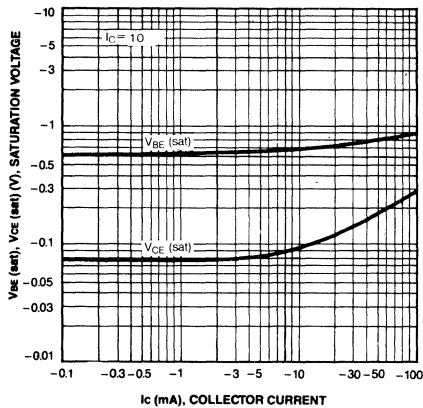
DC CURRENT GAIN



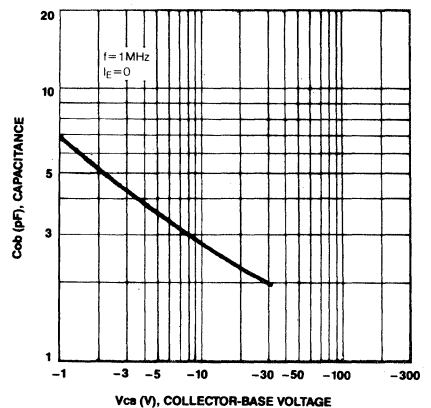
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

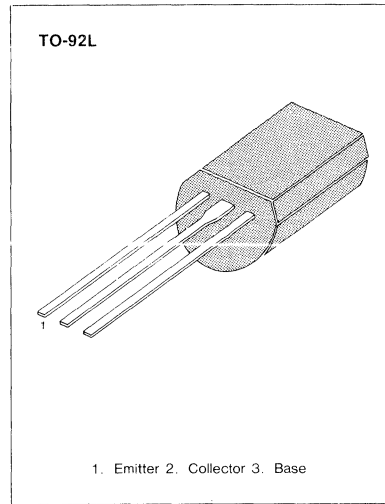


**DRIVER STAGE AUDIO AMPLIFIER
HIGH VOLTAGE SWITCHING APPLICATIONS**

- Complement to KSC2310
- Collector-Emitter Voltage $V_{CE0} = -150V$
- Output Capacitance: $C_{ob} = 5pF$ (MAX)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 150	V
Collector-Emitter Voltage	V_{CEO}	- 150	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 50	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ C$



3

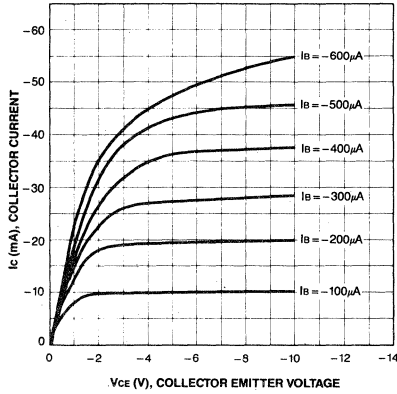
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 150			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -5mA, I_B = 0$	- 150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	- 5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -150V, I_E = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -10mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			- 0.8	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -30V, I_C = -10mA$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1MHz$			5.0	pF

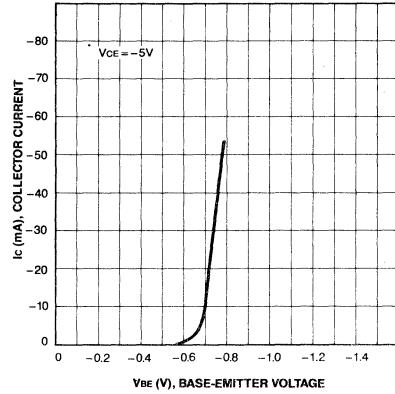
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

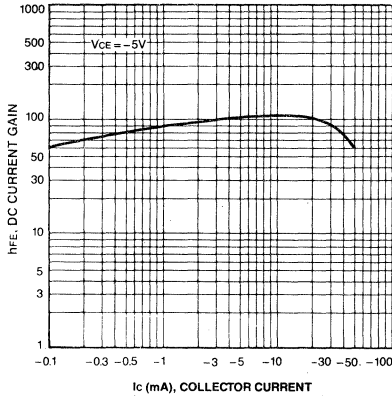
STATIC CHARACTERISTIC



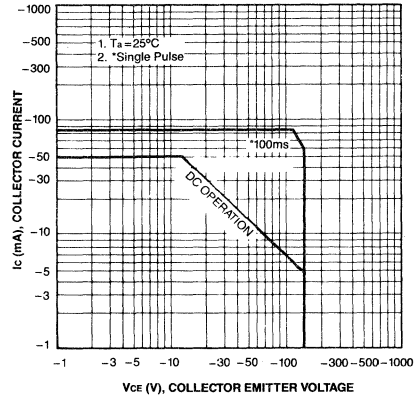
BASE-EMITTER ON VOLTAGE



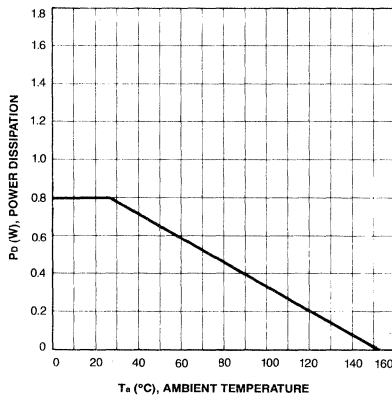
DC CURRENT GAIN



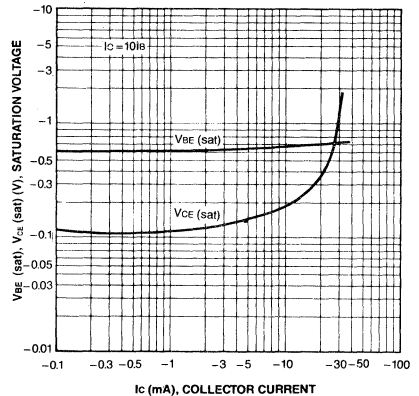
SAFE OPERATING AREA



POWER DERATING



COLLECTOR-EMITTER SATURATION VOLTAGE. BASE-EMITTER SATURATION VOLTAGE.

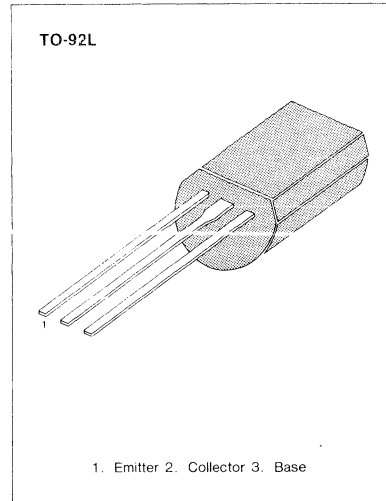


AUDIO POWER AMPLIFIER

- Driver Stage Amplifier
- Complement to KSC2316

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	- 120	V
Collector-Emitter Voltage	V _{CEO}	- 120	V
Emitter-Base Voltage	V _{EBO}	- 5	V
Collector Current	I _C	- 800	mA
Collector Dissipation	P _C	900	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	- 55 ~ + 150	°C



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

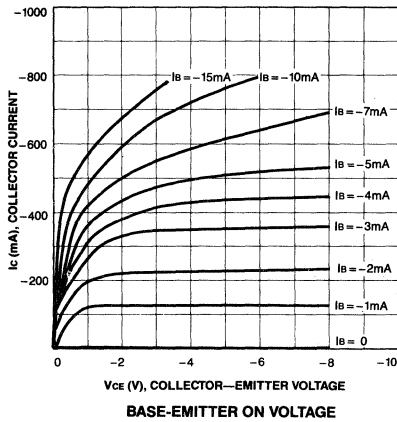
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -1mA, I _E = 0	- 120			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -10mA, I _B = 0	- 120			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -1mA, I _C = 0	- 5			V
Collector Cutoff Current	I _{CBO}	V _{CB} = -120V, I _E = 0			--0.1	μA
DC Current Gain	h _{FE1}	V _{CE} = -5V, I _C = -10mA	60			
	h _{FE2}	V _{CE} = -5V, I _C = -100mA	80		240	
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -500mA, I _B = -50mA			- 1	V
Current-Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -100mA		120		MHz
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz			40	pF

h_{FE} CLASSIFICATION

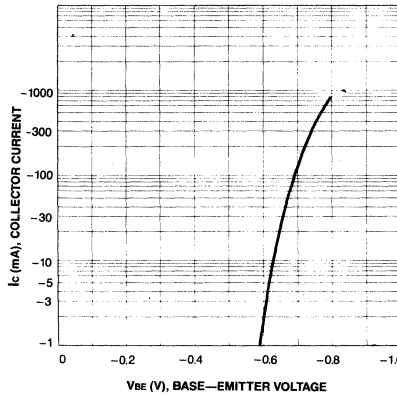
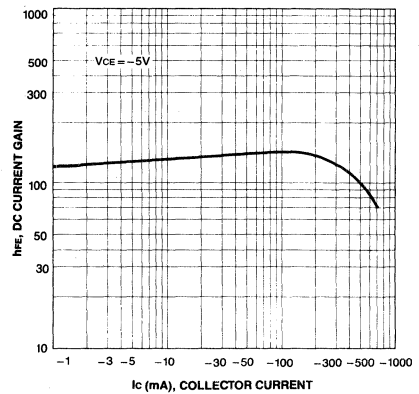
Classification	O	Y
h _{FE(2)}	80-160	120-240



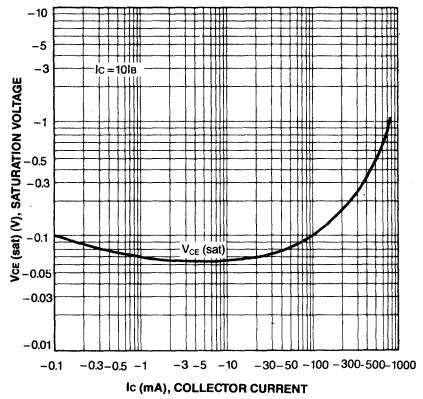
STATIC CHARACTERISTIC



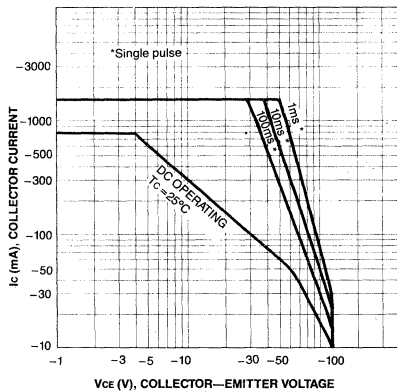
DC CURRENT GAIN



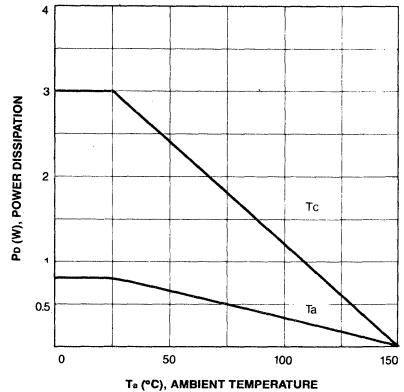
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA



POWER DERATING

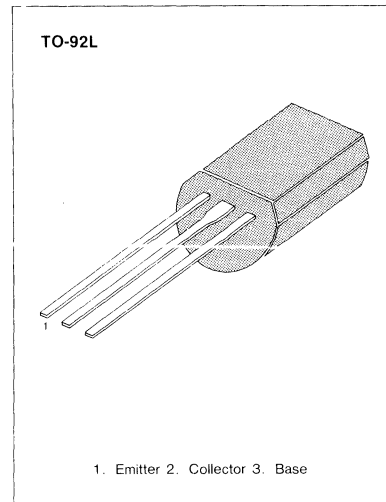


AUDIO POWER AMPLIFIER

- Complement of KSC2328A
- Collector Dissipation $P_C=1$ Watt
- 3 Watt Output Application

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-30	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-2	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$

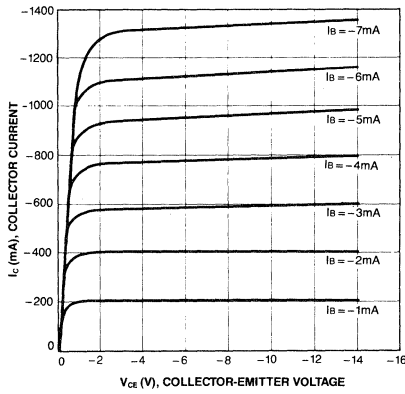
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\text{mA}, I_C = 0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30\text{V}, I_E = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$	100		320	
Base-Emitter On Voltage	$V_{BE(ON)}$	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$			-1.0	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1.5\text{A}, I_B = -0.03\text{A}$			-2.0	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0,$ $f = 1\text{MHz}$		48		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$		120		MHz

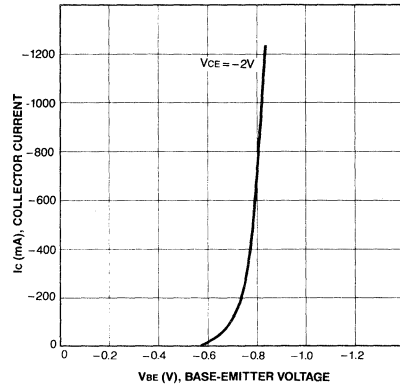
 h_{FE} CLASSIFICATION

Classification	O	Y
h_{FE}	100-200	160-320

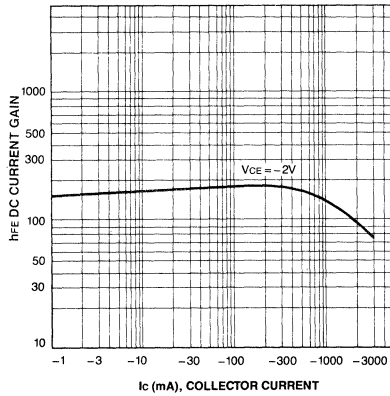
STATIC CHARACTERISTIC



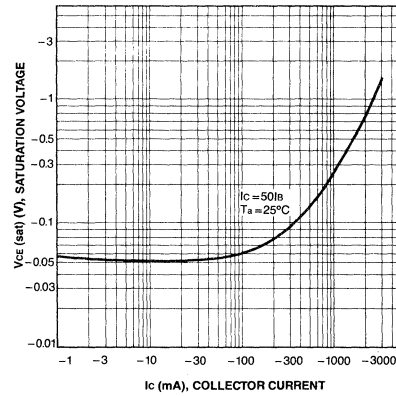
BASE-EMITTER ON VOLTAGE



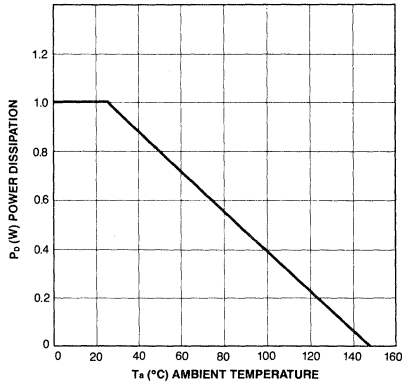
DC CURRENT GAIN



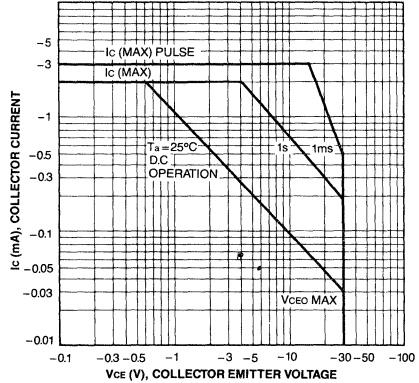
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA

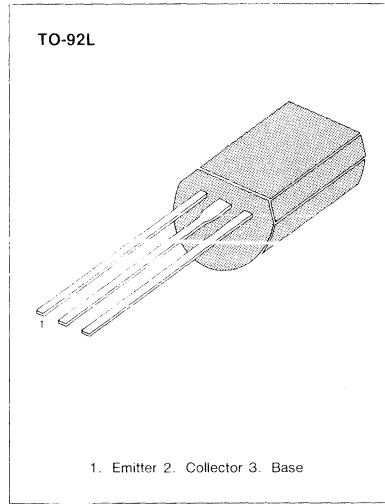


**LOW FREQUENCY AMPLIFIER
MEDIUM SPEED SWITCHING**

- Compiement to KSC2331
- Collector-Base Voltage $V_{CBO} = -80V$
- Collector Dissipation $P_C = 1W$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 80	V
Collector-Emitter Voltage	V_{CEO}	- 60	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_C	- 700	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ C$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

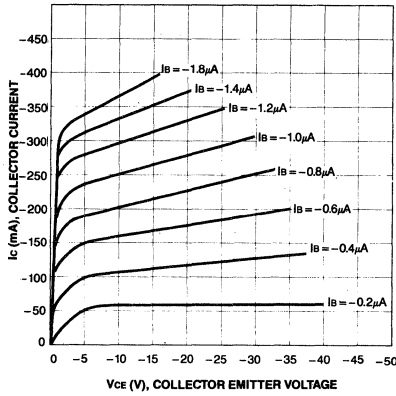
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -500mA, I_B = -50mA^*$		- 0.3	- 0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -500mA, I_B = -50mA^*$		- 0.9	- 1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		13		pF

* Pulse Test $PW \leq 350\mu s$, duty cycle $\leq 2\%$

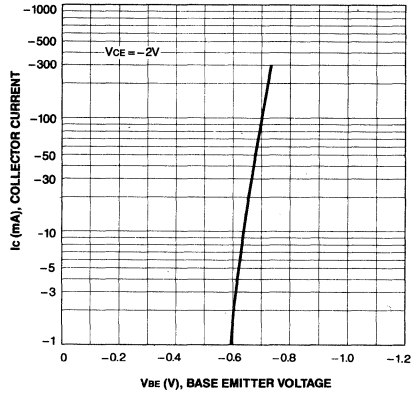
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

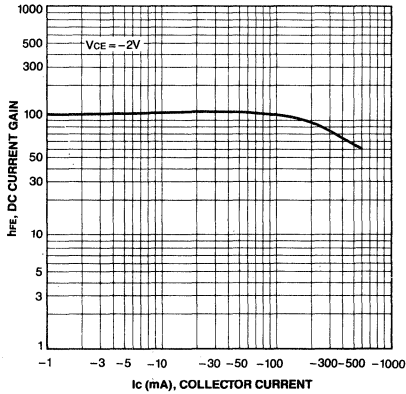
STATIC CHARACTERISTIC



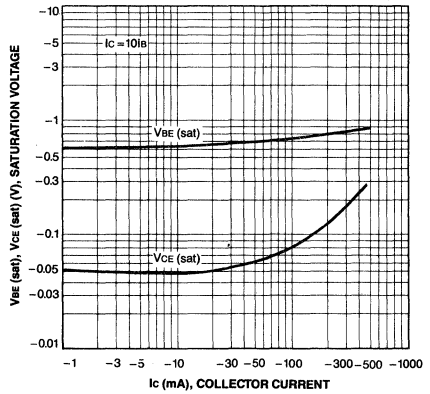
BASE-EMITTER ON VOLTAGE



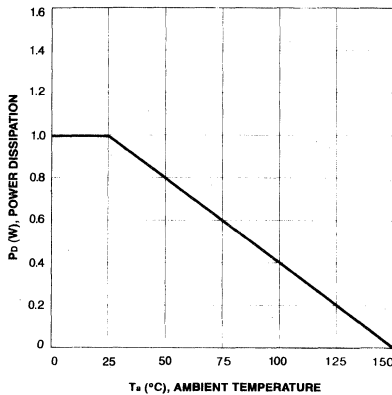
DC CURRENT GAIN



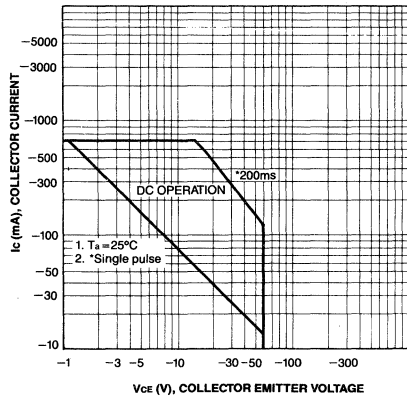
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA

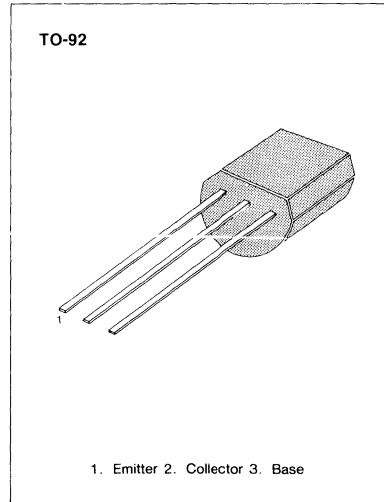


AUDIO FREQUENCY AMPLIFIER

• Complement to KSC2002/KSC2003

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSA953	V _{CB0}	-60	V
: KSA954		-80	V
Collector-Emitter Voltage : KSA953	V _{CEO}	-60	V
: KSA954		-80	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current (DC)	I _C	-300	mA
* Collector Current (Pulse)	I _C	-500	mA
Collector Dissipation	P _C	600	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



* PW<10ms, Duty Cycle ≤50%

3

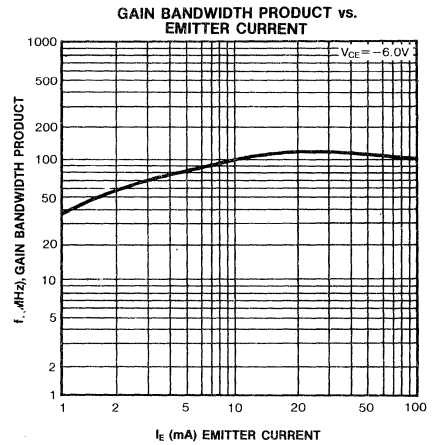
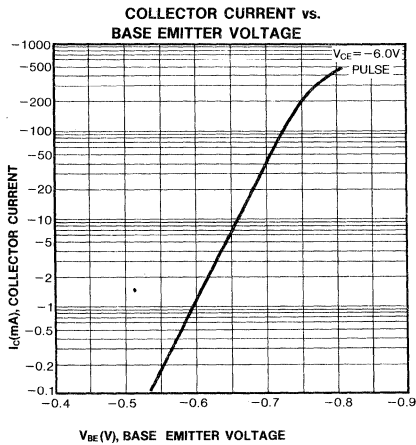
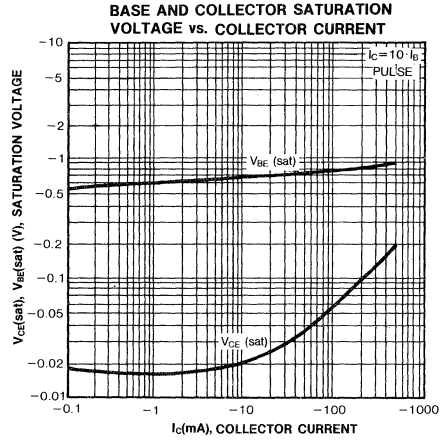
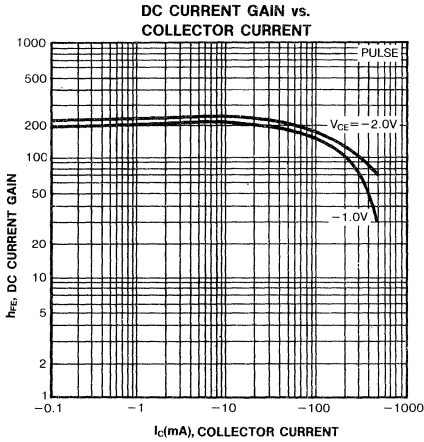
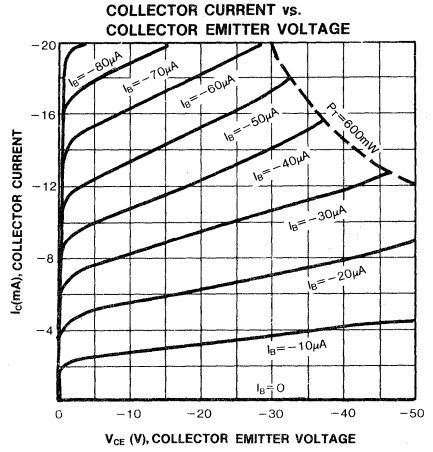
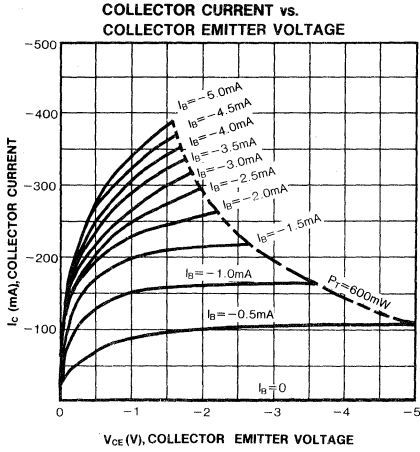
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current : KSA953	I _{CBO}	V _{CB} = -60V, I _E = 0			-100	nA
: KSA954		V _{CB} = -80V, I _E = 0			-100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = -5V, I _C = 0			-100	nA
* DC Current Gain	h _{FE1}	V _{CE} = -1V, I _C = -50mA	90	200	400	
	h _{FE2}	V _{CE} = -2V, I _C = -300mA	30	80		
* Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = -6V, I _C = -10mA	-600	-660	-700	mV
* Base Emitter Saturation Voltage	V _{BE (sat)}	I _C = -300mA, I _B = -30mA		-0.85	-1.2	V
* Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -300mA, I _B = -30mA		-0.15	-0.6	V
Output Capacitance	C _{ob}	V _{CB} = -6V, I _E = 0, f = 1MHz		13	25	pF
Current Gain-Bandwidth Product	f _T	V _{CE} = -6V, I _E = 10mA	50	100		MHz

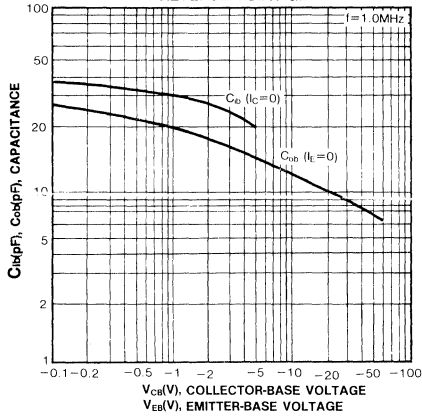
* Pulse Test: PW ≤ 350μs, Duty Cycle ≤ 2% Pulsed

h_{FE} (1) CLASSIFICATION

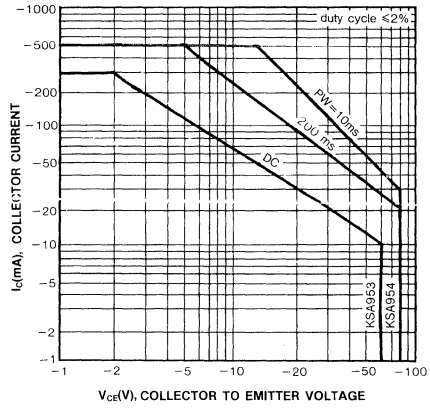
Classification	O	Y	G
h _{FE1}	90-180	135-270	200-400



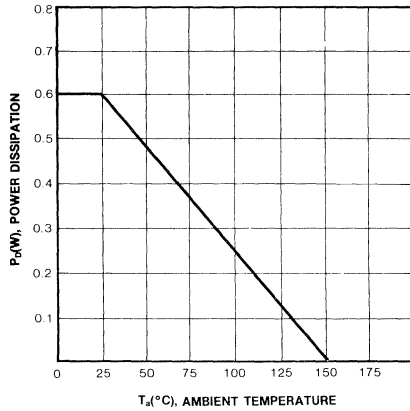
INPUT AND OUTPUT CAPACITANCE vs. REVERSE VOLTAGE



SAFE OPERATING AREA



POWER DERATING



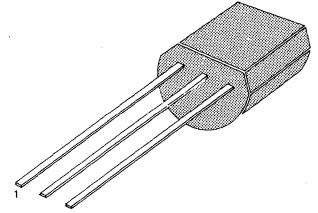
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSC1845

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-120	V
Collector-Emitter Voltage	V_{CEO}	-120	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-50	mA
Base Current	I_B	-10	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



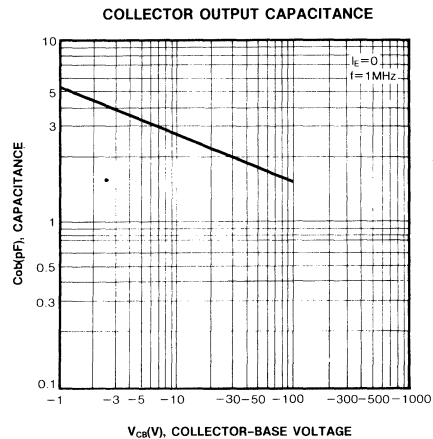
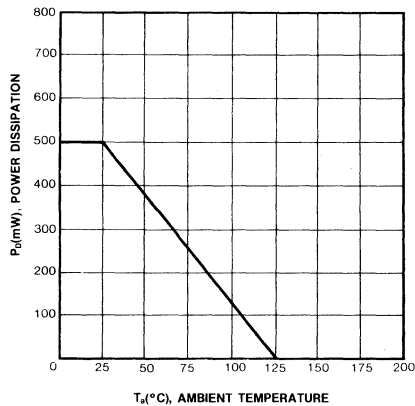
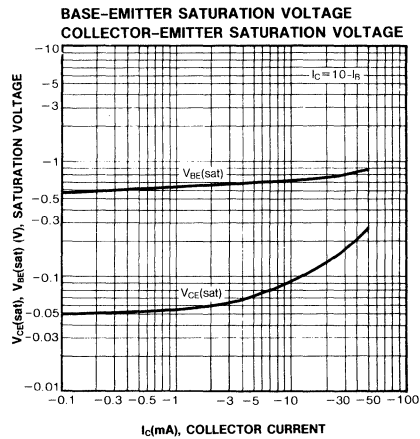
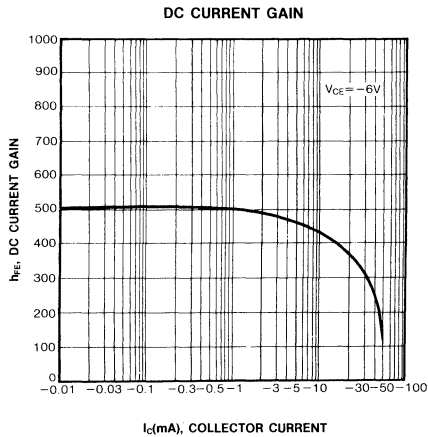
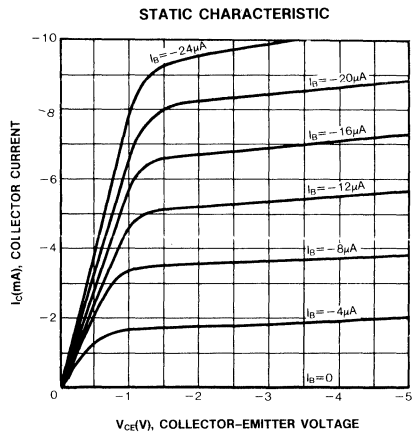
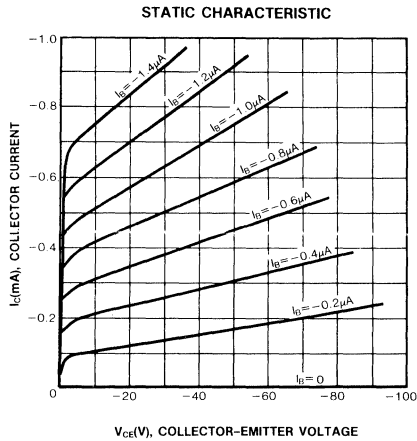
1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

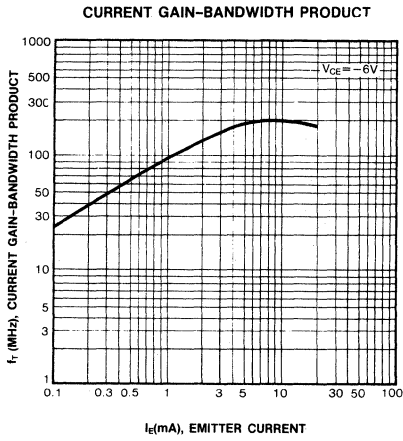
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -120\text{V}, I_E = 0$			-50	nA
Collector Cutoff Current	I_{CEO}	$V_{CE} = -100\text{V}, R_{BE} = \infty$			-1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-50	nA
DC Current Gain	h_{FE1}	$V_{CE} = -6\text{V}, I_C = -0.1\text{mA}$	150	500		
	h_{FE2}	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$	200	500	800	
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$	-0.55	-0.61	-0.65	V
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -10\text{mA}, I_B = -1\text{mA}$		-0.09	-0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -6\text{V}, I_E = 1\text{mA}$	50	100		MHz
Output Capacitance	Cob	$V_{CB} = -30\text{V}, I_E = 0$ $f = 1\text{MHz}$		2	3	pF
Noise Voltage	NV			25	40	mV

 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E
$h_{FE}(2)$	200-400	300-600	400-800



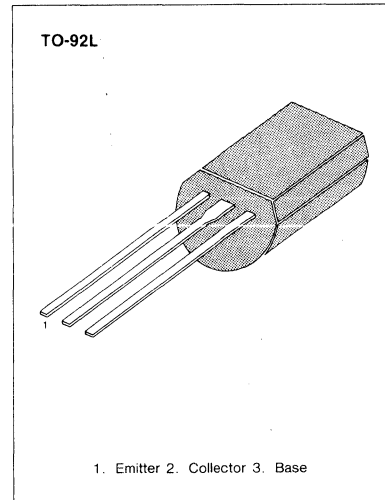
3



COLOR TV AUDIO OUTPUT
 COLOR TV VERTICAL DEFLECTION OUTPUT

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-160	V
Collector-Emitter Voltage	V_{CEO}	-160	V
Emitter-Base Voltage	V_{EBO}	-6	V
Collector Current	I_C	-1	A
Base Current	I_B	-0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



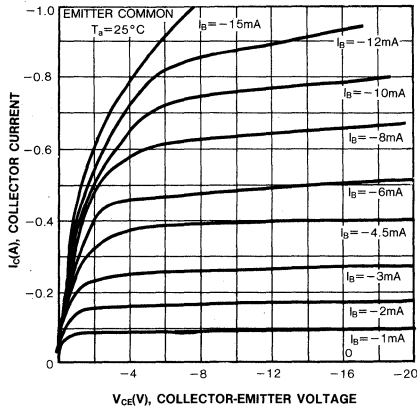
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -150\text{V}, I_E = 0$			-1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -6\text{V}, I_C = 0$			-1	μA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-160			V
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -200\text{mA}$	60		320	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -500\text{mA}, I_B = -50\text{mA}$			-1.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -5\text{V}, I_C = -5\text{mA}$	-0.45		-0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -200\text{mA}$	15	50		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$			35	pF

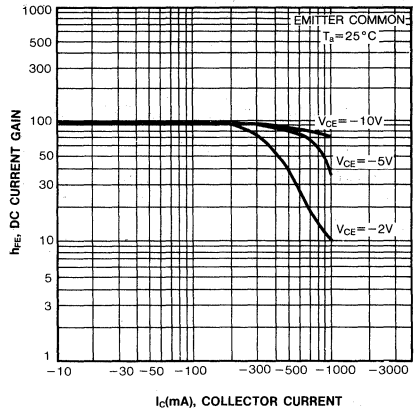
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	60-120	100-200	160-320

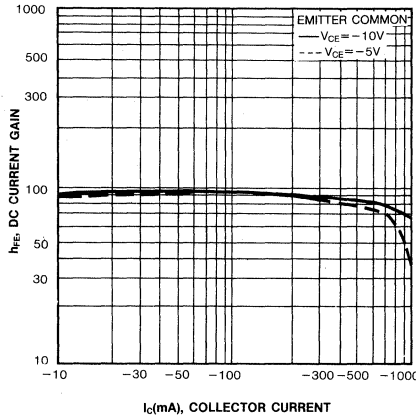
STATIC CHARACTERISTIC



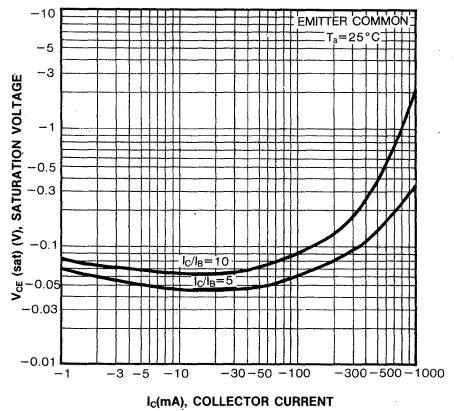
DC CURRENT GAIN



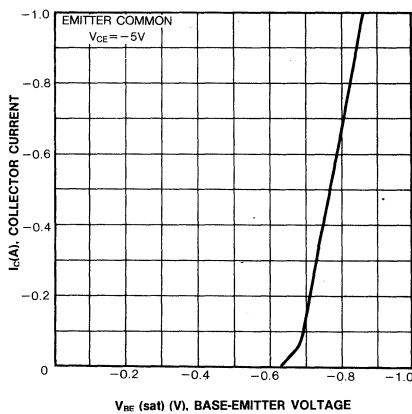
DC CURRENT GAIN



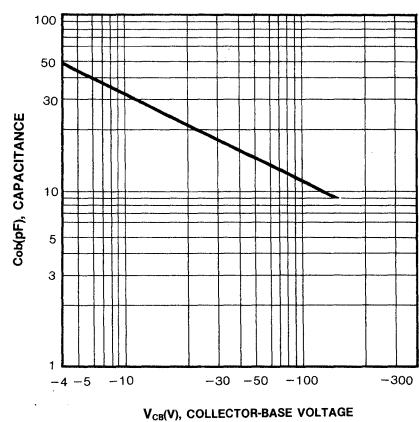
COLLECTOR-EMITTER SATURATION VOLTAGE



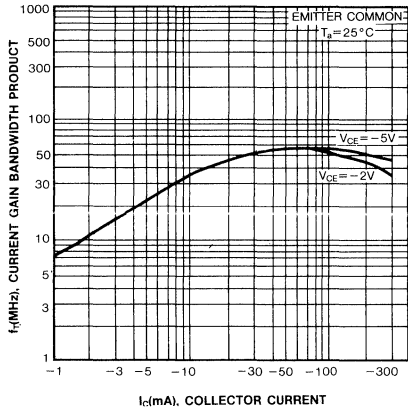
BASE-EMITTER VOLTAGE



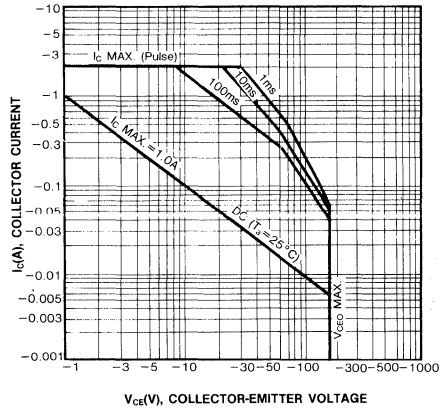
COLLECTOR OUTPUT CAPACITANCE



CURRENT GAIN-BANDWIDTH PRODUCT



SAFE OPERATING AREA



LOW FREQUENCY POWER AMPLIFIER

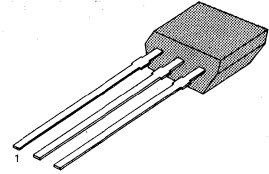
- Complement to KSC2710
- Collector Dissipation $P_c = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-20	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C (DC)	-500	mA
* Collector Current (pulse)	I_C (pulse)	-700	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* $PW \leq 10\text{ms}$, duty Cycle $\leq 50\%$.

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

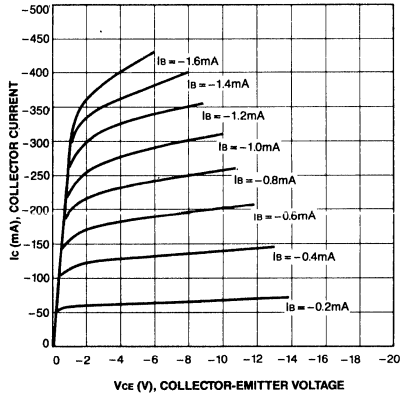
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}$, $I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}$, $I_B = 0$	-20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}$, $I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}$, $I_E = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}$, $I_C = 0$			-100	nA
* DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}$, $I_C = -100\text{mA}$	40		400	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -500\text{mA}$, $I_B = -50\text{mA}$		-0.3	-0.4	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = -500\text{mA}$, $I_B = -50\text{mA}$		-1.0	-1.3	V

* Pulse Test: $PW \leq 350\mu\text{s}$, duty cycle $\leq 2\%$

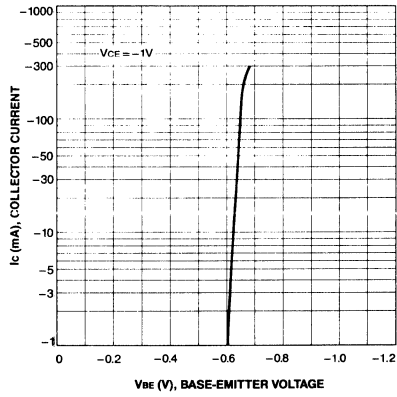
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

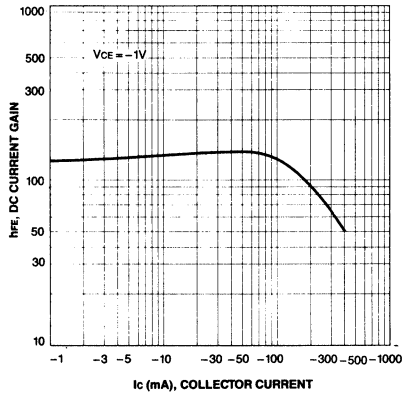
STATIC CHARACTERISTIC



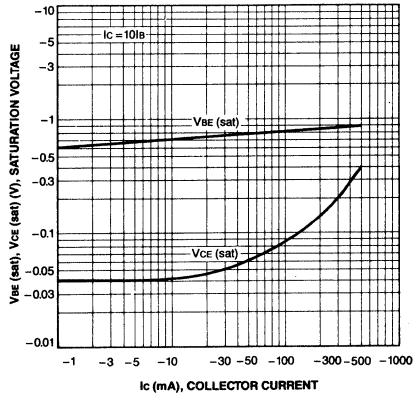
BASE-EMITTER ON VOLTAGE



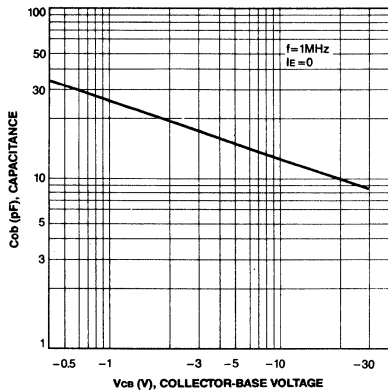
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

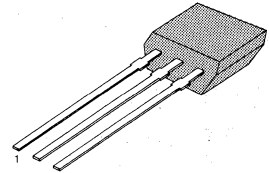
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSC2784

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-120	V
Collector-Emitter Voltage	V_{CE0}	-120	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current	I_C	-50	mA
Base Current	I_B	-10	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

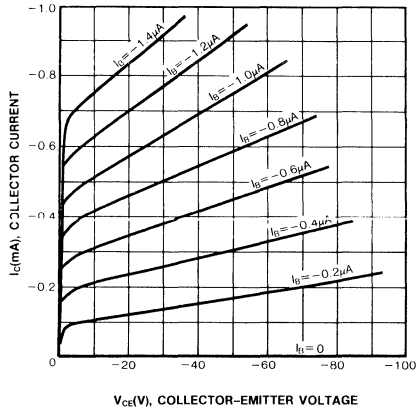
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CB0}	$V_{CB} = -120\text{V}, I_E = 0$			-50	nA
Collector Cutoff Current	I_{CE0}	$V_{CE} = -100\text{V}, R_{BE} = \infty$			-1	μA
Emitter Cutoff Current	I_{EB0}	$V_{EB} = -5\text{V}, I_C = 0$			-50	nA
DC Current Gain	h_{FE1}	$V_{CE} = -6\text{V}, I_C = -0.1\text{mA}$	150	500		
	h_{FE2}	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$	200	500	800	
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$	-0.55	-0.61	-0.65	V
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -10\text{mA}, I_B = -1\text{mA}$		-0.09	-0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -6\text{V}, I_E = 1\text{mA}$	50	100		MHz
Output Capacitance	C_{ob}	$V_{CB} = -30\text{V}, I_E = 0$ $f = 1\text{MHz}$		2	3	pF
Noise Voltage	NV			25	40	mV

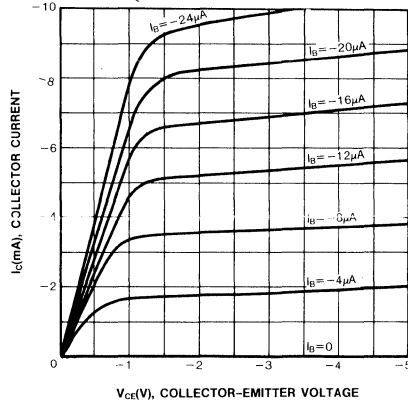
 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E
$h_{FE}(2)$	200-400	300-600	400-800

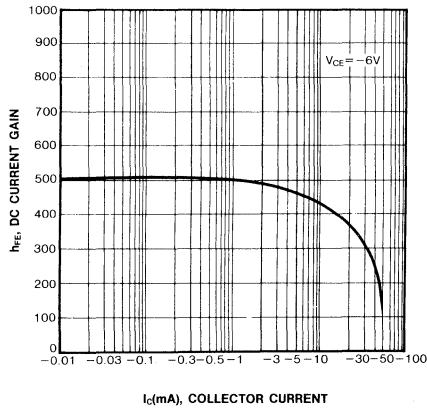
STATIC CHARACTERISTIC



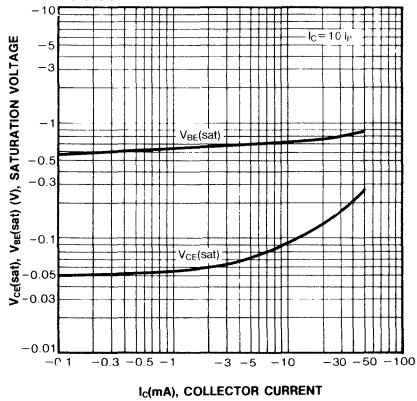
STATIC CHARACTERISTIC



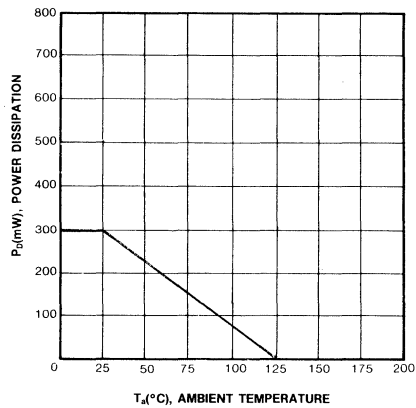
DC CURRENT GAIN



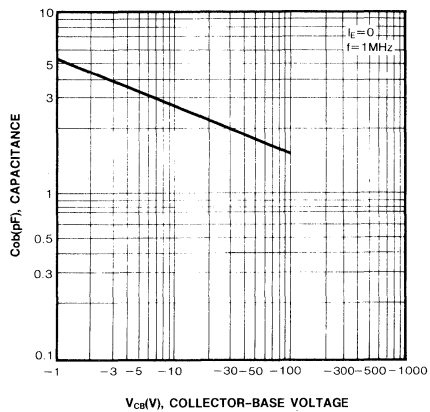
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

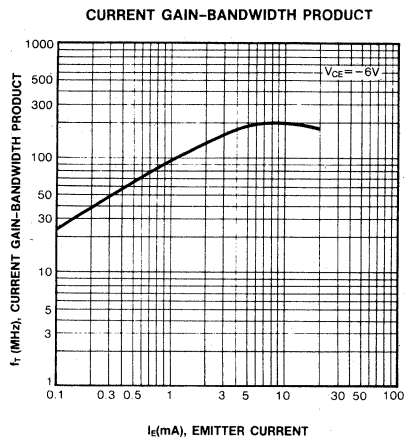


POWER DERATING



COLLECTOR OUTPUT CAPACITANCE





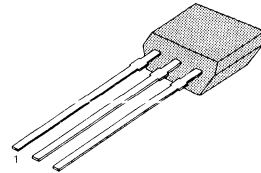
LOW FREQUENCY AMPLIFIER

- Complement to KSC2785
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92S



1. Emitter 2. Collector 3. Base

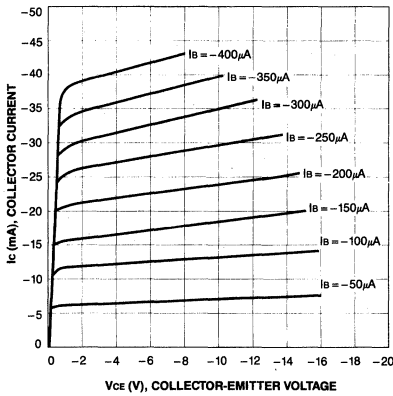
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	40		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6V, I_C = -1mA$	-0.50	-0.62	-0.80	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$	50	180		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		2.8		pF
Noise Figure	NF	$V_{CE} = -6V, I_C = -0.3mA$ $f = 100Hz, R_s = 10K\Omega$		6.0	20	dB

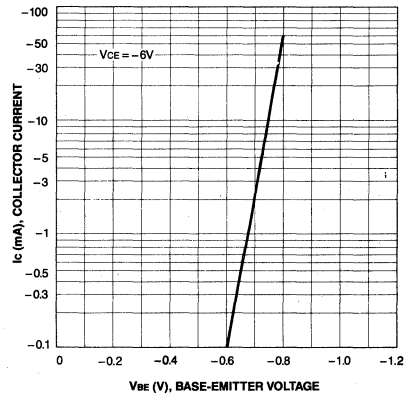
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700

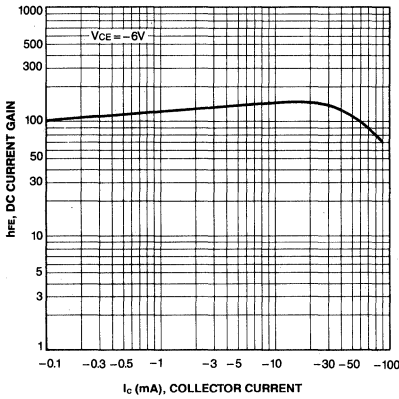
STATIC CHARACTERISTIC



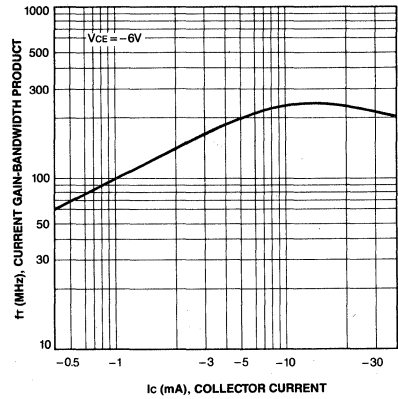
BASE-EMITTER ON VOLTAGE



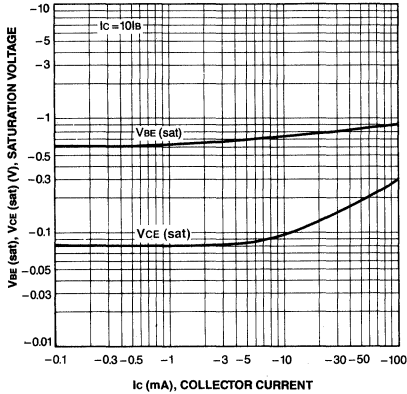
DC CURRENT GAIN



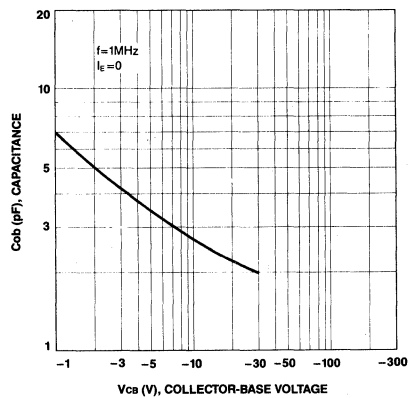
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

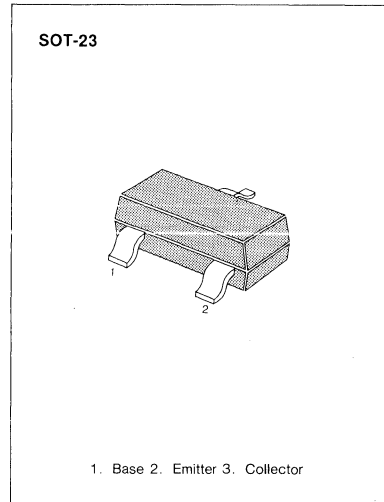


LOW FREQUENCY POWER AMPLIFIER

• Complement to KSA2859

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-35	V
Collector-Emitter Voltage	V_{CEO}	-30	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



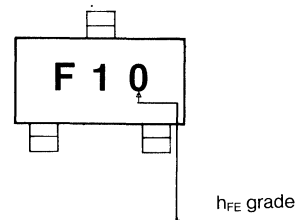
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -35\text{V}, I_E = 0$			-0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE1}	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$	70		240	
	h_{FE2}	$V_{CE} = -6\text{V}, I_C = -400\text{mA}$	25			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100\text{mA}, I_B = -10\text{mA}$		-0.1	-0.25	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = -100\text{mA}, V_{CE} = -1\text{V}$		-0.8	-1.0	V
Current Gain-Bandwidth Product	f_T	$I_C = -20\text{mA}, V_{CE} = -6\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -6\text{V}, I_E = 0$ $f = 1\text{MHz}$		13		pF

h_{FE} CLASSIFICATION

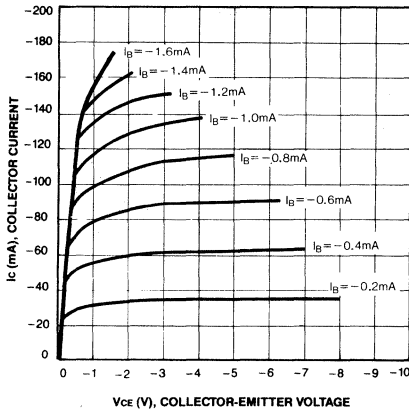
Classification	O	Y
$h_{FE} (1)$	70-140	120-240

Marking

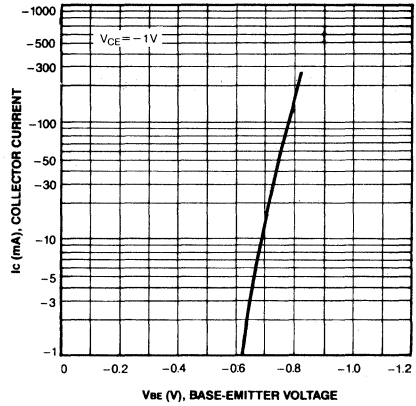


3

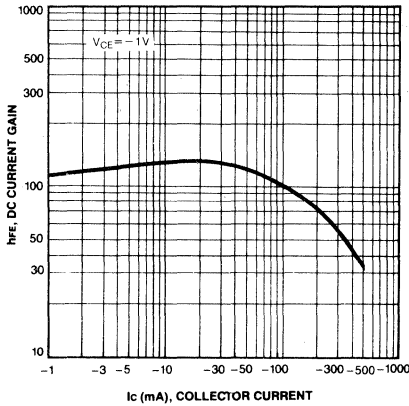
STATIC CHARACTERISTIC



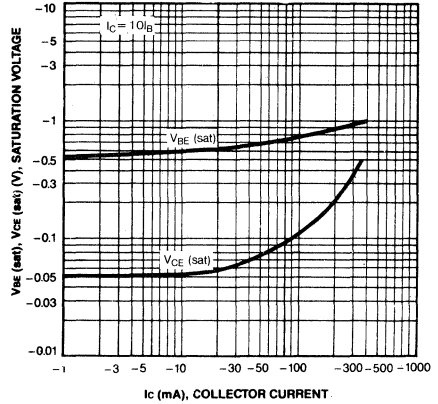
BASE-EMITTER ON VOLTAGE



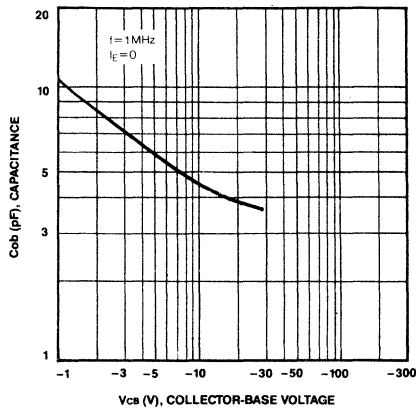
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



LOW FREQUENCY AMPLIFIER

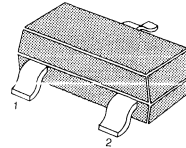
• Complement to KSC3265

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-800	mA
Base Current	I_B	-160	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

• Refer to KSA643 for graphs.

SOT-23



1. Base 2. Emitter 3. Collector

3

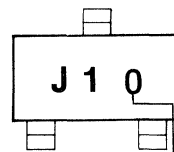
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-10\text{mA}, I_B=0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-1\text{mA}, I_C=0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}, I_C=0$			-100	nA
DC Current Gain	h_{FE1}	$V_{CE}=-1\text{V}, I_C=-100\text{mA}$	100		320	
	h_{FE2}	$V_{CE}=-1\text{V}, I_C=-800\text{mA}$	40			
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-500\text{mA}, I_B=-20\text{mA}$			-0.4	V
Base-Emitter (on) Voltage	$V_{BE(on)}$	$V_{CE}=-1\text{V}, I_C=-10\text{mA}$	-0.5		-0.8	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{V}, I_C=-10\text{mA}$		120		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_C=0$ $f=1\text{MHz}$		13		pF

h_{FE} (1) CLASSIFICATION

Classification	O	Y
h_{FE} (1)	100-200	160-320

Marking



h_{FE} grade

LOW FREQUENCY POWER AMPLIFIER

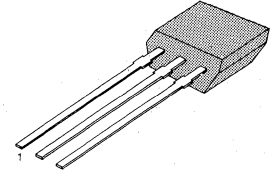
- Complement to KSC3488
- Collector Dissipation $P_C = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 30	V
Collector-Emitter Voltage	V_{CEO}	- 25	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current (DC)	I_C (DC)	- 300	mA
* Collector Current (pulse)	I_C (pulse)	- 500	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* $PW \leq 10\text{ms}$, duty cycle $\leq 50\%$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

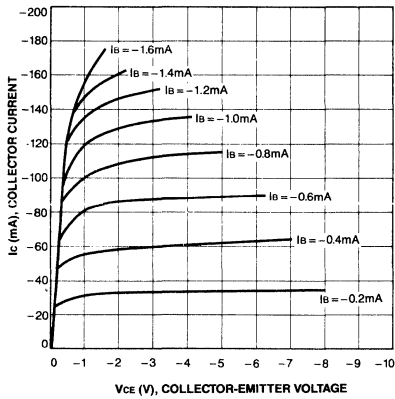
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}$, $I_E = 0$	- 30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}$, $I_B = 0$	- 25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}$, $I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}$, $I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}$, $I_C = 0$			- 100	nA
* DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}$, $I_C = -50\text{mA}$	70		400	nA
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -300\text{mA}$, $I_B = -30\text{mA}$		- 0.35	- 0.6	V

* Pulse Test: $PW \leq 350\mu\text{s}$, duty cycle $\leq 2\%$

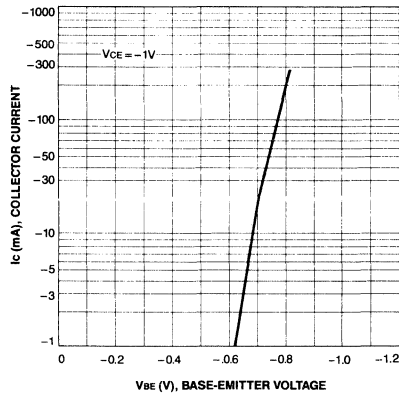
 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

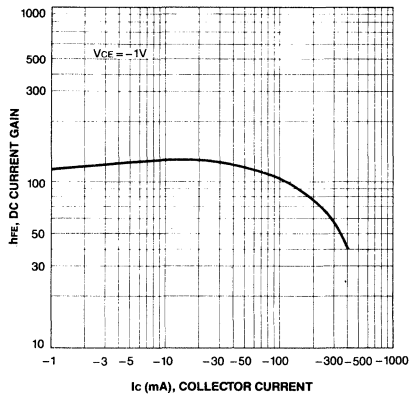
STATIC CHARACTERISTIC



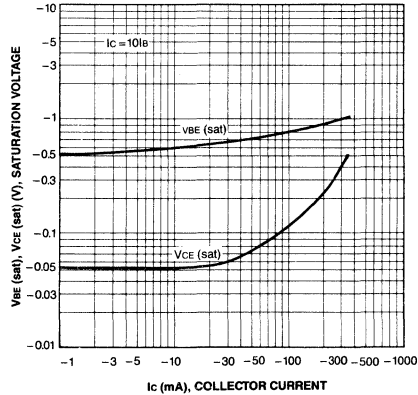
BASE-EMITTER ON VOLTAGE



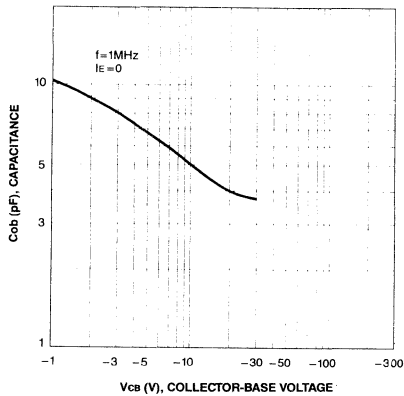
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

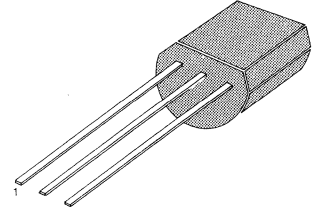
HIGH VOLTAGE SWITCH

- High Breakdown Voltage
- High Speed Switching

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Characteristics	Symbol	Rating	Unit
Collector Base Voltage	V _{CBO}	-400	V
Collector Emitter Voltage	V _{CEO}	-400	V
Emitter Base Voltage	V _{EBO}	-7	V
Base Current	I _B	-0.25	A
Collector Current (DC)	I _C	-0.5	A
Collector Current (Pulse)	I _C	-1.0	A
Collector Dissipation (Ta=25°C)	P _C	0.75	W
Collector Dissipation (Tc=25°C)	P _C	2	W
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C

TO-92



1. Emitter 2. Base 3. Collector

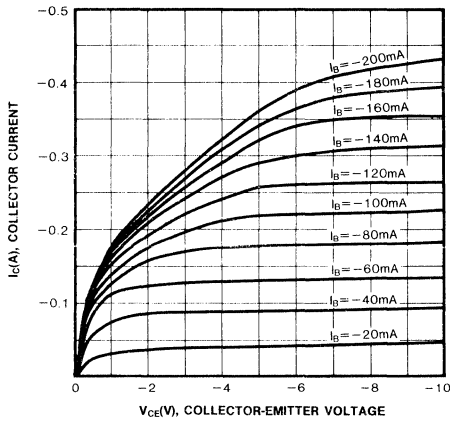
ELECTRICAL CHARACTERISTICS (Ta=25°C)

Characteristics	Symbol	Test Conditions	Min	Max	Unit
Collector Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _B = 0	-400		V
Collector Cutoff Current	I _{CBO}	V _{CB} = -400V, I _E = 0		-1	μA
Emitter Cutoff Current	I _{EBO}	V _{EB} = -5V, I _C = 0		-1	μA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -50mA	40	200	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = -100mA, I _B = -10mA		-1	V
Base Emitter Saturation Voltage	V _(sat)	I _C = -100mA, I _B = -10mA		-1.2	V
Current Gain Bandwidth Product	f _T	V _{CE} = -10V, I _E = -10mA	10		MHz
Output Capacitance	C _{OB}	V _{CB} = -10V, f = 1MHz		25	pF
Turn On Time	t _{ON}	I _C = -100mA, R _L = 1.5kΩ		1	us
Storage Time	t _{STG}	I _{B1} = -10mA, I _{B2} = -10mA		5	us
Fall Time	t _F	V _{CC} = -150V		1	us

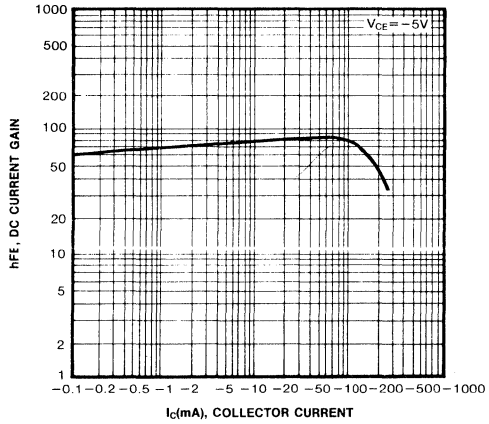
hFE CLASSIFICATION

Classification	M	L	K
hFE	40-80	60-120	100-120

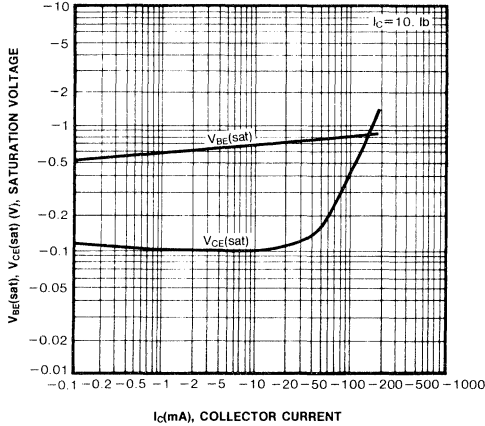
STATIC CHARACTERISTIC



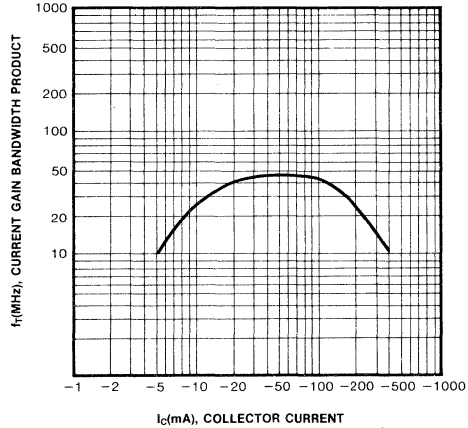
DC CURRENT GAIN



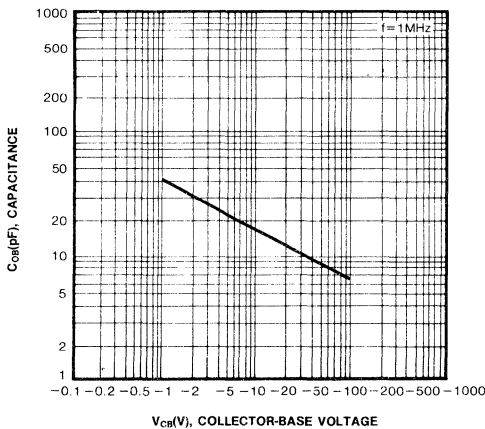
COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



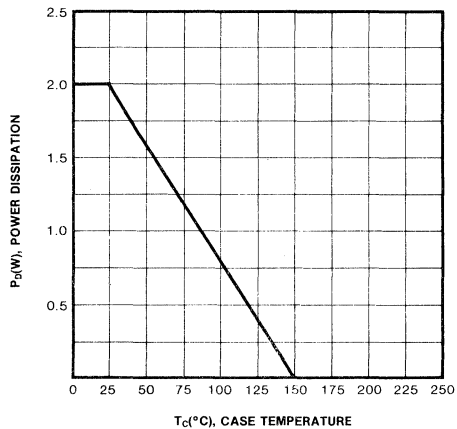
CURRENT GAIN BANDWIDTH PRODUCT



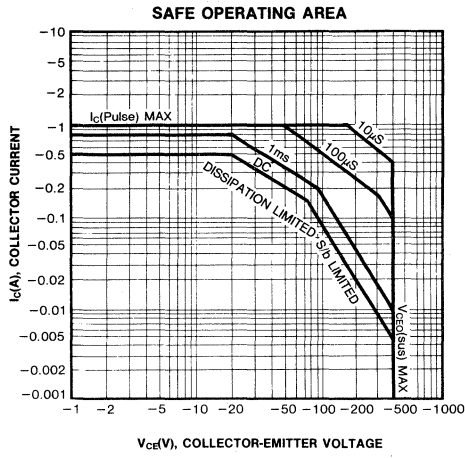
COLLECTOR OUTPUT CAPACITANCE



POWER DERATING



3

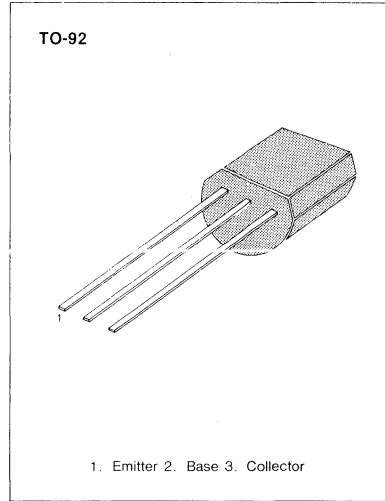


AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSD471A
- Collector Current $I_C = -1A$
- Collector Dissipation $P_C = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-1.0	A
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

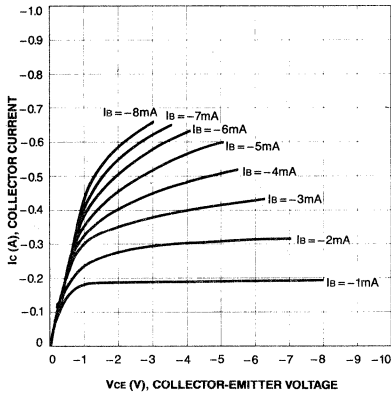
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1A, I_B = -0.1A$			-0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -1A, I_B = -0.1A$			-1.2	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$		110		MHz
Output Capacitance	C_{ob}	$V_{CB} = -6V, f = 1 MHz, I_E = 0$		18		pF

h_{FE} CLASSIFICATION

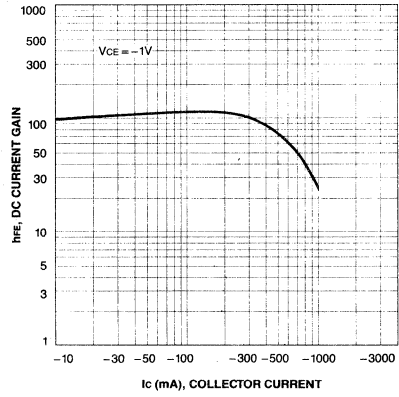
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



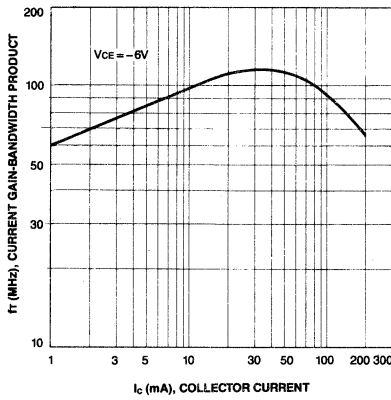
STATIC CHARACTERISTIC



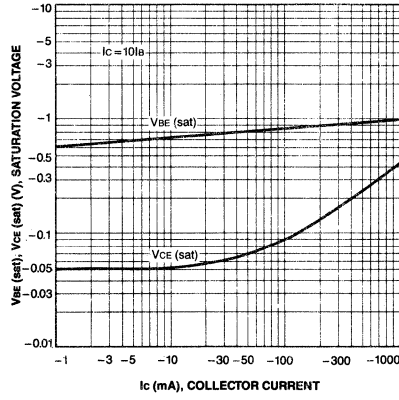
DC CURRENT GAIN



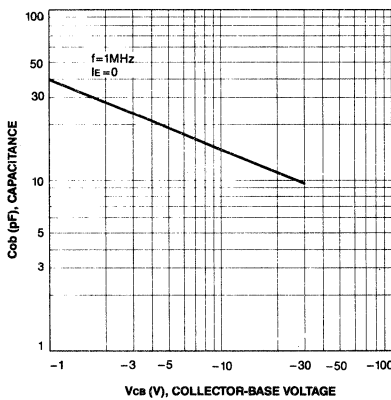
CURRENT GAIN-BANDWIDTH PRODUCT



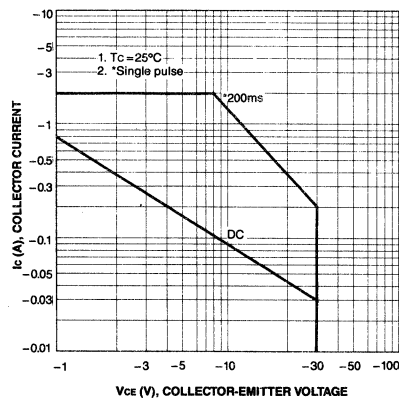
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



SAFE OPERATING AREA



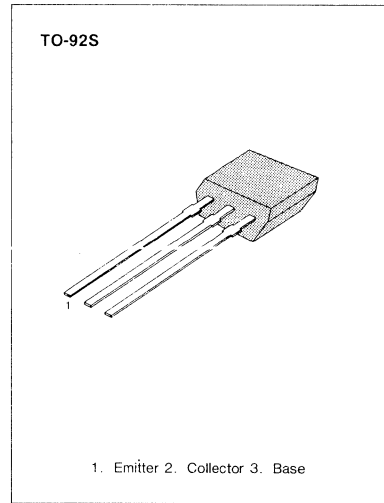
AUDIO FREQUENCY AMPLIFIER

• Complement to KSD1020

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5.0	V
Collector Current (DC)	I_C	-700	mA
* Collector Current (Pulse)	I_C	-1.0	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* $PW \leq 10$ ms, duty cycle ≤ 50 %



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-100	nA
* DC Current Gain	h_{FE1}	$V_{CE} = -1V, I_C = -100mA$	70	200	400	
	h_{FE2}	$V_{CE} = -1V, I_C = -700mA$	35	100		
* Base Emitter Voltage	V_{BE}	$V_{CE} = -6V, I_C = -10mA$	-600	-640	-700	mV
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -700mA, I_B = -70mA$		-0.25	-0.4	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -700mA, I_B = -70mA$		-0.95	-1.2	V
Output Capacitance	C_{OB}	$V_{CB} = -6V, I_E = 0, f = 1MHz$		17	40	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_E = 10mA$	50	160		MHz

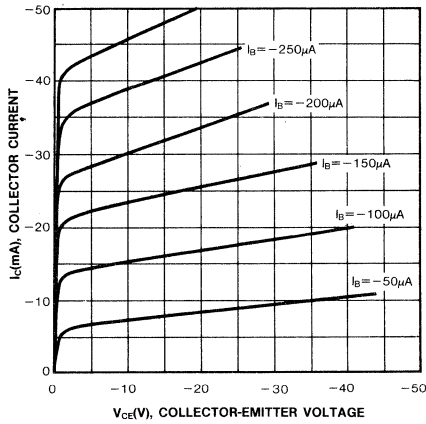
* Pulse Test: $PW \leq 350 \mu s$, Duty Cycle $\leq 2\%$ Pulsed

$h_{FE}(1)$ CLASSIFICATION

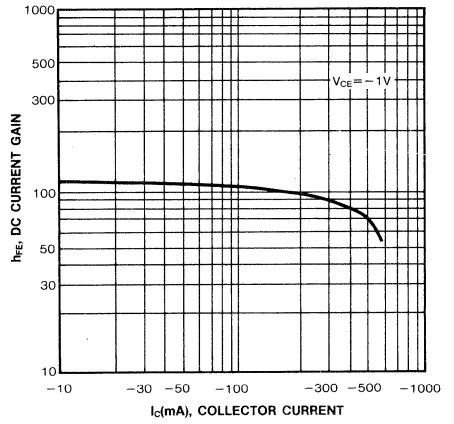
Classification	O	Y	G
$h_{FE}(1)$	70-140	120-240	200-400

3

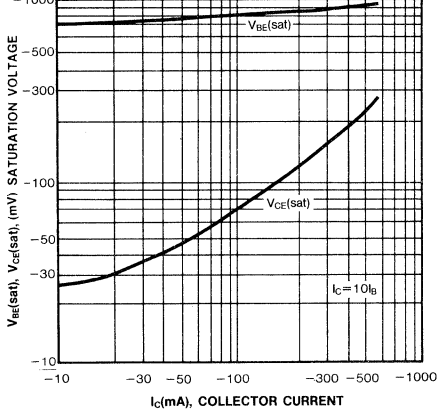
STATIC CHARACTERISTIC



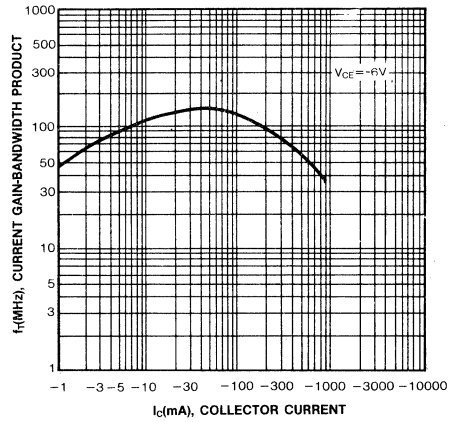
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

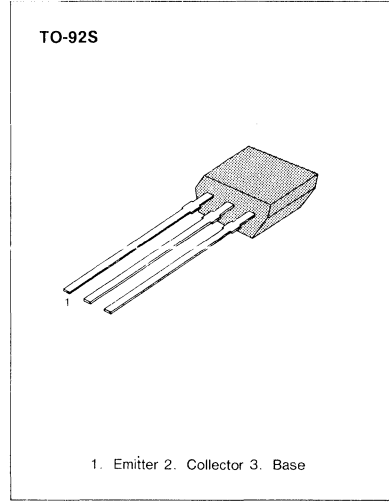


AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSD1021
- Collector Current $I_C = -1A$
- Collector Dissipation $P_C = 350mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-1.0	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



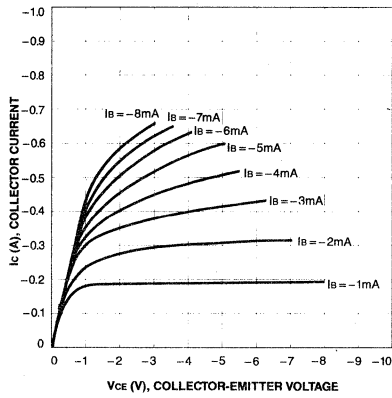
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = -1A, I_B = -0.1A$			-0.5	V
Base-Emitter Saturation Voltage	$V_{BE} (sat)$	$I_C = -1A, I_B = -0.1A$			-1.2	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$		110		MHz
Output Capacitance	Cob	$V_{CB} = -6V, f = 1 MHz, I_E = 0$		18		pF

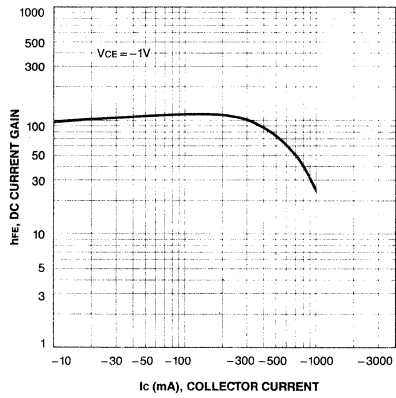
h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

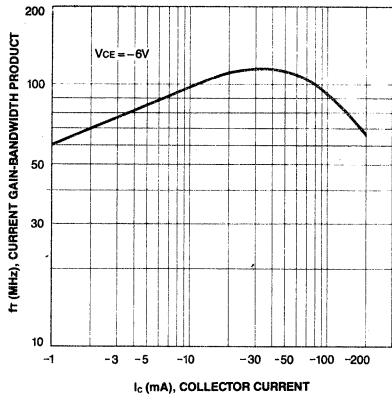
STATIC CHARACTERISTIC



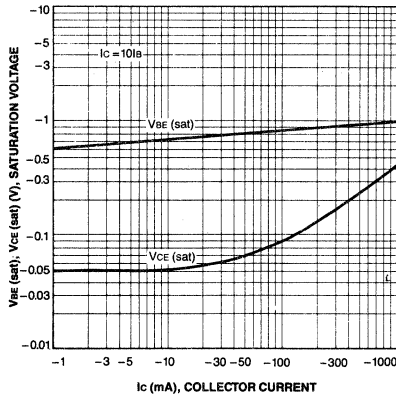
DC CURRENT GAIN



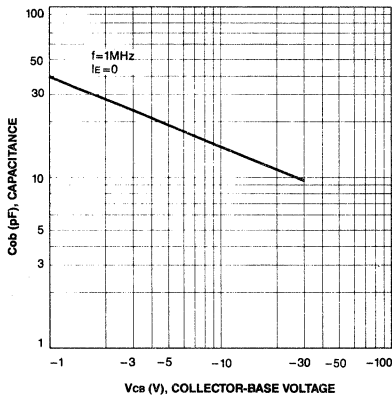
CURRENT GAIN-BANDWIDTH PRODUCT



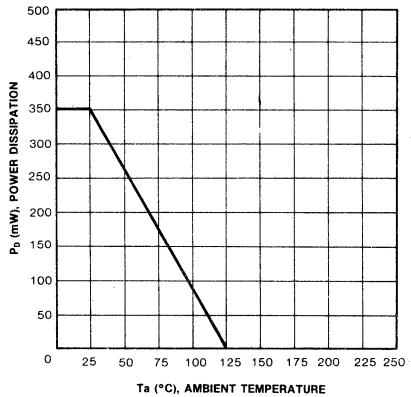
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

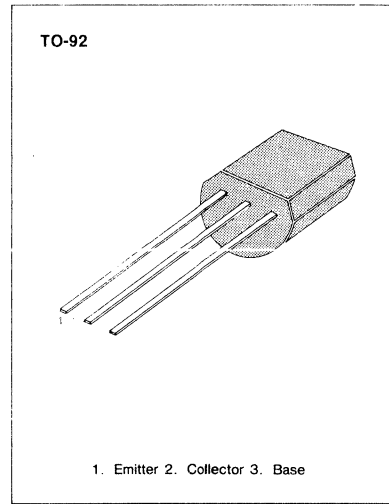


**AUDIO FREQUENCY POWER AMPLIFIER
MEDIUM SPEED SWITCHING**

• Complement to KSD1616/1616A

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSB1116	V _{CBO}	-60	V
: KSB1116A		-80	V
Collector-Emitter Voltage : KSB1116	V _{CEO}	-50	V
: KSB1116A		-60	V
Emitter-Base Voltage	V _{EBO}	-6	V
Collector Current (DC)	I _C	-1	A
*Collector Current (Pulse)	I _C	-2	A
Collector Dissipation	P _C	0.75	W
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



* PW≤10ms, Duty Cycle≤50%

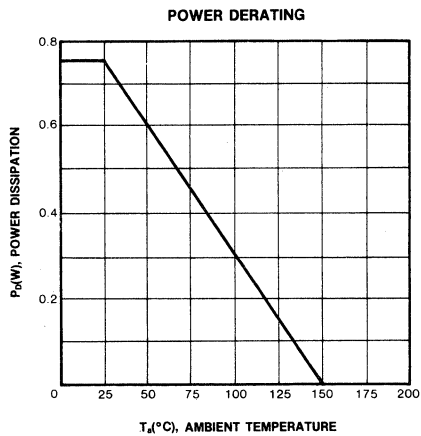
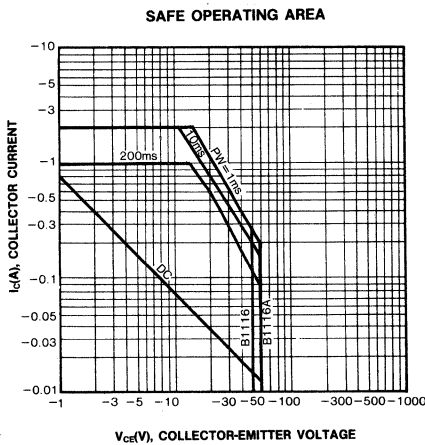
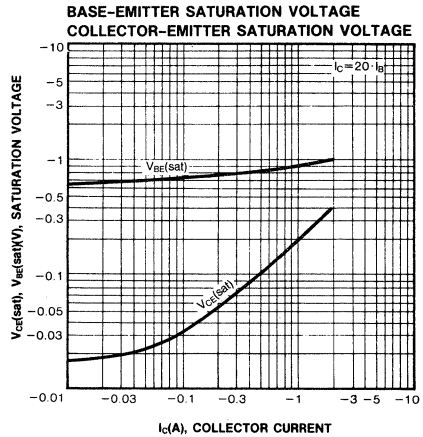
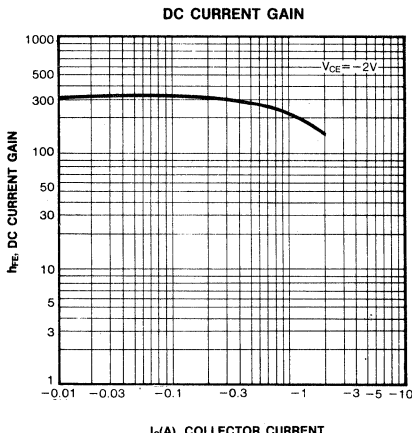
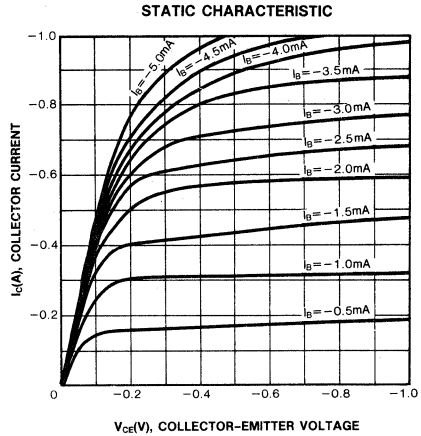
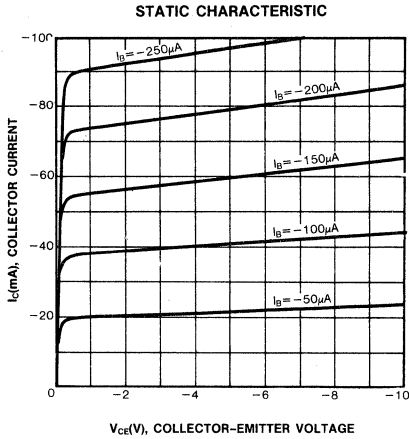
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} =-60V, I _E =0			-100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =-6V, I _C =0			-100	nA
*DC Current Gain : KSB1116	h _{FE1}	V _{CE} =-2V, I _C =-100mA	135		600	
: KSB1116A			135		400	
	h _{FE2}	V _{CE} =-2V, I _C =-1A	81			
* Base Emitter On Voltage	V _{BE} (on)	V _{CE} =-2V, I _C =-50mA	-600		-700	mV
* Collector Emitter Saturation Voltage	V _{CE} (sat)	I _C =-1A, I _B =-50mA			-0.2	V
* Base Emitter Saturation Voltage	V _{BE} (sat)	I _C =-1A, I _B =-50mA			-0.9	V
Output Capacitance	C _{ob}	V _{CB} =-10V, I _E =0 f=1MHz		25		pF
Current Gain Bandwidth Product	f _T	V _{CE} =-2V, I _C =-100mA	70	120		MHz
Turn On Time	t _{on}	V _{CC} =-10V, I _C =-100mA		0.07		μs
Storage Time	t _s	I _{B1} =-I _{B2} =-10mA		0.7		μs
Fall Time	t _f	V _{BE} (off)= 2~3V		0.07		μs

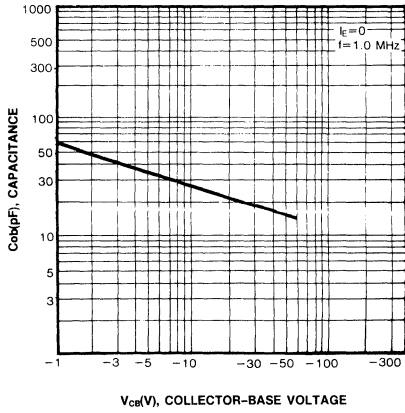
* Pulse Test: PW≤350μs, Duty Cycle≤2% Pulsed

h_{FE}(1) CLASSIFICATION

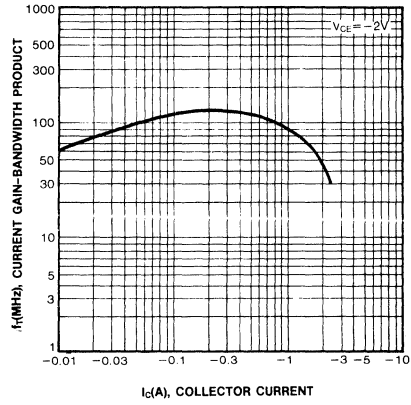
Classification	Y	G	L
h _{FE} (1)	135-270	200-400	300-600



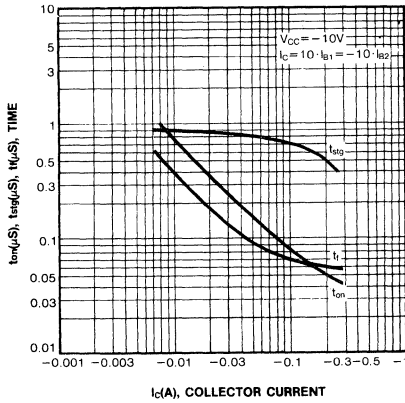
COLLECTOR OUTPUT CAPACITANCE



CURRENT GAIN-BANDWIDTH PRODUCT



SWITCHING TIME



3

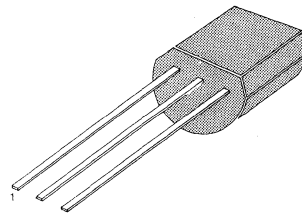
AM FREQUENCY CONVERTER IF AMPLIFIER

- Current Gain Bandwidth Product $f_T = 100\text{MHz}$ (Typ)
- Complement to KSA542

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	30	V
Collector-Emitter Voltage	V_{CE0}	25	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

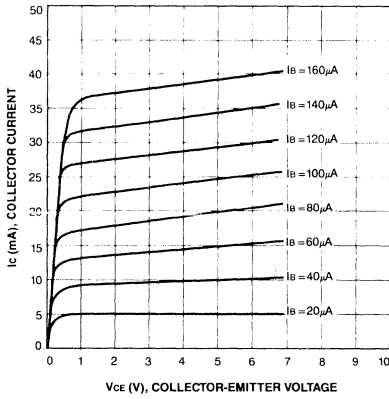
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 10\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	40		1000	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.6	4.4	pF

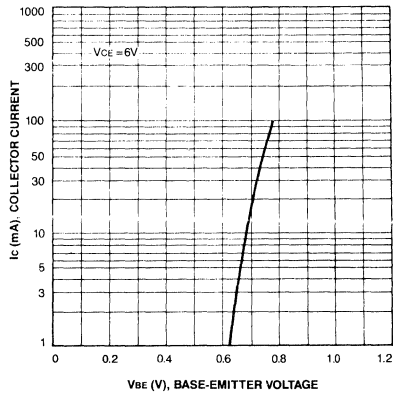
h_{FE} CLASSIFICATION

Classification	R	O	Y	G	L	V
h_{FE}	40-80	70-140	120-240	200-400	350-700	600-1000

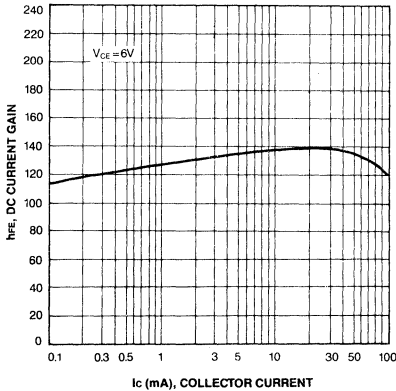
STATIC CHARACTERISTIC



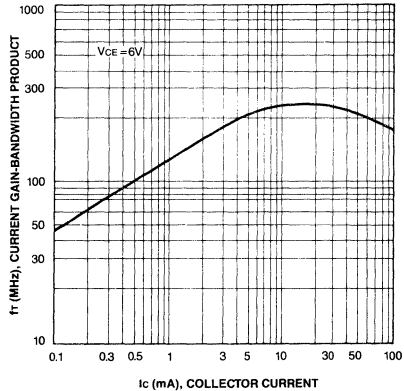
BASE-EMITTER ON VOLTAGE



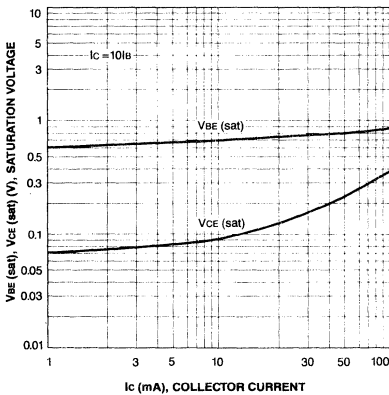
DC CURRENT GAIN



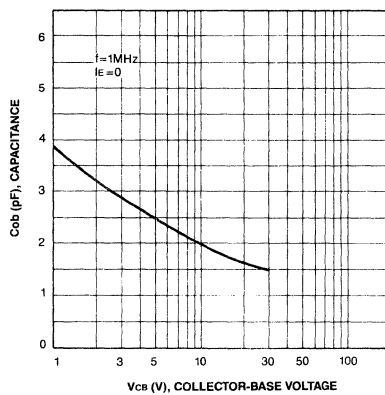
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



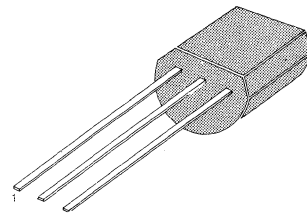
TV FINAL PICTURE IF AMPLIFIER APPLICATIONS

- $G_{pe}=33dB$ (Typ) ($f=45MHz$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92

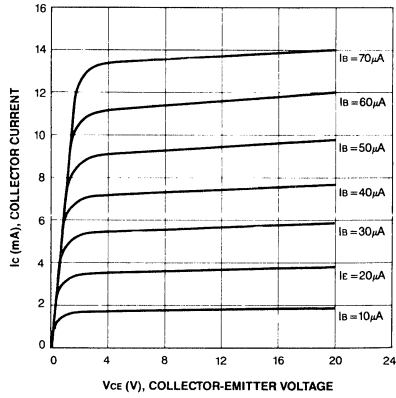


1. Emitter 2. Base 3. Collector

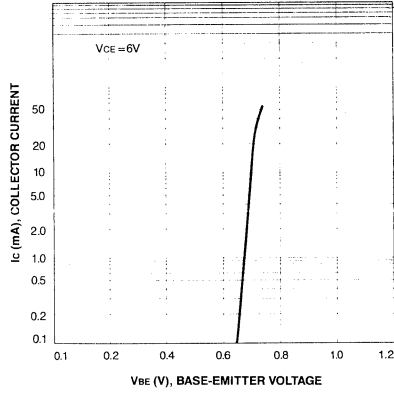
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=5mA, I_B=0$	25			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=3V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=12.5V, I_C=12.5mA$	20		200	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=15mA, I_B=1.5mA$			0.2	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=15mA, I_B=1.5mA$			1.5	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0, f=1MHz$	0.8		2	pF
Collector-Base Time Constant	$C_c'r_{bb}'$	$V_{CB}=10V, I_E=-1mA$ $f=30MHz$			25	ps
Current Gain-Bandwidth Product	f_T	$V_{CE}=12.5V, I_C=12.5mA$	300			MHz
Power Gain	G_{pe}	$V_{CC}=12.5V, f=45MHz$ $I_E=-12.5mA$	28		36	dB

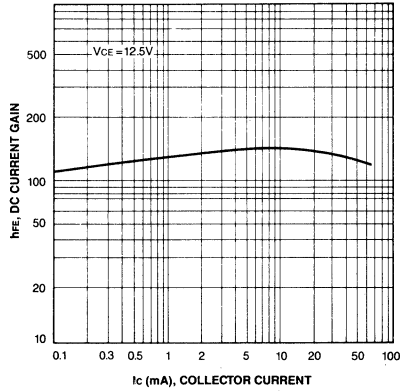
STATIC CHARACTERISTIC



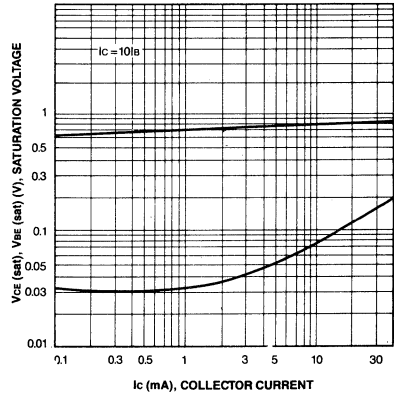
BASE-EMITTER ON VOLTAGE



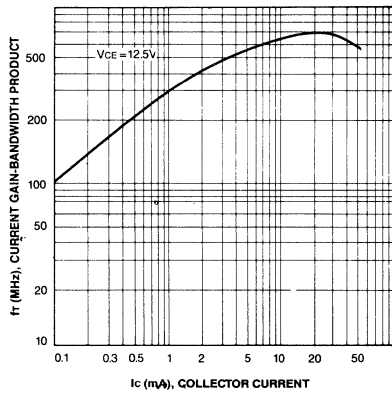
DC CURRENT GAIN



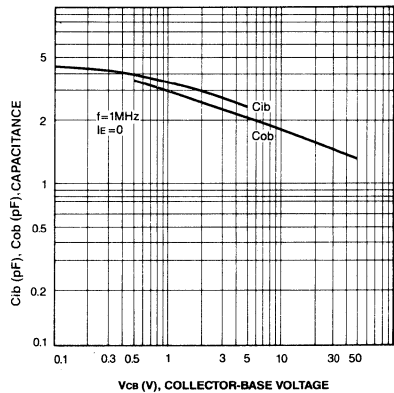
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE



3

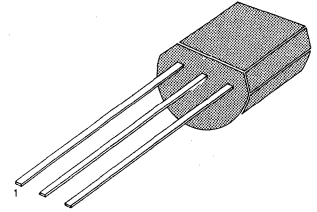
LOW FREQUENCY AMPLIFIER
HIGH FREQUENCY OSCILLATOR

- Complement to KSA539
- Collector-Base Voltage $V_{CBO} = 60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

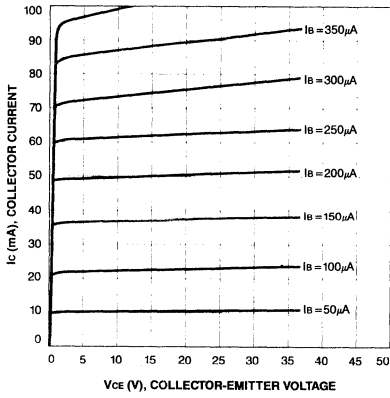
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 45V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 50mA$	40		400	
Base-Emitter On Voltage	$V_{BE (on)}$	$V_{CE} = 10V, I_C = 10mA$	0.6	0.65	0.9	V
Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_C = 150mA, I_B = 15mA$		0.15	0.4	V
Base-Emitter Saturation Voltage	$V_{BE (sat)}$	$I_C = 150mA, I_B = 15mA$		0.83	1.1	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 10mA$	100	200		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		4		pF

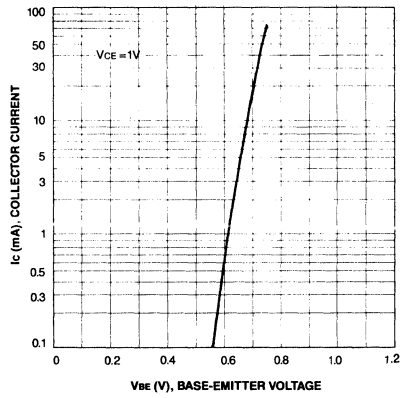
h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

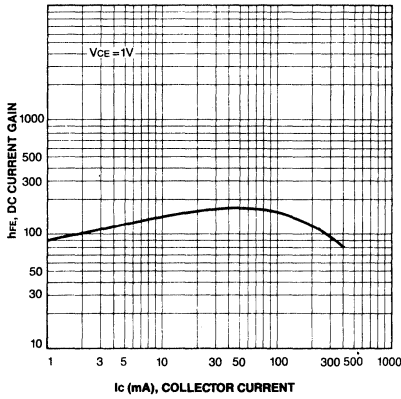
STATIC CHARACTERISTIC



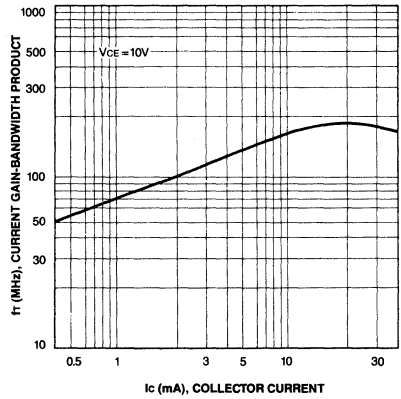
BASE-EMITTER ON VOLTAGE



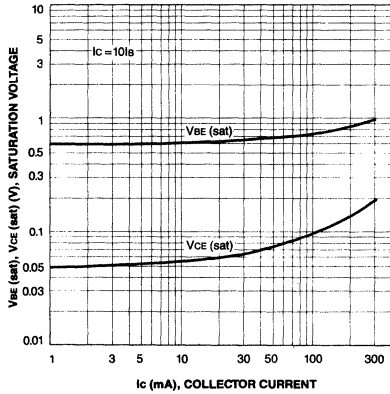
DC CURRENT GAIN



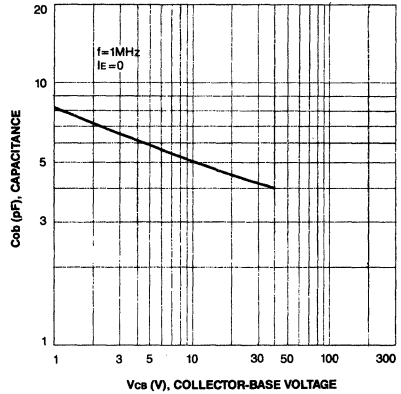
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

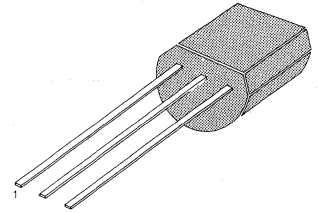
FM RADIO RF AMP, MIX, CONV, OSC, IF AMP

- High Current Gain Bandwidth Product $f_T = 250\text{MHz}$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	35	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$

TO-92



1 Emitter 2. Base 3. Collector

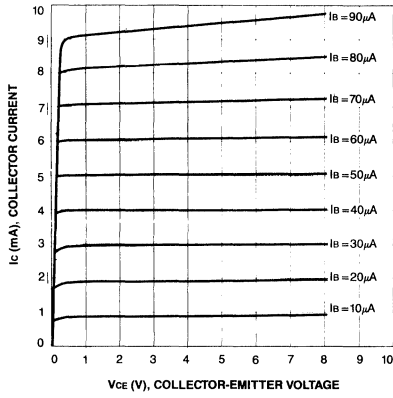
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	100	250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.2	pF

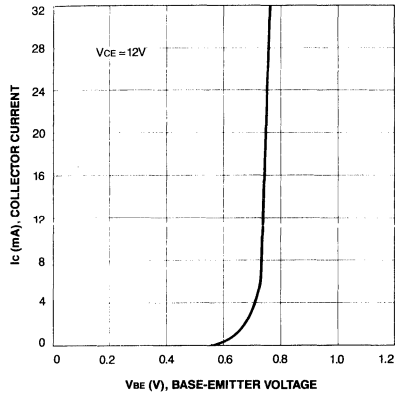
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

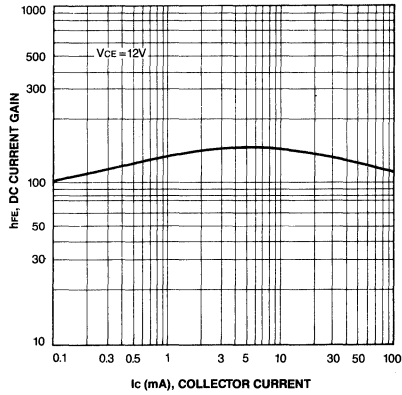
STATIC CHARACTERISTIC



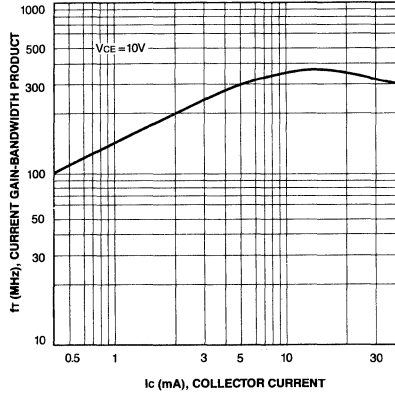
BASE-EMITTER ON VOLTAGE



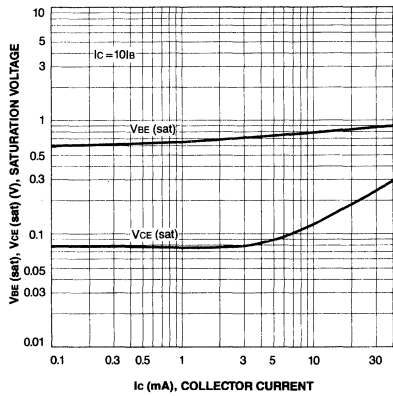
DC CURRENT GAIN



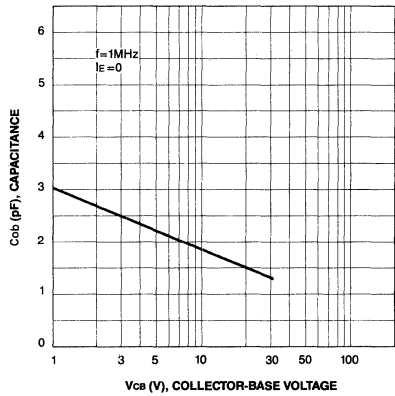
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

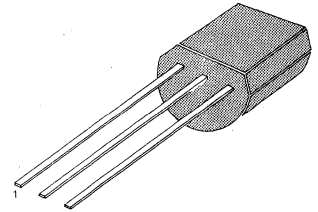
FM/AM RADIO RF AMP, CONV, OSC, IF AMP

- Current-Gain-Bandwidth Product $f_T = 200\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	35	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

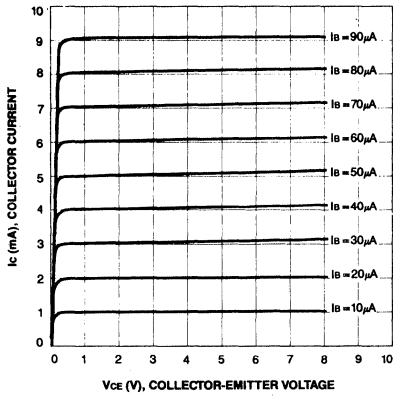
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CB0}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EB0}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		400	
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	80	200		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.5	pF

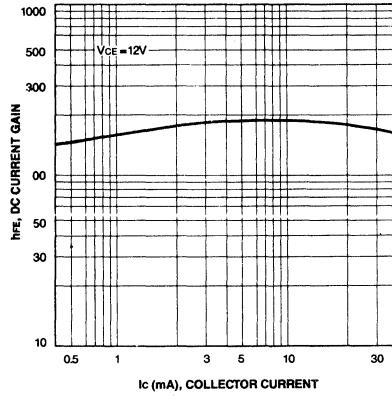
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

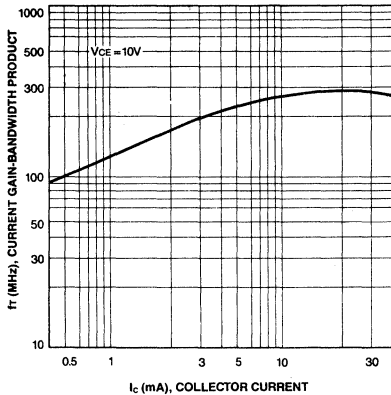
STATIC CHARACTERISTIC



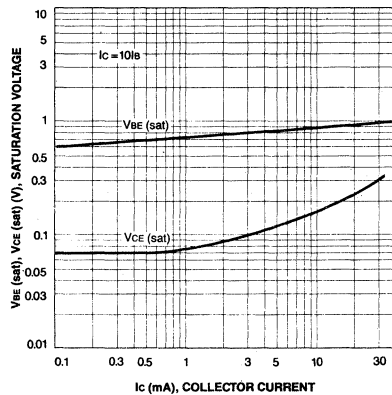
DC CURRENT GAIN



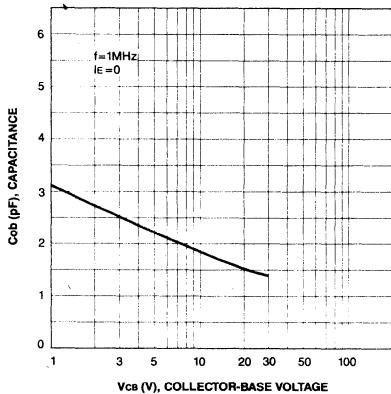
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



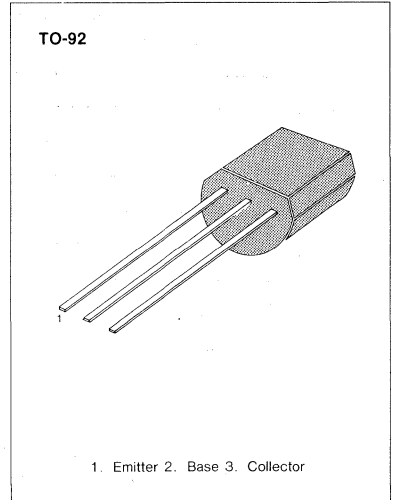
3

LOW FREQUENCY, LOW NOISE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = 30V$
- Low Noise Level $NL = 50mV$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



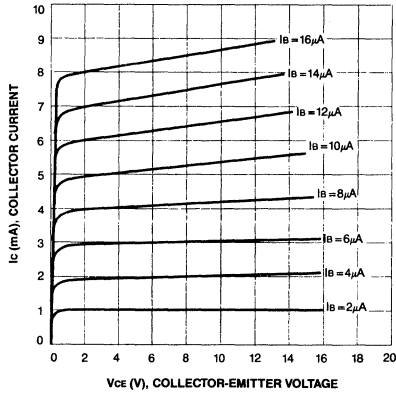
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 3V, I_C = 0.5mA$	120		1000	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 20mA, I_B = 2mA$		0.1	0.2	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 3V, I_C = 0.5mA$		0.62	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 3V, I_C = 1mA$		100		MHz
Noise Level	NL	$V_{CC} = 12V, I_C = 0.1mA$ $R_S = 25K\Omega$ $A_V = 80dB, (f = 1KHz)$		30	50	mV

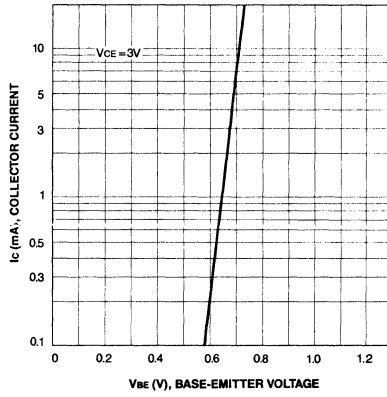
h_{FE} CLASSIFICATION

Classification	Y	G	L	V
h_{FE}	120-240	200-400	350-700	600-1000

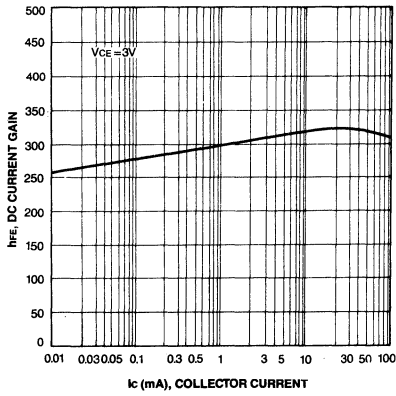
STATIC CHARACTERISTIC



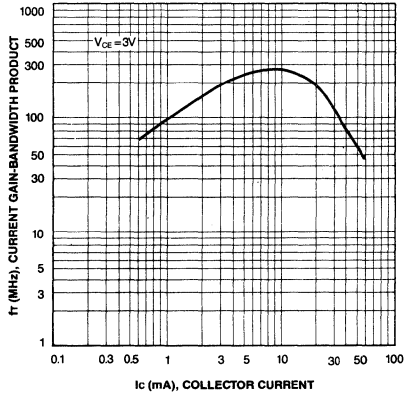
BASE-EMITTER ON VOLTAGE



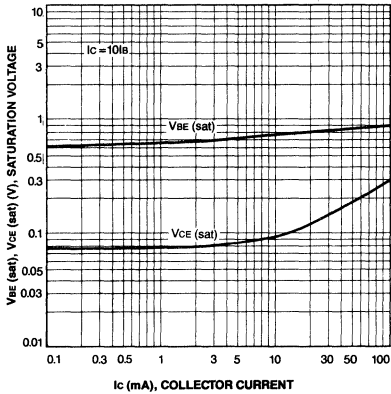
DC CURRENT GAIN



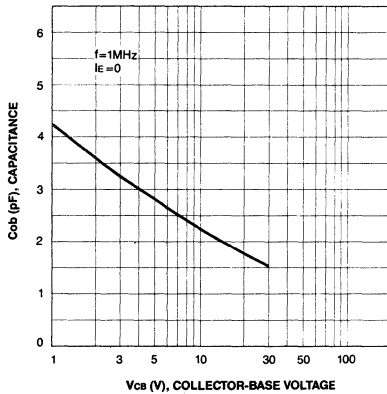
CURRENT GAIN-BANDWIDTH PRODUCT

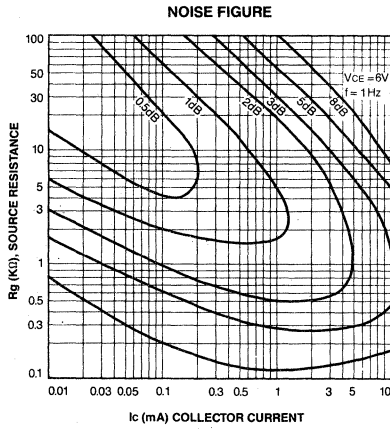
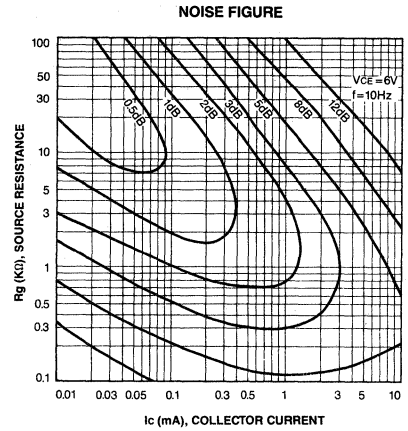
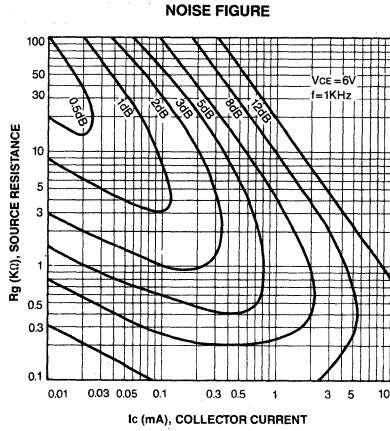


BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



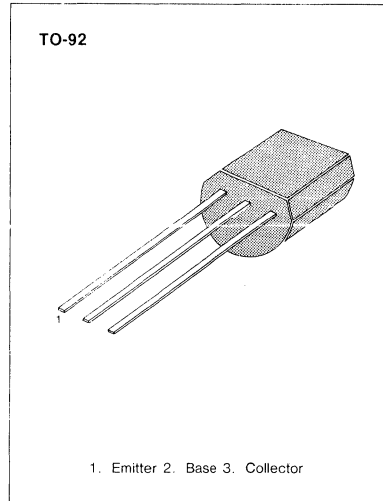


**AUDIO FREQUENCY AMPLIFIER
HIGH FREQUENCY OSC.**

- Complement to KSA733
- Collector-Base Voltage $V_{CBO} = 60V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



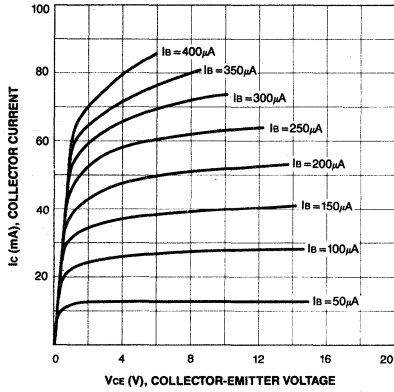
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1.0mA$	40		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100mA, I_B = 10mA$		0.15	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 10mA$		300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0$ $f = 1MHz$		2.5		pF
Noise Figure	NF	$V_{CE} = 6V, I_E = -0.5mA$ $f = 1KHz, R_s = 500\Omega$		4.0		dB

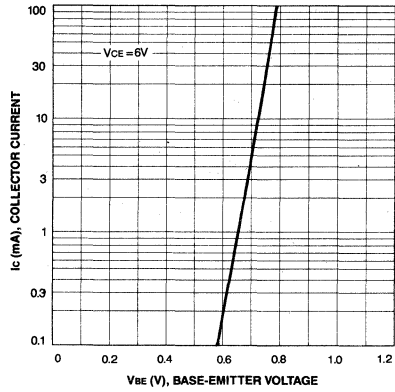
h_{FE} CLASSIFICATION

Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700

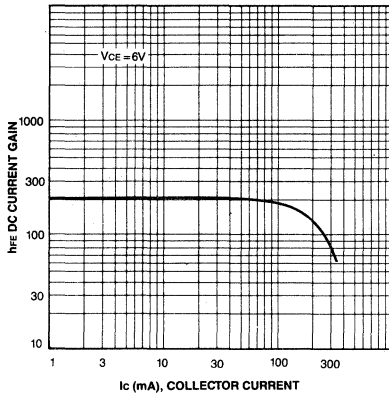
STATIC CHARACTERISTIC



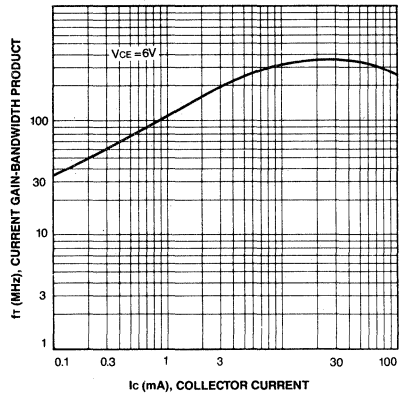
TRANSFER CHARACTERISTIC



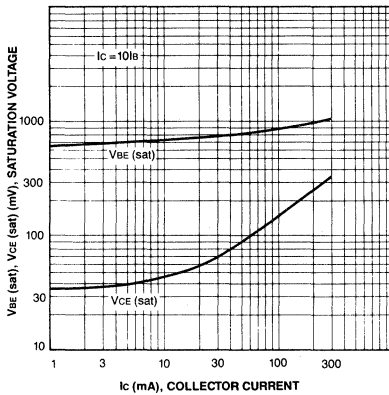
DC CURRENT GAIN



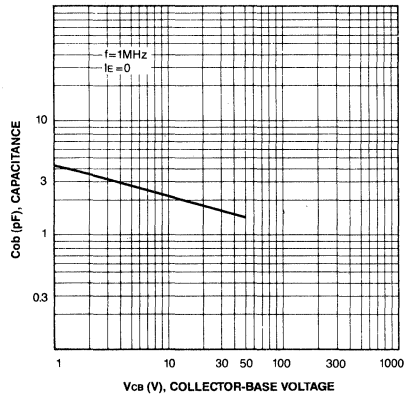
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

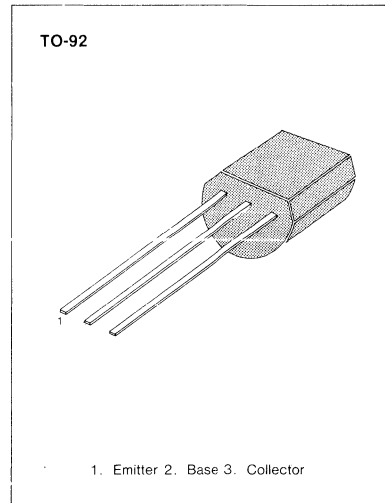


LOW FREQUENCY AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSA708
- High Collector-Base Voltage $V_{CBO}=80V$
- Collector Current $I_C=700mA$
- Collector Dissipation $P_C=800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



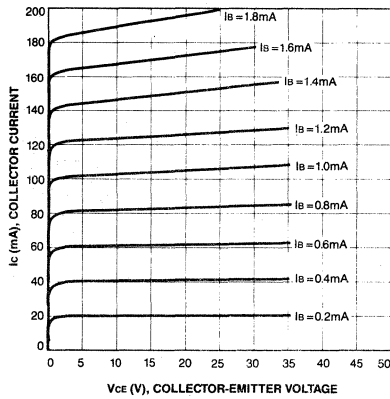
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu A, I_C=0$	8			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=60V, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=5V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=2V, I_C=50mA$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=500mA, I_B=50mA$		0.2	0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=500mA, I_B=50mA$		0.86	1.1	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=50mA$	30	50		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		8		pF

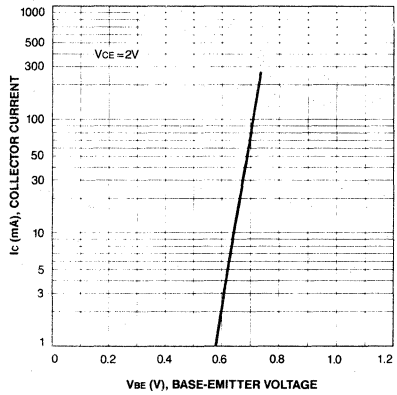
h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

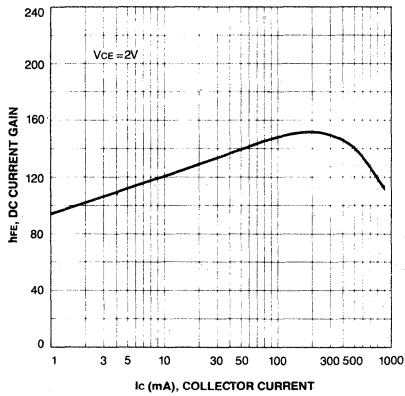
STATIC CHARACTERISTIC



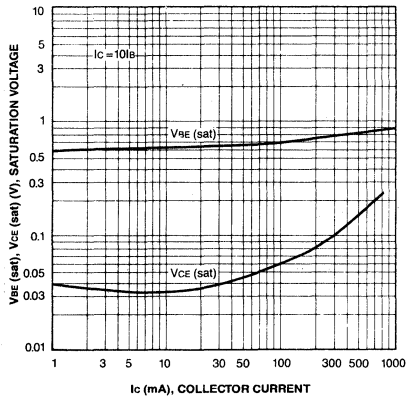
BASE-EMITTER ON VOLTAGE



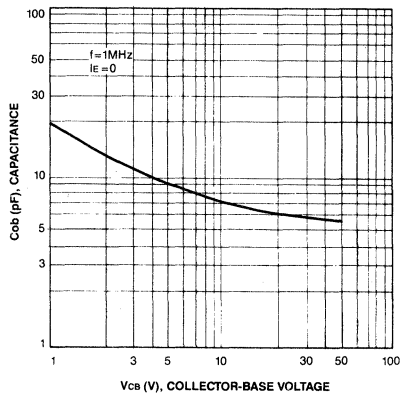
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



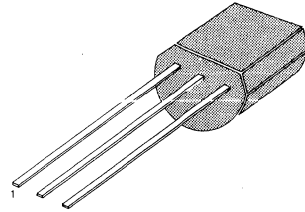
HIGH VOLTAGE AMPLIFIER

- High Collector-Base Voltage $V_{CBO} = 160V$
- Collector Current $I_C = 700mA$
- Collector Dissipation $P_C = 800mW$
- Complement to KSA709

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	140	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

3

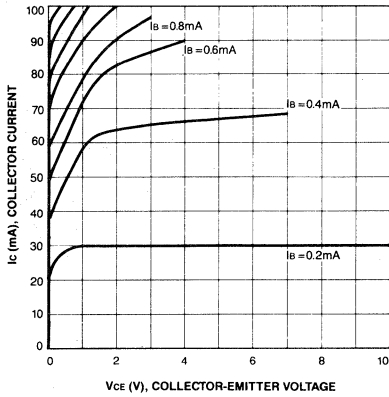
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	160			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	8			V
Collector Cut-off Current (Continuous)	I_{CBO}	$V_{CB} = 60V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 2V, I_C = 50mA$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 200mA, I_B = 20mA$		0.2	0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 200mA, I_B = 20mA$		0.86	1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 50mA$	30	50		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		8		pF

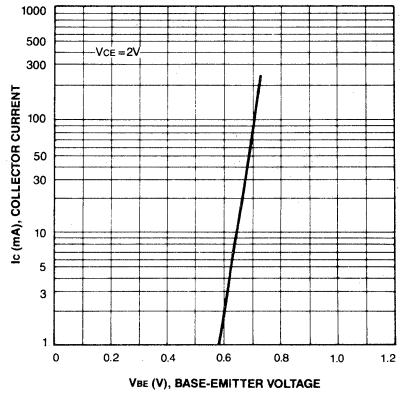
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

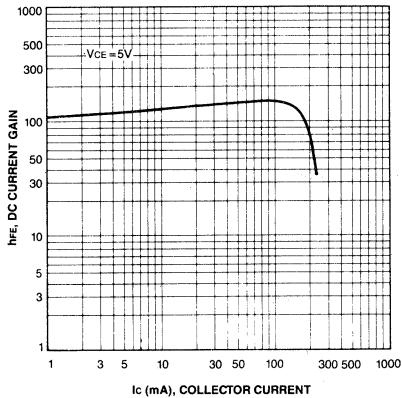
STATIC CHARACTERISTIC



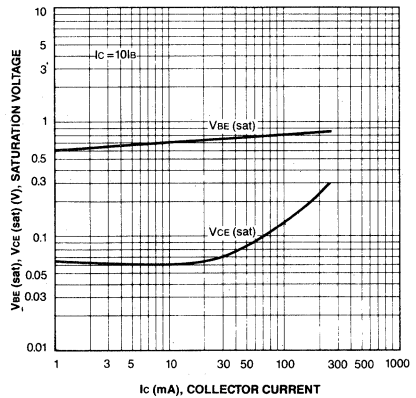
BASE-EMITTER ON VOLTAGE



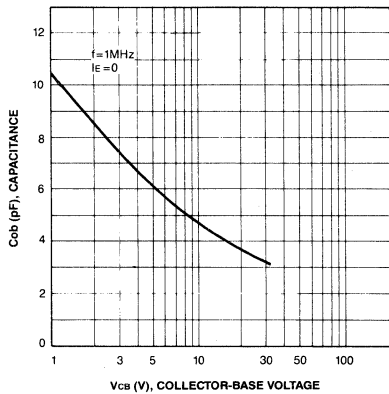
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

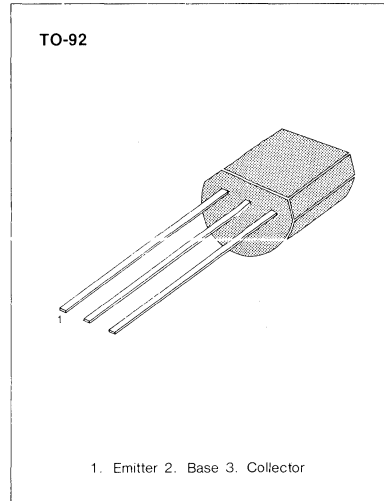


TV 1ST, 2ND PICTURE IF AMPLIFIER
(FORWARD AGC)

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$
- High Power Gain $G_{pe} = 24\text{dB}$ (Typ) at 45MHz

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

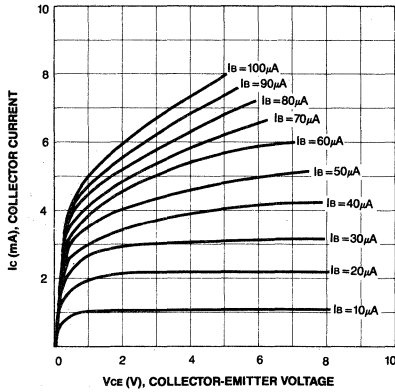
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		240	
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 3\text{mA}$	400	700		MHz
Reverse Transfer Capacitance	C_{re}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		0.6		pF
Power Gain	G_{pe}	$V_{CE} = 10\text{V}, I_E = -3\text{mA}$ $f = 45\text{MHz}$	20	24		dB
AGC Voltage	V_{AGC}	$G_{pe} = -30\text{dB}$ $f = 45\text{MHz}$	4.4	5.2	6.0	V

h_{FE} CLASSIFICATION

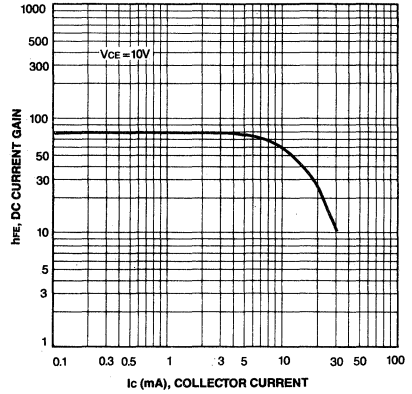
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



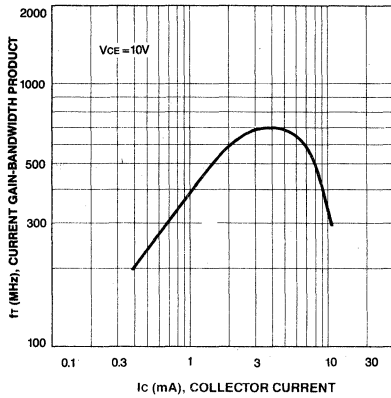
STATIC CHARACTERISTIC



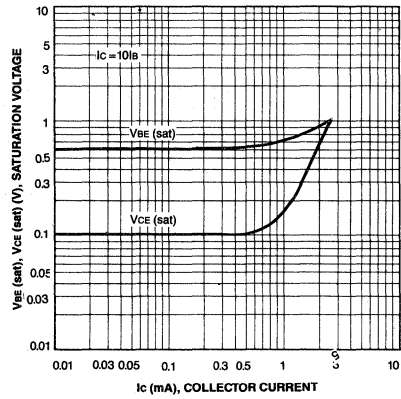
DC CURRENT GAIN



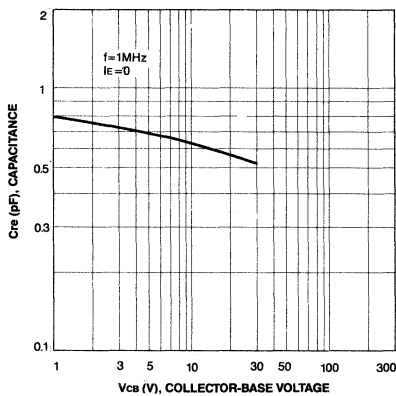
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



REVERSE CAPACITANCE

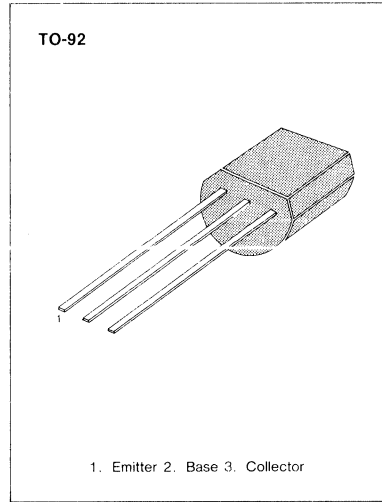


LOW FREQUENCY LOW NOISE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = 50V$
- Low Noise Level $NL = 40mV$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

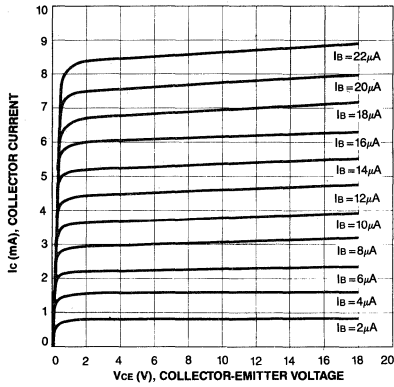
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 3V, I_C = 0.5mA$	120		1000	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 20mA, I_B = 2mA$		0.1	0.2	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 3V, I_C = 0.5mA$		0.62	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 3V, I_C = 1mA$	50	100		MHz
Noise Level	NL	$V_{CE} = 12V, I_E = -0.1mA$ $R_S = 25K\Omega$ $A_V = 80dB, (f = 1KHz)$		27	40	mV

h_{FE} CLASSIFICATION

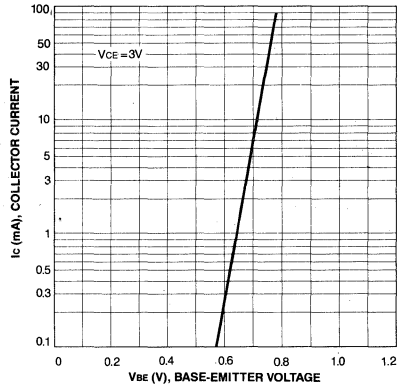
Classification	Y	G	L	V
h_{FE}	120-240	200-400	350-700	600-1000



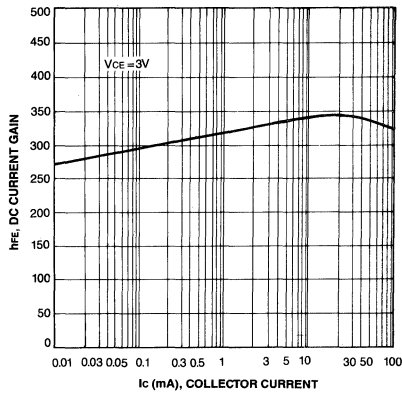
STATIC CHARACTERISTIC



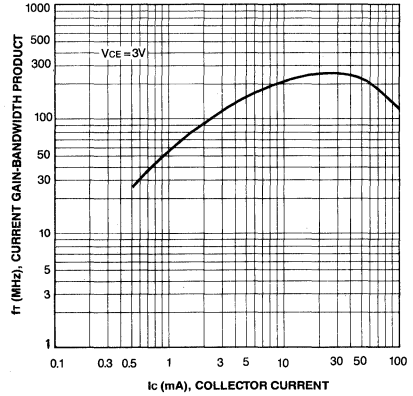
BASE-EMITTER ON VOLTAGE



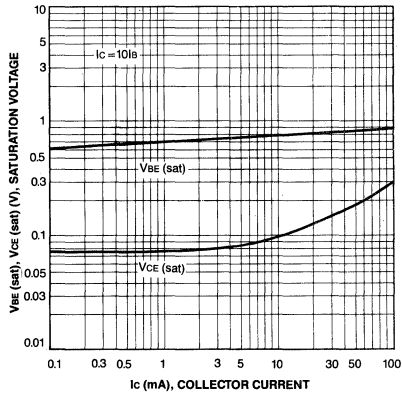
DC CURRENT GAIN



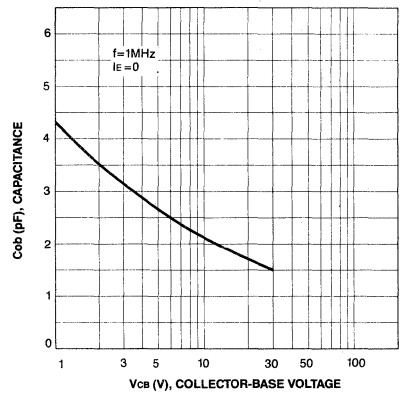
CURRENT GAIN-BANDWIDTH PRODUCT



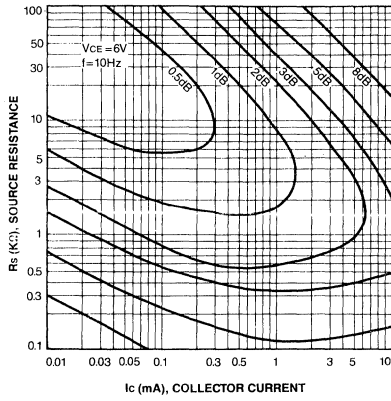
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



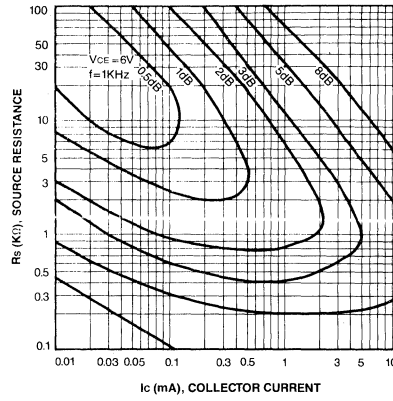
OUTPUT CAPACITANCE



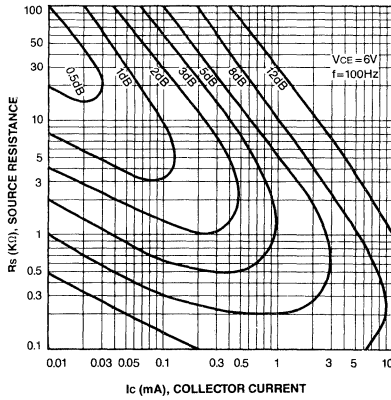
NOISE FIGURE



NOISE FIGURE



NOISE FIGURE



3

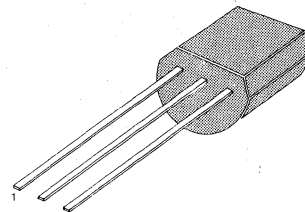
TV VHF TUNER RF AMPLIFIER (FORWARD AGC)

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$ (Typ)
- Low Noise Figure $NF = 3.0\text{dB}$ (Max) at $f = 200\text{MHz}$
- Low Reverse Transfer Capacitance $C_{re} = 0.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	30	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Base 2. Emitter 3. Collector

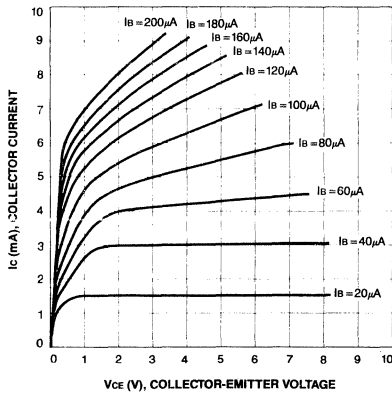
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		180	
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 3\text{mA}$	400	700		MHz
Reverse Transfer Capacitance	C_{re}	$f = 1\text{MHz}, V_{CB} = 10\text{V}, I_E = 0$		0.35	0.5	pF
Power Gain	G_{pe}	$f = 200\text{MHz}, I_E = -3\text{mA}, R_S = 50\Omega, V_{CE} = 10\text{V}$	20	24		dB
AGC Current	I_{AGC}	I_E at $G_{pe} = -30\text{dB}, f = 200\text{MHz}$		-10	-12	mA
Noise Figure	NF	$f = 200\text{MHz}, I_E = -3\text{mA}, V_{CE} = 10\text{V}, R_S = 50\Omega$		2.0	3.0	dB

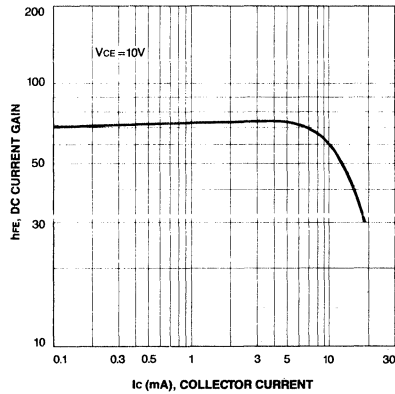
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	60-140	90-180

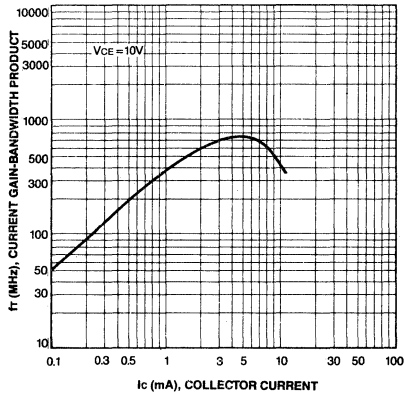
STATIC CHARACTERISTIC



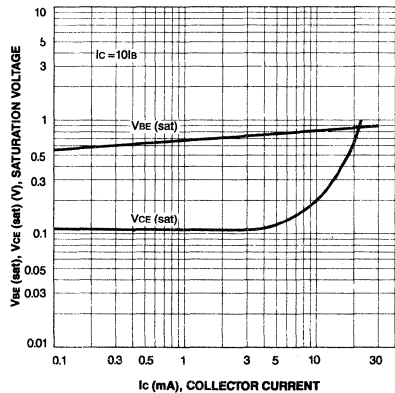
DC CURRENT GAIN



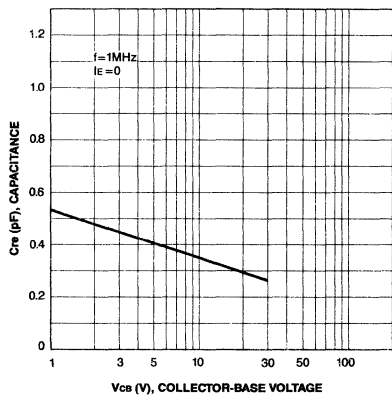
CURRENT GAIN-BANDWIDTH PRODUCT



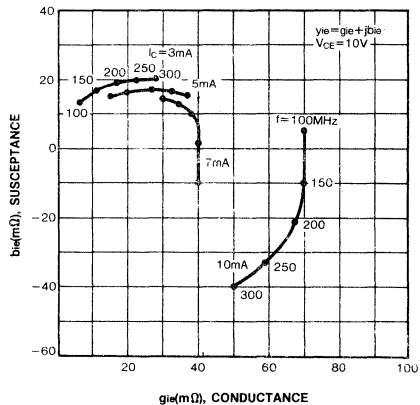
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



REVERSE CAPACITANCE

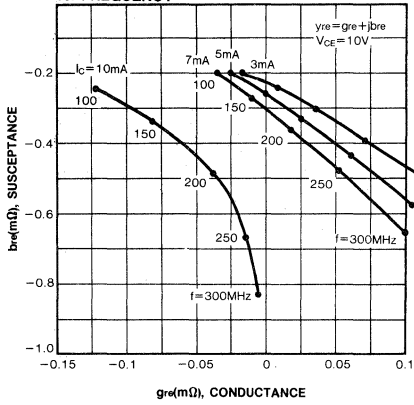


INPUT ADMITTANCE (yie) vs. FREQUENCY

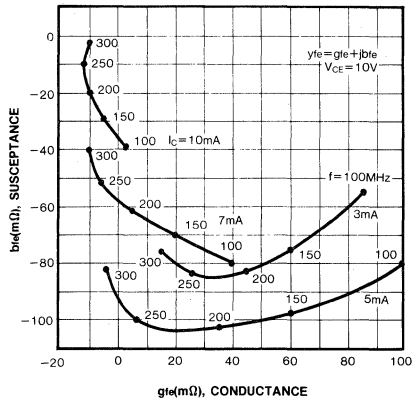


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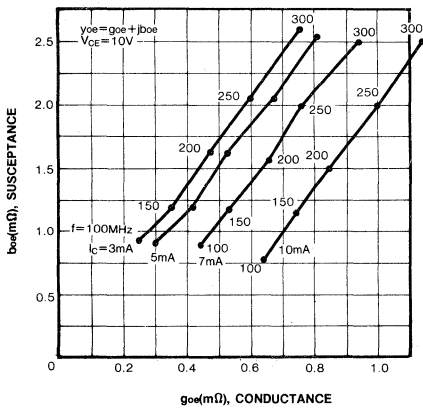
REVERSE TRANSFER ADMITTANCE (y_{re}) vs. FREQUENCY



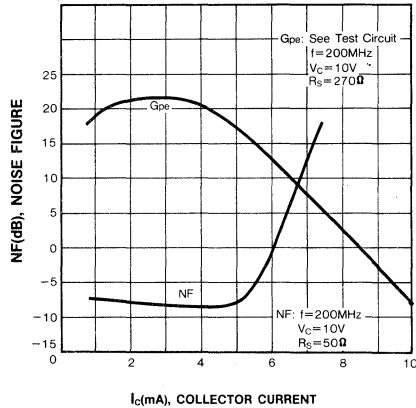
FORWARD TRANSFER ADMITTANCE (y_{fe}) vs. FREQUENCY



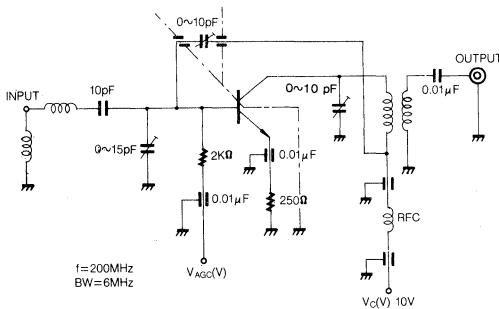
OUTPUT ADMITTANCE (y_{oe}) vs. FREQUENCY



POWER GAIN AND NOISE FIGURE vs. COLLECTOR CURRENT



POWER GAIN AND NOISE FIGURE TEST CIRCUIT



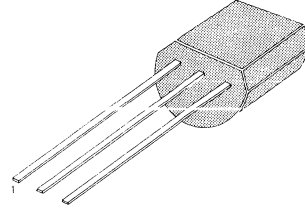
TV VHF TUNER MIXER

- High Current Gain Bandwidth Product $f_T=700\text{MHz}$ (Typ)
- High Power Gain $G_{pe}=20\text{dB}$ (Min) at $f=200\text{MHz}$
- Low Noise Figure $NF=3.5\text{dB}$ (Max) at $f=200\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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1. Base 2. Emitter 3. Collector

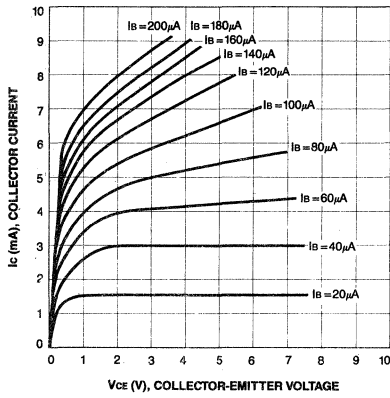
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=5\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=2\text{mA}$	40		180	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=3\text{mA}$	400	700		MHz
Reverse Transfer Capacitance	C_{re}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		0.35	0.5	pF
Power Gain	G_{pe}	$V_{CE}=6\text{V}, I_E=-3\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$	20			dB
Noise Figure	NF	$V_{CE}=6\text{V}, I_E=-3\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$			3.5	dB

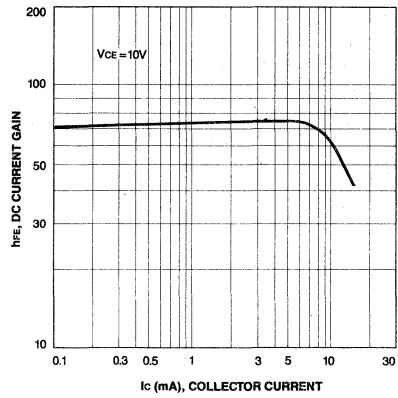
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	60-140	90-180

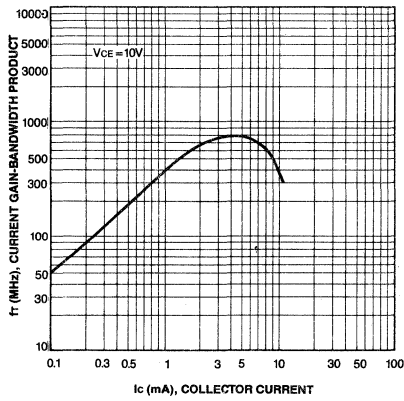
STATIC CHARACTERISTIC



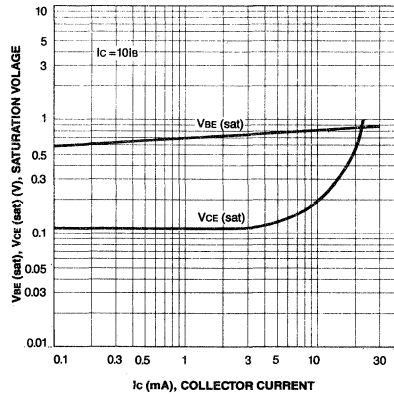
DC CURRENT GAIN



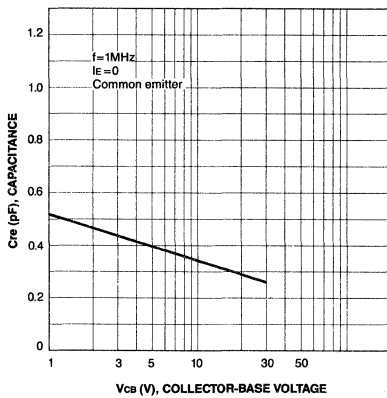
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



REVERSE CAPACITANCE

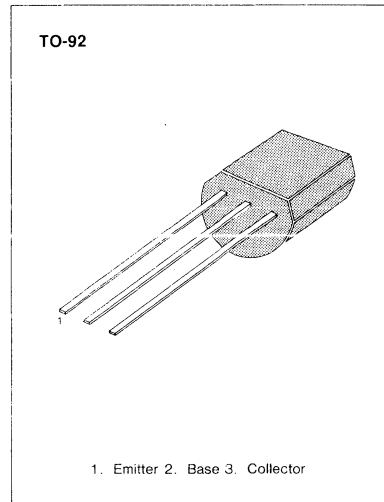


TV VHF TUNER OSCILLATOR

- High Current-Gain Bandwidth Product $f_T = 600\text{MHz}$ (Min)
- Output Capacitance $C_{ob} = 1.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

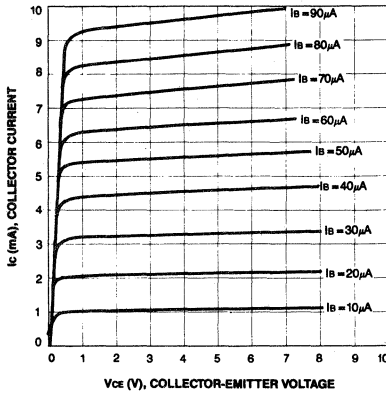
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 12\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	V
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.5	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	600	1100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, f = 1\text{MHz}, I_E = 0$			1.5	pF

h_{FE} CLASSIFICATION

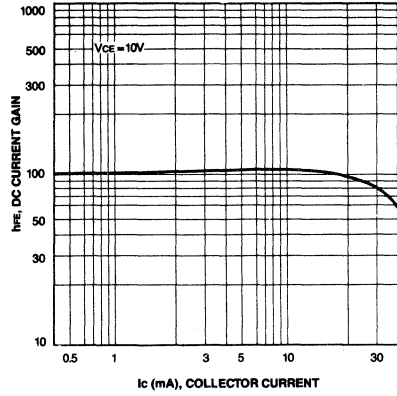
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



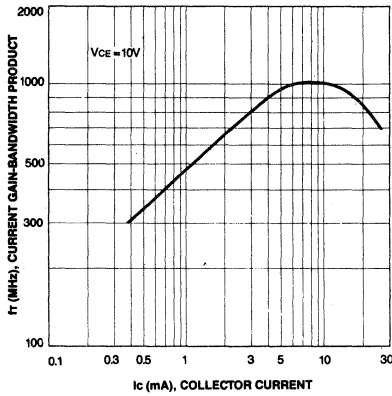
STATIC CHARACTERISTIC



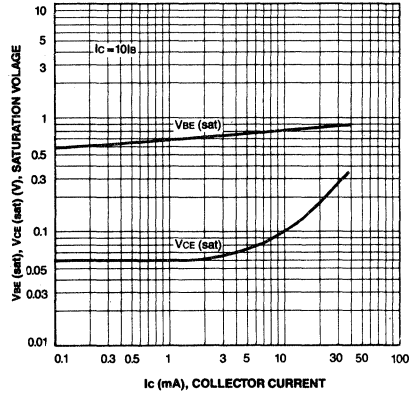
DC CURRENT GAIN



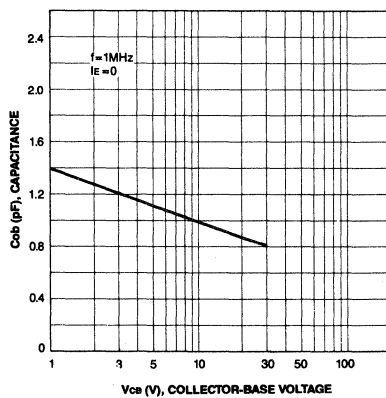
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

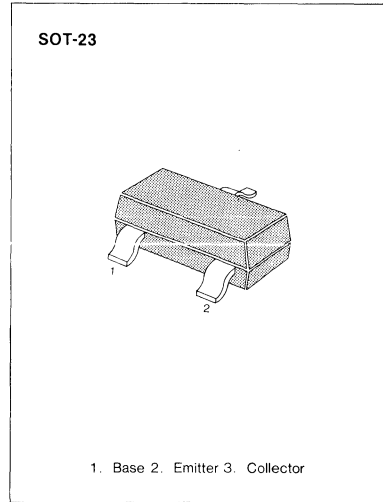


LOW FREQUENCY AMPLIFIER
HIGH FREQUENCY OSC

• Complement to KSA812

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



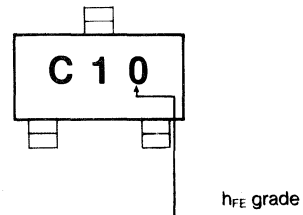
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 60\text{V}, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	90	200	600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100\text{mA}, I_B = 10\text{mA}$		0.15	0.3	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 100\text{mA}, I_B = 10\text{mA}$		0.86	1.0	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 1\text{mA}, V_{CE} = 6\text{V}$	0.55	0.62	0.65	V
Current Gain-Bandwidth Product	f_T	$I_E = 10\text{mA}, V_{CE} = 6\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		3		pF

h_{FE} CLASSIFICATION

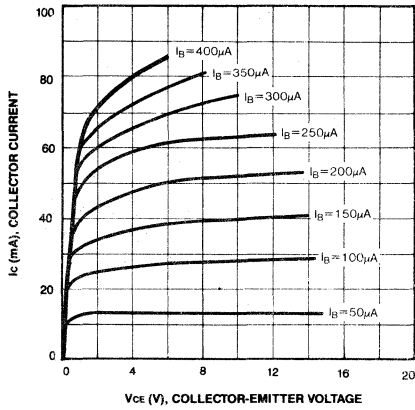
Classification	O	Y	G	L
h_{FE}	90-180	135-270	200-400	300-600

Marking

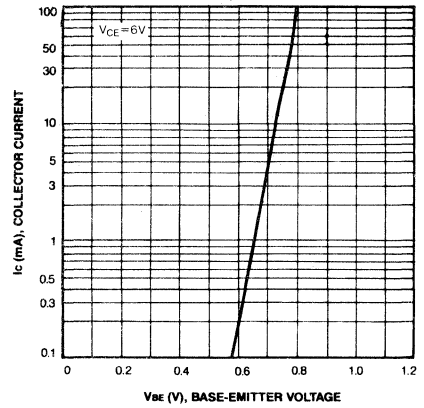


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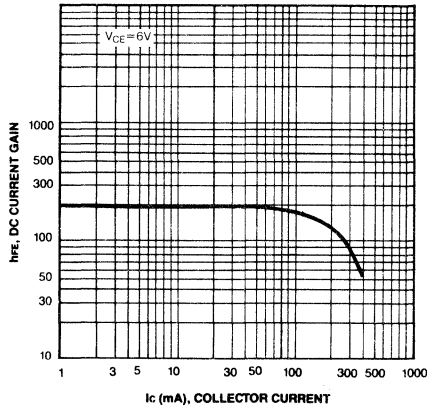
STATIC CHARACTERISTIC



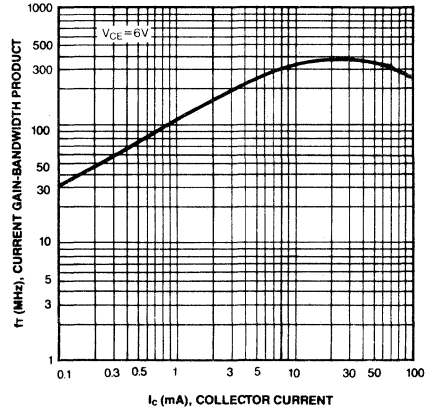
TRANSFER CHARACTERISTIC



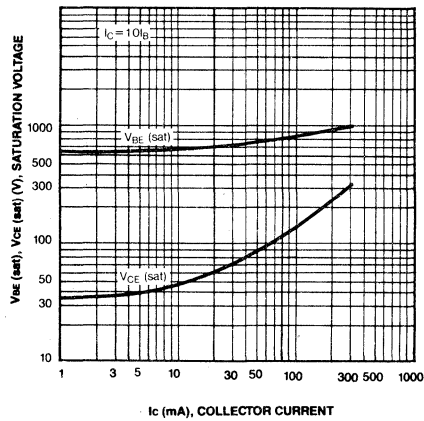
DC CURRENT GAIN



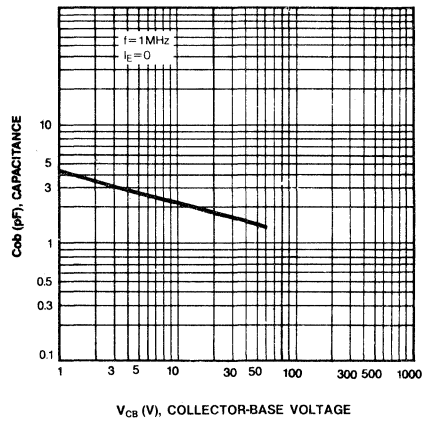
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



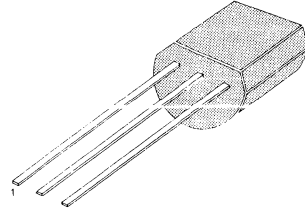
TV PIF AMPLIFIER, FM TUNER RF AMPLIFIER, MIXER, OSCILLATOR

- High Current-Gain-Bandwidth Product $f_T = 600\text{MHz}$ (Typ)
- High Power Gain $G_{pe} = 22\text{dB}$ at $f = 100\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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1. Emitter 2. Base 3. Collector

3

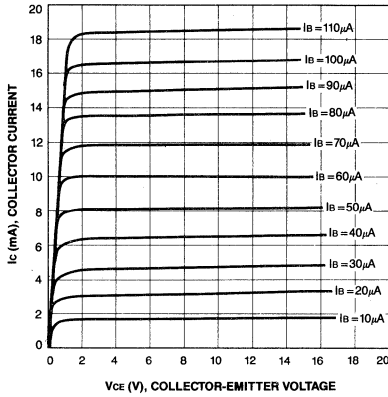
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$		0.72		V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	400	600		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.2		pF
Collector-Base Time Constant	$C_c \text{ rbb}'$	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$ $f = 31.9\text{MHz}$		12	15	ps
Common Source Noise Figure	NF	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$ $R_S = 50\Omega, f = 100\text{MHz}$		3.0	5.0	dB
Power Gain	G_{pe}	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$ $R_S = 50\Omega, f = 100\text{MHz}$ (Typ)	18	22		dB

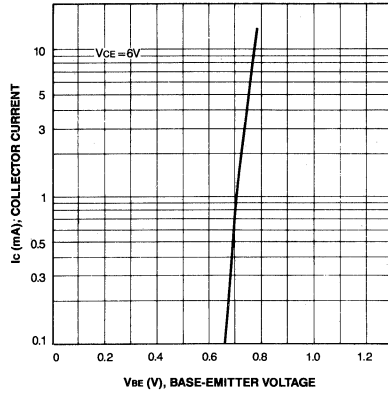
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

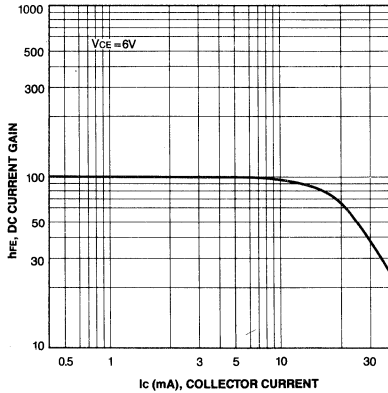
STATIC CHARACTERISTIC



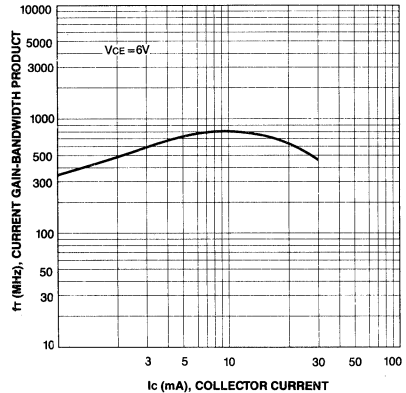
BASE-EMITTER ON VOLTAGE



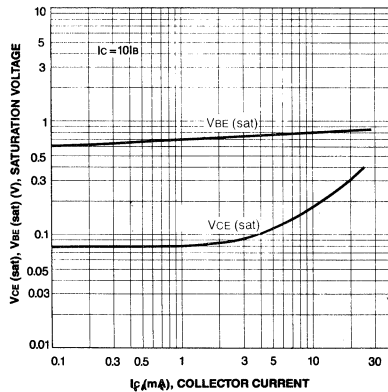
DC CURRENT GAIN



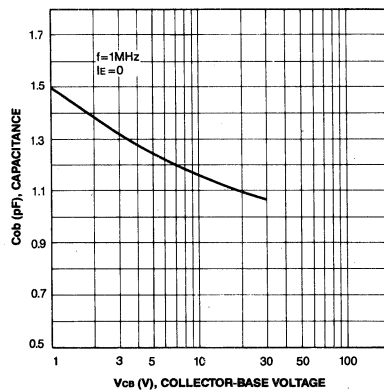
CURRENT GAIN-BANDWIDTH PRODUCT

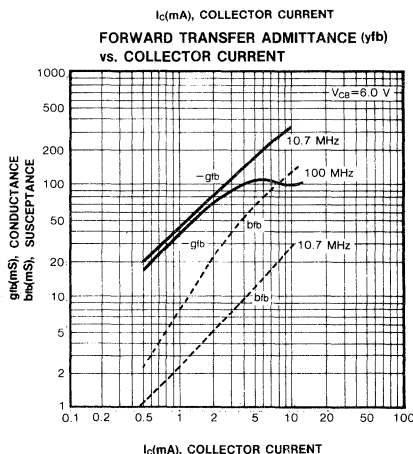
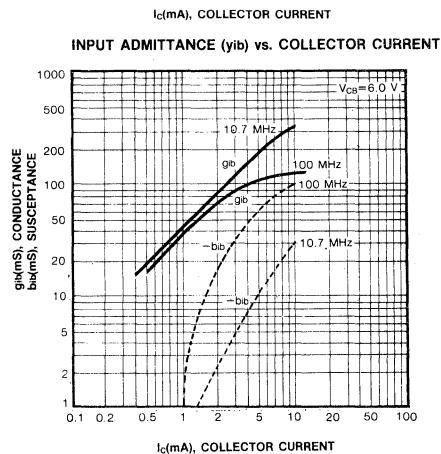
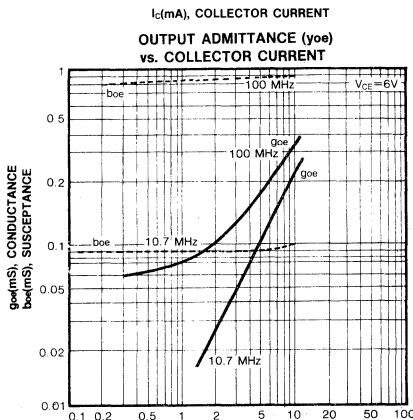
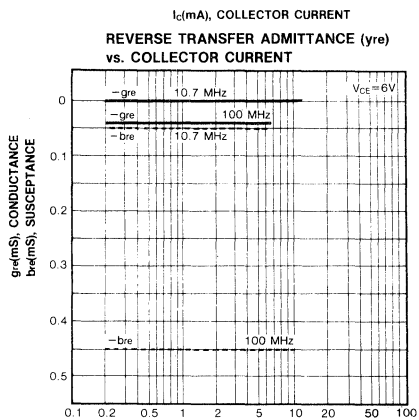
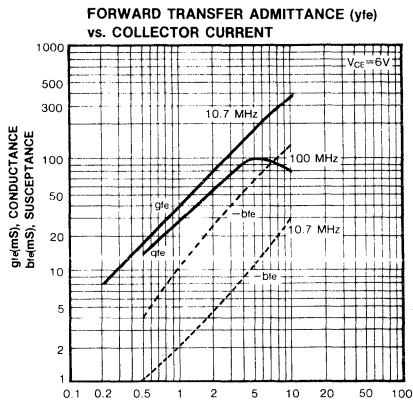
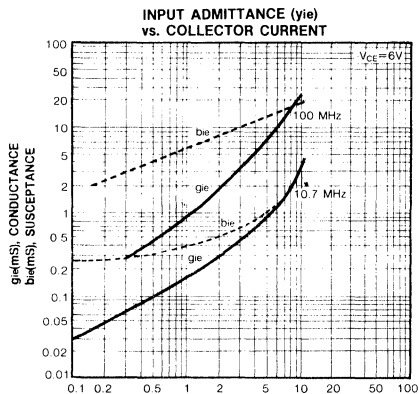


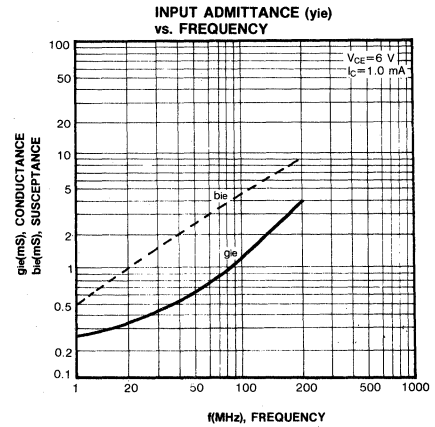
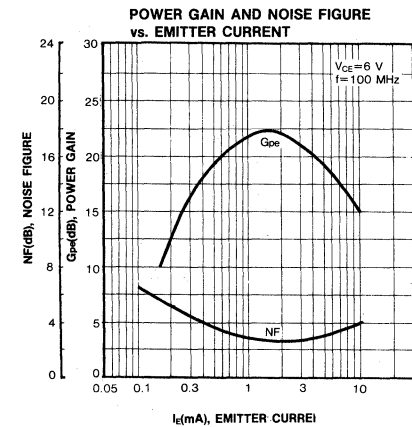
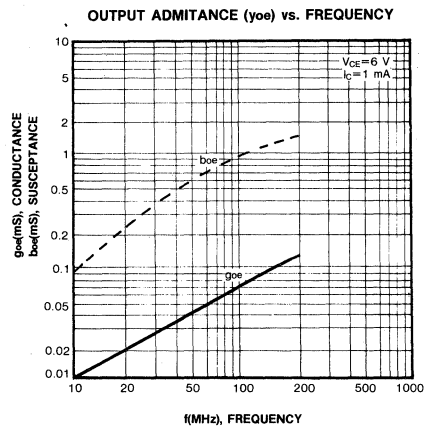
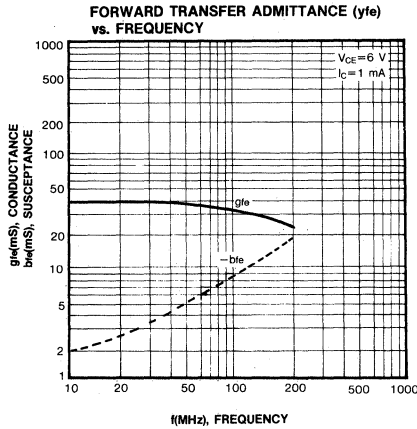
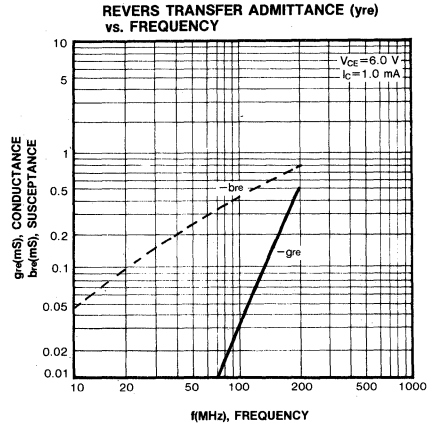
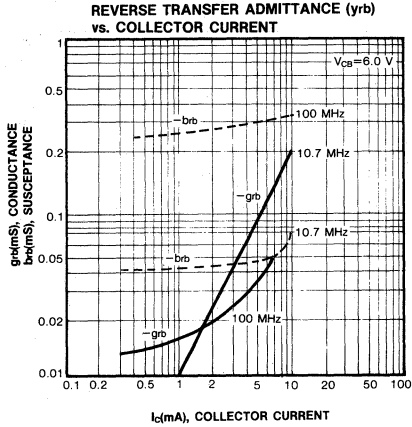
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

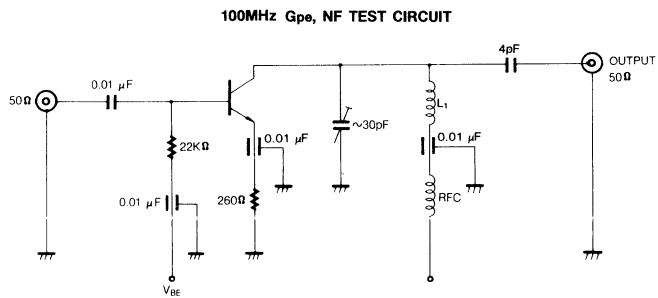


COLLECTOR OUTPUT CAPACITANCE









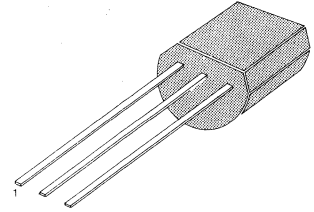
FM/AM RF AMP, MIX, CONV, OSC, IF

- Collector-Base Voltage $V_{CE0} = 30V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)
- Low Collector Capacitance $C_{ob} = 2.0PF$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

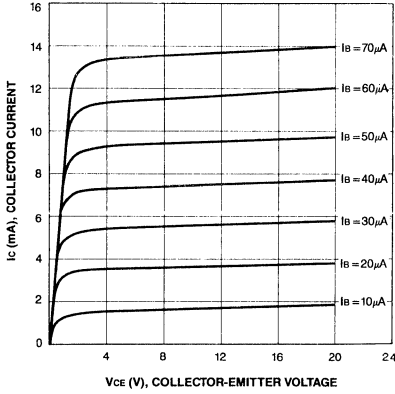
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1mA$	40		240	
Base-Emitter On Voltage	$V_{BE(ON)}$	$V_{CE} = 6V, I_C = 1mA$		0.67	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$		0.08	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 1mA$	150	300		MHz
Output Capacitance	C_{ob}	$f = 1MHz, V_{CB} = 6V$		2.0	2.5	PF

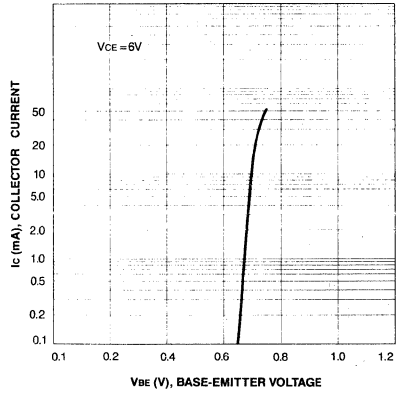
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

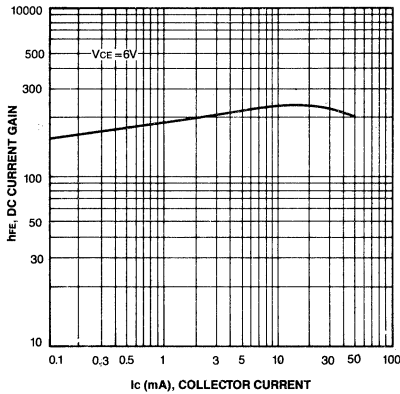
STATIC CHARACTERISTIC



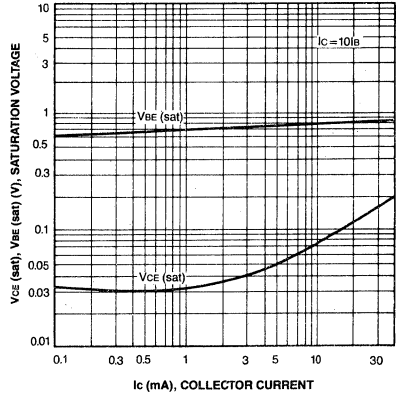
BASE-EMITTER ON VOLTAGE



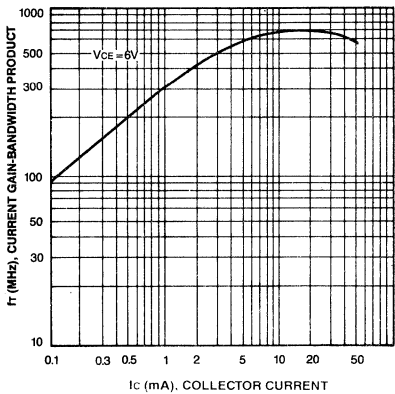
DC CURRENT GAIN



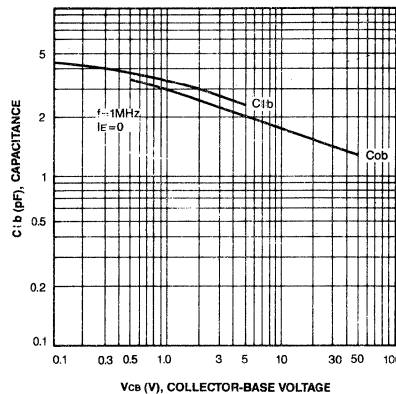
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE



3

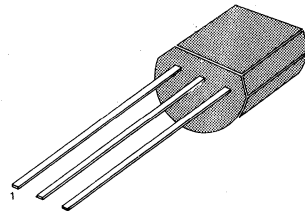
TV, VHF, UHF TUNER OSCILLATOR

- High Current Gain Bandwidth Product $f_T = 1100\text{MHz}$ (Typ)
- Output Capacitance $C_{ob} = 1.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

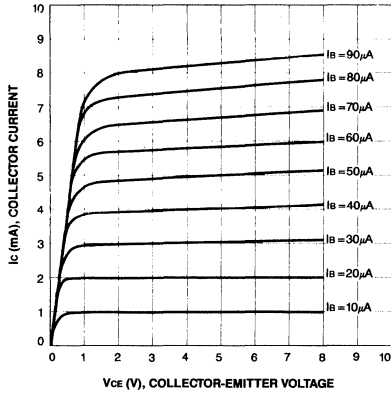
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 12\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5.0\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	800	1100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, f = 1\text{MHz}$ $I_E = 0$			1.5	pF
Collector-Base Time Constant	$C_C - r_{bb}$	$V_{CE} = 10\text{V}, f = 31.9\text{MHz}$ $I_E = 5\text{mA}$		10	20	ps

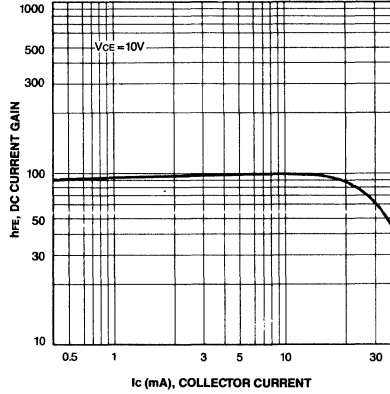
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

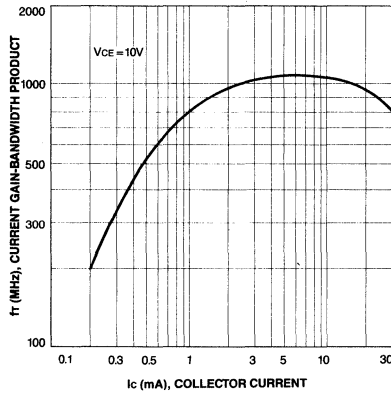
STATIC CHARACTERISTIC



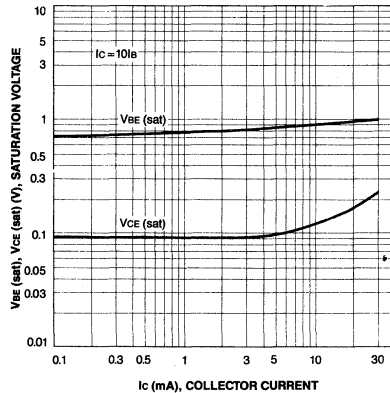
DC CURRENT GAIN



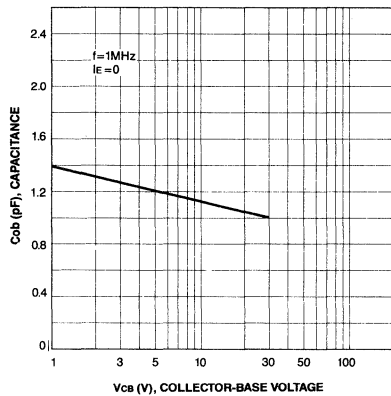
CURRENT GAIN-BANDWIDTH PRODUCT



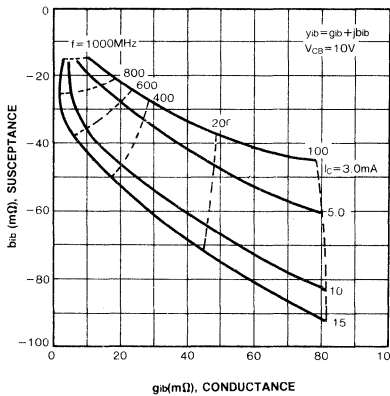
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



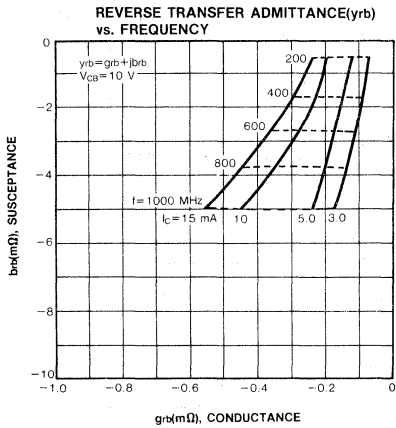
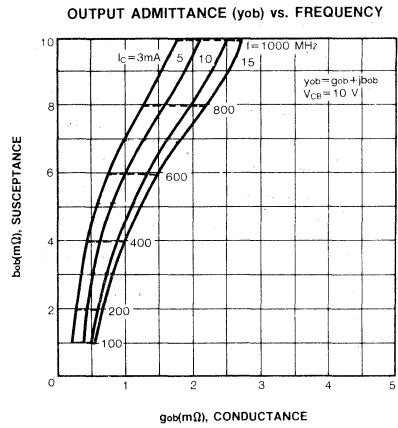
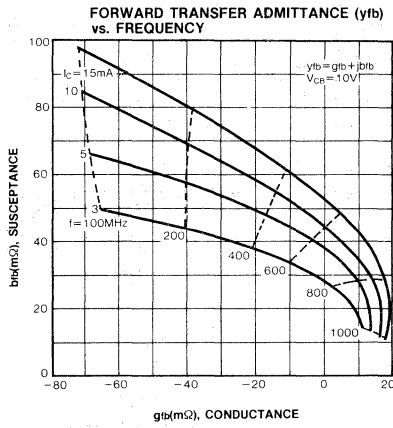
OUTPUT CAPACITANCE



INPUT ADMITTANCE (yib) vs. FREQUENCY



3

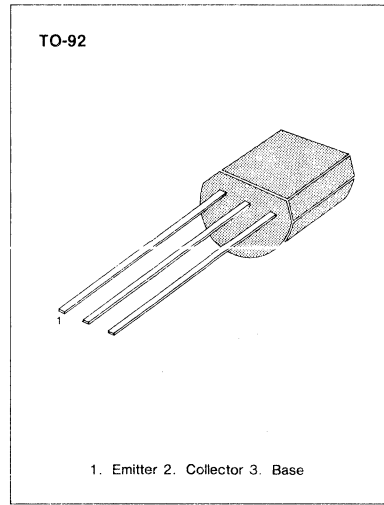


AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSA992

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Base Current	I_B	10	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

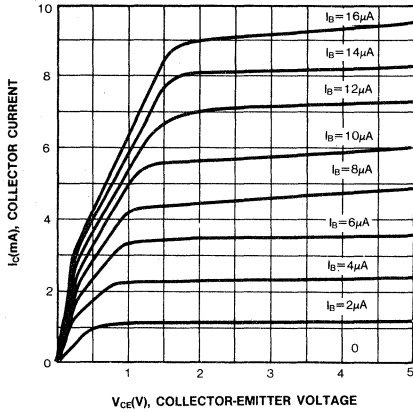
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 120\text{V}, I_E = 0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			50	nA
DC Current Gain	h_{FE1}	$V_{CE} = 6\text{V}, I_C = 0.1\text{mA}$	150	580		
	h_{FE2}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	200	600	1200	
Base Emitter On Voltage	$V_{BE} (on)$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.55	0.59	0.65	V
Collector Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.07	0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$	50	110		MHz
Output Capacitance	C_{ob}	$V_{CB} = 30\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.6	2.5	pF
Noise Voltage	NV			25	40	mV

$h_{FE}(2)$ CLASSIFICATION

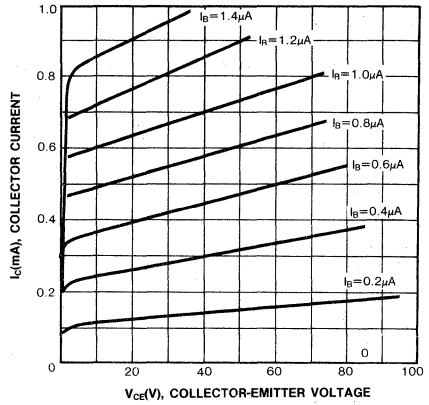
Classification	P	F	E	U
$h_{FE}(2)$	200-400	300-600	400-800	600-1200

3

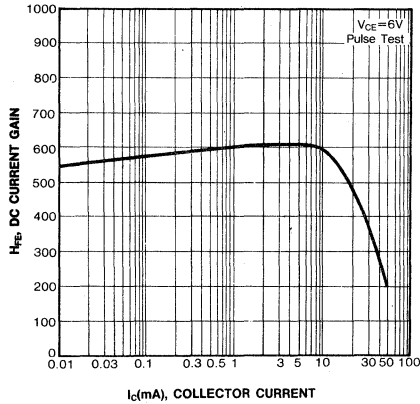
STATIC CHARACTERISTIC



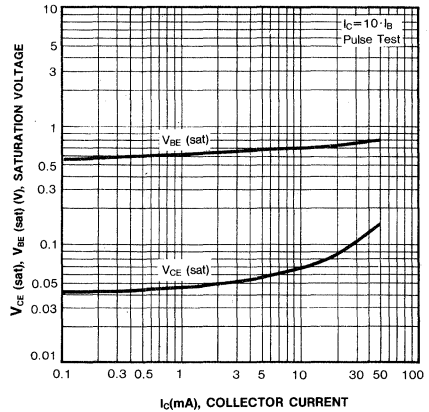
STATIC CHARACTERISTIC



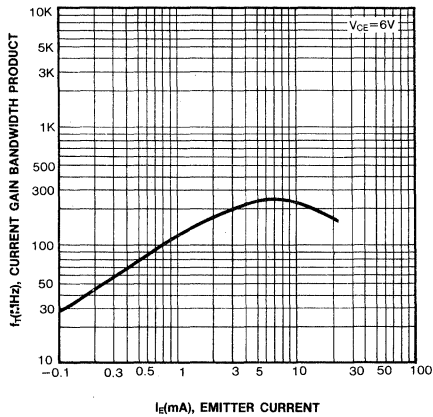
DC CURRENT GAIN



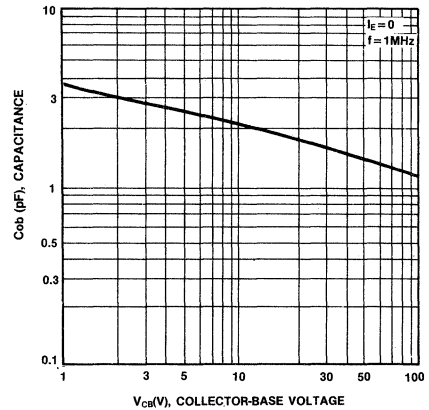
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

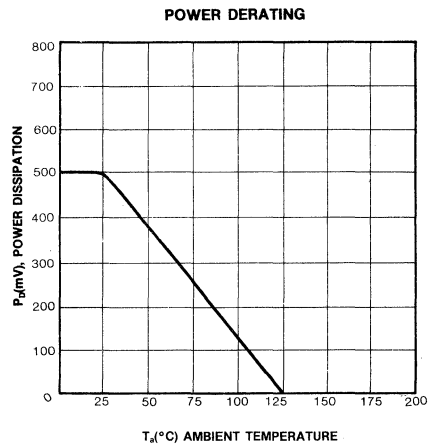
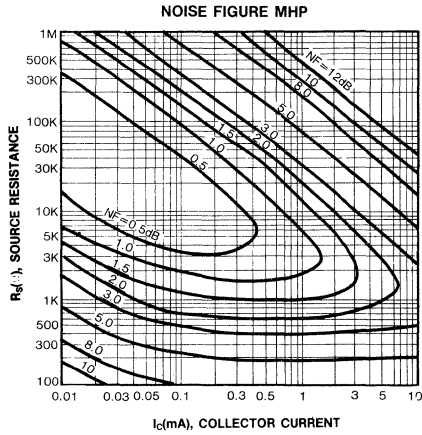
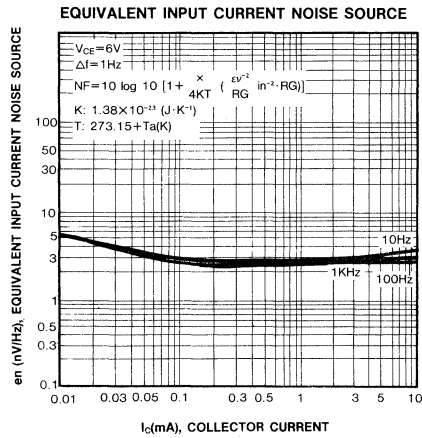
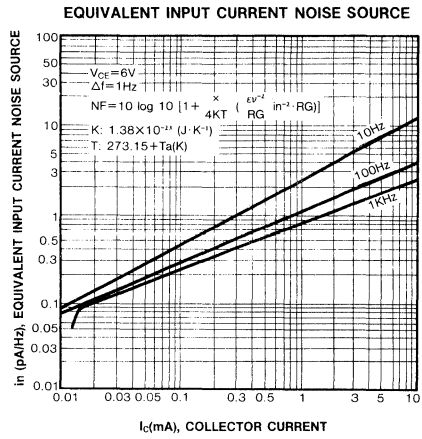
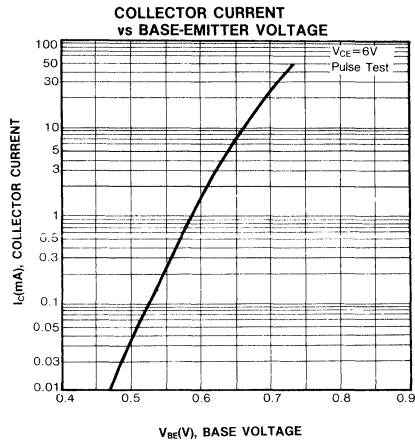


CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE





3

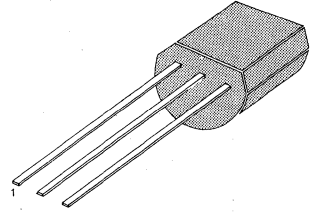
GENERAL PURPOSE APPLICATIONS
HIGH TOTAL POWER DISSIPATION
(PT= 600 mW)

High h_{FE} and LOW $V_{CE(sat)}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	700	mA
Base Current	I_B	150	mA
Collector Dissipation	P_C	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
* Base Emitter Voltage	V_{BE}	$V_{CE}=6V, I_C=10mA$	600	640	700	mV
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5V, I_C=0$			100	nA
* DC Current Gain	h_{FE1}	$V_{CE}=1V, I_C=100mA$	90	200	400	
	h_{FE2}	$V_{CE}=1V, I_C=700mA$	50	140		
* Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=700mA, I_B=70mA$		0.2	0.6	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=700mA, I_B=70mA$		0.95	1.2	V
Output Capacitance	C_{ob}	$V_{CB}=6V, I_E=0, f=1MHz$		13	25	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=6V, I_E=10mA$	50	170		MHz

* Pulse test: $PW \leq 350 \mu s$, duty cycle $\leq 2\%$ Pulsed

h_{FE1} CLASSIFICATION

Classification	O	Y	G
h_{FE1}	90-180	135-270	200-400

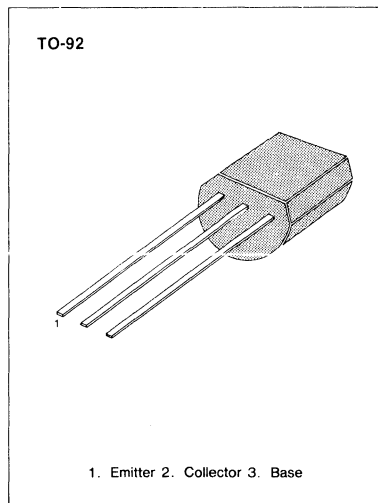
AUDIO FREQUENCY AMPLIFIER

• Complement to KSA953/KSA954

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSC2002	V_{CB0}	60	V
: KSC2003		80	V
Collector-Emitter Voltage : KSC2002	V_{CE0}	60	V
: KSC2003		80	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current (DC)	I_C	300	mA
*Collector Current (Pulse)	I_C	500	mA
Collector Dissipation	P_C	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

* $PW \leq 10\text{ms}$, Duty Cycle $\leq 50\%$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

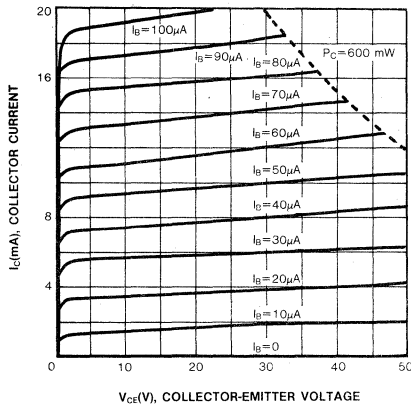
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current: KSC2002	I_{CBO}	$V_{CB} = 60\text{V}, I_E = 0$			100	nA
: KSC2003		$V_{CB} = 80\text{V}, I_E = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			100	nA
*DC Current Gain	h_{FE1}	$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	90	200	400	
	h_{FE2}	$V_{CE} = 2\text{V}, I_C = 300\text{mA}$	30	80		
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 10\text{mA}$	600	645	700	mV
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 300\text{mA}, I_B = 30\text{mA}$		0.15	0.6	V
*Base Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 300\text{mA}, I_B = 30\text{mA}$		0.86	1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_E = 10\text{mA}$	50	140		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0, f = 1\text{MHz}$		7	15	pF

* Pulse Test: $PW \leq 350\mu\text{s}$, Duty Cycle $\leq 2\%$ Pulsed

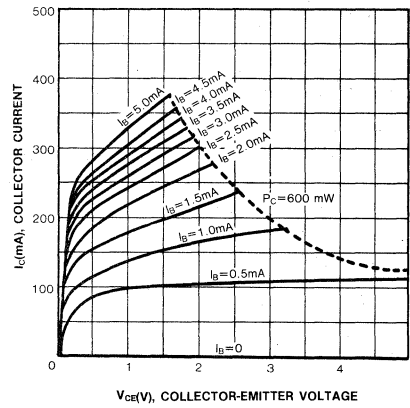
 $h_{FE}(1)$ CLASSIFICATION

Classification	O	Y	G
$h_{FE}(1)$	90-180	135-270	200-400

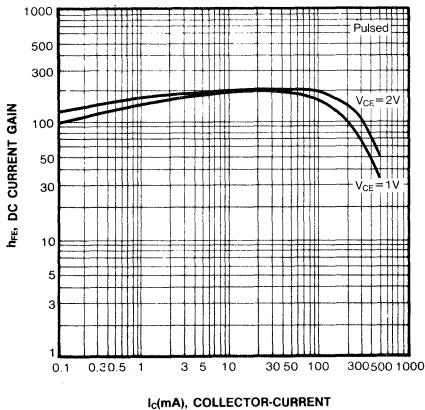
STATIC CHARACTERISTIC



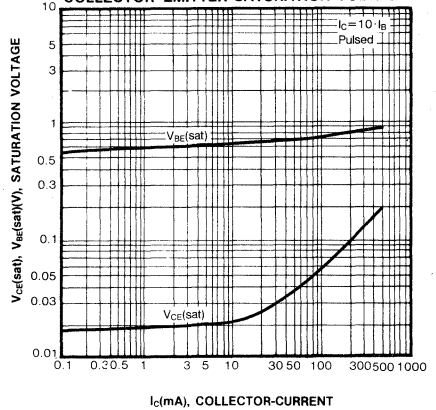
STATIC CHARACTERISTIC



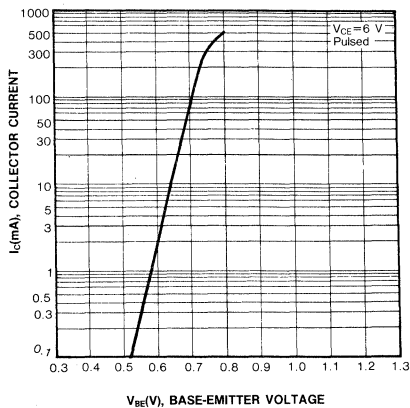
DC CURRENT GAIN



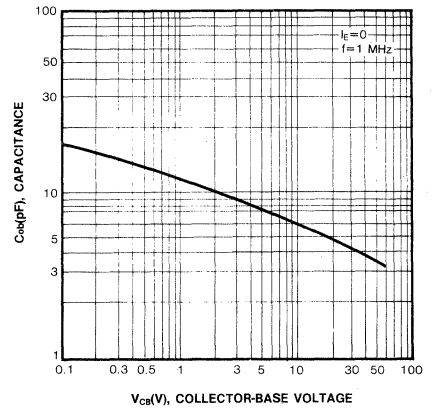
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



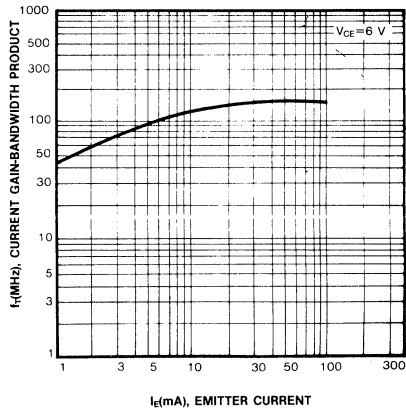
BASE-EMITTER ON VOLTAGE



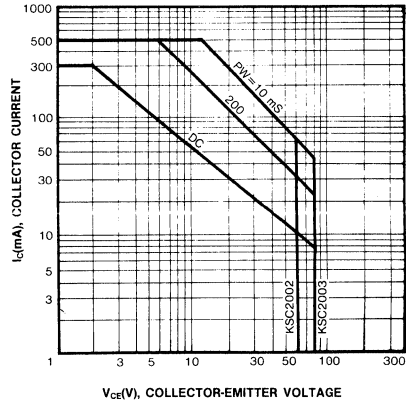
COLLECTOR OUTPUT CAPACITANCE



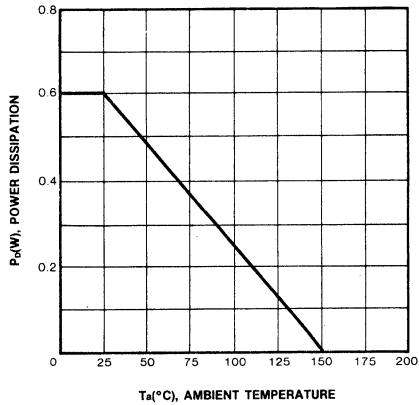
CURRENT GAIN-BANDWIDTH PRODUCT



SAFE OPERATING AREA



POWER DERATING



3

HIGH FREQUENCY AMPLIFIER

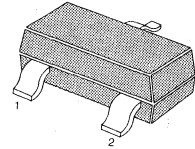
Very small size to assure good space factor in hybrid IC applications

- $f_T = 600\text{MHz}$ Typ. ($I_E = -1\text{mA}$)
- $C_{ob} = 1\text{pF}$ Typ ($V_{CB} = 6\text{V}$)
- $NF = 3\text{dB}$ Typ ($f = 100\text{MHz}$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

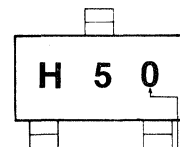
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	40	90	180	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.3	V
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0, f = 1\text{MHz}$		1		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	400	600		MHz
Time Constant	$C_c \text{ rbb}$	$V_{CB} = 6\text{V}, I_E = 1\text{mA}$ $f = 31.9\text{MHz}$		12		ps
Noise Figure	NF	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$ $f = 100\text{MHz}, R_S = 50\Omega$		3		dB

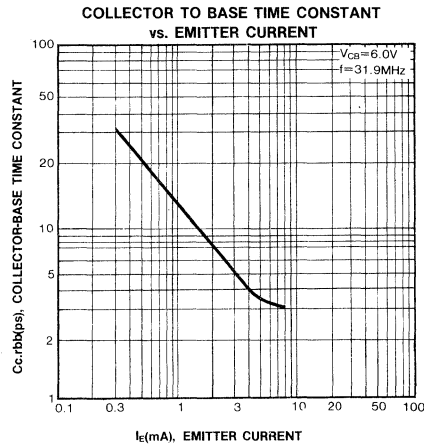
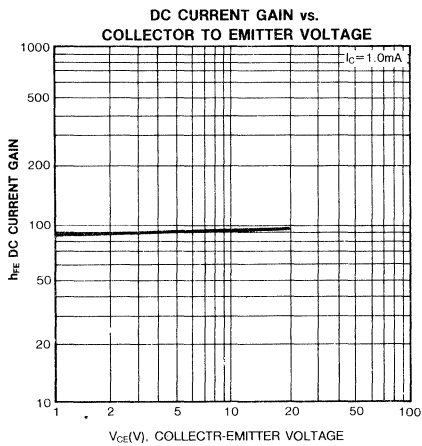
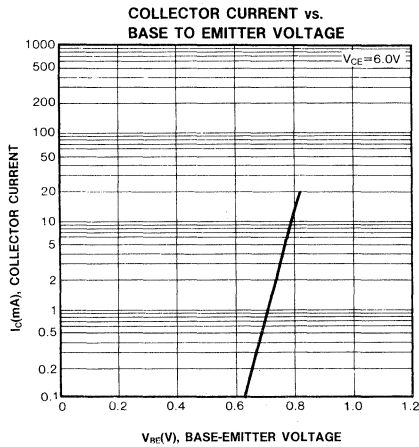
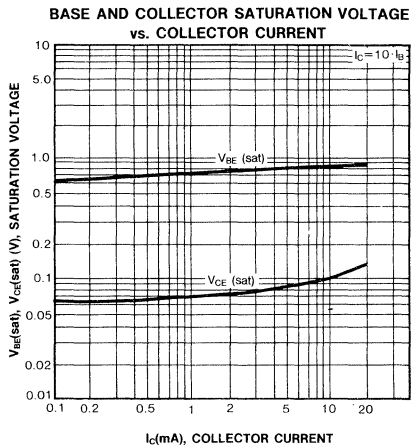
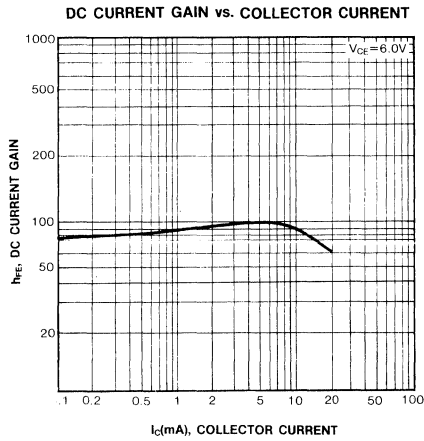
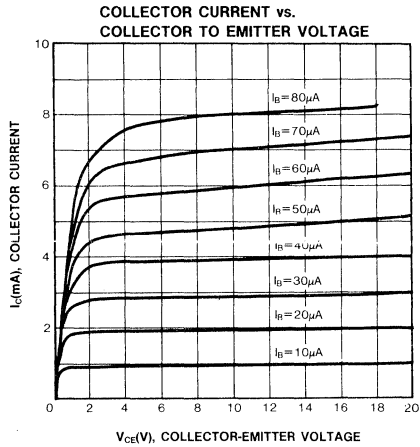
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	60-120	90-180

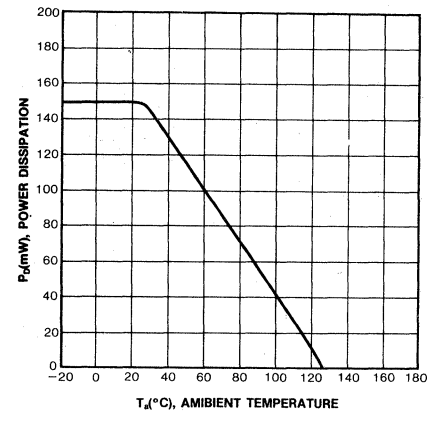
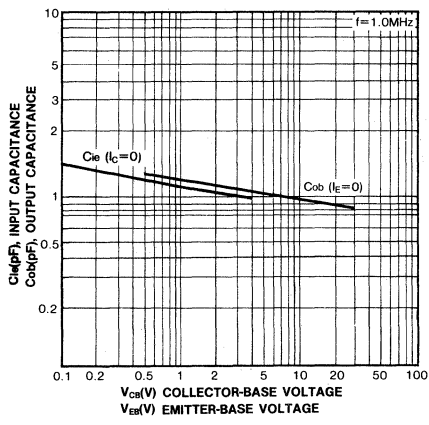
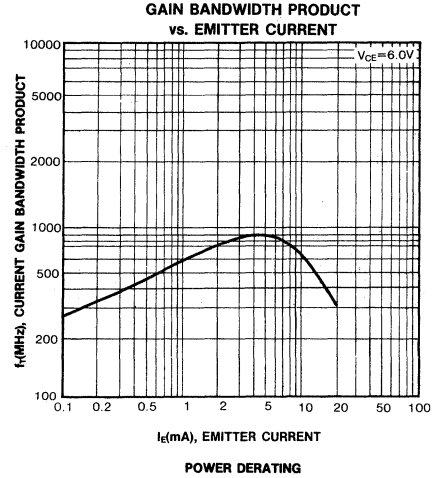
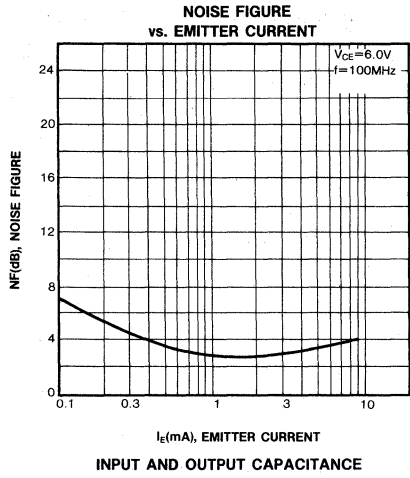
Marking



h_{FE} grade



3

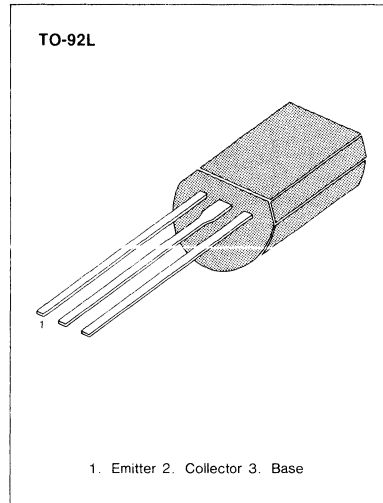


HIGH VOLTAGE POWER AMPLIFIER

- Collector — Base Voltage $V_{CBO} = 200V$
- Current Gain-Bandwidth Product $f_T = 100MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	200	V
Collector-Emitter Voltage	V_{CEO}	150	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

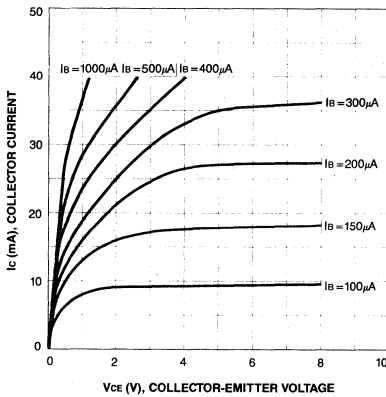
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	200			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 10mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 30V, I_C = 10mA$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1KHz$		3.5	5	pF

h_{FE} CLASSIFICATION

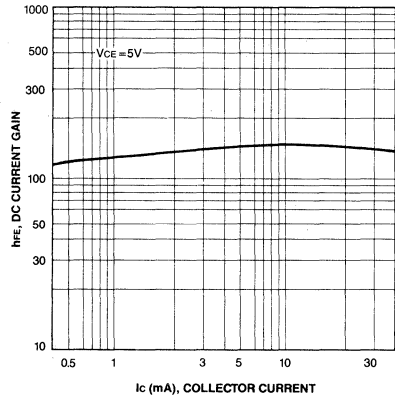
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

3

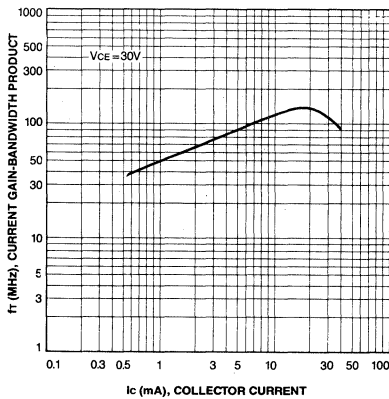
STATIC CHARACTERISTIC



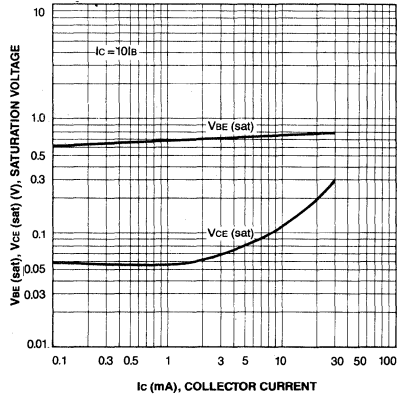
DC CURRENT GAIN



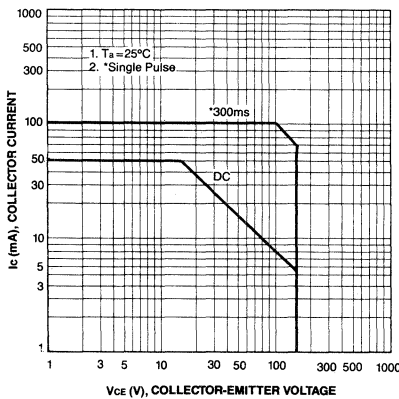
CURRENT GAIN-BANDWIDTH PRODUCT



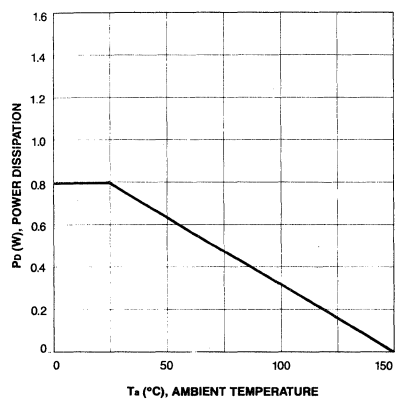
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA



POWER DERATING

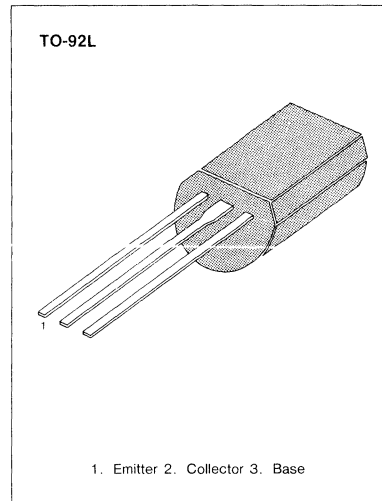


AUDIO POWER AMPLIFIER APPLICATIONS

- Driver Stage Amplifier
- Complement to KSA916

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	800	mA
Collector Dissipation	P_C	900	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$

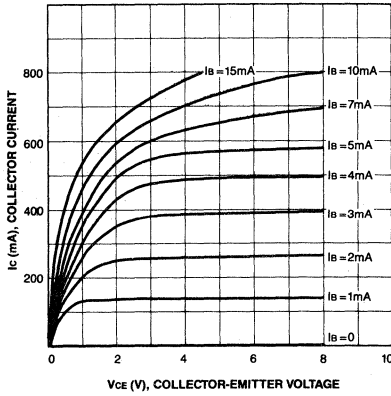
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 1\text{mA}, I_E = 0$	120			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	120			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1\text{mA}, I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 120\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE1}	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$	60			
	h_{FE2}	$V_{CE} = 5\text{V}, I_C = 100\text{mA}$	80		240	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 500\text{mA}, I_B = 50\text{mA}$			1	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 100\text{mA}$		120		MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$			30	pF

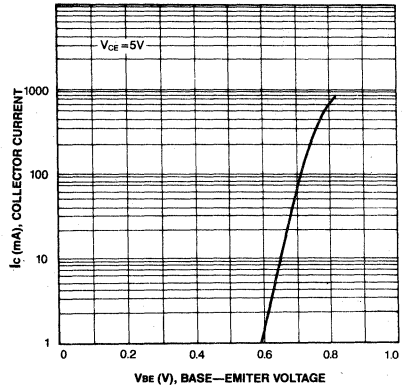
 h_{FE} CLASSIFICATION

Classification	O	Y
$h_{FE}(2)$	80-160	120-240

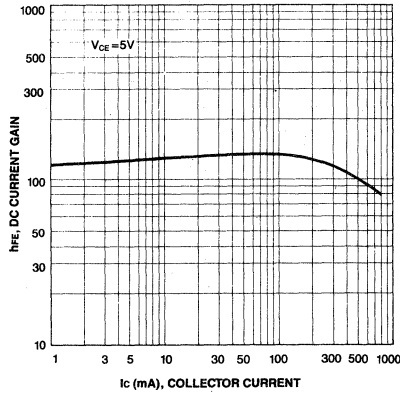
STATIC CHARACTERISTIC



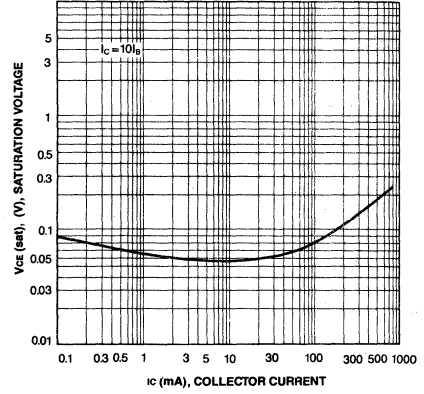
BASE-EMITTER ON VOLTAGE



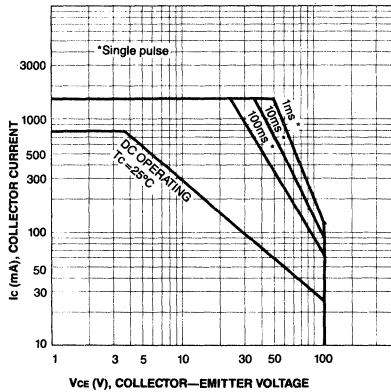
DC CURRENT GAIN



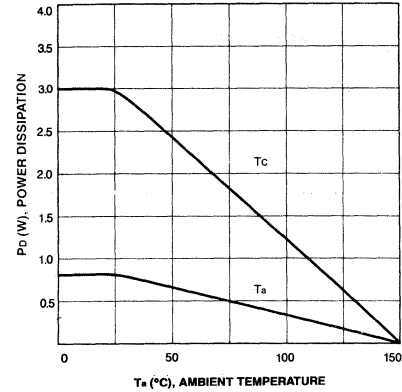
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA



POWER DERATING

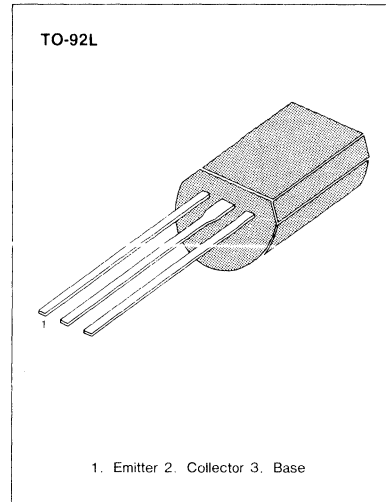


AUDIO POWER AMPLIFIER APPLICATIONS

- Complement to KSA928A
- Collector Dissipation $P_C = 1$ Watt
- 3 Watt Output Application

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	2	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$

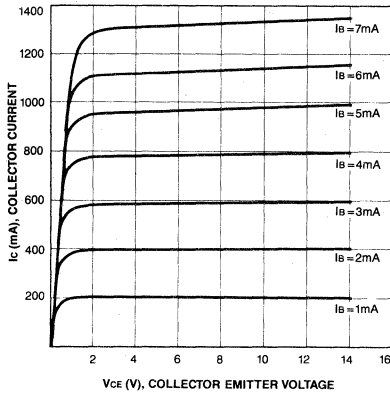
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}$, $I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}$, $I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1\text{mA}$, $I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}$, $I_E = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}$, $I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 2\text{V}$, $I_C = 500\text{mA}$	100		320	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 2\text{V}$, $I_C = 500\text{mA}$			1.0	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 1.5\text{A}$, $I_B = 0.03\text{A}$			2.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 2\text{V}$, $I_C = 500\text{mA}$		120		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}$, $I_E = 0$, $f = 1\text{MHz}$		30		pF

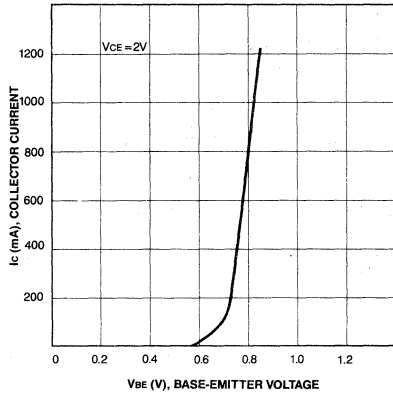
 h_{FE} CLASSIFICATION

Classification	O	Y
h_{FE}	100-200	160-320

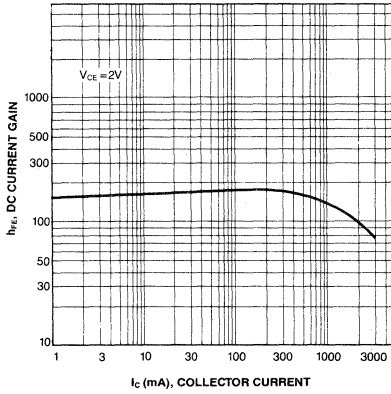
STATIC CHARACTERISTIC



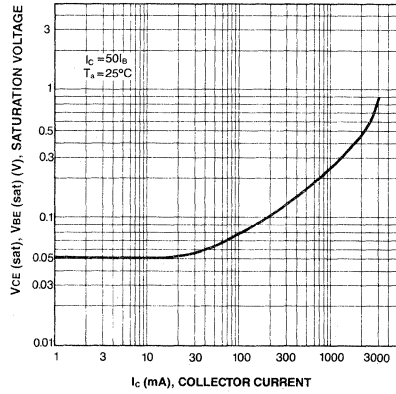
BASE-EMITTER ON VOLTAGE



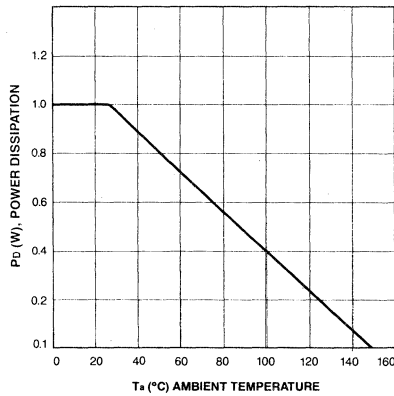
DC CURRENT GAIN



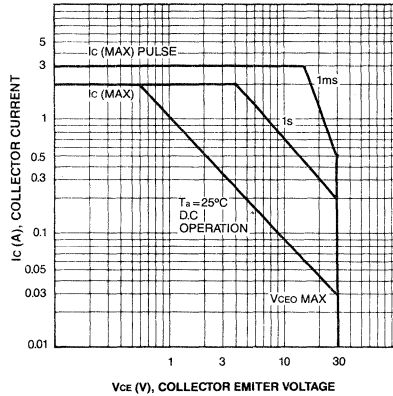
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA

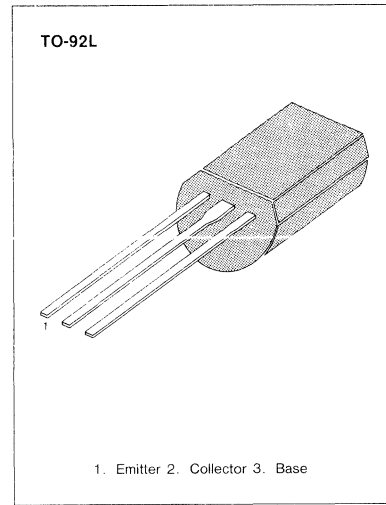


COLOR TV CHROMA OUTPUT

- Collector-Base Voltage $V_{CBO} = 300V$
- Current Gain-Bandwidth Product $f_T = 50MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

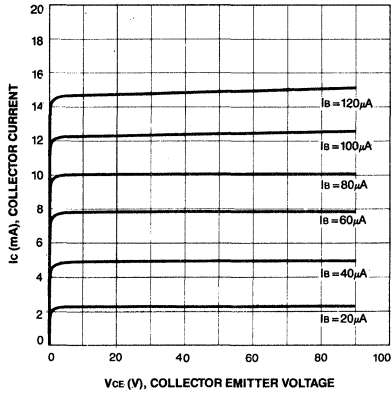
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	300			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	7			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10V, I_C = 20mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 30V, I_C = 10mA$		50		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		4		pF

h_{FE} CLASSIFICATION

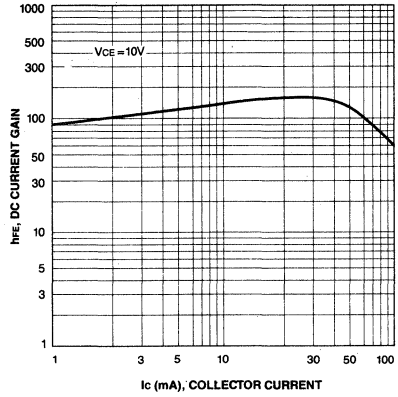
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

3

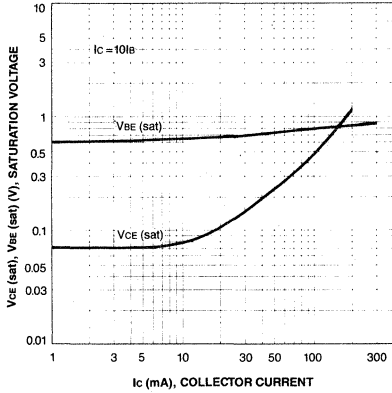
STATIC CHARACTERISTIC



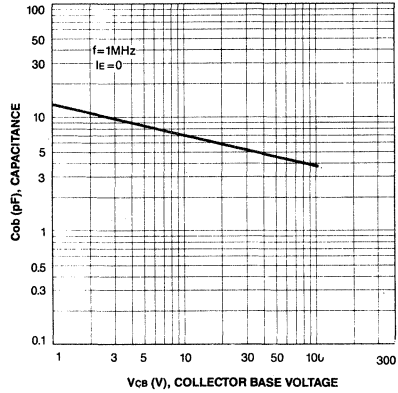
DC CURRENT GAIN



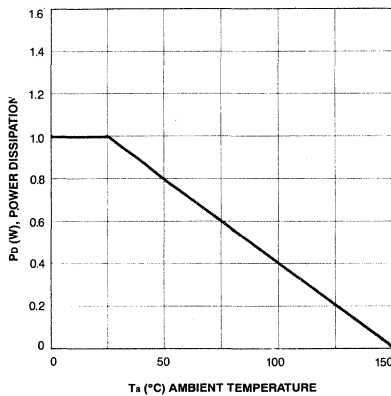
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

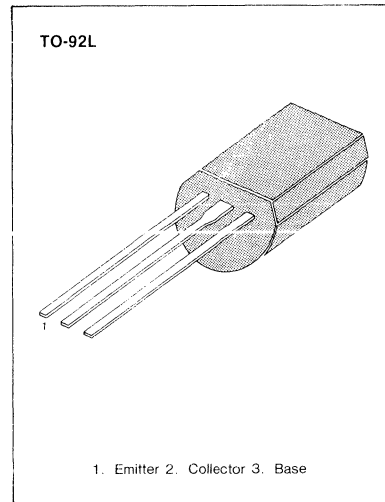


LOW FREQUENCY AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSA931
- High Collector-Base Voltage $V_{CB0} = 80V$
- Collector Current $I_C = 700mA$
- Collector Dissipation $P_C = 1W$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	80	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ C$



3

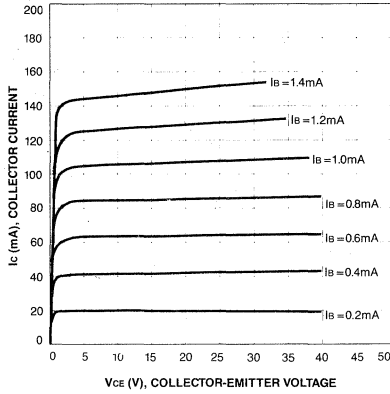
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu A, I_E = 0$	80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	8			V
Collector Cut-off Current	I_{CB0}	$V_{CB} = 60V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 2V, I_C = 50mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 500mA, I_B = 50mA$		0.2	0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 500mA, I_B = 50mA$		0.86	1.20	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 50mA$	30	50		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		8		pF

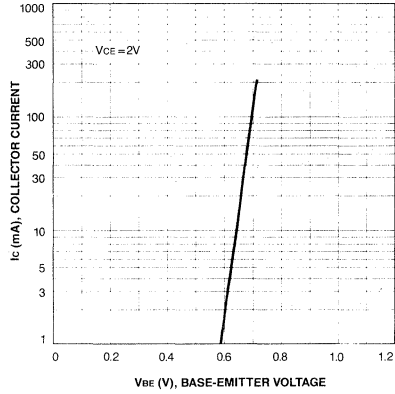
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

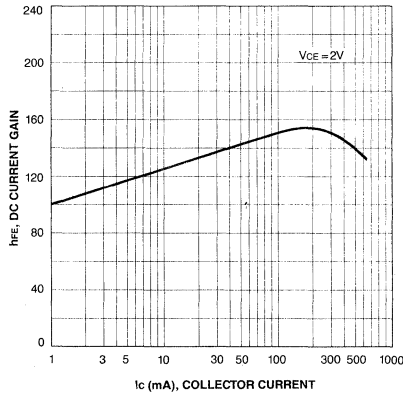
STATIC CHARACTERISTIC



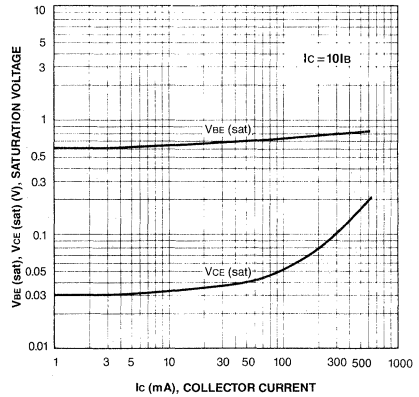
BASE-EMITTER ON VOLTAGE



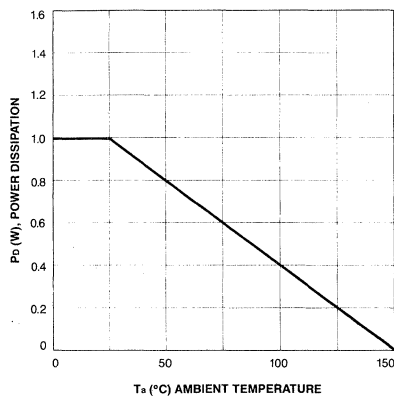
DC CURRENT GAIN



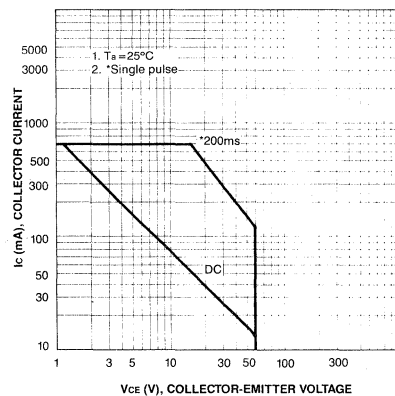
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



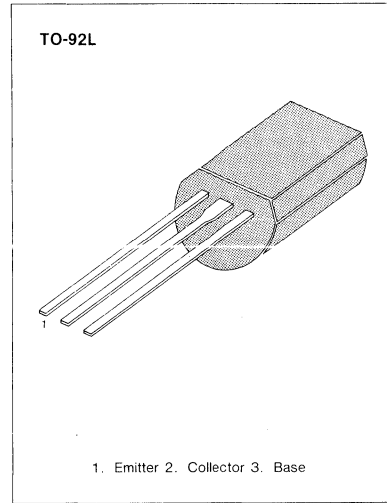
SAFE OPERATING AREA



**COLOR TV AUDIO OUTPUT
COLOR TV VERTICAL DEFLECTION OUTPUT**

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	160	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	1	A
Base Current	I_B	0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



3

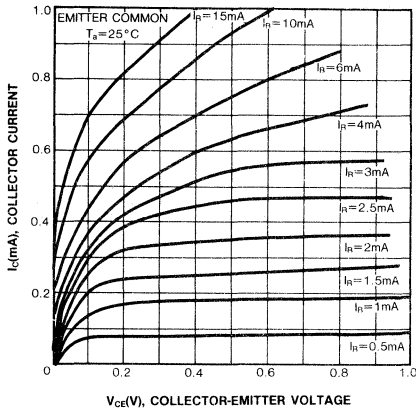
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 150\text{V}, I_E = 0$			1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 6\text{V}, I_C = 0$			1	μA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	160			V
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 200\text{mA}$	60		320	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 500\text{mA}, I_B = 50\text{mA}$			1.5	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 5\text{V}, I_C = 5\text{mA}$	0.45		0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 200\text{mA}$	20	100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$			20	pF

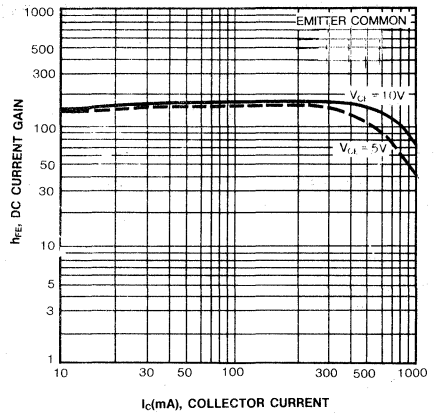
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	60-120	100-200	160-320

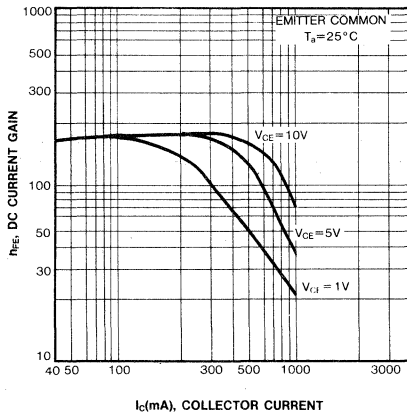
STATIC CHARACTERISTIC



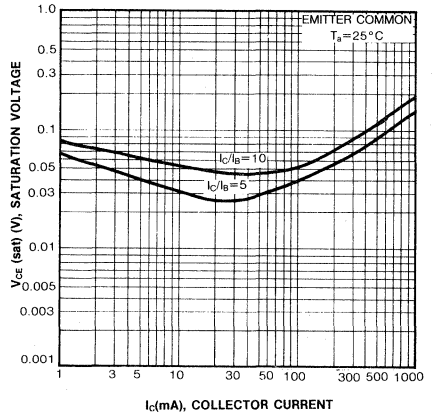
DC CURRENT GAIN



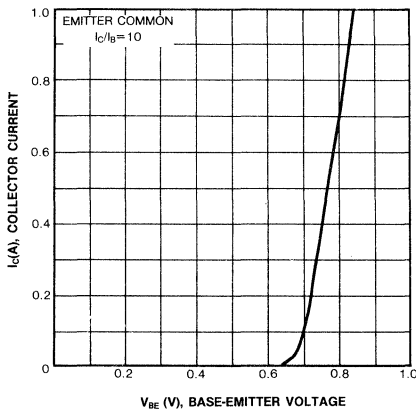
DC CURRENT GAIN



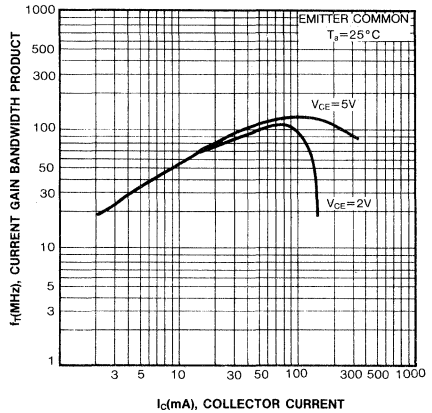
COLLECTOR-EMITTER SATURATION VOLTAGE



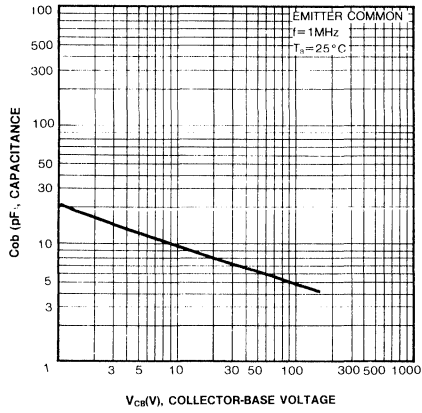
BASE-EMITTER ON VOLTAGE



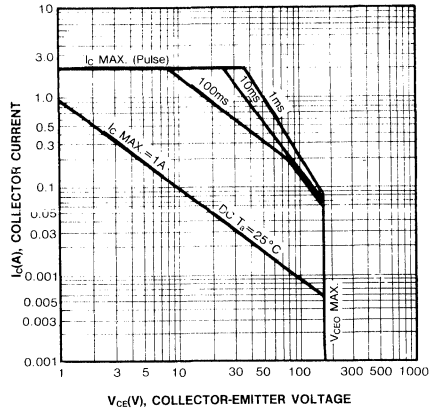
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE



SAFE OPERATING AREA

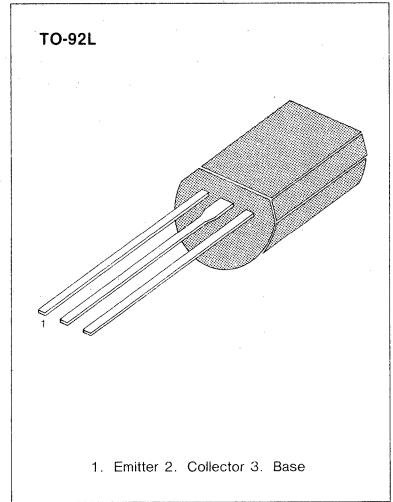


**MEDIUM POWER AMPLIFIER
LOW SATURATION**

• $V_{CE(sat)}=0.5V$ ($I_C=2A, I_B=50mA$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Collector-Emitter Voltage	V_{CEO}	10	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current (DC)	I_C	2	A
* Collector Current (Pulse)	I_C	5	A
Base Current	I_B	0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$



* $PW \leq 10ms$, Duty Cycle $\leq 30\%$

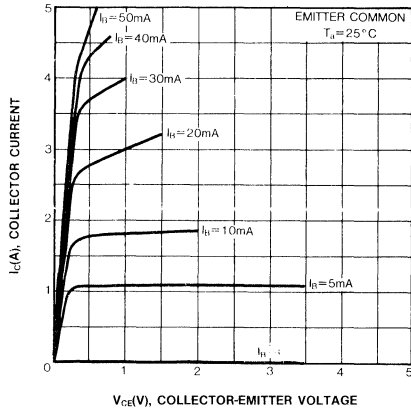
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6V, I_C=0$			100	nA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	10			V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_C=0$	6			V
DC Current Gain	h_{FE1}	$V_{CE}=1V, I_C=0.5A$	140		600	
	h_{FE2}	$V_{CE}=1V, I_C=2A$	70	200		
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=2A, I_B=50mA$		0.2	0.5	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE}=1V, I_C=2A$		0.86	1.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=1V, I_C=0.5A$		150		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0, f=1MHz$		27		pF

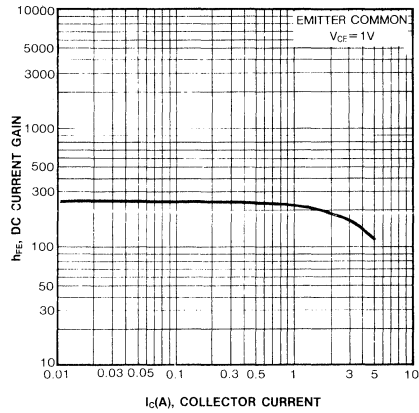
h_{FE} (1) CLASSIFICATION

Classification	A	B	C	D
$h_{FE}(1)$	140-240	200-330	300-450	420-600

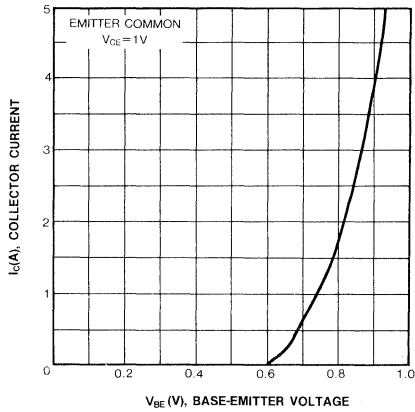
STATIC CHARACTERISTIC



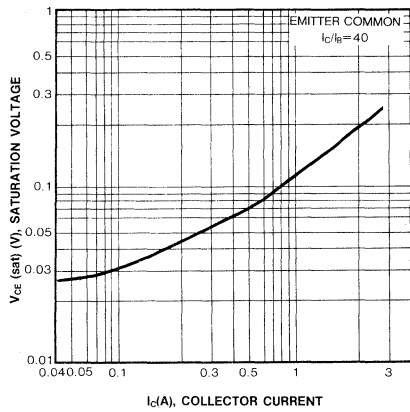
DC CURRENT GAIN



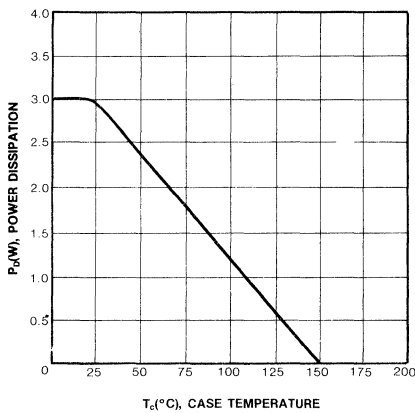
BASE-EMITTER ON VOLTAGE



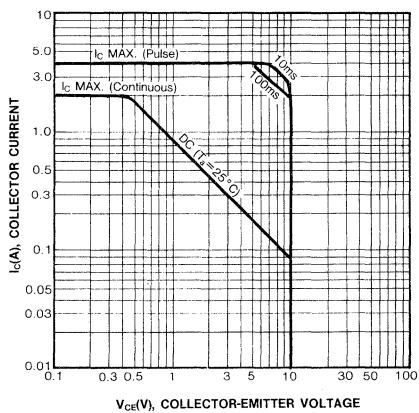
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA



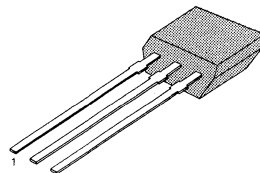
FM RADIO RF AMP, MIX, CONV, OSC, IF AMP

- High Current Gain Bandwidth Product $f_T = 250\text{MHz}$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	35	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

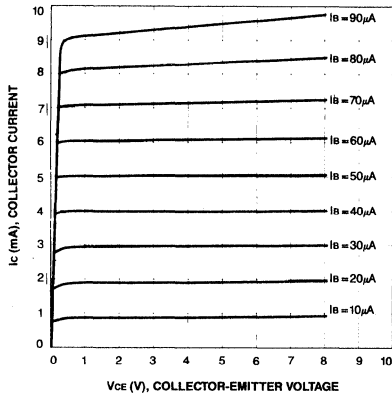
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	100	250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.2	pF

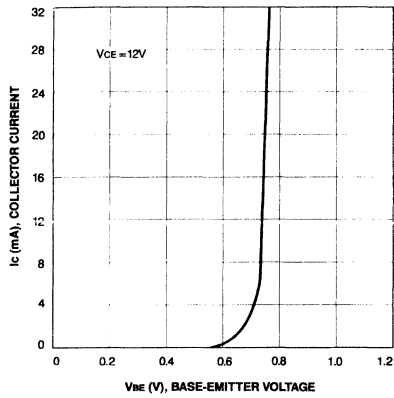
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

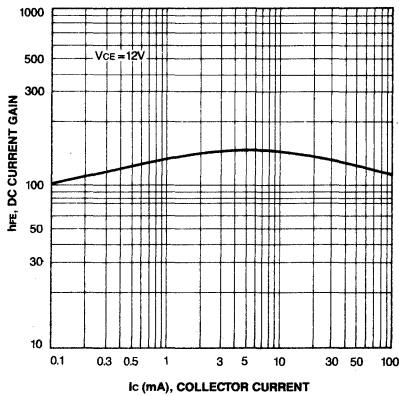
STATIC CHARACTERISTIC



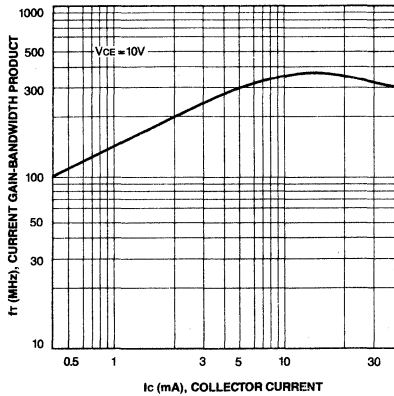
BASE-EMITTER ON VOLTAGE



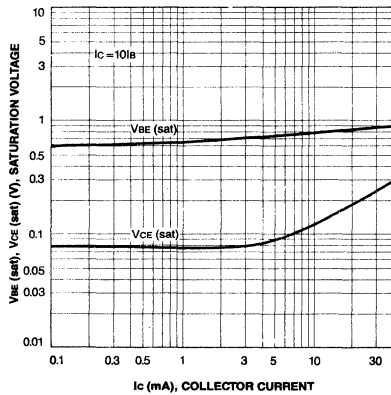
DC CURRENT GAIN



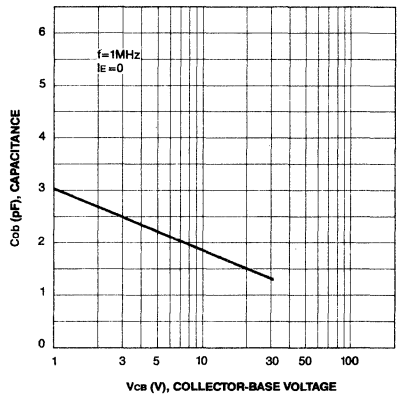
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

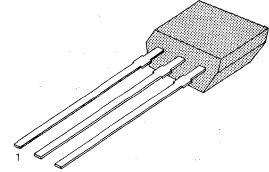
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA1150
- Collector Dissipation $P_C = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

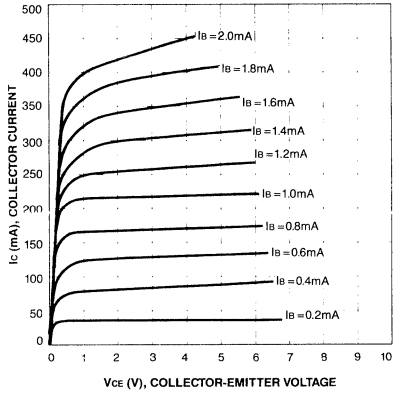
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 0.1\text{A}$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 0.5\text{A}, I_B = 0.05\text{A}$		0.18	0.4	V

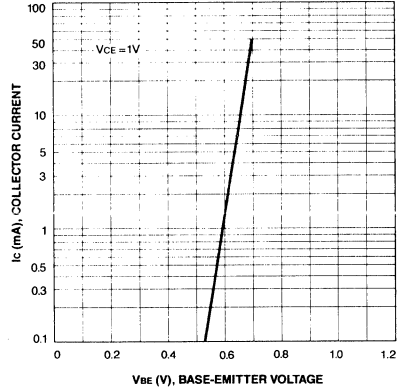
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

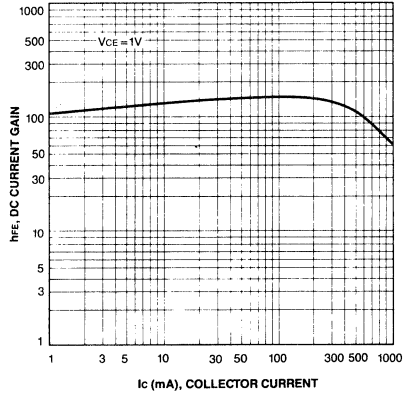
STATIC CHARACTERISTIC



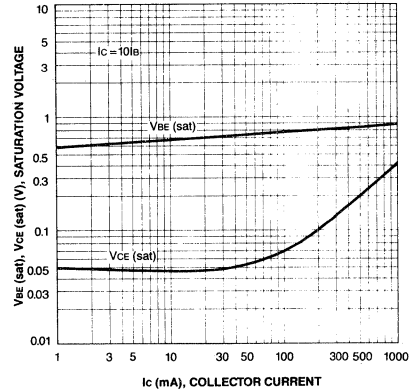
BASE-EMITTER ON VOLTAGE



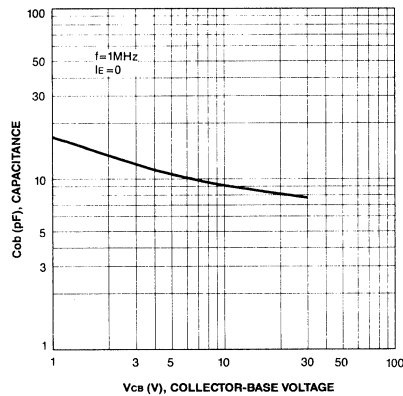
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

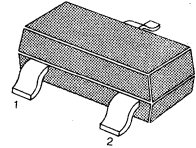
FM RADIO AMP, MIX, CONV OSC, IF AMP

• High Power Gain $G_{pe} = 30dB$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23



1. Base 2. Emitter 3. Collector

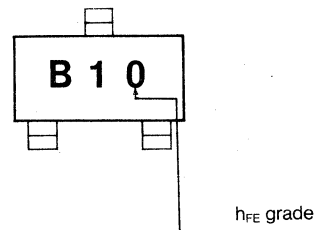
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 35V, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4V, I_C = 0$			1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12V, I_C = 2mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10mA, I_B = 1mA$			1.0	V
Current Gain-Bandwidth Product	f_T	$I_C = 1mA, V_{CE} = 10V$	100		400	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$		2.	3.2	pF
Power Gain	G_{pe}	$f = 1MHz$ $V_{CE} = 6V, I_E = 1mA$ $f = 10.7MHz$	27	30	33	dB

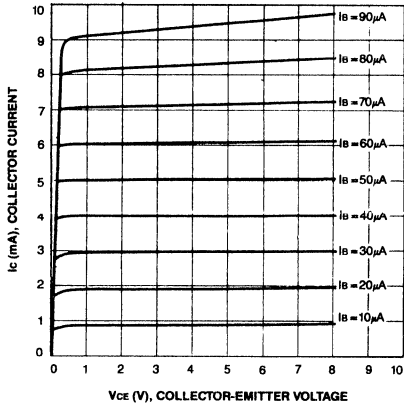
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

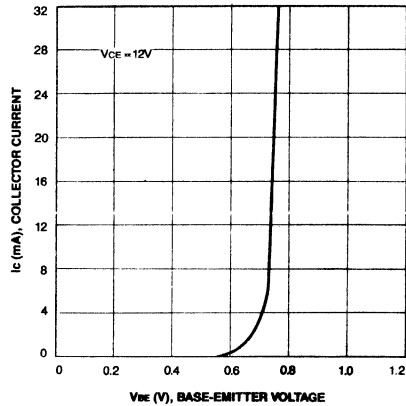
Marking



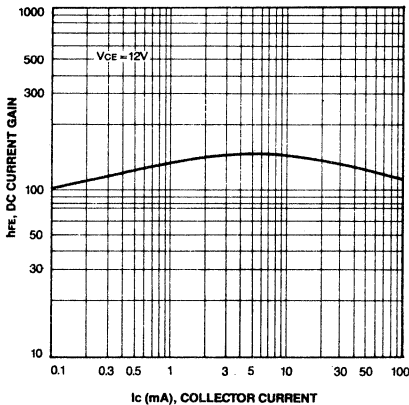
STATIC CHARACTERISTIC



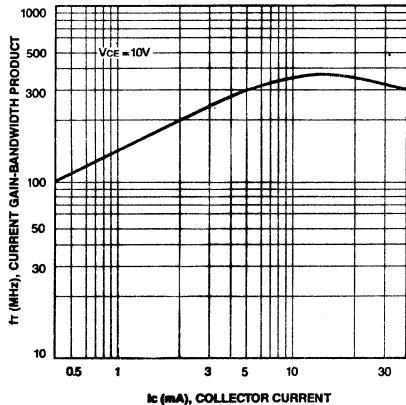
BASE-EMITTER ON VOLTAGE



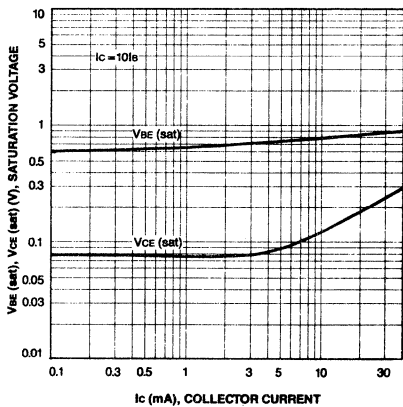
DC CURRENT GAIN



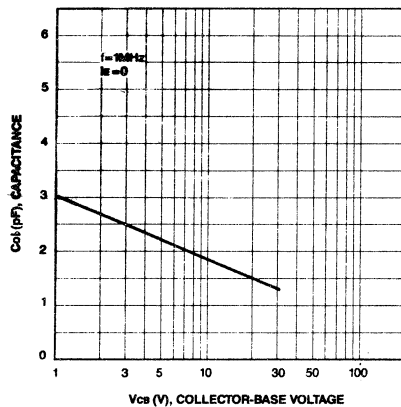
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



3

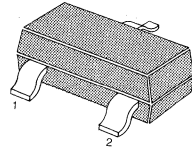
MIXER, OSC. FOR UHF TV TUNER

High f_T : 3.5GHz (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	12	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current (DC)	I_C	50	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	125	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~125	$^\circ\text{C}$

SOT-23

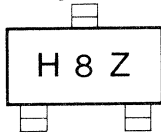


1. Base 2. Emitter 3. Collector

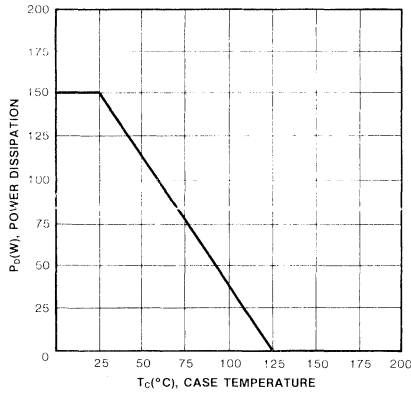
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	20			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, R_{BE} = \infty$	12			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	3			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 15\text{V}, I_E = 0$			700	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	20	90	200	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 5\text{mA}$			0.7	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 10\text{mA}$	1.4	3.5		GHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.9	1.5	pF

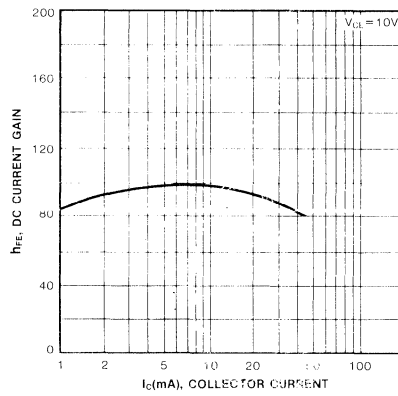
Marking



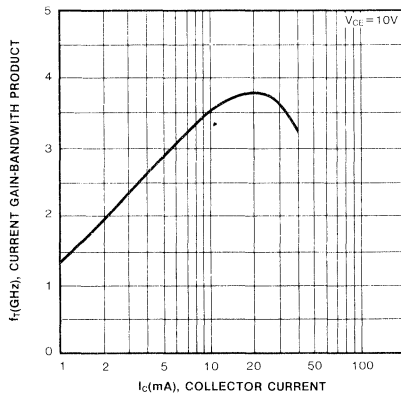
POWER DERATING



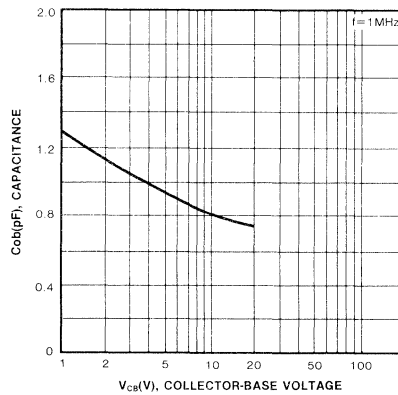
DC CURRENT GAIN



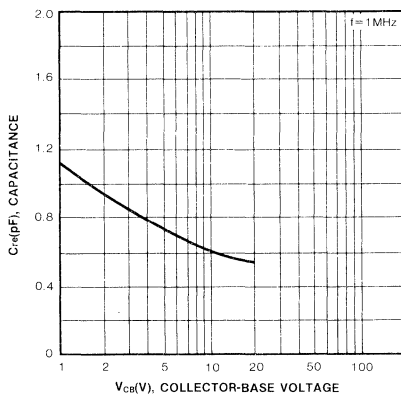
CURRENT GAIN BANDWIDTH PRODUCT



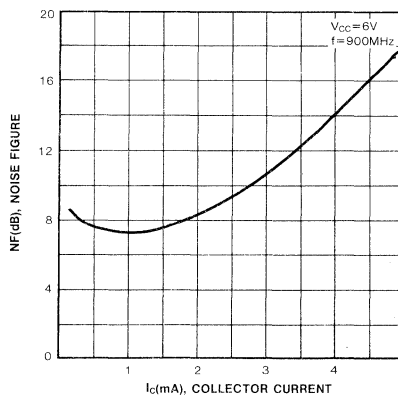
COLLECTOR OUTPUT CAPACITANCE



REVERSE TRANSFER CAPACITANCE

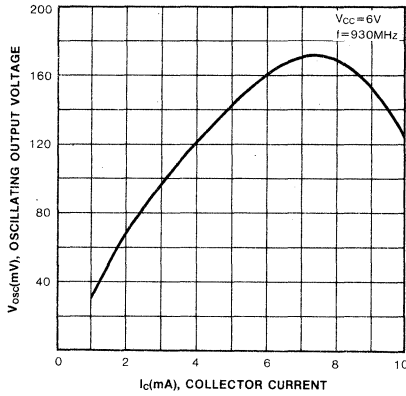


NOISE FIGURE vs. COLLECTOR CURRENT

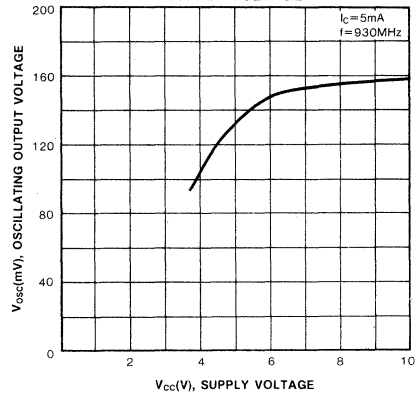


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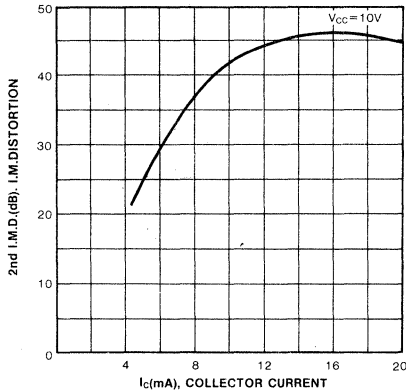
OSCILLATING OUTPUT VOLTAGE vs. COLLECTOR CURRENT



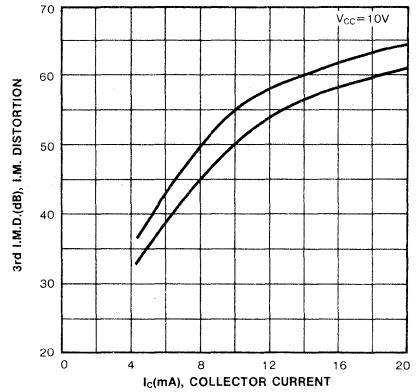
OSCILLATING OUTPUT VOLTAGE vs. SUPPLY VOLTAGE



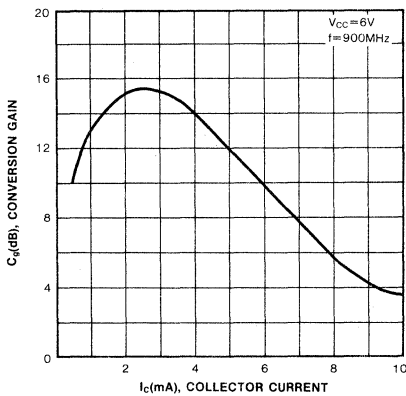
2ND I.M.DISTORTION vs. COLLECTOR CURRENT



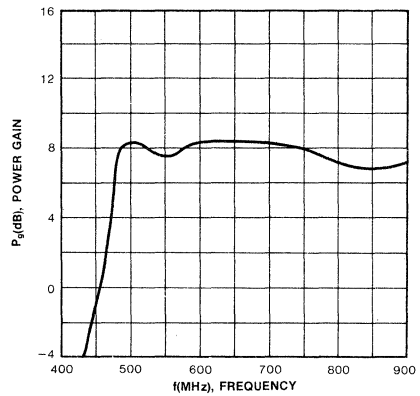
3RD I.M. DISTORTION vs. COLLECTOR CURRENT



CONVERSION GAIN vs. COLLECTOR CURRENT



POWER GAIN vs. FREQUENCY



**LOW NOISE AMPLIFIER
FOR VHF/UHF**

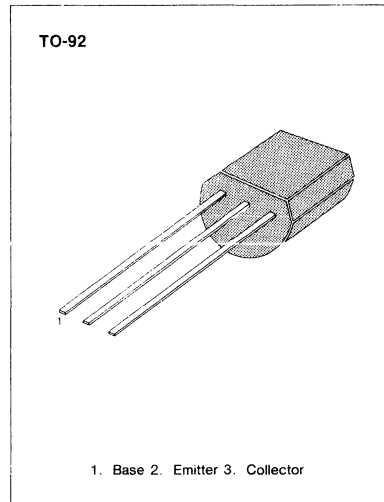
High $f_T = 5\text{GHz}$

NF = 1.5dB, $|S_{21e}|^2 = 16\text{dB}$ (f = 500MHz)

NF = 1.7dB, $|S_{21e}|^2 = 10.5\text{dB}$ (f = 1000MHz)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

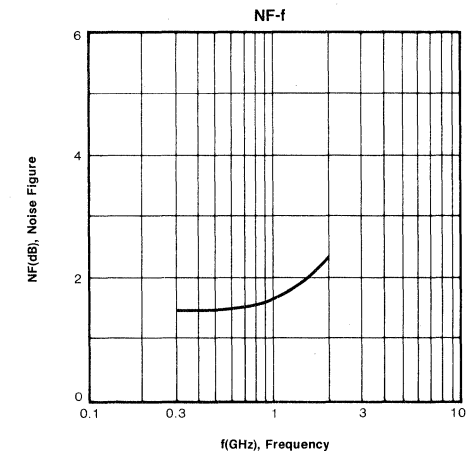
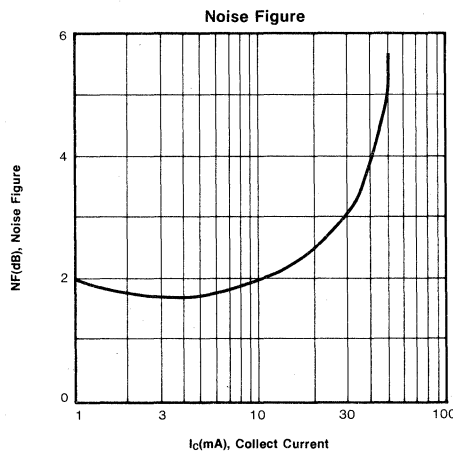
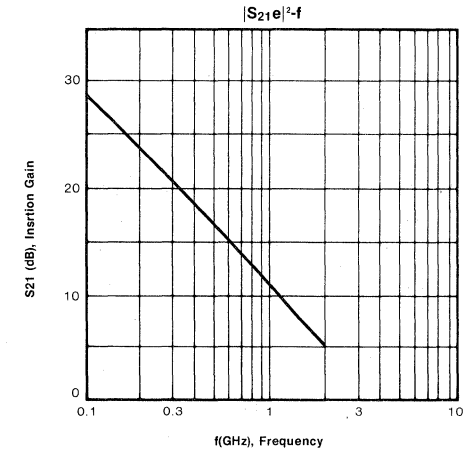
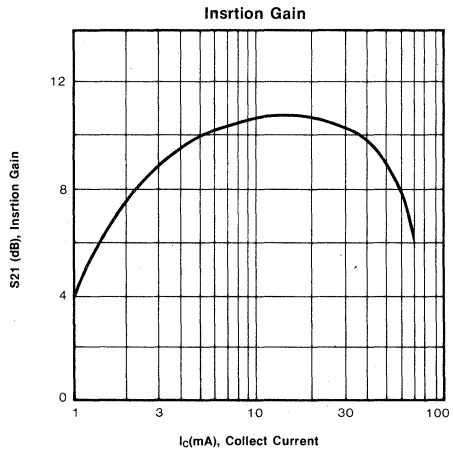
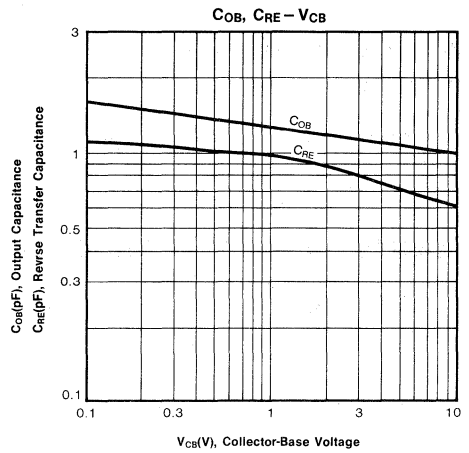
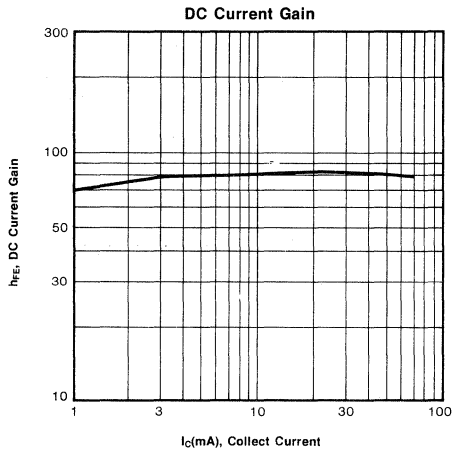
Characteristics	Symbol	Rating	Unit
Collector Base Voltage	V_{CB0}	17	V
Collector Emitter Voltage	V_{CE0}	12	V
Emitter Base Voltage	V_{EB0}	3	V
Collector Current	I_C	70	mA
Base Current	I_B	30	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

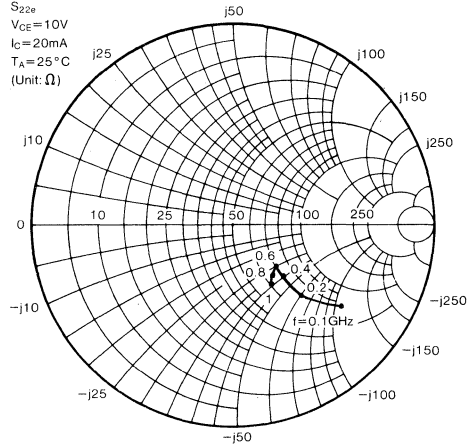
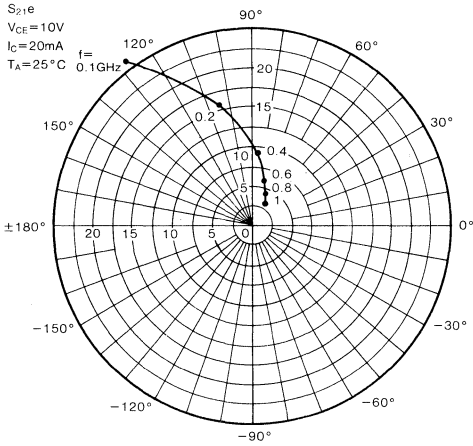
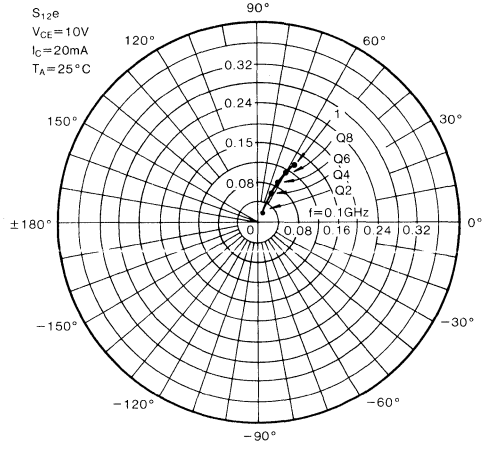
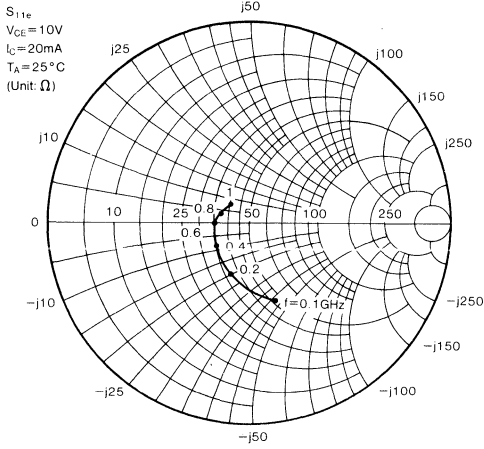


3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CB0}	$V_{CB} = 10\text{V}, I_E = 0$	—	—	1	μA
Emitter Cutoff Current	I_{EB0}	$V_{EB} = 1\text{V}, I_C = 0$	—	—	1	μA
D.C Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 20\text{mA}$	30	—	180	
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 20\text{mA}$	—	5	—	GHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$	—	1.1	—	pF
Reverse Transfer Capacitance	C_{RE}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$	—	0.65	—	pF
Insertion Gain	$ S_{21e} ^2(1)$ $ S_{21e} ^2(2)$	$V_{CE} = 10\text{V}, I_C = 20\text{mA}, f = 500\text{MHz}$ $V_{CE} = 10\text{V}, I_C = 20\text{mA}, f = 1000\text{MHz}$	—	16	—	dB
Noise Figure	NF(1)	$V_{CE} = 10\text{V}, I_C = 5\text{mA}, f = 500\text{MHz}$	—	1.5	—	dB
	NF(2)	$V_{CE} = 10\text{V}, I_C = 5\text{mA}, f = 1000\text{MHz}$	—	1.7	—	dB





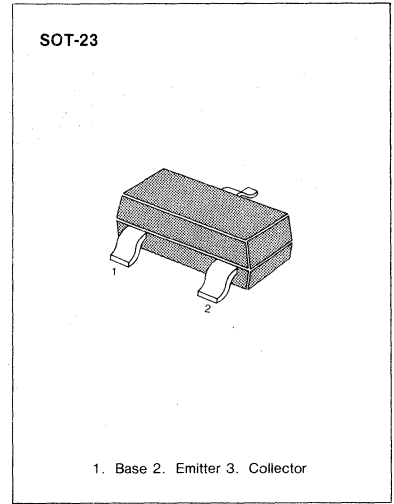
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RF AMP, FOR VHF TV TUNER

- LOW NF, HIGH G_{pe}
- NF=2.0dB Typ. G_{pe}=23dB Typ. (f=200MHz)
- FORWARD AGC CAPABILITY TO 30 dB

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	30	V
Collector-Emitter Voltage	V _{CE0}	30	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current (DC)	I _C	20	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C



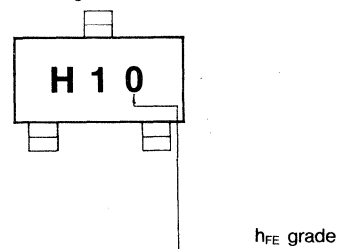
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CB0}	V _{CB} =20V, I _E =0			0.1	μA
DC Current Gain	h _{FE}	V _{CE} =10V, I _C =3mA	60	120	240	
Current Gain Bandwidth Product	f _T	V _{CE} =10V, I _C =3mA	400	600		MHz
Reverse Transfer Capacitance	C _{re}	f=1MHz, V _{CB} =10V, I _E =0		0.3	0.5	pF
Power Gain	G _{pe}	f=200MHz, I _C =3mA	20	23		dB
AGC Current	I _{AGC}	f=200MHz		-10	-12	mA
Noise Figure	NF	I _E of G _{pe} -30dB f=200MHz, I _C =3mA		2.0	3.0	dB

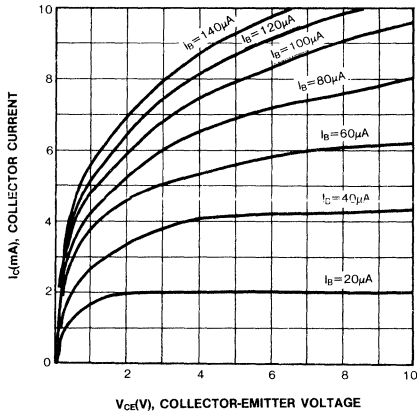
h_{FE} CLASSIFICATION

Classification	R	O	Y
h _{FE}	60-120	90-180	120-240

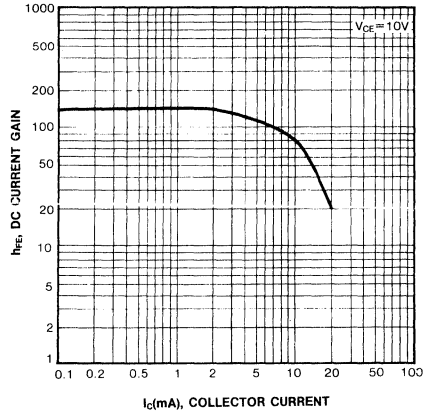
Marking



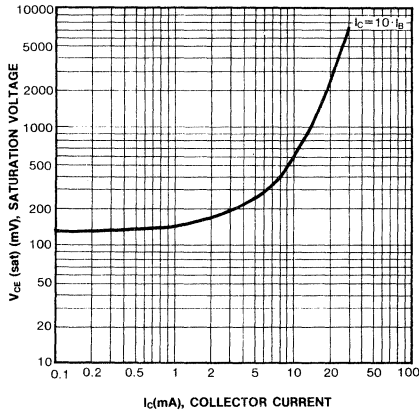
I_C - V_{CE} CHARACTERISTIC



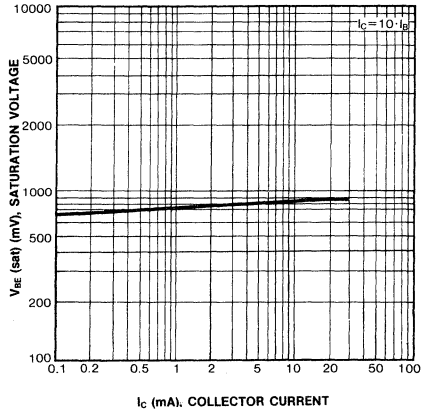
h_{FE} - I_C CHARACTERISTIC



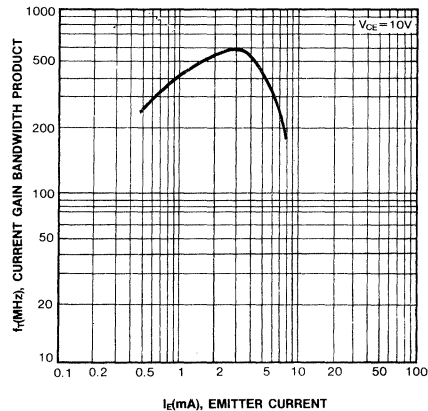
$V_{CE(sat)}$ - I_C CHARACTERISTIC



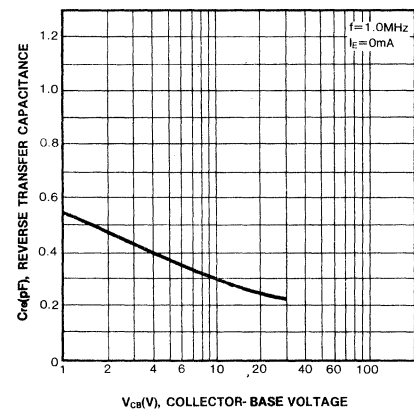
$V_{BE(sat)}$ - I_C CHARACTERISTIC



f_T - I_E CHARACTERISTIC

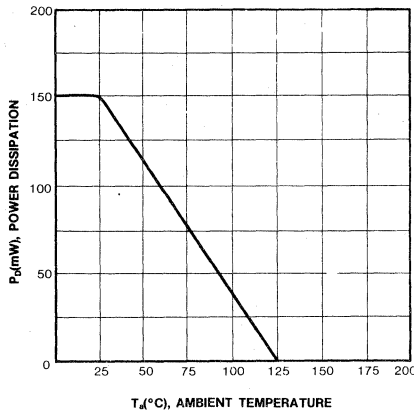


C_{re} - V_{CB} CHARACTERISTIC

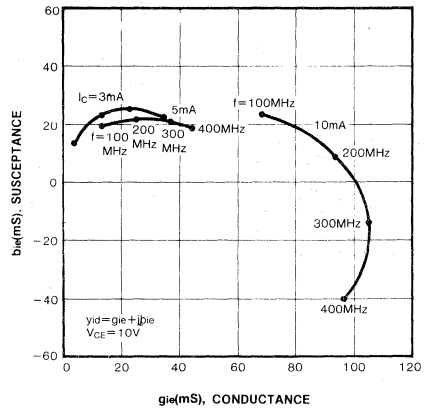


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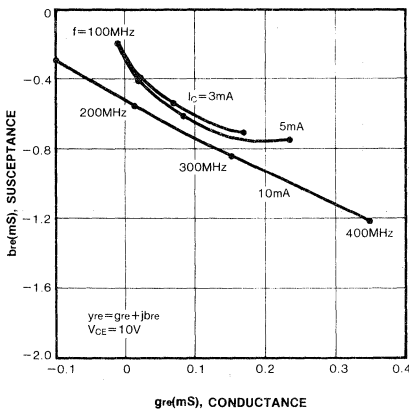
P_D - T_a CHARACTERISTIC



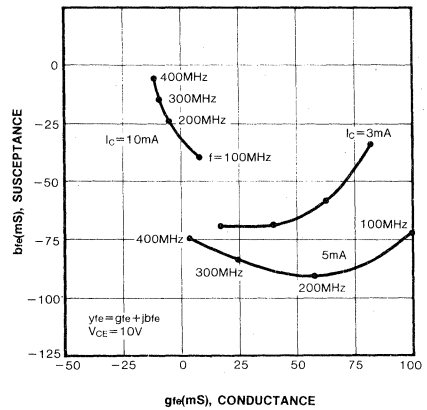
y_{ie} - f CHARACTERISTIC



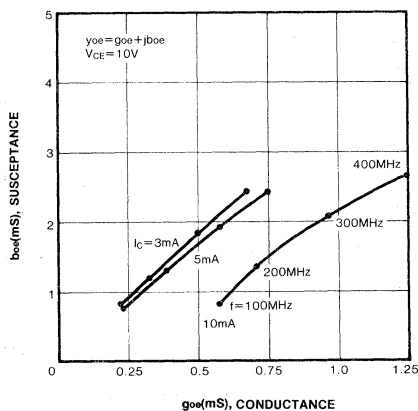
y_{re} - f CHARACTERISTIC



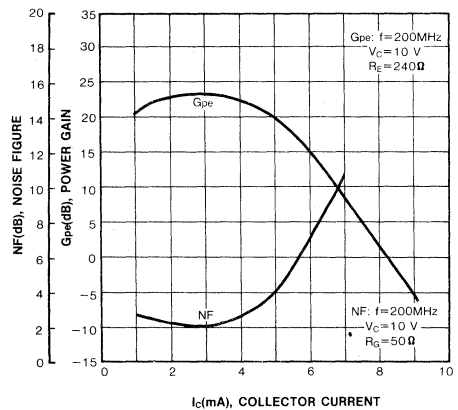
y_{fe} - f CHARACTERISTIC



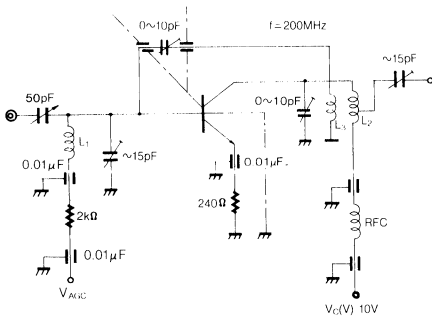
y_{oe} - f CHARACTERISTIC



G_{pe} - I_C , NF- I_C CHARACTERISTIC



POWER GAIN AND NOISE FIGURE TEST



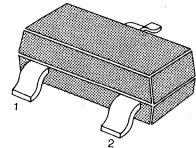
MIXER FOR VHF TV TUNER

- HIGH Gce (Typ. 23dB)

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	20	V
Emitter-Base Voltage	V _{EBO}	4	V
Collector Current	I _C	30	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C

SOT-23



1. Base 2. Emitter 3. Collector

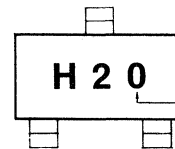
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} = 20V, I _E = 0			0.1	μA
DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 5mA	60	120	240	
Collector Emitter Saturation Voltage	V _{CE} (sat)	I _C = 10mA, I _B = 1mA			0.5	V
Current Gain Bandwidth Product	f _T	V _{CE} = 10V, I _E = 5mA	500	850		MHz
Reverse Transfer Capacitance	C _{re}	V _{CB} = 10V, I _E = 0, f = 1MHz		0.35	0.5	pF
Conversion Gain	G _{ce}	V _{CE} = 10V, I _C = 3mA	15	23		dB
Noise Figure	NF	f _{RF} = 200MHz, I _F = 58MHz V _{CE} = 10V, I _C = 3mA f _{RF} = 200MHz, I _F = 58MHz		6.5		dB

h_{FE} CLASSIFICATION

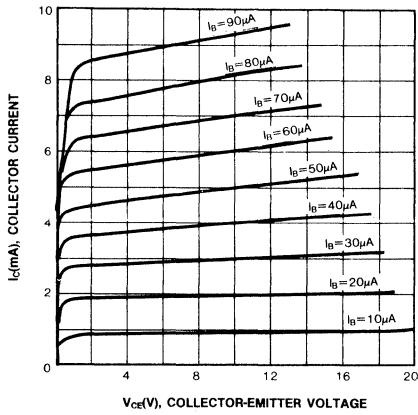
Classification	R	O	Y
h _{FE}	60-120	90-180	120-240

Marking

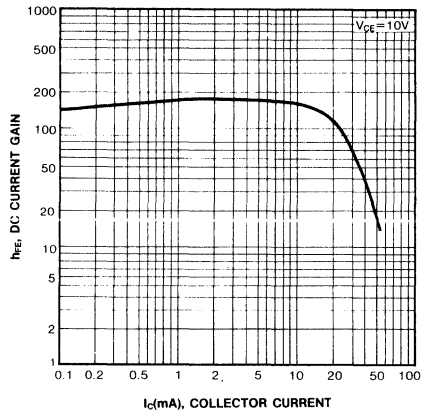


h_{FE} grade

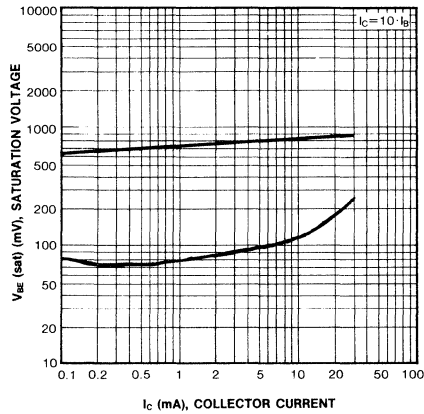
I_C - V_{CE} CHARACTERISTIC



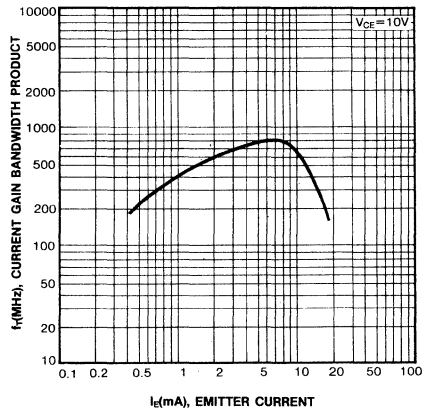
h_{FE} - I_C CHARACTERISTIC



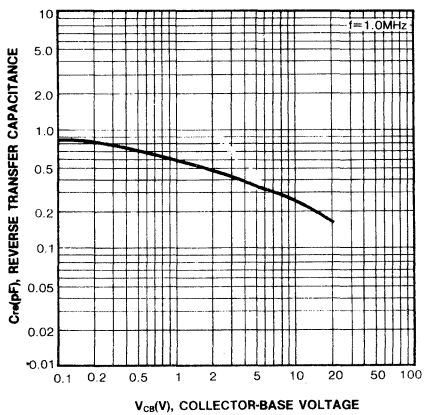
$V_{CE(sat)}$, $V_{BE(sat)}$ - I_C CHARACTERISTIC



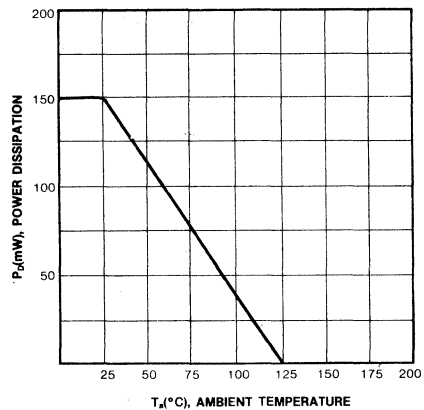
f_T - I_E CHARACTERISTIC



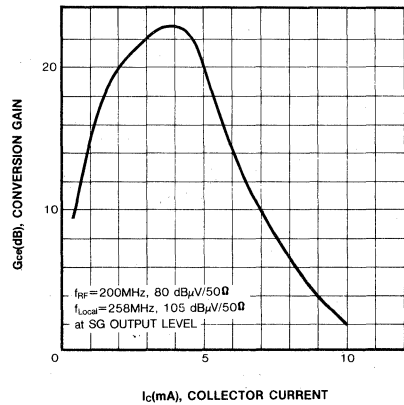
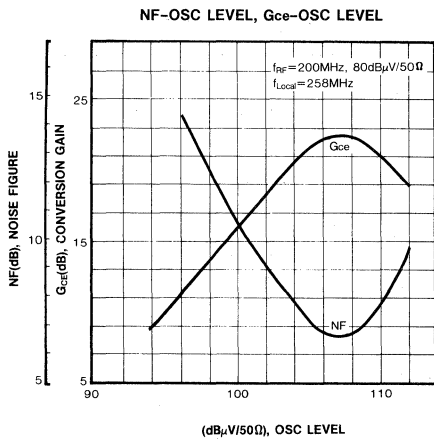
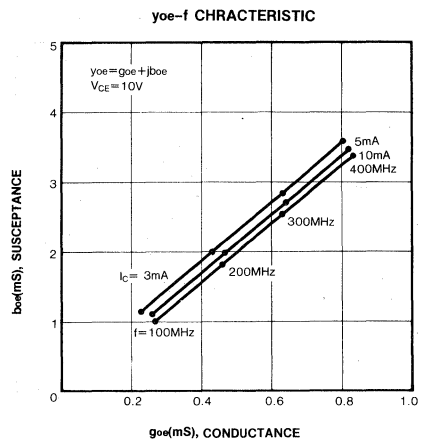
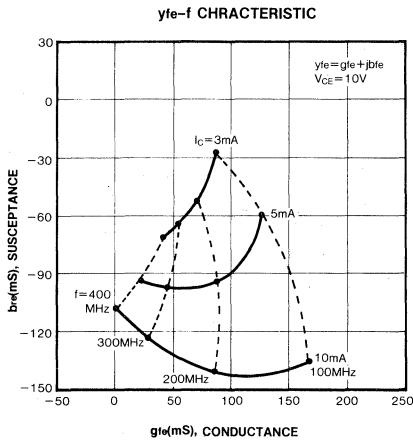
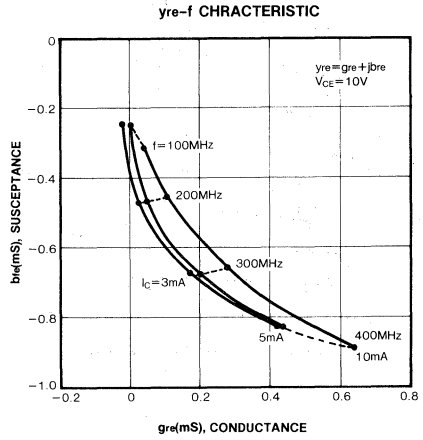
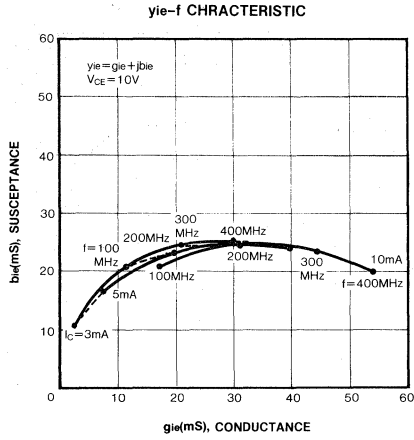
C_{re} - V_{CB} CHARACTERISTIC



P_D - T_A CHARACTERISTIC



3

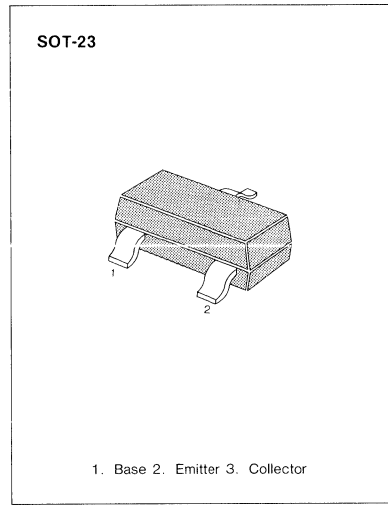


MIXER OSCILLATOR FOR VHF TUNER

HIGH f_T ($f_T=1100\text{MHz Typ.}$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V_{CBU}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$



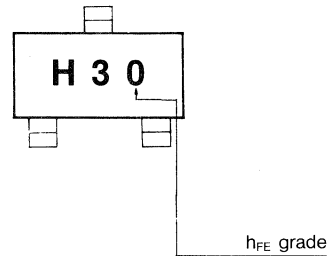
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=12\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=5\text{mA}$	60	120	240	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_E=5\text{mA}$	800	1100		MHz
Output Capacitance	C_{ob}	$f=1\text{MHz}, V_{CB}=10\text{V}, I_E=0$			1.5	pF
Collector Base Time Constant	$C_C \cdot r_{bb}$	$f=31.9\text{MHz}, V_{CE}=10\text{V}, I_E=5\text{mA}$		10	15	ps

h_{FE} CLASSIFICATION

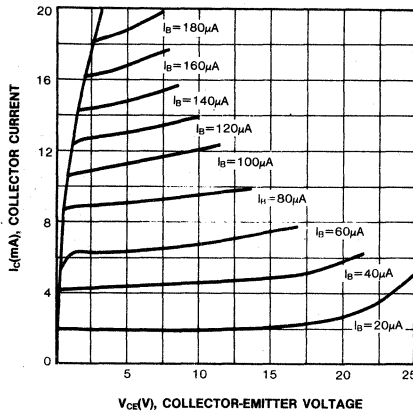
Classification	R	O	Y
h_{FE}	60-120	90-180	120-240

Marking

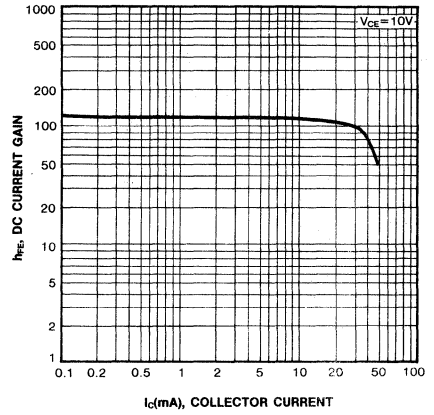


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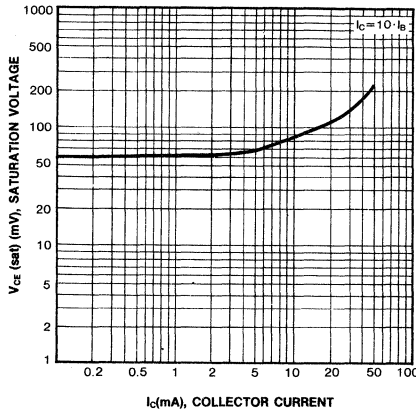
I_C - V_{CE} CHARACTERISTIC



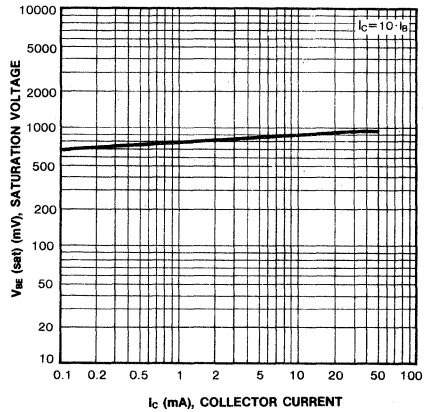
h_{FE} - I_C CHARACTERISTIC



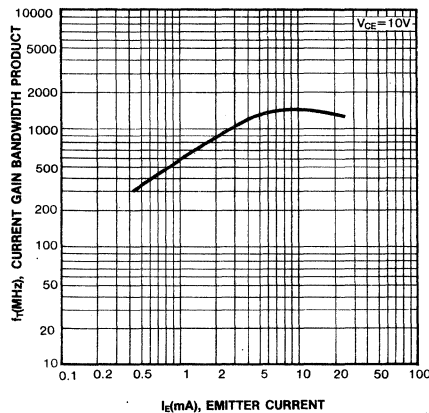
$V_{CE(sat)}$ - I_C CHARACTERISTIC



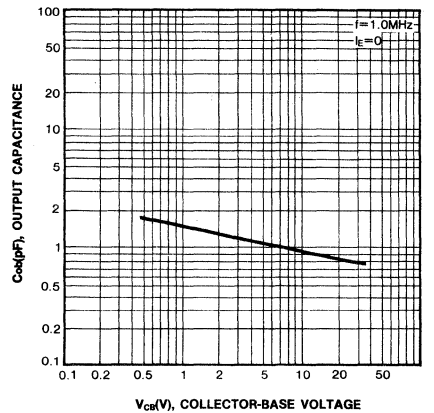
$V_{BE(sat)}$ - I_C CHARACTERISTIC



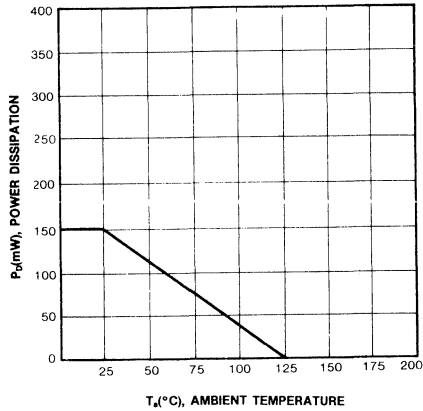
f_T - I_E CHARACTERISTIC



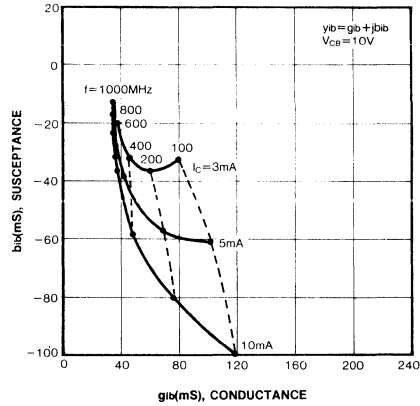
Cob- V_{CB} CHARACTERISTIC



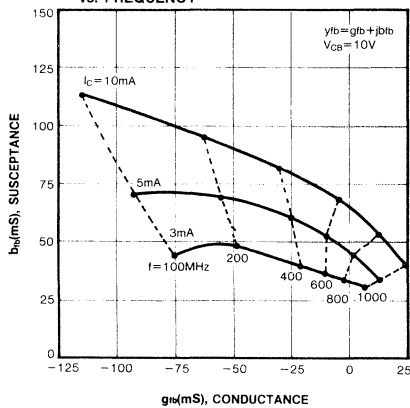
P_D - T_a CHARACTERISTIC



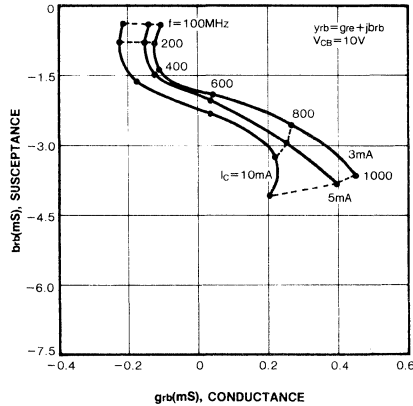
INPUT ADMITTANCE (y_{ib}) vs. FREQUENCY



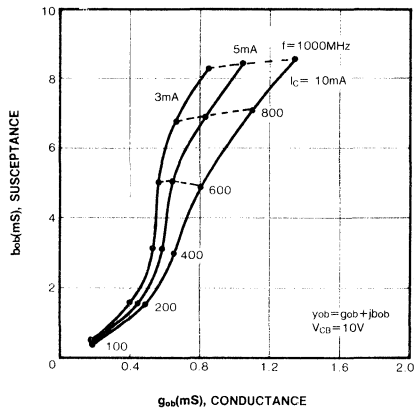
FORWARD TRANSFER ADMITTANCE (y_{fb}) vs. FREQUENCY



REVERSE TRANSFER ADMITTANCE (y_{rb}) vs. FREQUENCY



OUTPUT ADMITTANCE (y_{ob}) vs. FREQUENCY



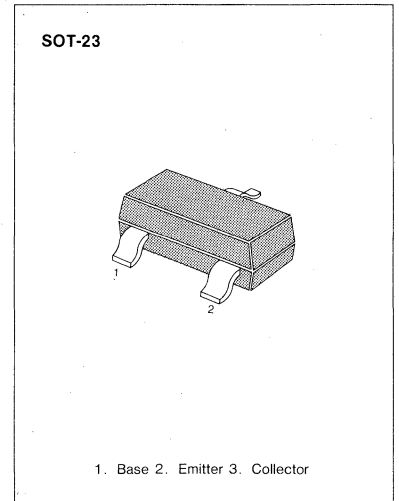
3

RF. MIXER FOR UHF TUNER

- HIGH POWER GAIN TYP. 17dB
- LOW NF TYP. 2.8dB

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

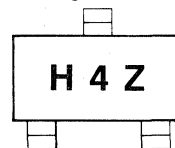
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	4	V
Collector Current (DC)	I _C	20	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C



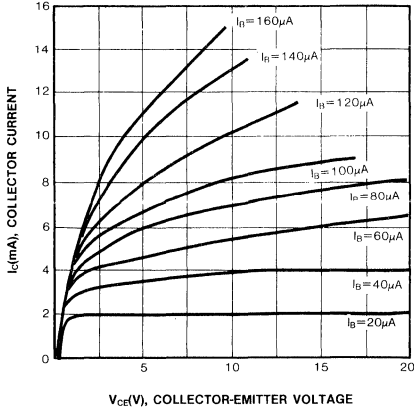
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} = 25V, I _E = 0			0.1	μA
DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 3mA	60	120	240	
Current Gain Bandwidth Product	f _T	V _{CE} = 10V, I _E = 3mA	750	1000		MHz
Output Capacitance	C _{ob}	f = 1MHz, V _{CB} = 10V, I _E = 0		0.6	0.8	pF
Noise Figure	NF	V _{CB} = 10V, I _E = 3mA f = 900MHz		2.8	4.5	dB
Power Gain	G _{pb}	V _{CB} = 10V, I _E = 3mA, f = 900MHz	14	17		dB
AGC Current	I _{AGC}	G _{pb} AGC = I _E of G _{pb} - 30dB		-8	-11	mA

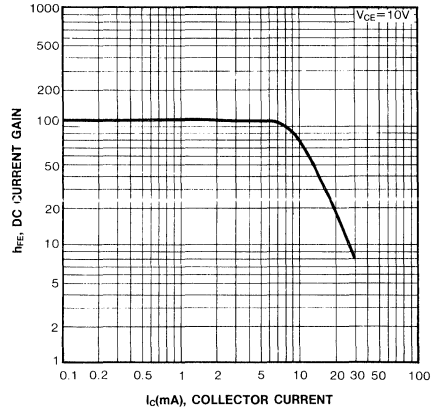
Marking



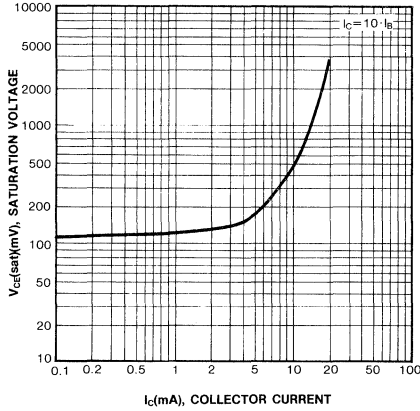
I_C - V_{CE} CHARACTERISTIC



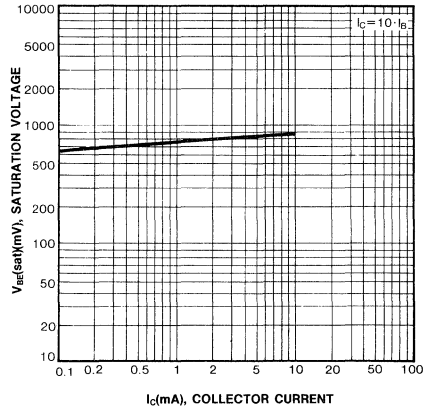
h_{FE} - I_C CHARACTERISTIC



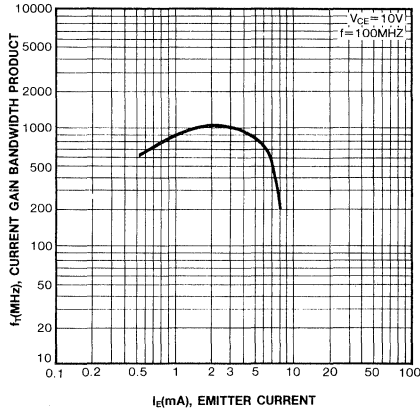
$V_{CE(sat)}$ - I_C CHARACTERISTIC



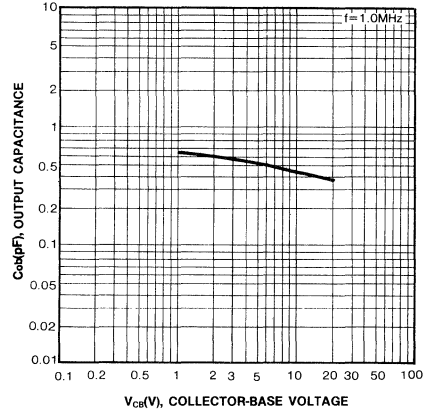
$V_{BE(sat)}$ - I_C CHARACTERISTIC



f_T - I_E CHARACTERISTIC

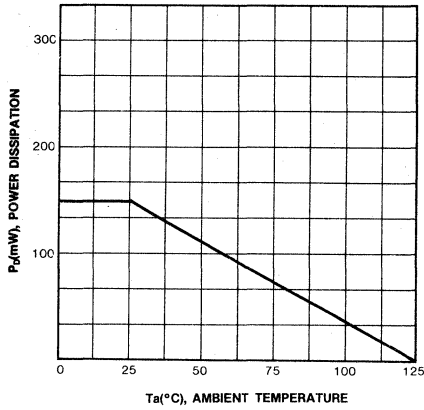


C_{ob} - V_{CB} CHARACTERISTIC

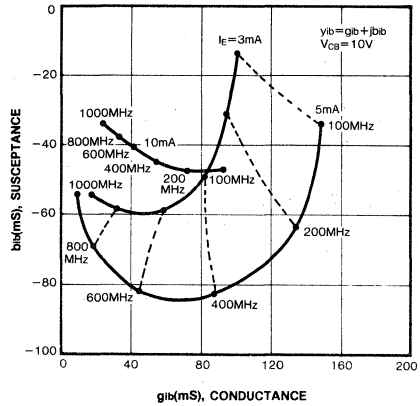


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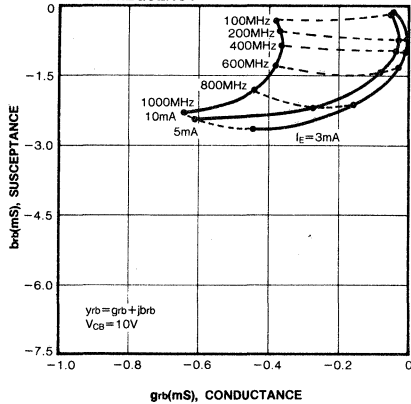
P_D - T_a CHARACTERISTIC



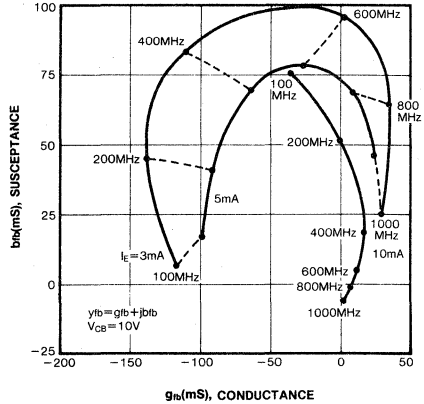
INPUT ADMITTANCE vs. FREQUENCY



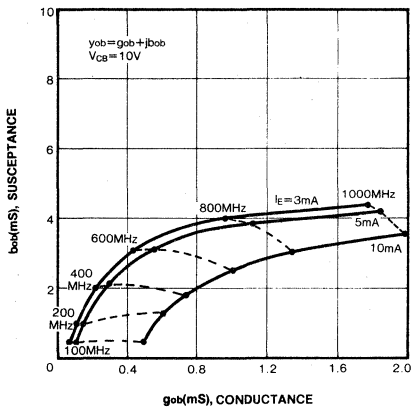
REVERSE TRANSFER ADMITTANCE vs. FREQUENCY



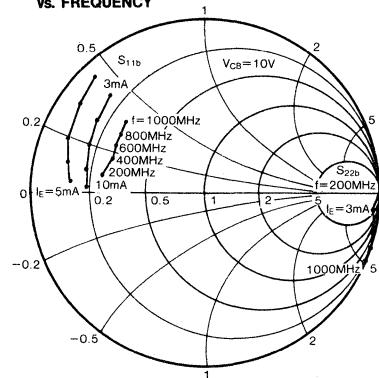
FORWARD TRANSFER ADMITTANCE vs. FREQUENCY



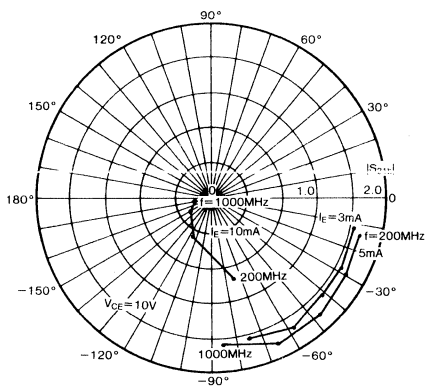
OUTPUT ADMITTANCE vs. FREQUENCY



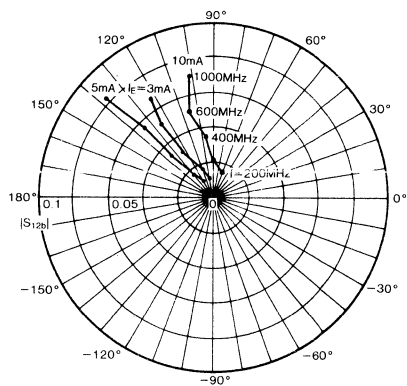
INPUT AND OUTPUT REFLECTION COEFFICIENT vs. FREQUENCY



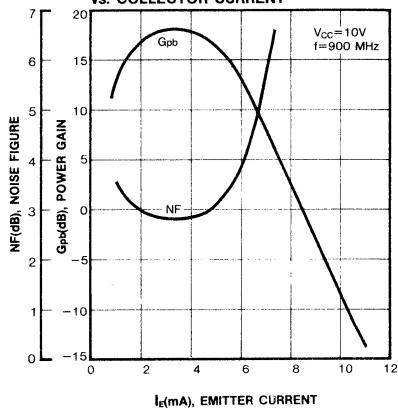
FORWARD INSERTION GAIN vs. FREQUENCY



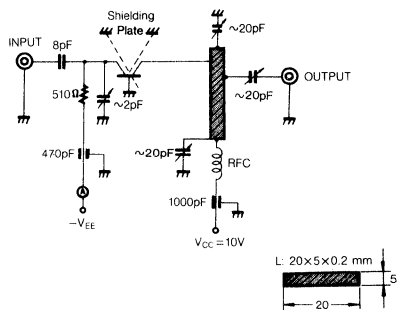
REVERSE INSERTION GAIN vs. FREQUENCY



POWER GAIN AND NOISE FIGURE vs. COLLECTOR CURRENT



900 MHz Gpb, NF TEST CIRCUIT

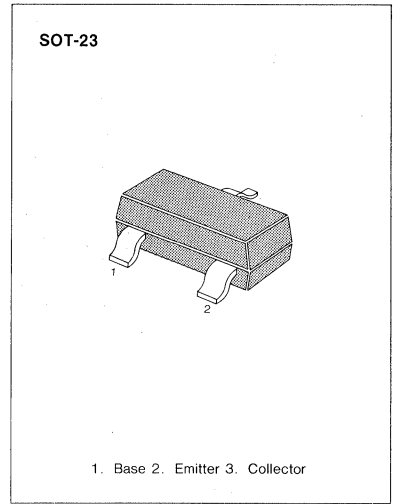


3

MIXER, OSCILLATOR FOR UHF TUNER

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	14	V
Emitter-Base Voltage	V _{EBO}	3	V
Collector Current	I _C	50	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C



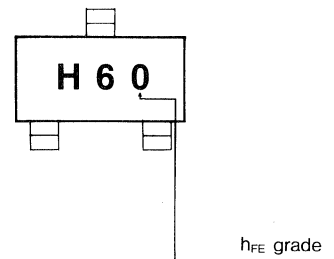
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} = 15V, I _E = 0			0.1	μA
DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 5mA	40	100	180	
Current Gain Bandwidth Product	f _T	V _{CE} = 10V, I _C = 5mA	1.5	2		GHz
Output Capacitance	C _{ob}	V _{CB} = 10V, I _E = 0, f = 1MHz		1	1.3	pF
Conversion Gain	G _{cb}	V _{CB} = 10V, I _E = 5mA f _{RF} = 900MHz, f _{osc} = 935MHz 115dBμ	10	12.5		dB

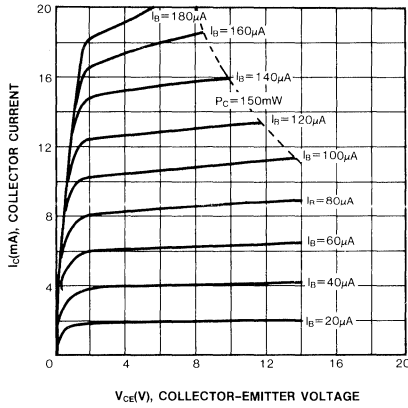
h_{FE} CLASSIFICATION

Classification	R	O	Y
h _{FE}	40-80	60-120	90-180

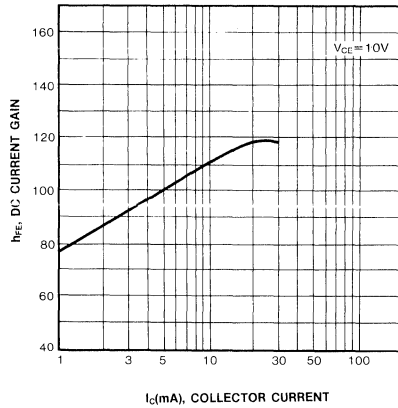
Marking



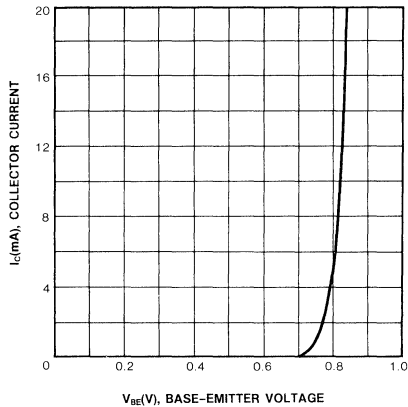
STATIC CHARACTERISTIC



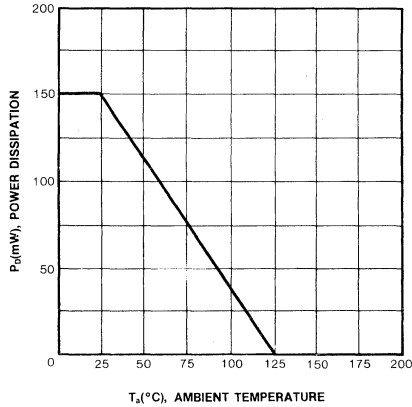
DC CURRENT GAIN



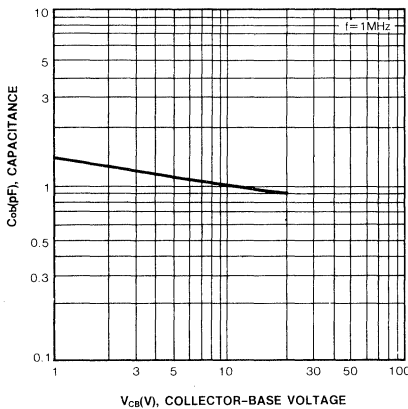
BASE-EMITTER ON VOLTAGE



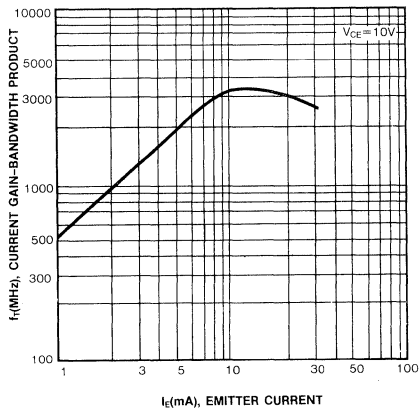
POWER DERATING



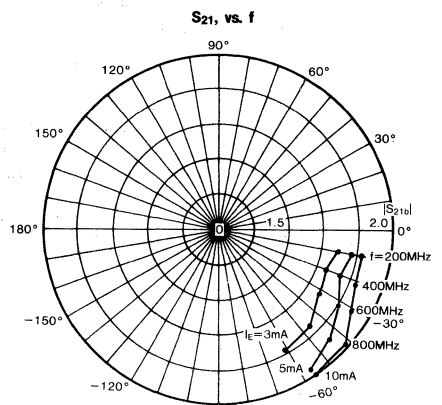
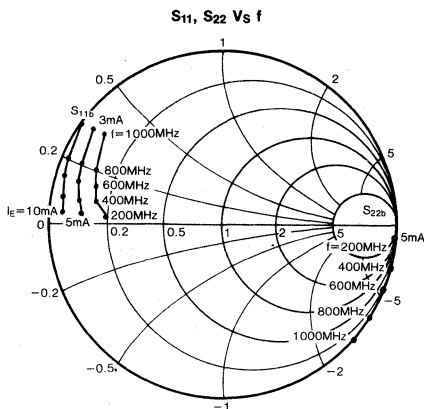
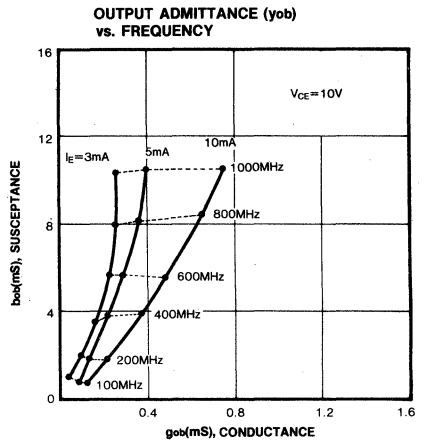
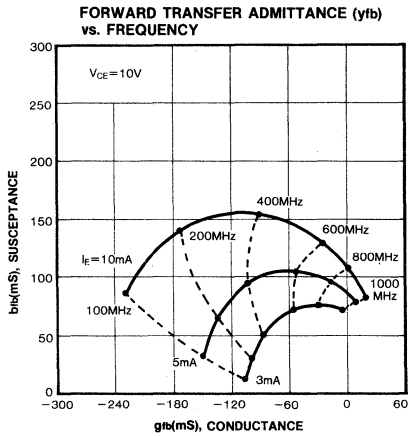
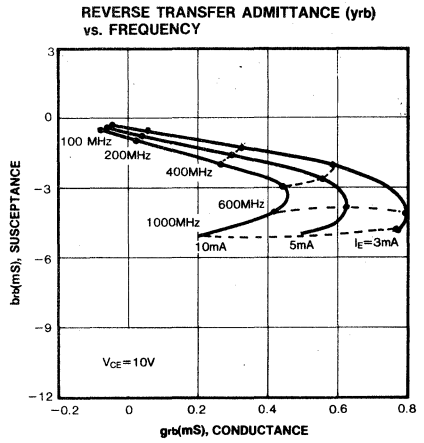
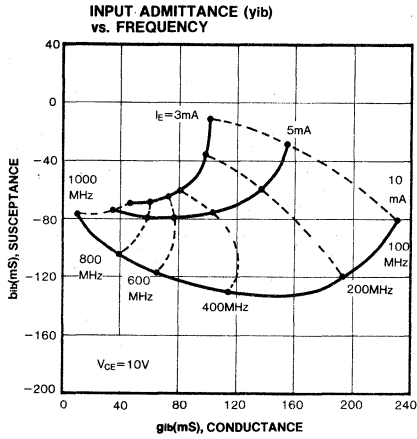
COLLECTOR OUTPUT CAPACITANCE

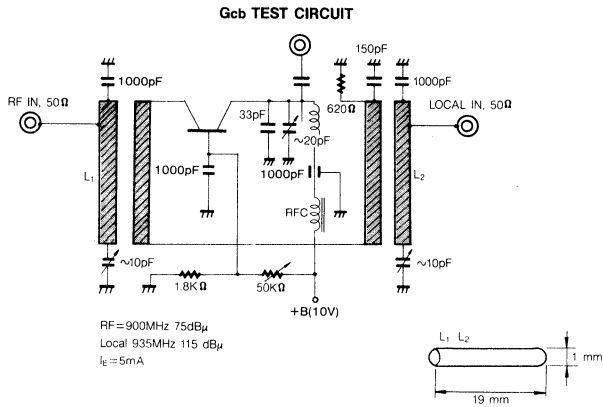
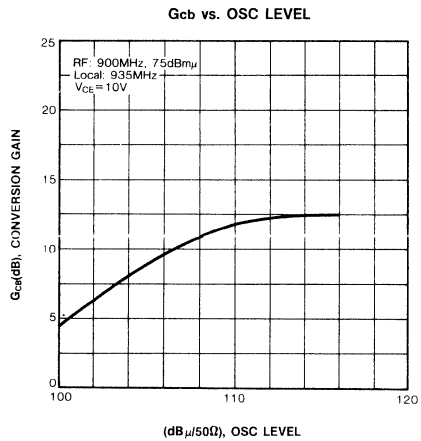
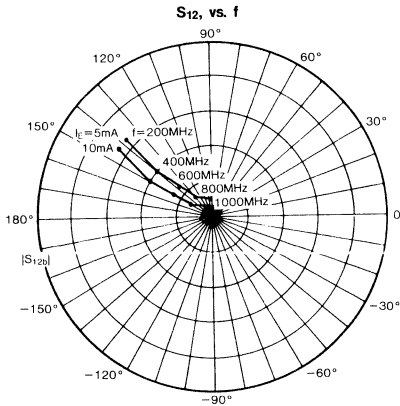


CURRENT GAIN - BANDWIDTH PRODUCT



3





3

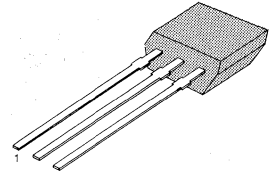
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSA1174

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Base Current	I_B	10	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

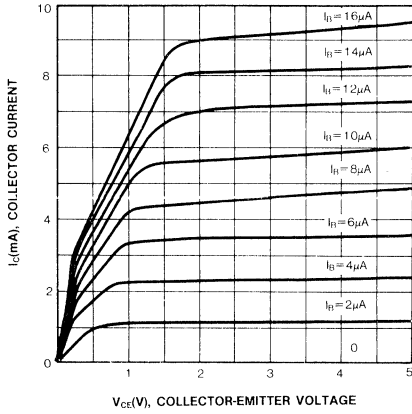
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 120\text{V}, I_E = 0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			50	nA
DC Current Gain	h_{FE1}	$V_{CE} = 6\text{V}, I_C = 0.1\text{mA}$	150	580		
	h_{FE2}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	200	600	1200	
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.55	0.59	0.65	V
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.07	0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_E = 1\text{mA}$	50	110		MHz
Output Capacitance	C_{ob}	$V_{CB} = 30\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.6	2.5	pF
Noise Voltage	NV			25	40	mV

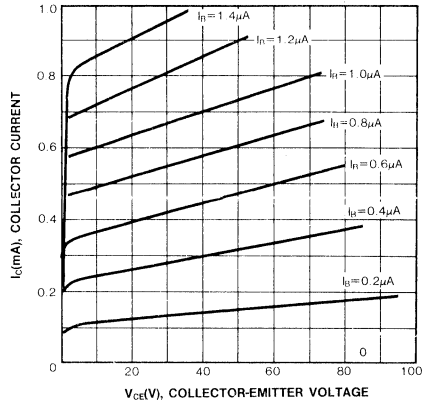
 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E	U
$h_{FE}(2)$	200-400	300-600	400-800	600-1200

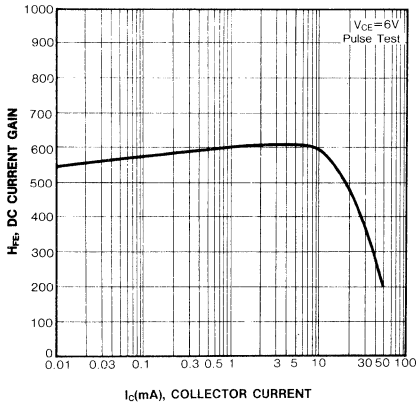
STATIC CHARACTERISTIC



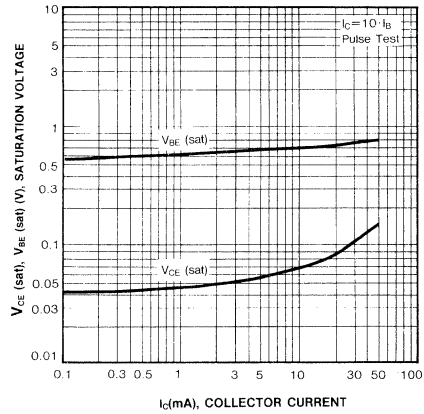
STATIC CHARACTERISTIC



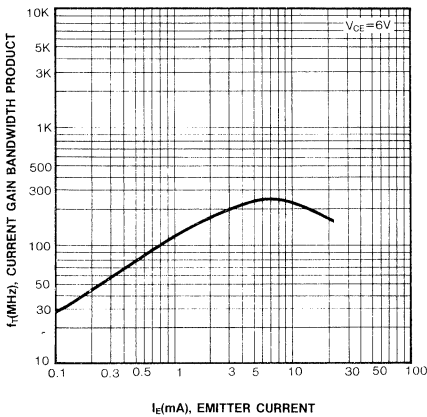
DC CURRENT GAIN



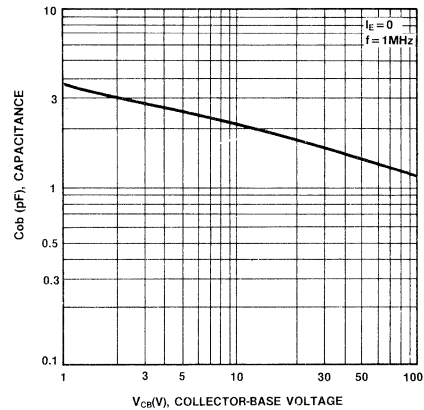
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE



3

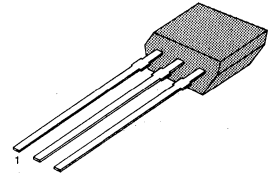
AUDIO FREQUENCY AMPLIFIER HIGH FREQUENCY OSC.

- Complement to KSA1175
- Collector-Base Voltage $V_{CBO} = 60V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92S



1. Emitter 2. Collector 3. Base

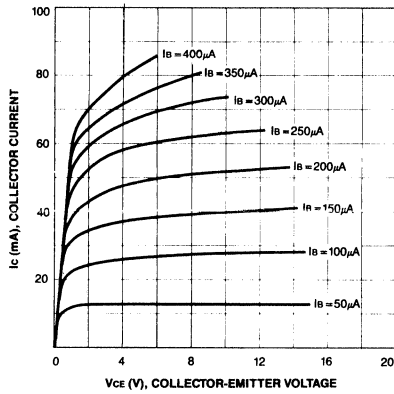
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1.0mA$	70		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100mA, I_B = 10mA$		0.15	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 10mA$		300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0$ $f = 1MHz$		2.5		pF
Noise Figure	NF	$V_{CE} = 6V, I_E = 0.5mA$ $f = 1KHz, R_s = 500\Omega$		4.0		dB

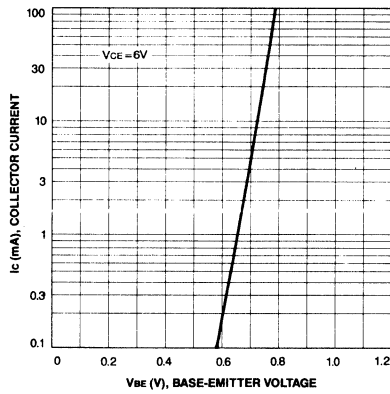
h_{FE} CLASSIFICATION

Classification	O	Y	G	L
h_{FE}	70-140	120-240	200-400	350-700

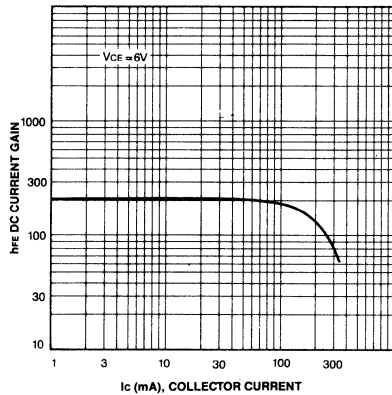
STATIC CHARACTERISTIC



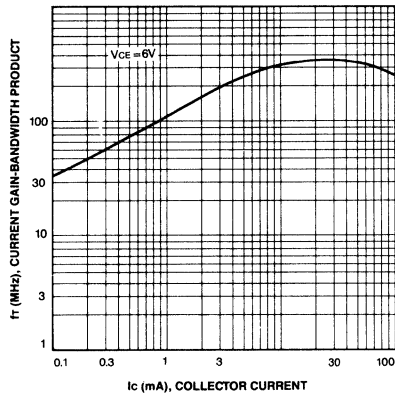
TRANSFER CHARACTERISTIC



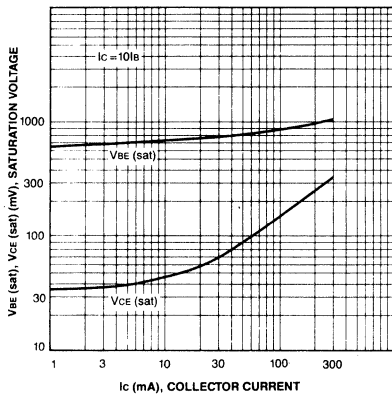
DC CURRENT GAIN



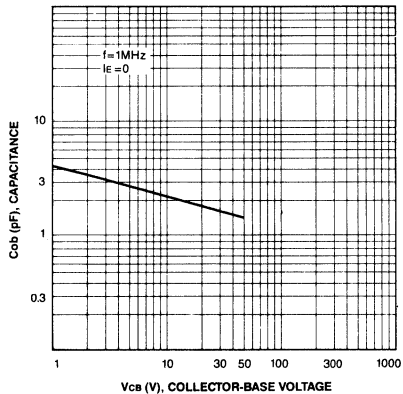
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

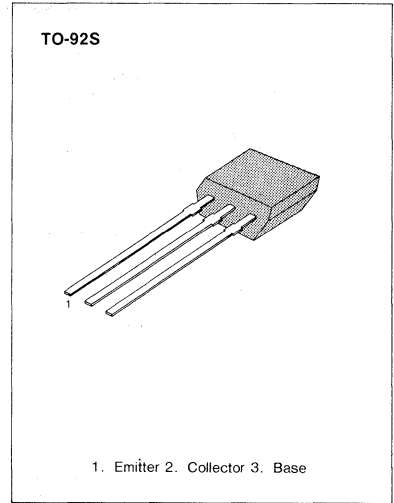


TV PIF AMPLIFIER, FM TUNER RF AMPLIFIER, MIXER, OSCILLATOR

- High Current-Gain-Bandwidth Product $f_T=600\text{MHz}$ (Typ)
- High Power Gain $G_{pe}=22\text{dB}$ at $f=100\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



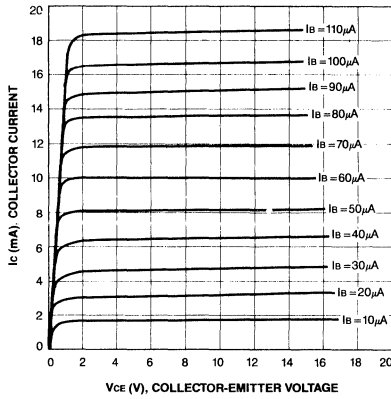
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=5\text{mA}, I_B=0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}, I_C=1\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=6\text{V}, I_C=1\text{mA}$		0.72		V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.1	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_C=1\text{mA}$	400	600		MHz
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}, I_E=0$ $f=1\text{MHz}$		1.2		pF
Collector-Base Time Constant	C_c' rbb'	$V_{CE}=6\text{V}, I_E=1\text{mA}$ $f=31.9\text{MHz}$		12	15	ps
Common Source Noise Figure	NF	$V_{CE}=6\text{V}, I_E=1\text{mA}$ $R_S=50\Omega, f=100\text{MHz}$		3.0	5.0	dB
Power Gain	G_{pe}	$V_{CE}=6\text{V}, I_E=1\text{mA}$ $R_S=50\Omega, f=100\text{MHz}$ (Typ)	18	22		dB

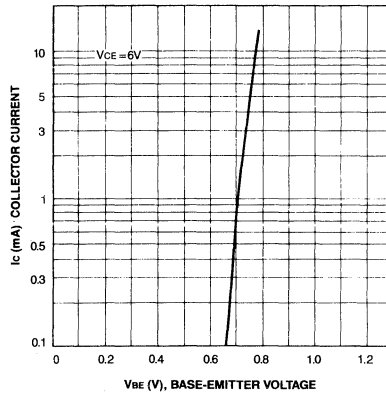
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

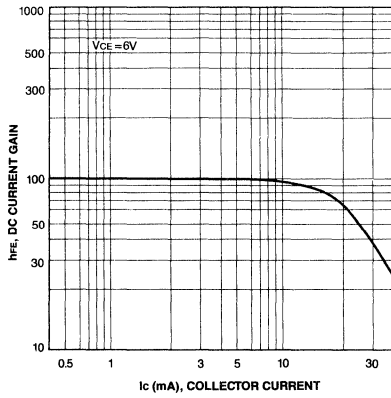
STATIC CHARACTERISTIC



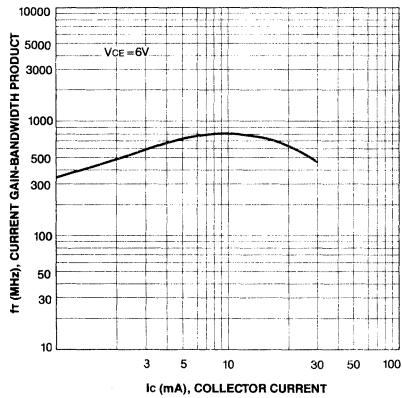
BASE-EMITTER ON VOLTAGE



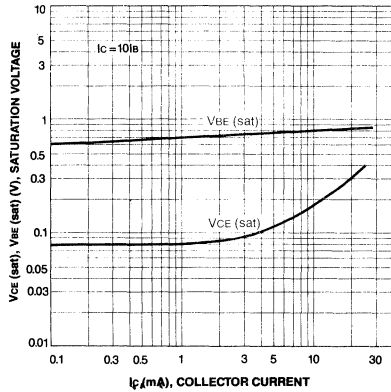
DC CURRENT GAIN



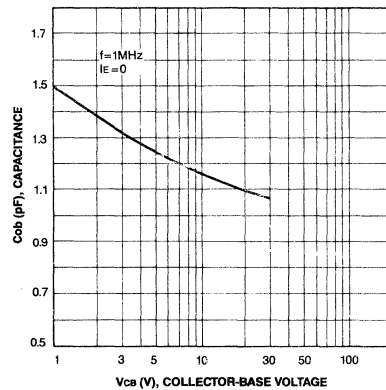
CURRENT GAIN-BANDWIDTH PRODUCT



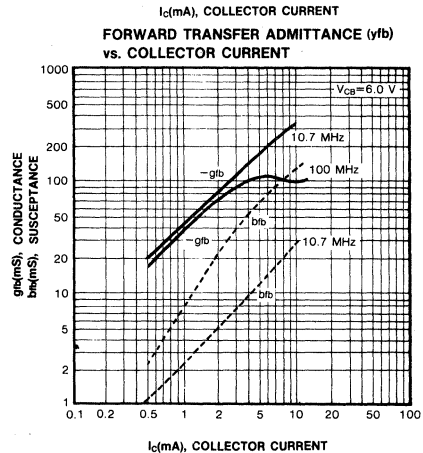
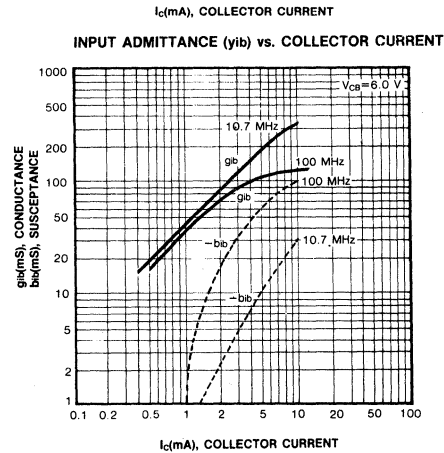
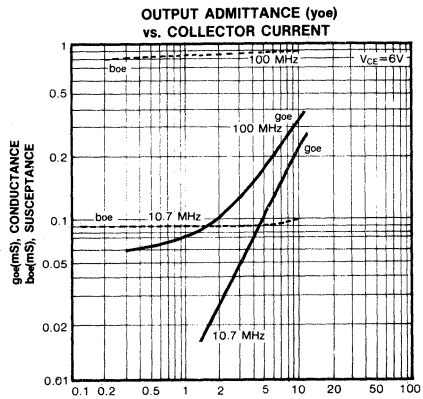
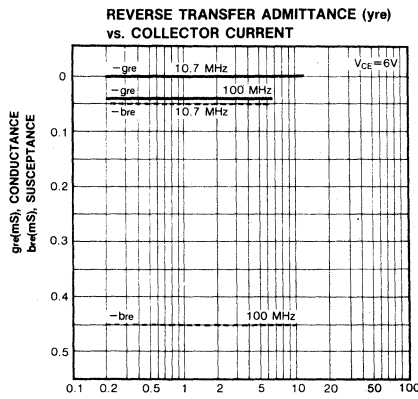
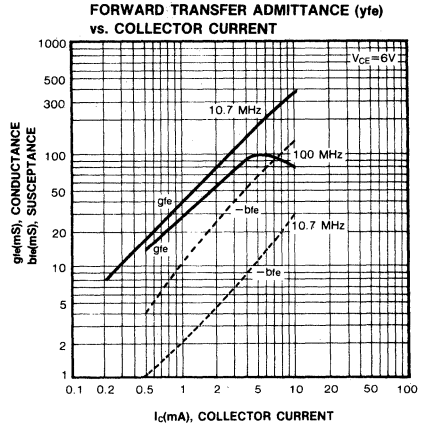
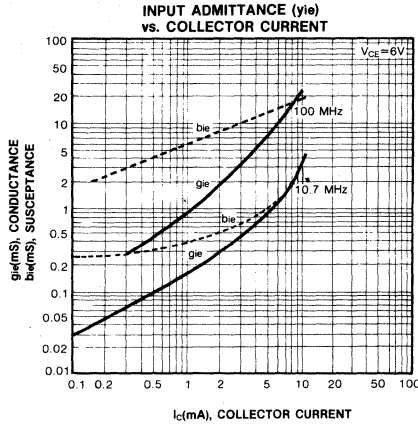
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

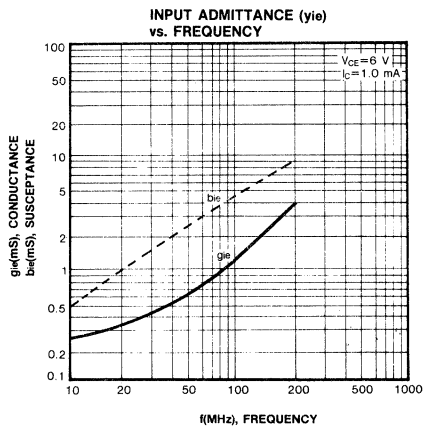
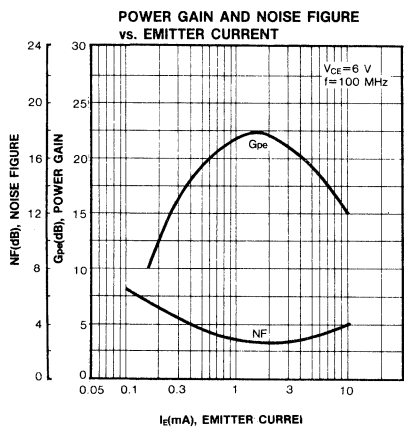
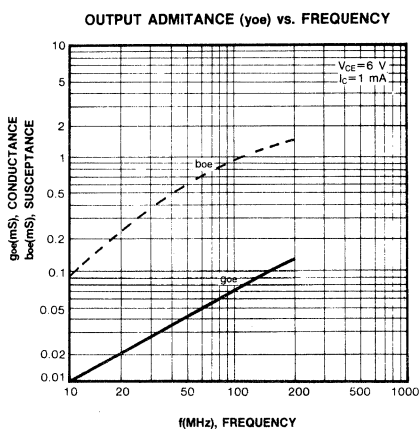
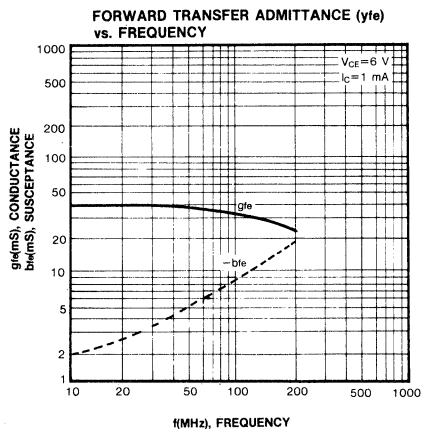
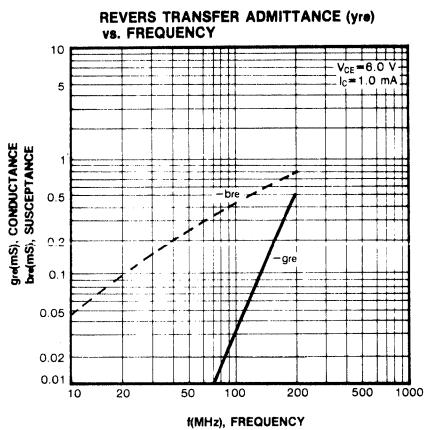
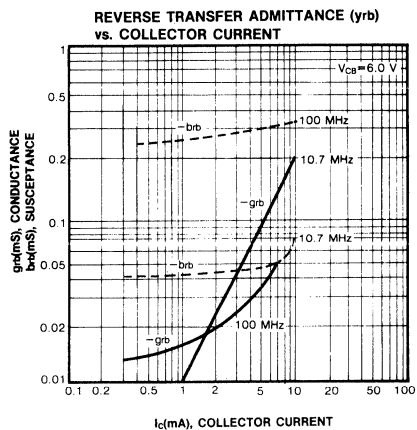


COLLECTOR OUTPUT CAPACITANCE



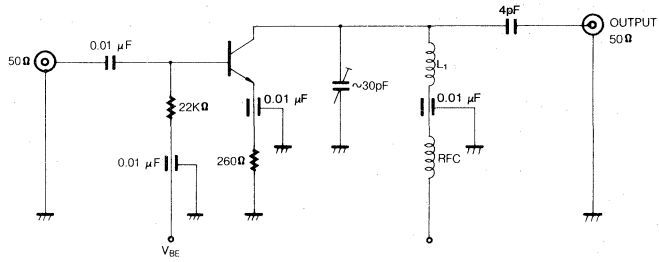
3





3

100MHz G_{pe} , NF TEST CIRCUIT

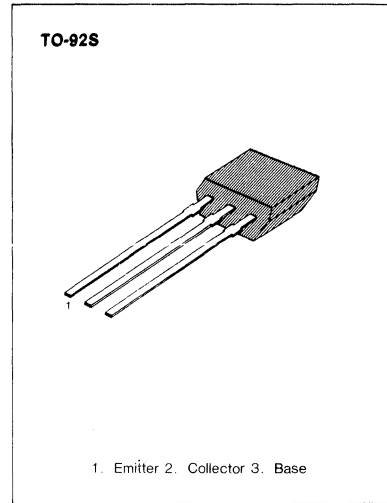


FM/AM RF AMP, MIX, CONV, OSC, IF

- Collector-Base Voltage $V_{CBO} = 30V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)
- Low Collector Capacitance $C_{ob} = 2.0PF$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



3

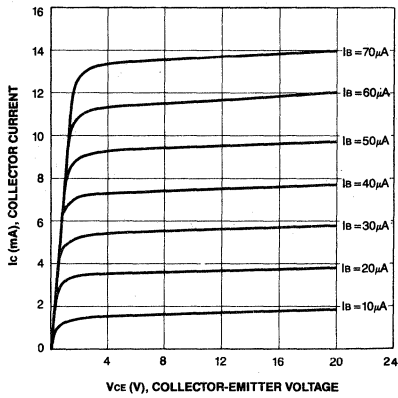
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1mA$	40		240	
Base-Emitter On Voltage	$V_{BE} (on)$	$V_{CE} = 6V, I_C = 1mA$		0.67	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = 10mA, I_B = 1mA$		0.08	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 1mA$	150	300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, f = 1MHz$		2.0	2.5	PF

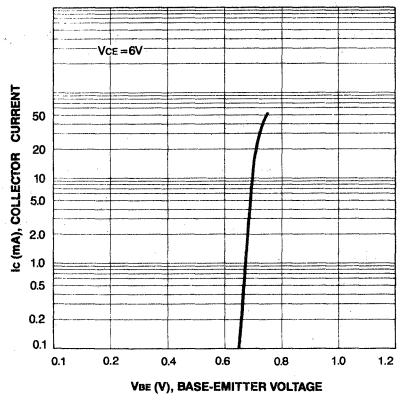
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

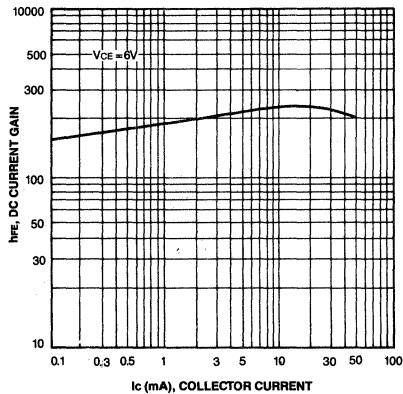
STATIC CHARACTERISTIC



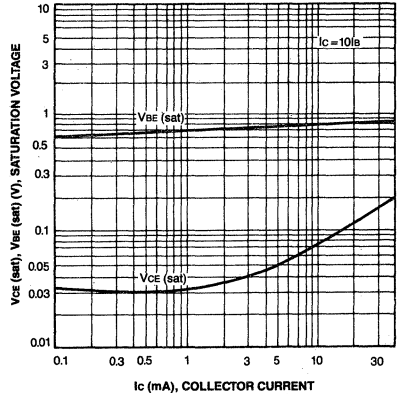
BASE-EMITTER ON VOLTAGE



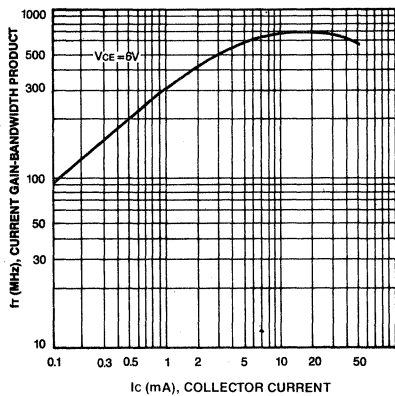
DC CURRENT GAIN



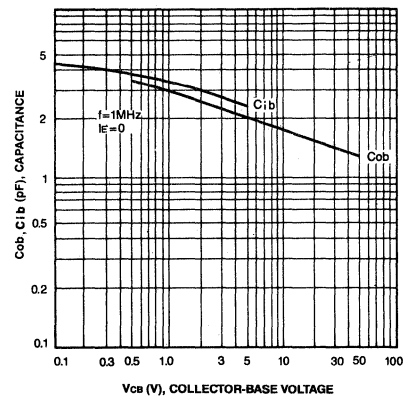
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE

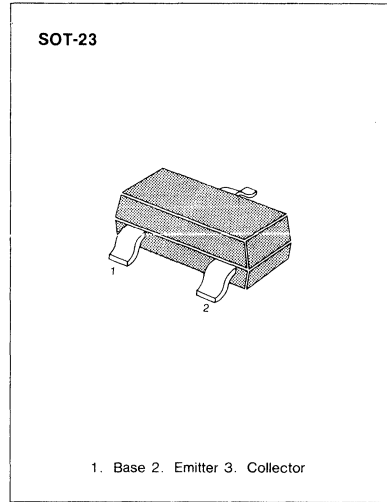


LOW FREQUENCY POWER AMPLIFIER

• Complement to KSA1182

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	35	V
Collector-Emitter Voltage	V _{CEO}	30	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	500	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C



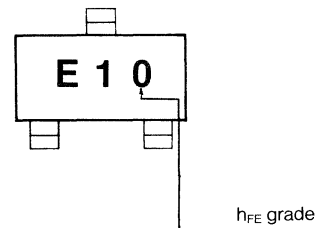
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} =35V, I _E =0			0.1	μA
Emitter Cutoff Current	I _{EBO}	V _{EB} =5V, I _C =0			0.1	μA
DC Current Gain	h _{FE} (1)	V _{CE} =1V, I _C =100mA	70		240	
	h _{FE} (2)	V _{CE} =6V, I _C =400mA	25			
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C =100mA, I _B =10mA		0.1	0.25	V
Base-Emitter On Voltage	V _{BE(on)}	I _C =100mA, V _{CE} =1V		0.8	1.0	V
Current Gain-Bandwidth Product	f _T	I _C =20mA, V _{CE} =6V		300		MHz
Output Capacitance	C _{ob}	V _{CB} =6V, I _E =0 f=1MHz		7		pF

h_{FE} CLASSIFICATION

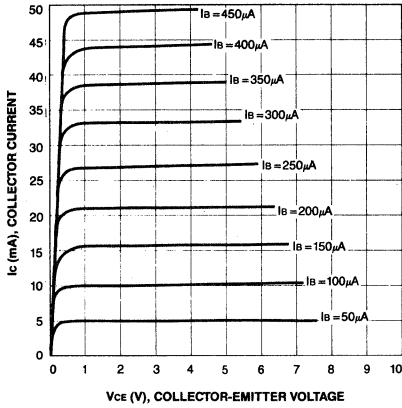
Classification	O	Y
h _{FE} (1)	70-140	120-240

Marking

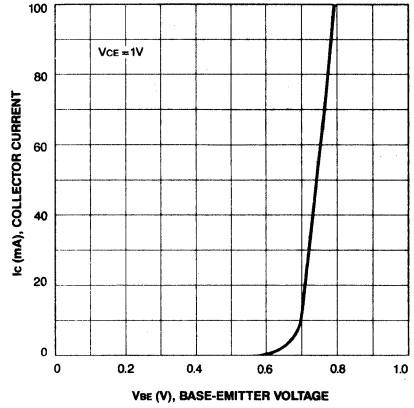


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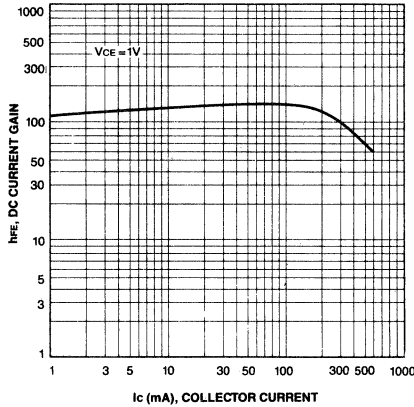
STATIC CHARACTERISTIC



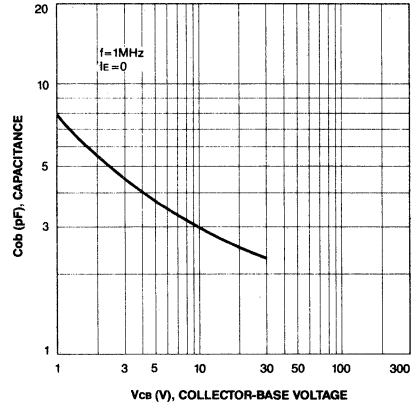
BASE-EMITTER ON VOLTAGE



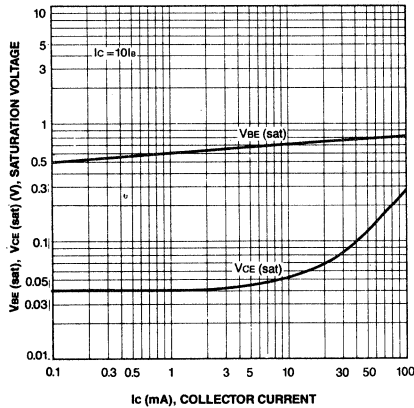
DC CURRENT GAIN



COLLECTOR OUTPUT CAPACITANCE



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



MIXER FOR UHF TV TUNER

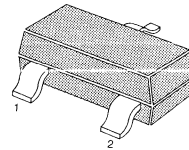
$G_{CE} = 17\text{dB}$ (TYP)

$C_{re} = 0.6\text{pF}$ (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	50	mA
Base Current (DC)	I_B	25	mA
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_C	150	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

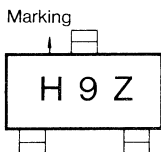
SOT-23



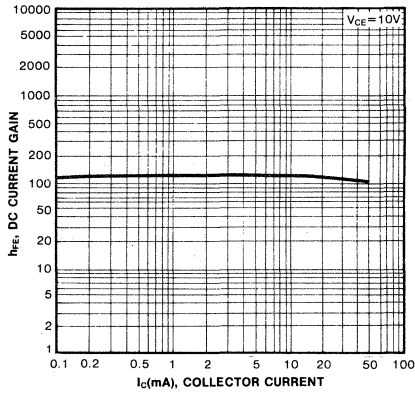
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

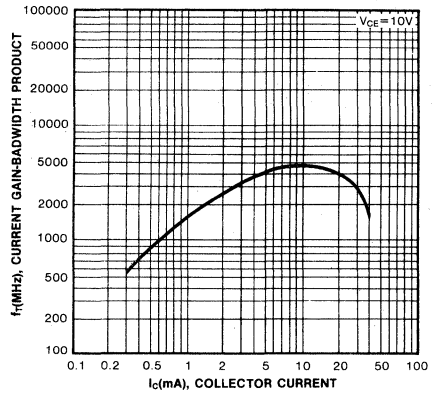
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	15			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 2\text{V}, I_C = 0$			1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	40	100	200	
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	1500	2400		MHz
Reverse Transier Capacitance	C_{re}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.6	0.9	pF
Conversion Gain	G_{ce}	$V_{CC} = 10\text{V}, I_C = 2\text{mA}$ $f = 800\text{MHz}, f_i = 830\text{MHz}$	12	17		dB
Noise Figure	NF	$V_{CC} = 10\text{V}, I_C = 2\text{mA}$ $f = 800\text{MHz}, f_i = 830\text{MHz}$		8		dB



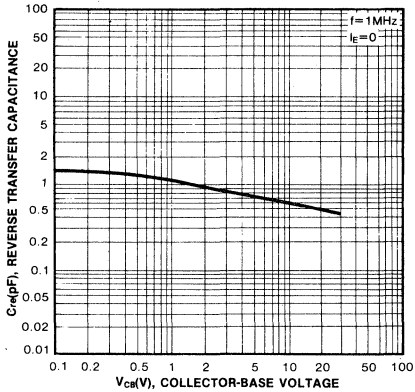
DC CURRENT GAIN



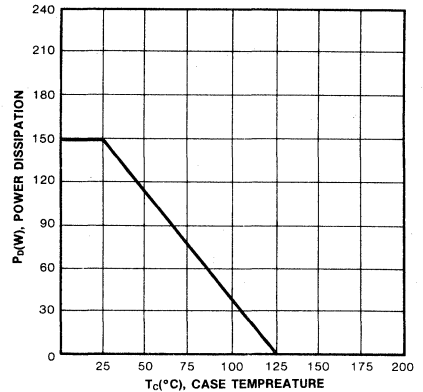
CURRENT GAIN BANDWIDTH PRODUCT



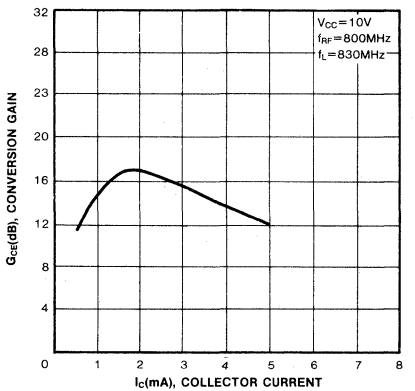
Cre-Vcb CHARACTERISTIC



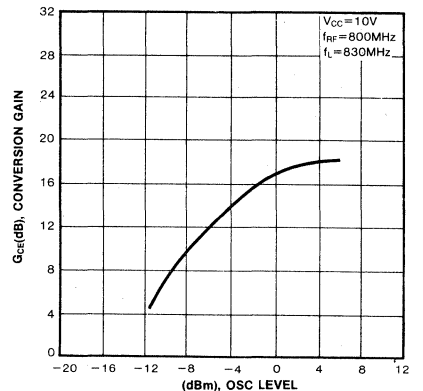
POWER DERATING



Gce-Ic CHARACTERISTIC



OSC LEVEL



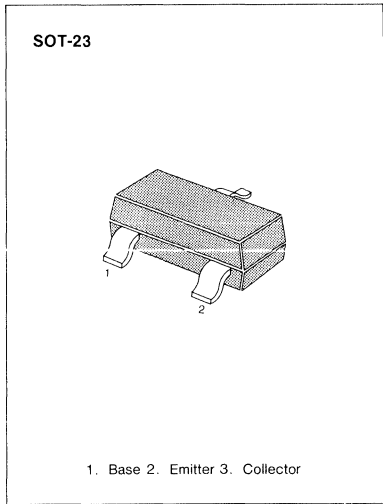
MIXER FOR VHF TV TUNER

G_{CE} = 23dB

C_{RE} = 0.4pF

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Characteristic	Symbol	Value	Unit
Collector Base Voltage	V _{CB0}	30	V
Collector Emitter Voltage	V _{CE0}	20	V
Emitter Base Voltage	V _{EBO}	3	V
Collector Current	I _C	50	mA
Base Current	I _B	25	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



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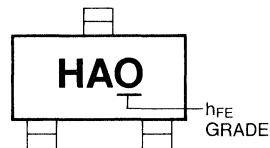
ELECTRICAL CHARACTERISTICS (Ta=25°C)

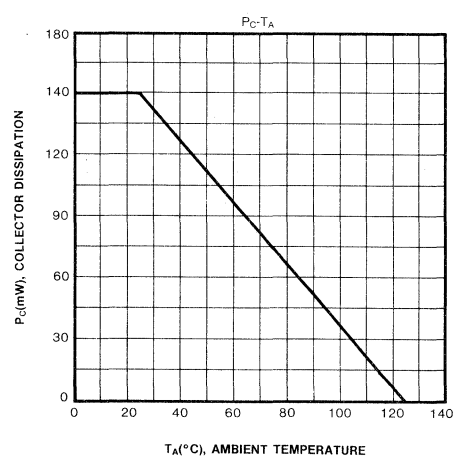
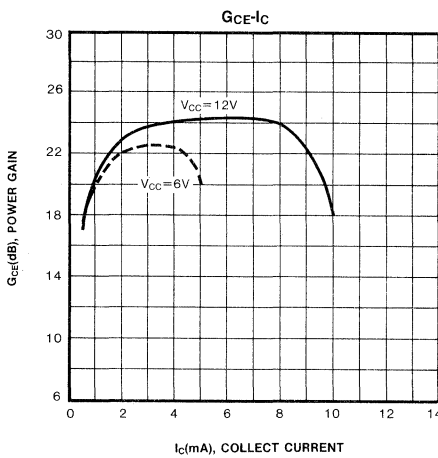
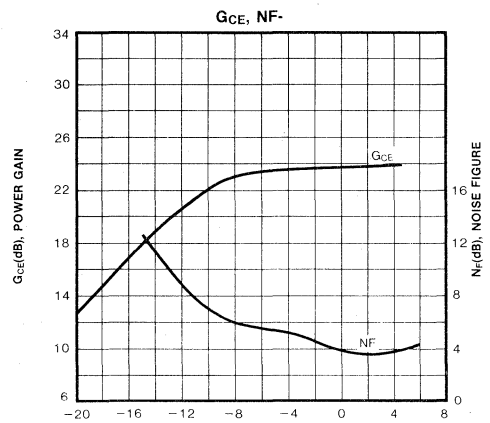
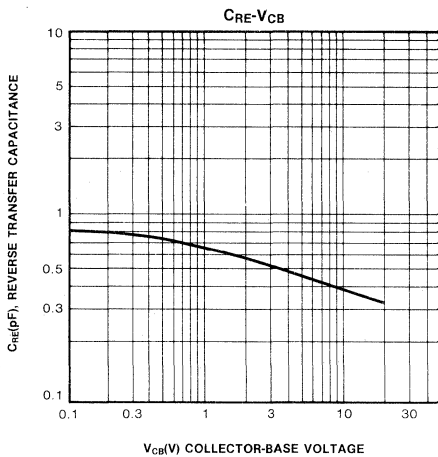
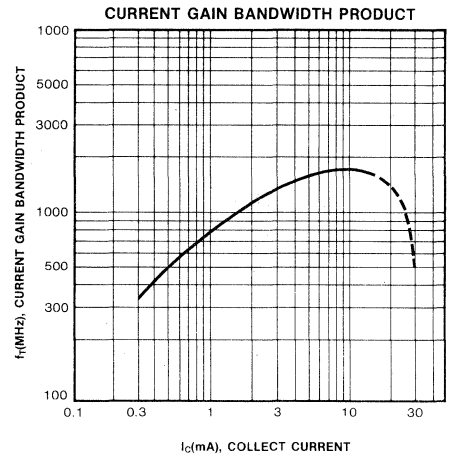
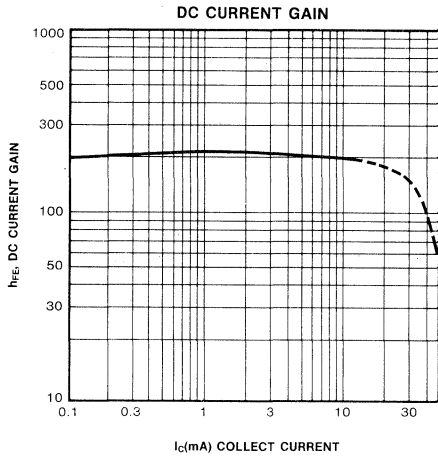
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C =1mA, I _B =0	20	—	—	V
Collector Cutoff Current	I _{CBO}	V _{CB} =25V, I _E =0	—	—	0.1	μA
Emitter Cutoff Current	I _{EBO}	V _{EB} =3V, I _C =0	—	—	1	μA
D.C Current Gain	h _{FE}	V _{CE} =10V, I _C =5mA	60	—	240	—
Current Gain-Bandwidth Product	f _T	V _{CE} =10V, I _C =5mA	900	1400	—	MHz
Reverse Transfer Capacitance	C _{RE}	V _{CB} =10V, I _E =0, f=1MHz	—	0.4	0.5	pF
Conversion Gain	G _{CE}	V _{CC} =12V, f=200MHz, f _L =260MHz (0dBm)	20	23	—	dB
Noise Figure	NF	V _{CC} =12V, f=200MHz, f _L =260MHz (0dBm)	—	3.8	5.5	dB

h_{FE} CLASSIFICATION

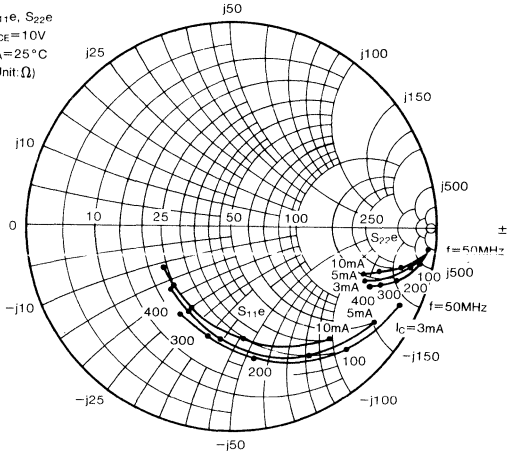
Classification	R	O	Y
h _{FE}	60~120	90~180	120~240

Marking

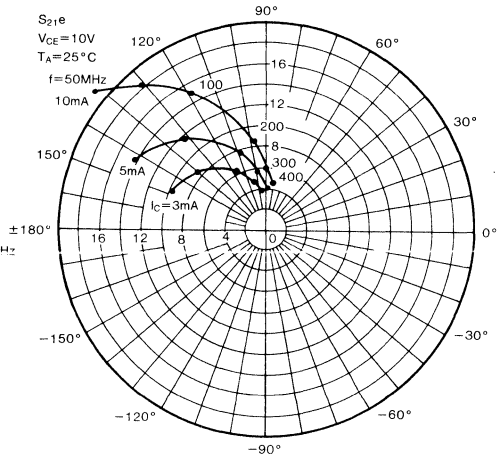




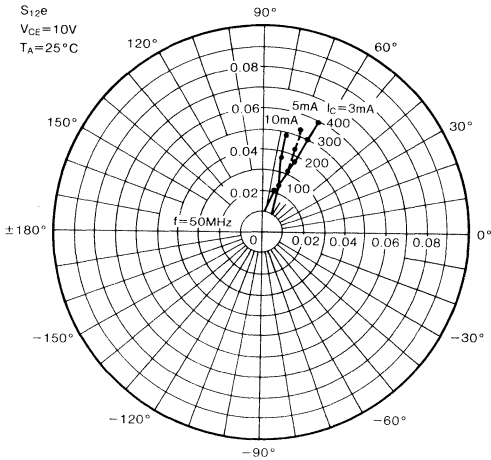
S_{11e}, S_{22e}
 $V_{CE}=10V$
 $T_A=25^\circ C$
 (Unit: Ω)



S_{21e}
 $V_{CE}=10V$
 $T_A=25^\circ C$
 $f=50MHz$



S_{12e}
 $V_{CE}=10V$
 $T_A=25^\circ C$

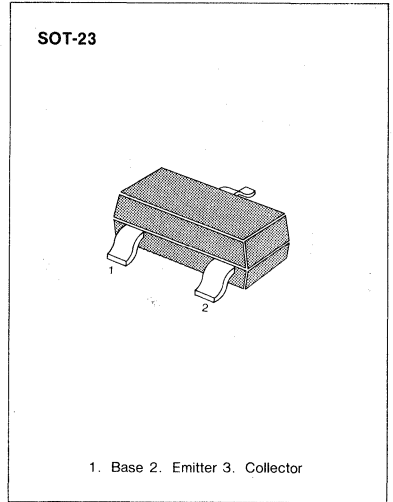


TV FINAL PICTURE AMPLIFIER APPLICATION

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	4	V
Collector Current	I _C	50	mA
Collector Dissipation	P _C	150	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 - 150	°C

• Refer to KSC388 for graphs



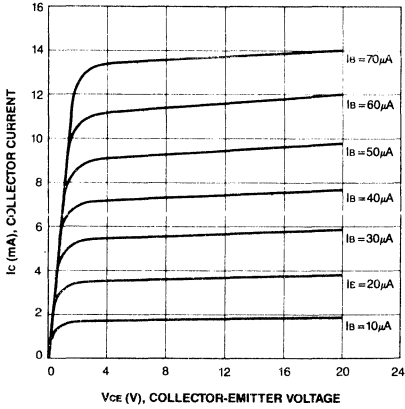
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage		I _C = 1mA, I _R = 0	25			V
Collector Cutoff Current	I _{CBO}	V _{CB} = 30V, I _E = 0			0.1	uA
Emitter Cutoff Current	I _{EBO}	V _{EB} = 3V, I _C = 0			0.1	uA
DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 10mA	20	70	200	
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = 15mA, I _B = 1.5mA			0.2	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = 15mA, I _B = 1.5mA			1.5	V
Current Gain-Bandwidth Product	f _T	I _C = 10mA, V _{CE} = 10V	250	600		MHz
Output Capacitance	C _{ob}	V _{CB} = 10V, I _E = 0 f = 1MHz		1.1	1.6	pF

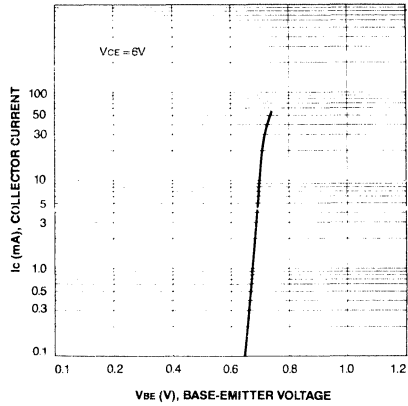
Marking



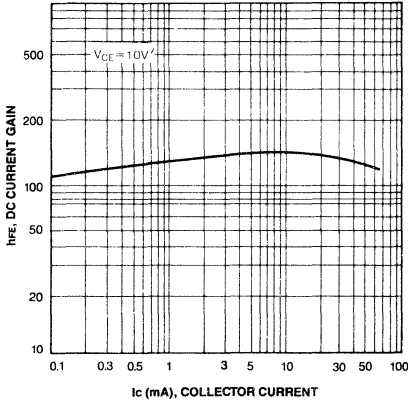
STATIC CHARACTERISTIC



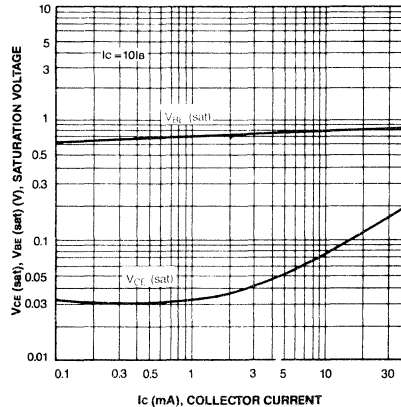
BASE-EMITTER ON VOLTAGE



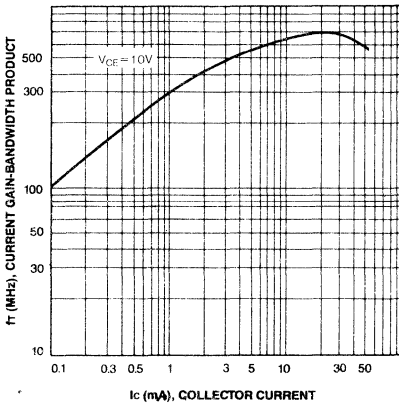
DC CURRENT GAIN



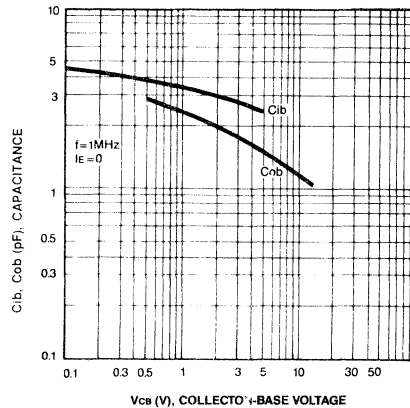
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE



3

LOW FREQUENCY AMPLIFIER

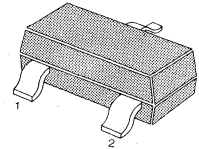
- Complement to KSA1298

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	800	mA
Base Current	I _B	160	mA
Collector Dissipation	P _C	200	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C

- Refer to KSD261 for graphs

SOT-23



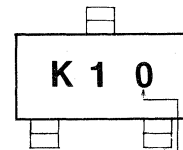
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 10mA, I _B = 0	25			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 1mA, I _C = 0	5			V
Collector Cutoff Current	I _{CBO}	V _{CB} = 30V, I _E = 0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = 5V, I _C = 0			100	nA
DC Current Gain	h _{FE1}	V _{CE} = 1V, I _C = 100mA	100		320	
	h _{FE2}	V _{CE} = 1V, I _C = 800mA	40			
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = 500mA, I _B = 20mA			0.4	V
Base-Emitter On Voltage	V _{BE(on)}	V _{CE} = 1V, I _C = 10mA	0.5		0.8	V
Current Gain Bandwidth Product	f _T	V _{CE} = 5V, I _C = 10mA,		120		MHz
Output Capacitance	C _{ob}	V _{CB} = 10V, I _E = 0 f = 1MHz		13		pF

h_{FE} (1) CLASSIFICATION

Classification	O	Y
h _{FE} (1)	100-200	160-320



h_{FE} grade

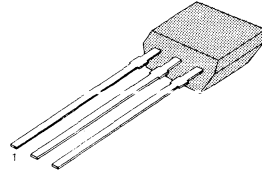
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA1378
- Collector Dissipation $P_C = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	300	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

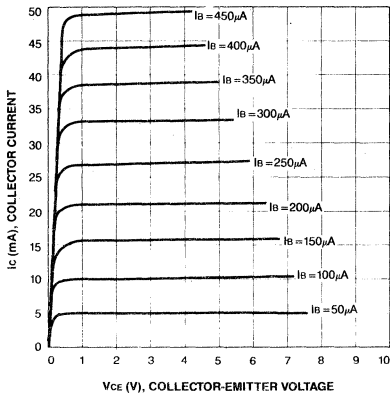
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 300\text{mA}, I_B = 30\text{mA}$		0.14	0.4	V

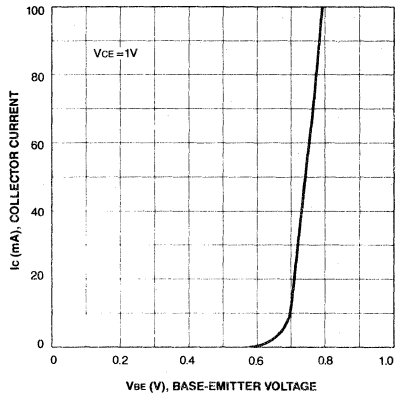
 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

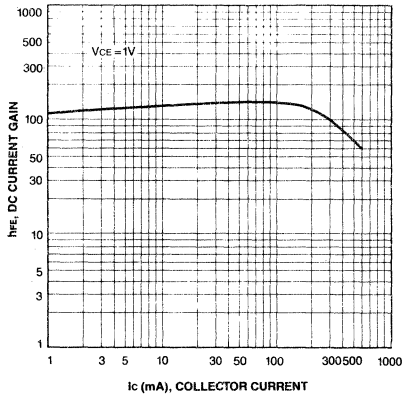
STATIC CHARACTERISTIC



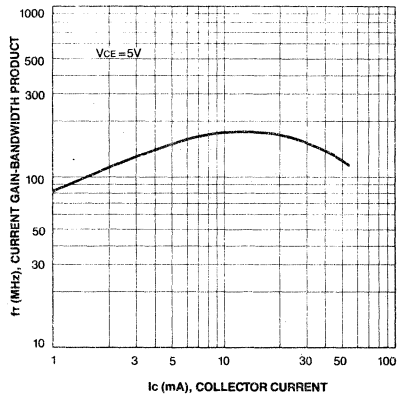
BASE-EMITTER ON VOLTAGE



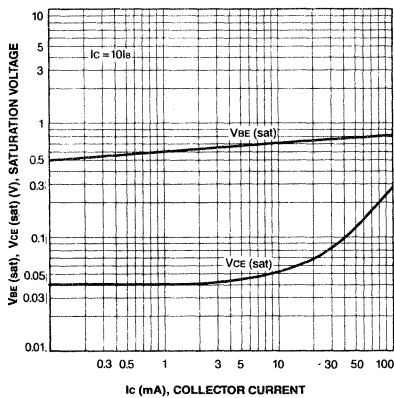
DC CURRENT GAIN



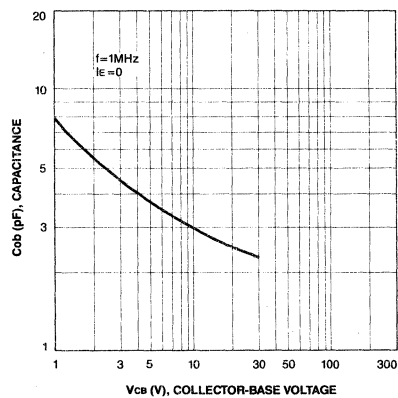
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



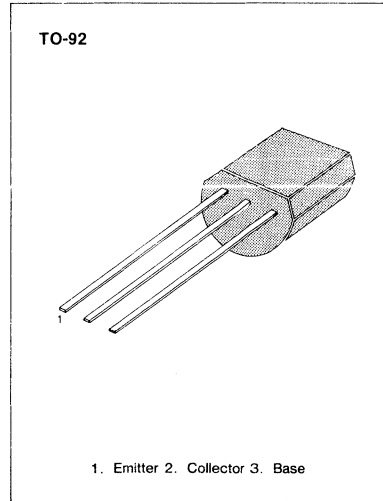
LOW SATURATION

- $V_{ce(sat)}=0.5V$ ($I_c=2A, I_b=50mA$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Collector-Emitter Voltage	V_{CEO}	10	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current (DC)	I_c	2	A
*Collector Current(Pulse)	I_c	5	A
Base Current	I_b	2	A
Collector Dissipation	P_c	750	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$

* $PW \leq 10ms$. Duty Cycle $\leq 30\%$



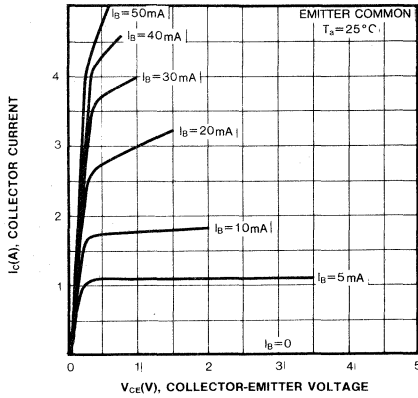
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6V, I_C=0$			100	nA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	10			V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_C=0$	6			V
DC Current Gain	h_{FE1}	$V_{CE}=1V, I_C=0.5A$	140		600	
	h_{FE2}	$V_{CE}=1V, I_C=2A$	70	200		
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=2A, I_B=50mA$		0.2	0.5	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE}=1V, I_C=2A$		0.86	1.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=1V, I_C=0.5A$		150		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0, f=1MHz$		27		pF

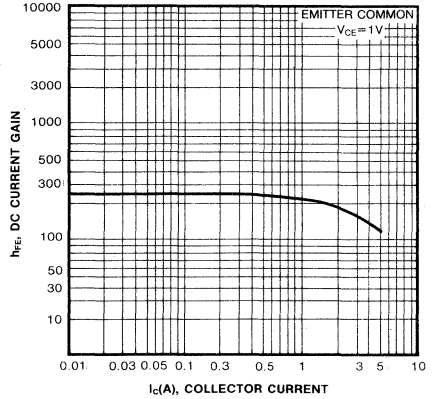
$h_{FE}(1)$ CLASSIFICATION

Classification	A	B	C	D
$h_{FE}(1)$	140-240	200-330	300-450	420-600

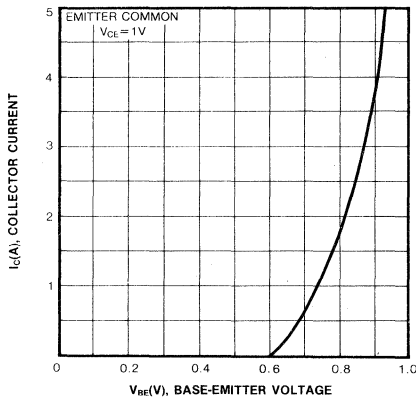
STATIC CHARACTERISTIC



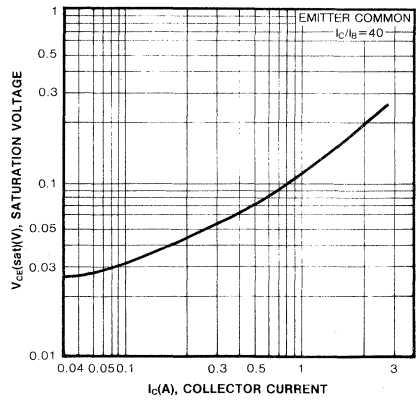
DC CURRENT GAIN



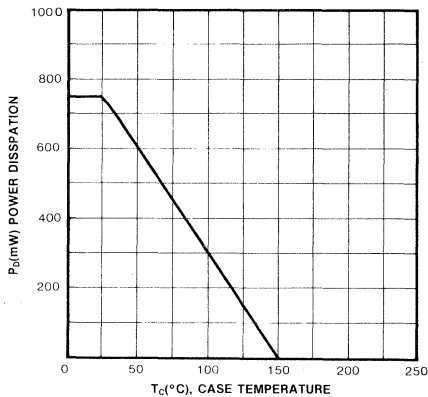
BASE-EMITTER ON VOLTAGE



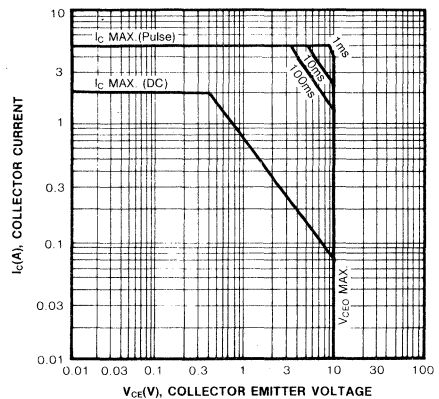
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA

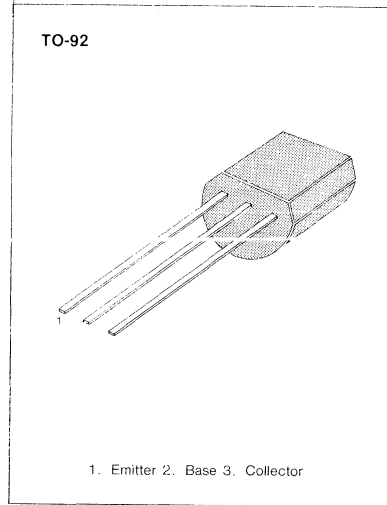


LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA642
- Collector Dissipation $P_C=400\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	300	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

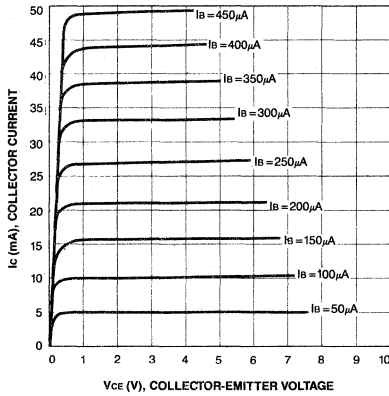
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=50\text{mA}$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=300\text{mA}, I_B=30\text{mA}$		0.14	0.4	V

h_{FE} CLASSIFICATION

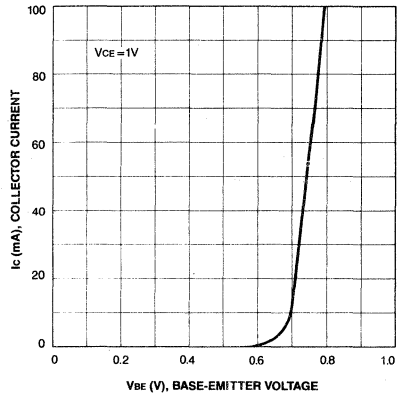
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

3

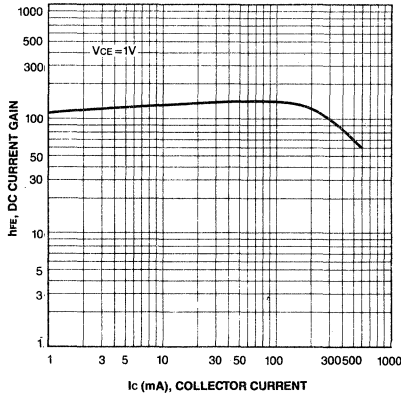
STATIC CHARACTERISTIC



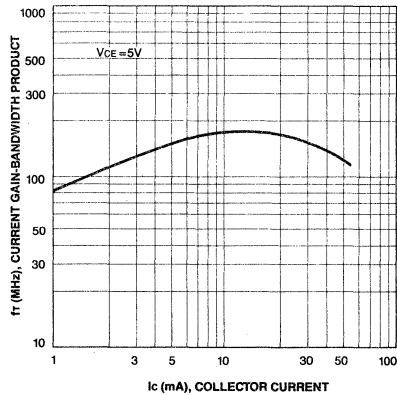
BASE-EMITTER ON VOLTAGE



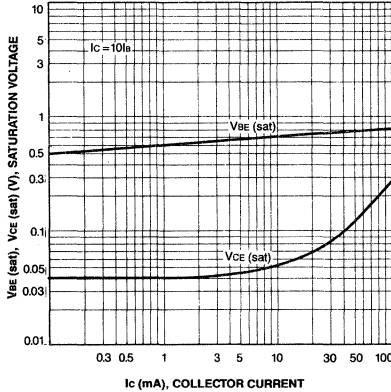
DC CURRENT GAIN



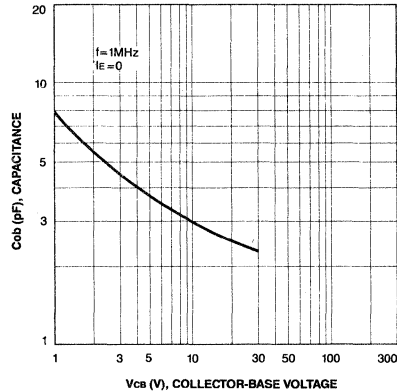
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



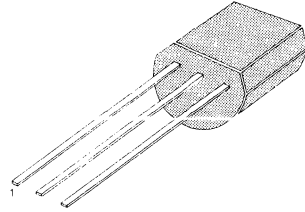
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA643
- Collector Dissipation $P_C = 500\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

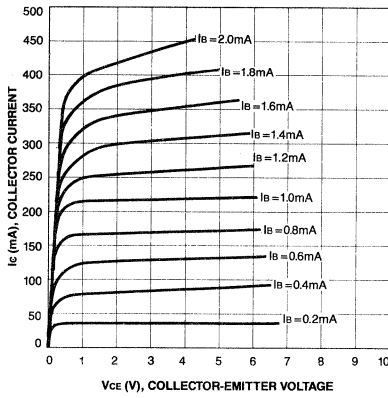
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 0.1\text{A}$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 0.5\text{A}, I_B = 0.05\text{A}$		0.18	0.4	V

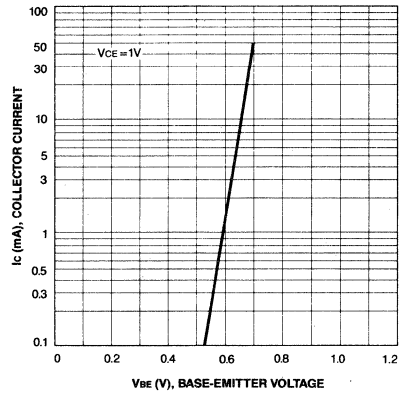
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

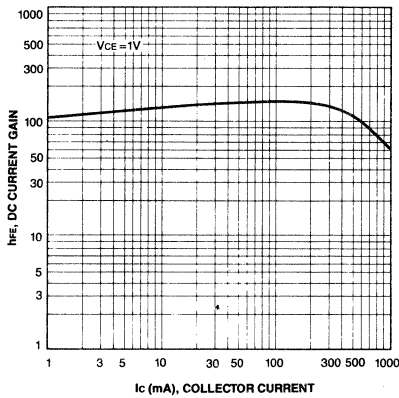
STATIC CHARACTERISTIC



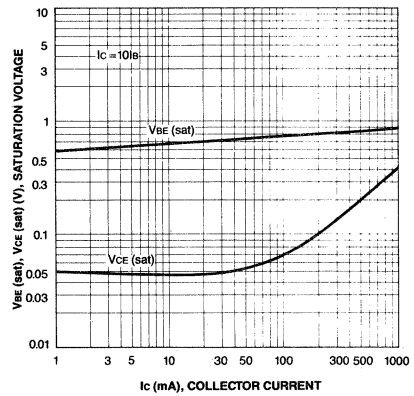
BASE-EMITTER ON VOLTAGE



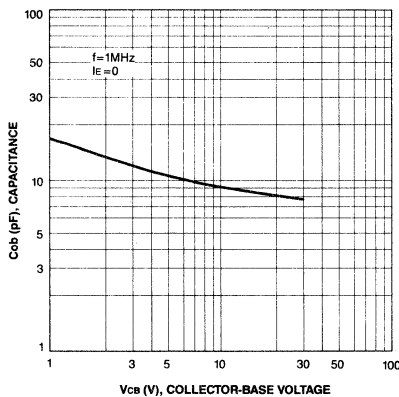
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



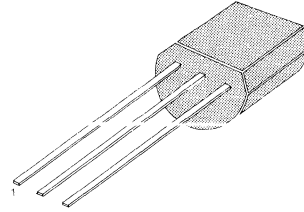
AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSB564A
- Collector Current $I_C = 1A$
- Collector Dissipation $P_C = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	1	A
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

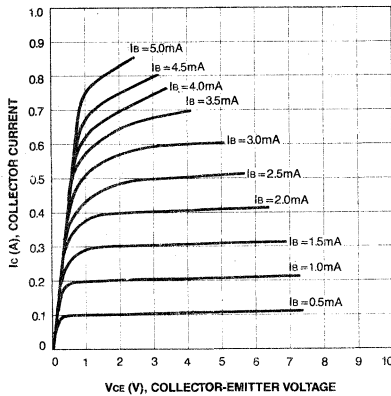
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 1A, I_B = 0.1A$			0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 1A, I_B = 0.1A$			1.2	V
Current Gain-Band width Product	f_T	$V_{CE} = 6V, I_C = 10mA$		130		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0, f = 1MHz$		16		pF

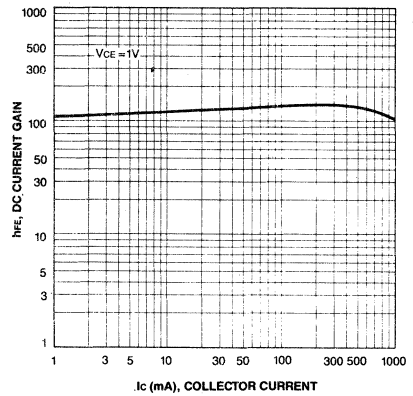
 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

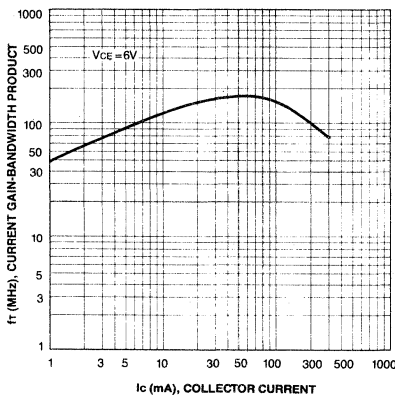
STATIC CHARACTERISTIC



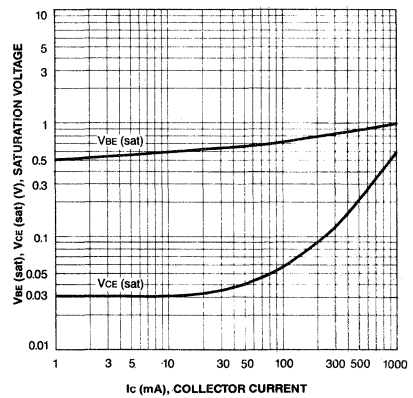
DC CURRENT GAIN



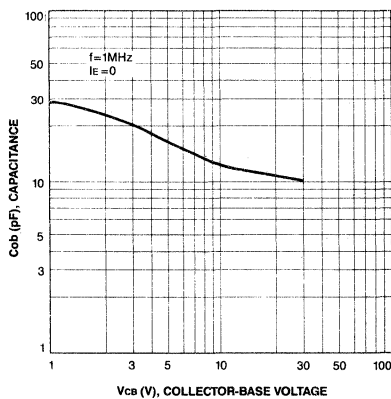
CURRENT GAIN-BANDWIDTH PRODUCT



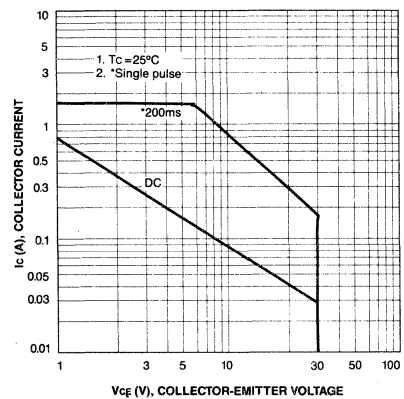
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



SAFE OPERATING AREA



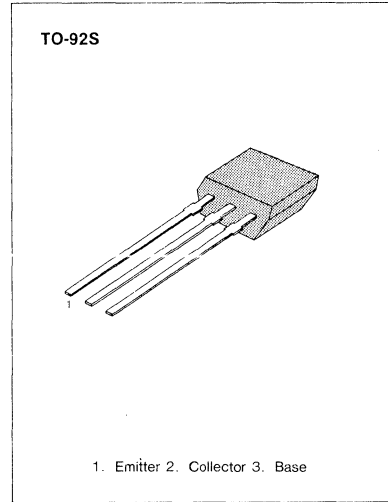
AUDIO FREQUENCY AMPLIFIER

• Complement to KSB810

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	30	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	5.0	V
Collector Current (DC)	I _C	700	mA
* Collector Current (Pulse)	I _C	1.0	A
Collector Dissipation	P _C	350	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C

* PW ≤ 10 ms, duty cycle ≤ 50 %



3

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

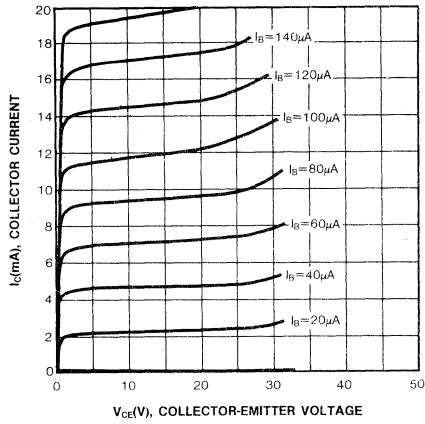
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CBO}	V _{CB} =30V, I _E =0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =5V, I _C =0			100	nA
* DC Current Gain	h _{FE1}	V _{CE} =1V, I _C =100mA	70	200	400	
	h _{FE2}	V _{CE} =1V, I _C =700mA	35	140		
* Base Emitter Voltage	V _{BE}	V _{CE} =6V, I _C =10mA	600	640	700	mV
* Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C =700mA, I _B =70mA		0.20	0.4	V
* Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C =700mA, I _B =70mA		0.95	1.2	V
Output Capacitance	C _{OB}	V _{CB} =6V, I _E =0, f=1MHz		13	25	pF
Current Gain-Bandwidth Product	f _T	V _{CE} =6V, I _E =10mA	50	170		MHz

* Pulse Test: PW≤350 μs, Duty Cycle ≤ 2% Pulsed

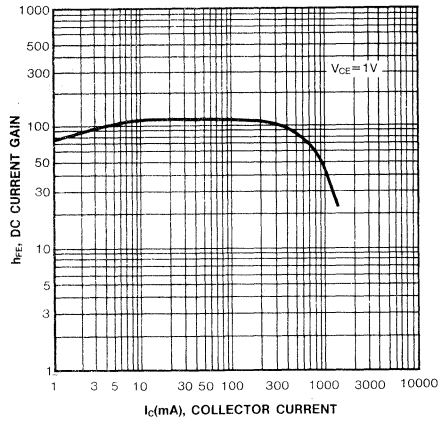
h_{FE}(1) CLASSIFICATION

Classification	O	Y	G
h _{FE} (1)	70-140	120-240	200-400

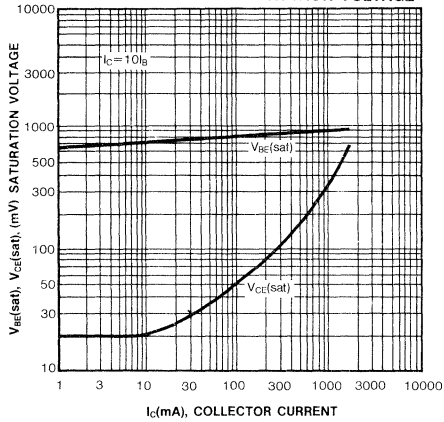
STATIC CHARACTERISTIC



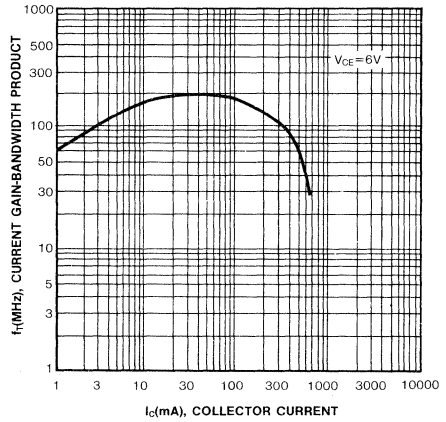
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

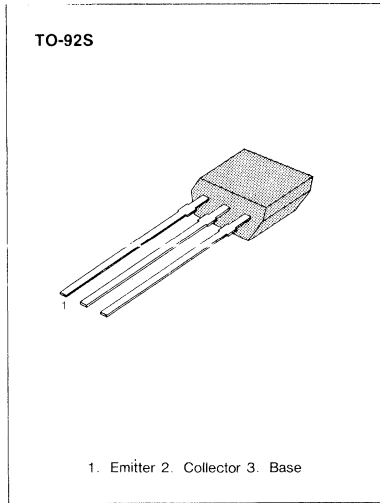


AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSB811
- Collector Current $I_C=1A$
- Collector Dissipation $P_C = 350mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	1	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



3

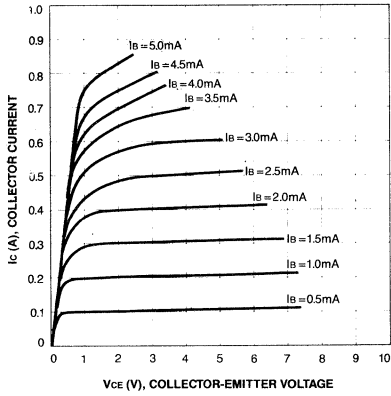
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1V, I_C=100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=1A, I_B=0.1A$			0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=1A, I_B=0.1A$			1.2	V
Current Gain-Band width Product	f_T	$V_{CE}=6V, I_C=10mA$		130		MHz
Output Capacitance	C_{ob}	$V_{CB}=6V, I_E=0, f=1MHz$		16		pF

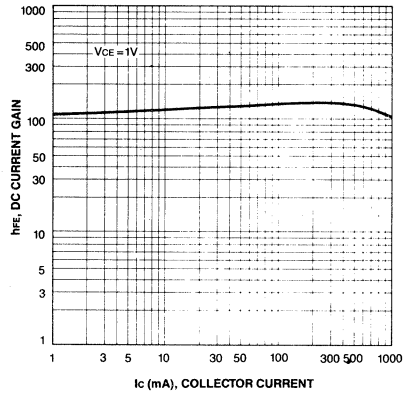
h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

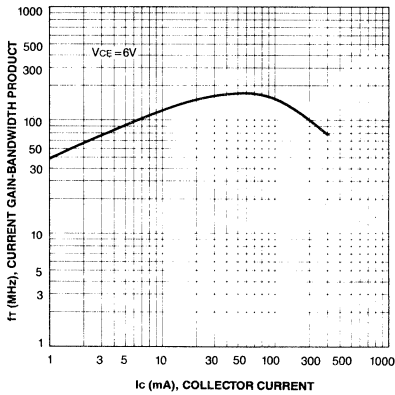
STATIC CHARACTERISTIC



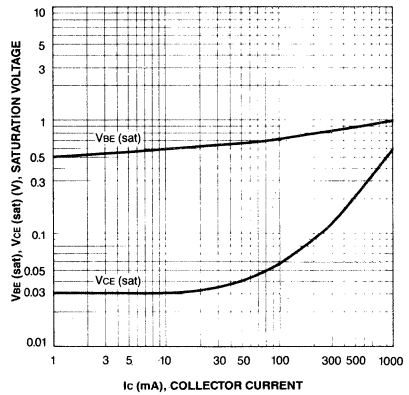
DC CURRENT GAIN



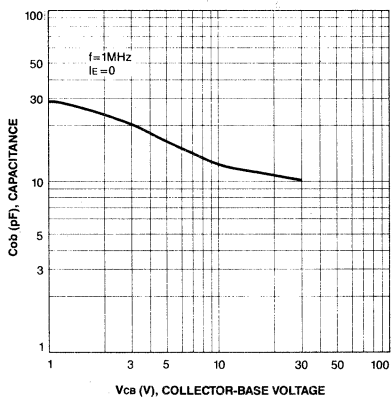
CURRENT GAIN-BANDWIDTH PRODUCT



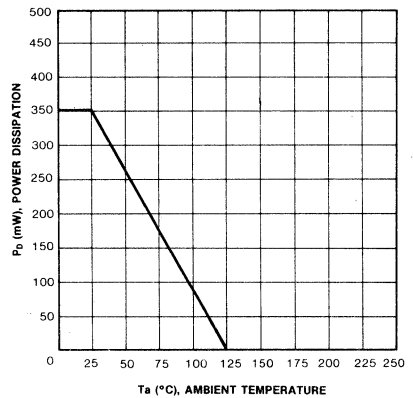
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

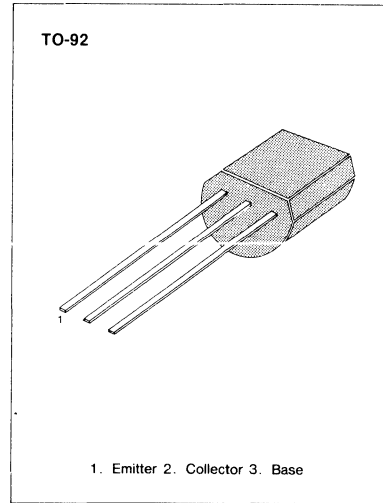


**AUDIO FREQUENCY POWER AMPLIFIER
MEDIUM SPEED SWITCHING**

• Complement to KSB1116/1116A

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSD1616	V _{CB0}	60	V
: KSD1616A		120	V
Collector-Emitter Voltage : KSD1616	V _{CE0}	50	V
: KSD1616A		60	V
Emitter-Base Voltage	V _{EB0}	6	V
Collector Current (DC)	I _C	1	A
* Collector Current (Pulse)	I _C	2	A
Collector Dissipation	P _C	0.75	W
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



* PW<10ms, Duty Cycle<50%

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

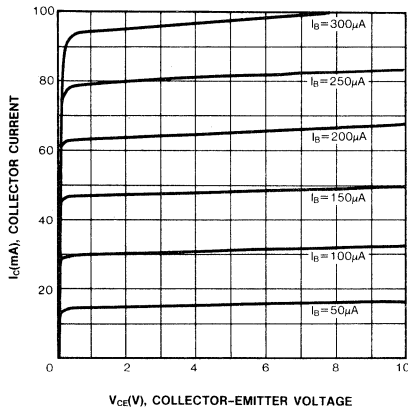
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CB0}	V _{CB} =60V, I _E =0			100	nA
Emitter Cutoff Current	I _{EB0}	V _{EB} =6V, I _C =0			100	nA
* DC Current Gain : KSD1616	h _{FE1}	V _{CE} =2V, I _C =100mA	135		600	
: KSD1616A			135		400	
	h _{FE2}	V _{CE} =2V, I _C =1A	81			
** Base Emitter On Voltage	V _{BE (on)}	V _{CE} =2V, I _C =50mA	600	640	700	mV
* Collector Emitter Saturation Voltage	V _{CE (sat)}	I _C =1A, I _B =50mA		0.15	0.3	V
* Base Emitter Saturation Voltage	V _{BE (sat)}	I _C =1A, I _B =50mA		0.9	1.2	V
Output Capacitance	C _{ob}	V _{CB} =10V, I _E =0, f=1MHz		19		pF
Current Gain Bandwidth Product	f _T	V _{CE} =2V, I _C =100mA	100	160		MHz
Turn On Time	t _{on}	V _{CC} =10V, I _C =100mA		0.07		μs
Storage Time	t _s	I _{B1} = -I _{B2} = 10mA		0.95		μs
Fall Time	t _f	V _{BE (off)} = -2~-3V		0.07		μs

* Pulse Test: PW<350μs, Duty Cycle≤2% Pulsed

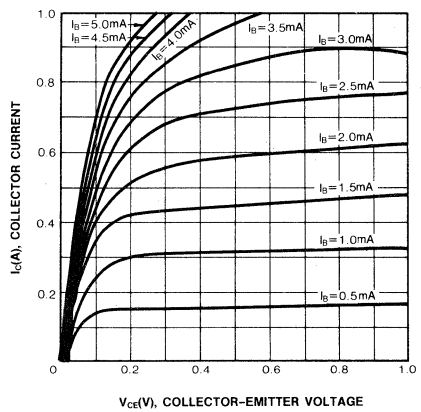
h_{FE}(1) CLASSIFICATION

Classification	Y	G	L
h _{FE} (1)	135-270	200-400	300-600

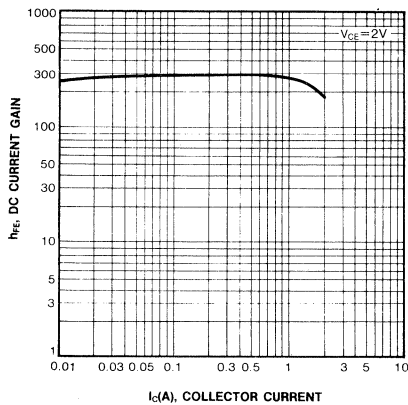
STATIC CHARACTERISTIC



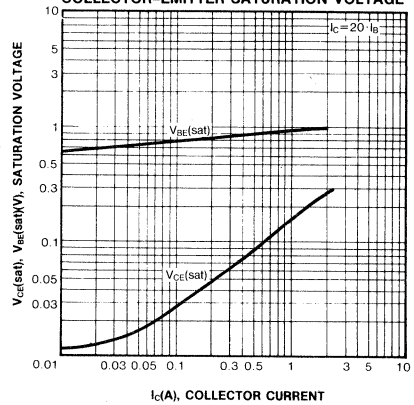
STATIC CHARACTERISTIC



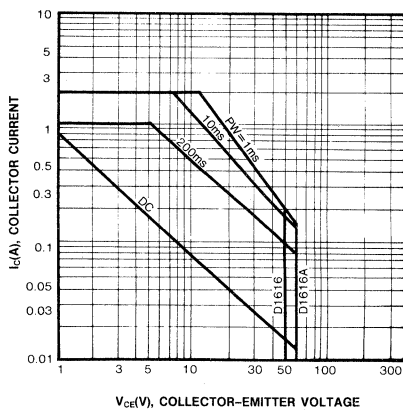
DC CURRENT GAIN



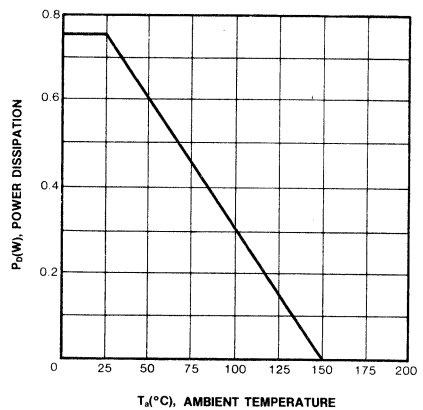
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



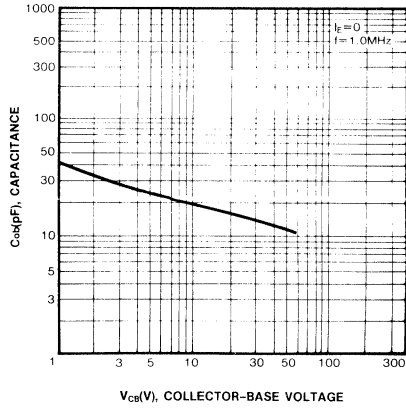
SAFE OPERATING AREA



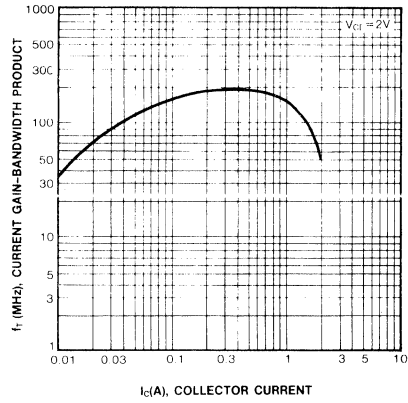
POWER DERATING



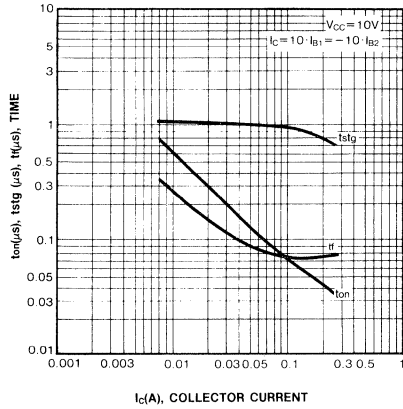
COLLECTOR OUTPUT CAPACITANCE



CURRENT GAIN-BANDWIDTH PRODUCT



SWITCHING TIME



3

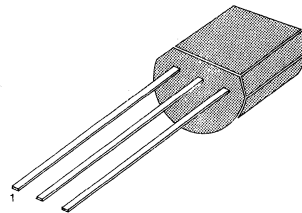
AF OUTPUT AMPLIFIER FOR ELECTRONIC FLASH UNIT

- Low $V_{ce(sat)}$
- High Performance at Low Supply Voltage

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	I_C	5	A
Collector Dissipation	P_C	0.75	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	$-55 \sim 150$	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

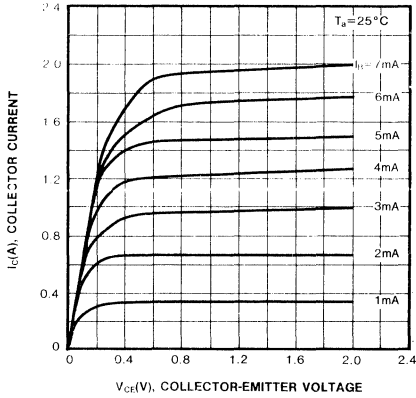
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	20			V
Emitter Base Voltage	BV_{EBO}	$I_C = 10\mu\text{A}, I_C = 0$	7			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 10\text{V}, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 7\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE1}	$V_{CE} = 2\text{V}, I_C = 0.5\text{A}$	180		600	
	h_{FE2}	$V_{CE} = 2\text{V}, I_C = 2\text{A}$	150			
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 3\text{A}, I_B = 0.1\text{A}$			1	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 50\text{mA}$		150		MHz
Output Capacitance	C_{ob}	$V_{CB} = 20\text{V}, I_E = 0, f = 1\text{MHz}$			50	pF

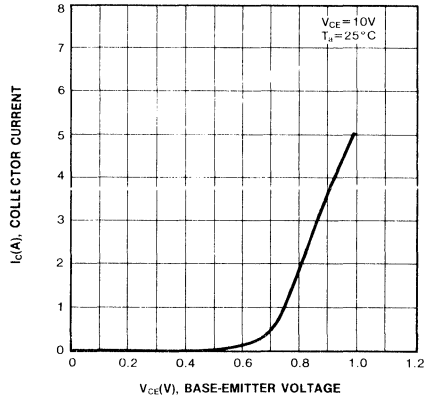
h_{FE1} CLASSIFICATION

Classification	P	Q	R
h_{FE1}	180-270	230-380	340-600

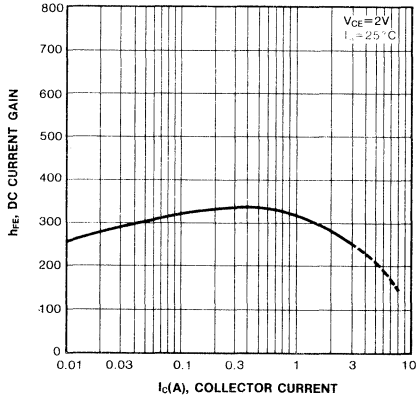
STATIC CHARACTERISTIC



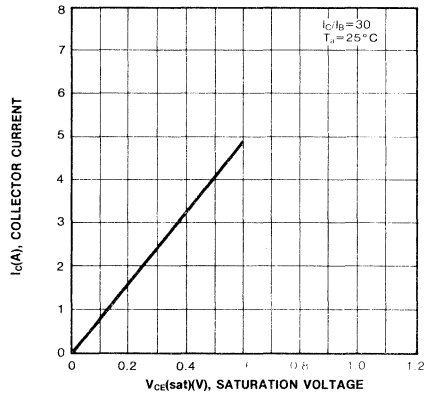
BASE-EMITTER SATURATION VOLTAGE



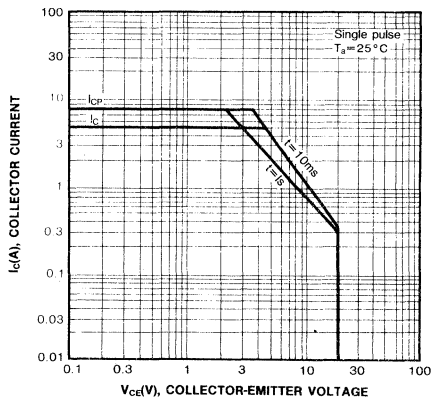
DC CURRENT GAIN



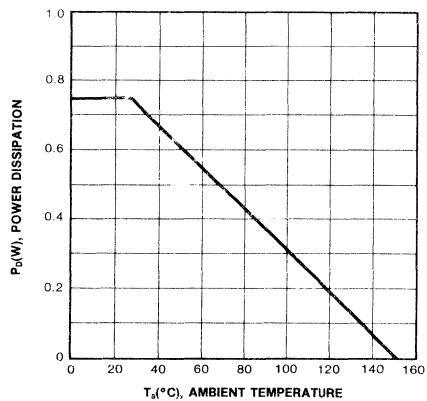
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA

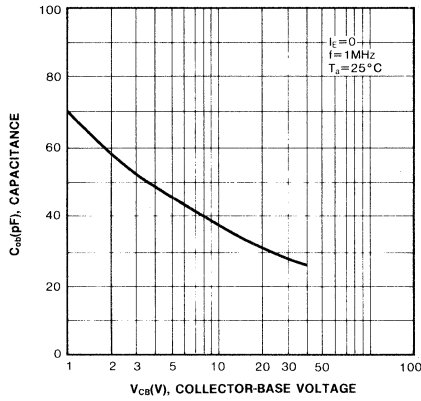


POWER DERATING

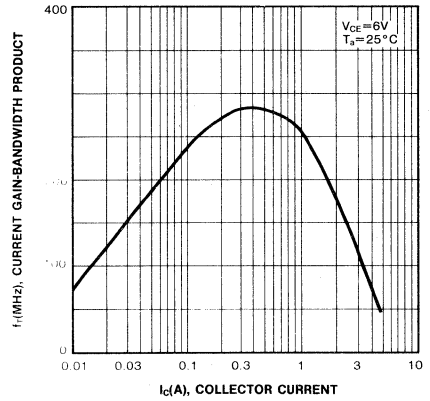


3

OUTPUT CAPACITANCE



CURRENT GAIN BANDWIDTH PRODUCT



LOW NOISE PRE-AMP. USE

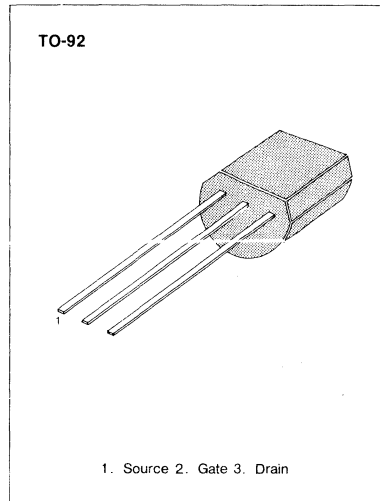
High Input Impedance: $I_{gss} = 1\text{nA (MAX)}$

Low Noise: $\text{NF} = 0.5\text{dB (TYP)}$

High Voltage: $V_{gds} = -50\text{V}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{gds}	-50	V
Gate Current	I_g	10	mA
Collector Dissipation	P_c	100	mW
Junction Temperature	T_j	125	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~125	$^\circ\text{C}$



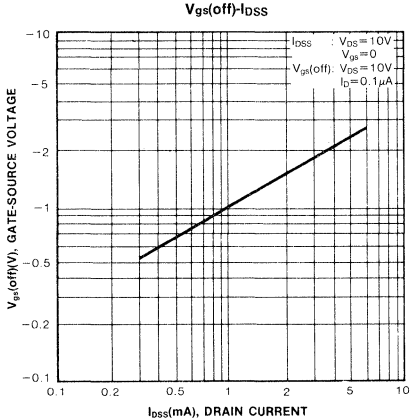
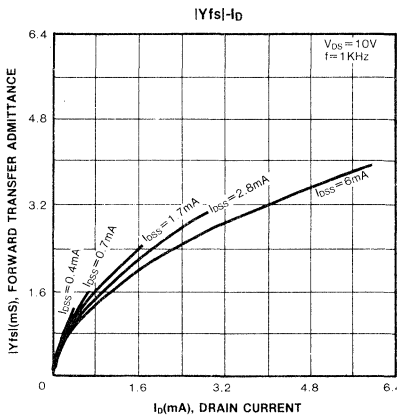
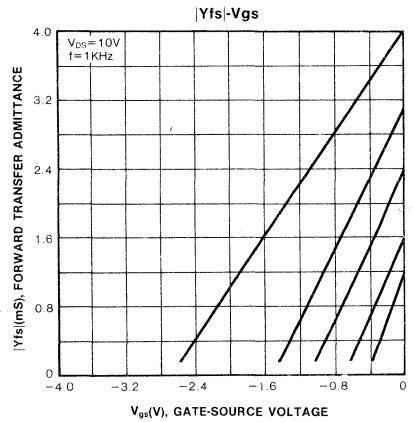
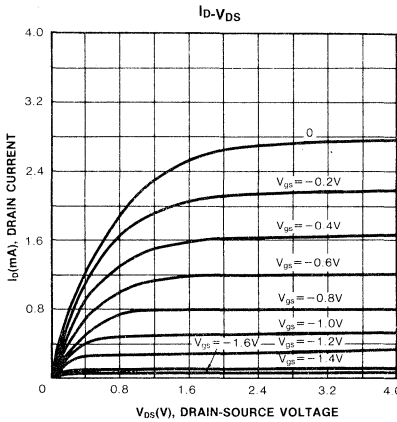
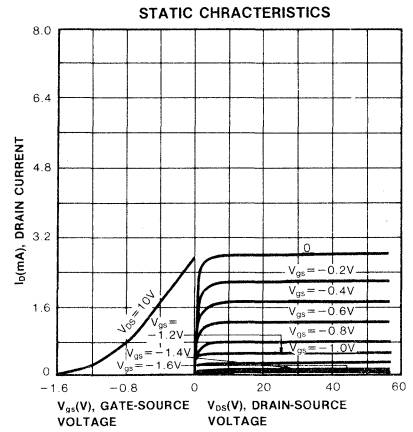
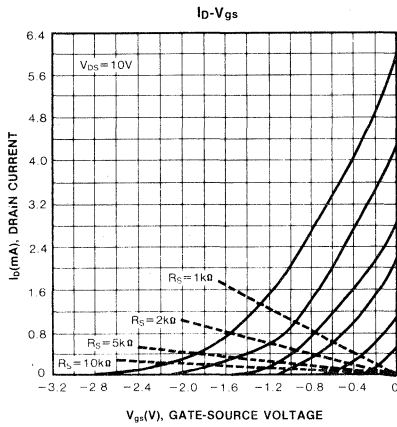
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

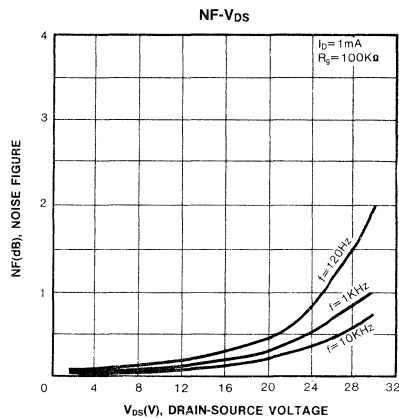
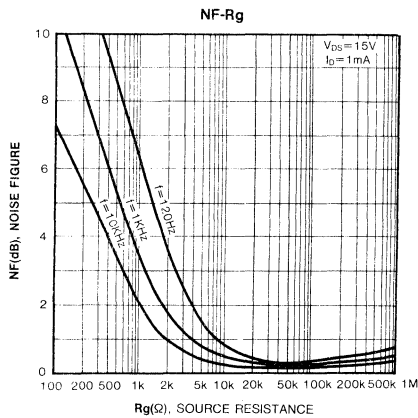
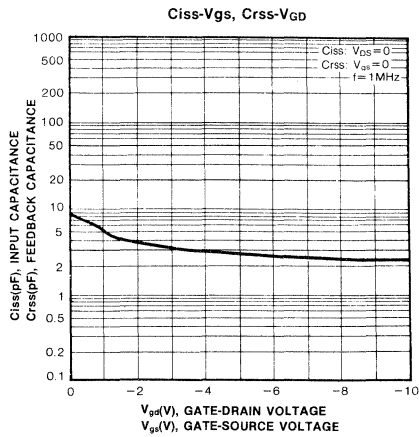
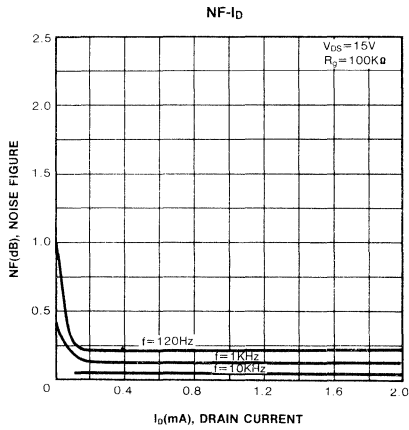
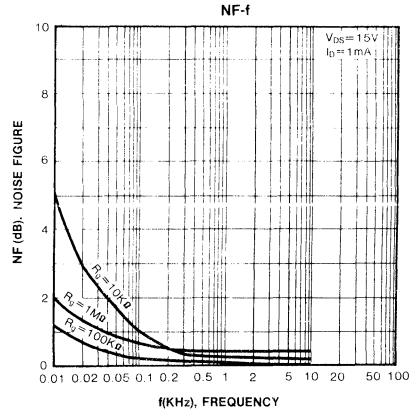
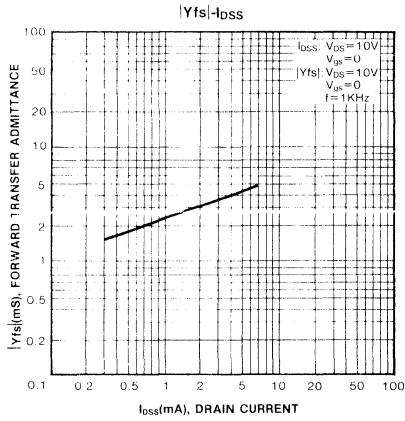
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate-Drain Breakdown Voltage	BV_{gds}	$V_{DS} = 0, I_g = -100\mu\text{A}$	-50			V
Gate Leak Current	I_{gss}	$V_{gs} = -30\text{V}, V_{DS} = 0$			-1	nA
Drain Leak Current	I_{DSS}	$V_{DS} = 10\text{V}, V_{GS} = 0$	0.3		6.5	mA
Gate-Source Voltage	$V_{gs(\text{off})}$	$V_{DS} = 10\text{V}, I_D = 0.1\mu\text{A}$	-0.4		-5	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS} = 10\text{V}, V_{gs} = 0, f = 1\text{KHz}$	1.2			mS
Input Capacitance	C_{iss}	$V_{DS} = 0, V_{gs} = 0, f = 1\text{MHz}$		8.2		pF
Feedback Capacitance	C_{rss}	$V_{gd} = 10\text{V}, V_{DS} = 0, f = 1\text{MHz}$		2.6		pF
Noise Figure	NF	$V_{DS} = 15\text{V}, V_{gs} = 0, R_g = 100\text{k}\Omega, f = 120\text{Hz}$		0.5	5	dB

I_{DSS} CLASSIFICATION

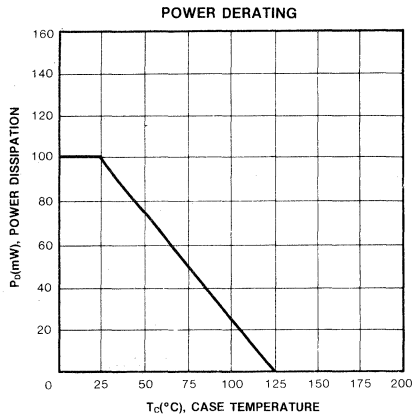
Classification	R	O	Y	G
$I_{DSS}(\text{mA})$	0.30-0.75	0.60-1.40	1.20-3.00	2.60-6.50







3

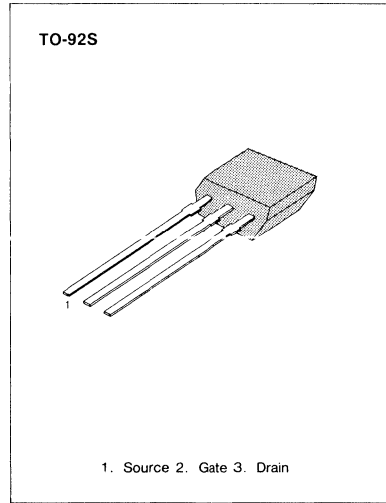


AF IMPEDANCE CONVERTER

- Built-In Diode Between G and S
- Low NV

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Drain-Source Voltage	V _{DSO}	12	V
Gate-Drain Voltage	V _{GDO}	12	V
Drain-source Current	I _{DSO}	2	mA
Drain-Gate Current	I _{DGO}	2	mA
Gate-Source Current	I _{GSO}	2	mA
Power Dissipation	P _D	20	mW
Operate Temperature	T _{OPR}	-10~+70	°C
Storage Temperature	T _{stg}	-20~+80	°C

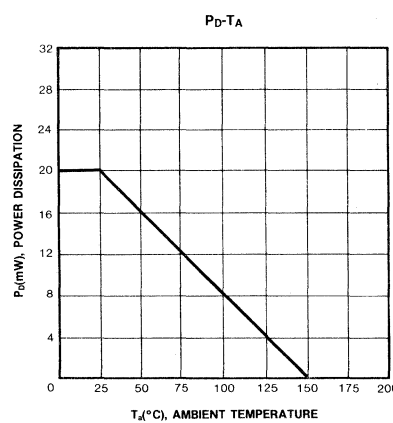
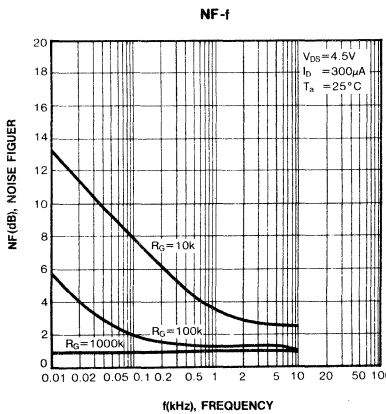
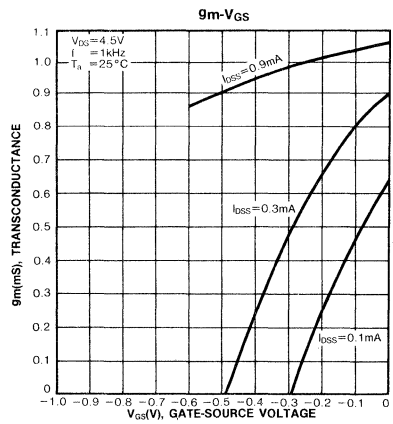
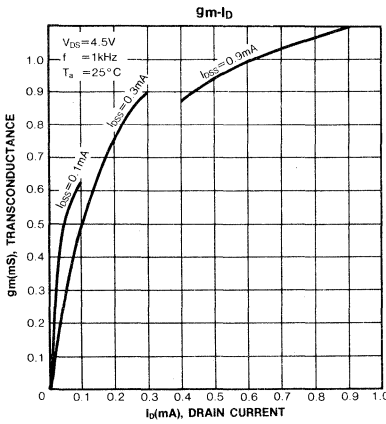
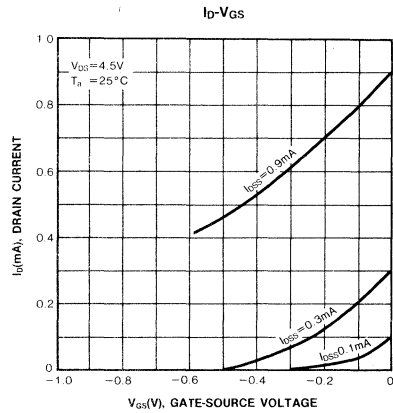
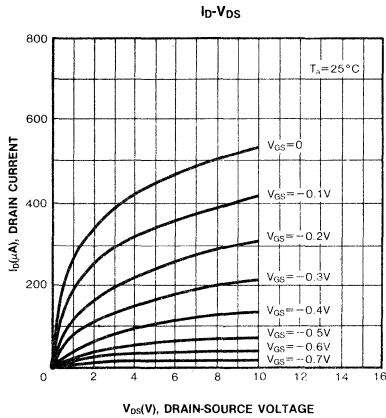


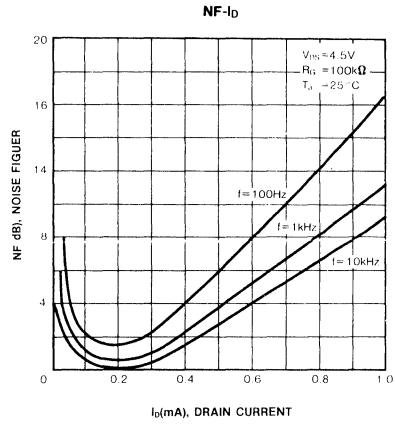
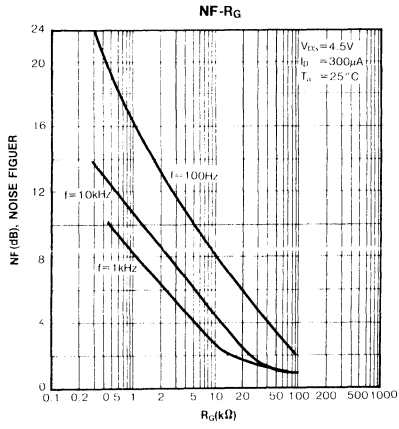
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Drain Current	I _{DSS}	V _{DS} = 4.5V, V _{GS} = 0, R _S = 2.2kΩ ± 1%	0.04		0.8	mA
Transconductance	g _m	V _{DS} = 4.5V, V _{GS} = 0, R _S = 2.2kΩ ± 1%, f = 1kHz	300	500		μS
Noise Voltage	NV	V _{DS} = 4.5V, R _S = 2.2kΩ ± 1%, C _G = 10pF, A curve			4	μV
Voltage Gain	G _{V1}	V _{DS} = 4.5V, R _S = 2.2kΩ ± 1%, C _G = 10pF, E _G = 100mV, f = 70Hz		-10		dB
Voltage Gain	G _{V2}	V _{DS} = 12V, R _S = 2.2kΩ ± 1%, C _G = 10pF, E _G = 100mV, f = 70Hz		-9.5		dB
Voltage Gain	G _{V3}	V _{DS} = 1V, R _S = 2.2kΩ ± 1%, C _G = 10pF, E _G = 100mV, f = 70Hz		-11		dB

I_{DSS}-G_v CLASSIFICATION

Classification	P	Q
I _{DSS} (mA)	0.04-0.2	0.15-0.8
G _{V1} (dB)	> -13	> -12
G _{V2} (dB)	> -12	> -11
Δ G _{V1} -G _{V2} (dB)	< 3	< 3
Δ G _{V1} -G _{V3} (dB)	< 3	-





3

LOW FREQUENCY LOW NOISE AMP.

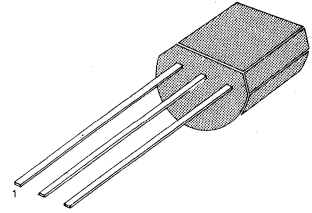
High $|Y_{fs}|$: 15mS (TYP)High Input Impedance : $I_{gss} = -1nA$

Low Noise, NF = 1dB (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{gds}	-50	V
Gate Current	I_g	10	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	125	$^\circ C$
Storage Temperature	T_{stg}	-55~125	$^\circ C$

TO-92



1. Drain 2. Gate 3. Source

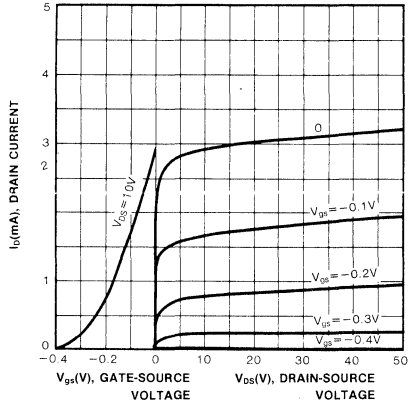
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate-Drain Breakdown Voltage	BV_{gds}	$V_{DS}=0, I_g=-100\mu A$	-50			V
Gate Leak Current	I_{gss}	$V_{gs}=-30V, V_{DS}=0$			-1	nA
Drain Leak Current	I_{DSS}	$V_{DS}=10V, V_{GS}=0$	0.6		14	mA
Gate-Source Voltage	$V_{gs(Off)}$	$V_{DS}=10V, I_D=0.1\mu A$	-0.2		-1.5	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS}=10V, V_{gs}=0, f=1KHz$	4.0	15		mS
Input Capacitance	C_{iss}	$V_{DS}=10V, V_{gs}=0, f=1MHz$		13		pF
Feedback Capacitance	C_{rss}	$V_{gd}=10V, I_D=0$ $f=1MHz$		3		pF
Noise Figure	NF1	$V_{DS}=10V, R_g=1k\Omega$ $I_D=0.5mA, f=10Hz$		5	10	dB
	NF2	$V_{DS}=10V, R_g=1k\Omega$ $I_D=0.5mA, f=1KHz$		1	2	dB

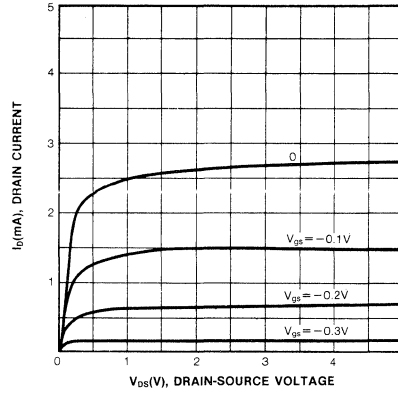
 I_{DSS} CLASSIFICATION

Classification	Y	G	L
$I_{DSS}(mA)$	1.2-3.0	2.6-6.5	6.0-14

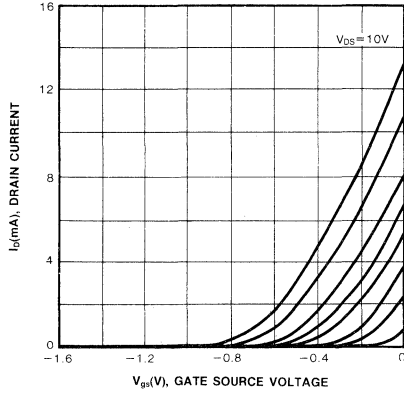
STATIC CHARACTERISTIC



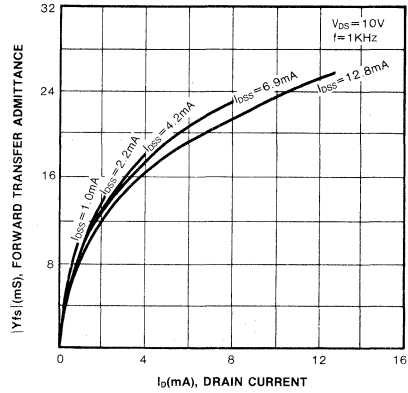
I_D - V_{DS}



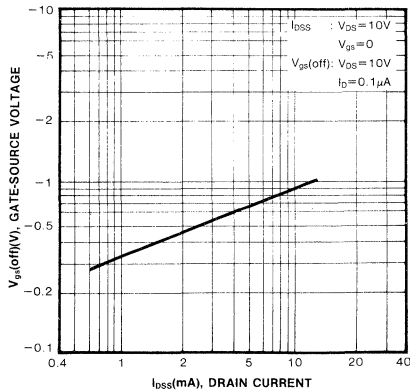
I_D - V_{GS}



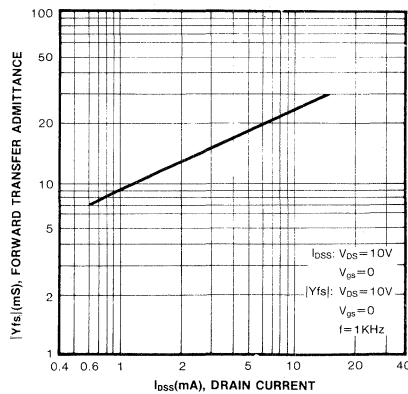
$|Y_{fs}|$ - I_D



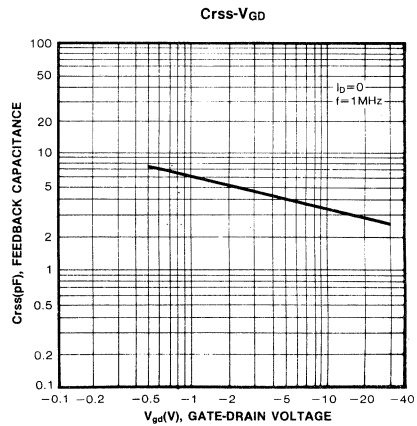
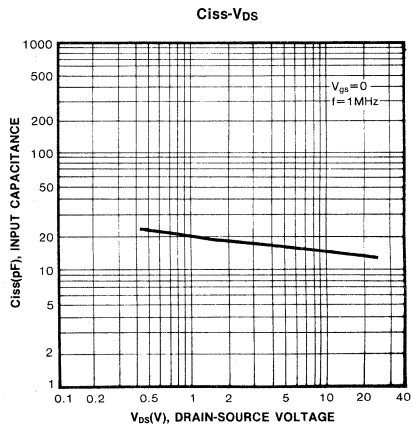
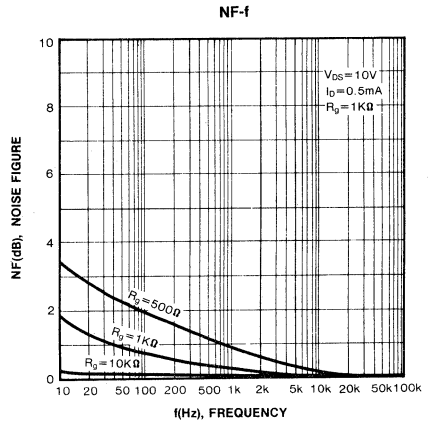
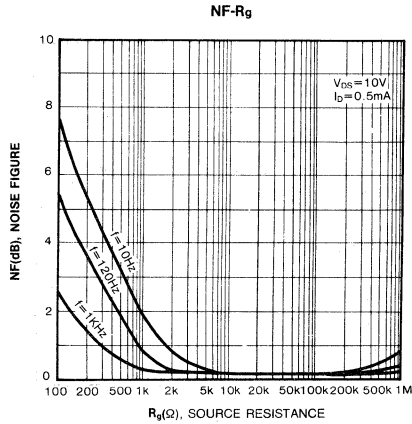
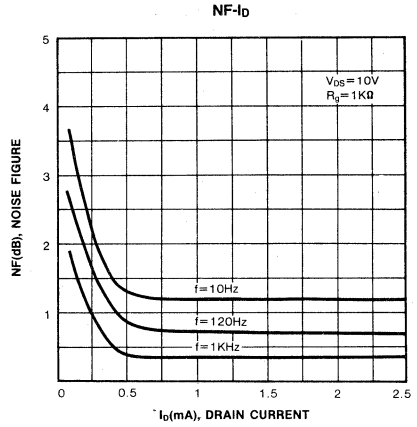
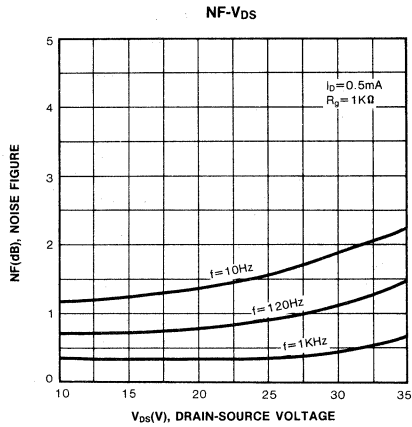
$V_{GS(off)}$ - I_{DSS}

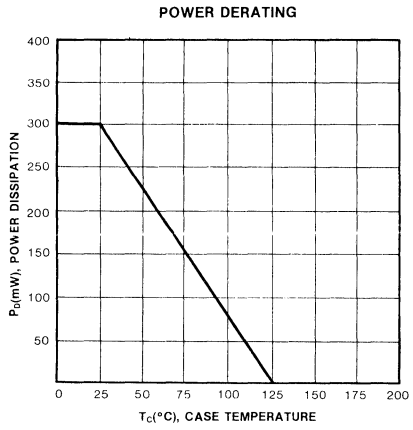


$|Y_{fs}|$ - I_{DSS}



3





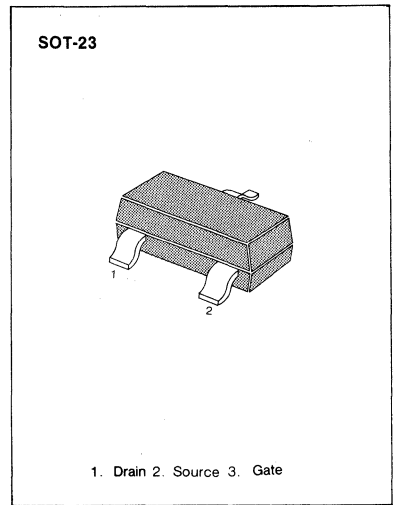
3

AF IMPEDANCE CONVERTER

- BUILT-IN DIODE BETWEEN G AND S
- LOW NV

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

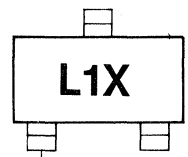
Characteristic	Symbol	Rating	Unit
Drain Source Voltage	V _{DSO}	20	V
Drain Gate Voltage	V _{DGO}	20	V
Drain Source Current	I _{DSO}	2	mA
Drain Gate Current	I _{DGO}	2	mA
Gate Source Current	I _{GSO}	2	mA
Power Dissipation	P _D	200	mW
Operate Temperature	T _{OPR}	-20~80	°C
Storage Temperature	T _{STG}	-55~100	°C

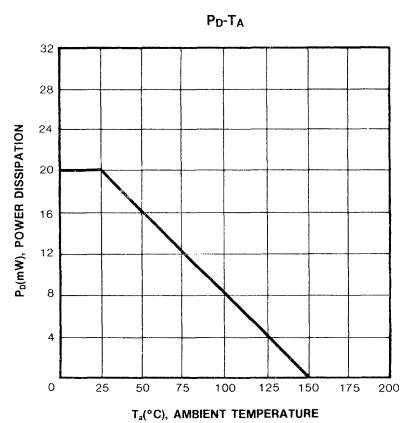
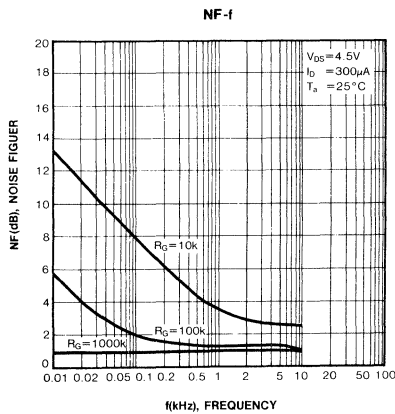
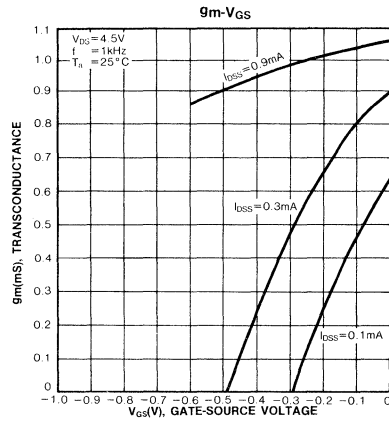
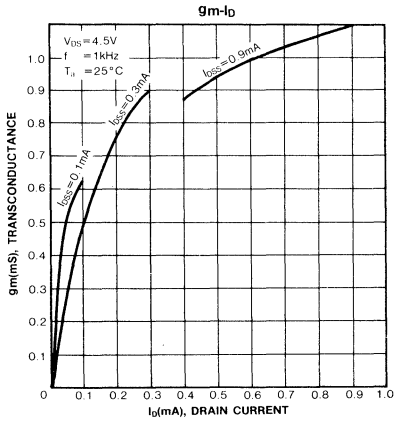
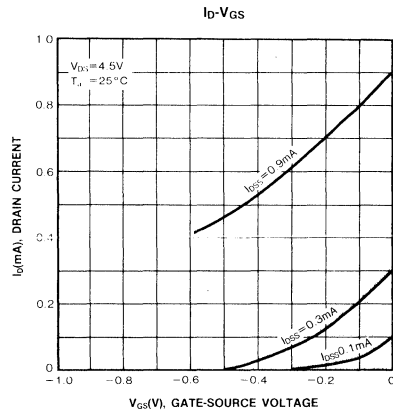
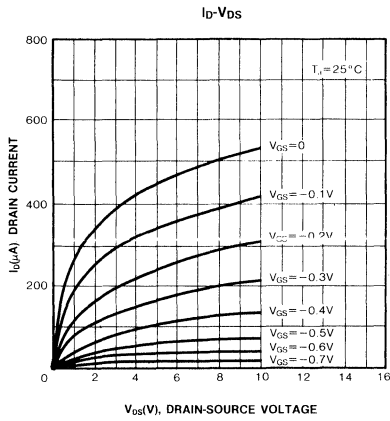


ELECTRICAL CHARACTERISTICS (T_a = 25°C)

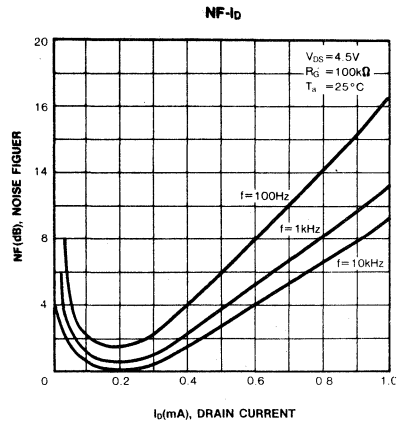
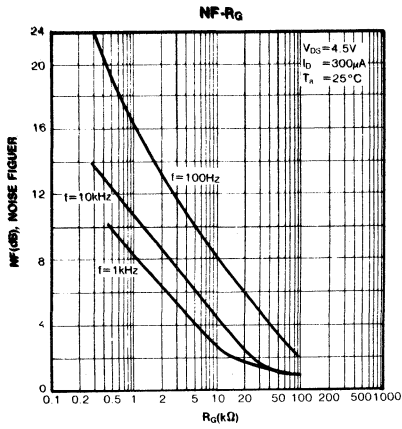
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Drain Current	I _{DSS}	V _{DS} =4.5V, V _{GS} =0 R _S =2.2kohm ± 1%	130	200	470	μA
Transconductance	gm	V _{DS} =4.5V, V _{GS} =0 R _S =2.2kohm±1%, f=1kHz	0.9	1.6	4	mS μV
Voltage Gain	G _{v1}	C _G =10pF, A curve V _{DS} =4.5V, R _S =2.2kohm: ± 1% C _G =10pF, E _G =10mV, f=70Hz	-1			dB
Voltage Gain	G _{v2}	V _{DS} =12V, R _S =2.2kohm±1% C _G =10pF, E _G =10mV, f=70Hz	0			dB
Voltage Gain	G _{v3}	V _{DS} =1.5V, R _S =2.2kohm±1% C _G =10pF, E _G =10mV, f=70Hz	-4			dB

Marking





3

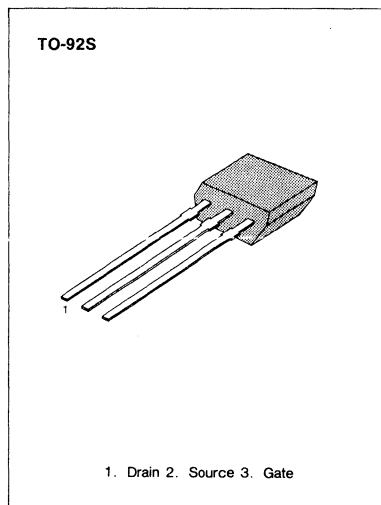


FM TUNER
VHF AMPLIFIER

- NF = 2.5 dB (TYP)
- |Y_{FS}| = 9.0 mS (TYP)

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V _{GDO}	-18	V
Gate Current	I _G	10	mA
Power Dissipation	P _D	200	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



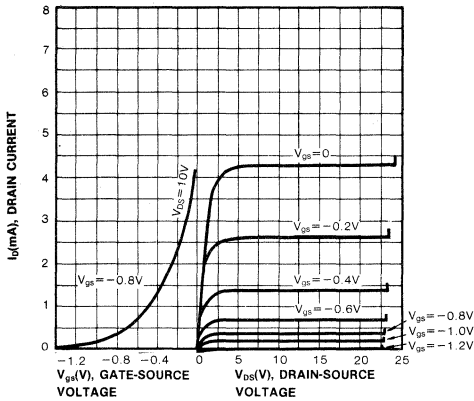
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate Cut-off Current	I _{GSS}	V _{GS} = -0.5V, V _{DS} = 0			-10	nA
Gate-Drain Breakdown Voltage	V(BR) _{GDO}	I _G = -100μA, Drain	-18			V
Drain Current	I _{DSS}	V _{DS} = 10V, V _{GS} = 0	1.0		10	mA
Gate-Source Cuf-off Voltage	V _{GS(off)}	V _{DS} = 10V, I _D = 1μA	0.4		4.0	V
Forward Transfer Admittance	Y _{FS}	V _{DS} = 10V, V _{GS} = 0, f = 1kHz		9		mS
Reverse Transfer Capacitance	C _{rfs}	V _{GD} = 10V, f = 1MHz			0.15	pF
Power Gain	C _{PS}	V _{DD} = 10V, f = 100MHz		18		dB
Noise Figuer	NF	V _{DD} = 10V, f = 100MHz		2.5	3.5	dB

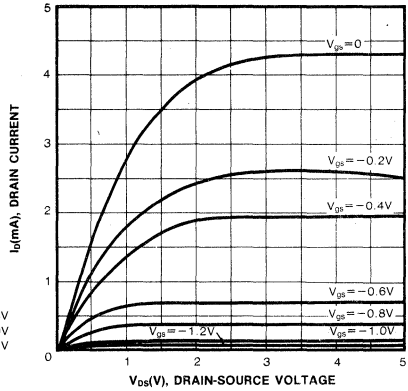
I_{DSS} CLASSIFICATION

Classification	O	Y	G
I _{DSS}	1.0-3.0	2.5-6.0	5.0-10

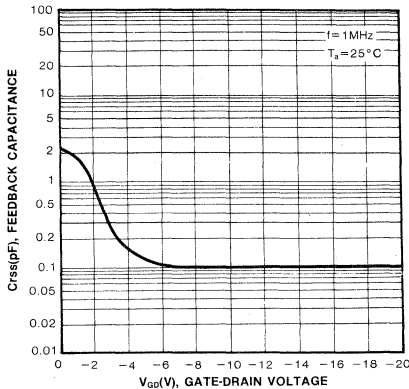
STATIC CHARACTERISTIC



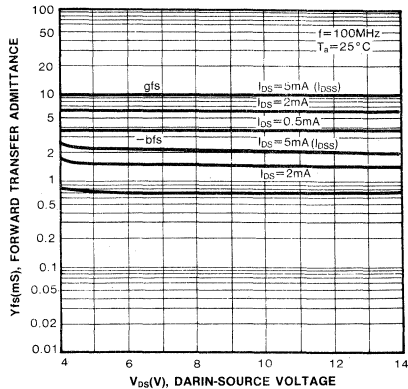
I_D - V_{DS}



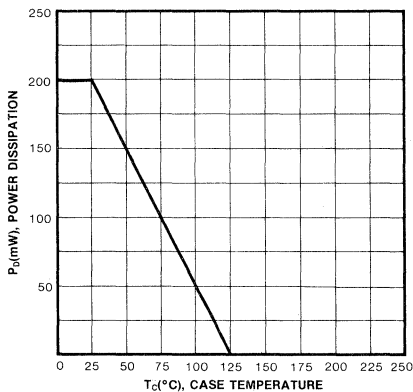
C_{rss} - V_{GD}



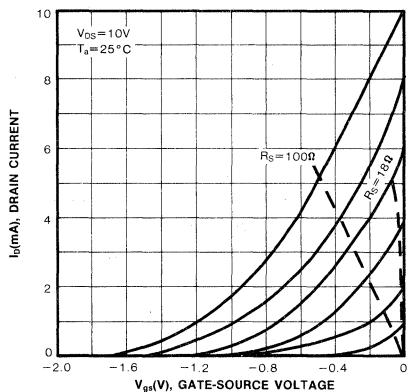
Y_{fs} - V_{DS}

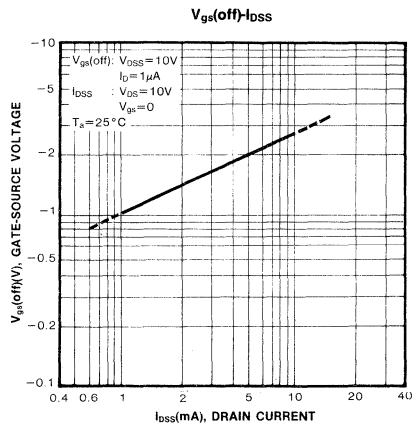
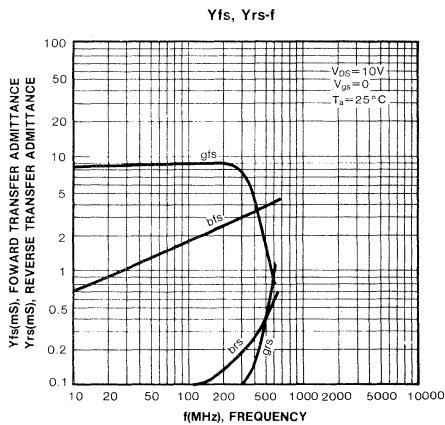
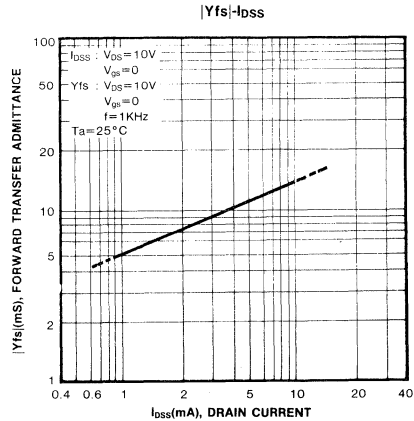
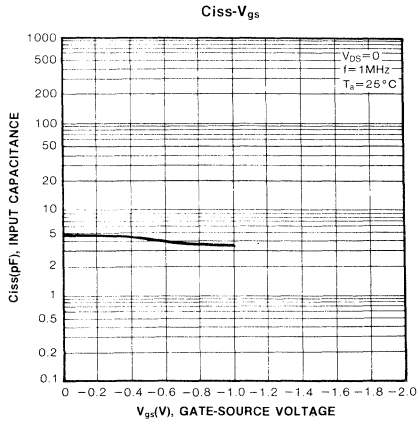
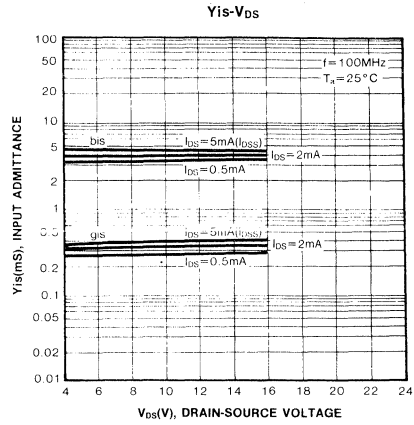
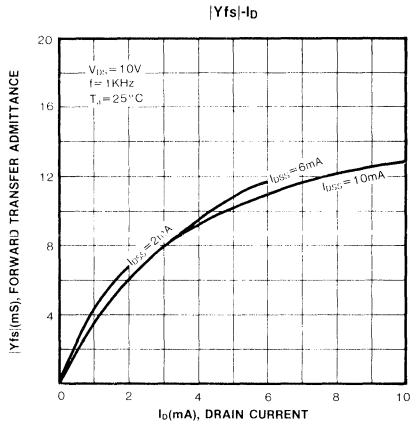


POWER DERATING

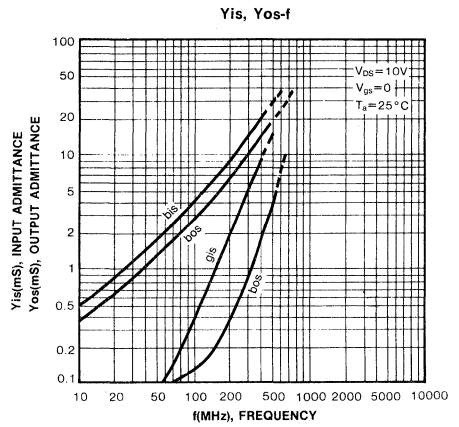
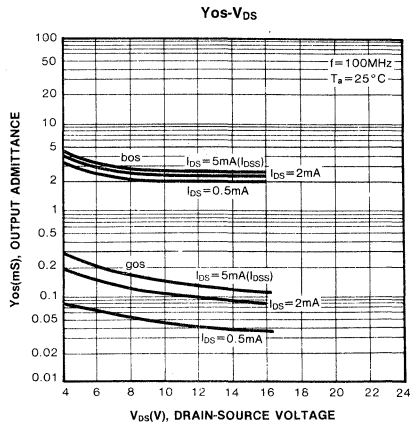


I_D - V_{GS}





3

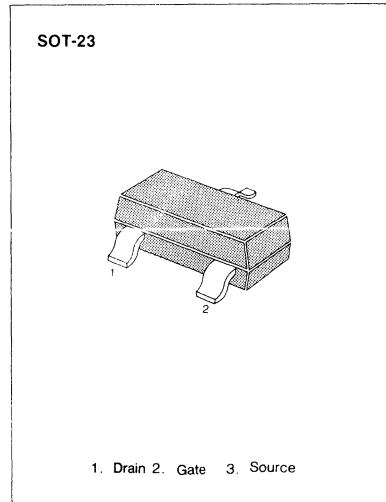


**FM TUNER
VHF AMPLIFIER**

- NF = 2.5 dB (TYP)
- |Y_{FS}| = 9.0 mS (TYP)

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V _{GDO}	-18	V
Gate Current	I _G	10	mA
Power Dissipation	P _D	200	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



3

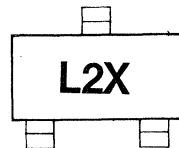
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate Cut-off Current	I _{GSS}	V _{GS} = -0.5V, V _{DS} = 0			-10	nA
Gate-Drain Breakdown Voltage	V(BR) _{GDO}	I _G = -100μA, Drain	-18			V
Drain Current	I _{DSS}	V _{DS} = 10V, V _{GS} = 0	1.0		10	mA
Gate-Source Cuf-off Voltage	V _{GS(off)}	V _{DS} = 10V, I _D = 1μA	0.4		4.0	V
Forward Transfer Admittance	Y _{FS}	V _{DS} = 10V, V _{GS} = 0, f = 1kHz		9		mS
Reverse Transfer Capacitance	C _{rfs}	V _{GD} = 10V, f = 1MHz			0.15	pF
Power Gain	C _{PS}	V _{DD} = 10V, f = 100MHz		18		dB
Noise Figuer	NF	V _{DD} = 10V, f = 100MHz		2.5	3.5	dB

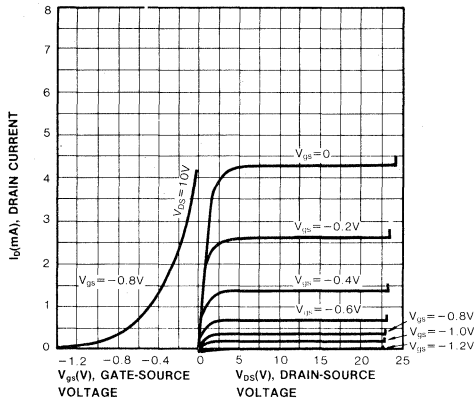
I_{DSS} CLASSIFICATION

Classification	O	Y	G
I _{DSS}	1.0-3.0	2.5-6.0	5.0-10

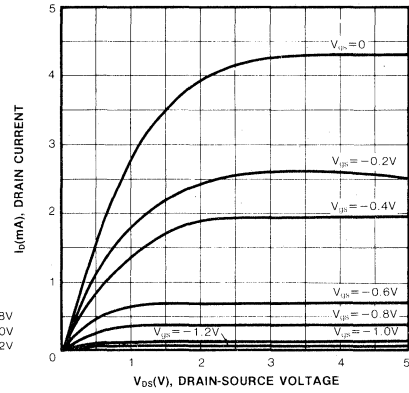
Marking



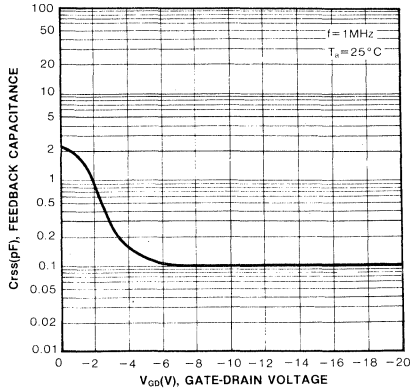
STATIC CHARACTERISTIC



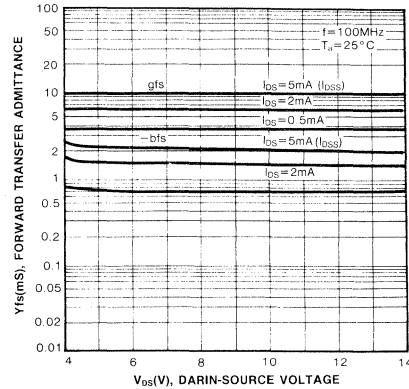
I_D - V_{DS}



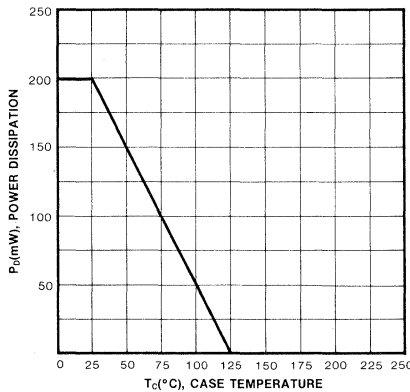
C_{rss} - V_{GD}



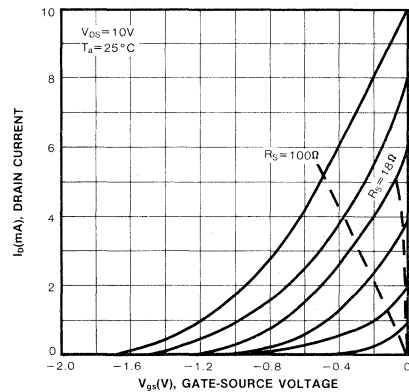
Y_{fs} - V_{DS}

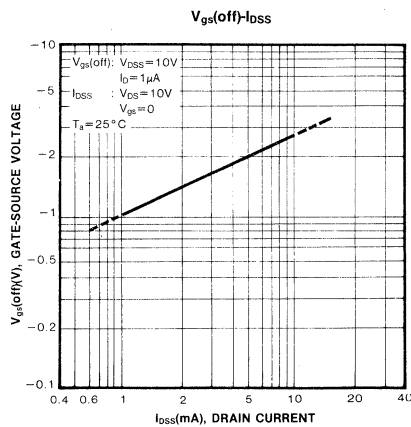
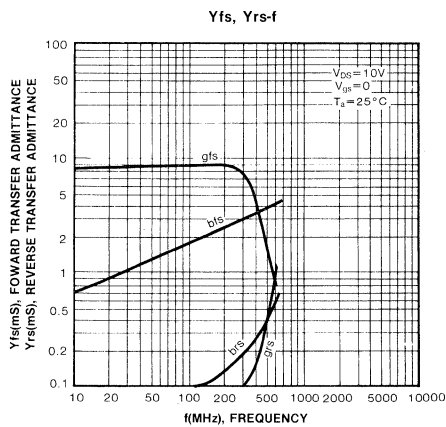
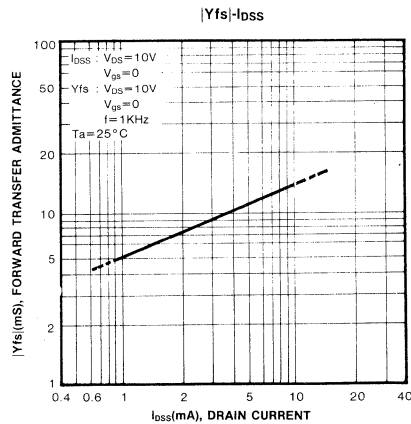
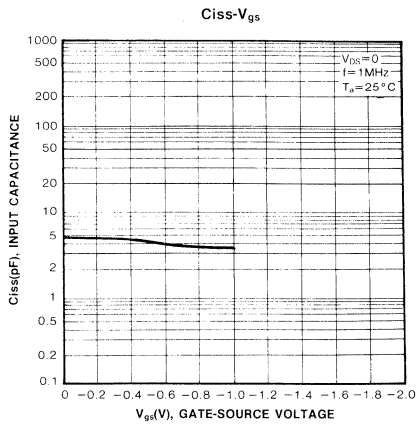
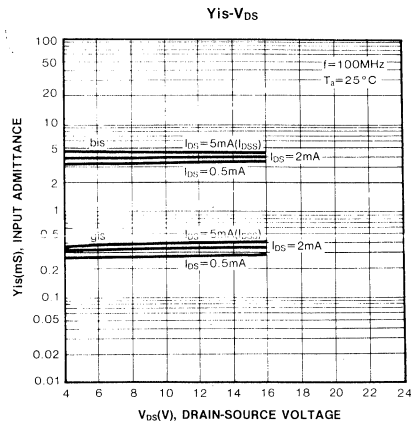
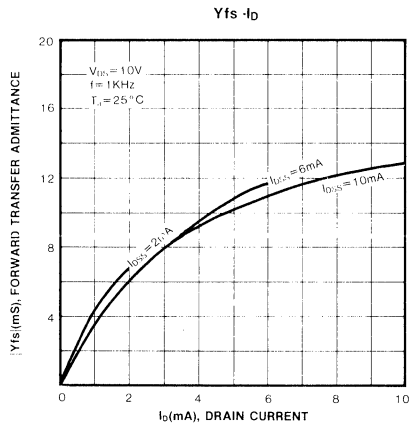


POWER DERATING

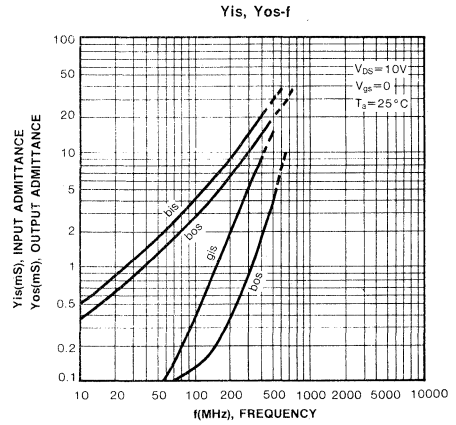
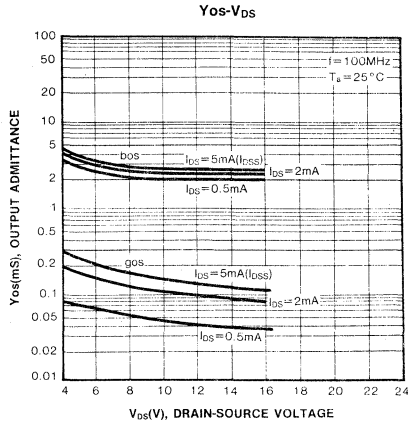


I_D - V_{GS}





3

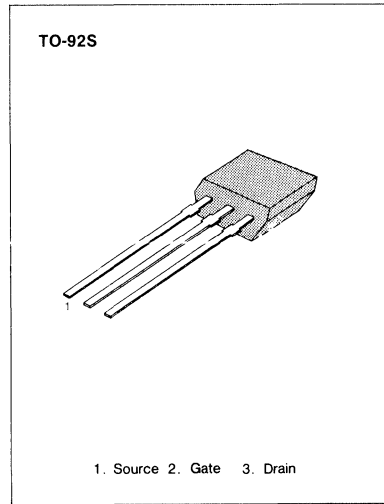


CAPACITOR MICROPHONE APPLICATIONS

- Especially Suited for use in Audio, Telephone Capacitor Microphones
- Excellent Voltage Characteristic
- Excellent Transient Characteristic

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Characteristic	Symbol	Rating	Unit
Gate Drain Voltage	V _{GDO}	-20	V
Gate Current	I _G	10	mA
Drain Current	I _D	1	mA
Power Dissipation	P _D	100	mW
Junctin Temperature	T _J	150	°C
Storage Temperature	T _{STG}	-55~150	°C



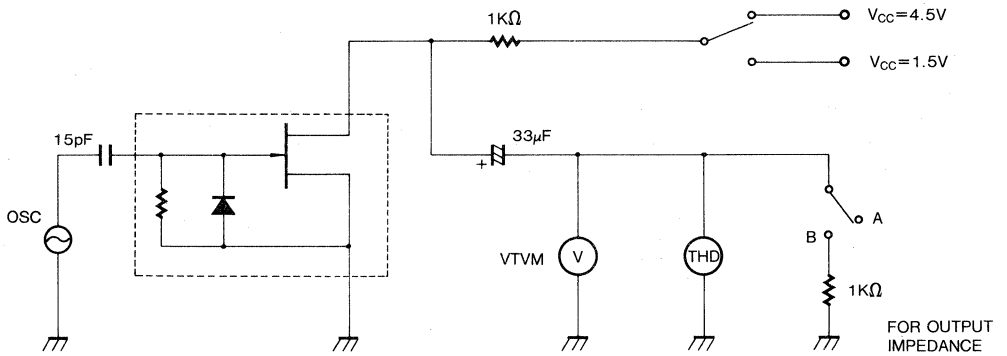
ELECTRICAL CHARACTERISTICS (Ta=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate Drain Breakdown Voltage	BV _{GDO}	I _G = -100μA	-20			V
Gate Source Cut off Voltage	V _{GS(off)}	V _{DS} = 5V, I _B = 1μA		-0.6	-1.5	V
Drain Current	I _{DSS}	V _{DS} = 5V, V _{GS} = 0	100		80	uA
Forward Transfer Admittance	Y _{FS}	V _{DS} = 5V, V _{GS} = 0, f = 1KHz	0.4	1.2		mS
Input Capacitance	C _{ISS}	V _{DS} = 5V, V _{GS} = 0, f = 1MHz		3.5		pF
Output Capacitance	C _{RSS}	V _{DS} = 5V, V _{GS} = 0, f = 1MHz		0.65		pF

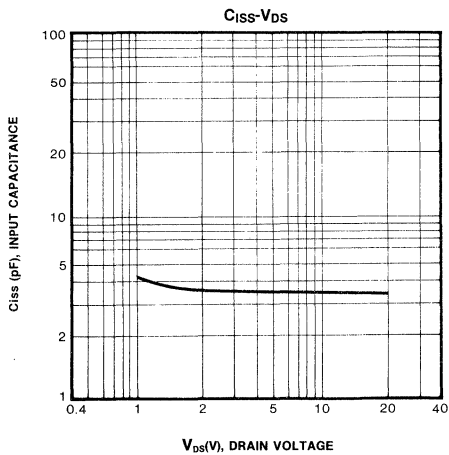
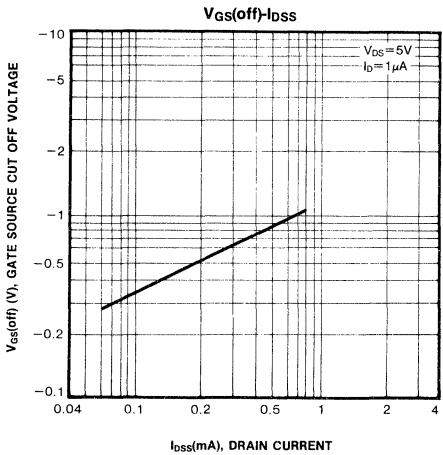
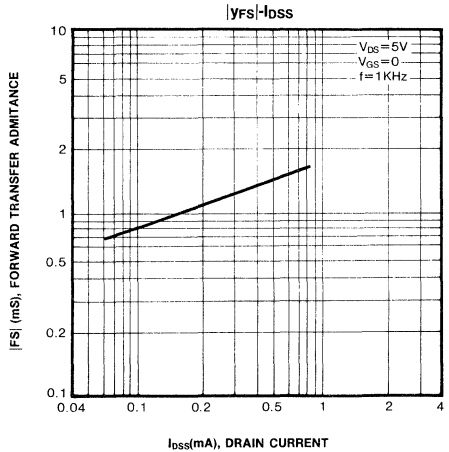
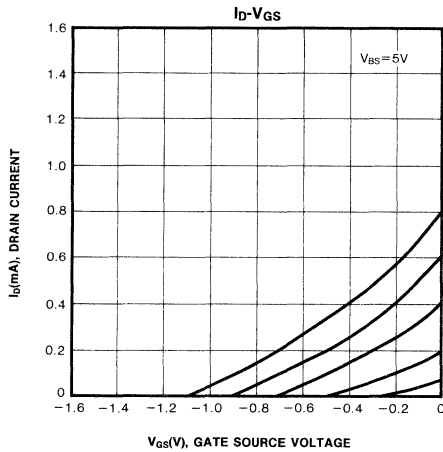
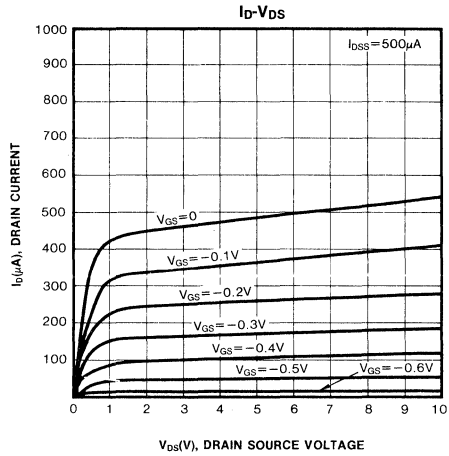
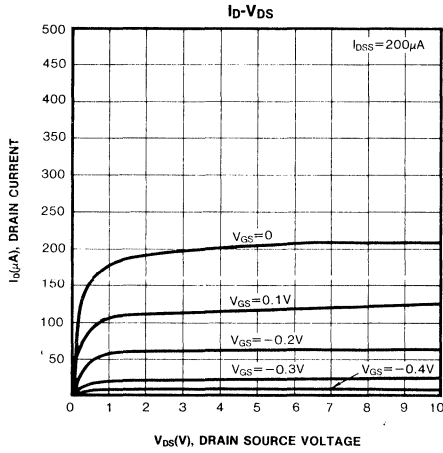
I_{DSS} CLASSIFICATION

Classification	A	B	C	D	E
I _{DSS} (uA)	100~170	150~240	210~350	320~480	440~800

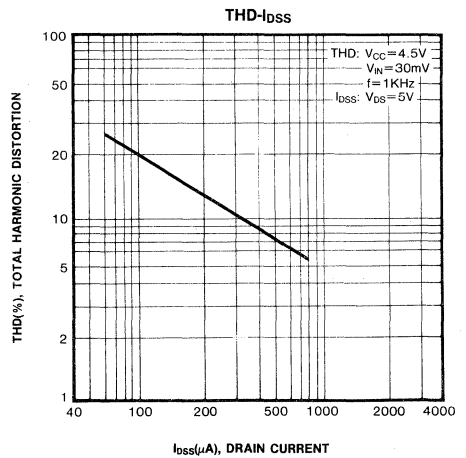
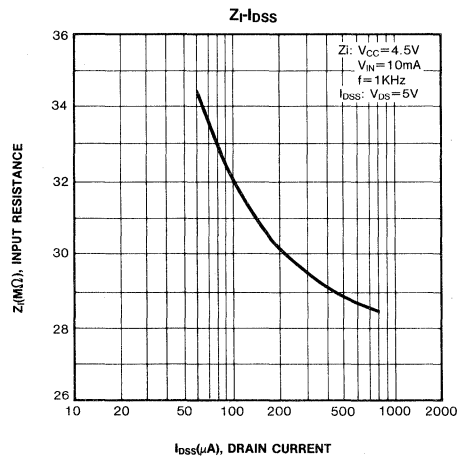
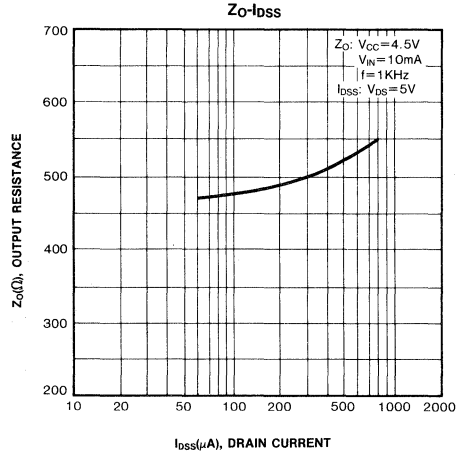
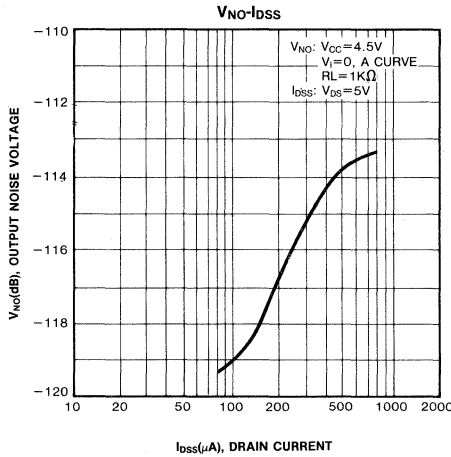
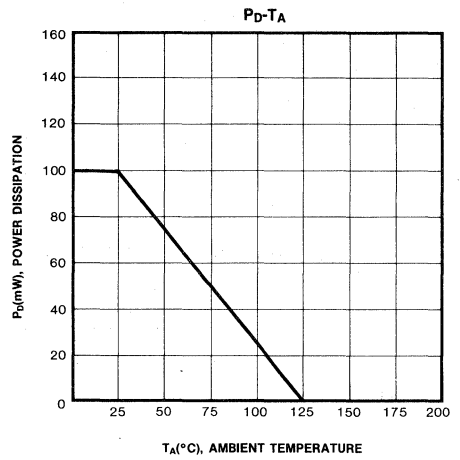
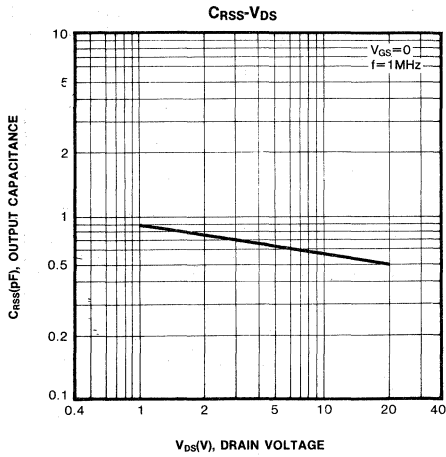
SPECIFIED TEST CIRCUIT (Ta = 25°C)

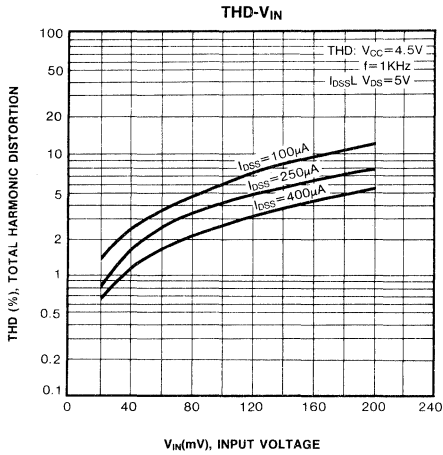
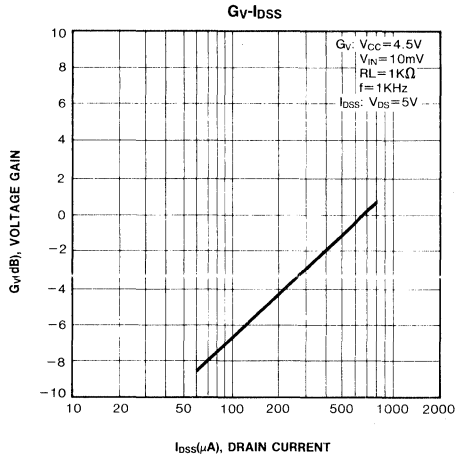
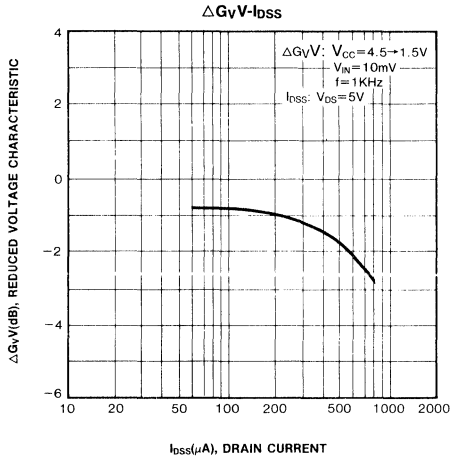


Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Voltage Gain	G_V	$V_{IN}=10mV, f=1KHz$		-3		dB
Reduced Voltage Characteristic	ΔG_V	$V_{IN}=10mV, f=1KHz$ $V_{CC}=4.5V \rightarrow 1.5V$		-1.2	-3.5	dB
Frequency Characteristic	ΔG_V	$f=1KHz$ to 110Hz			-1	dB
Input Resistance	Z_{IN}	$f=1KHz$	25			$M\Omega$
Output Resistance	Z_O	$f=1KHz$			700	Ω
Total Harmonic Distortion	THD	$V_{IN}=30mV, f=1KHz$		1		%
Output Noise Voltage	V_{NO}	$V_{IN}=0, A$ CURVE			-110	dB



3





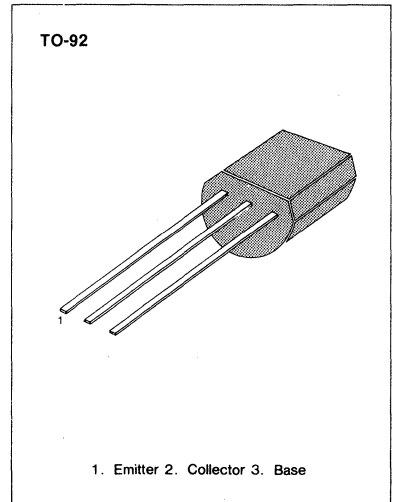
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=4.7K\Omega$)
- Complement to KSR2001

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

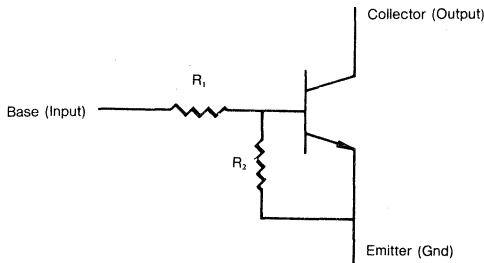
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



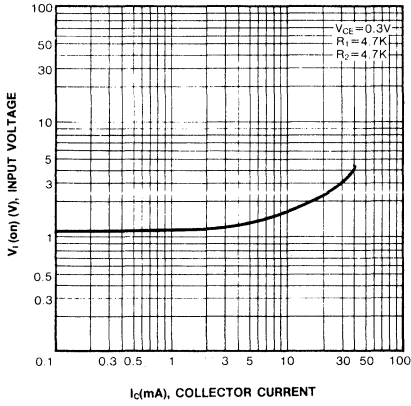
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=10mA$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V$, $I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE}=5V$, $I_C=100\mu A$	0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE}=0.3V$, $I_C=20mA$			3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

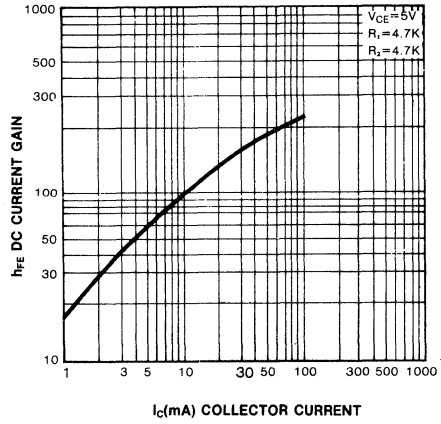
Equivalent Circuit



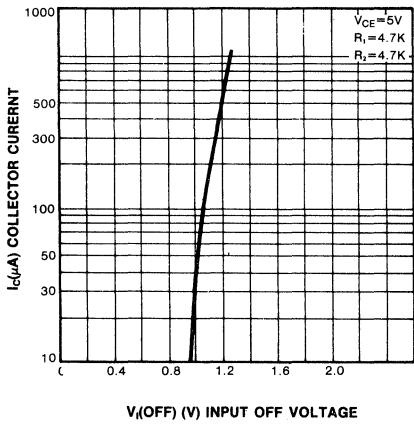
INPUT ON VOLTAGE



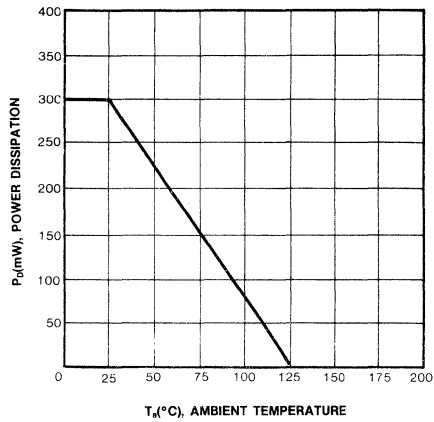
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



3

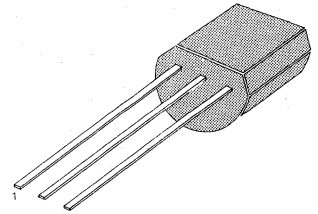
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2002

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

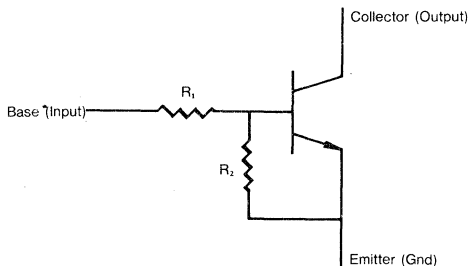
TO-92



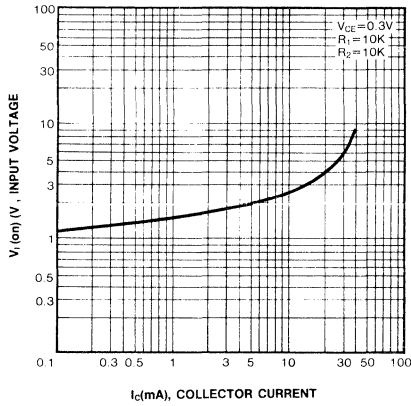
1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

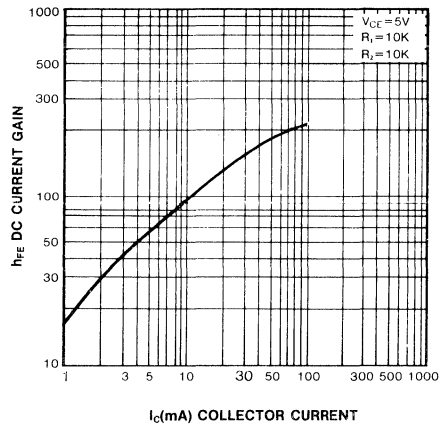
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}$, $I_C=10\text{mA}$			3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

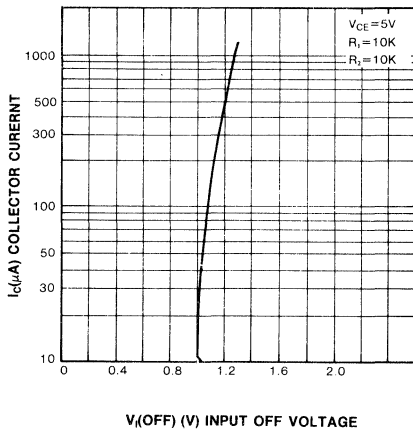
INPUT ON VOLTAGE



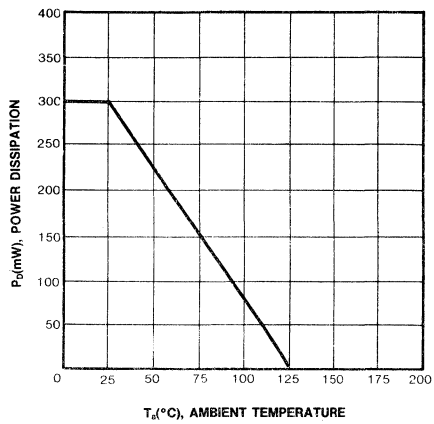
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



3

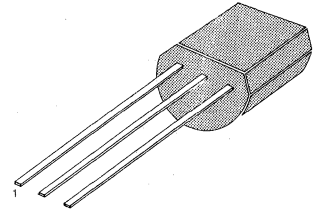
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2003

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

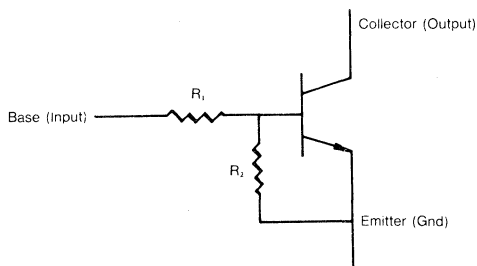
TO-92



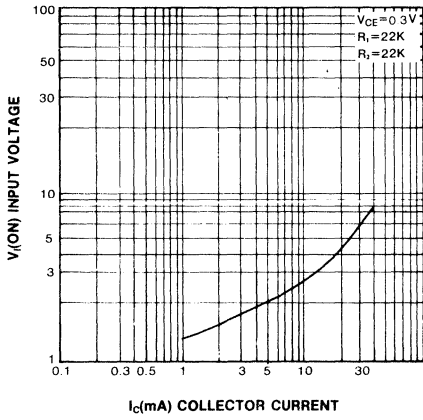
1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

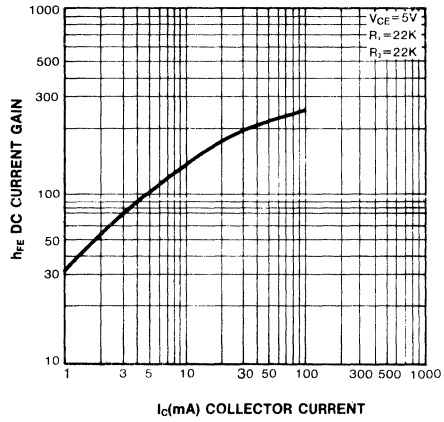
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}$, $I_C=5\text{mA}$			3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

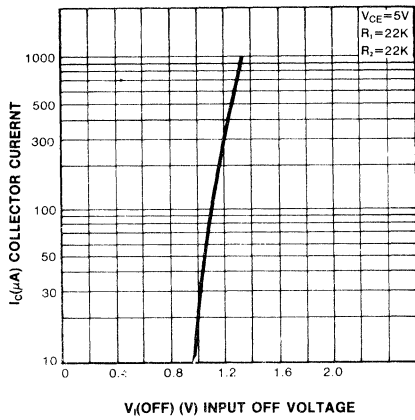
INPUT ON VOLTAGE



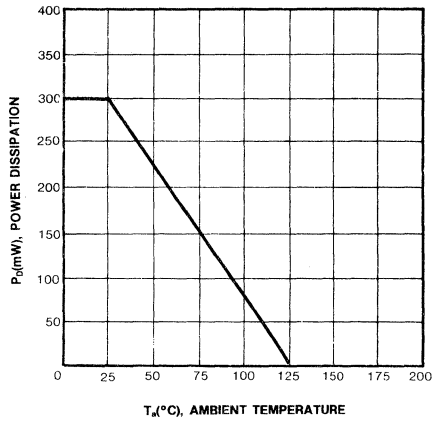
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



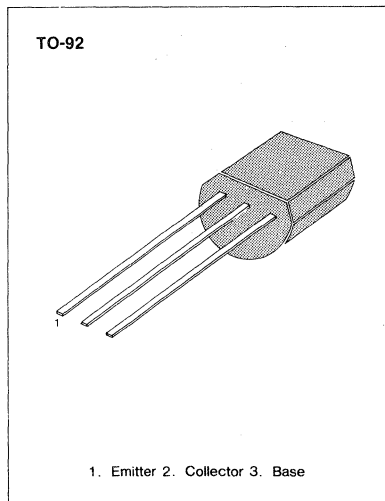
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2004

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

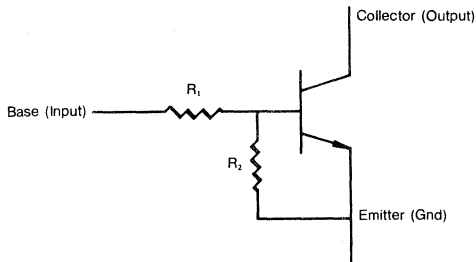
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



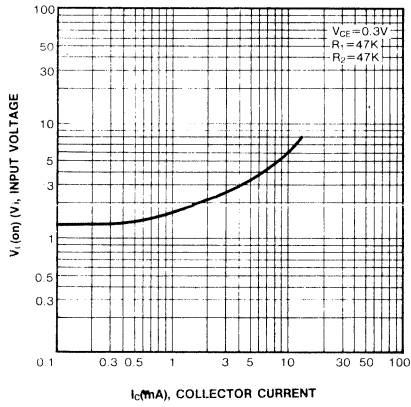
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V$, $I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V$, $I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V$, $I_C=2mA$			3	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

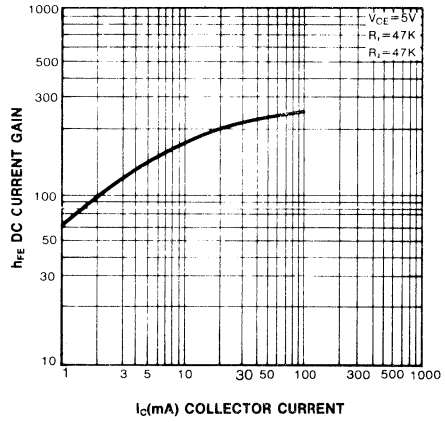
Equivalent Circuit



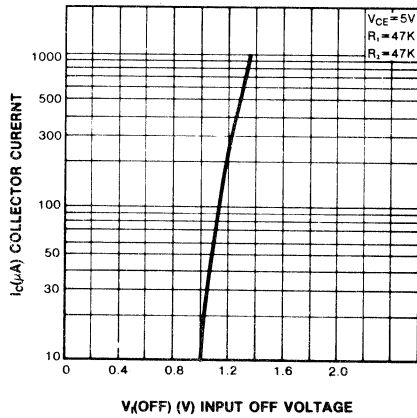
INPUT ON VOLTAGE



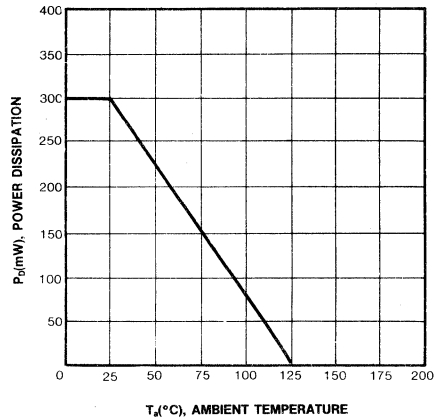
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



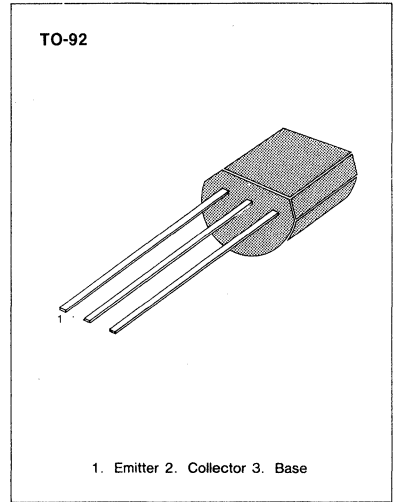
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2005

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

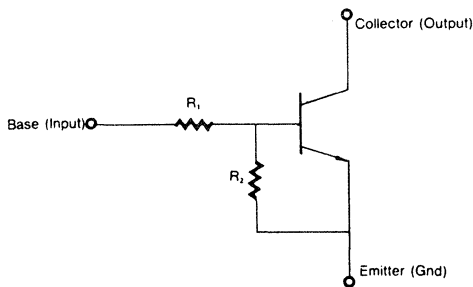
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



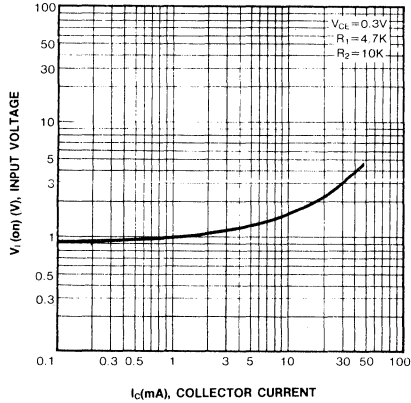
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Off Voltage	$V_{i(off)}$	$V_{CE}=5V, I_C=100\mu A$	0.3			V
Input On Voltage	$V_{i(on)}$	$V_{CE}=0.3V, I_C=20mA$			2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

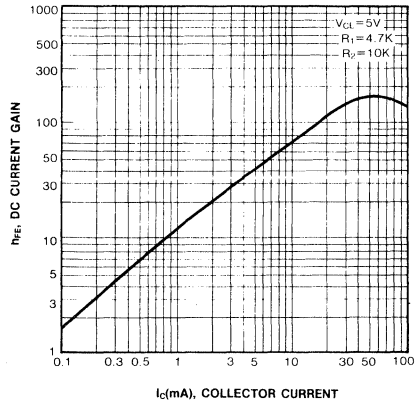
Equivalent Circuit



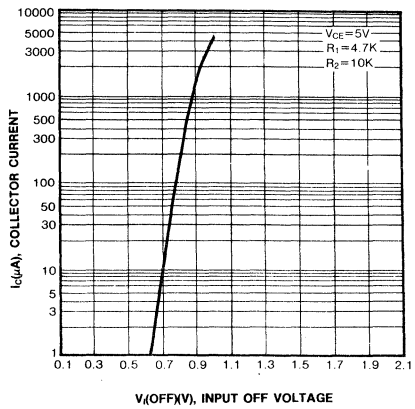
INPUT ON VOLTAGE



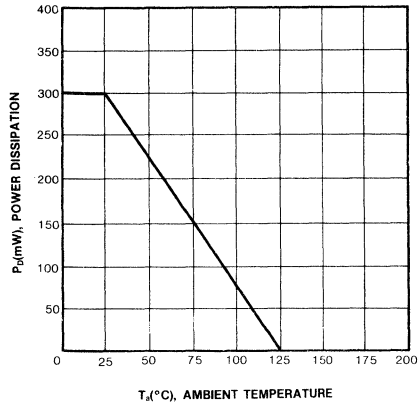
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



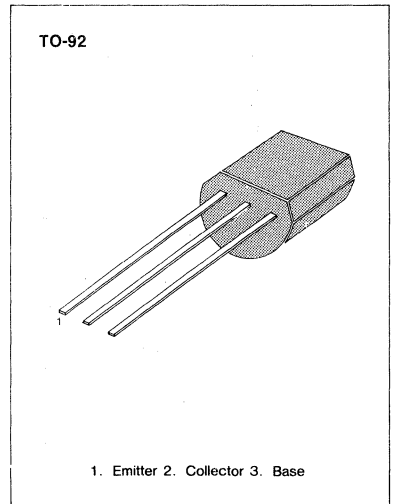
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2006

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

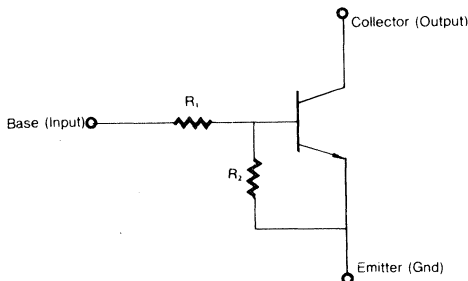
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C^*$



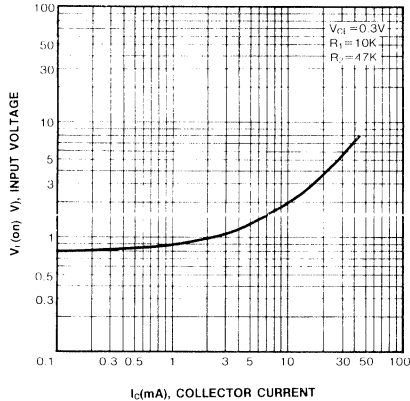
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.3			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=1mA$			1.4	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

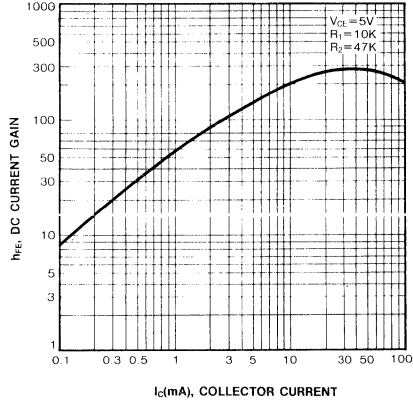
Equivalent Circuit



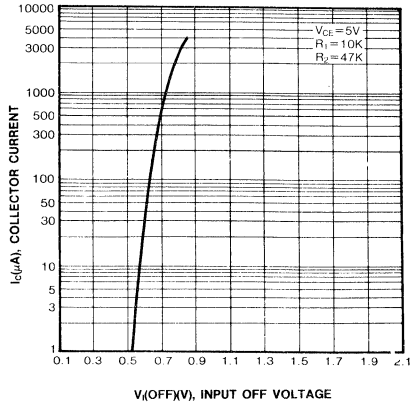
INPUT ON VOLTAGE



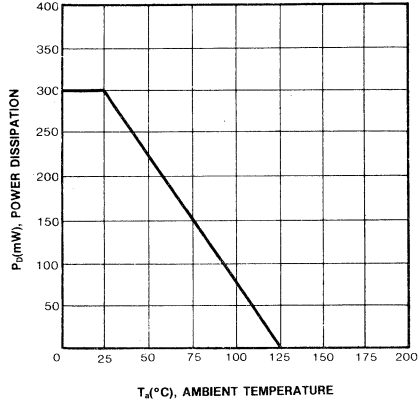
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



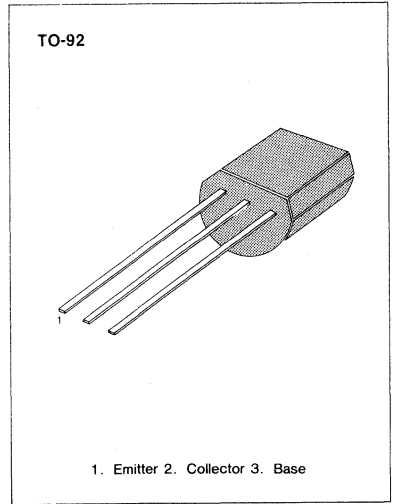
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2007

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

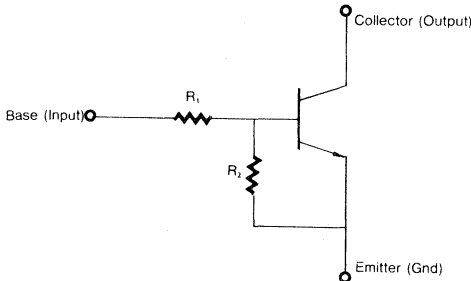
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



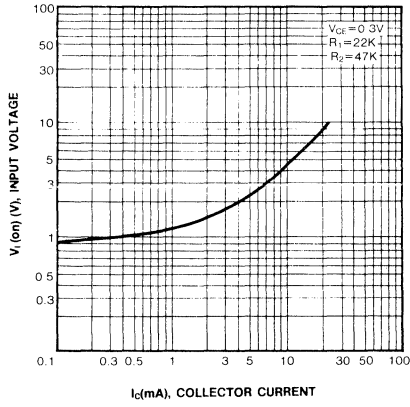
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V$, $I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$		250		MHz
Input Off Voltage	$V_{i(off)}$	$V_{CE}=5V$, $I_C=100\mu A$	0.4			V
Input On Voltage	$V_{i(on)}$	$V_{CE}=0.3V$, $I_C=2mA$			2.5	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

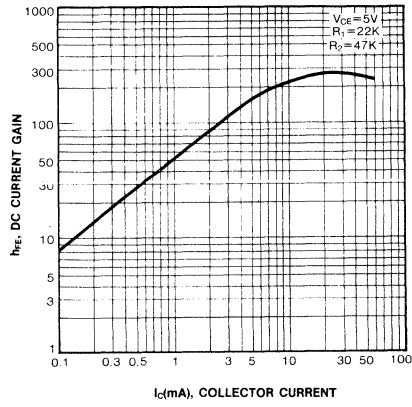
Equivalent Circuit



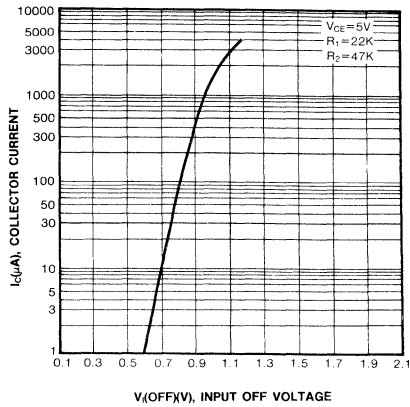
INPUT ON VOLTAGE



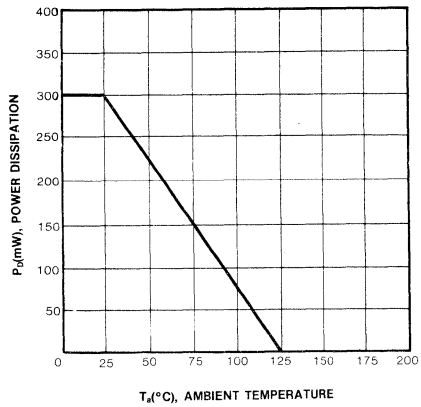
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



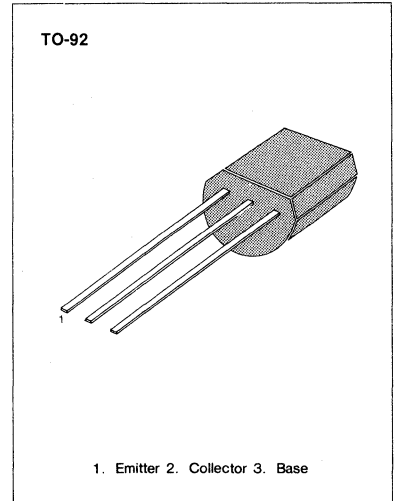
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SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2008

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

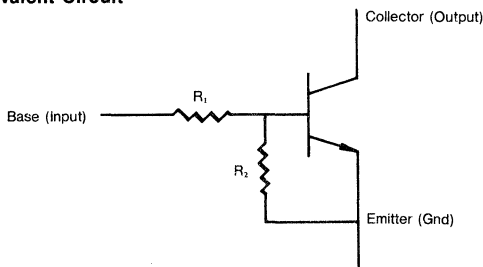
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



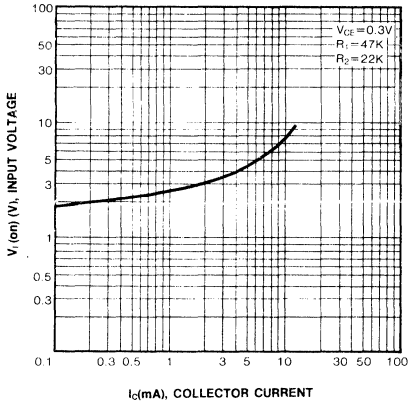
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.8			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			4	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

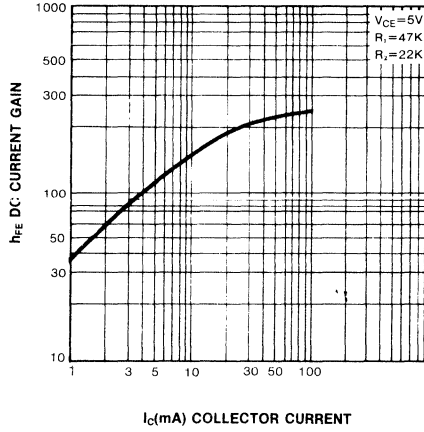
Equivalent Circuit



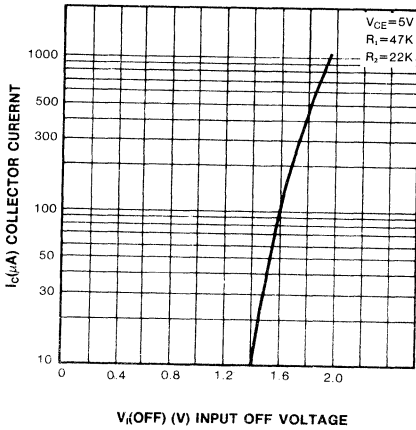
INPUT ON VOLTAGE



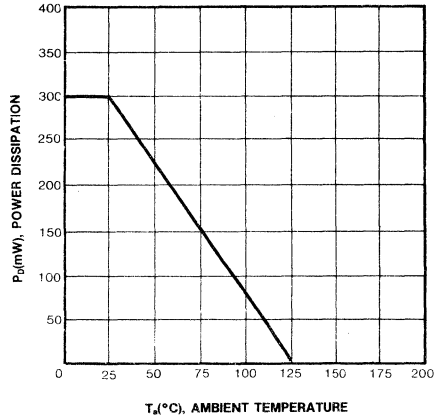
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



3

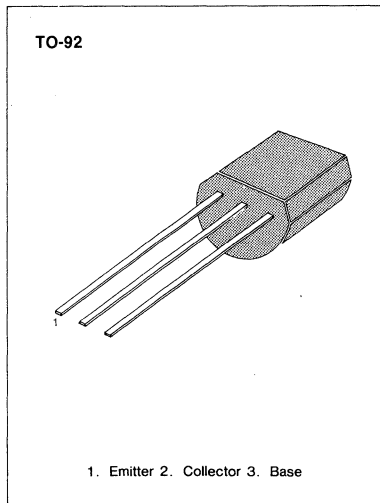


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR2009

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

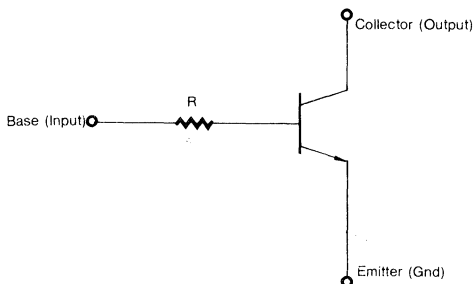
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



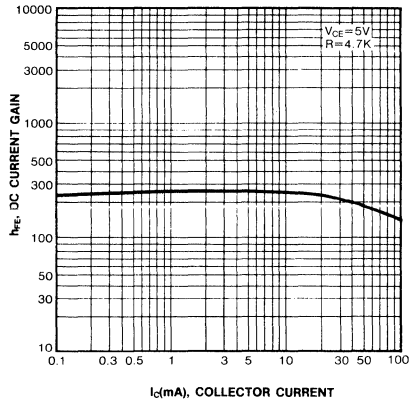
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.70		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		3.2	4.7	6.2	$K\Omega$

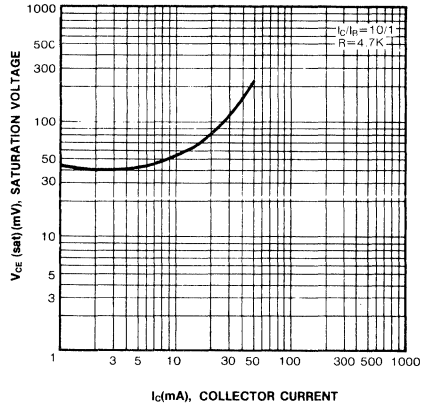
Equivalent Circuit



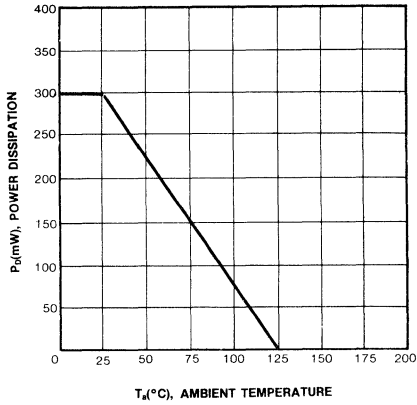
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



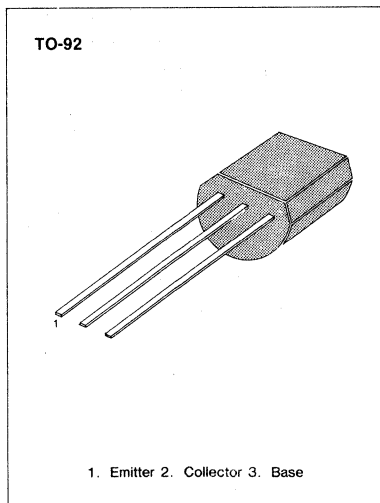
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR2010

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

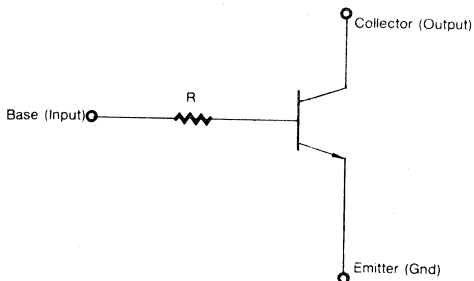
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	40	V
Collector-Emitter Voltage	V_{CE0}	40	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



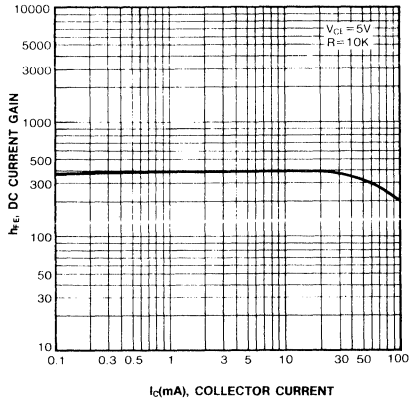
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 1\text{mA}, I_B = 0$	40			V
Collector Cutoff Current	I_{CB0}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$		250		MHz
Input Resistor	R		7	10	13	$K\Omega$

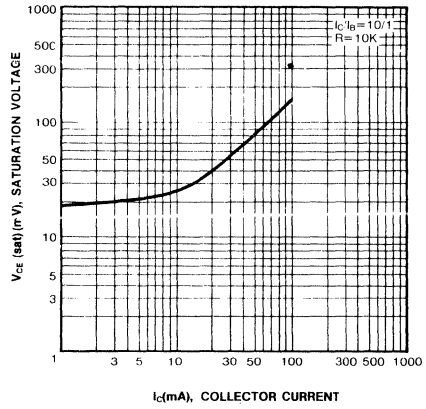
Equivalent Circuit



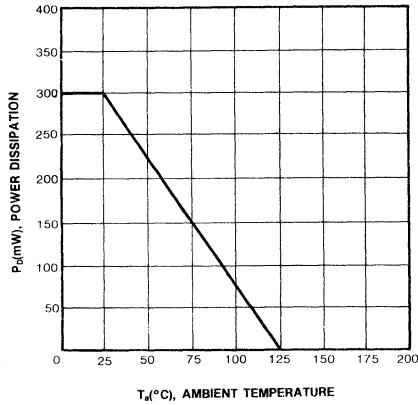
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



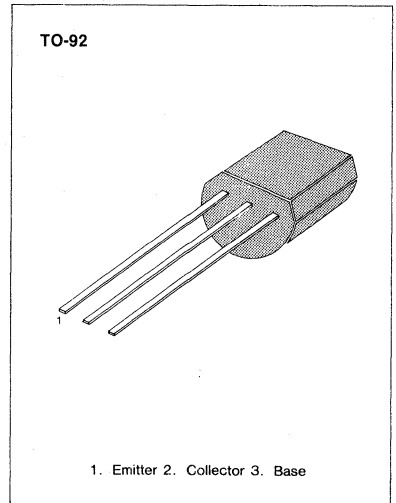
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR2011

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

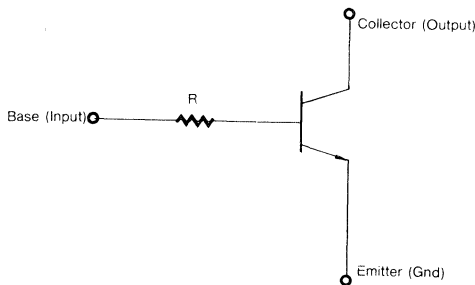
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		15	22	29	$K\Omega$

Equivalent Circuit

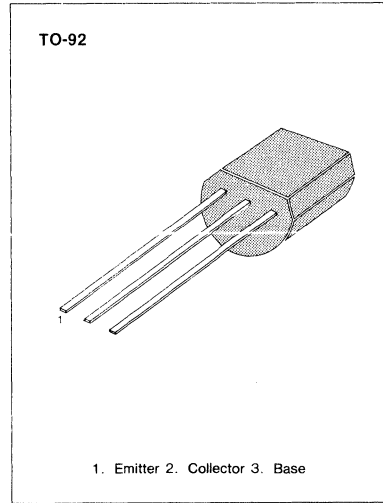


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47K\Omega$)
- Complement to KSR2012

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

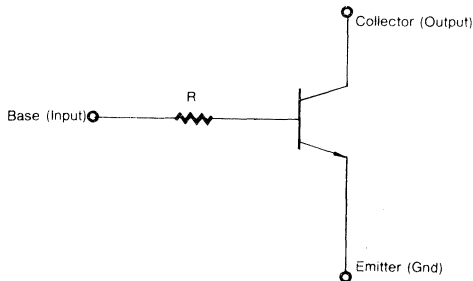
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		32	47	62	$K\Omega$

Equivalent Circuit

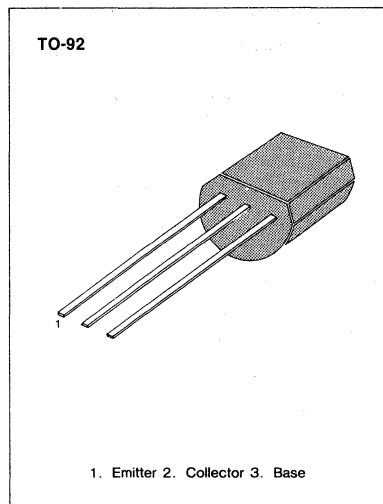


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 2.2K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2013

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

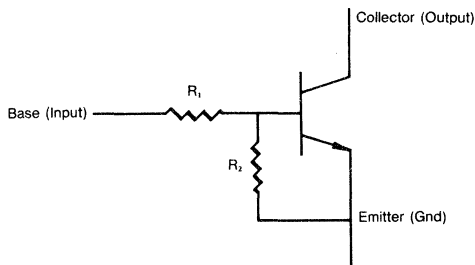
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 - 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A$, $I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A$, $I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V$, $I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V$, $I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA$, $I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA$, $I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V$, $I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = 5V$, $I_C = 100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = 0.2V$, $I_C = 5mA$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit

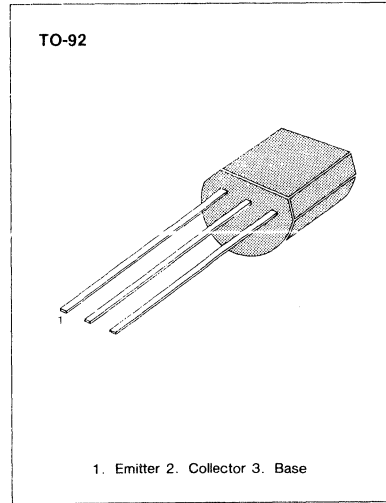


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

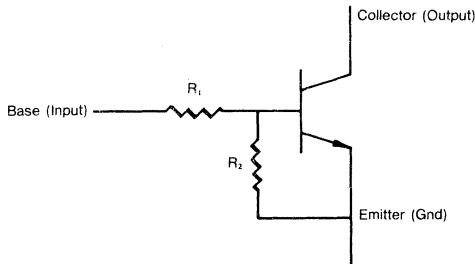


3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A, I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA, I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = 5V, I_C = 100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = 0.2V, I_C = 5mA$			1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit

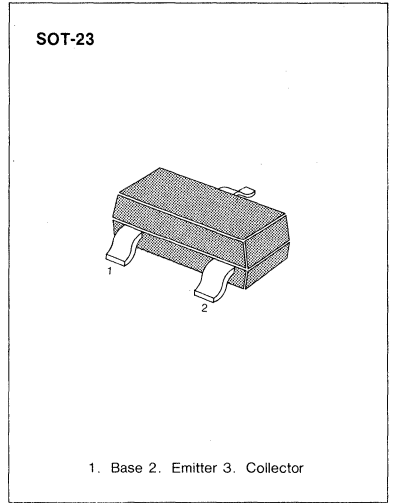


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$ $R_2=4.7K\Omega$)
- Complement to KSR2101

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

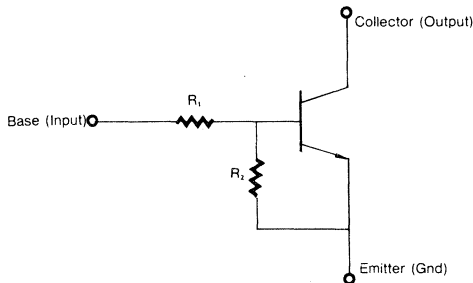
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



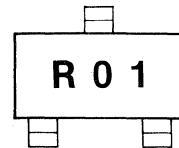
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=10mA$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=20mA$			3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

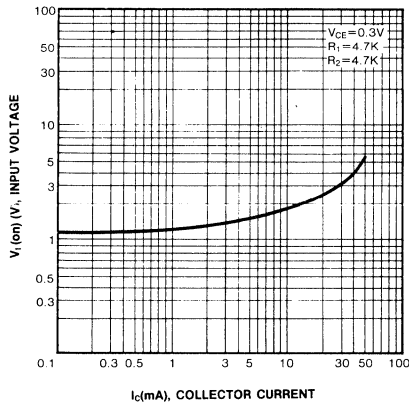
Equivalent Circuit



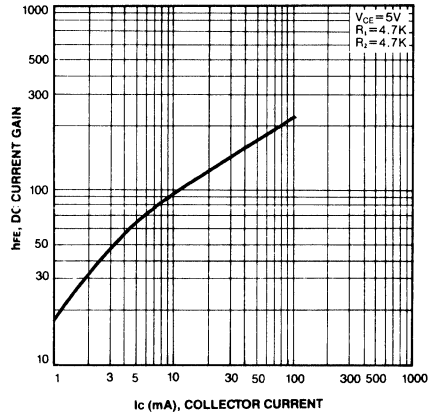
Marking



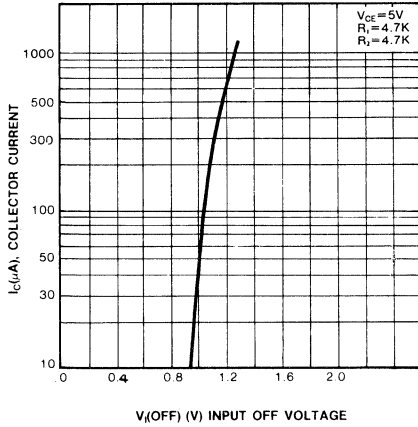
INPUT ON VOLTAGE



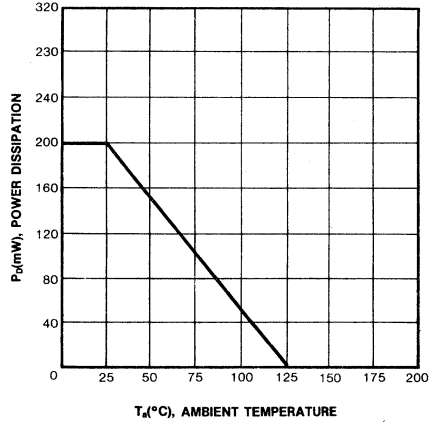
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

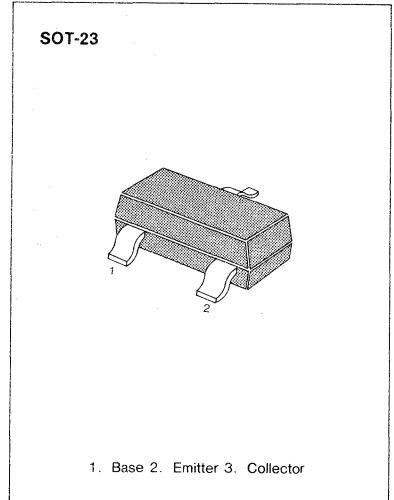


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2102

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

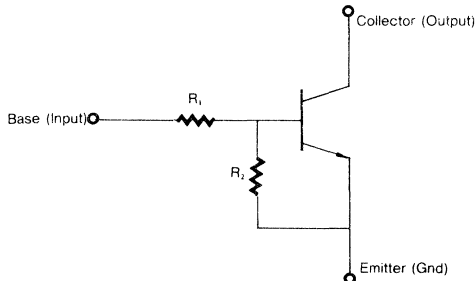
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



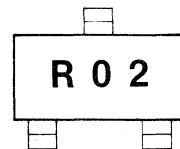
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=10mA$			3	V
Input Resistor	R_1		7	10	13	K Ω
Resistor Ratio	R_1/R_2		0.9	1	1.1	

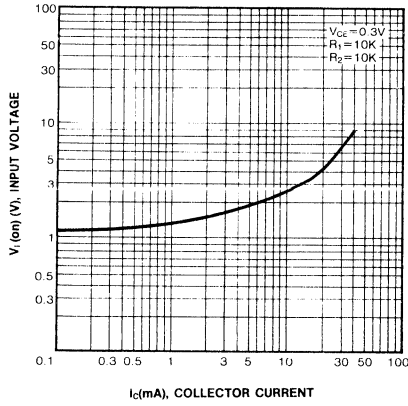
Equivalent Circuit



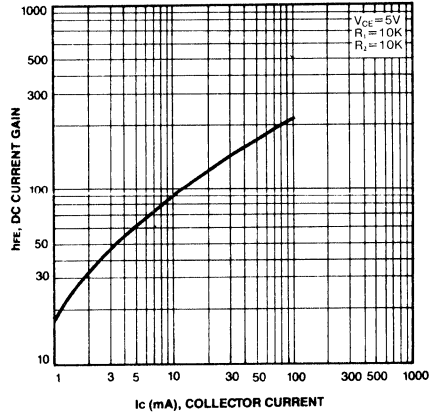
Marking



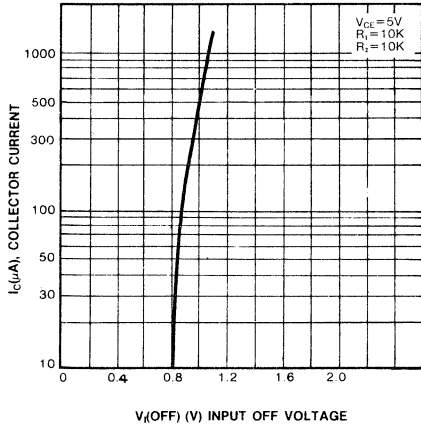
INPUT ON VOLTAGE



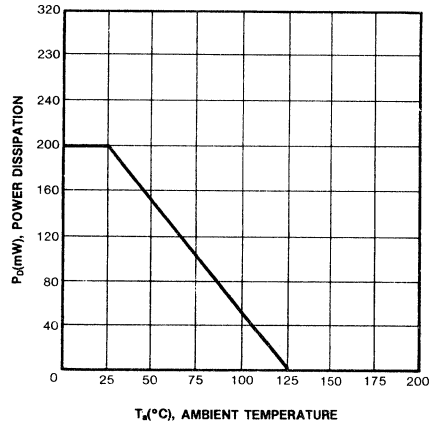
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

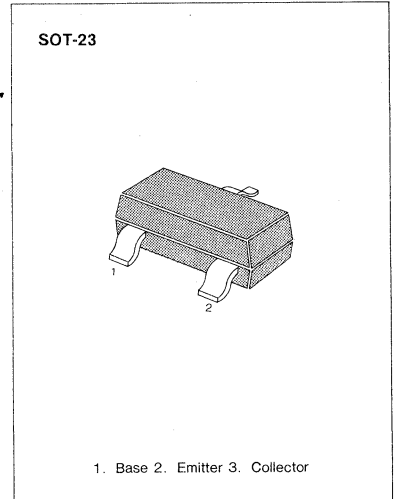


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2103

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

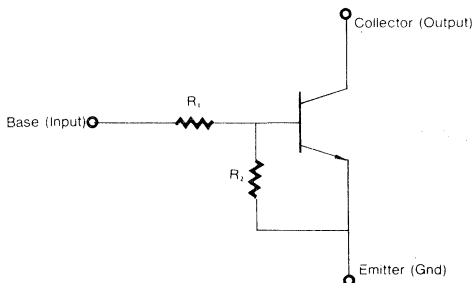
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



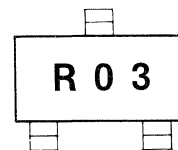
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=5mA$			3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

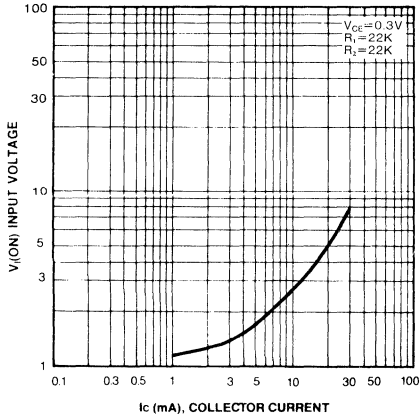
Equivalent Circuit



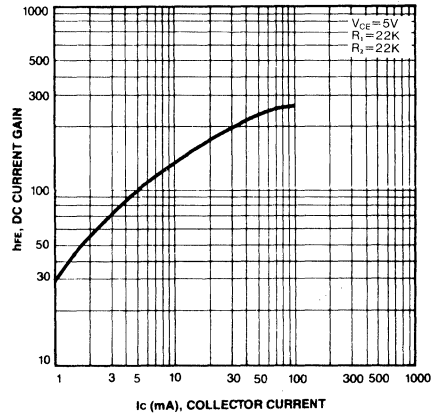
Marking



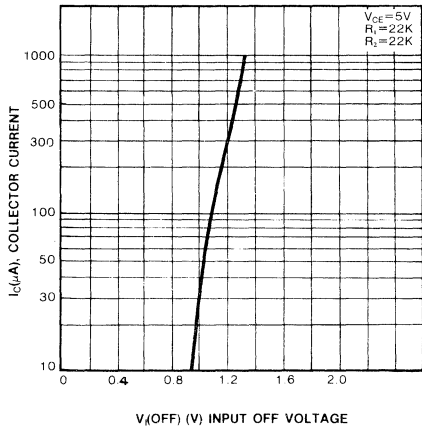
INPUT ON VOLTAGE



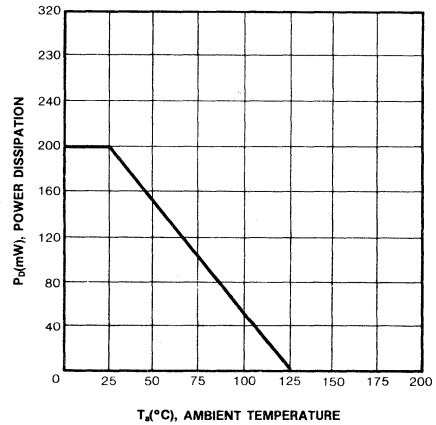
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



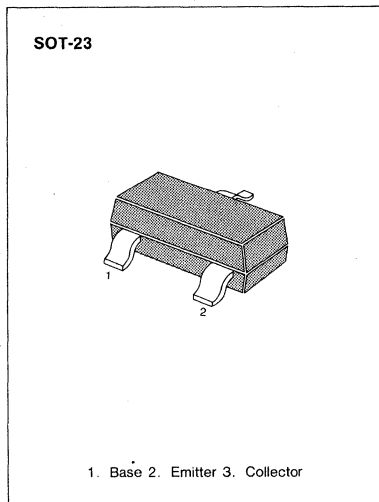
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2104

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

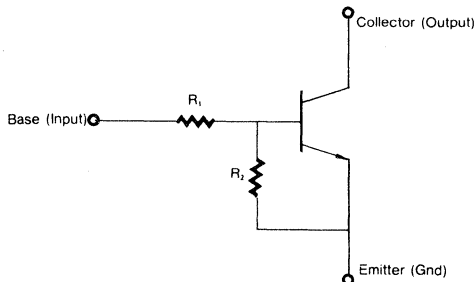
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



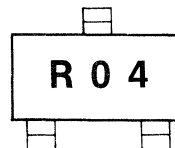
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			3	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

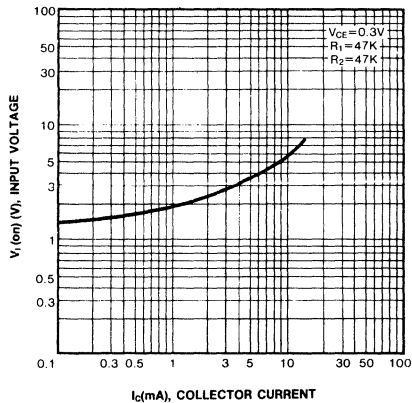
Equivalent Circuit



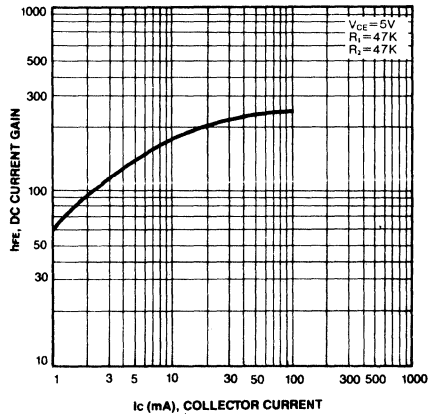
Marking



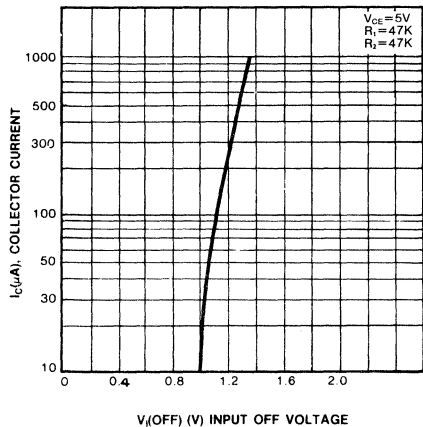
INPUT ON VOLTAGE



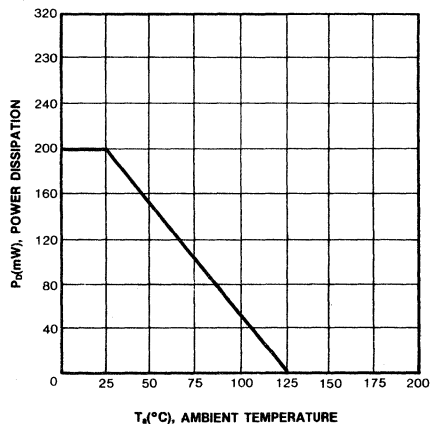
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



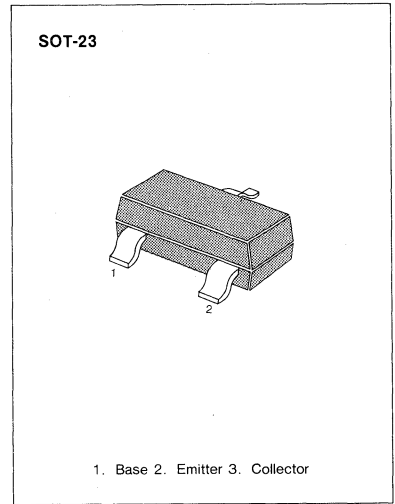
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2105

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

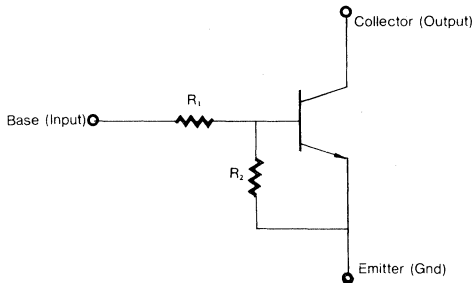
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current (max)	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



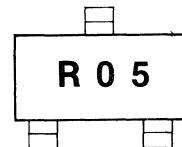
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.3			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=20mA$			2.5	V
Input Resistor	R_1		3.2	4.7	6.2	K Ω
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

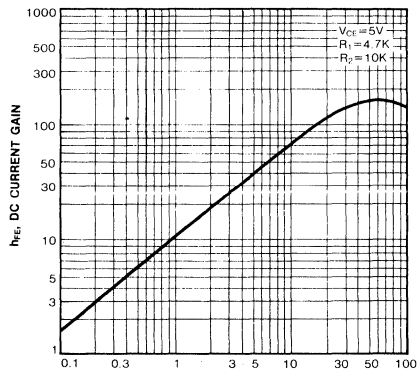
Equivalent Circuit



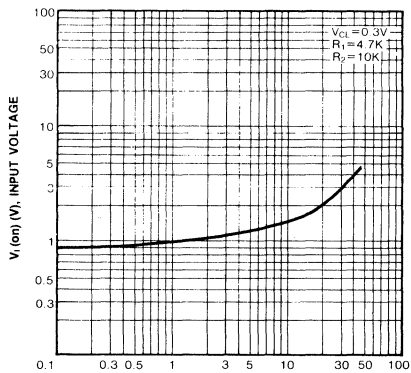
Marking



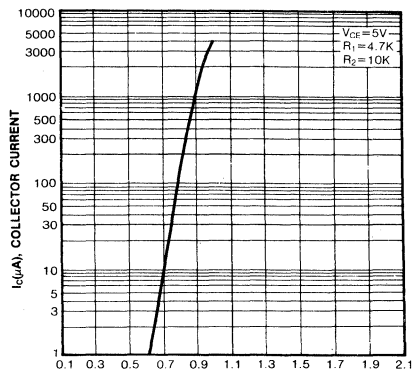
DC CURRENT GAIN



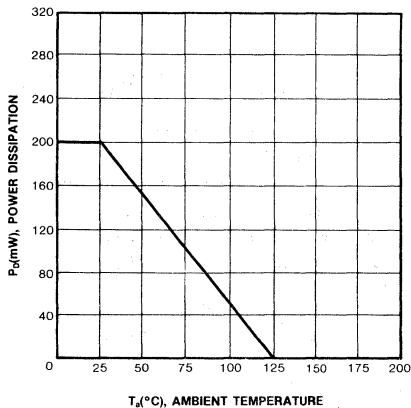
INPUT ON VOLTAGE



INPUT OFF VOLTAGE



POWER DERATING



3

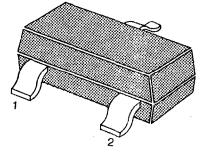
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2106

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23

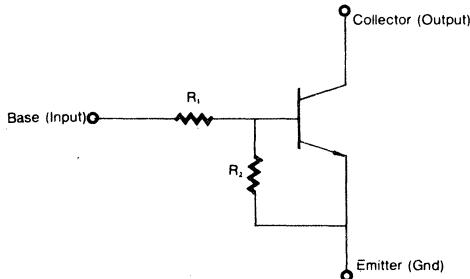


1. Base 2. Emitter 3. Collector

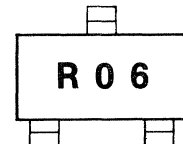
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.3			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=1mA$			1.4	V
Input Resistor	R_1		7	10	13	K Ω
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

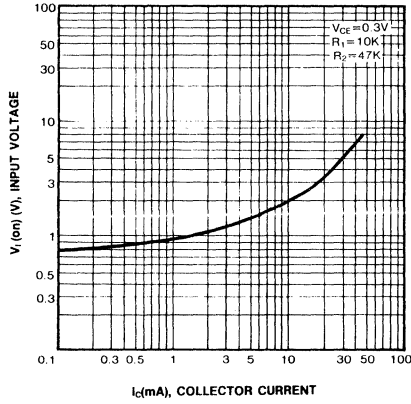
Equivalent Circuit



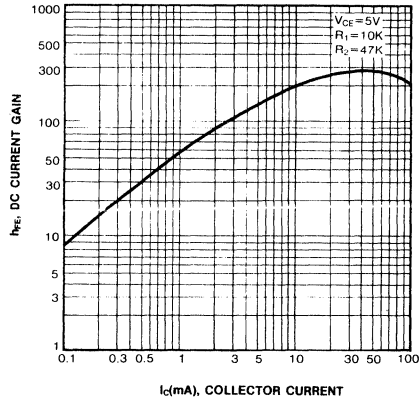
Marking



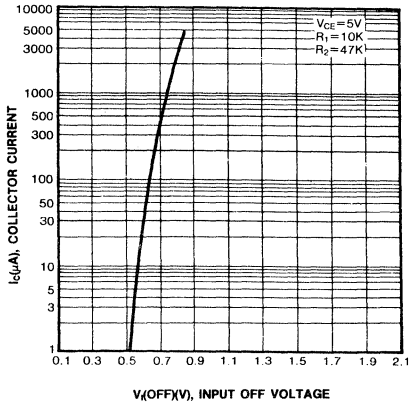
INPUT ON VOLTAGE



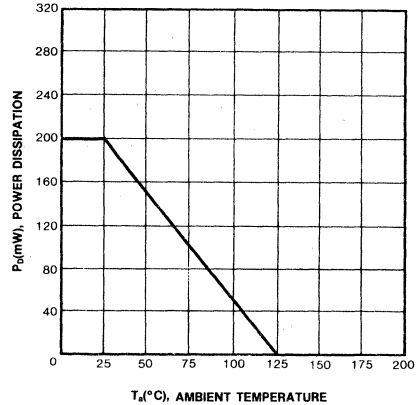
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



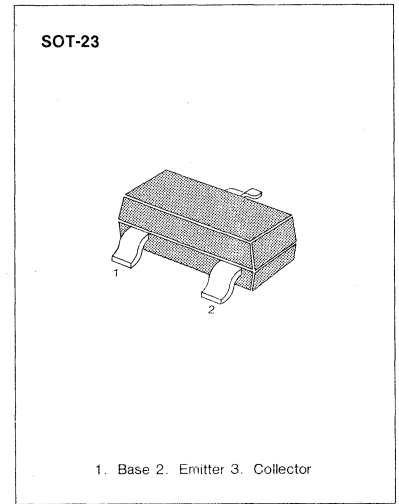
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2107

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

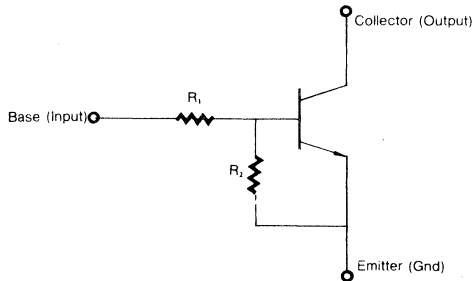
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



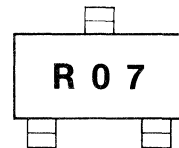
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.4			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			2.5	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

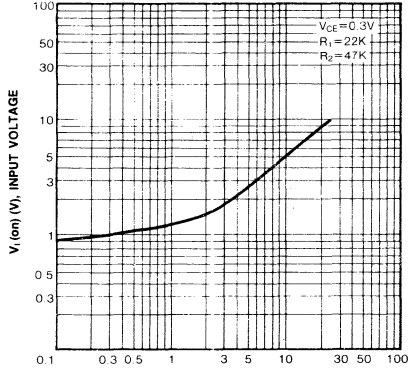
Equivalent Circuit



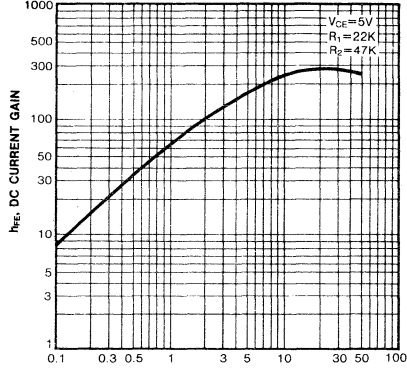
Marking



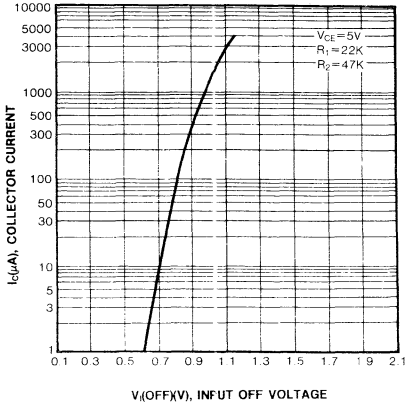
INPUT ON VOLTAGE



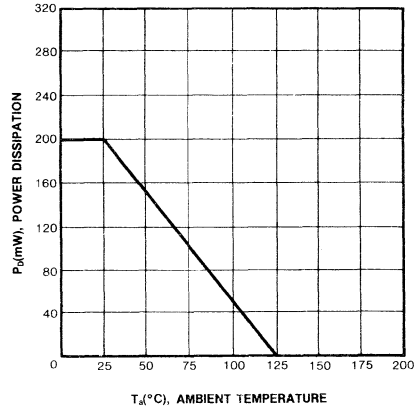
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



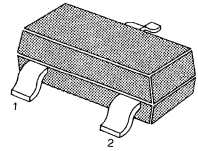
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2108

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23

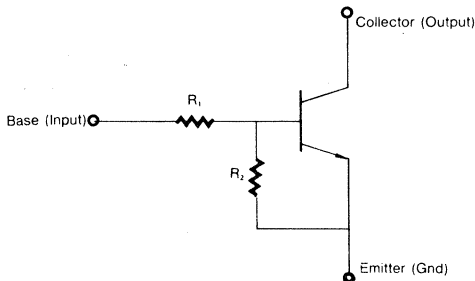


1. Base 2. Emitter 3. Collector

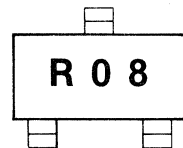
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.8			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			4	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

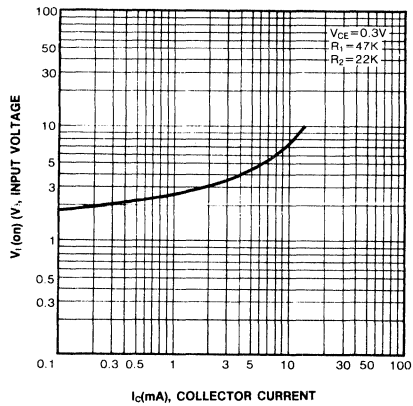
Equivalent Circuit



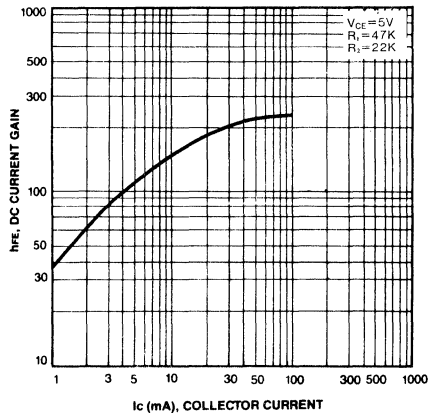
Marking



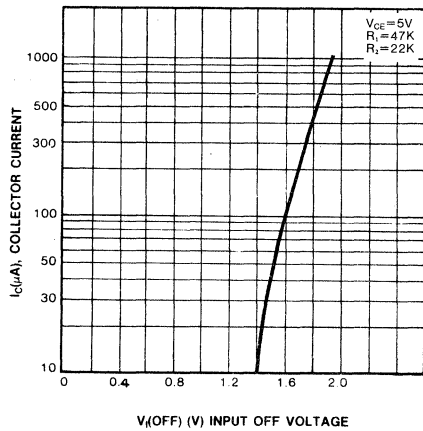
INPUT ON VOLTAGE



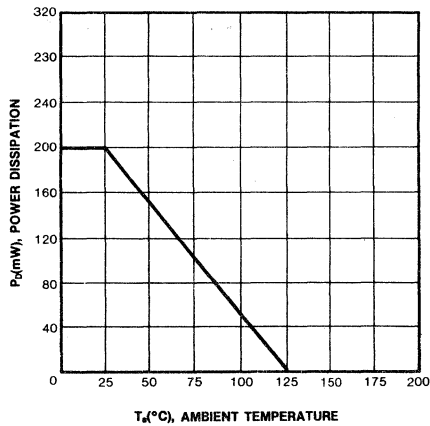
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



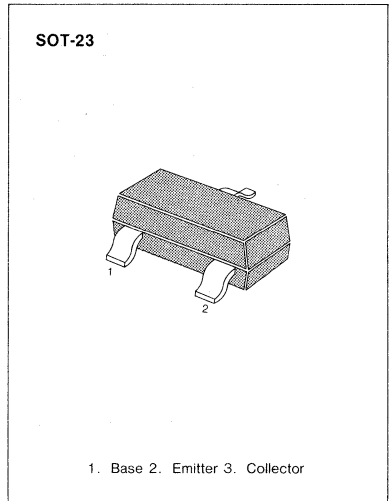
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR2109

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

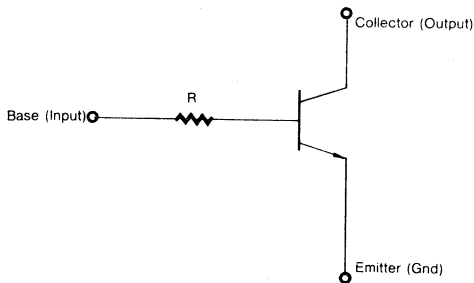
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



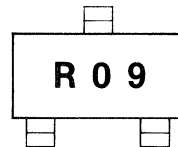
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.70		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		3.2	4.7	6.2	$K\Omega$

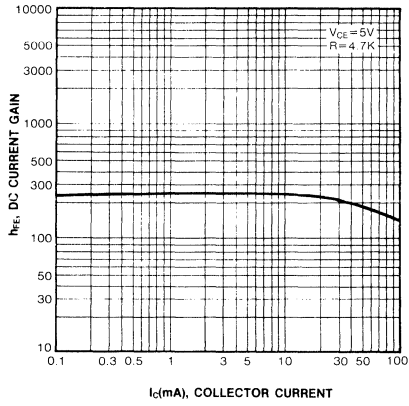
Equivalent Circuit



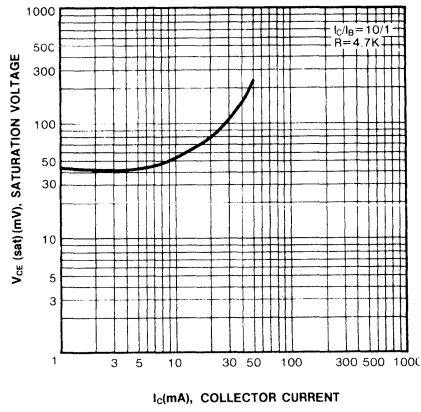
Marking



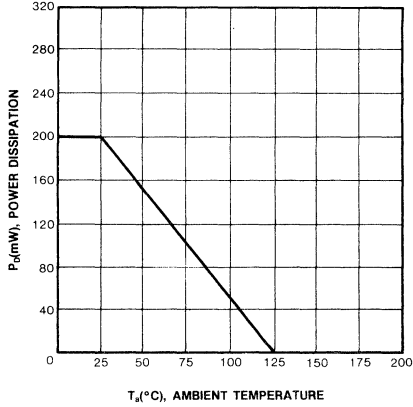
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



3

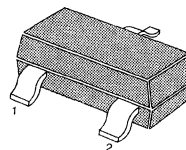
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR2110

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23

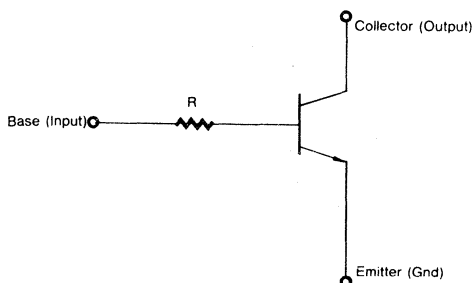


1. Base 2. Emitter 3. Collector

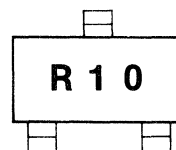
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Resistor	R		7	10	13	$K\Omega$

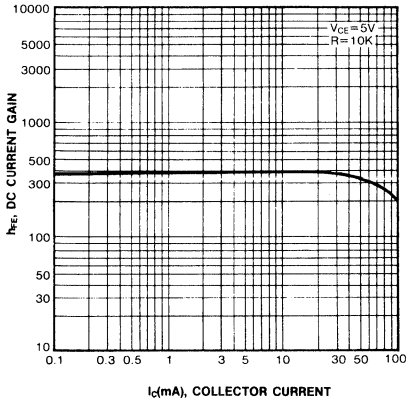
Equivalent Circuit



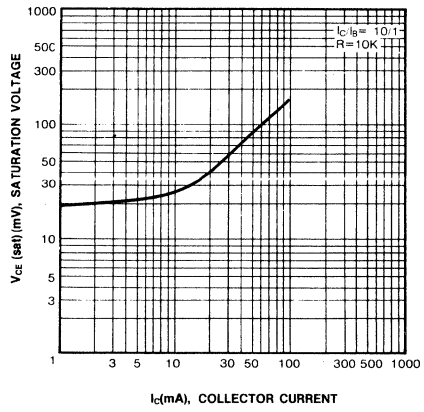
Marking



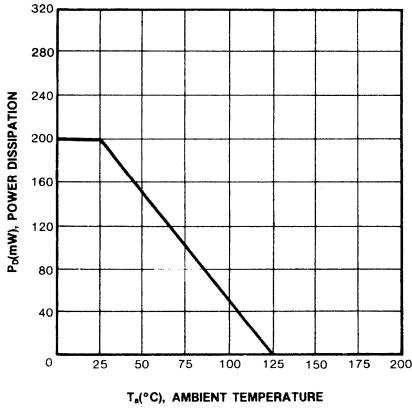
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



3

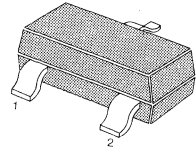
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR2111

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23

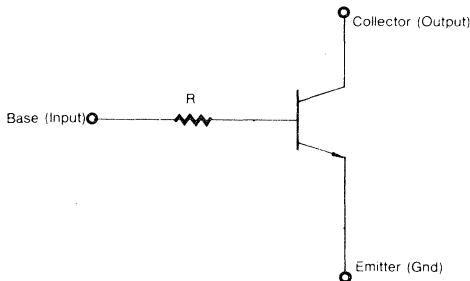


1. Base 2. Emitter 3. Collector

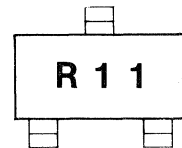
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		15	22	29	K Ω

Equivalent Circuit



Marking

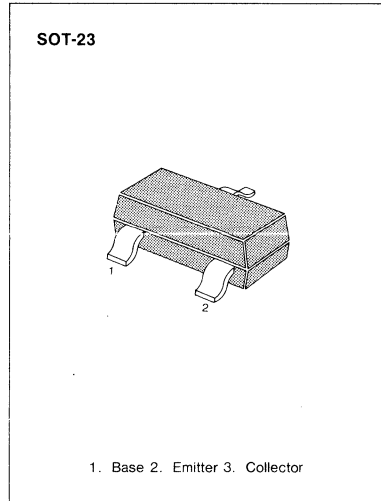


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47K\Omega$)
- Complement to KSR2112

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

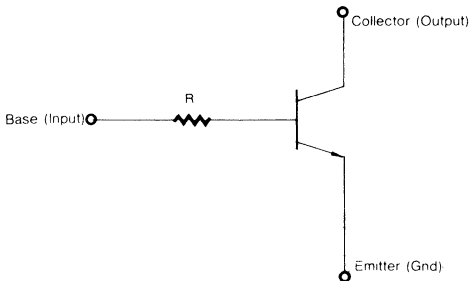


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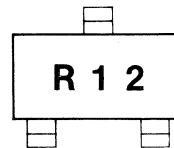
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1mA, I_B = 0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 5mA$		250		MHz
Input Resistor	R		32	47	62	$K\Omega$

Equivalent Circuit



Marking



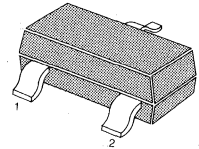
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 2.2K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2113

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23

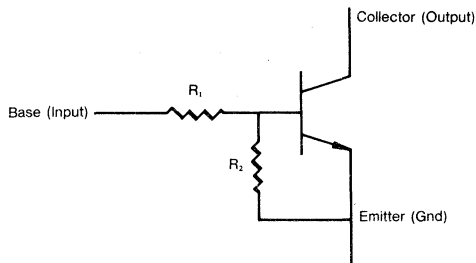


1. Base 2. Emitter 3. Collector

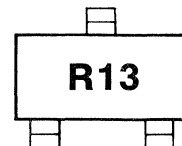
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A$, $I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A$, $I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V$, $I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V$, $I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA$, $I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA$, $I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V$, $I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = 5V$, $I_C = 100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = 0.2V$, $I_C = 5mA$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit



Marking

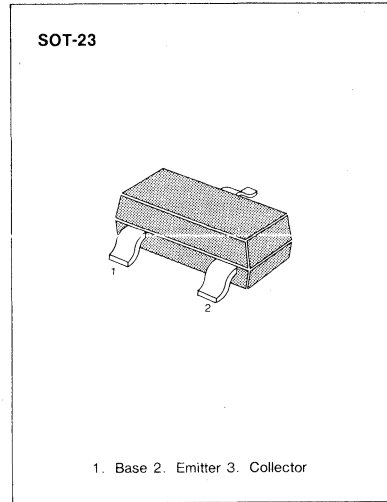


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2114

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

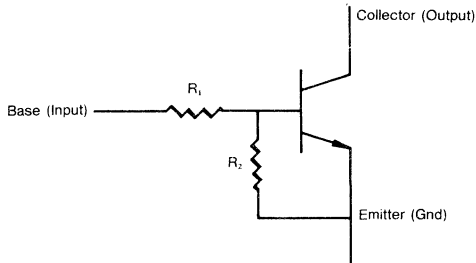


3

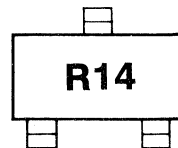
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A, I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA, I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE} = 5V, I_C = 100\mu A$	0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = 0.2V, I_C = 5mA$			1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit



Marking

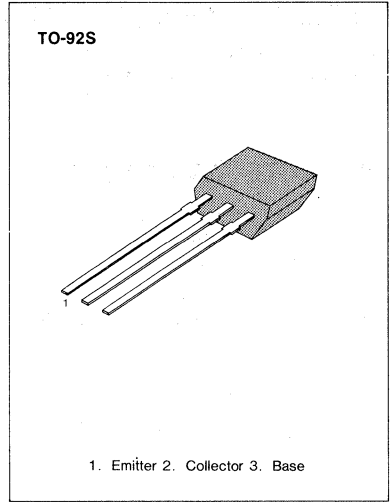


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=4.7K\Omega$)
- Complement to KSR2201

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

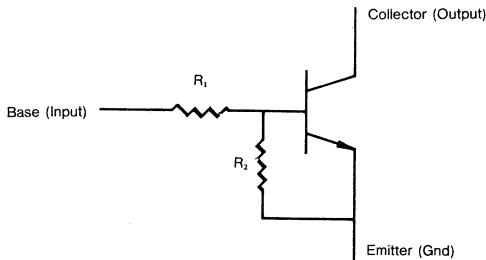
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



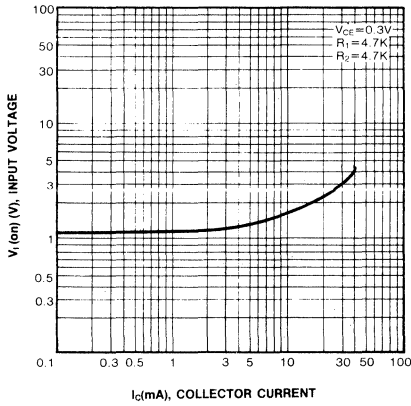
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A$, $I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A$, $I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V$, $I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V$, $I_C = 10mA$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA$, $I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA$, $I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V$, $I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = 5V$, $I_C = 100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = 0.3V$, $I_C = 20mA$			3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

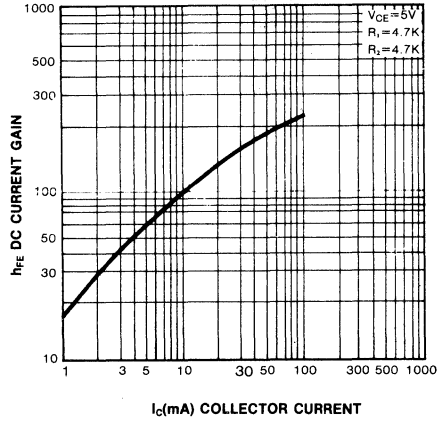
Equivalent Circuit



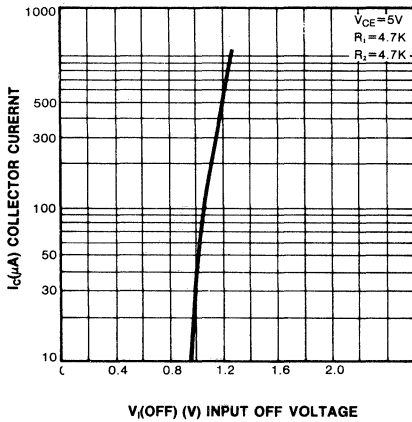
INPUT ON VOLTAGE



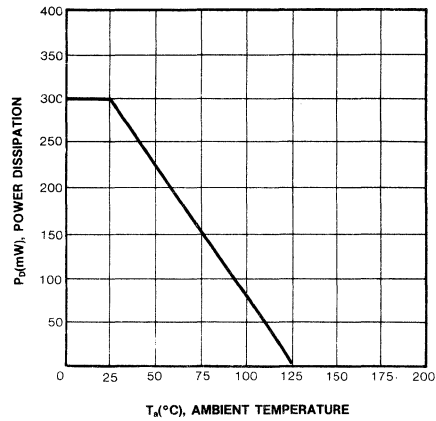
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

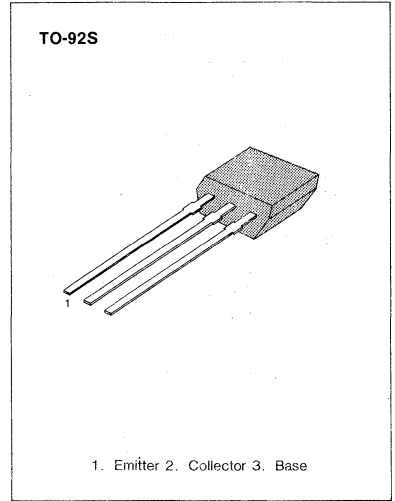


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2202

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

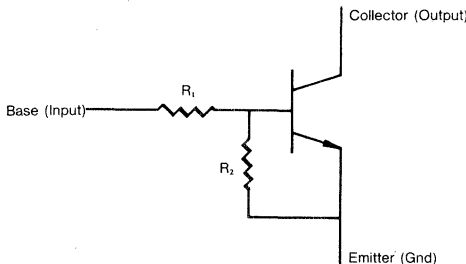
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



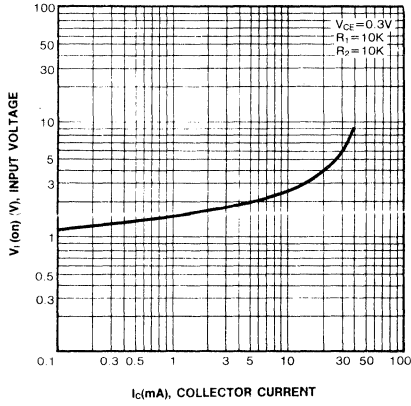
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	Cob	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=10mA$			3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

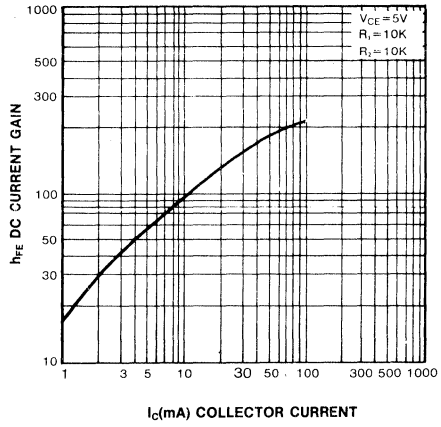
Equivalent Circuit



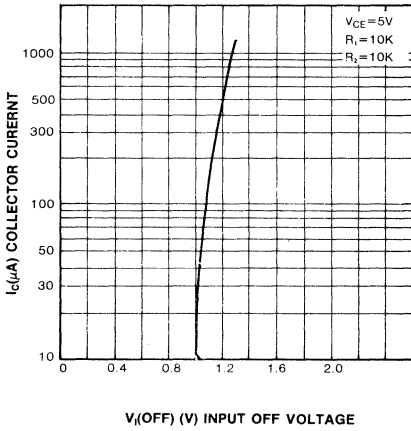
INPUT ON VOLTAGE



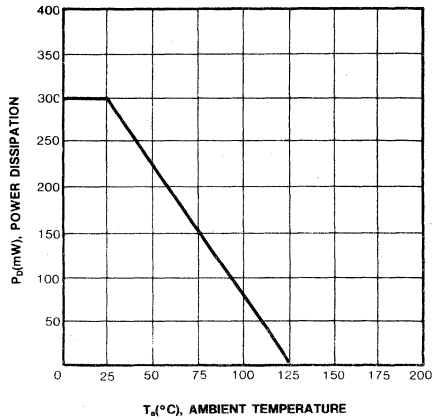
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



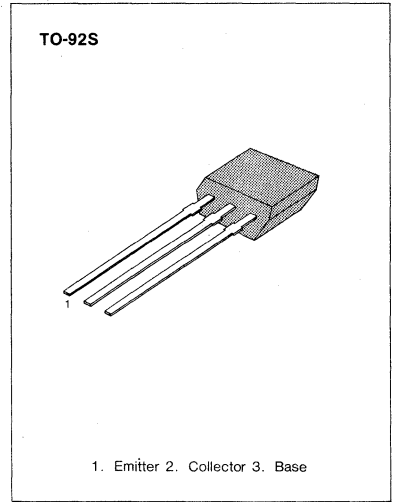
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2203

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

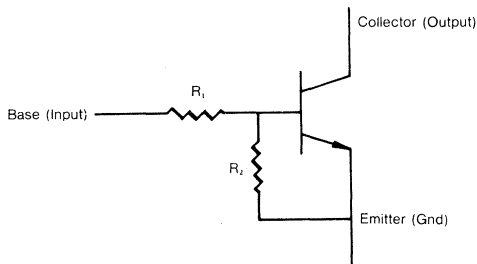
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



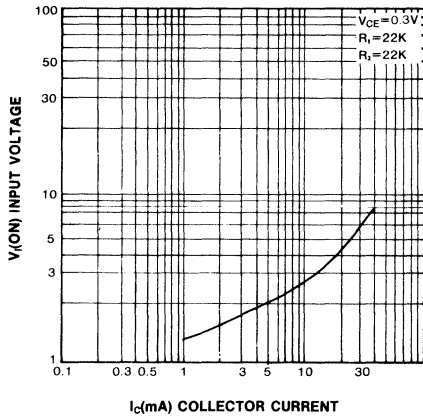
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=5mA$			3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

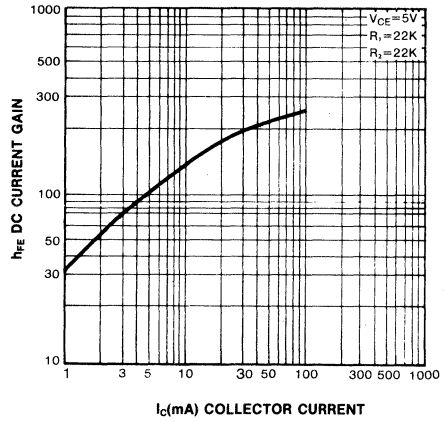
Equivalent Circuit



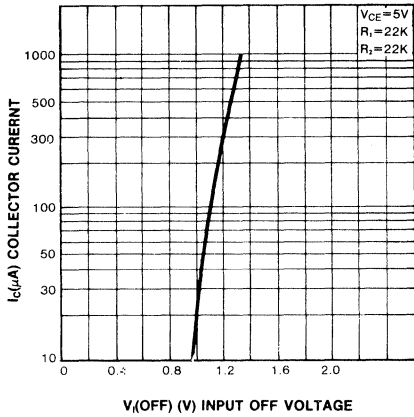
INPUT ON VOLTAGE



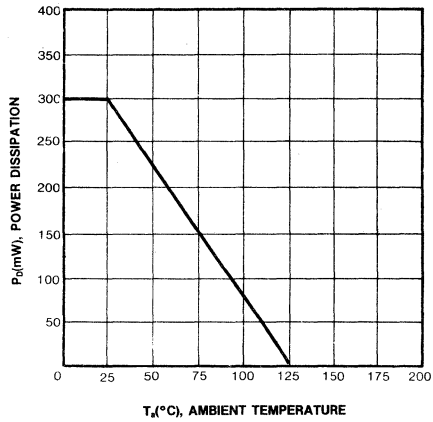
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



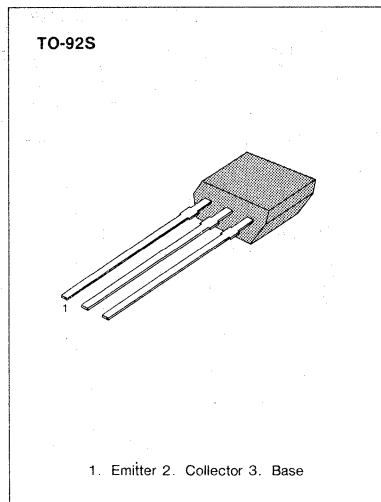
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2204

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

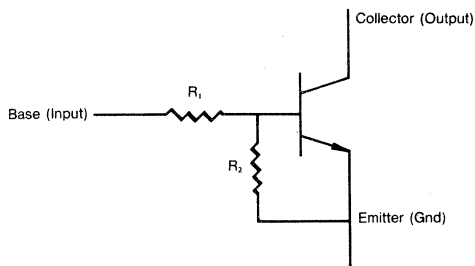
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



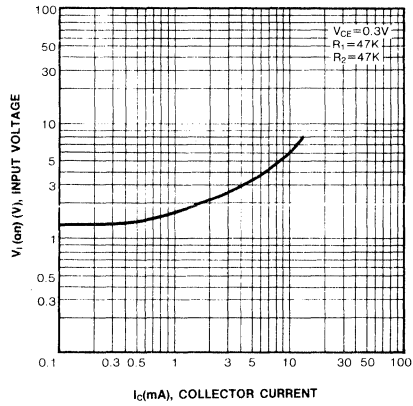
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	Cob	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			3	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

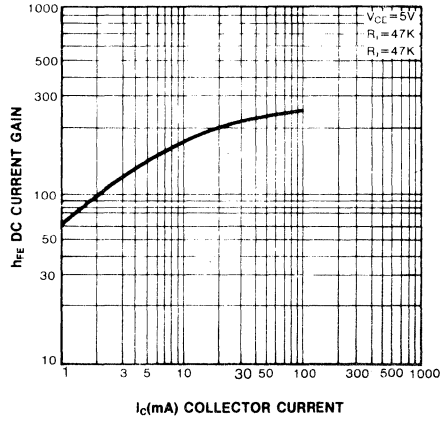
Equivalent Circuit



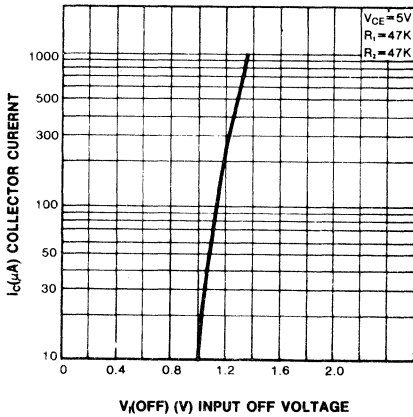
INPUT ON VOLTAGE



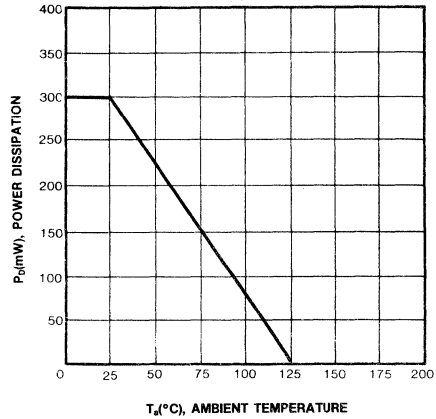
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



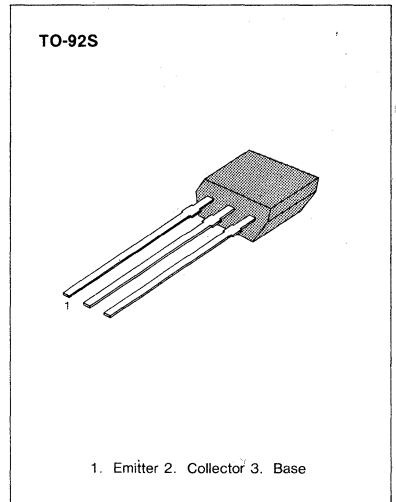
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2205

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

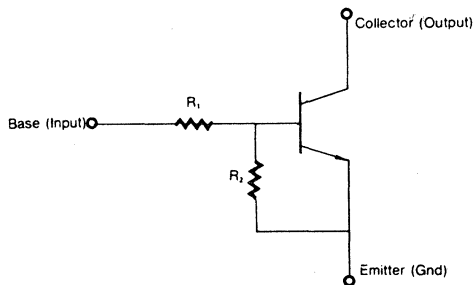
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



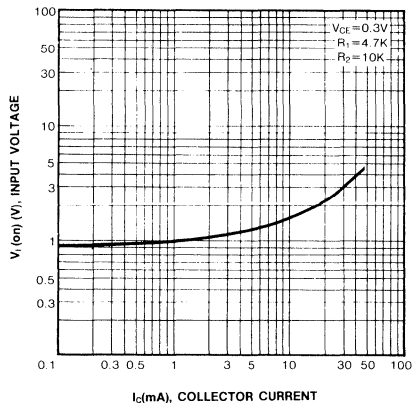
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.3			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=20mA$			2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

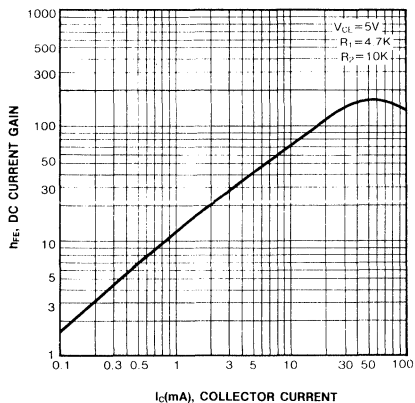
Equivalent Circuit



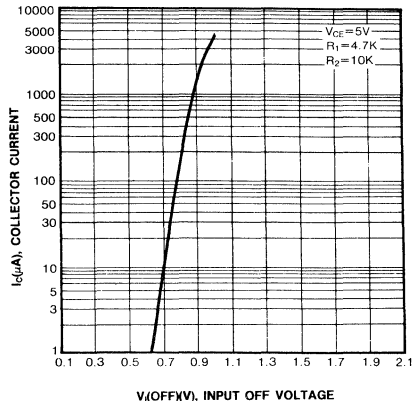
INPUT ON VOLTAGE



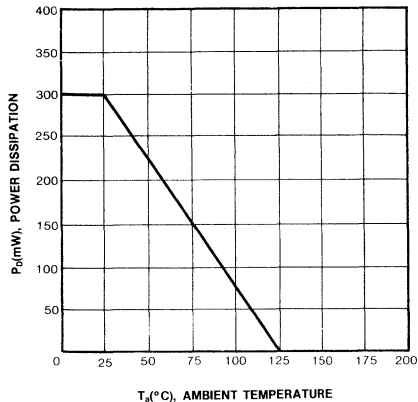
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



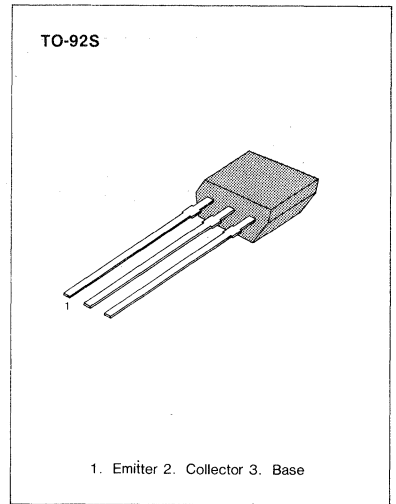
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2206

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

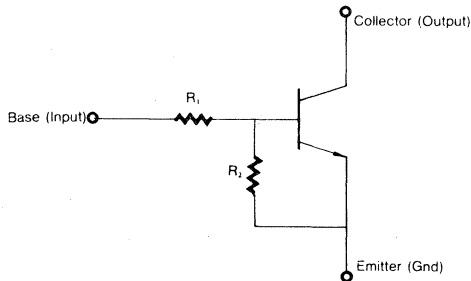
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



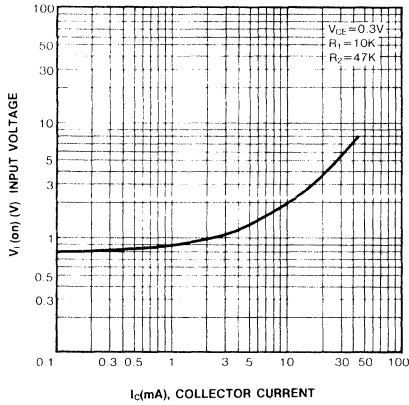
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_C=5\text{mA}$		250		MHz
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.3			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}$, $I_C=1\text{mA}$			1.4	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

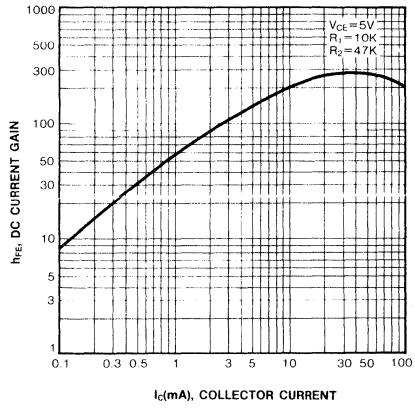
Equivalent Circuit



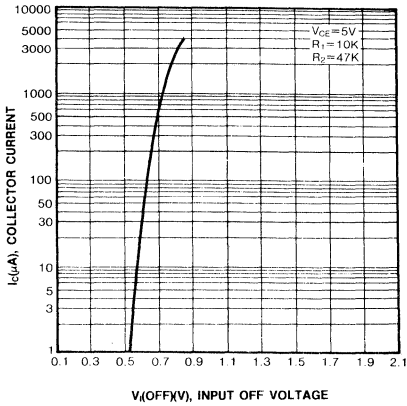
INPUT ON VOLTAGE



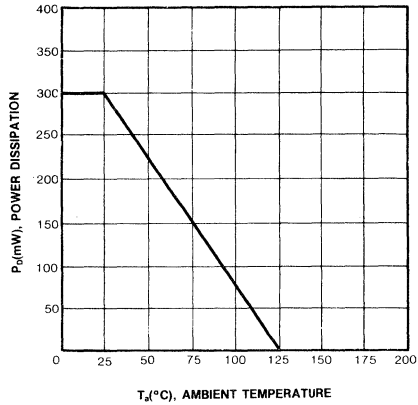
DC CURRENT GAIN



INPUT OFF VOLTAGE



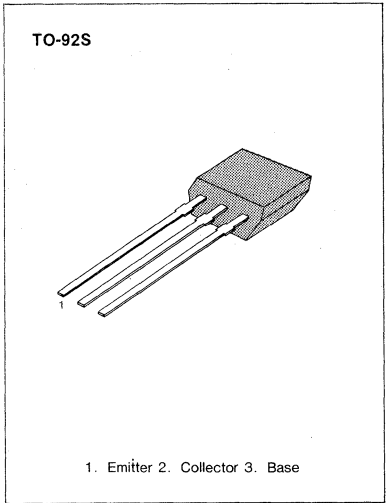
POWER DERATING



3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=47K\Omega$)
- Complement to KSR2207



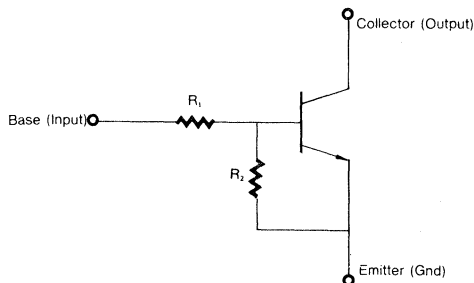
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

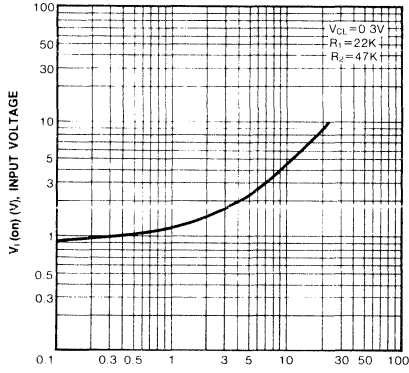
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$		250		MHz
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.4			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}$, $I_C=2\text{mA}$			2.5	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit

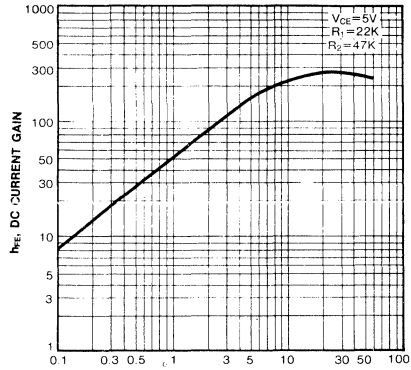


INPUT ON VOLTAGE



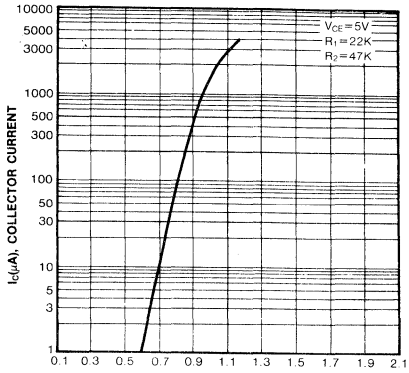
I_c (mA), COLLECTOR CURRENT

DC CURRENT GAIN



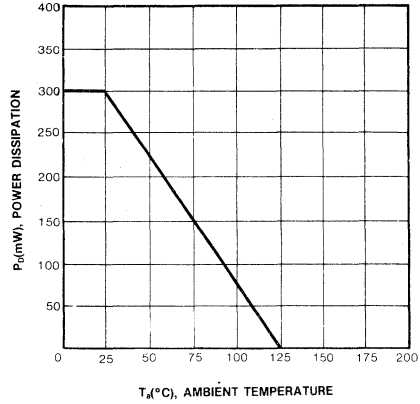
I_c (mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE



$V(OFF)$ (V), INPUT OFF VOLTAGE

POWER DERATING



T_a (°C), AMBIENT TEMPERATURE

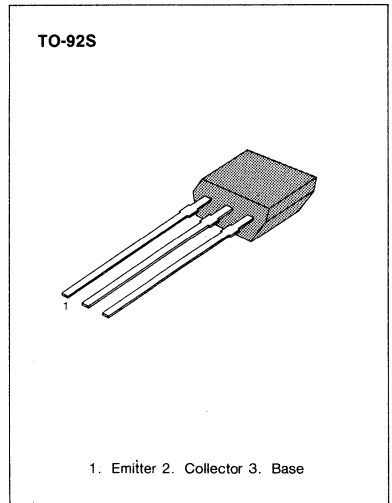
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR2208

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

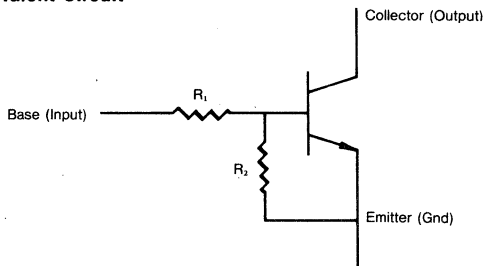
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



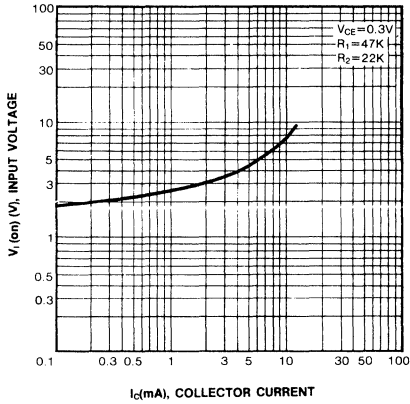
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA, I_C=10V$		250		MHz
Output Capacitance	Cob	$V_{CB}=10V, I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=5V, I_C=100\mu A$	0.8			V
Input On Voltage	$V_i(on)$	$V_{CE}=0.3V, I_C=2mA$			4	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

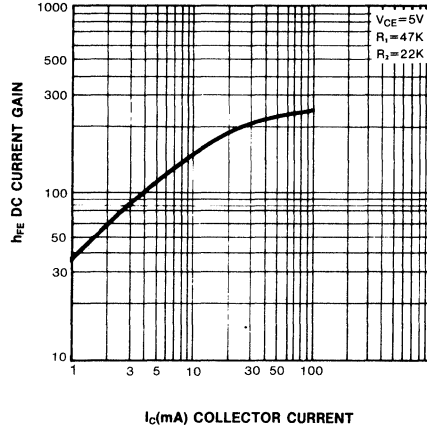
Equivalent Circuit



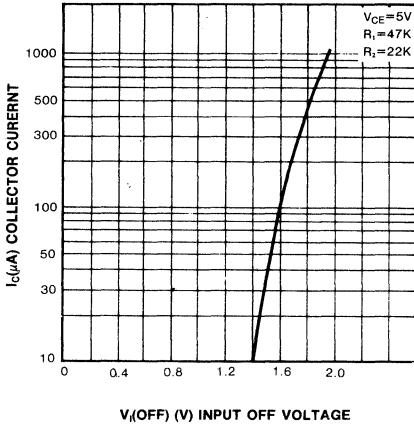
INPUT ON VOLTAGE



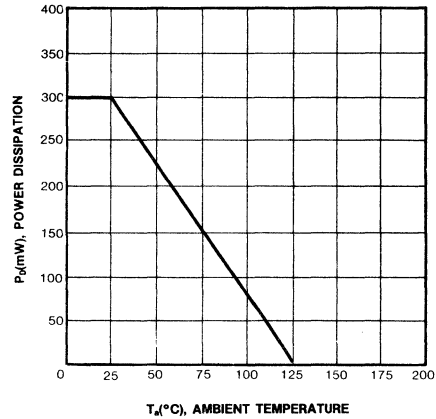
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



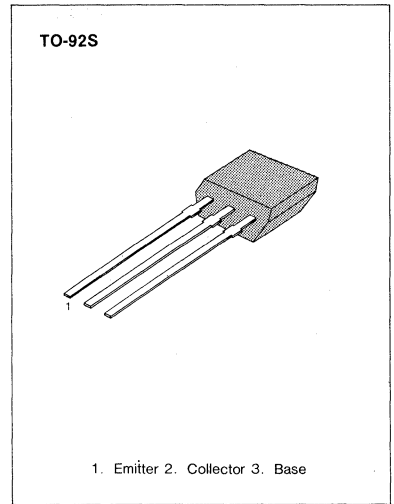
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR2209

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

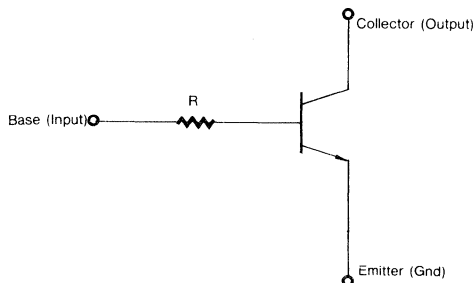
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



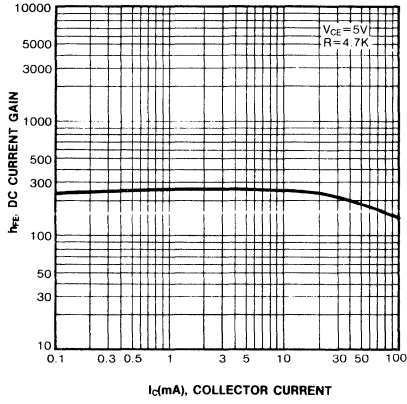
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1 mA, I_B = 0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 1 mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10 mA, I_B = 1 mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1 MHz$		3.70		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 5 mA$		250		MHz
Input Resistor	R		3.2	4.7	6.2	$K\Omega$

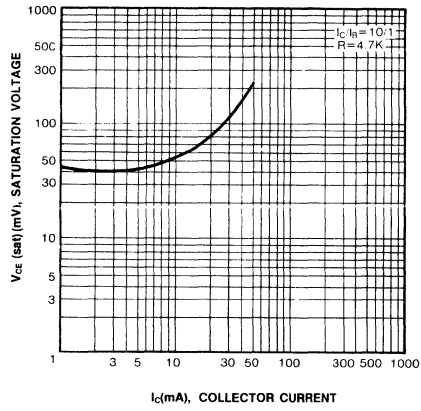
Equivalent Circuit



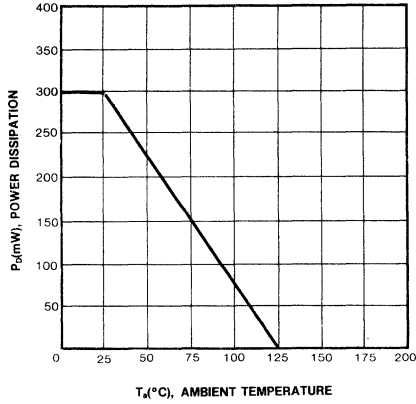
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



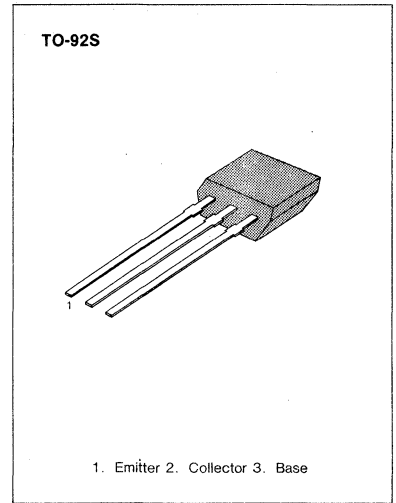
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR2210

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

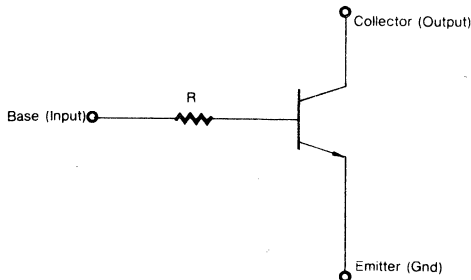
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



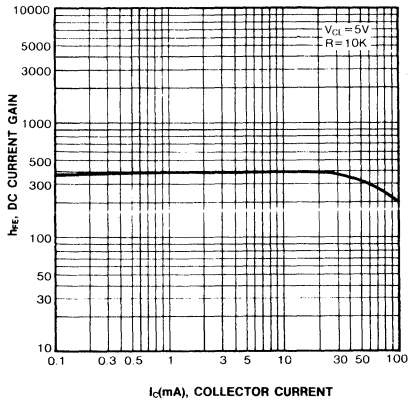
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Resistor	R		7	10	13	$K\Omega$

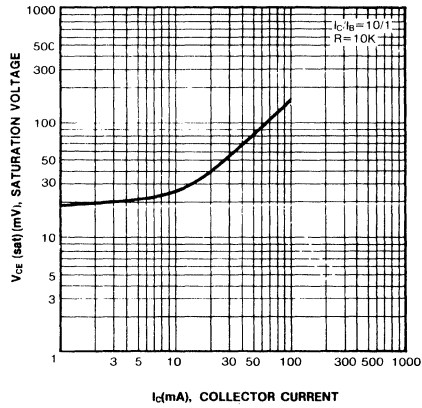
Equivalent Circuit



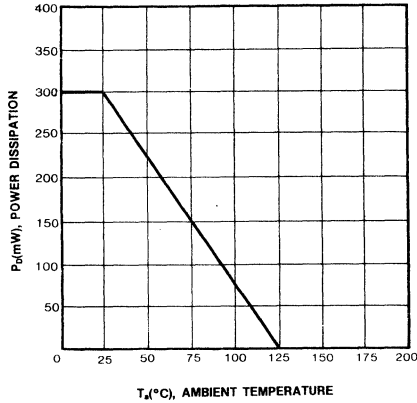
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



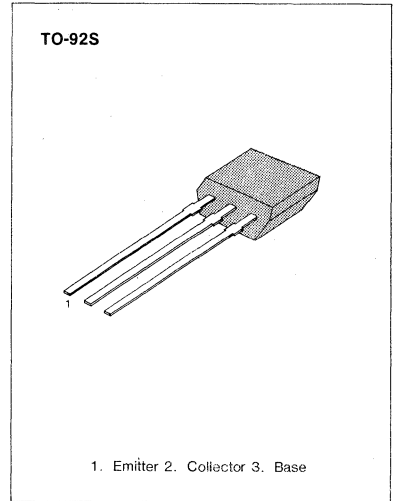
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR2211

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

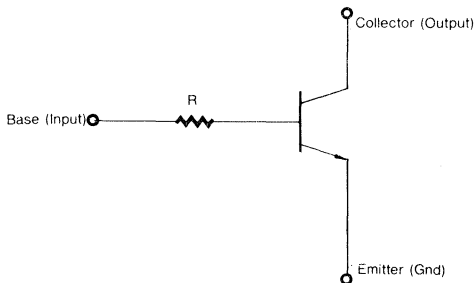
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Resistor	R		15	22	29	$K\Omega$

Equivalent Circuit

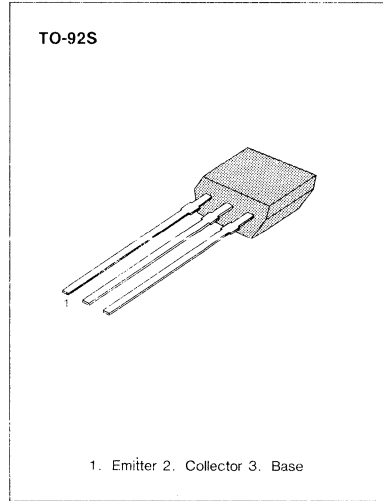


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47K\Omega$)
- Complement to KSR2212

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

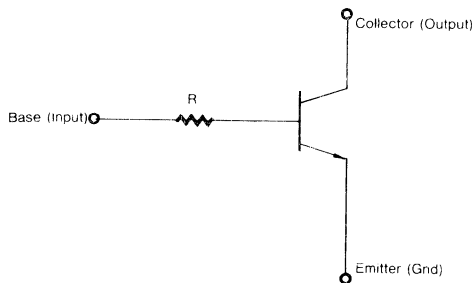


3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$		250		MHz
Input Resistor	R		32	47	62	K Ω

Equivalent Circuit

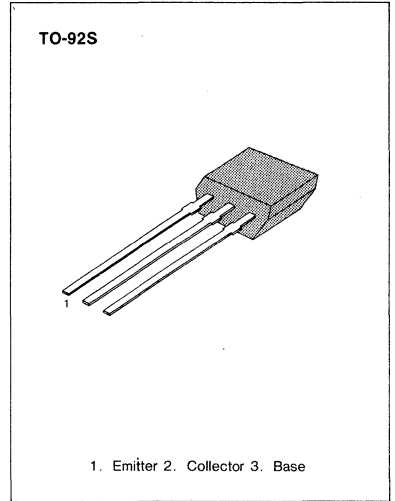


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1 = 2.2K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2213

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

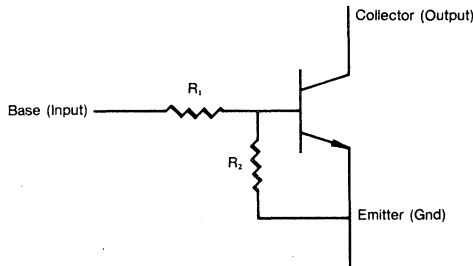
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A, I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
DC Current Gain	β_{FE}	$V_{CE} = 5V, I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA, I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = 5V, I_C = 100\mu A$	0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = 0.2V, I_C = 5mA$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit

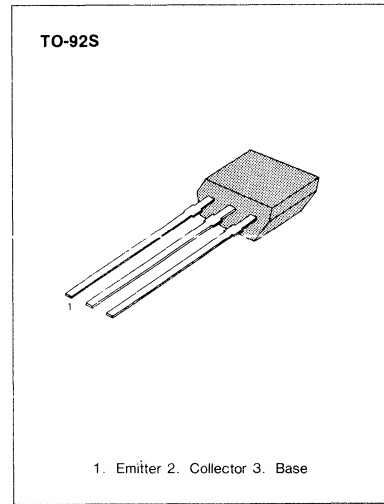


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2214

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

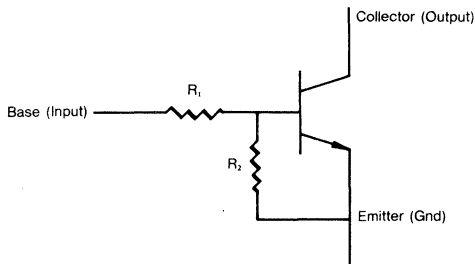


3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A, I_B = 0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA, I_C = 10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1.0MHz$		3.7		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE} = 5V, I_C = 100\mu A$	0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = 0.2V, I_C = 5mA$			1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit

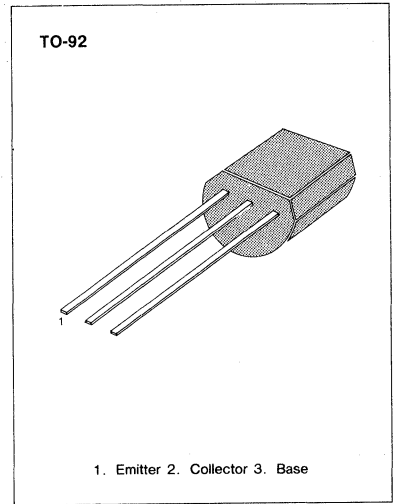


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=4.7K\Omega$)
- Complement to KSR1001

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

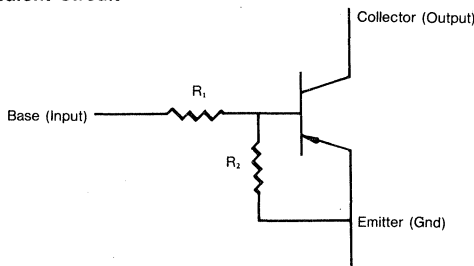
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



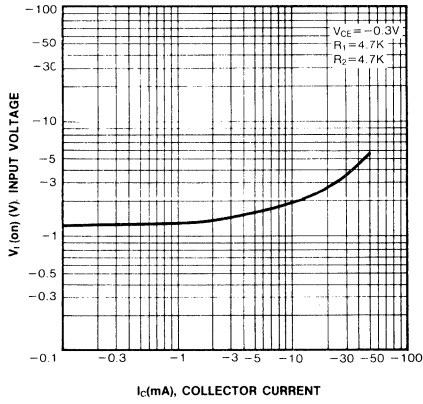
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -10mA$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -20mA$			-3	V
Input Resistor	R_1		3.2	4.7	6.2	K Ω
Resistor Ratio	R_1/R_2		0.9	1	1.1	

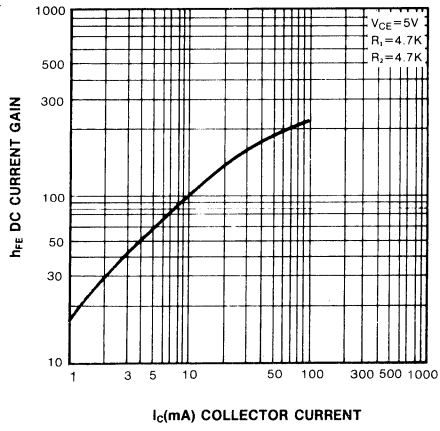
Equivalent Circuit



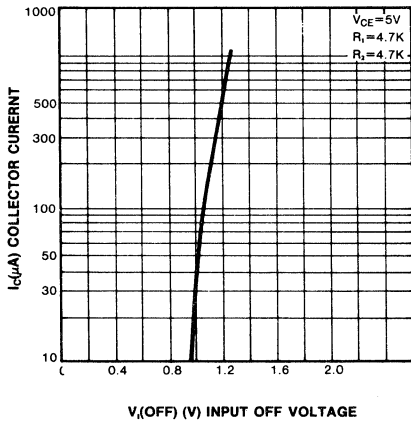
INPUT ON VOLTAGE



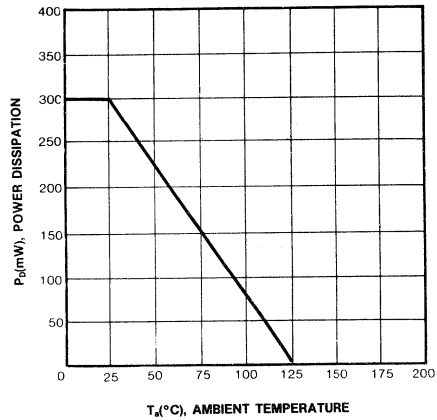
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



3

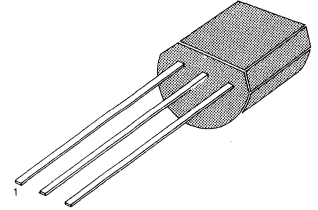
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR1002

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

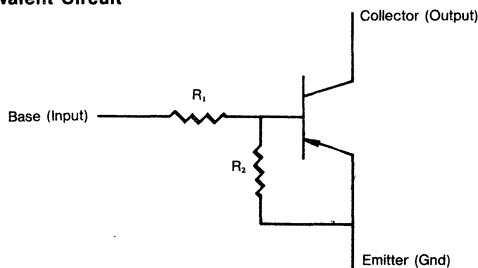
TO-92



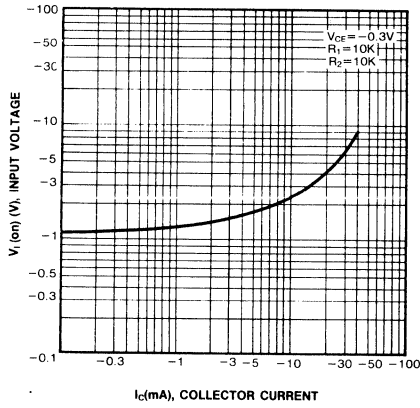
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

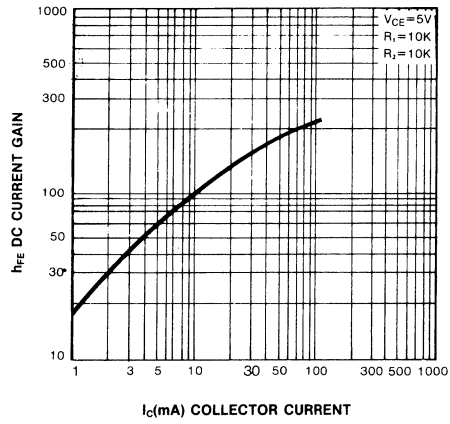
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}$, $I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}$, $I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40\text{V}$, $I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}$, $I_B = -0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}$, $I_C = -10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE} = -5\text{V}$, $I_C = -100\mu\text{A}$	-0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE} = -0.3\text{V}$, $I_C = -10\text{mA}$			-3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

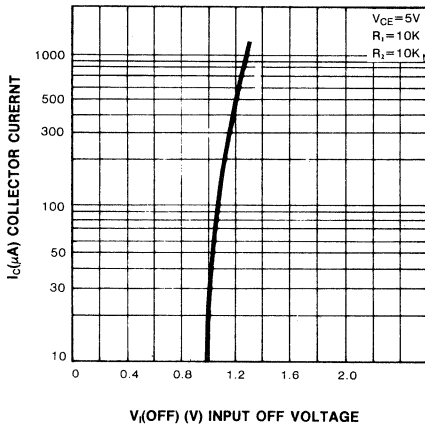
INPUT ON VOLTAGE



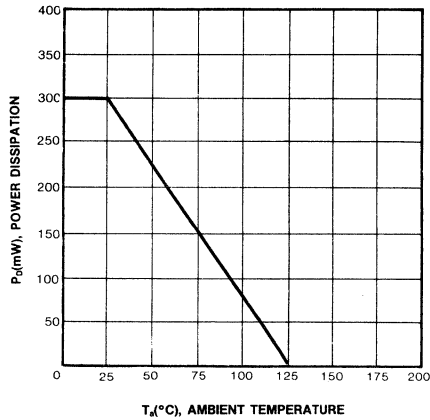
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



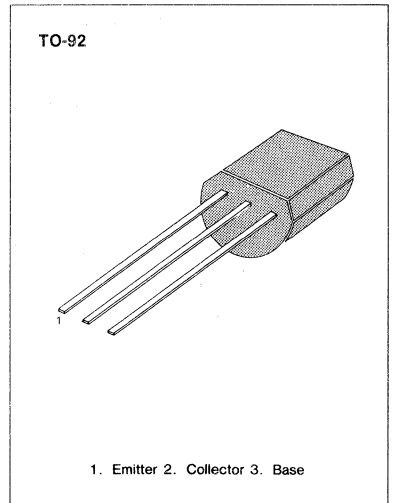
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1=22K\Omega$, $R_2=22K\Omega$)
- Complement to KSR1003

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

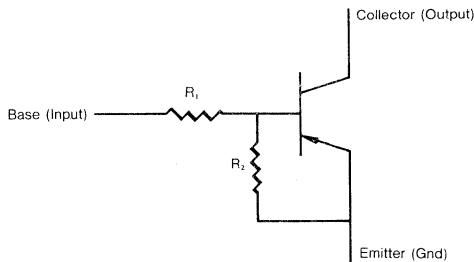
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



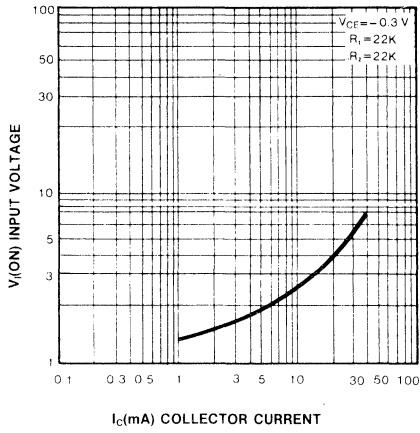
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	η_{FE}	$V_{CE} = -5V, I_C = -5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -5mA$			-3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

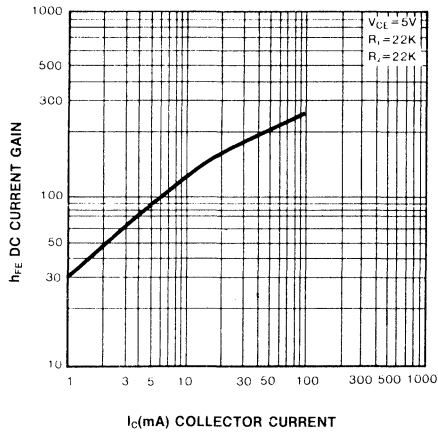
Equivalent Circuit



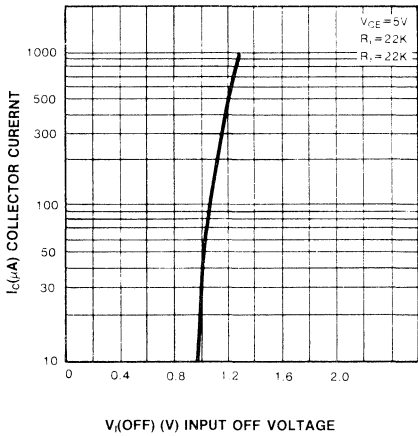
INPUT ON VOLTAGE



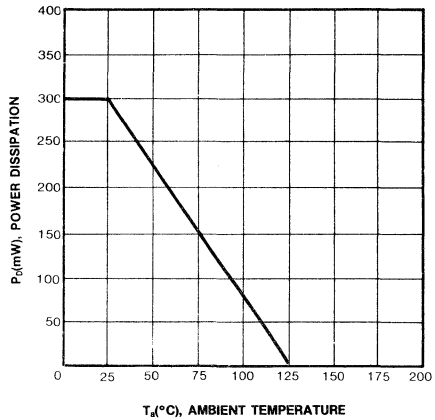
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

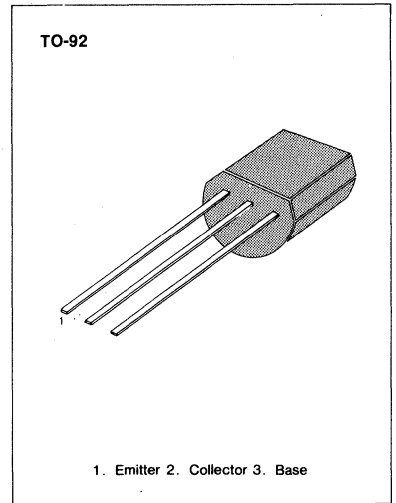


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1004

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

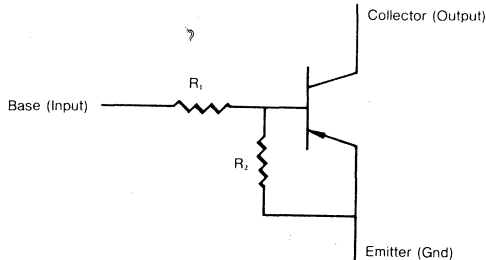
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



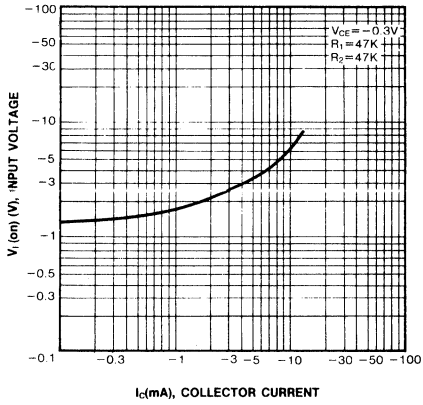
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -2mA$			-3	V
Input Resistor	R_1		32	47	62	K Ω
Resistor Ratio	R_1/R_2		0.9	1	1.1	

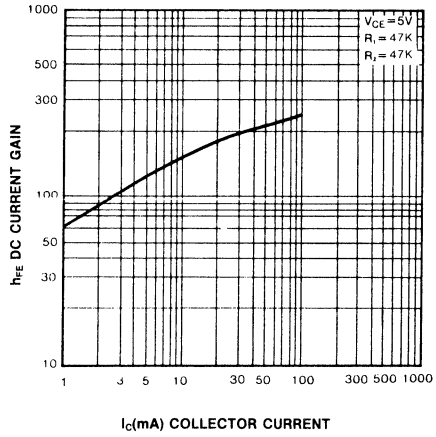
Equivalent Circuit



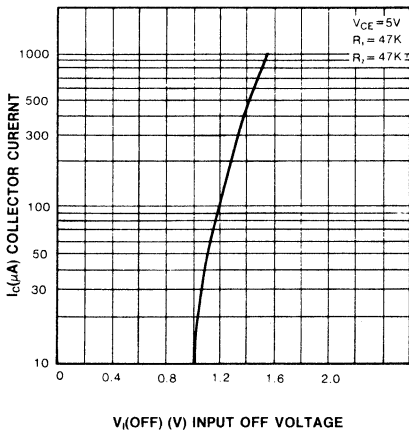
INPUT ON VOLTAGE



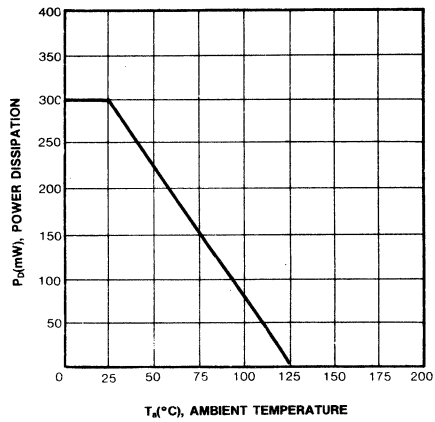
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

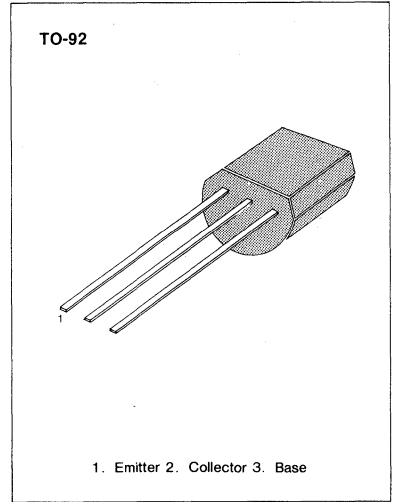


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR1005

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

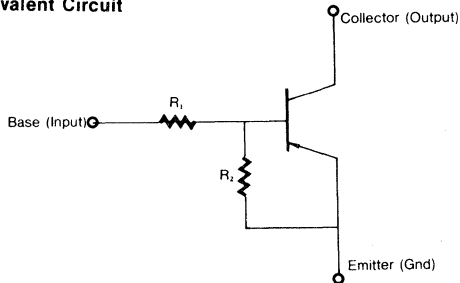
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



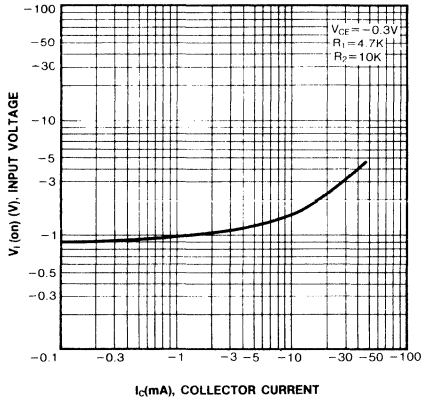
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-20mA$			-2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

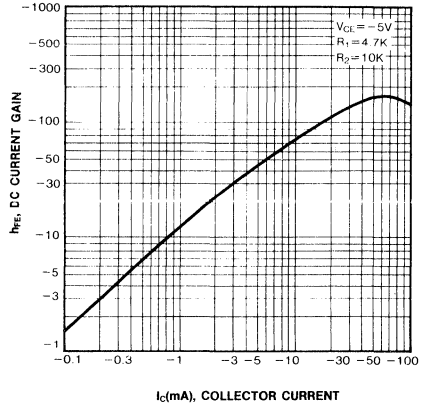
Equivalent Circuit



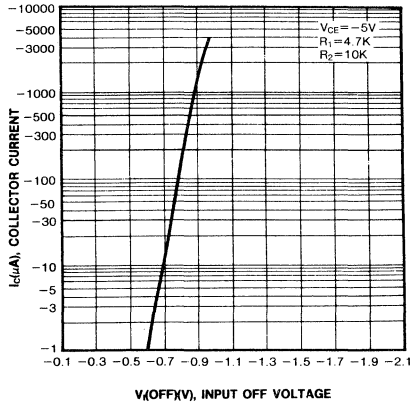
INPUT ON VOLTAGE



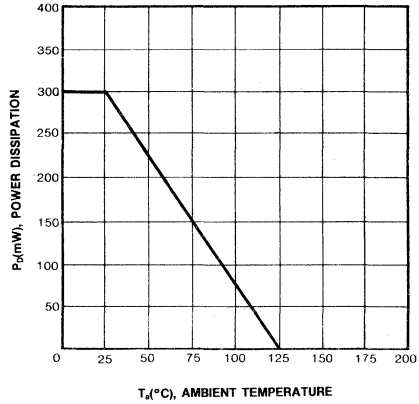
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



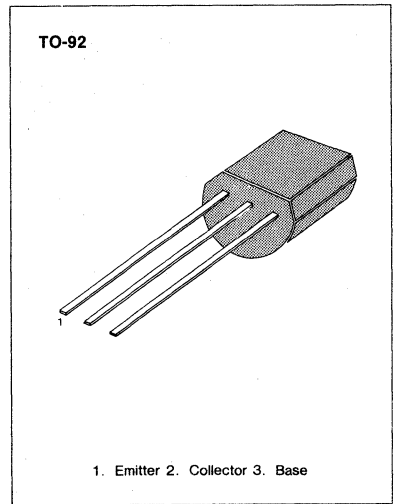
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1006

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

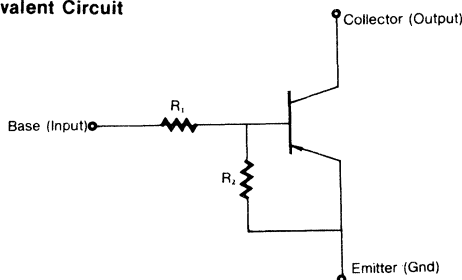
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



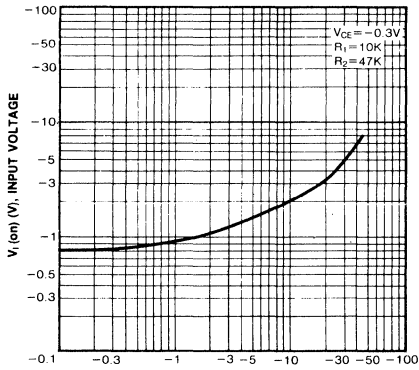
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_c = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c = -10mA, I_B = -0.5mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_c = -5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_c = -100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_c = -1mA$			-1.4	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

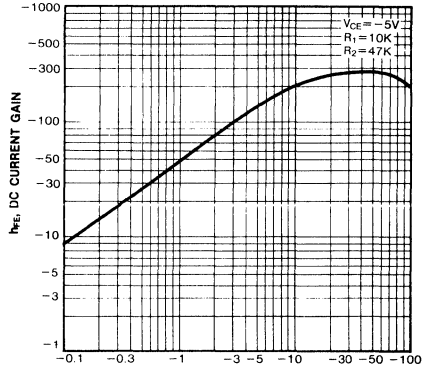
Equivalent Circuit



INPUT ON VOLTAGE



DC CURRENT GAIN

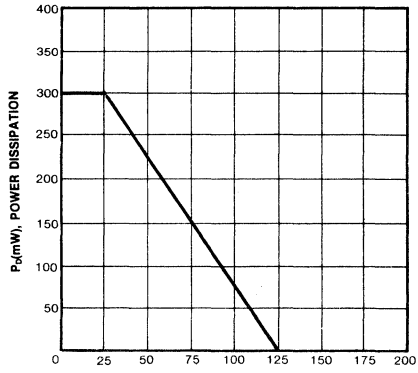
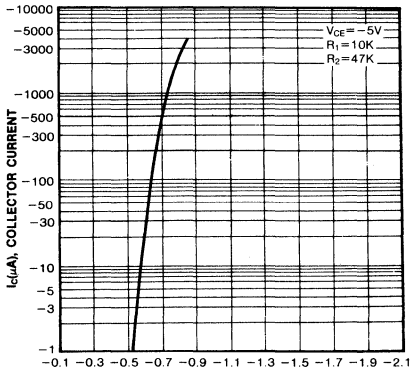


I_c (mA), COLLECTOR CURRENT

I_c (mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE

POWER DERATING



$V_i(\text{off})$ (V), INPUT OFF VOLTAGE

T_d ($^{\circ}C$), AMBIENT TEMPERATURE

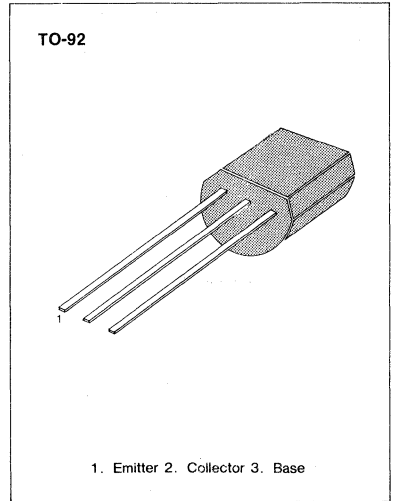
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$ $R_2=47K\Omega$)
- Complement to KSR1007

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

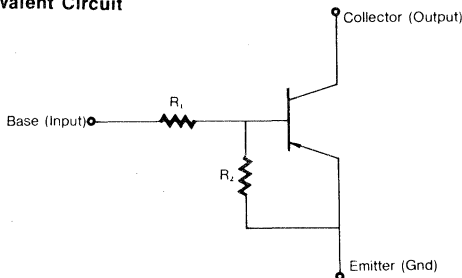
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



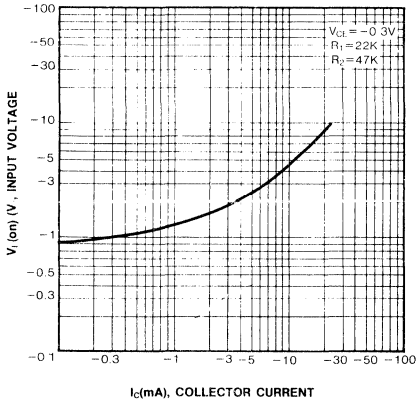
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.4			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-2mA$			-2.5	V
Input Resistor	R_1		15	22	29	K Ω
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

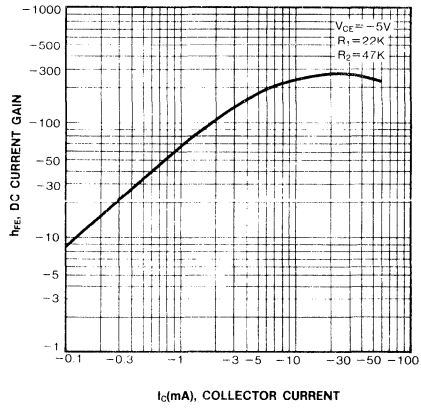
Equivalent Circuit



INPUT ON VOLTAGE



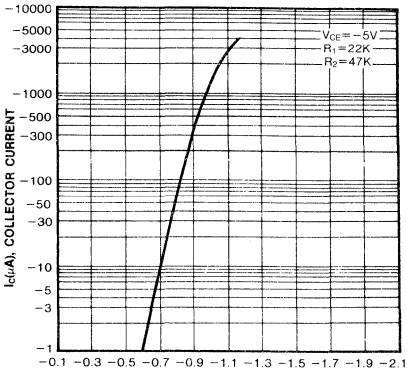
DC CURRENT GAIN



I_c (mA), COLLECTOR CURRENT

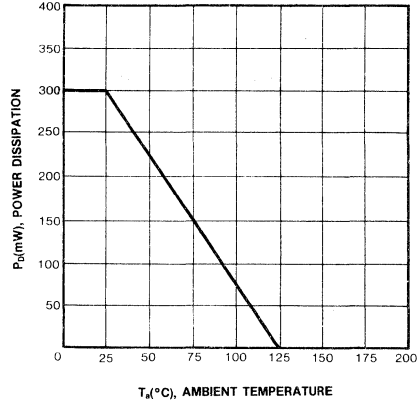
I_c (mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE



$V_{i(off)}$ (V), INPUT OFF VOLTAGE

POWER DERATING



T_a (°C), AMBIENT TEMPERATURE

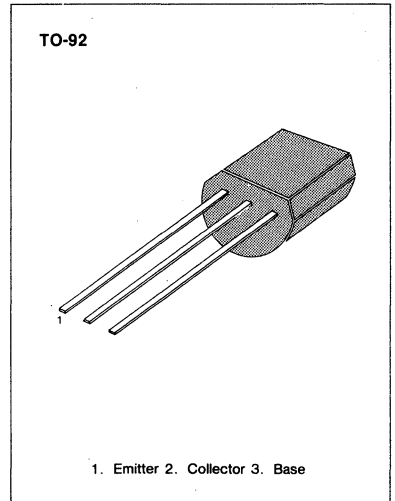
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR1008

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

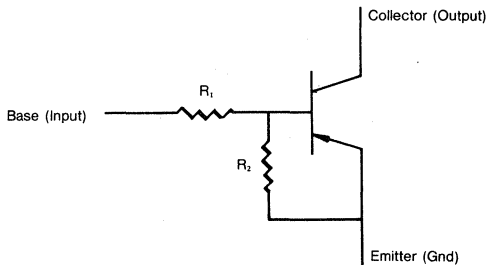
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



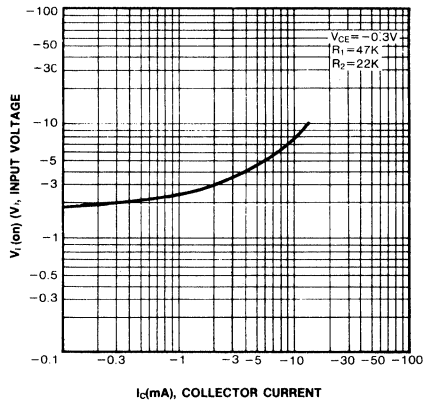
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.8			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -2mA$			-4	V
Input Resistor	R_1		32	47	62	K Ω
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

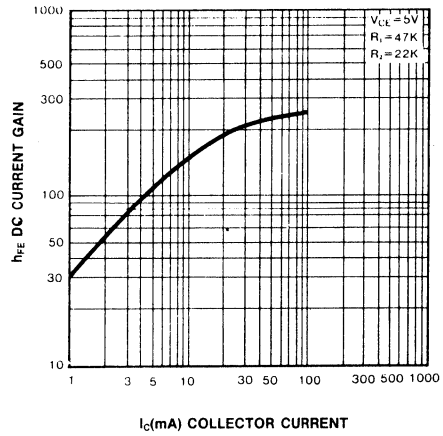
Equivalent Circuit



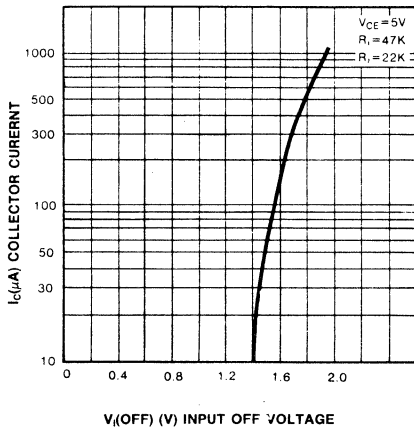
INPUT ON VOLTAGE



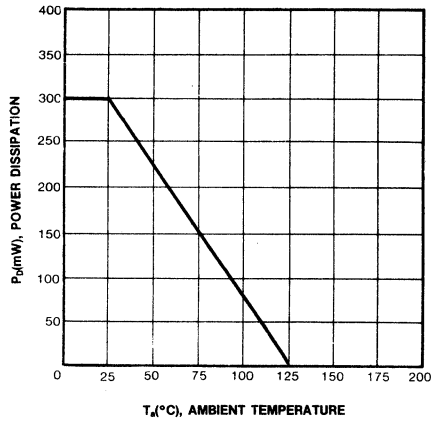
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

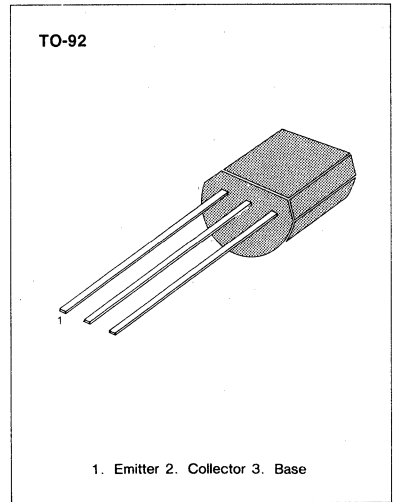


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR1009

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

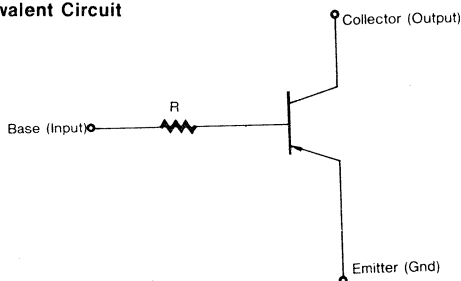
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



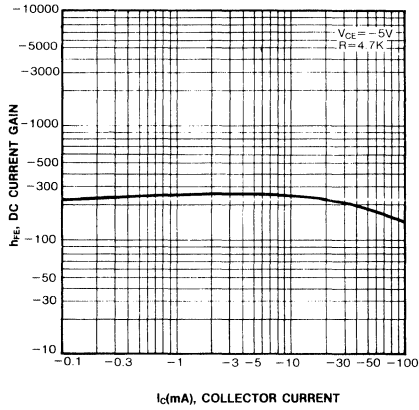
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$

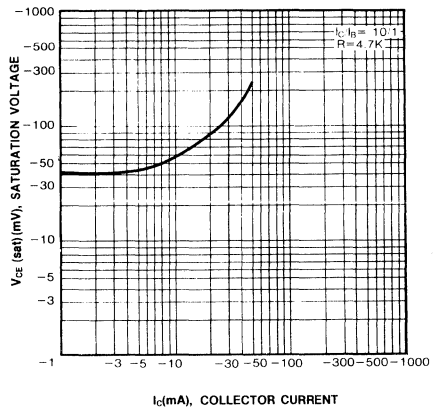
Equivalent Circuit



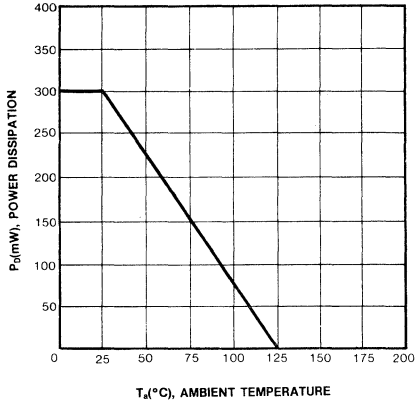
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



3

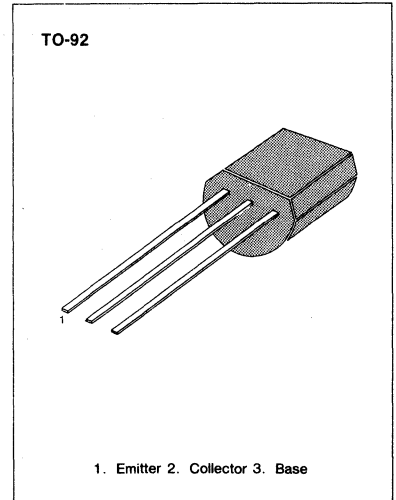
KSR2010 PNP EPITAXIAL SILICON TRANSISTOR

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor (R=10K)
- Complement to KSR1010

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

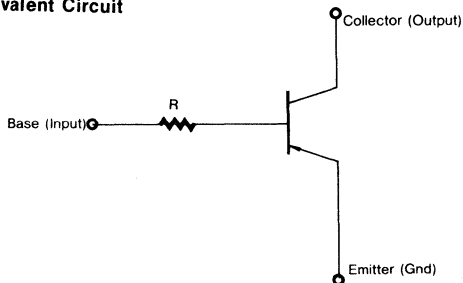
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



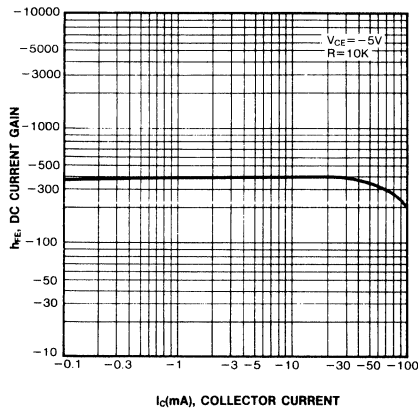
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E = -1\text{mA}, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30\text{V}, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}, I_B = -1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10\text{V}, I_C = -5\text{mA}$		200		MHz
Input Resistor	R		7	10	13	K Ω

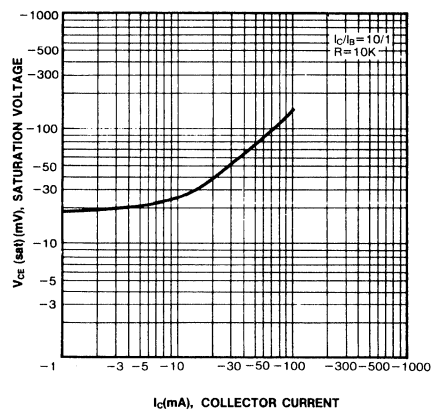
Equivalent Circuit



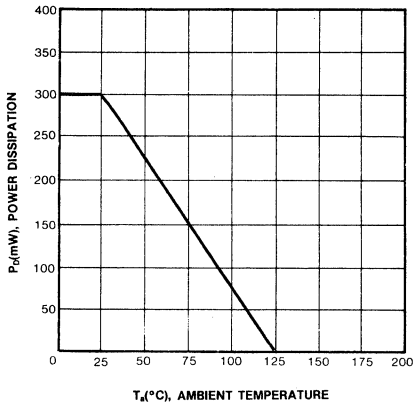
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



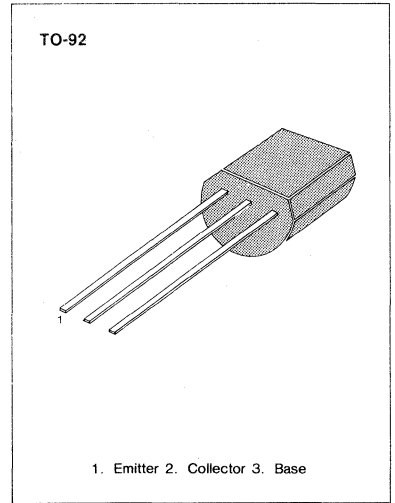
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR1011

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

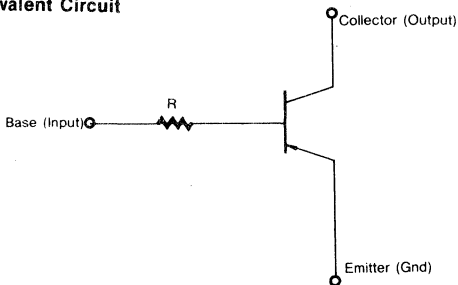
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E = -1 mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1 mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10 mA, I_B = -1 mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1 MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5 mA$		200		MHz
Input Resistor	R		15	22	29	$K\Omega$

Equivalent Circuit

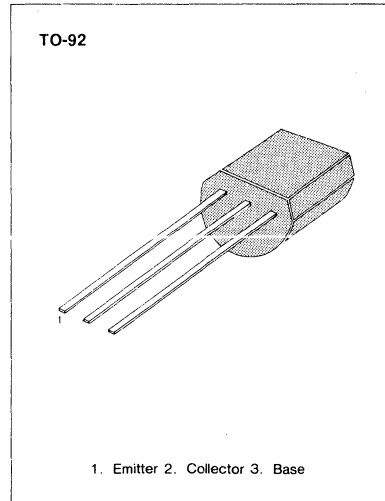


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47K\Omega$)
- Complement to KSR1012

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

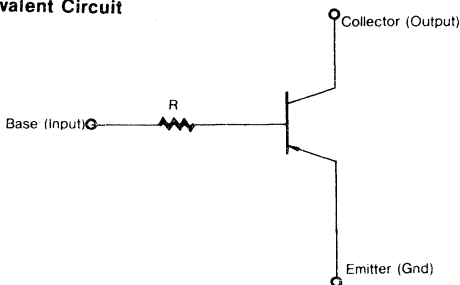


3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1 mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1 mA$	100		600	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10 mA, I_B = -1 mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1 MHz$		5.5		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5 mA$		200		MHz
Input Resistor	R		32	47	62	$K\Omega$

Equivalent Circuit

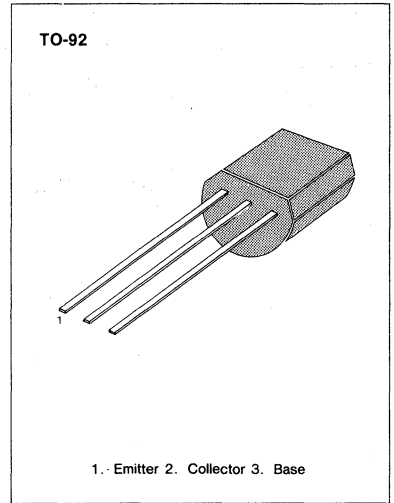


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1013

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

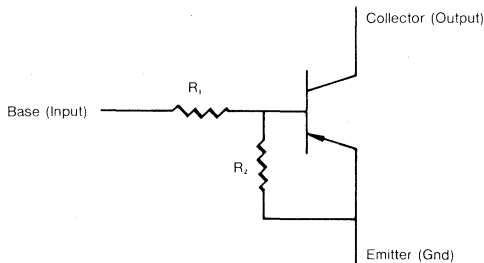
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5mA, I_C=-10V$		200		MHz
Output Capacitance	Cob	$V_{CB}=-10V, I_E=0$ $f=1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.2V, I_C=-10mA$			-1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit

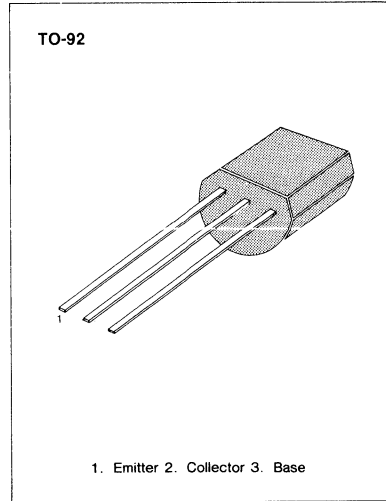


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR1014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

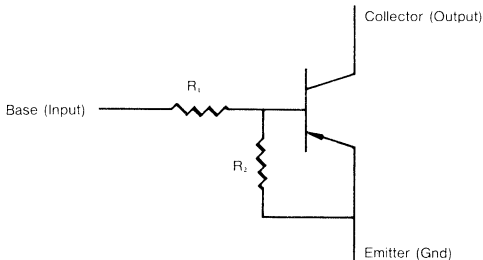


3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.2V, I_C = -5mA$			-1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

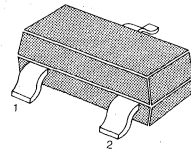
Equivalent Circuit



SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=4.7K\Omega$)
- Complement to KSR1101

SOT-23



1. Base 2. Emitter 3. Collector

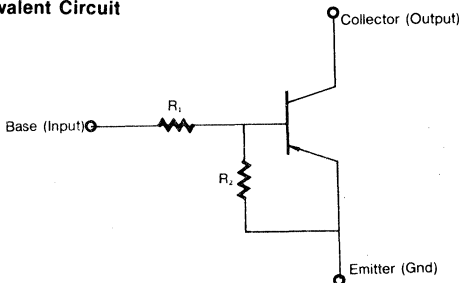
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-50	V
Collector-Emitter Voltage	V_{CE0}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

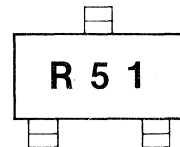
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -10\mu\text{A}$, $I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -100\mu\text{A}$, $I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40\text{V}$, $I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -10\text{mA}$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}$, $I_B = -0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}$, $I_C = -10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE} = -5\text{V}$, $I_C = -100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = -0.3\text{V}$, $I_C = -20\text{mA}$			-3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

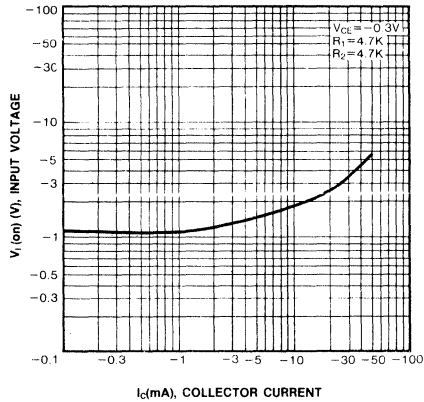
Equivalent Circuit



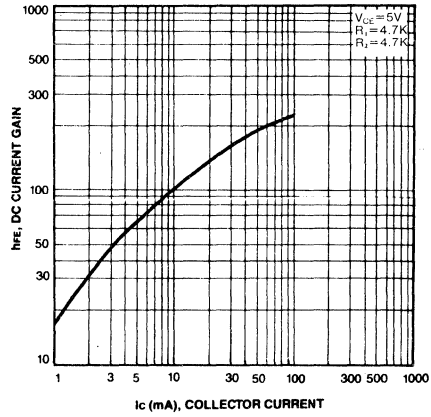
Marking



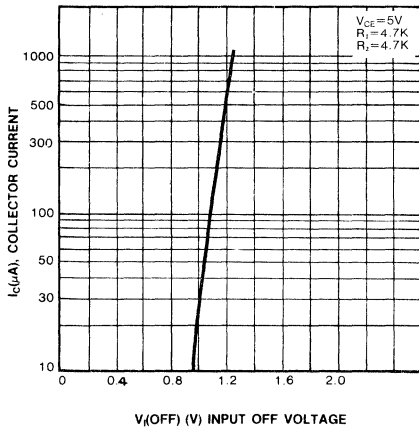
INPUT ON VOLTAGE



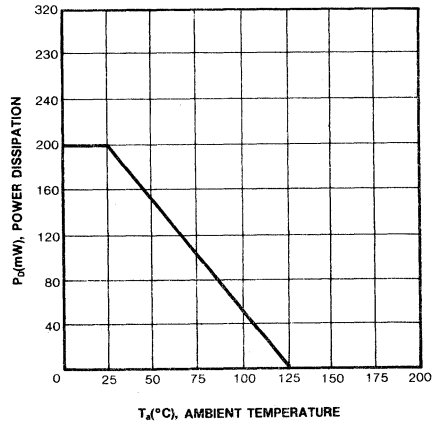
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

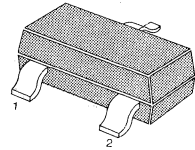


3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR1102

SOT-23



1. Base 2. Emitter 3. Collector

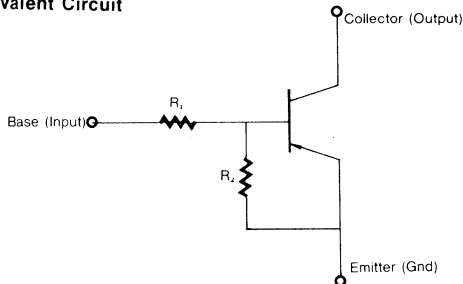
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

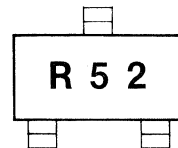
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}$, $I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}$, $I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}$, $I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}$, $I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10\text{mA}$, $I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}$, $I_C=-10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=-5\text{V}$, $I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=-0.3\text{V}$, $I_C=-10\text{mA}$			-3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

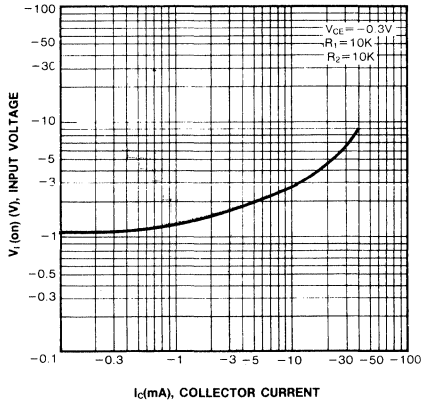
Equivalent Circuit



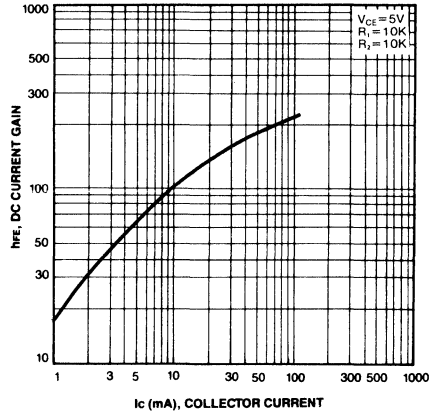
Marking



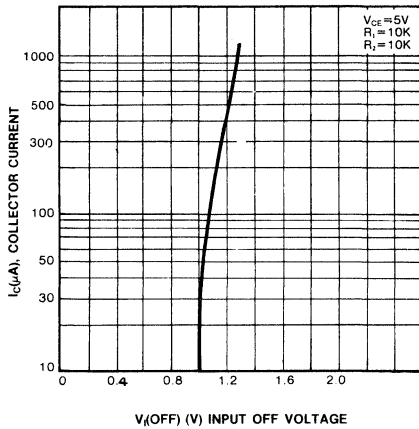
INPUT ON VOLTAGE



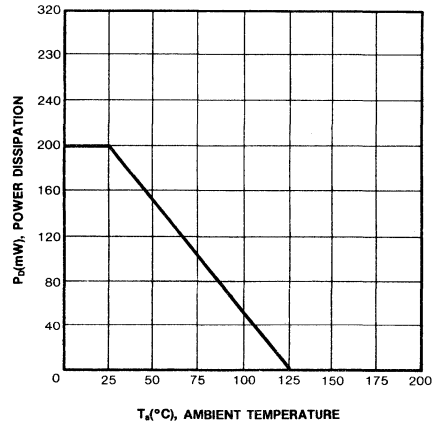
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



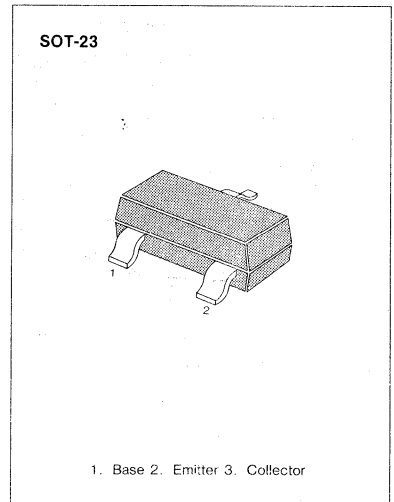
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=22K\Omega$)
- Complement to KSR1103

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

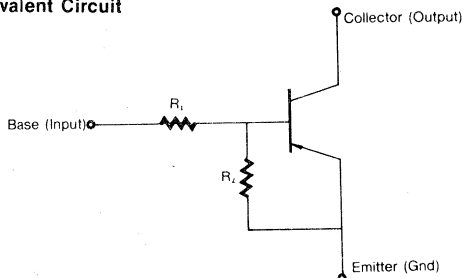
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



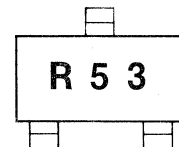
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5mA, I_C=-10V$		200		MHz
Output Capacitance	Cob	$V_{CB}=-10V, I_E=0$ $f=1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-5mA$			-3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

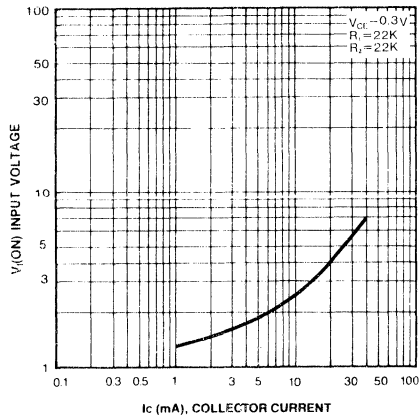
Equivalent Circuit



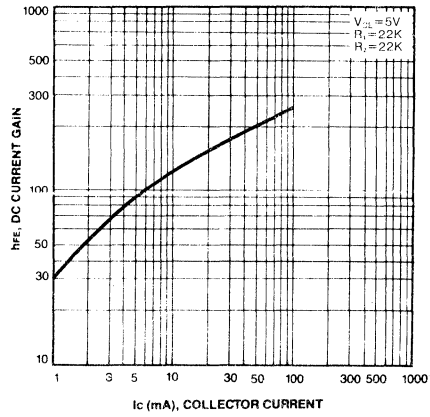
Marking



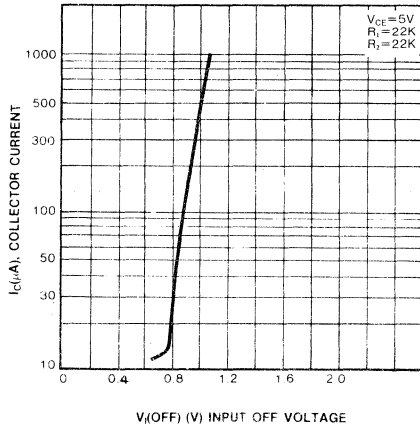
INPUT ON VOLTAGE



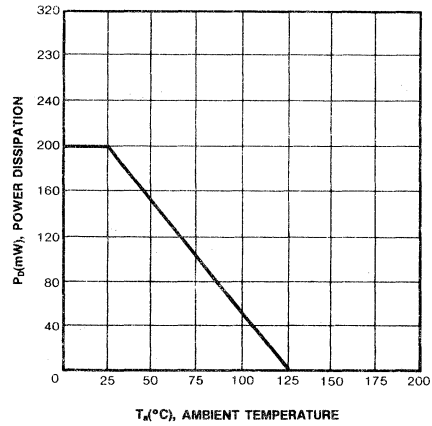
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

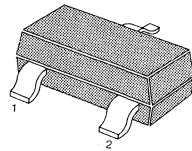


3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1104

SOT-23



1. Base 2. Emitter 3. Collector

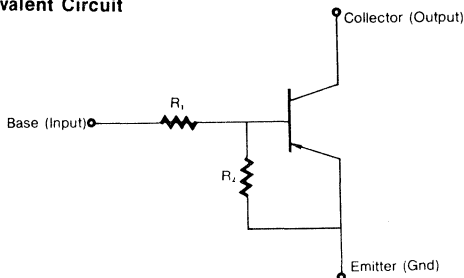
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

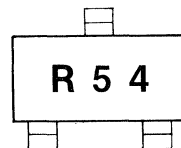
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = -0.3V, I_C = -2mA$			-3	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

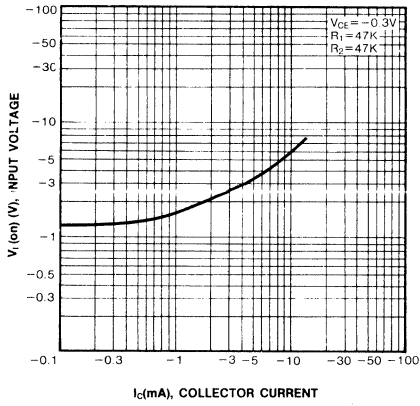
Equivalent Circuit



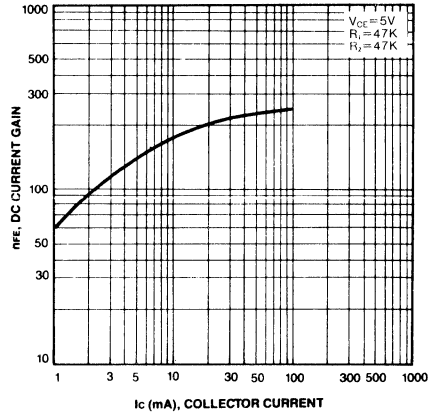
Marking



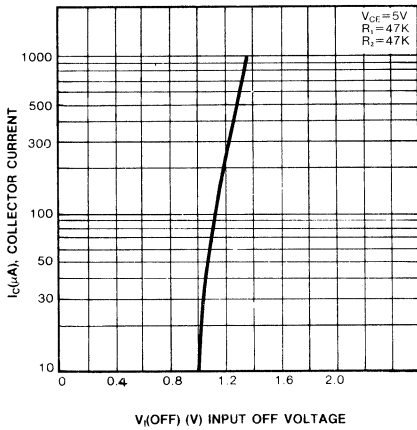
INPUT ON VOLTAGE



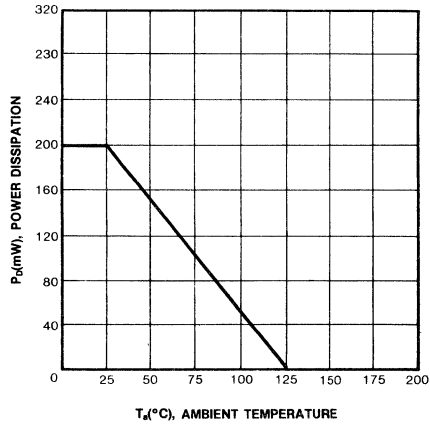
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



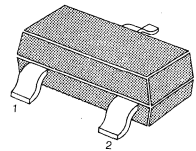
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR1105

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23

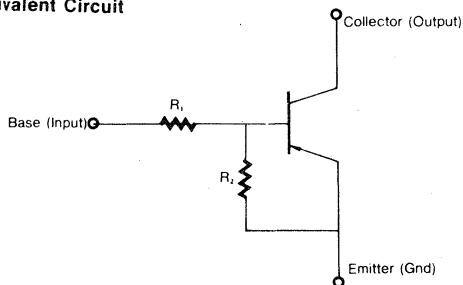


1. Base 2. Emitter 3. Collector

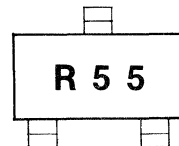
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -20mA$			-2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

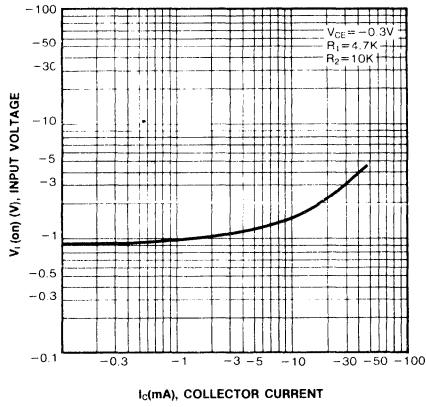
Equivalent Circuit



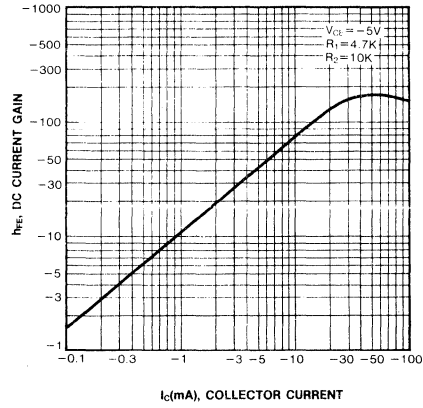
Marking



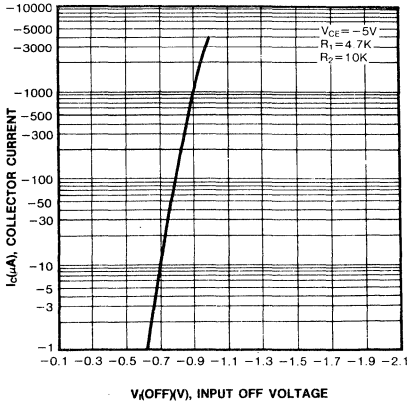
INPUT ON VOLTAGE



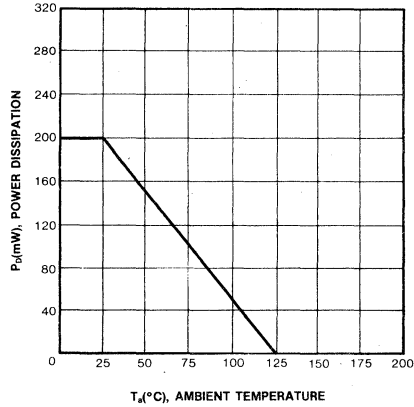
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



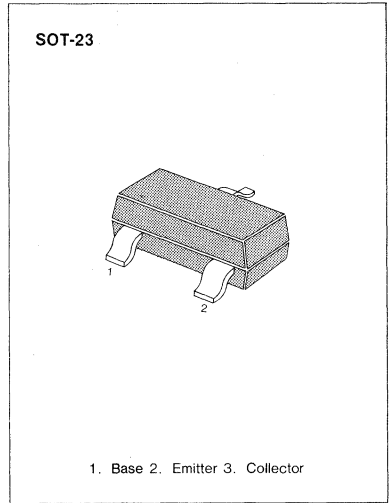
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1106

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

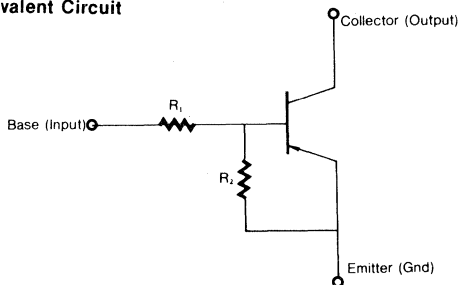
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



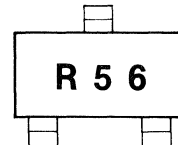
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -1mA$			-1.4	V
Input Resistor	R_1		7	10	13	K Ω
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

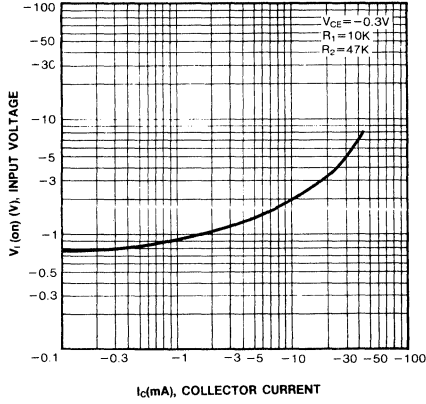
Equivalent Circuit



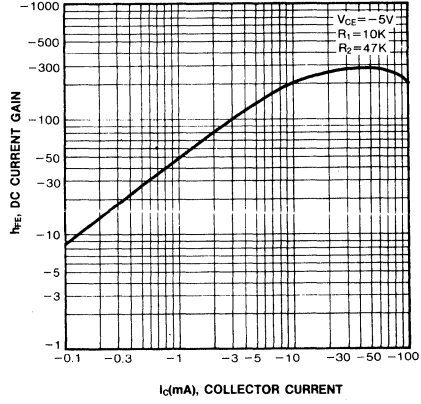
Marking



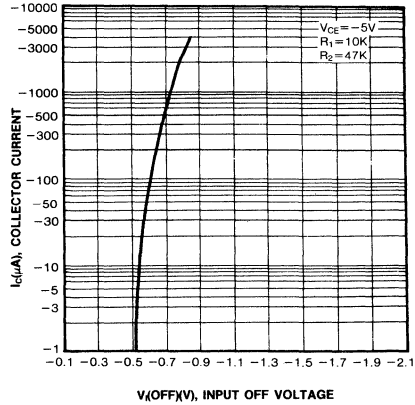
INPUT ON VOLTAGE



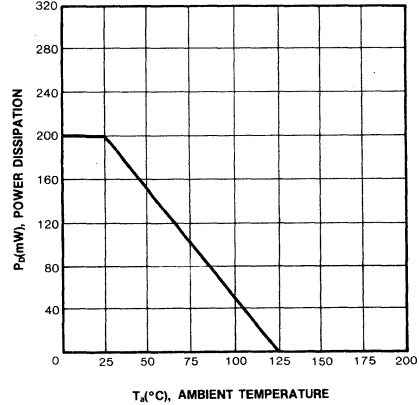
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



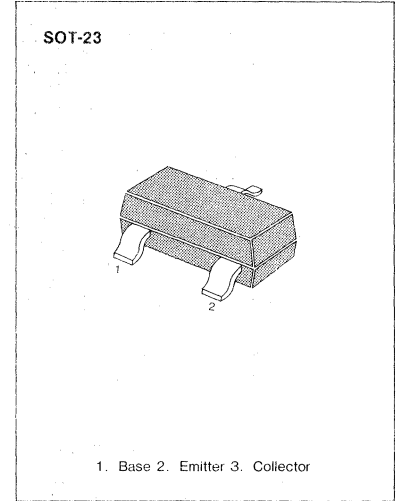
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1107

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

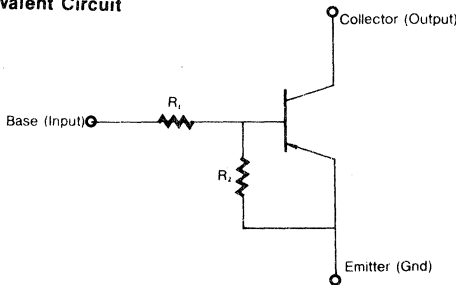
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



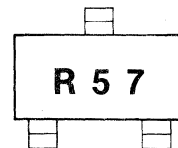
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.4			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-2mA$			-2.5	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

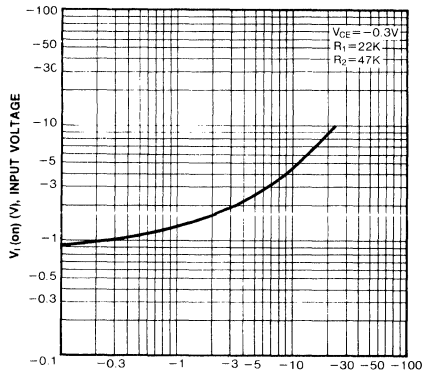
Equivalent Circuit



Marking

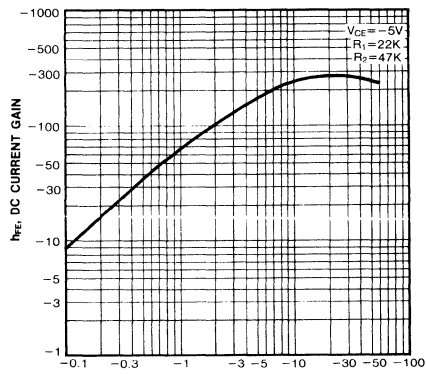


INPUT ON VOLTAGE



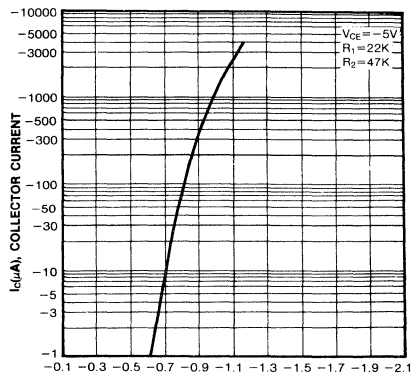
I_c(mA), COLLECTOR CURRENT

DC CURRENT GAIN



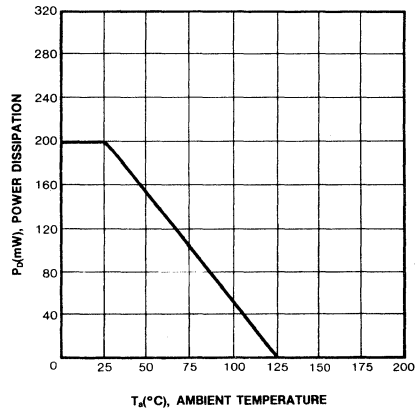
I_c(mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE



V_i(OFF)(V), INPUT OFF VOLTAGE

POWER DERATING



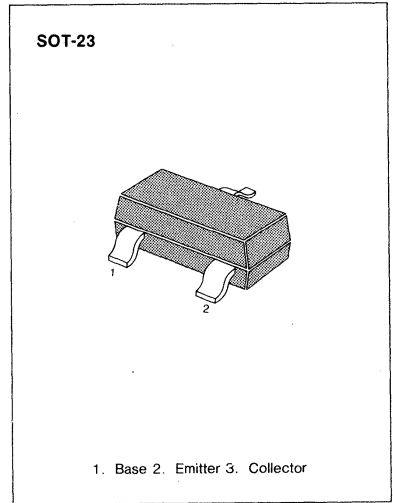
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR1108

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

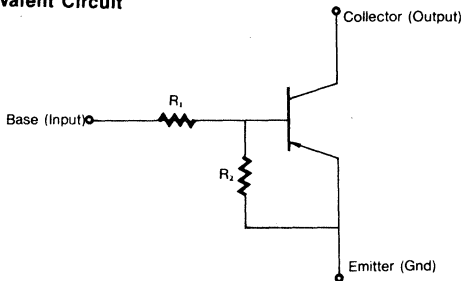
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$



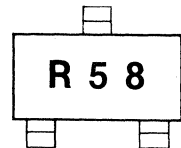
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.8			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -2mA$			-4	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

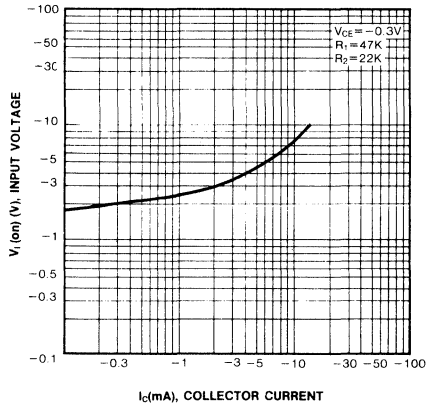
Equivalent Circuit



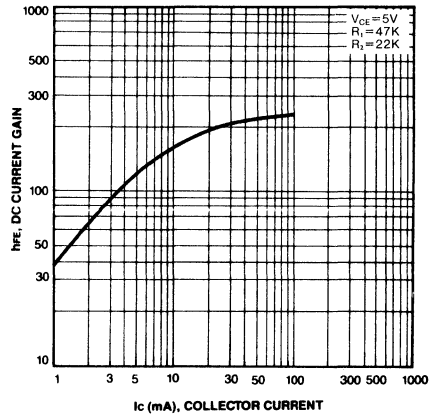
Marking



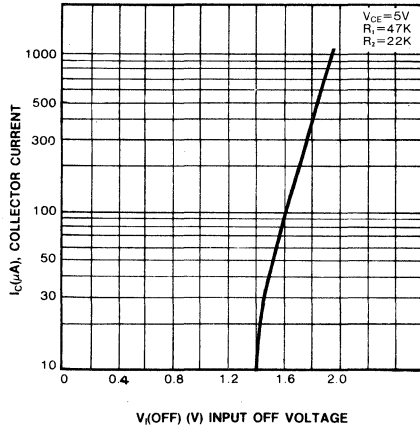
INPUT ON VOLTAGE



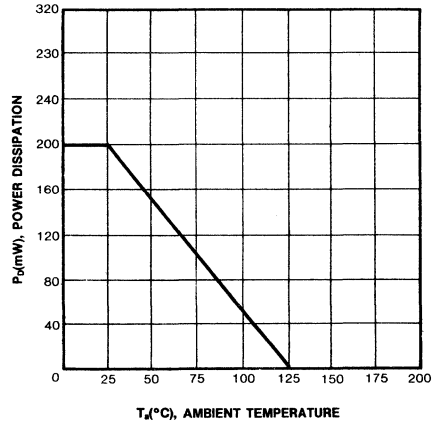
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



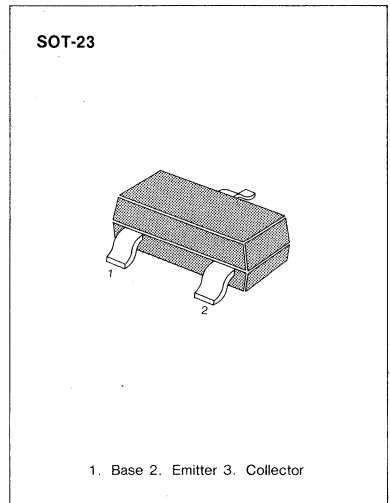
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR1109

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

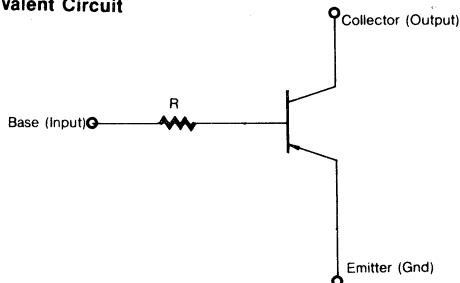
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



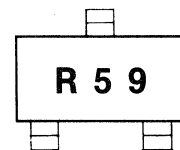
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$

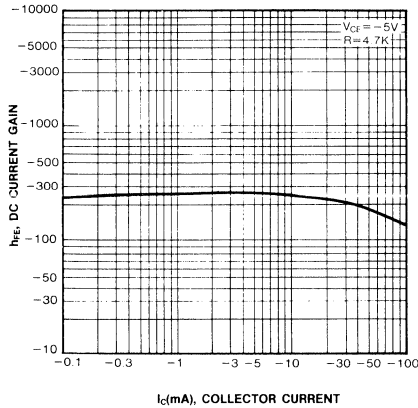
Equivalent Circuit



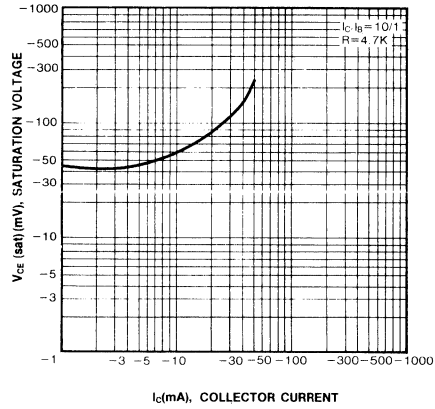
Marking



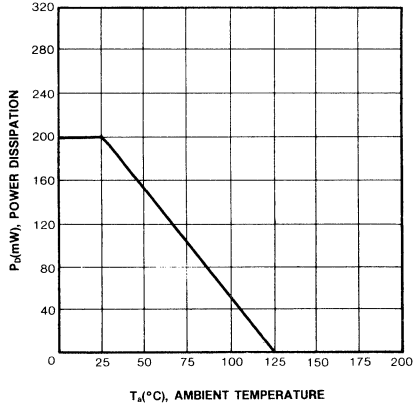
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



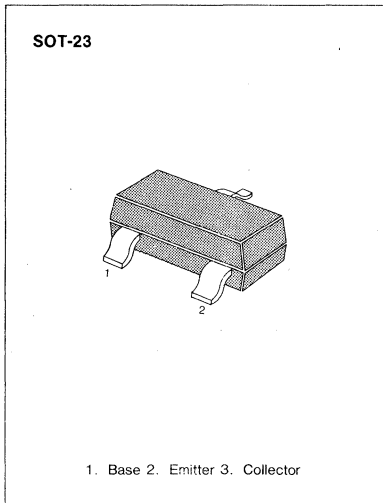
POWER DERATING



3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor (R=10KΩ)
- Complement to KSR1110



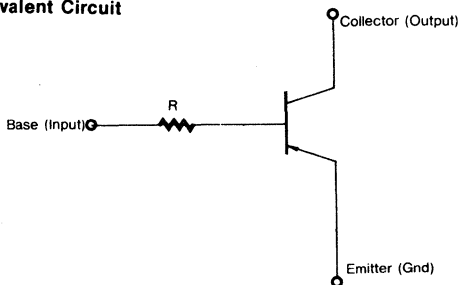
ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-40	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	200	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C

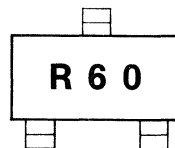
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -100μA, I _E = 0	-40			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _E = -1mA, I _B = 0	-40			V
Collector Cutoff Current	I _{CBO}	V _{CB} = -30V, I _E = 0			-0.1	μA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -1mA	100		600	
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -1mA			0.3	V
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz		5.5		pF
Current Gain-Bandwidth Product	f _T	V _{CE} = -10V, I _C = -5mA		200		MHz
Input Resistor	R		7	10	13	KΩ

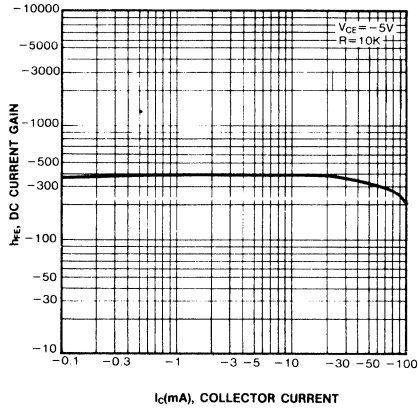
Equivalent Circuit



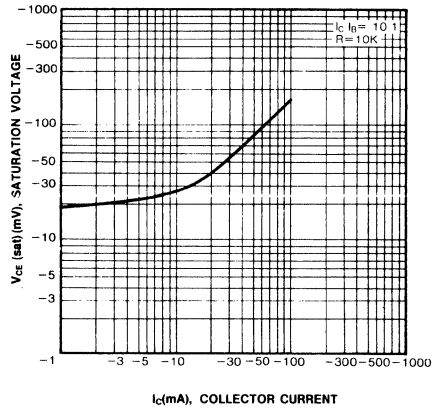
Marking



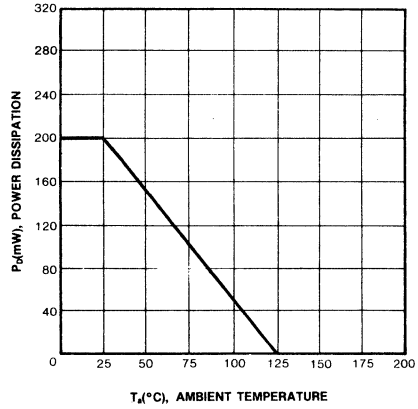
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING

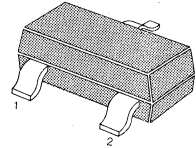


3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR1111

SOT-23



1. Base 2. Emitter 3. Collector

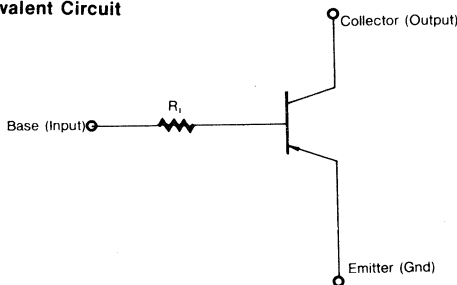
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

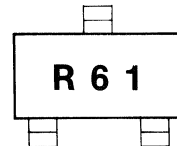
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E = -1 mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_c = -1 mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c = -10 mA, I_B = -1 mA$			-0.3	V
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1 MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_c = -5 mA$		200		MHz
Input Resistor	R		15	22	29	$K\Omega$

Equivalent Circuit



Marking

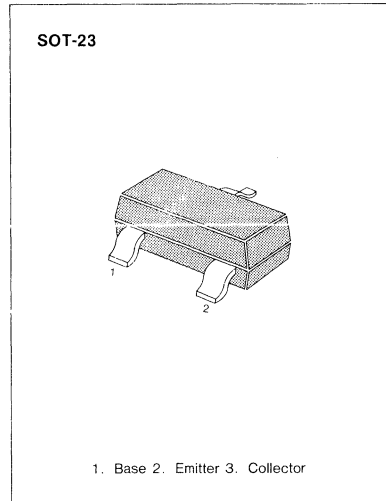


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor (R=47KΩ)
- Complement to KSR1112

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-40	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	200	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C

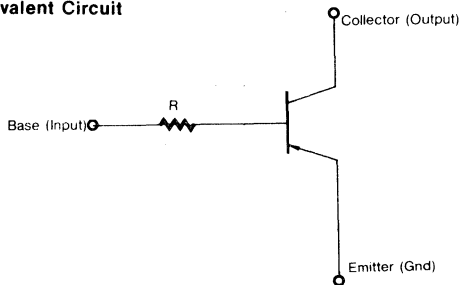


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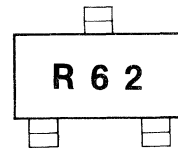
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C =-100μA, I _E =0	-40			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C =-1mA, I _B =0	-40			V
Collector Cutoff Current	I _{CBO}	V _{CB} =-30V, I _E =0			-0.1	μA
DC Current Gain	h _{FE}	V _{CE} =-5V, I _C =-1mA	100		600	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C =-10mA, I _B =-1mA			-0.3	V
Output Capacitance	C _{ob}	V _{CB} =-10V, I _E =0 f=1MHz		5.5		pF
Current Gain Bandwidth Product	f _T	V _{CE} =-10V, I _C =-5mA,		200		MHz
Input Resistor	R		32	47	62	KΩ

Equivalent Circuit



Marking

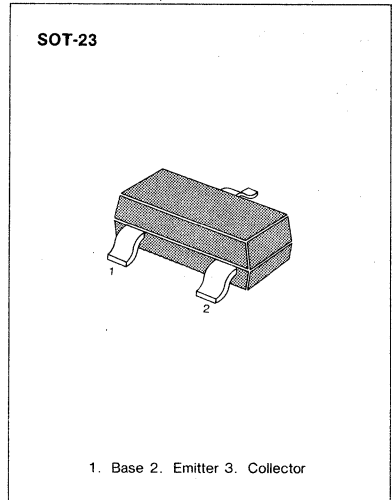


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1113

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

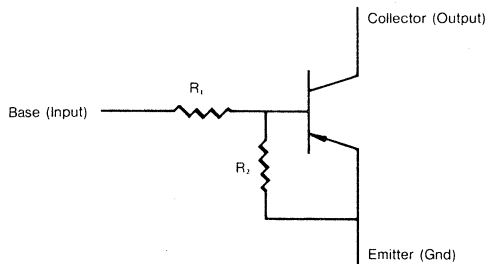
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



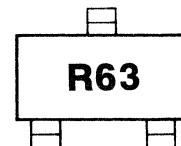
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5mA, I_C=-10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10V, I_E=0$ $f=1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.2V, I_C=-10mA$			-1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit



Marking

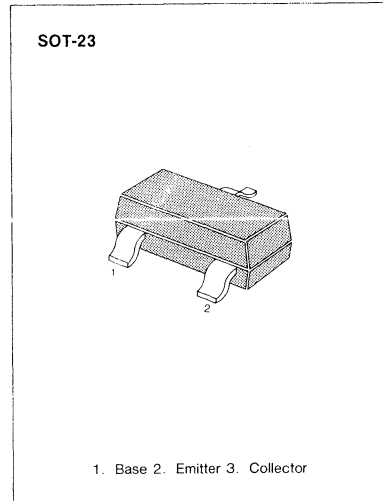


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR1114

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

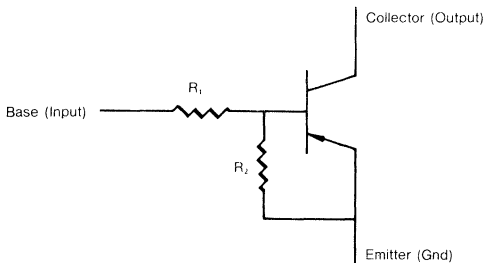


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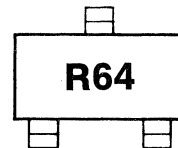
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.2V, I_C = -5mA$			-1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11 ¹	

Equivalent Circuit



Marking

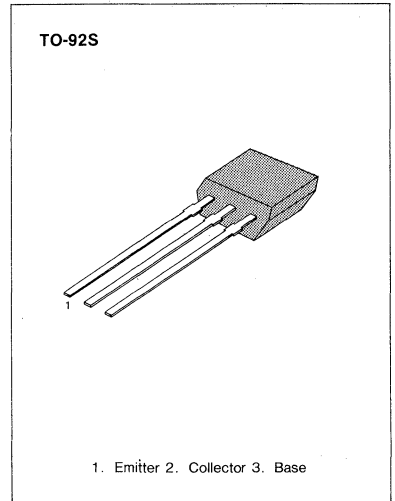


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=4.7K\Omega$)
- Complement to KSR1201

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

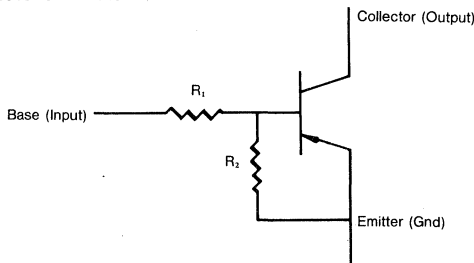
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



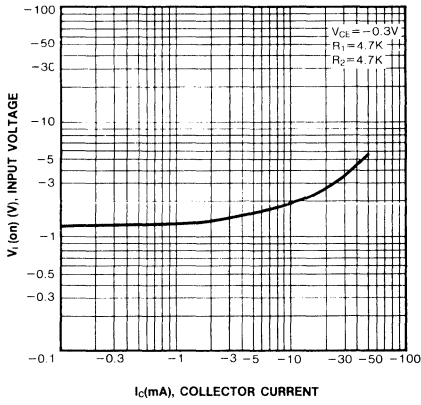
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -10mA$	20			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -20mA$			-3	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

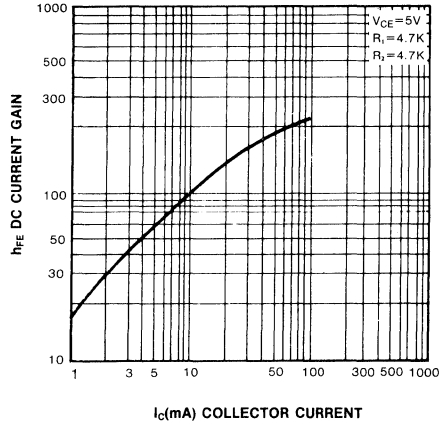
Equivalent Circuit



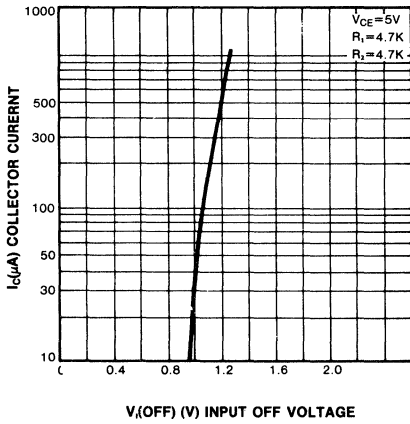
INPUT ON VOLTAGE



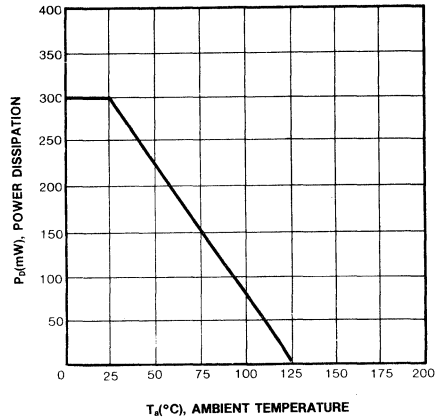
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



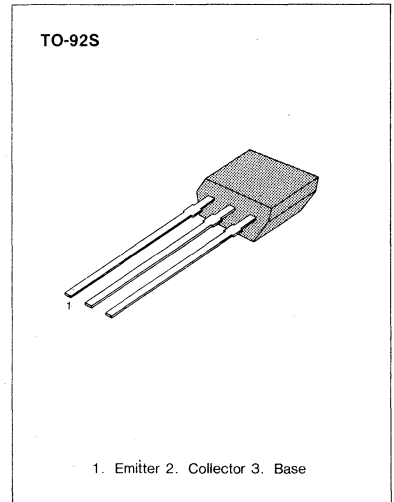
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1 = 10K\Omega$, $R_2 = 10K\Omega$)
- Complement to KSR1202

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

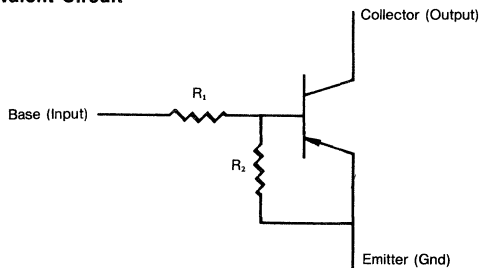
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



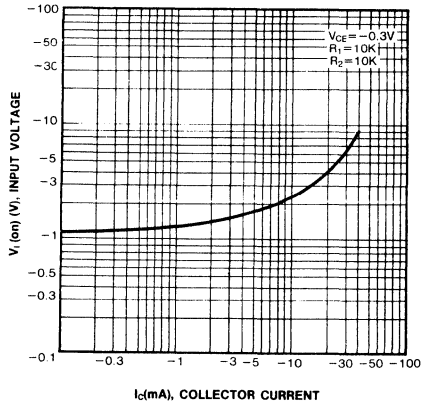
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = -0.3V, I_C = -10mA$			-3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

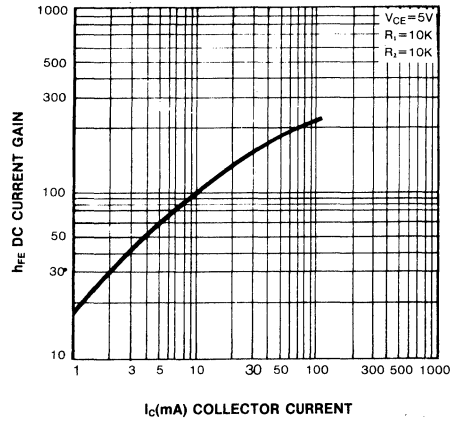
Equivalent Circuit



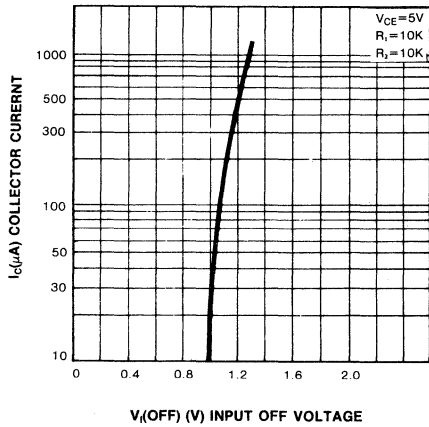
INPUT ON VOLTAGE



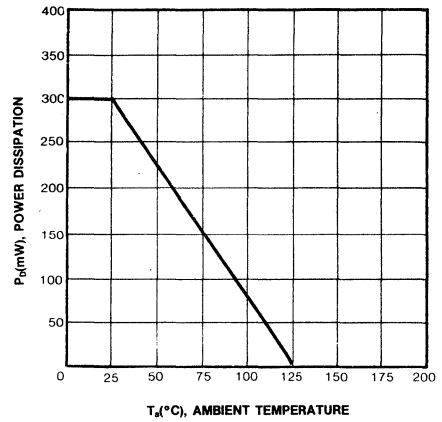
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



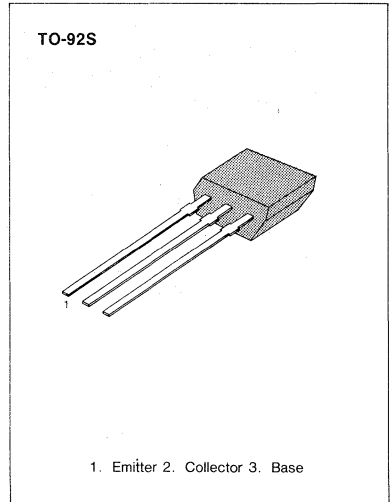
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor($R_1 = 22K\Omega$, $R_2 = 22K\Omega$)
- Complement to KSR1203

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

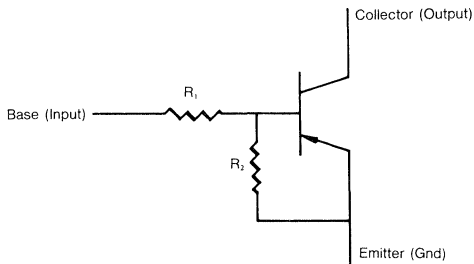
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



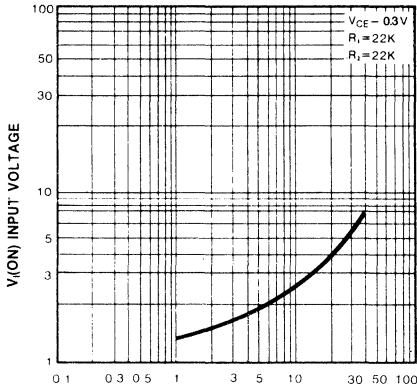
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -5mA$			-3.0	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

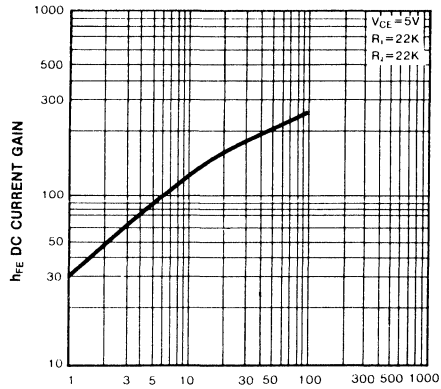


INPUT ON VOLTAGE



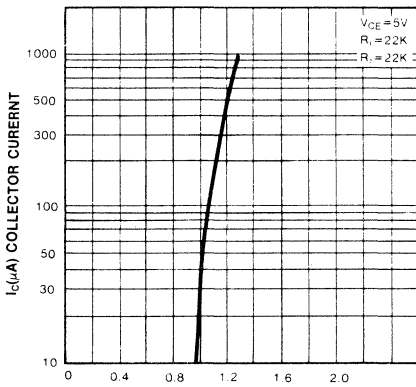
I_c (mA) COLLECTOR CURRENT

DC CURRENT GAIN



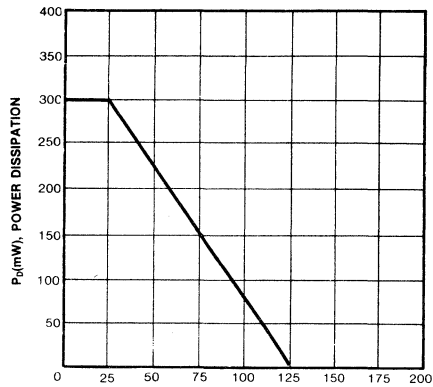
I_c (mA) COLLECTOR CURRENT

INPUT OFF VOLTAGE



$V_{I(OFF)}$ (V) INPUT OFF VOLTAGE

POWER DERATING



T_a (°C), AMBIENT TEMPERATURE

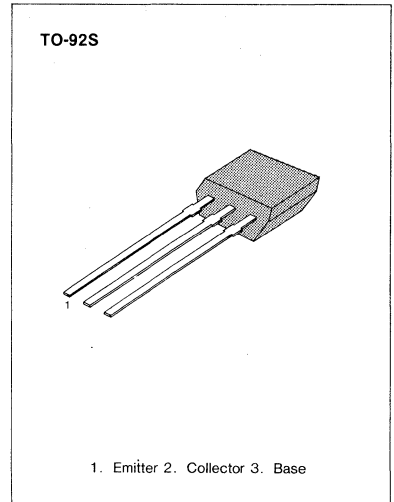
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1204

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

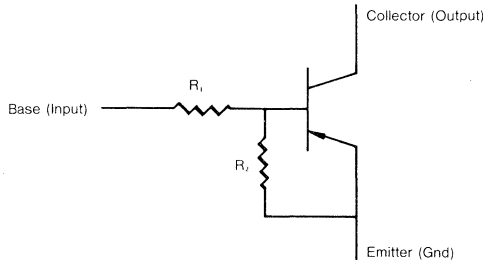
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



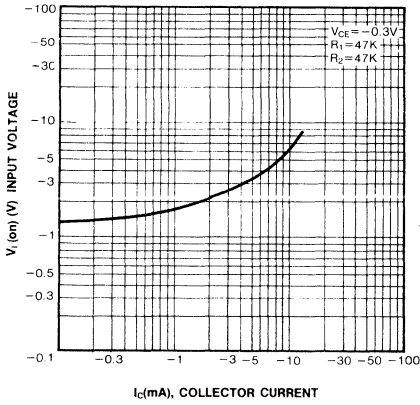
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5mA, I_C=-10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10V, I_E=0$ $f=1.0MHz$		5.5		pF
Input Off Voltage	$V_{i(off)}$	$V_{CE}=-5V, I_C=-100\mu A$	-0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE}=-0.3V, I_C=-2mA$			-3	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

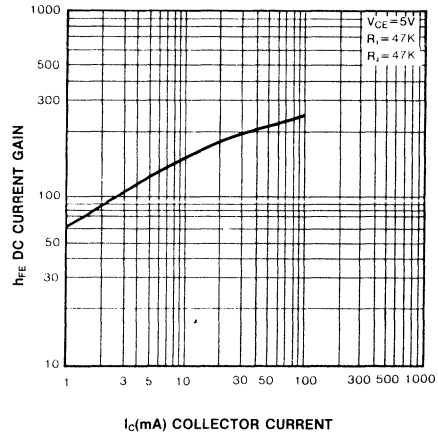
Equivalent Circuit



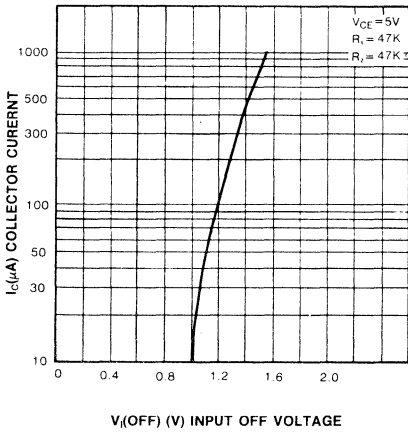
INPUT ON VOLTAGE



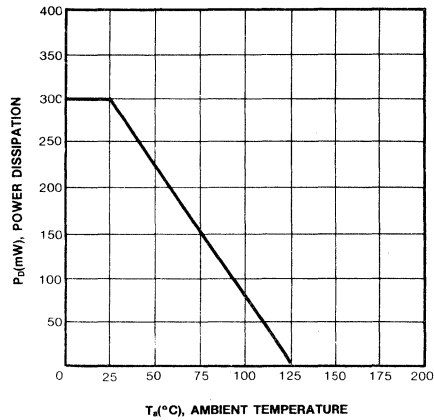
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



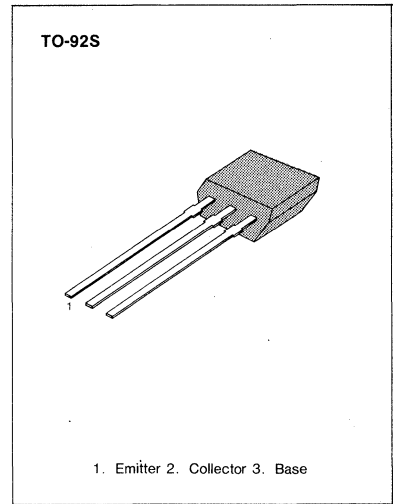
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7K\Omega$, $R_2=10K\Omega$)
- Complement to KSR1205

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

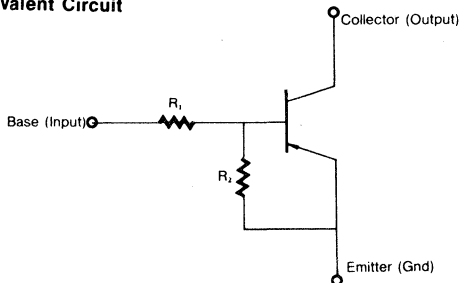
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



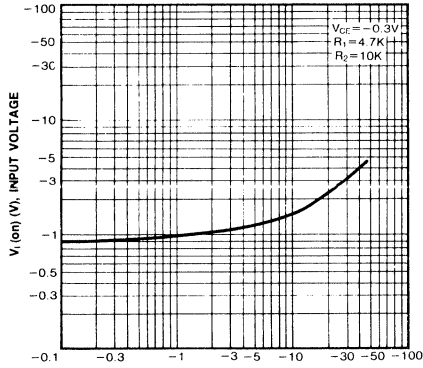
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -20mA$			-2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

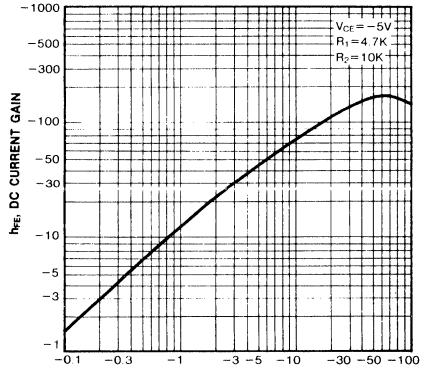
Equivalent Circuit



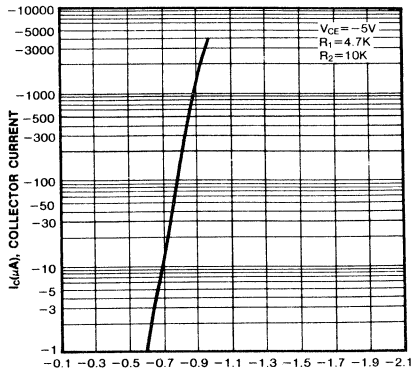
INPUT ON VOLTAGE



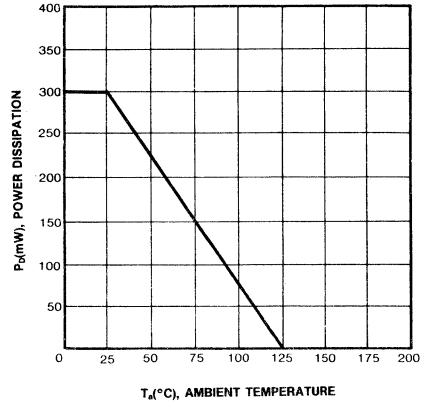
DC CURRENT GAIN



I_c (mA), COLLECTOR CURRENT
INPUT OFF VOLTAGE



I_c (mA), COLLECTOR CURRENT
POWER DERATING



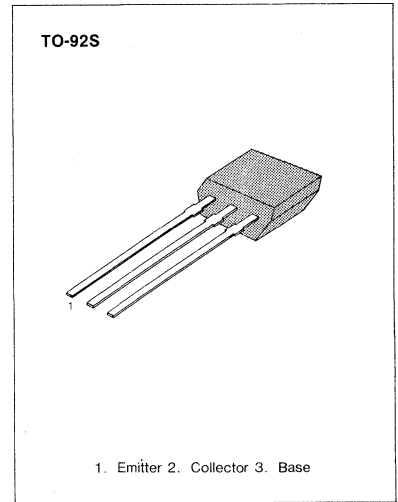
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1206

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

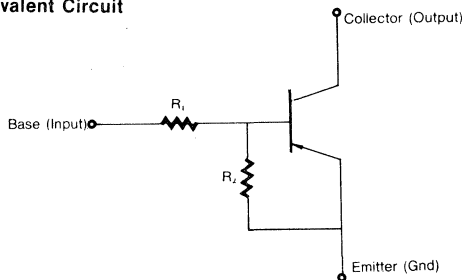
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



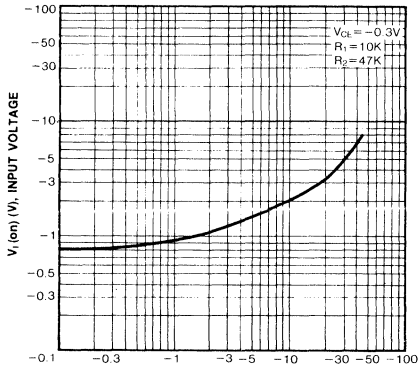
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.3			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.3V, I_C = -1mA$			-1.4	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

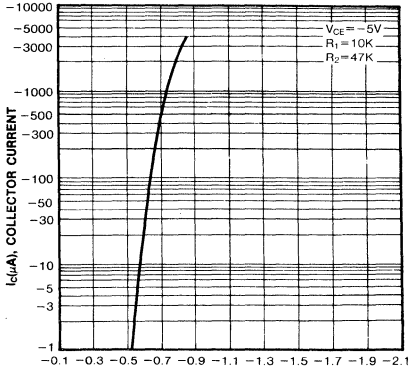
Equivalent Circuit



INPUT ON VOLTAGE

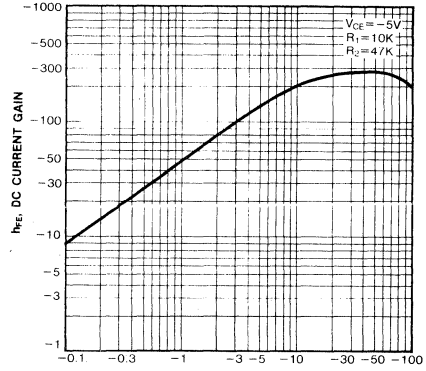


I_c (mA), COLLECTOR CURRENT
INPUT OFF VOLTAGE



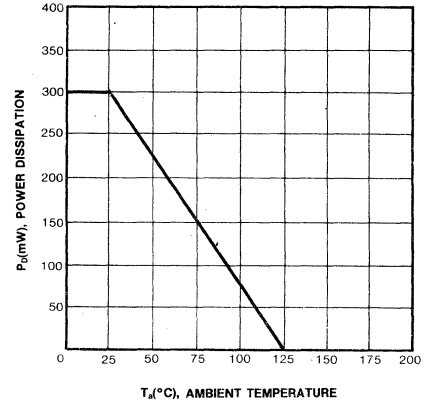
V_i (OFF)(V), INPUT OFF VOLTAGE

DC CURRENT GAIN



I_c (mA), COLLECTOR CURRENT

POWER DERATING



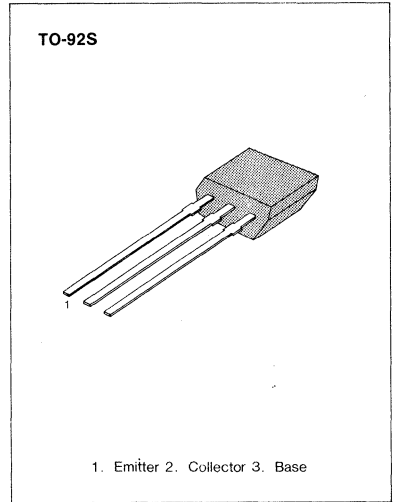
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$ $R_2=47K\Omega$)
- Complement to KSR1207

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

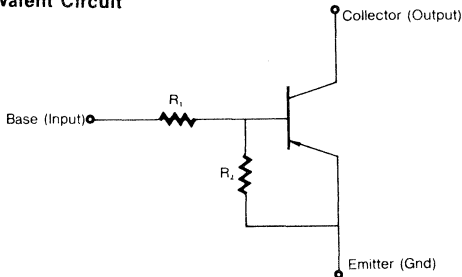
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



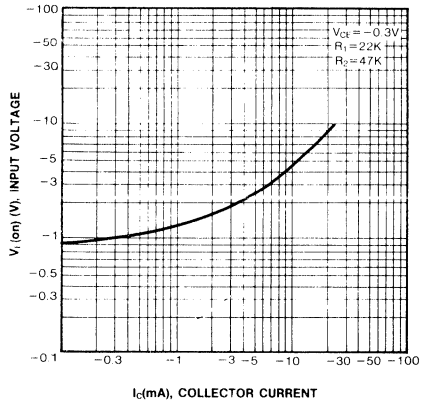
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	Cob	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.4			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-2mA$			-2.5	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

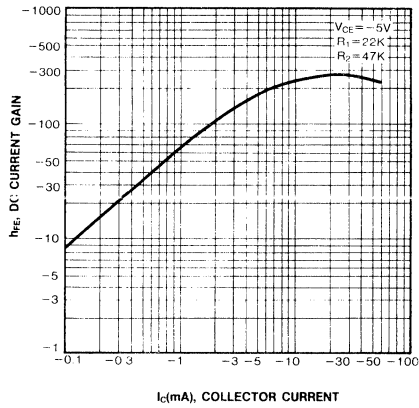
Equivalent Circuit



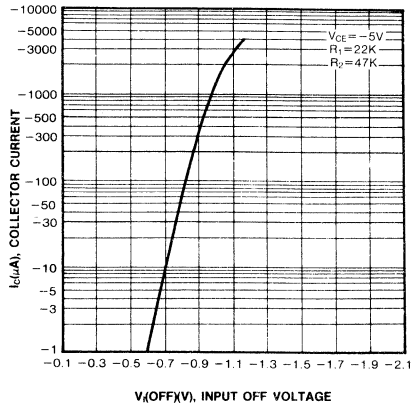
INPUT ON VOLTAGE



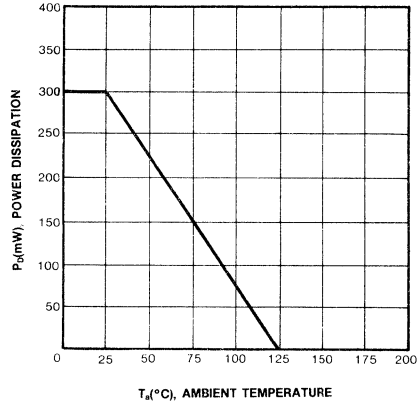
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

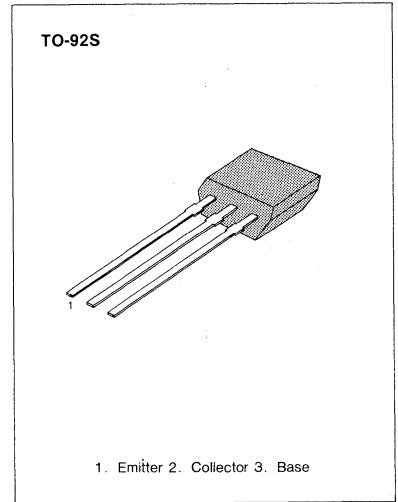


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47K\Omega$, $R_2=22K\Omega$)
- Complement to KSR1208

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

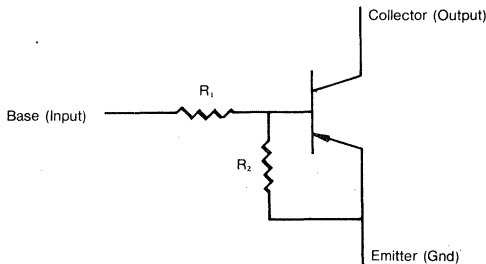
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



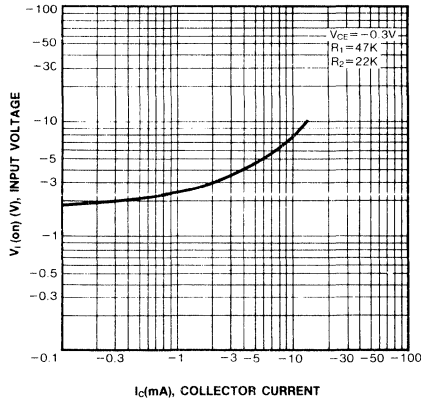
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5mA, I_C=-10V$		200		MHz
Output Capacitance	Cob	$V_{CB}=-10V, I_E=0$ $f=1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE}=-5V, I_C=-100\mu A$	-0.8			V
Input On Voltage	$V_i(on)$	$V_{CE}=-0.3V, I_C=-2mA$			-4	V
Input Resistor	R_1		32	47	62	$K\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

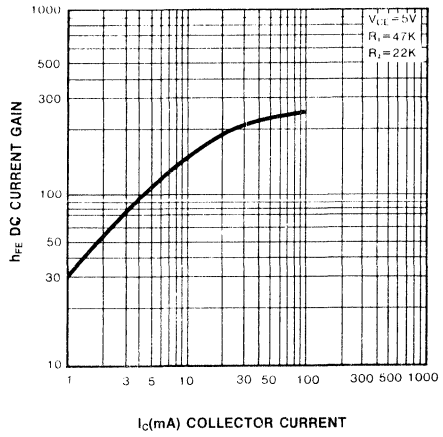
Equivalent Circuit



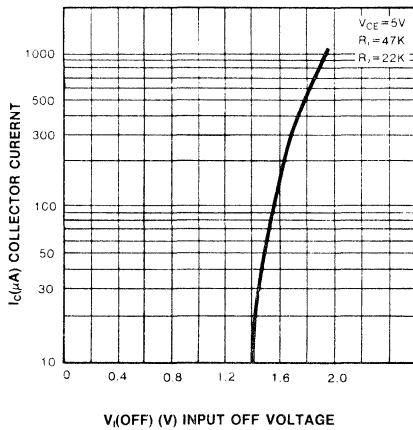
INPUT ON VOLTAGE



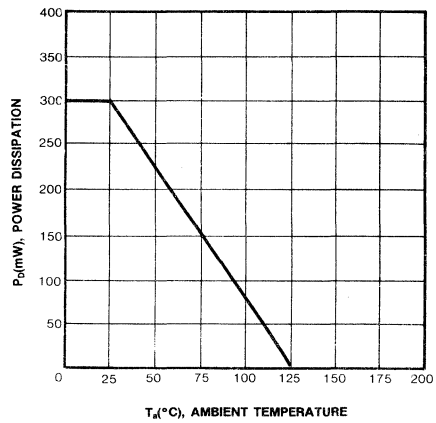
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



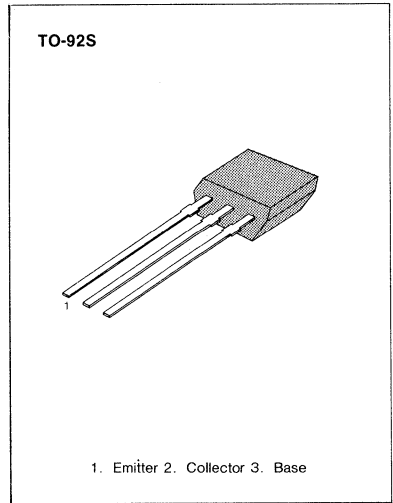
3

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7K\Omega$)
- Complement to KSR1209

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

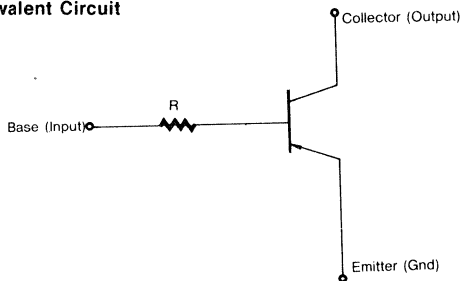
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



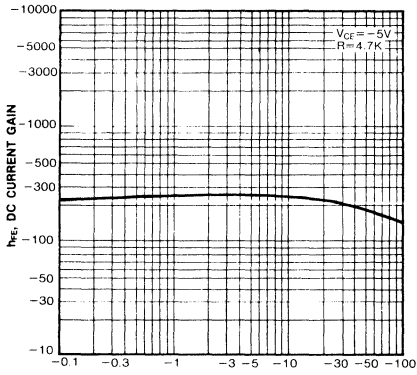
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$		200		MHz
Input Resistor	R_1		3.2	4.7	6.2	$K\Omega$

Equivalent Circuit

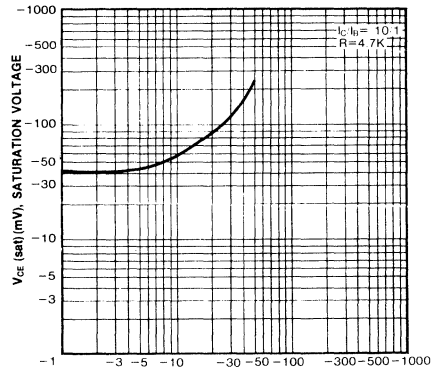


DC CURRENT GAIN



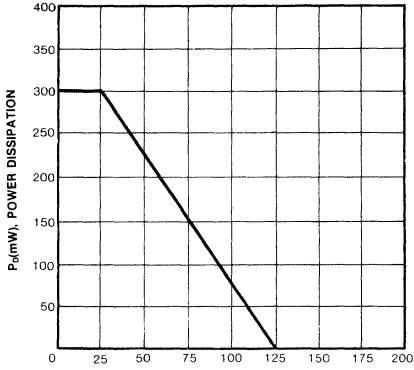
IC (mA), COLLECTOR CURRENT

COLLECTOR-EMITTER SATURATION VOLTAGE



IC (mA), COLLECTOR CURRENT

POWER DERATING



TA (°C), AMBIENT TEMPERATURE

3

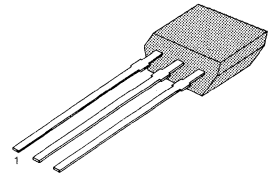
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR1210

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

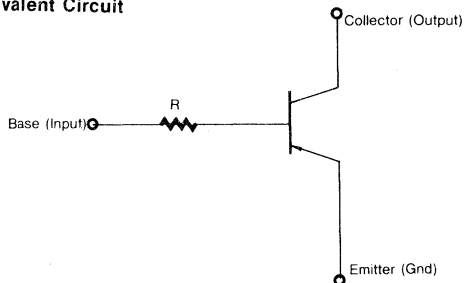
TO-92S



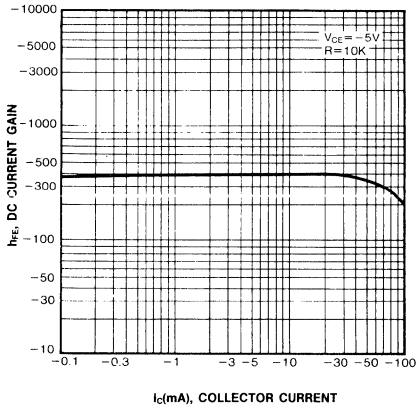
1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

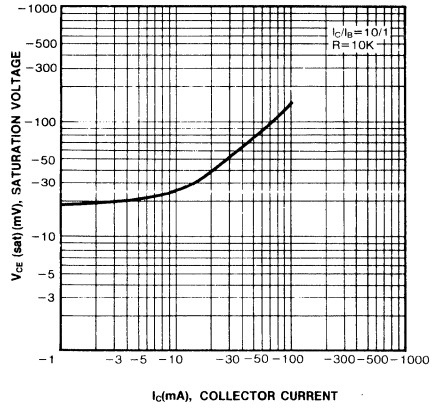
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1\text{mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10\text{mA}, I_B=-1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Resistor	R		7	10	13	$K\Omega$

Equivalent Circuit

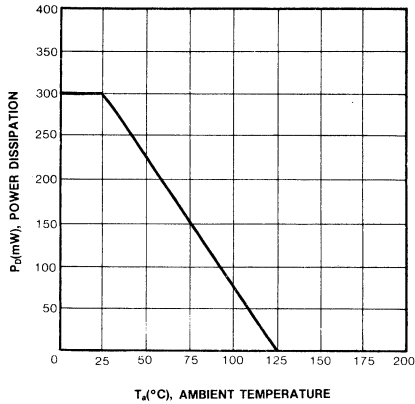
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



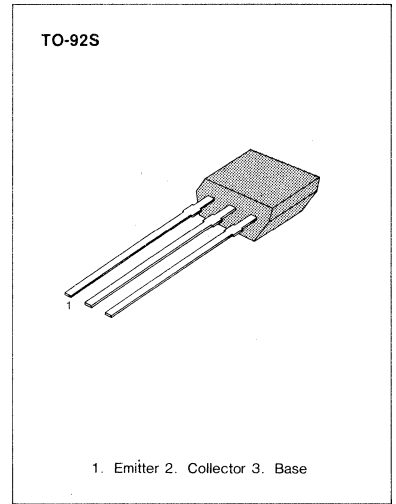
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SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22K\Omega$)
- Complement to KSR1211

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

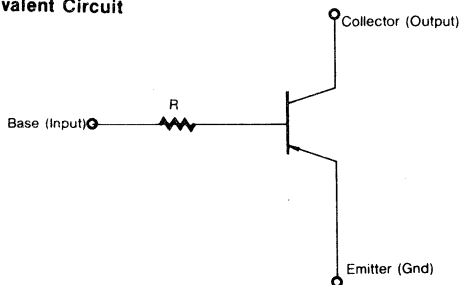
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

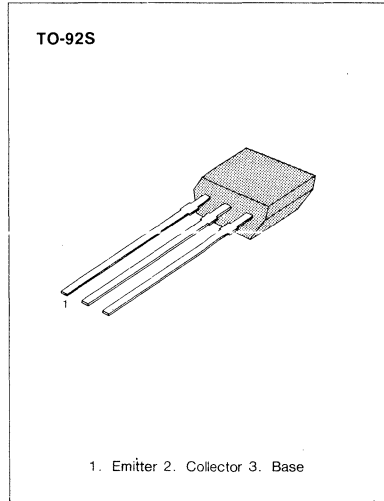
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu A, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1mA, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-1mA$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Resistor	R		15	22	29	K Ω

Equivalent Circuit



SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor (R=47KΩ)
- Complement to KSR1212



ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

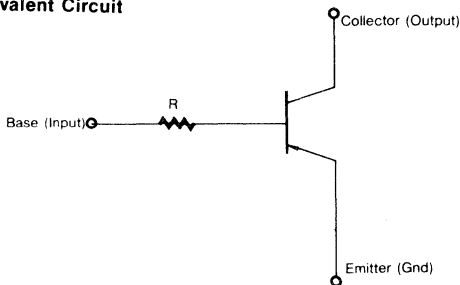
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-40	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	300	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55 ~ 150	°C

3

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -100μA, I _E = 0	-40			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _B = 0	-40			V
Collector Cutoff Current	I _{CBO}	V _{CB} = -30V, I _E = 0			-0.1	μA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -1mA	100		600	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -1mA			-0.3	V
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz		5.5		pF
Current Gain Bandwidth Product	f _T	V _{CE} = -10V, I _C = -5mA		200		MHz
Input Resistor	R		32	47	62	KΩ

Equivalent Circuit

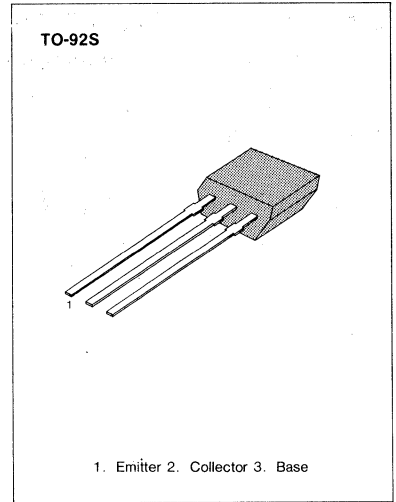


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1213

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

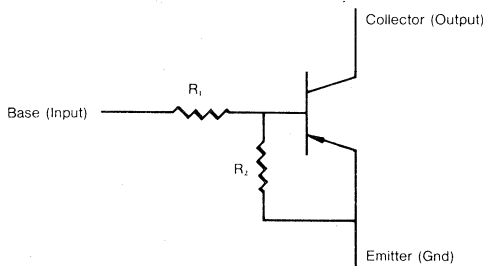
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA, I_C = -10V$		200		MHz
Output Capacitance	Cob	$V_{CB} = -10V, I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V, I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.2V, I_C = -10mA$			-1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit

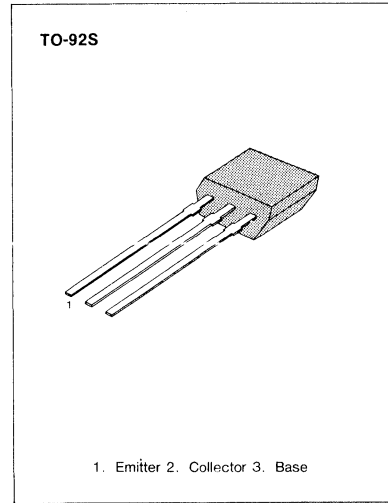


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR1214

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

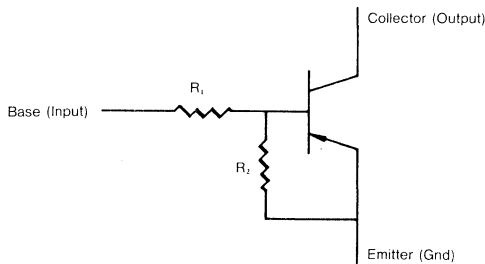


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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A$, $I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu A$, $I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40V$, $I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V$, $I_C = -5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA$, $I_B = -0.5mA$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5mA$, $I_C = -10V$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V$, $I_E = 0$ $f = 1.0MHz$		5.5		pF
Input Off Voltage	$V_i(off)$	$V_{CE} = -5V$, $I_C = -100\mu A$	-0.5			V
Input On Voltage	$V_i(on)$	$V_{CE} = -0.2V$, $I_C = -5mA$			-1.3	V
Input Resistor	R_1		3.2	4.7	6.2	K Ω
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit



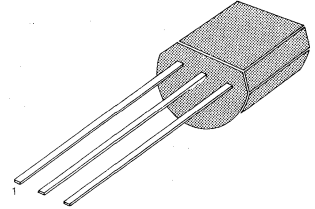
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CE0}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



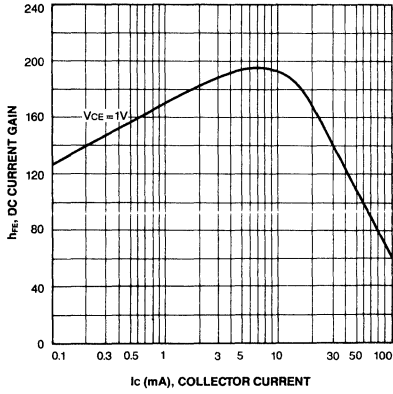
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

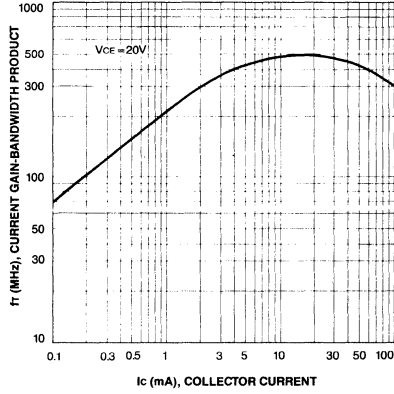
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1mA, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
Base Cut-off Current	I_{BL}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
*DC Current Gain	h_{FE}					
	:2N3903	$V_{CE} = 1V, I_C = 0.1mA$	20			
	2N3904		40			
	2N3903	$V_{CE} = 1V, I_C = 1mA$	35			
	2N3904		70			
	2N3903	$V_{CE} = 1V, I_C = 10mA$	50		150	
	2N3904		100		300	
	2N3903	$V_{CE} = 1V, I_C = 50mA$	30			
	2N3904		60			
	2N3903	$V_{CE} = 1V, I_C = 100mA$	15			
	2N3904		30			
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.2	V
		$I_C = 50mA, I_B = 5mA$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10mA, I_B = 1mA$	0.65		0.85	V
		$I_C = 50mA, I_B = 5mA$			0.95	V
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$			4	pF
Current Gain Bandwidth Product	f_T	$f = 1MHz$				
	:2N3903	$V_{CE} = 20V, I_C = 10mA$	250			MHz
	2N3904	$f = 100MHz$	300			MHz
Turn On Time	t_{ON}	$V_{CC} = 3V, V_{BE} = 0.5V$			70	ns
		$I_C = 10mA, I_{B1} = 1mA$				
Turn Off Time	t_{OFF}	$V_{CC} = 3V, I_C = 10mA$			225	ns
	:2N3903	$I_{B1} = I_{B2} = 1mA$			250	ns
	2N3904					

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

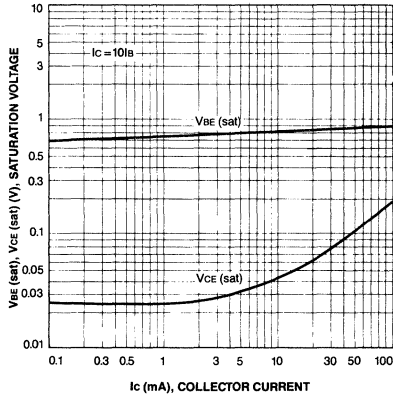
DC CURRENT GAIN



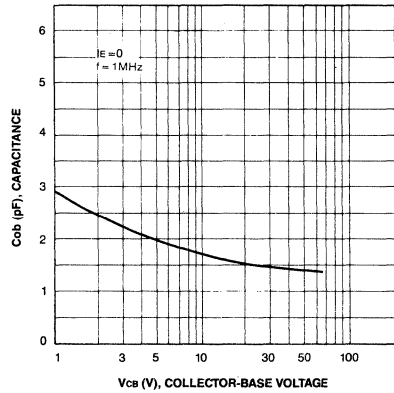
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



3

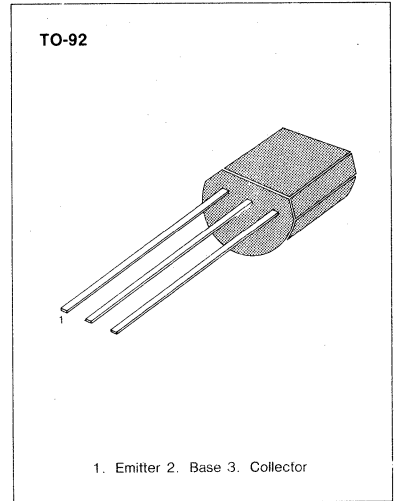
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_c (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-200	mA
Collector Dissipation	P_C	-625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N3906 for graphs

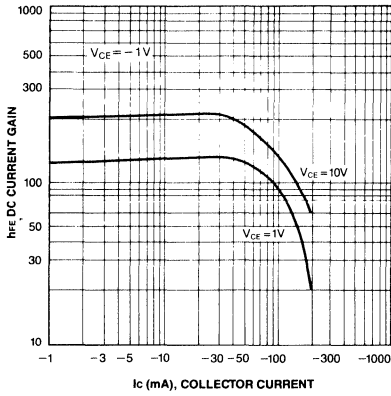


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

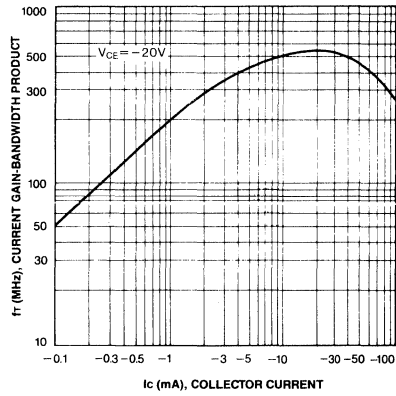
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-40			V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = -30V, V_{EB} = -3V$			-50	nA
Base Cut-off Current	I_{BL}	$V_{CE} = -30V, V_{EB} = -3V$			-50	nA
* DC Current Gain	h_{FE}					
	:2N3905	$V_{CE} = -1V, I_C = -0.1mA$	30			
	2N3906		60			
	2N3905	$V_{CE} = -1V, I_C = -1mA$	40			
	2N3906		80			
	2N3905	$V_{CE} = -1V, I_C = -10mA$	50		150	
	2N3906		100		300	
	2N3905	$V_{CE} = -1V, I_C = -50mA$	30			
	2N3906		60			
	2N3905	$V_{CE} = -1V, I_C = 100mA$	15			
	2N3906		30			
* Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_C = -10mA, I_B = -1mA$			-0.25	V
		$I_C = -50mA, I_B = -5mA$			-0.4	V
* Base-Emitter Saturation Voltage	$V_{BE (sat)}$	$I_C = -10mA, I_B = -1mA$	-0.65		-0.85	V
		$I_C = -50mA, I_B = -5mA$			-0.95	V
Output Capacitance	C_{OB}	$V_{CB} = -5V, I_E = 0$ $f = 100KHz$			4.5	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -20V, I_C = -10mA$ $f = 100MHz$	200			MHz
	:2N3905		250			MHz
Turn On Time	t_{ON}	$V_{CC} = -3V, V_{BE} = -0.5V$ $I_C = -10mA, I_{B1} = -1mA$			70	ns
Turn Off Time	t_{OFF}	$V_{CC} = -3V, I_C = -10mA$ $I_{B1} = I_{B2} = 1 - mA$			260	ns
	:2N3905				300	ns
	2N3906					

*Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

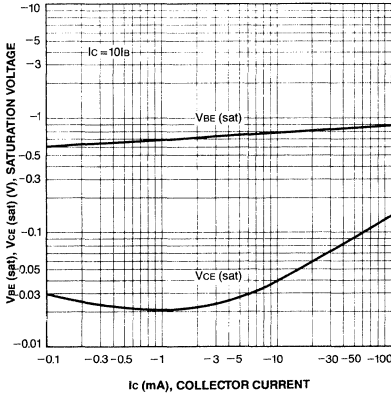
DC CURRENT GAIN



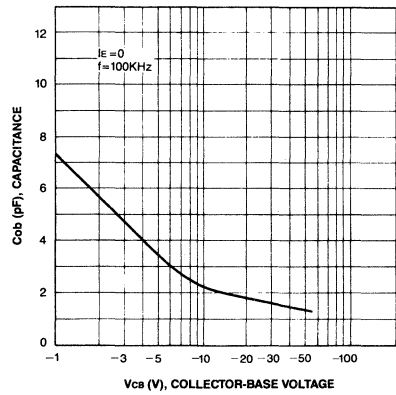
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



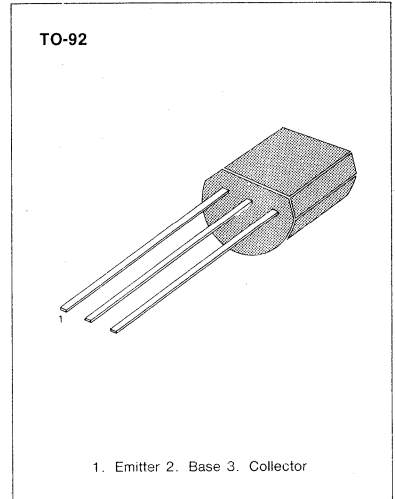
3

GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 2N4123: 30V$
 $2N4124: 25V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage :2N4123	V_{CBO}	40	V
2N4124		30	V
Collector-Emitter Voltage :2N4123	V_{CEO}	30	V
2N4124		25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55~150	$^\circ C$



• Refer to 2N3904 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	40			V
:2N4123			30			V
2N4124	BV_{CEO}	$I_C = 1mA, I_B = 0$	30			V
*Collector-Emitter Breakdown Voltage			25			V
:2N4123	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
2N4124						V
Emitter-Base Breakdown Voltage						V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_C = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 0.2mA$	50		150	
:2N4123			120		360	
2N4124			25			
2N4124			60			
*Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = 50mA, I_B = 5mA$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE} (sat)$	$I_C = 50mA, I_B = 5mA$			0.95	V
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 1MHz$			4	pF
Collector-Base Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 100KHz$			4	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 20V, I_C = 10mA$ $f = 100MHz$	250			MHz
:2N4123			300			MHz
2N4124						

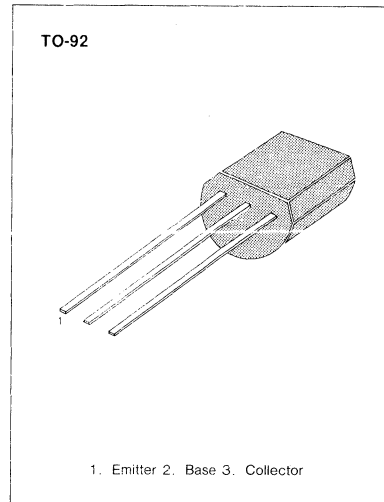
* Pulse Test: Pulse Width $\leq 300\mu s$. Duty Cycle $\leq 2\%$

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 2N4125: 30V$
 $2N4126: 25V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
:2N4125		-25	V
Collector-Emitter Voltage	V_{CEO}	-30	V
:2N4126		-25	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55~150	$^\circ C$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-30			V
:2N4125			-25			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-30			V
:2N4126			-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -20V, V_C = 0$			-50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			-50	nA
*DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -2mA$	50		150	
:2N4125			120		360	
:2N4126			25			
:2N4126			60			
*Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = -50mA, I_B = -5mA$			-0.4	V
*Base-Emitter Saturation Voltage	$V_{BE} (sat)$	$I_C = -50mA, I_B = -5mA$			-0.95	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -20V, I_C = -10mA$ $f = 100MHz$	200			MHz
:2N4125			250			MHz
Collector-Base Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 1MHz$			4.5	pF
Noise figure	N_F	$I_C = -100\mu A, V_{CE} = -5V$ $R_G = 1K\Omega$ Noise Bandwidth= 10Hz to 15.7KHz			5	dB
:2N4125					4	dB
:2N4126						

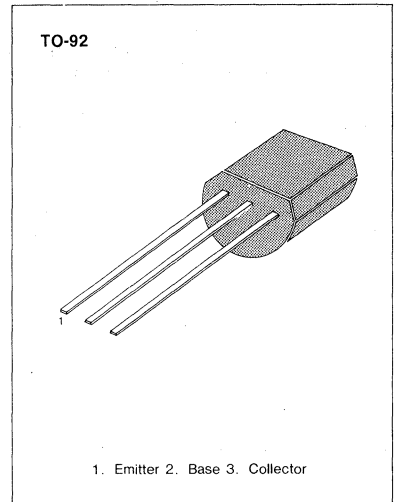
*Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

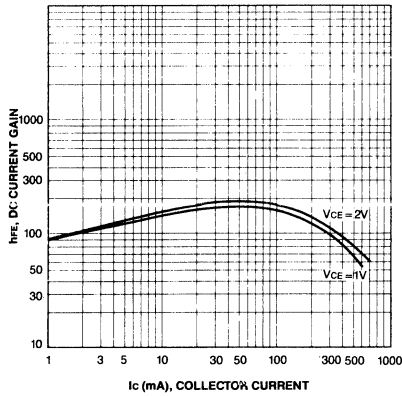


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

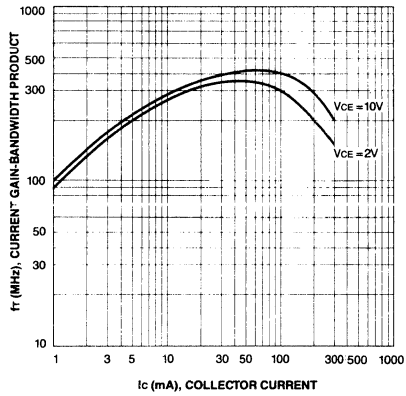
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 35V, V_{EB} = 0.4V$			100	nA
* DC Current Gain	h_{FE}					
	:2N4401	$V_{CE} = 1V, I_C = 0.1mA$	20			
	2N4400	$V_{CE} = 1V, I_C = 1mA$	20			
	2N4401		40			
	2N4400	$V_{CE} = 1V, I_C = 10mA$	40			
	2N4401		80			
	2N4400	$V_{CE} = 1V, I_C = 150mA$	50		150	
	2N4401		100		300	
	2N4400	$V_{CE} = 2V, I_C = 500mA$	20			
	2N4401		40			
* Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_C = 150mA, I_B = 15mA$ $I_C = 50mA, I_B = 50mA$			0.4 0.75	V V
* Base-Emitter Saturation Voltage	$V_{BE (sat)}$	$I_C = 150mA, I_B = 15mA$ $I_C = 500mA, I_B = 50mA$	0.75		0.95 1.2	V V
Output Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 100MHz$			6.5	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 20mA$ $f = 100MHz$				
	:2N4400		200			MHz
	2N4401		250			MHz
Turn On Time	t_{ON}	$V_{CC} = 30V, V_{BE} = 2V$ $I_C = 150mA, I_{B1} = 15mA$			35	ns
Turn Off Time	t_{OFF}	$V_{CC} = 30V, I_C = 150mA$ $I_{B1} = I_{B2} = 15mA$			255	ns

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

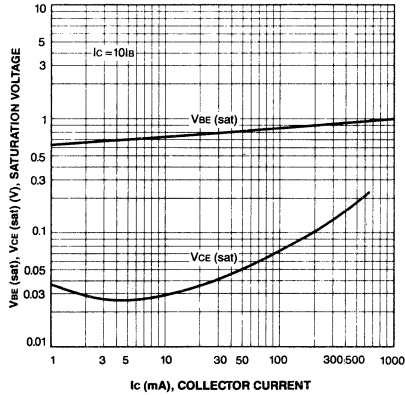
DC CURRENT GAIN



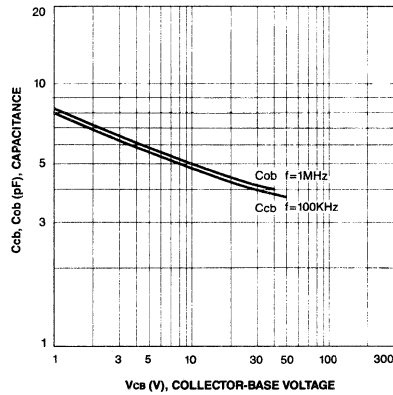
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE
OUTPUT CAPACITANCE



3

GENERAL PURPOSE TRANSISTOR

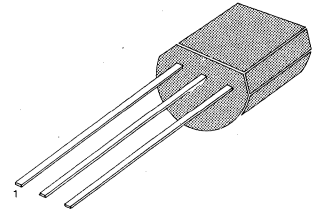
- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N4403 for graphs

TO-92



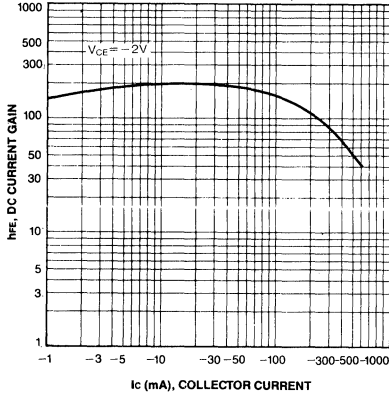
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

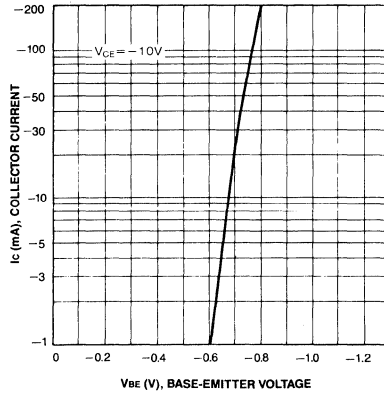
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = -35V, V_{EB} = -0.4V$			-100	nA
Base Cut-off Current	I_{BEV}	$V_{CE} = -35V, V_{EB} = -0.4V$			-100	nA
*DC Current Gain	h_{FE}					
	:2N4403	$V_{CE} = -1V, I_C = -0.1mA$	30			
	2N4402	$V_{CE} = -1V, I_C = -1mA$	30			
	2N4403		60			
	2N4402	$V_{CE} = -1V, I_C = -10mA$	50			
	2N4403		100			
	2N4402	* $V_{CE} = -2V, I_C = -150mA$	50		150	
	2N4403		100		300	
	2N4402/2N4403	* $V_{CE} = -2V, I_C = -500mA$	20			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = -150mA, I_B = -15mA$			-0.4	V
		$I_C = -500mA, I_B = -50mA$			-0.75	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = -150mA, I_B = -15mA$	-0.75		-0.95	V
		$I_C = -500mA, I_B = -50mA$			-1.3	V
Collector-Base Capacitance	C_{CB}	$V_{CB} = -10V, I_E = 0, f = 140KHz$			8.5	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -20mA$ $f = 100MHz$	150			MHz
	:2N4402		200			MHz
	2N4403					
Turn On Time	t_{ON}	$V_{CC} = -30V, V_{BE} = -2V$ $I_C = -150mA, I_{B1} = -15mA$			35	ns
Turn Off Time	t_{OFF}	$V_{CC} = -30V, I_C = -150mA$ $I_{B1} = I_{B2} = -15mA$			255	ns

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

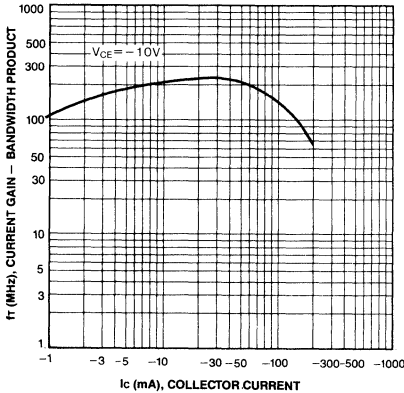
DC CURRENT GAIN



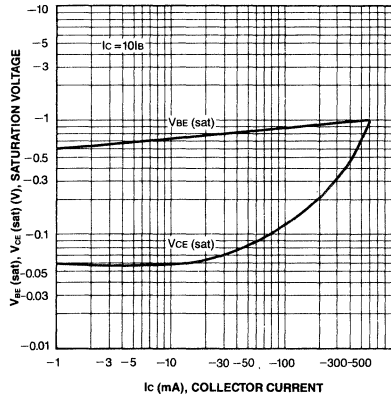
BASE-EMITTER ON VOLTAGE



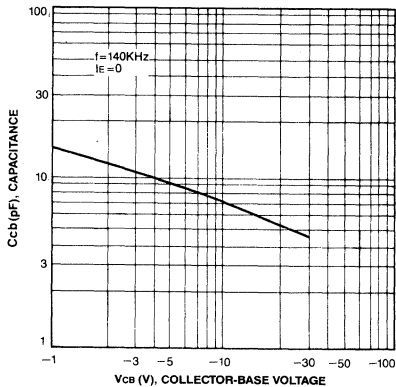
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



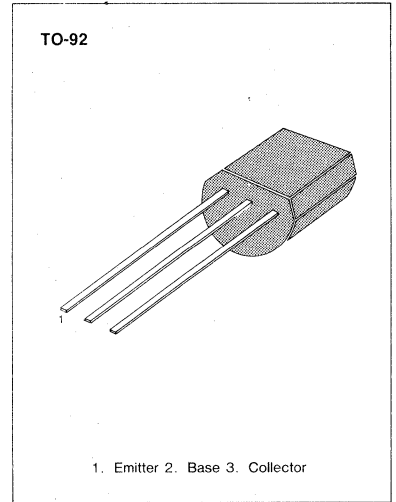
3

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 50V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-3	V
Collector Current	I_C	-50	mA
Collector Dissipation	P_C	-625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

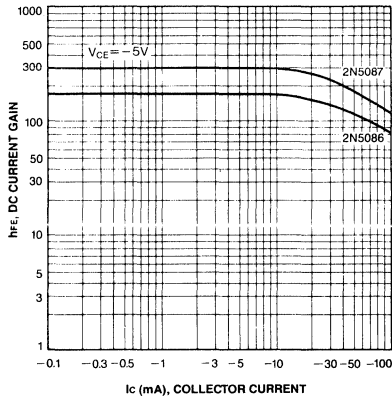


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

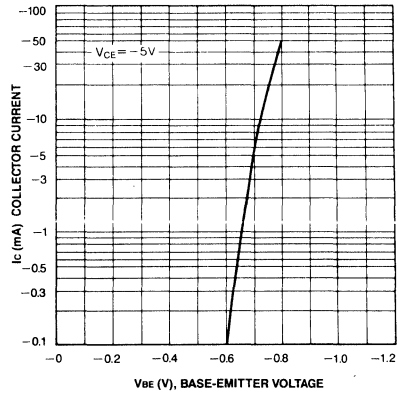
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -10V, I_E = 0$ $V_{CB} = -35V, I_E = 0$			-10 -50	nA nA
Base Cut-off Current	I_{EBO}	$V_{BE} = -3V, I_C = 0$			-50	nA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -100\mu A$	150		500	
	2N5086		250		800	
	2N5087	$V_{CE} = -5V, I_C = -1mA$	150			
	2N5087		250			
	2N5086	* $V_{CE} = -5V, I_C = -10mA$	150			
	2N5087		250			
Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = -10mA, I_B = -1mA$			-0.3	V
Base-Emitter On Voltage	$V_{BE} (on)$	$I_C = -1mA, V_{CE} = -5V$			-0.85	V
Collector-Base Capacitance	C_{CB}	$V_{CB} = -5V, I_E = 0$ $f = 100KHz$			4	pF
Current Gain bandwidth Product	f_T	$V_{CE} = -5V, I_C = -500\mu A$ $f = 20MHz$	40			MHz
Noise Figures	N_F	$V_{CE} = -5V, I_C = -20\mu A$ $R_S = 10K\Omega$ $f = 10Hz$ to 15.7KHz				
	2N5086				3	dB
	2N5087				2	dB
	2N5086	$V_{CE} = -5V, I_C = -100\mu A$ $R_S = 3K\Omega, f = 1KHz$			3	dB
	2N5087				2	dB

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

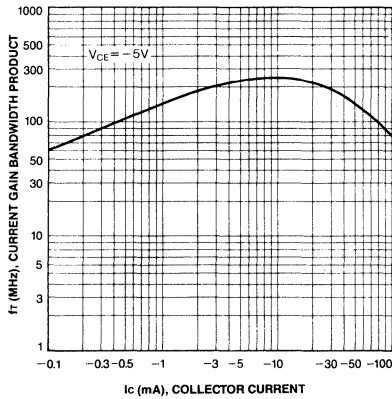
DC CURRENT GAIN



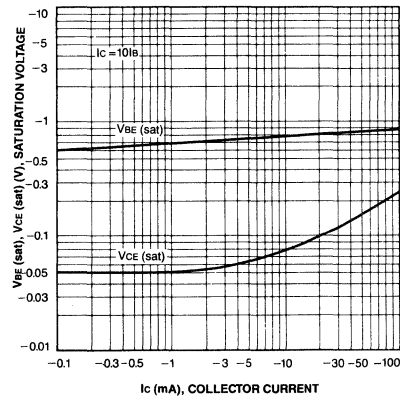
BASE-EMITTER ON VOLTAGE



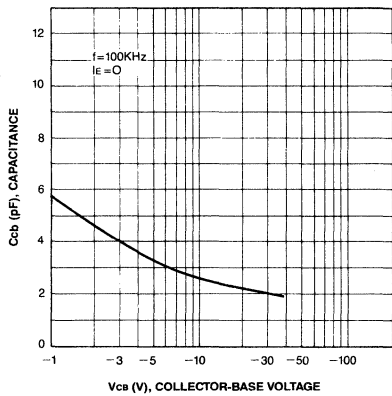
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



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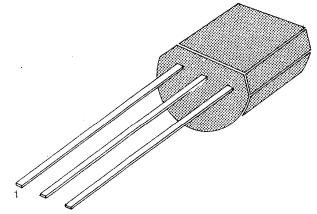
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 2N5088: 30V$
 $2N5089: 25V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage :2N5088	V_{CBO}	30	V
2N5089		30	V
Collector-Emitter Voltage :2N5088	V_{CEO}	25	V
2N5089		4.5	V
Emitter-Base Voltage	V_{EBO}	50	mA
Collector Current	I_C	625	mW
Collector Dissipation	P_C	150	$^\circ C$
Junction Temperature	T_J	-55~150	$^\circ C$
Storage Temperature	T_{STG}		

TO-92



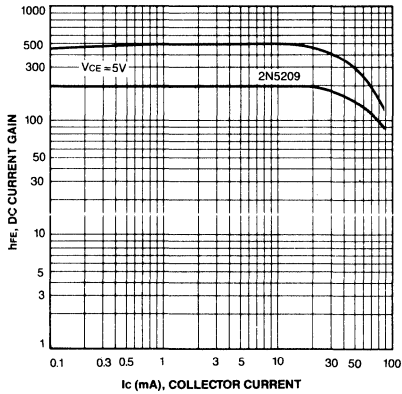
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

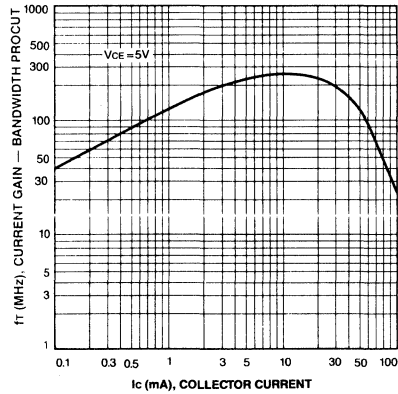
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Base Breakdown Voltage :2N5088	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	35			V
2N5089			30			V
*Collector-Emitter Breakdown Voltage :2N5088	BV_{CEO}	$I_C = 1mA, I_B = 0$	30			V
2N5089			25			V
Collector Cut-off Current :2N5088	I_{CBO}	$V_{CB} = 20V, I_E = 0$			50	nA
2N5089		$V_{CB} = 15V, I_E = 0$			50	nA
Base Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
		$V_{BE} = 4.5V, I_C = 0$			100	nA
DC Current Gain :2N5088	h_{FE}	$V_{CE} = 5V, I_C = 100\mu A$	300		900	
2N5089			400		1,200	
2N5088		$V_{CE} = 5V, I_C = 1mA$	350			
2N5089			450			
2N5088		* $V_{CE} = 5V, I_C = 10mA$	300			
2N5089			400			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.5	V
*Base-Emitter Saturation Voltage	$V_{BE(on)}$	$I_C = 10mA, V_{CE} = 5V$			0.8	V
Collector-Base Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 100KHz$			4	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 5V, I_C = 500\mu A$ $f = 20MHz$	50			MHz
Noise Figure	N_F	$V_{CE} = 5V, I_C = 100\mu A$ $R_S = 10K\Omega$ $f = 10Hz$ to $15.7KHz$			3	dB
:2N5088					2	dB
2N5089						

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

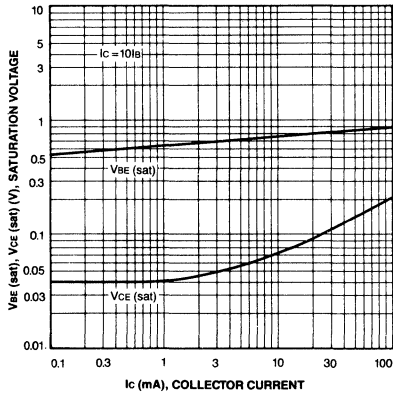
DC CURRENT GAIN



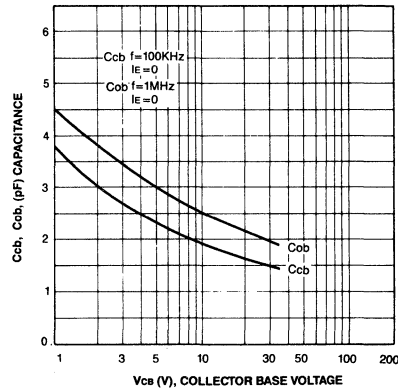
CURRENT GAIN BANDWIDTH PRODUCT



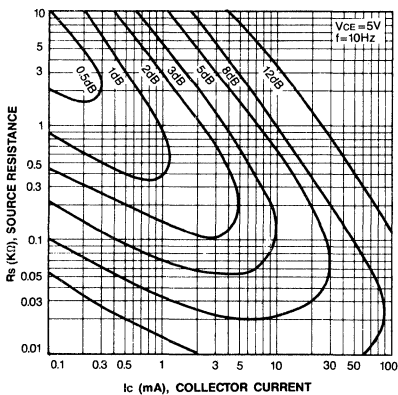
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE
COLLECTOR-BASE CAPACITANCE



NOISE FIGURE



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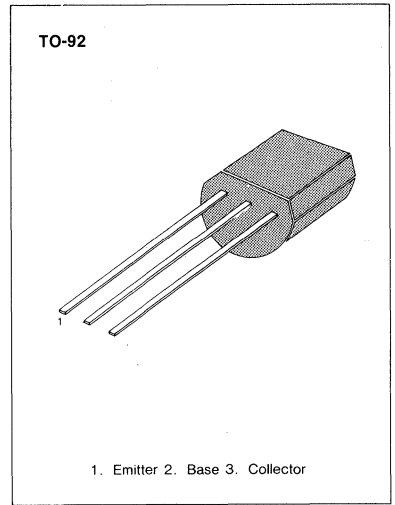
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 50V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N5088 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 35V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 100\mu A$	100		300	
	:2N5029		200		600	
	2N5210		150			
	2N5209	$V_{CE} = 5V, I_C = 1mA$	250			
	2N5210		150			
	2N5209	* $V_{CE} = 5V, I_C = 10mA$	250			
	2N5210					
Collector-Emitter Saturation Voltage	$V_{CE} (sat)$	$I_C = 10mA, I_B = 1mA$			0.7	V
Base-Emitter On Voltage	$V_{BE} (on)$	$I_C = 1mA, V_{CE} = 5V$			0.85	V
Collector-Base Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 100KHz$			4	pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 5V, I_C = 500\mu A$ $f = 20MHz$	30			MHz
Noise Figure	N_F	$V_{CE} = 5V, I_C = 20\mu A$ $R_S = 22K\Omega$ $f = 10Hz$ to $15.7KHz$			3	dB
	:2N5209				2	dB
	2N5210					
	2N5209	$V_{CE} = 5V, I_C = 20\mu A$ $R_S = 10K\Omega, f = 1KHz$			4	dB
	2N5210				3	dB

*Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

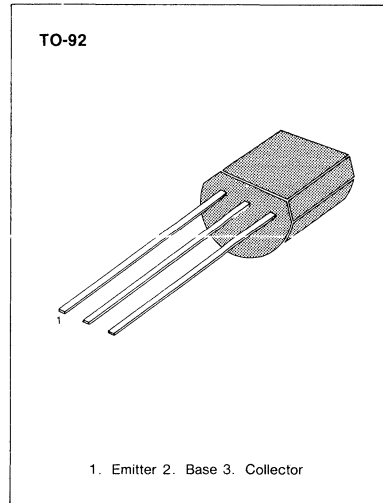
AMPLIFIER TRANSISTOR

- Collector-Base Voltage: $V_{CE0} = 120V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-130	V
Collector-Emitter Voltage	V_{CEO}	-120	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to 2N5401 for graphs



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-130			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-120			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -100V, I_E = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			-50	nA
*DC Current Gain	h_{FE}	$I_C = -1mA, V_{CE} = -5V$	30			
		$I_C = -10mA, V_{CE} = -5V$	40		180	
		$I_C = -50mA, V_{CE} = -5V$	40			
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.2	V
		$I_C = -50mA, I_B = -5mA$			-0.5	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -1mA$			-1	V
		$I_C = -50mA, I_B = -5mA$			-1	V
Current Gain Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -10V$ $f = 100MHz$	100		400	MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = -250\mu A, V_{CE} = -5V$ $R_S = 1K\Omega$ $f = 10Hz$ to $15.7KHz$			8	dB

* Pulse Test: Pulse Width= 300 μs , Duty Cycle=2%

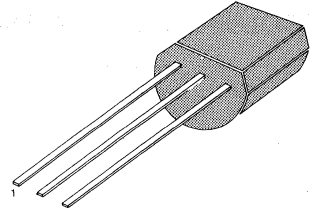
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 150V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-160	V
Collector-Emitter Voltage	V_{CEO}	-150	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

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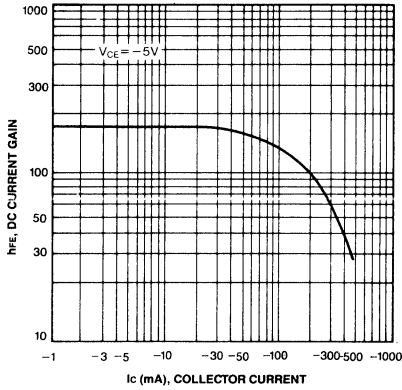
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

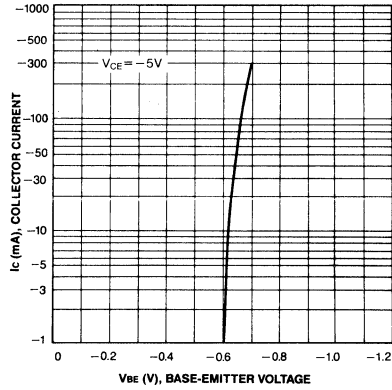
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-160			V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -120V, I_E = 0$			-50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			-50	nA
* DC Current Gain	h_{FE}	$I_C = -1mA, V_{CE} = -5V$	30			
		$I_C = -10mA, V_{CE} = -5V$	60		240	
		$I_C = -50mA, V_{CE} = -5V$	50			
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.2	V
		$I_C = -50mA, I_B = -5mA$			-0.5	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -1mA$			-1	V
		$I_C = -50mA, I_B = -5mA$			-1	V
Current Gain Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -10V$ $f = 100MHz$	100		400	MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = -250\mu A, V_{CE} = -5V$ $R_S = 1K\Omega$ $f = 10Hz \text{ to } 15.7KHz$			8	dB

* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

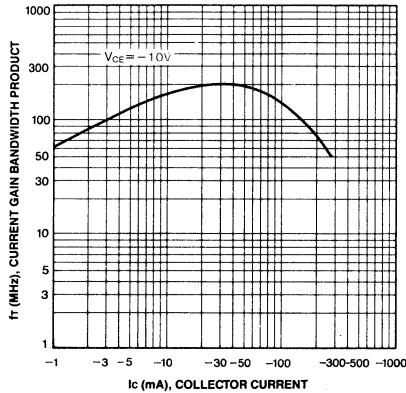
DC CURRENT GAIN



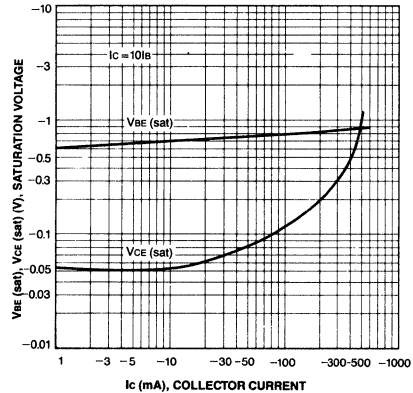
BASE-EMITTER ON VOLTAGE



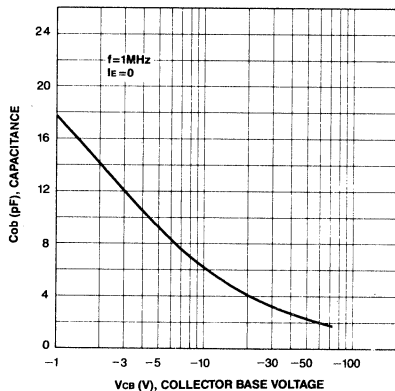
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



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AMPLIFIER TRANSISTOR

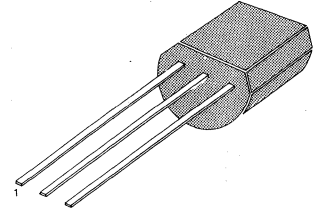
- Collector-Emitter Voltage: $V_{CE0} = 140V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CE0}	140	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N5551 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	160			V
*Collector-Emitter Saturation Voltage	BV_{CE0}	$I_C = 1mA, I_B = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 100V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 5V$	60			
		$I_C = 10mA, V_{CE} = 5V$	60		250	
		$I_C = 50mA, V_{CE} = 5V$	20			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.15	V
		$I_C = 50mA, I_B = 5mA$			0.25	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10mA, I_B = 1mA$			1	V
		$I_C = 50mA, I_B = 5mA$			1.2	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$ $f = 100MHz$	100		300	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = 250\mu A, V_{CE} = 5V$ $R_S = 1K\Omega$ $f = 10Hz \text{ to } 15.7KHz$			10	dB

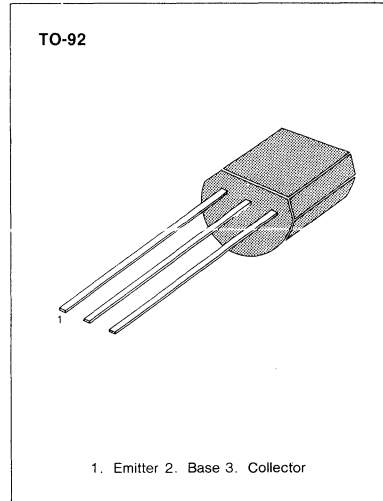
- *Pulse Test: Pulse Width=300 μ S, Duty Cycle=2%

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 160V$
- Collector Dissipation: $P_C(max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	180	V
Collector-Emitter Voltage	V_{CEO}	160	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

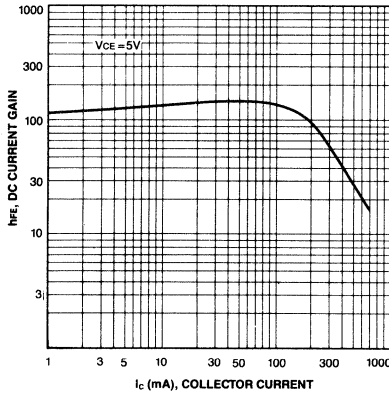


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

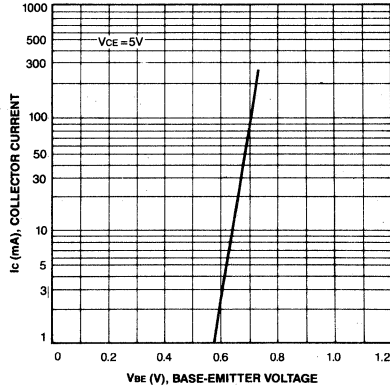
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	180			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	160			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 120V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 5V$	80			
		$I_C = 10mA, V_{CE} = 5V$	80		250	
		$I_C = 50mA, V_{CE} = 5V$	30			
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.15	V
		$I_C = 50mA, I_B = 5mA$			0.2	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10mA, I_B = 1mA$			1	V
		$I_C = 50mA, I_B = 5mA$			1	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$ $f = 100MHz$	100		300	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = 250\mu A, V_{CE} = 5V$ $R_S = 1K\Omega$ $f = 10Hz$ to $15.7KHz$			8	dB

*Pulse Test: Pulse Width=300 μ S, Duty Cycle=2%

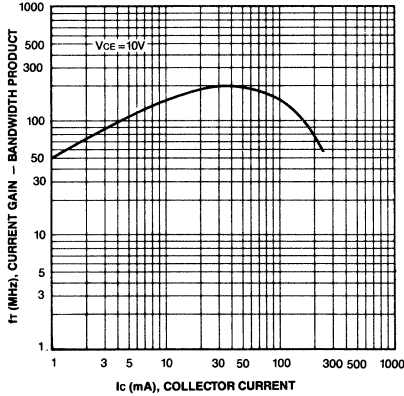
DC CURRENT GAIN



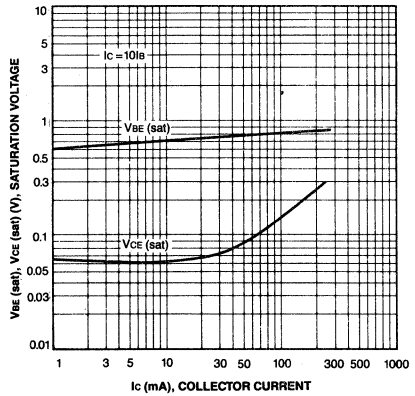
BASE-EMITTER ON VOLTAGE



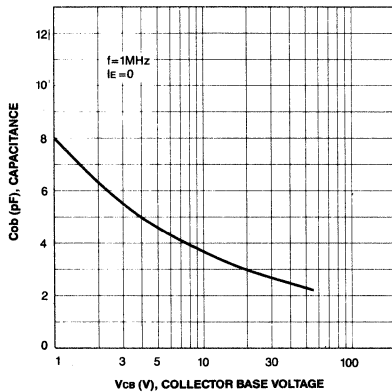
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

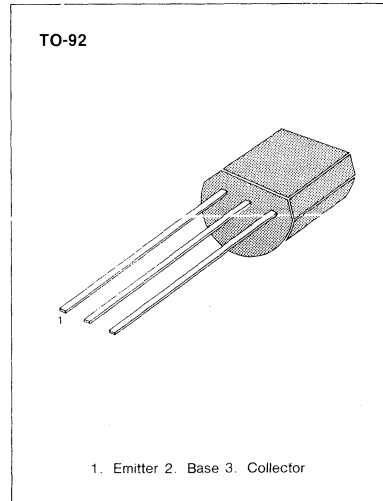


DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	40	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	12	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

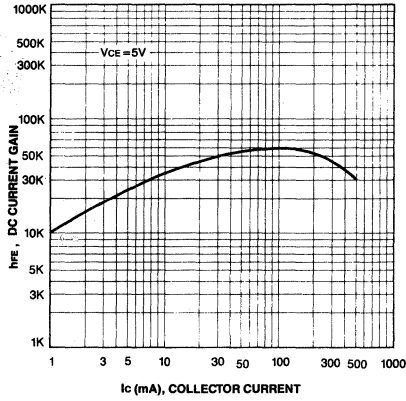


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

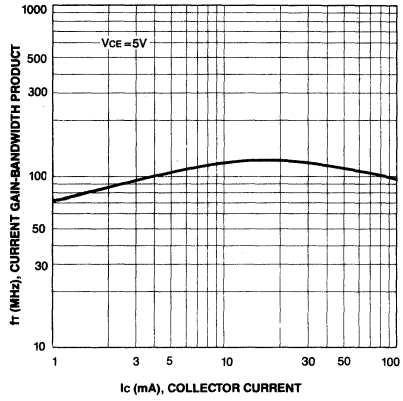
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 10mA, I_B = 0$	40			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	12			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			50	nA
Collector Cut-off Current	I_{CEO}	$V_{CE} = 25V, I_B = 0$			1	μA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	10K		100K	
		$I_C = 100mA, V_{CE} = 5V$	20K		200K	
		$I_C = 500mA, V_{CE} = 5V$	14K		140K	
Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_C = 50mA, I_B = 0.5mA$		0.71	1.2	V
		$I_C = 500mA, I_B = 0.5mA$		0.9	1.5	V
Base-Emitter Saturation Voltage	$V_{BE (sat)}$	$I_C = 500mA, I_B = 0.5mA$		1.52	2	V
Base-Emitter On Voltage	$V_{BE (on)}$	$I_C = 50mA, V_{CE} = 5V$		1.24	1.75	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		5.4	7	pF
Noise Figure	NF	$I_C = 1mA, V_{CE} = 5V$ $R_S = 100K\Omega$ $f = 10KHz \text{ to } 15.7 KHz$		3	10	dB

* Pulse Test: Pulse Width = 300 μ S, Duty Cycle = 2%

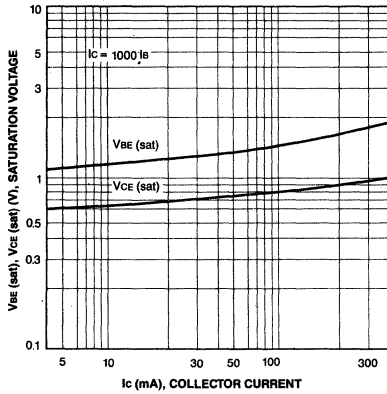
DC CURRENT GAIN



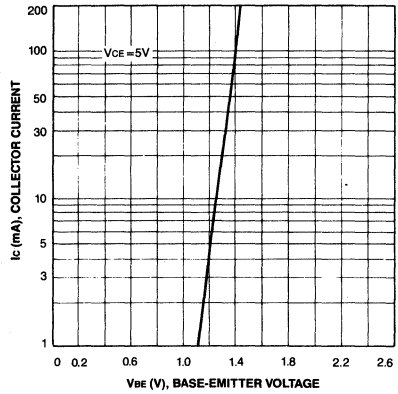
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



BASE-EMITTER ON VOLTAGE



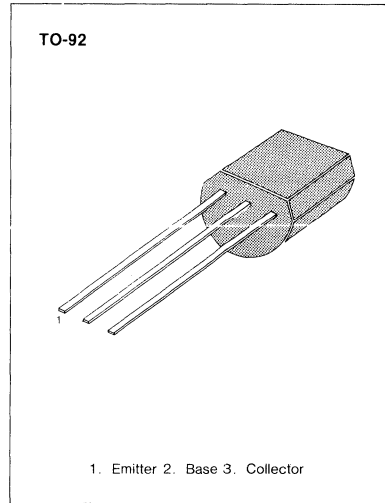
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 50V$
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N5088 for graphs



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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			10	nA
Collector Cut-off Current	I_{CEO}	$V_{CE} = 30V, I_B = 0$			25	nA
Base Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			10	nA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 10\mu A$	250			
		$V_{CE} = 5V, I_C = 100\mu A$	250		650	
		$V_{CE} = 5V, I_C = 1mA$	250			
		$V_{CE} = 5V, I_C = 10mA$	250			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$			0.2	V
		$I_C = 100mA, I_B = 5mA$			0.6	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 1mA, V_{CE} = 5V$	0.56		0.66	V
Output Capacitance	C_{OB}	$V_{CB} = 10V, I_E = 0$			3	pF
		$f = 1MHz$				
Current Gain Bandwidth Product	f_T	$V_{CE} = 5V, I_C = 1mA$	100		700	MHz
		$f = 100MHz$				
Noise Figure/Noise Voltage Level	N_F/N_V	$V_{CE} = 5V, I_C = 100\mu A$				
		(1) $R_S = 10K\Omega, B_W = 1Hz$				
		$f = 100Hz$				
	:2N6428				3/18.1	dB/nV
	2N6428A				2/16.2	dB/nV
		(2) $R_S = 50K\Omega, B_W = 15.7KHz$				
		$f = 10Hz - 10KHz$				
	2N6428				6/5.7	dB/nV
	2N6428A				4/4.6	dB/nV
		(3) $R_S = 500\Omega, B_W = 1Hz$				
		$f = 10Hz$				
	2N6428				3.5/4.3	dB/nV
	2N6428A				3/4.1	dB/nV

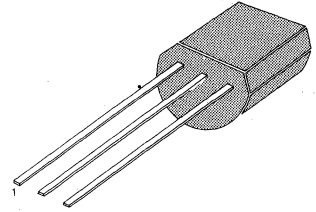
HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 250V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	250	V
Collector-Emitter Voltage	V_{CEO}	250	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



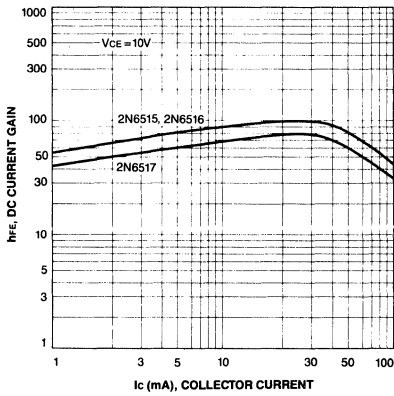
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

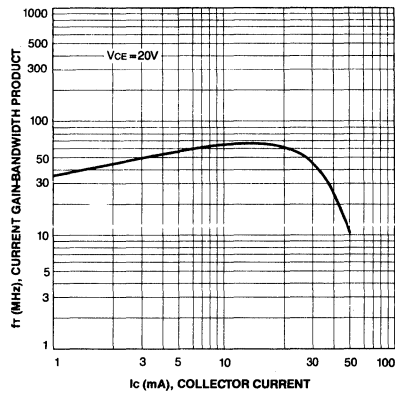
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	250			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	250			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 150V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 10V$	35			
		$I_C = 10mA, V_{CE} = 10V$	50			
		$I_C = 30mA, V_{CE} = 10V$	50		300	
		$I_C = 50mA, V_{CE} = 10V$	45		220	
		$I_C = 100mA, V_{CE} = 10V$	25			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.3	V
		$I_C = 20mA, I_B = 2mA$			0.35	V
		$I_C = 30mA, I_B = 3mA$			0.5	V
		$I_C = 50mA, I_B = 5mA$			1	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.75	V
		$I_C = 20mA, I_B = 2mA$			0.85	V
		$I_C = 30mA, I_B = 3mA$			0.9	V
Collector-Base Capacitance	C_{cb}	$V_{CB} = 20V, I_E = 0$			6	pF
*Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 20V$ $f = 20MHz$	40		200	MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100mA, V_{CE} = 10V$			2	V

* Pulse Test: Pulse Width=300 μ S, Duty Cycle=2%

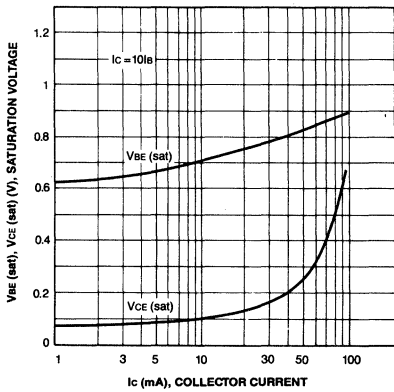
DC CURRENT GAIN



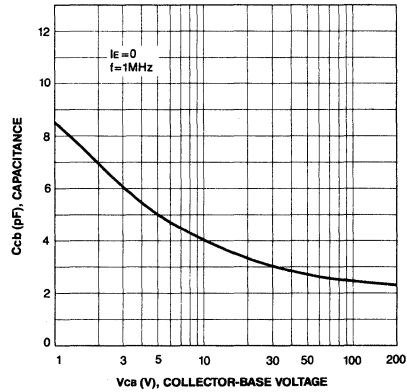
CURRENT GAIN BANDWIDTH PRODUCT



COLLECTOR EMITTER SATURATION VOLTAGE
BASE EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



3

HIGH VOLTAGE TRANSISOTR

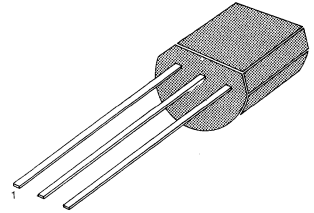
- Collector-Emitter Voltage: $V_{CE0} = 300V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N6515 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	300			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			50	nA
* DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 10V$	30			
		$I_C = 10mA, V_{CE} = 10V$	45			
		$I_C = 30mA, V_{CE} = 10V$	45		270	
		$I_C = 50mA, V_{CE} = 10V$	40		200	
		$I_C = 100mA, V_{CE} = 10V$	20			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.3	V
		$I_C = 20mA, I_B = 2mA$			0.35	V
		$I_C = 30mA, I_B = 3mA$			0.5	V
		$I_C = 50mA, I_B = 5mA$			1	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.75	
		$I_C = 20mA, I_B = 2mA$			0.85	
		$I_C = 30mA, I_B = 3mA$			0.9	
Collect-Base Capacitance	C_{cb}	$V_{CB} = 20V, I_E = 0$			6	pF
		$f = 1MHz$				
* Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 20V$	40		200	MHz
		$f = 20MHz$				
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100mA, V_{CE} = 10V$			2	v

* Pulse Test: Pulse Width= 300 μs , Duty Cycle= 2%

HIGH VOLTAGE TRANSISOTR

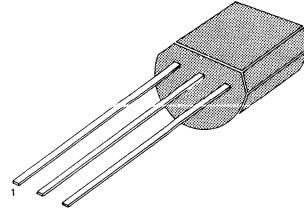
- Collector-Emitter Voltage: $V_{CEO}=350V$
- Collector Dissipation: $P_C(\text{max})=625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	350	V
Collector-Emitter Voltage	V_{CEO}	350	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N6515 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	350			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	350			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu A, I_C=0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=250V, I_E=0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=5V, I_C=0$			50	nA
* DC Current Gain	h_{FE}	$I_C=1mA, V_{CE}=10V$	20			
		$I_C=10mA, V_{CE}=10V$	30			
		$I_C=30mA, V_{CE}=10V$	30		200	
		$I_C=50mA, V_{CE}=10V$	20		200	
		$I_C=100mA, V_{CE}=10V$	15			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
		$I_C=20mA, I_B=2mA$			0.35	V
		$I_C=30mA, I_B=3mA$			0.5	V
		$I_C=50mA, I_B=5mA$			1	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=10mA, I_B=1mA$			0.75	V
		$I_C=20mA, I_B=2mA$			0.85	V
		$I_C=30mA, I_B=3mA$			0.9	V
Collect-Base Capacitance	C_{cb}	$V_{CB}=20V, I_E=0$			6	pF
		$f=1MHz$				
* Current Gain Bandwidth Product	f_T	$I_C=10mA, V_{CE}=20V$	40		200	MHz
		$f=20MHz$				
Base Emitter On Voltage	$V_{BE(on)}$	$I_C=100mA, V_{CE}=10V$			2	V

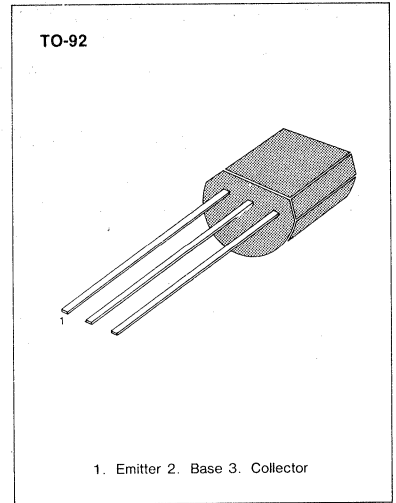
* Pulse Test: Pulse Width= 300 μs , Duty Cycle=2%

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-250	V
Collector-Emitter Voltage	V _{CEO}	-250	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-500	mA
Base Current	I _B	-250	mA
Collector Dissipation	P _C	0.625	W
Derate above 25°C		5	mW/°C
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C

• Refer to 2N6520 for graphs



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

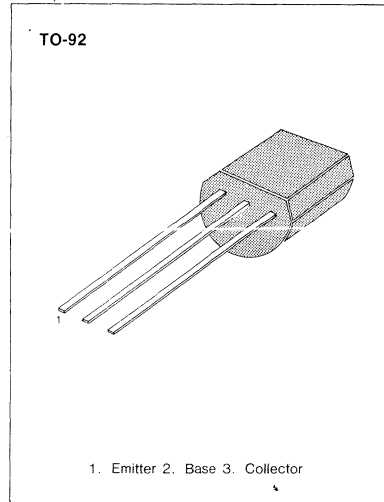
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltg	BV _{CBO}	I _C = -100μA, I _E = 0	-250		V
*Collector Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _B = 0	-250		V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CBO}	V _{CB} = -150V, I _E = 0		-50	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = -4V, I _C = 0		-50	nA
*DC Current Gain	h _{FE}	V _{CE} = -10V, I _C = -1mA	35		
		V _{CE} = -10V, I _C = -10mA	50		
		V _{CE} = -10V, I _C = -30mA	50	300	
		V _{CE} = -10V, I _C = -50mA	45	220	
		V _{CE} = -10V, I _C = -100mA	25		
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -10mA, I _B = -1mA		-0.30	V
		I _C = -20mA, I _B = -2mA		-0.35	V
		I _C = -30mA, I _B = -3mA		-0.50	V
		I _C = -50mA, I _B = -5mA		-1	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = -10mA, I _B = -1mA		-0.75	V
		I _C = -20mA, I _B = -2mA		-0.85	V
		I _C = -30mA, I _B = -3mA		-0.90	V
Base Emitter On Voltage	V _{BE (on)}	V _{CE} = -10V, I _C = -100mA		-2	V
*Current Gain Bandwidth Product	f _T	V _{CE} = -20V, I _C = -10mA, f = 20MHz	40	200	MHz
Collector Base Capacitance	C _{cb}	V _{CB} = -20V, I _E = 0, f = 1MHz		6	pF
Emitter Base Capacitance	C _{eb}	V _{EB} = -0.5V, I _C = 0, f = 1MHz		100	pF
Turn On Time	ton	V _{BE (off)} = -2V, V _{CC} = -100V I _C = -50mA, I _{B1} = -10mA		200	ns
Turn Off Time	toff	V _{CC} = -100V, I _C = -50mA I _{B1} = I _{B2} = -10mA		3.5	ns

* Pulse Test: PW=300μs, Duty Cycle=2%

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-300	V
Collector-Emitter Voltage	V _{CEO}	-300	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-500	mA
Base Current	I _B	-250	mA
Collector Dissipation	P _C	0.625	W
Derate above 25°C		5	mW/°C
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



• Refer to 2N6520 for graphs

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltag	BV _{CBO}	I _C = -100μA, I _E = 0	-300		V
* Collector Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _B = 0	-300		V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CBO}	V _{CB} = -200V, I _E = 0		-50	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = -4V, I _C = 0		-50	nA
* DC Current Gain	h _{FE}	V _{CE} = -10V, I _C = -1mA	30		
		V _{CE} = -10V, I _C = -10mA	45		
		V _{CE} = -10V, I _C = -30mA	45	270	
		V _{CE} = -10V, I _C = -50mA	40	200	
		V _{CE} = -10V, I _C = -100mA	20		
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -10mA, I _B = -1mA		-0.30	V
		I _C = -20mA, I _B = -2mA		-0.35	V
		I _C = -30mA, I _B = -3mA		-0.50	V
		I _C = -50mA, I _B = -5mA		-1	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = -10mA, I _B = -1mA		-0.75	V
		I _C = -20mA, I _B = -2mA		-0.85	V
		I _C = -30mA, I _B = -3mA		-0.90	V
Base Emitter On Voltage	V _{BE (on)}	V _{CE} = -10V, I _C = -100mA		-2	V
* Current Gain Bandwidth Product	f _T	V _{CE} = -20V, I _C = -10mA, f = 20MHz	40	200	MHz
Collector Base Capacitance	C _{cb}	V _{CB} = -20V, I _E = 0, f = 1MHz		6	pF
Emitter Base Capacitance	C _{eb}	V _{EB} = -0.5V, I _C = 0, f = 1MHz		100	pF
Turn On Time	ton	V _{BE (off)} = -2V, V _{CC} = -100V		200	ns
		I _C = -50mA, I _{B1} = -10mA			
Turn Off Time	toff	V _{CC} = -100V, I _C = -50mA		3.5	ns
		I _{B1} = I _{B2} = -10mA			

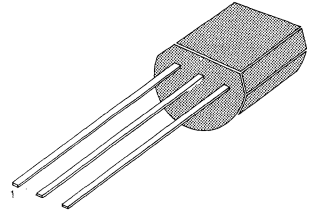
* Pulse Test: PW=300μs, Duty Cycle=2%

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-350	V
Collector-Emitter Voltage	V_{CEO}	-350	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Base Current	I_B	-250	mA
Collector Dissipation	P_C	0.625	W
Derate above 25°C		5	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

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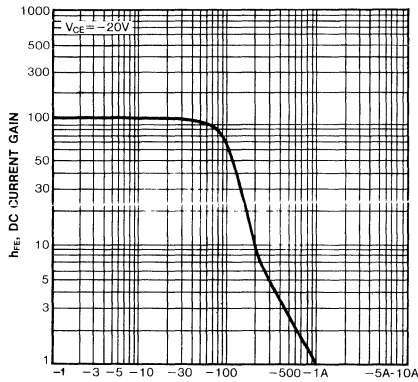
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-350		V
* Collector Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-350		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -250\text{V}, I_E = 0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -4\text{V}, I_C = 0$		-50	nA
* DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -1\text{mA}$	20		
		$V_{CE} = -10\text{V}, I_C = -10\text{mA}$	30		
		$V_{CE} = -10\text{V}, I_C = -30\text{mA}$	30	200	
		$V_{CE} = -10\text{V}, I_C = -50\text{mA}$	20	200	
		$V_{CE} = -10\text{V}, I_C = -100\text{mA}$	15		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}, I_B = -1\text{mA}$		-0.30	V
		$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.35	V
		$I_C = -30\text{mA}, I_B = -3\text{mA}$		-0.50	V
		$I_C = -50\text{mA}, I_B = -5\text{mA}$		-1	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10\text{mA}, I_B = -1\text{mA}$		-0.75	V
		$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.85	V
		$I_C = -30\text{mA}, I_B = -3\text{mA}$		-0.90	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -10\text{V}, I_C = -100\text{mA}$		-2	V
* Current Gain Bandwidth Product	f_T	$V_{CE} = -20\text{V}, I_C = -10\text{mA}, f = 20\text{MHz}$	40	200	MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = -20\text{V}, I_E = 0, f = 1\text{MHz}$		6	pF
Emitter Base Capacitance	C_{eb}	$V_{EB} = -0.5\text{V}, I_C = 0, f = 1\text{MHz}$		100	pF
Turn On Time	t_{on}	$V_{BE(off)} = -2\text{V}, V_{CC} = -100\text{V}$ $I_C = -50\text{mA}, I_{B1} = -10\text{mA}$		200	ns
Turn Off Time	t_{off}	$V_{CC} = -100\text{V}, I_C = -50\text{mA}$ $I_{B1} = I_{B2} = -10\text{mA}$		3.5	ns

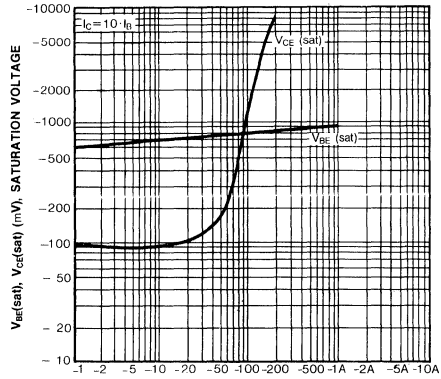
* Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

DC CURRENT GAIN



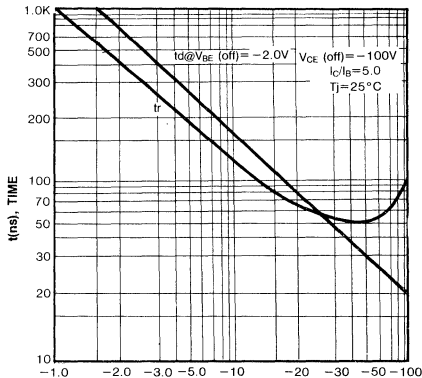
I_C (mA), COLLECTOR CURRENT

BASE EMITTER SATURATION VOLTAGE
COLLECTOR - EMITTER SATURATION VOLTAGE



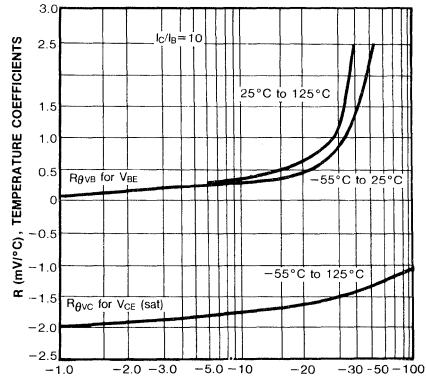
I_C (mA), COLLECTOR CURRENT

TURN-ON TIME



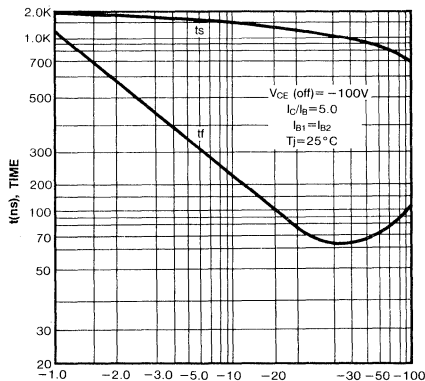
I_C (mA), COLLECTOR CURRENT

TEMPERATURE COEFFICIENTS



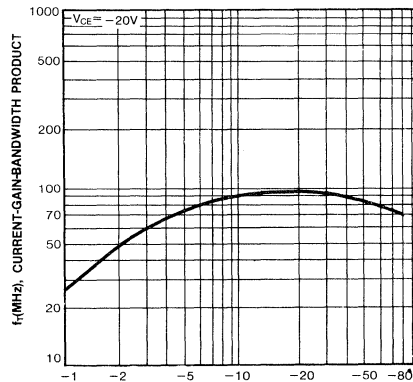
I_C (mA), COLLECTOR CURRENT

TURN-OFF TIME



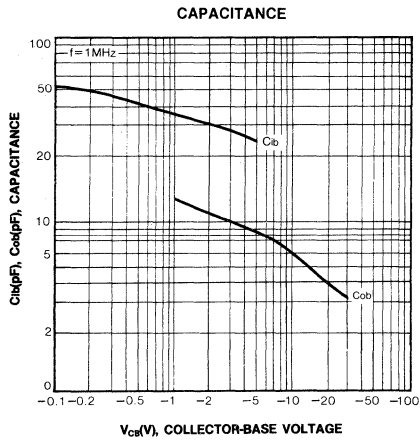
I_C (mA), COLLECTOR CURRENT

CURRENT GAIN-BANDWIDTH PRODUCT



I_C (mA), COLLECTOR CURRENT

3

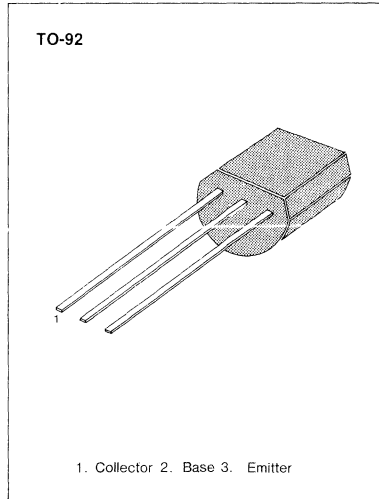


SWITCHING AND AMPLIFIER APPLICATIONS

• LOW NOISE: BC239

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage :BC237 :BC238/239	V _{CES}	50 30	V V
Collector-Emitter Voltage :BC237 :BC238/239	V _{CEO}	45 25	V V
Emitter-Base Voltage :BC237 :BC238/239	V _{EBO}	6 5	V V
Collector Current (DC)	I _C	100	mA
Collector Dissipation	P _C	500	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



3

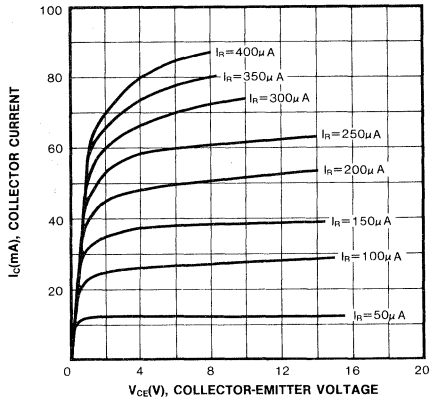
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage :BC237 :BC238/239	BV _{CEO}	I _C =2mA, I _B =0	45 25			V V
Emitter Base Breakdown Voltage :BC237 :BC238/239	BV _{EBO}	I _E =1μA, I _C =0	6 5			V V
Collector Cutoff Current :BC237 :BC238/239	I _{CES}	V _{CE} =50V, I _B =0 V _{CE} =30V, I _B =0		0.2 0.2	15 15	nA nA
DC Current Gain	h _{FE}	V _{CE} =5V, I _C =2mA	120		800	
Collector Emitter Saturation Voltage :BC237 :BC238/239	V _{CE(sat)}	I _C =10mA, I _B =0.5mA I _C =100mA, I _B =5mA		0.07 0.2	0.2 0.6	V V
Collector Base Saturation Voltage :BC237 :BC238/239	V _{BE(sat)}	I _C =10mA, I _B =0.5mA I _C =100mA, I _B =5mA		0.73 0.87	0.83 1.05	V V
Base Emitter On Voltage :BC237 :BC238/239	V _{BE(on)}	V _{CE} =5V, I _C =2mA V _{CE} =3V, I _C =0.5mA, f=100MHz	0.55	0.62 85	0.7	V MHz
Current Gain Bandwidth Product :BC237 :BC238/239	f _T	V _{CE} =5V, I _C =10mA, f=100MHz	150	250		MHz
Collector Base Capacitance	C _{CB0}	V _{CB} =10V, f=1MHz		3.5	6	pF
Emitter Base Capacitance	C _{EB0}	V _{EB} =0.5V, f=1MHz		8		pF
Noise Figure :BC237/238 :BC239	NF	V _{CE} =5V, I _C =0.2mA, f=1KHz R _g =2kohm		2	10	dB
:BC239	NF	V _{CE} =5V, I _C =0.2mA, R _g =2kohm, f=30~15KHz			4	dB

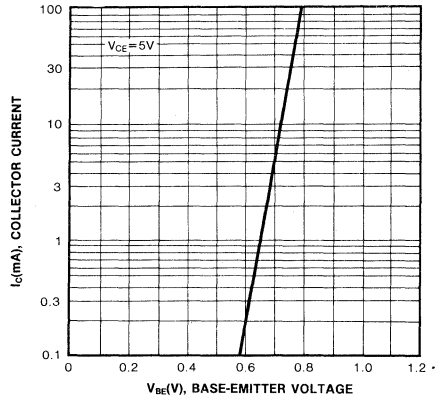
h_{FE} CLASSIFICATION

Classification	A	B	C
h _{FE}	120-220	180-460	380-800

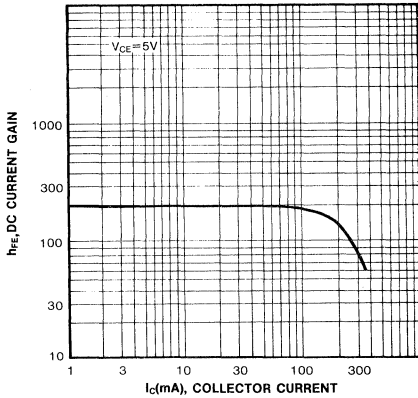
STATIC CHARACTERISTIC



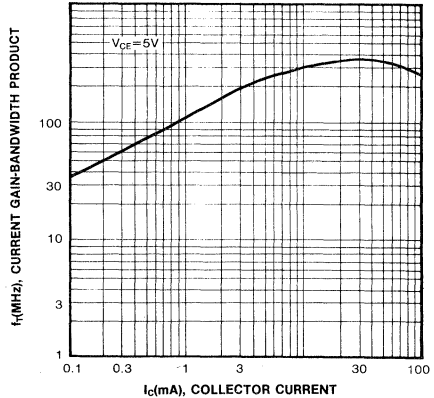
TRANSFER CHARACTERISTIC



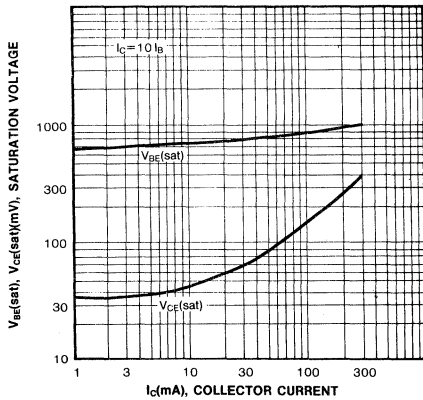
DC CURRENT GAIN



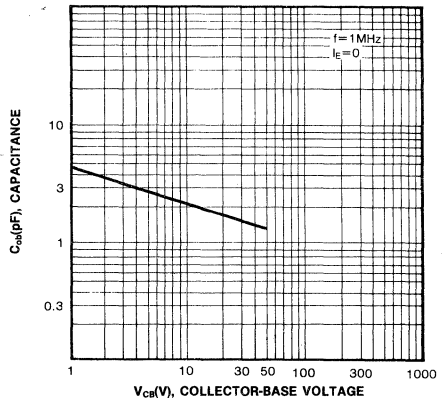
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



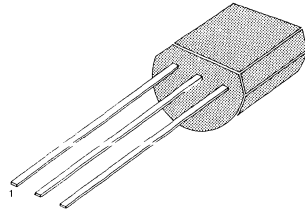
SWITCHING AND AMPLIFIER APPLICATIONS

• LOW NOISE: BC309

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V _{CES}		
:BC307		-50	V
:BC308/309		-30	V
Collector-Emitter Voltage	V _{CEO}		
:BC307		-45	V
:BC308/309		-25	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current (DC)	I _c	-100	mA
Collector Dissipation	P _c	500	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C

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1. Collector 2. Base 3. Emitter

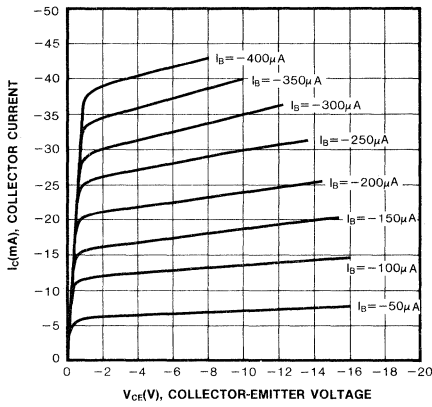
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage	BV _{CEO}	I _c = -2mA, I _B = 0				
:BC307			-45			V
:BC308/309			-25			V
Collector Emitter Breakdown Voltage	BV _{CES}	I _c = -10μA, I _B = 0				
:BC307			-50			V
:BC308/309			-30			V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5			V
Collector Cutoff Current	I _{CES}					
:BC307		V _{CE} = -45V, I _B = 0		-2	-15	nA
:BC308/309		V _{CE} = -25V, I _B = 0		-2	-15	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -2mA	120		800	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -0.5mA			-0.3	V
		I _C = -100mA, I _B = -5mA		-0.5		V
Collector Base Saturation Voltage	V _{BE(sat)}	I _C = -10mA, I _B = -0.5mA		-0.7		V
		I _C = -100mA, I _B = -5mA		-0.85		V
Base Emitter On Voltage	V _{BE(on)}	V _{CE} = -5V, I _C = -2mA	-0.55	-0.62	-0.7	V
Current Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -10mA, f = 50MHz		130		MHz
Collector Base Capacitance	C _{CB0}	V _{CB} = -10V, f = 1MHz			6	pF
Emitter Base Capacitance	C _{EB0}	V _{EB} = -0.5V, f = 1MHz		12		pF
Noise Figure	NF	V _{CE} = -5V, I _C = -0.2mA, R _g = 2kohm, f = 1KHz			10	dB
		V _{CE} = -5V, I _C = -0.2mA, R _g = 2kohm, f = 30~15KHz			4	dB
				2	4	dB

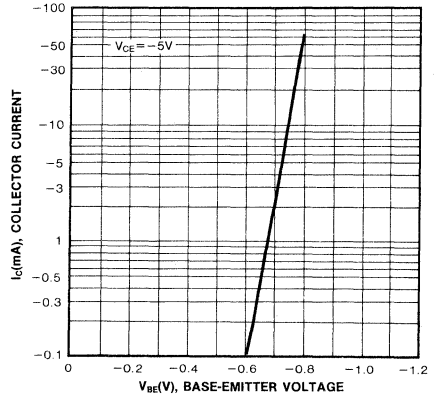
h_{FE} CLASSIFICATION

Classification	A	B	C
h _{FE}	120-220	180-460	380-800

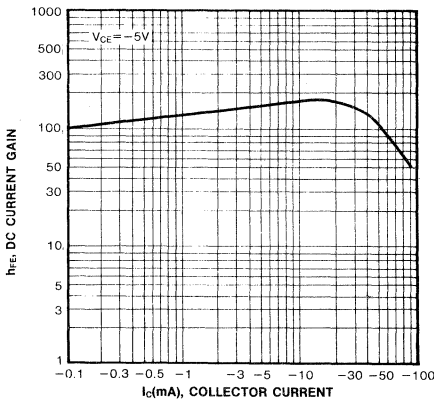
STATIC CHARACTERISTIC



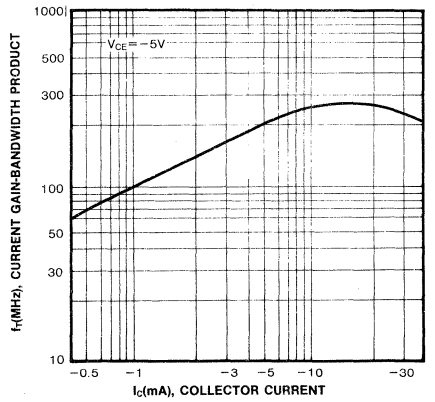
BASE-EMITTER ON VOLTAGE



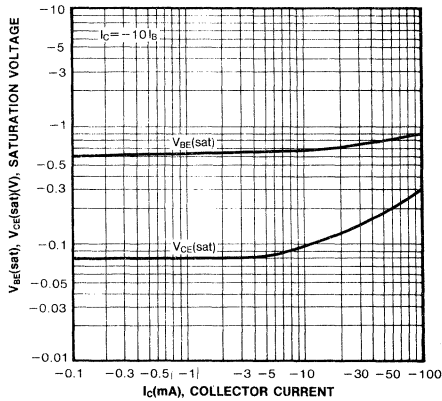
DC CURRENT GAIN



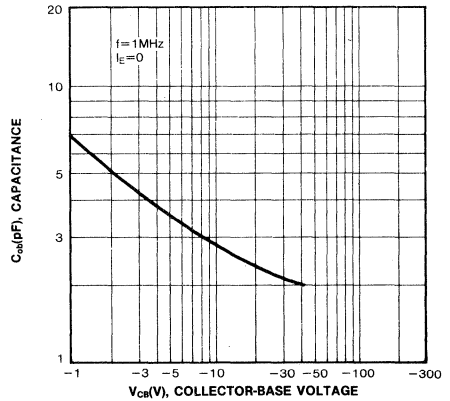
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

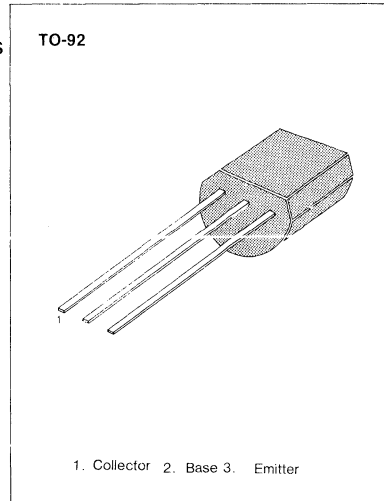


SWITCHING AND AMPLIFIER APPLICATIONS

- SUITABLE FOR AF-DRIVER STAGES AND LOW POWER OUTPUT STAGES
- Complement to BC337/BC338

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage	V _{CES}		
:BC327		-50	V
:BC328		-30	V
Collector Emitter Voltage	V _{CEO}		
:BC327		-45	V
:BC328		-25	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current (DC)	I _C	-800	mA
Collector Dissipation	P _C	625	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C

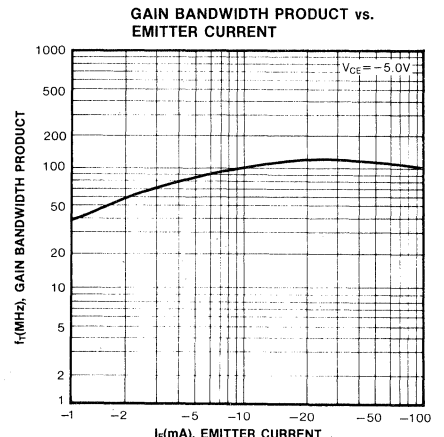
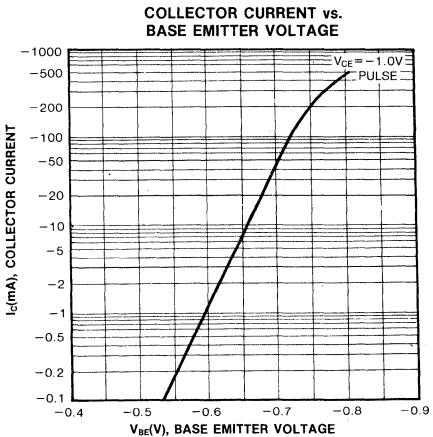
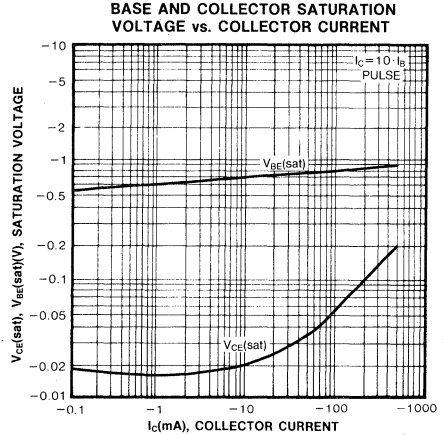
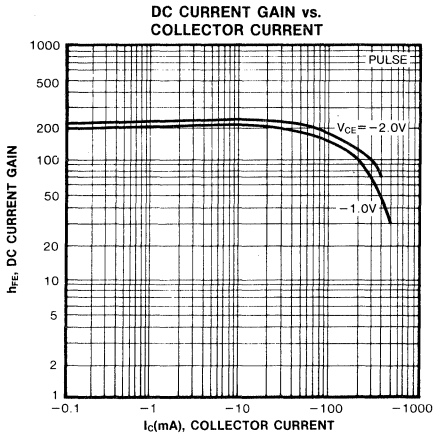
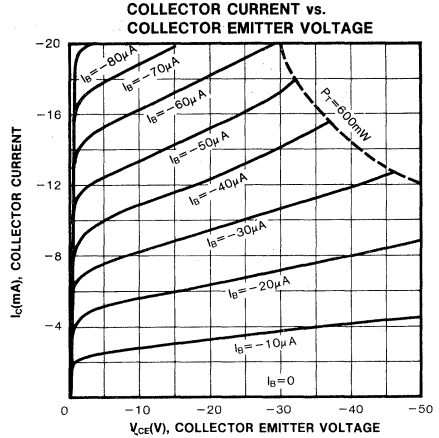
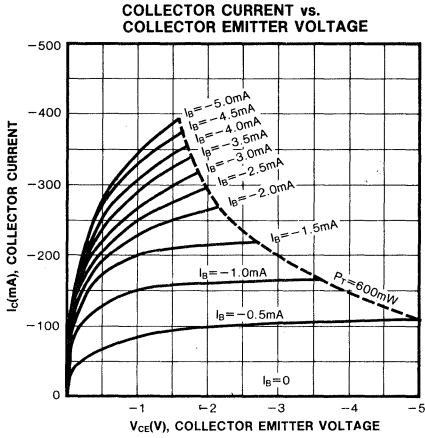


ELECTRICAL CHARACTERISTICS (T_a = 25°C)

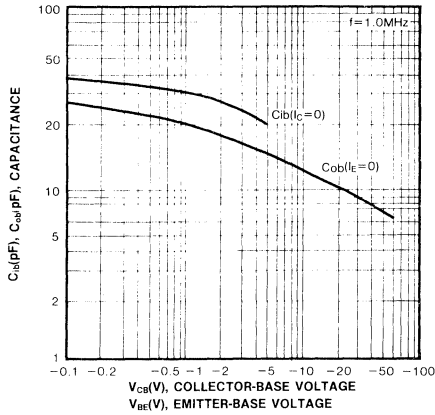
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage	BV _{CEO}	I _C = -10mA, I _B = 0	-45			V
:BC327			-25			V
:BC328						V
Collector Emitter Breakdown Voltage	BV _{CES}	I _C = -0.1mA, I _B = 0	-50			V
:BC327			-30			V
:BC328			-5			V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = -0.1mA, I _C = 0				V
Collector Cutoff Current	I _{CES}					nA
:BC327		V _{CE} = -45V, I _B = 0		-2	-100	nA
:BC328		V _{CE} = -25V, I _B = 0		-2	-100	nA
DC Current Gain	h _{FE}	V _{CE} = -1V, I _C = -100mA	100		630	
	h _{FE2}	V _{CE} = -1V, I _C = -30mA	60			
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = -500mA, I _B = -50mA			-0.7	V
Base Emitter On Voltage	V _{BE(on)}	V _{CE} = -1V, I _C = -300mA			-1.2	V
Current Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -10mA, f = 50MHz		100		MHz
Collector Base Capacitance	C _{CB0}	V _{CB} = -10V, f = 1MHz		12		pF

h_{FE} CLASSIFICATION

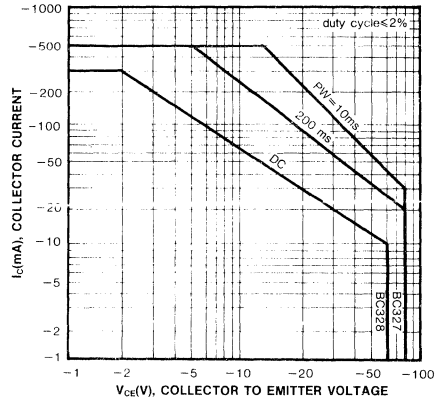
Classification	16	25	40
h _{FE}	100-250	160-400	250-630
h _{FE2}	60-	100-	170-



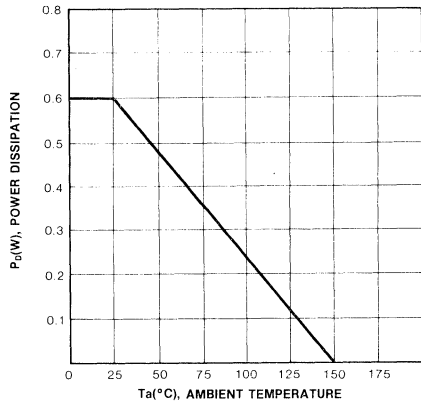
INPUT AND OUTPUT CAPACITANCE vs. REVERSE VOLTAGE



SAFE OPERATING AREA



POWER DERATING



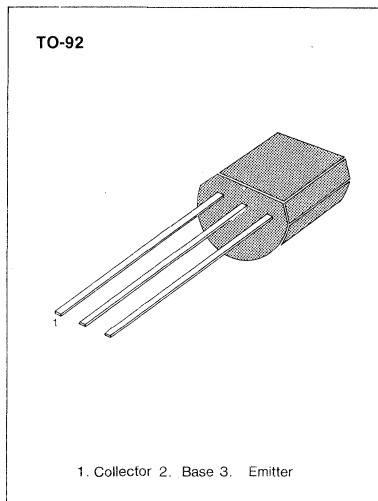
3

SWITCHING AND AMPLIFIER APPLICATIONS

- SUITABLE FOR AF-DRIVER STAGES AND LOW POWER OUTPUT STAGES
- Complement to BC327/BC328

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage	V _{CES}		
:BC337		50	V
:BC338		30	V
Collector Emitter Voltage	V _{CEO}		
:BC337		45	V
:BC338		25	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current (DC)	I _C	800	mA
Collector Dissipation	P _C	625	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage	BV _{CEO}	I _C =10mA, I _B =0				
:BC337			45			V
:BC338			25			V
Collector Emitter Breakdown Voltage	BV _{CES}	I _C =0.1mA, I _B =0				
:BC337			50			V
:BC338			30			V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E =0.1mA, I _C =0	5			V
Collector Cutoff Current	I _{CES}					
:BC337		V _{CE} =45V, I _B =0		2	100	nA
:BC338		V _{CE} =25V, I _B =0		2	100	nA
DC Current Gain	h _{FE}	V _{CE} =1V, I _C =100mA	100		630	
	h _{FE2}	V _{CE} =1V, I _C =300mA	60			
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C =500mA, I _B =50mA			0.7	V
Base Emitter On Voltage	V _{BE(on)}	V _{CE} =1V, I _C =300mA			1.2	V
Current Gain Bandwidth Product	f _T	V _{CE} =5V, I _C =10mA, f=50MHz		100		MHz
Collector Base Capacitance	C _{CBO}	V _{CB} =10V, f=1MHz		12		pF

h_{FE} CLASSIFICATION

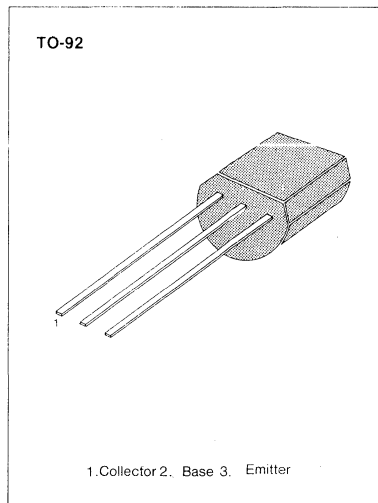
Classification	16	25	40
h _{FE}	100-250	160-400	250-630
h _{FE2}	60-	100-	170-

SWITCHING AND AF AMPLIFIER

- HIGH VOLTAGE: BC546, $V_{CE0} = 65V$
- LOW NOISE: BC549, BC550
- Complement to BC556 ... BC 560

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^{\circ}C$)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V_{CB0}		
:BC546		80	V
:BC547/550		50	V
:BC548/549		30	V
Collector Emitter Voltage	V_{CE0}		
:BC546		65	V
:BC547/550		45	V
:BC548/549		30	V
Emitter-Base Voltage	V_{EB0}		
:BC546/547		6	V
:BC548/549/550		5	V
Collector Current (DC)	I_C	100	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^{\circ}C$
Storage Temperature	T_{stg}	-65~150	$^{\circ}C$



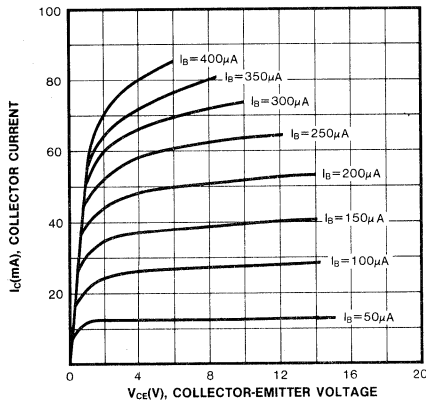
ELECTRICAL CHARACTERISTICS ($T_a = 25^{\circ}C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			15	nA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 2mA$	110		800	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 0.5mA$		90	250	mV
		$I_C = 100mA, I_B = 5mA$		200	600	mV
Collector Base Saturation Voltage	$V_{BE(sat)}$	$I_C = 10mA, I_B = 0.5mA$		700		mV
		$I_C = 100mA, I_B = 5mA$		900		mV
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 5V, I_C = 2mA$	580	660	700	mV
		$V_{CE} = 5V, I_C = 10mA$			720	mV
Current Gain Bandwidth Product	f_T	$V_{CE} = 5V, I_C = 10mA, f = 100MHz$		300		MHz
Collector Base Capacitance	C_{CBO}	$V_{CB} = 10V, f = 1MHz$		3.5	6	pF
Emitter Base Capacitance	C_{EBO}	$V_{EB} = 0.5V, f = 1MHz$		9		pF
Noise Figure :BC546/547/548	NF	$V_{CE} = 5V, I_C = 200\mu A, f = 1KHz, R_g = 2kohm$		2	10	dB
:BC549/550				1.2	4	dB
:BC549	NF	$V_{CE} = 5V, I_C = 200\mu A, R_g = 2kohm, f = 30\sim 15000Hz$		1.4	4	dB
:BC550				1.4	3	dB

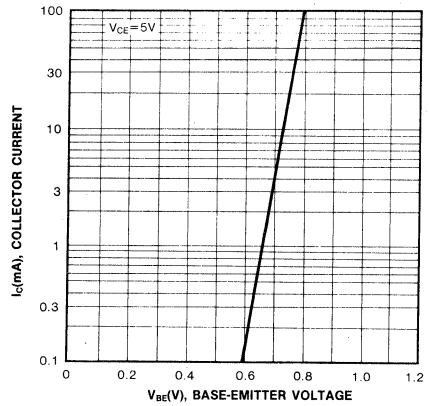
h_{FE} CLASSIFICATION

Classification	A	B	C
h_{FE}	110-220	200-450	420-800

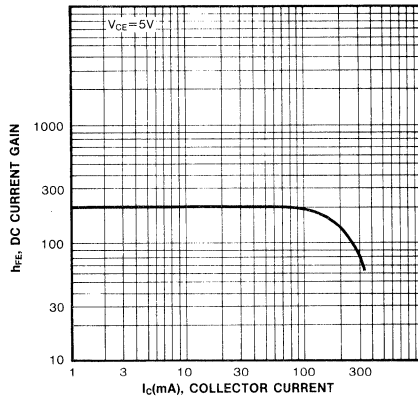
STATIC CHARACTERISTIC



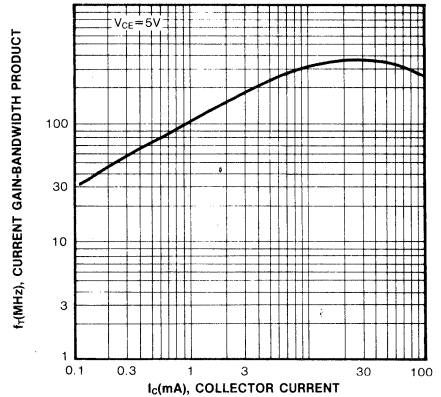
TRANSFER CHARACTERISTIC



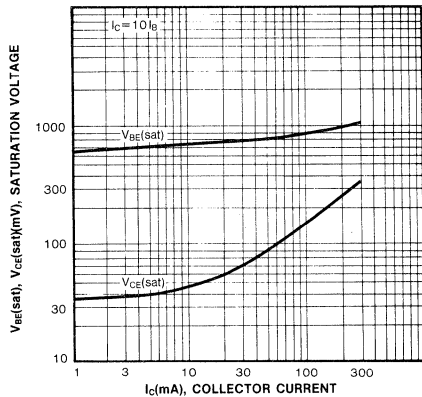
DC CURRENT GAIN



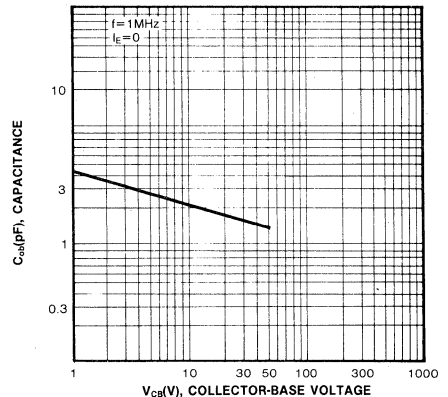
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

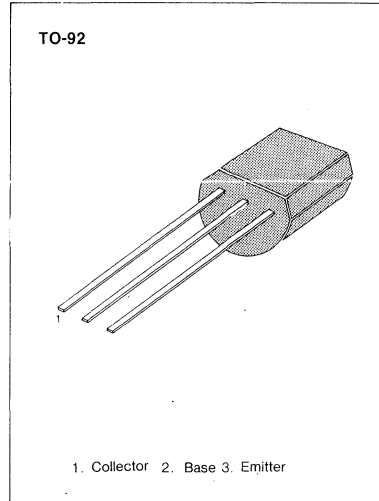


SWITCHING AND AF AMPLIFIER

- HIGH VOLTAGE: BC556, $V_{CE0} = -65V$
- LOW NOISE: BC559, BC560
- Complement to BC546 ... BC 550

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector Base Capacitance	V_{CBO}		
:BC556		-80	V
:BC557/560		-50	V
:BC558/559		-30	V
Collector Emitter Voltage	V_{CEO}		
:BC556		-65	V
:BC557/560		-45	V
:BC558/559		-30	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C	-100	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-65~150	$^\circ C$



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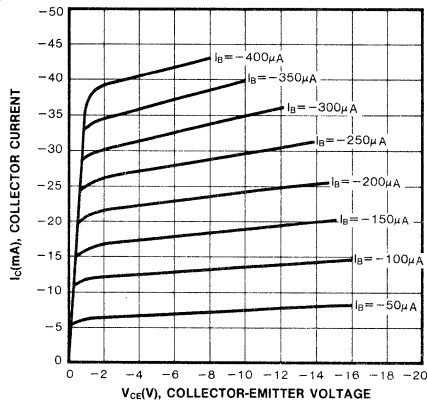
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-15	nA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = 2mA$	110		800	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$ $I_C = -100mA, I_B = -5mA$		-90 -250	-300 -650	mV
Collector Base Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -0.5mA$ $I_C = -100mA, I_B = -5mA$		-700 -900		mV
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -5V, I_C = -2mA$ $V_{CE} = -5V, I_C = -10mA$	-600	-660	-750 -800	mV
Current Gain Bandwidth Product	f_T	$V_{CE} = -5V, I_C = -10mA, f = 100MHz$		150		MHz
Collector Base Capacitance	C_{CBO}	$V_{CB} = -10V, f = 1MHz$			6	pF
Noise Figure	NF	$V_{CE} = -5V, I_C = -200\mu A, f = 1KHz, R_g = 2k\Omega$		2	10	dB
	NF	$V_{CE} = -5V, I_C = -200\mu A, R_g = 2k\Omega, f = 30\sim 15000Hz$		1 1.2	4 4	dB
	NF			1.2	2	dB

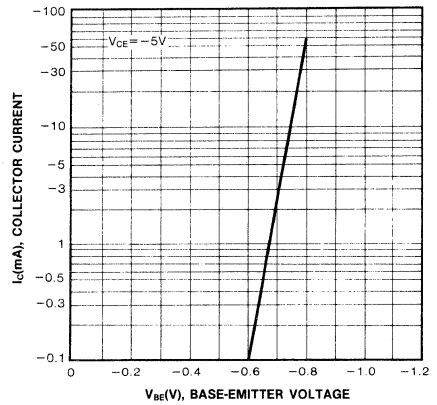
h_{FE} CLASSIFICATION

Classification	A	B	C
h_{FE}	110-220	200-450	420-800

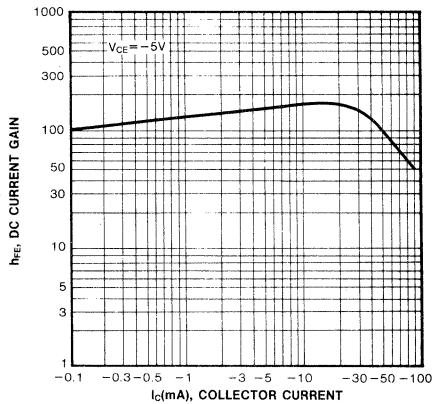
STATIC CHARACTERISTIC



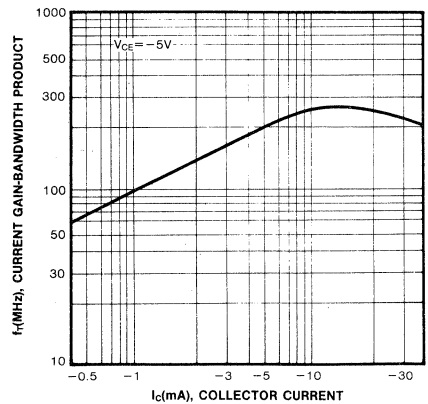
BASE-EMITTER VOLTAGE



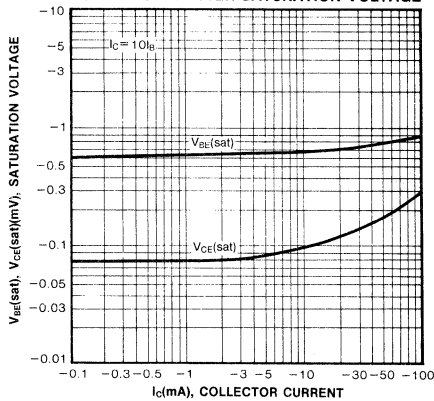
DC CURRENT GAIN



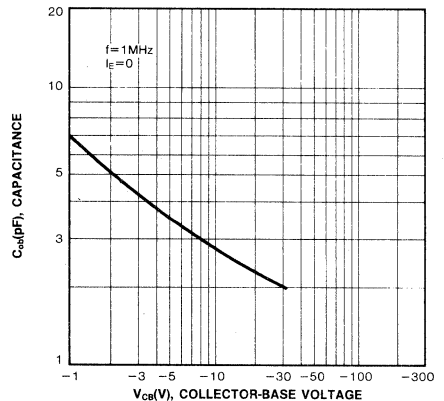
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



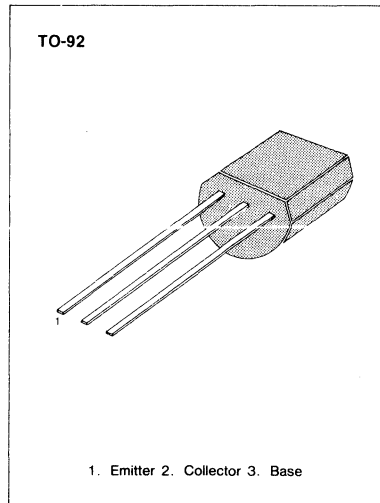
BC635/637/639 NPN EPITAXIAL SILICON TRANSISTOR

SWITCHING AND AMPLIFIER APPLICATIONS

• Complement to BC635/638/640

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage: BC635 at $R_{BE} = 1\text{Kohm}$	V_{CER}	45 60 100	V V V
Collector Emitter Voltage: BC635 : BC637 : BC639	V_{CES}	45 60 100	V V V
Collector Emitter Voltage: BC635 : BC637 : BC639	V_{CEO}	45 60 80	V V V
Emitter Base Voltage	V_{EBO}	5	V
Collector Current	I_C	1	A
Peak Collector Current	I_{CP}	1.5	A
Base Current	I_B	100	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-65 ~ 150	$^\circ\text{C}$

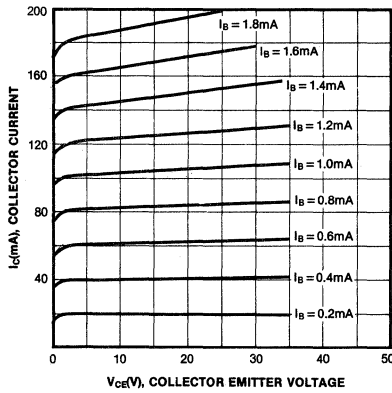


* PW = 5mS, Duty Cycle = 10%

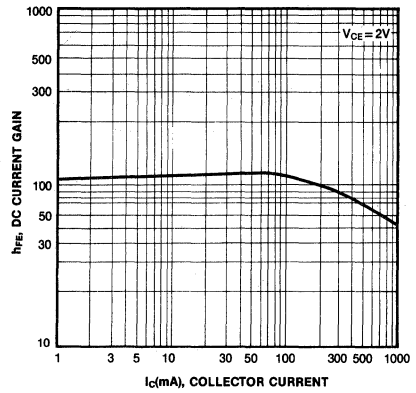
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage :BC635 :BC736 :BC639	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	45 60 80			V V V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			0.1	μA
DC Current Gain :BC635 :BC637/BC639	h_{FE}	$V_{CE} = 2\text{V}, I_C = 5\text{mA}$ $V_{CE} = 2\text{V}, I_C = 150\text{mA}$	25 40 40 25		250 160	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$			0.5	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$			1	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 10\text{mA},$ $f = 50\text{MHz}$		100		MHz

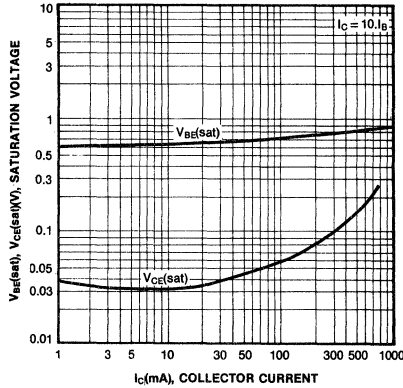
STATIC CHARACTERISTIC



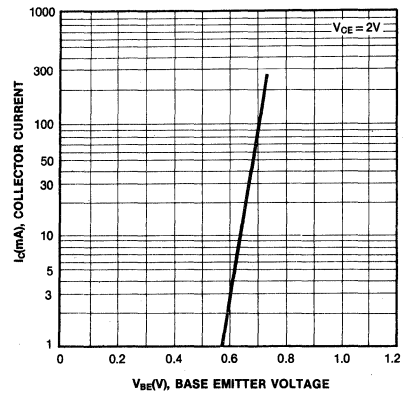
DC CURRENT GAIN



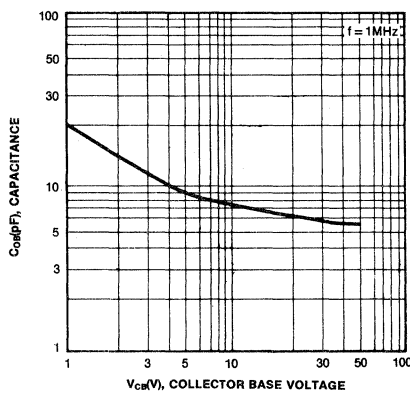
BASE EMITTER SATURATION VOLTAGE
COLLECTOR EMITTER SATURATION VOLTAGE



BASE EMITTER ON VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



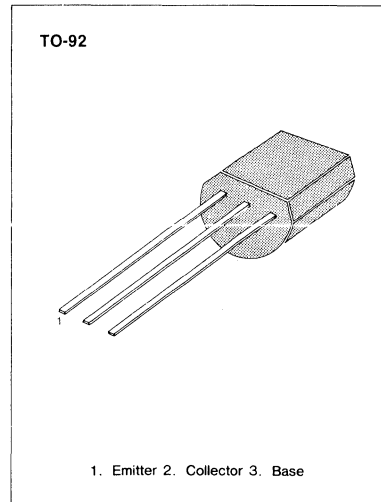
BC636/638/640 PNP EPITAXIAL SILICON TRANSISTOR

SWITCHING AND AMPLIFIER APPLICATIONS

• Complement to BC635/637/639

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage: BC636 at $R_{BE} = 1\text{Kohm}$	V_{CER}	-45 -60 -100	V V V
Collector Emitter Voltage: BC636 : BC638 : BC640	V_{CES}	-45 -60 -100	V V V
Collector Emitter Voltage: BC636 : BC638 : BC640	V_{CEO}	-45 -60 -80	V V V
Emitter Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-1	A
Peak Collector Current	I_{CP}	-1.5	A
Base Current	I_B	-100	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-65 ~ 150	$^\circ\text{C}$

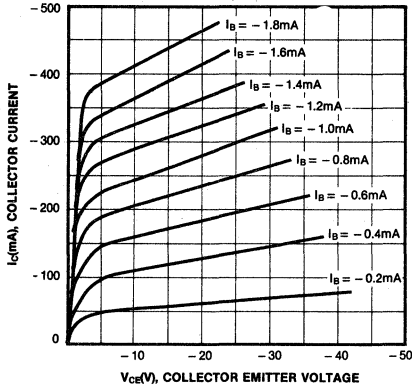


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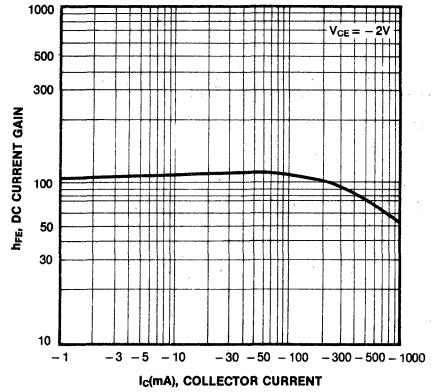
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage :BC636 :BC638 :BC640	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-45 -60 -80			V V V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30\text{V}, I_E = 0$			-0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-0.1	μA
DC Current Gain :BC636 :BC638/BC640	h_{FE}	$V_{CE} = -2\text{V}, I_C = -5\text{mA}$ $V_{CE} = -2\text{V}, I_C = -150\text{mA}$	25 40 40		250 160	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$ $I_C = -500\text{mA}, I_B = -50\text{mA}$	25		-0.5	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$			-1	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -10\text{mA},$ $f = 50\text{MHz}$		100		MHz

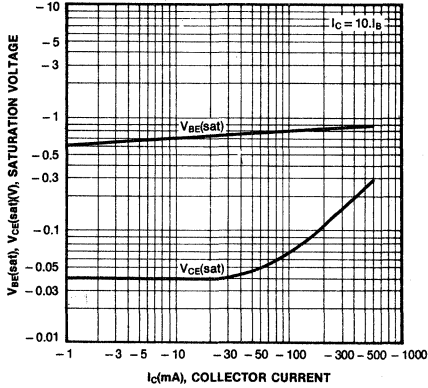
STATIC CHARACTERISTIC



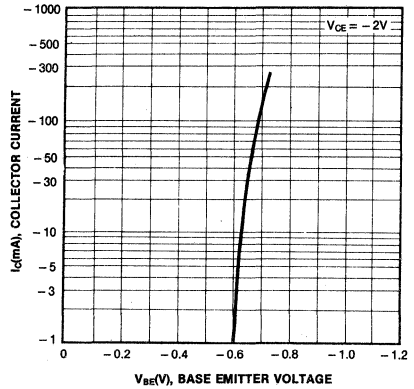
DC CURRENT GAIN



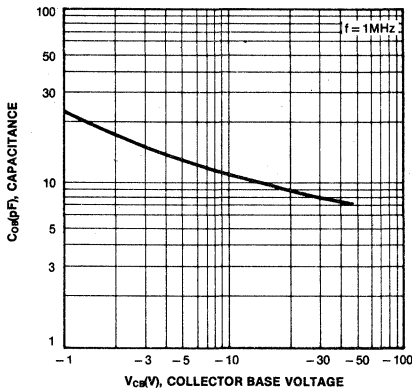
BASE EMITTER SATURATION VOLTAGE
COLLECTOR EMITTER SATURATION VOLTAGE



BASE EMITTER ON VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



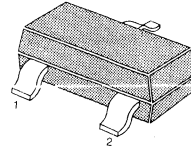
SWITCHING AND AMPLIFIER APPLICATIONS

- SUITABLE FOR AF-DRIVER STAGES AND LOW POWER OUTPUT STAGES
- Complement to BC817/BC818

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage: BC807	V _{CEs}	-50	V
BC808		-30	V
Collector Emitter Voltage: BC807	V _{CEO}	-45	V
BC808		-25	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current (DC)	I _C	-800	mA
Collector Dissipation	P _C	-310	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-65~150	°C

SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

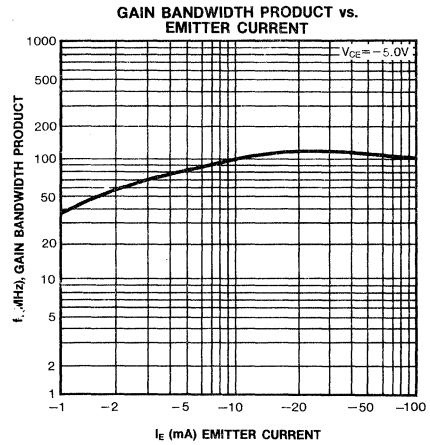
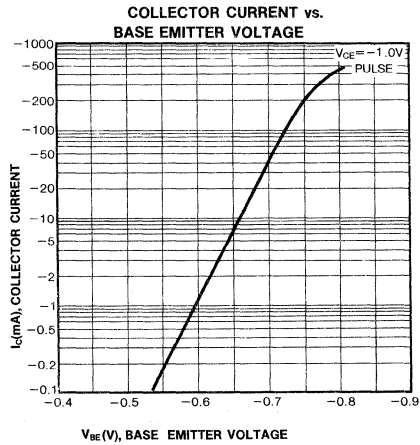
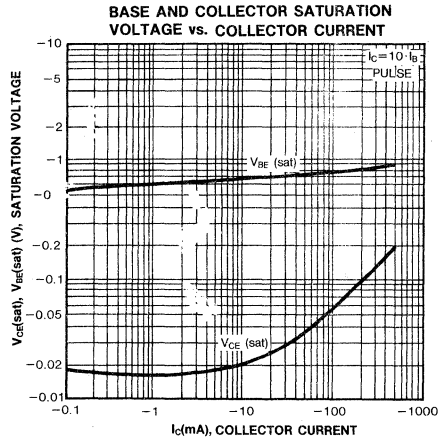
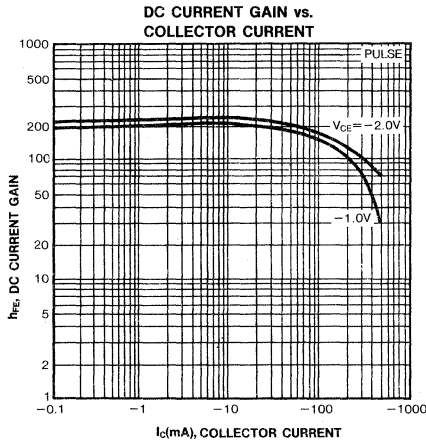
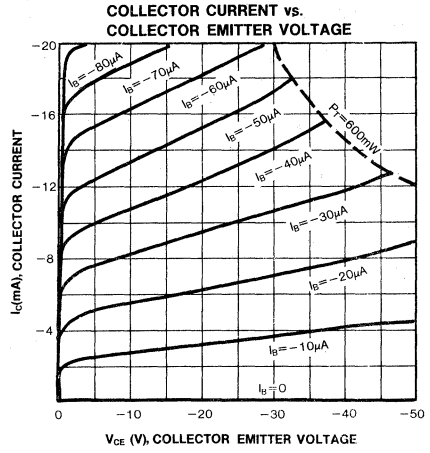
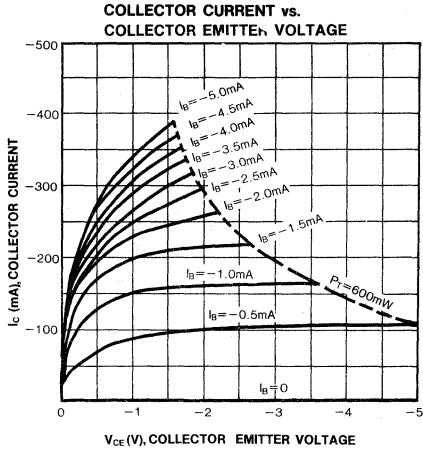
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage :BC807	BV _{CEO}	I _C = -10mA, I _B = 0	-45			V
:BC808			-25			V
Collector Emitter Breakdown Voltage :BC807	BV _{CEs}	I _C = -0.1mA, I _B = 0	-50			V
:BC808			-30			V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = -0.1mA, I _C = 0	-5			V
Collector Cutoff Current	I _{CEs}	V _{CE} = -25V, I _B = 0			-100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = -4V, I _C = 0			-100	nA
DC Current Gain	h _{FE}	V _{CE} = -1V, I _C = -100mA	100		630	
	h _{FE2}	V _{CE} = -1V, I _C = -300mA	60			
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = -500mA, I _B = -50mA			-0.7	V
Base Emitter On Voltage	V _{BE(on)}	V _{CE} = -1V, I _C = -300mA			-1.2	V
Current Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -10mA, f = 50MHz		100		MHz
Collector Base Capacitance	C _{CBO}	V _{CB} = -10V, f = 1MHz			12	pF

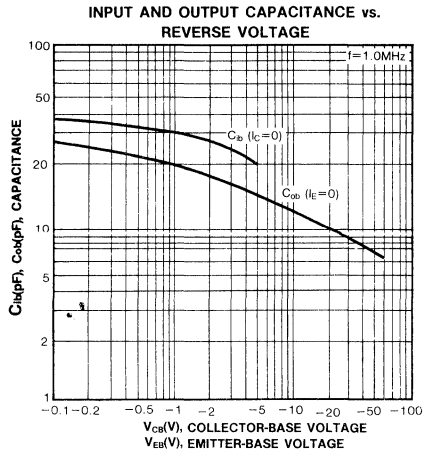
h_{FE} CLASSIFICATION

Classification	16	25	40
h _{FE}	100-250	160-400	250-630
h _{FE2} [*]	60-	100-	170-

MARKING CODE

TYPE	807-16	807-25	807-40	808-16	808-25	808-40
MARKING	9FA	9FB	9FC	9GA	9GB	9GC





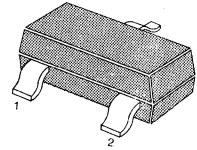
SWITCHING AND AMPLIFIER APPLICATIONS

- SUITABLE FOR AF-DRIVER STAGES AND LOW POWER OUTPUT STAGES
- Complement to BC807/BC808

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Emitter Voltage: BC817	V_{CES}	50	V
BC818		30	V
Collector Emitter Voltage: BC817	V_{CEO}	45	V
BC818		25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current (DC)	I_C	800	mA
Collector Dissipation	P_C	310	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-65~150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage :BC817	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	45			V
:BC818			25			V
Collector Emitter Breakdown Voltage :BC817	BV_{CES}	$I_C = 0.1\text{mA}, I_B = 0$	50			V
:BC818			30			V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E = 0.1\text{mA}, I_C = 0$	5			V
Collector Cutoff Current	I_{CES}	$V_{CE} = 25\text{V}, I_B = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$	100		630	
	h_{FE2}	$V_{CE} = 1\text{V}, I_C = 300\text{mA}$	60			
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 500\text{mA}, I_B = 50\text{mA}$			0.7	V
Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 1\text{V}, I_C = 300\text{mA}$			1.2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 10\text{mA}, f = 50\text{MHz}$		100		MHz
Collector Base Capacitance	C_{CBO}	$V_{CB} = 10\text{V}, f = 1\text{MHz}$			12	pF

 h_{FE} CLASSIFICATION

Classification	16	25	40
h_{FE}	100-250	160-400	250-630
h_{FE2}	60-	100-	170-

MARKING CODE

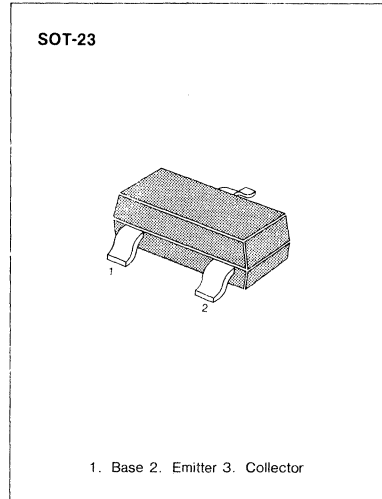
TYPE	817-16	817-25	817-40	818-16	818-25	818-40
MARKING	8FA	8FB	8FC	8GA	8GB	8GC

SWITCHING AND AF AMPLIFIER APPLICATIONS

- SUITABLE FOR AUTOMATIC INSERTION IN THICK AND THIN-FILM CIRCUITS
- LOW NOISE: BC849, BC850
- Complement to BC856 ... BC860

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V _{CB0}	80	V
:BC846		50	V
:BC847/850		30	V
Collector Emitter Voltage	V _{CE0}	65	V
:BC846		45	V
:BC847/850		30	V
Emitter-Base Voltage	V _{EB0}	6	V
:BC846/847		5	V
:BC848/849/850			
Collector Current (DC)	I _C	100	mA
Collector Dissipation	P _C	310	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-65~150	°C



3

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CB0}	V _{CB} = 30V, I _E = 0			15	nA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 2mA	110		800	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C = 10mA, I _B = 0.5mA		90	250	mV
		I _C = 100mA, I _B = 5mA		200	600	mV
Collector Base Saturation Voltage	V _{BE(sat)}	I _C = 10mA, I _B = 0.5mA		700		mV
		I _C = 100mA, I _B = 5mA		900		mV
Base Emitter On Voltage	V _{BE(on)}	V _{CE} = 5V, I _C = 2mA	580	660	700	mV
		V _{CE} = 5V, I _C = 10mA			720	mV
Current Gain Bandwidth Product	f _T	V _{CE} = 5V, I _C = 10mA, f = 100MHz		300		MHz
Collector Base Capacitance	C _{CB0}	V _{CB} = 10V, f = 1MHz		3.5	6	pF
Emitter Base Capacitance	C _{EB0}	V _{EB} = 0.5V, f = 1MHz		9		pF
Noise Figure	NF	V _{CE} = 5V, I _C = 200μA, f = 1KHz, R _g = 2kohm		2	10	dB
		V _{CE} = 5V, I _C = 200μA, R _g = 2kohm, f = 30~15000Hz		1.2	4	dB
				1.4	4	dB
				1.4	3	dB

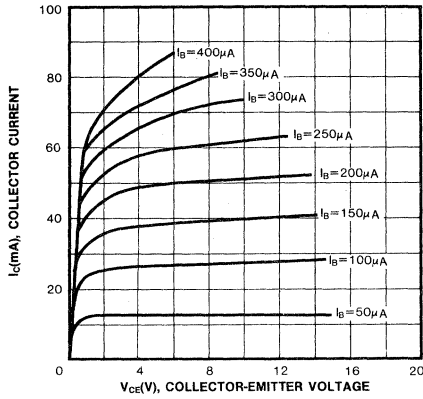
h_{FE} CLASSIFICATION

Classification	A	B	C
h _{FE}	110-220	200-450	420-800

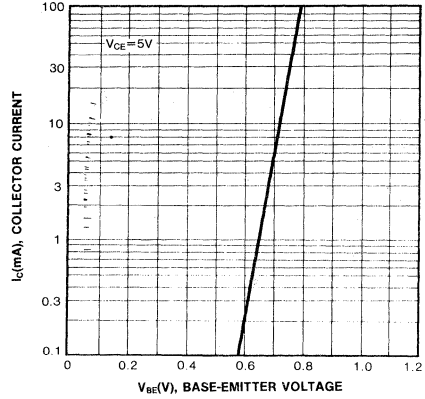
MARKING CODE

TYPE	846A	846B	846C	847A	847B	847C	848A	848B	848C	849A	849B	849C	850A	850B	850C
MARK	8AA	8AB	8AC	8BA	8BB	8BC	8CA	8CB	8CC	8DA	8DB	8DC	8EA	8EB	8EC

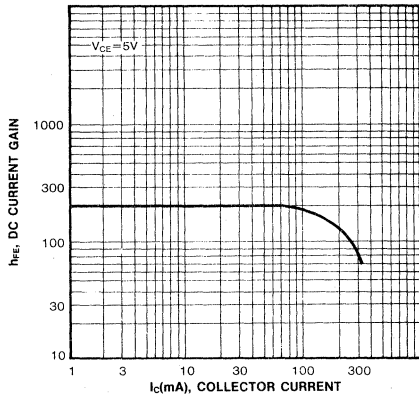
STATIC CHARACTERISTIC



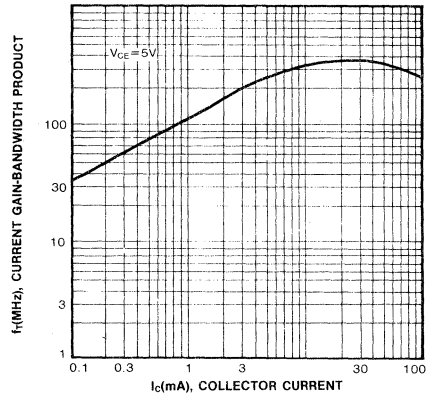
TRANSFER CHARACTERISTIC



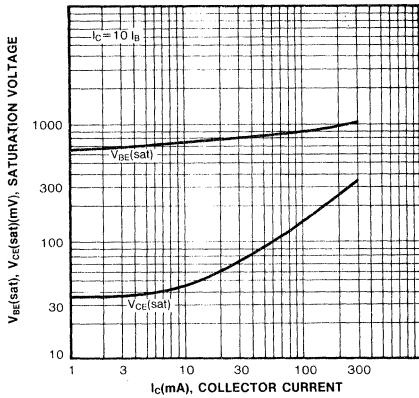
DC CURRENT GAIN



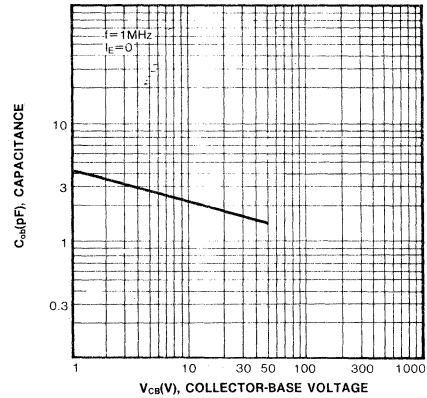
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

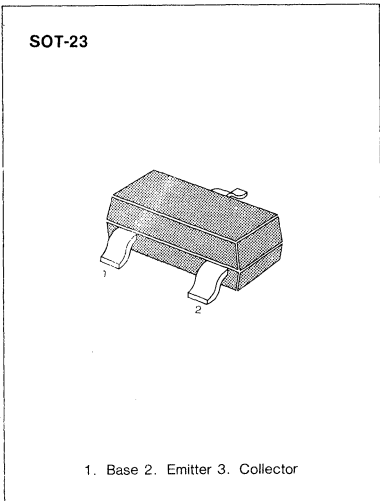


SWITCHING AND AF AMPLIFIER APPLICATIONS

- SUITABLE FOR AUTOMATIC INSERTION IN THICK AND THIN-FILM CIRCUITS
- LOW NOISE: BC859, BC860
- Complement to BC846 ... BC850

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V _{CB0}		
:BC856		-80	V
:BC857/860		-50	V
:BC858/859		-30	V
Collector Emitter Voltage	V _{CE0}		
:BC856		-65	V
:BC857/860		-45	V
:BC858/859		-30	V
Emitter-Base Voltage	V _{EB0}	-5	V
Collector Current (DC)	I _C	-100	mA
Collector Dissipation	P _C	310	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-65~150	°C



ELECTRICAL CHARACTERISTICS (T_a=25°C)

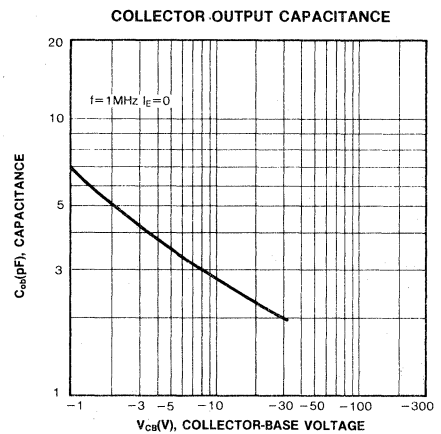
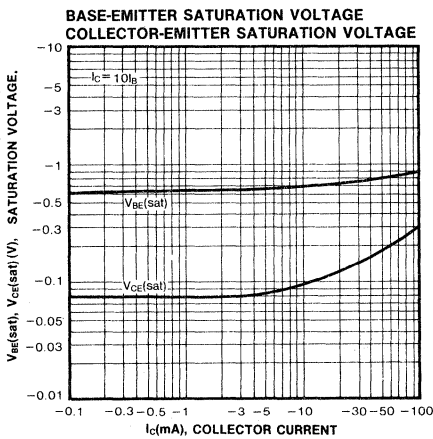
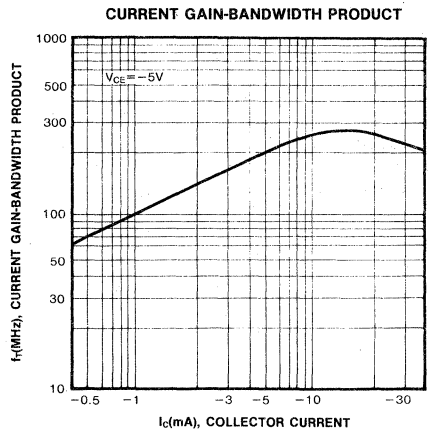
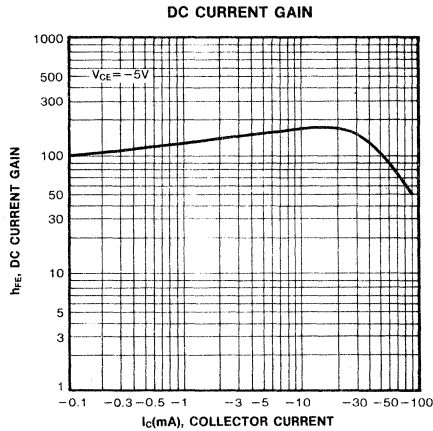
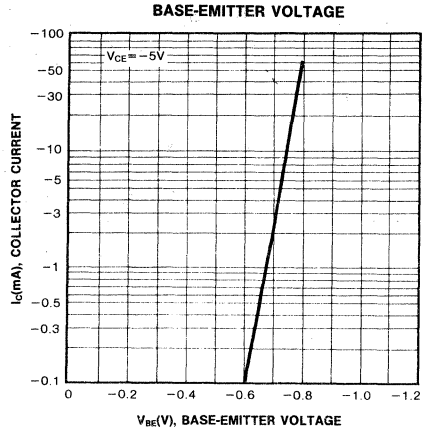
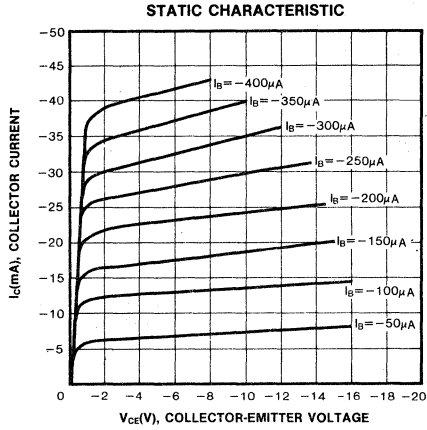
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I _{CB0}	V _{CB} =-30V, I _E =0			-15	nA
DC Current Gain	h _{FE}	V _{CE} =-5V, I _C =-2mA	110		800	
Collector Emitter Saturation Voltage	V _{CE(sat)}	I _C =-10mA, I _B =-0.5mA		-90	-300	mV
		I _C =-100mA, I _B =-5mA		-250	-650	mV
Collector Base Saturation Voltage	V _{BE(sat)}	I _C =-10mA, I _B =-0.5mA		-700		mV
		I _C =-100mA, I _B =-5mA		-900		mV
Base Emitter On Voltage	V _{BE(on)}	V _{CE} =-5V, I _C =-2mA	-600	-660	-750	mV
		V _{CE} =-5V, I _C =-10mA			-800	mV
Current Gain Bandwidth Product	f _T	V _{CE} =-5V, I _C =-10mA, f=100MHz		150		MHz
Collector Base Capacitance	C _{CB0}	V _{CB} =-10V, f=1MHz			6	pF
Noise Figure	NF	V _{CE} =-5V, I _C =-200μA, f=1KHz R _g =2kohm		2	10	dB
		V _{CE} =-5V, I _C =-200μA, R _g =2kohm, f=30~15000Hz		1	4	dB
				1.2	4	dB
				1.2	2	dB

h_{FE} CLASSIFICATION

Classification	A	B	C
h _{FE}	110-220	200-450	420-800

MARKING CODE

TYPE	856A	856B	856C	857A	857B	857C	858A	858B	858C	859A	859B	859C	860A	860B	860C
MARK.	9AA	9AB	9AC	9BA	9BB	9BC	9CA	9CB	9CC	9DA	9DB	9DC	9EA	9EB	9EC

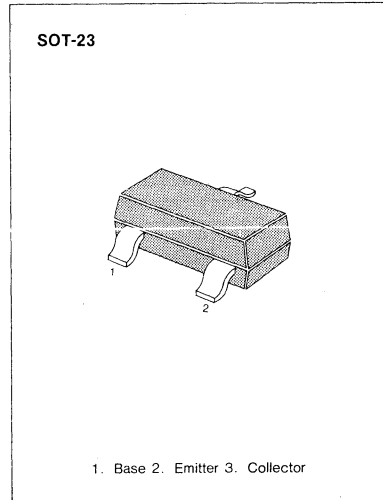


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-30	V
Collector-Emitter Voltage	V _{CEO}	-20	V
Emitter-Base Voltage	V _{EBO}	-5.0	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT5086 for graphs



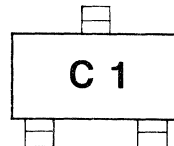
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -10μA, I _E = 0	-30			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -2mA, I _B = 0	-20			V
Collector-Emitter Breakdown Voltage	BV _{CES}	I _C = -100μA, V _{EB} = 0	-30			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5			V
Collector Cut-off Current	I _{CBO}	V _{CB} = -20V, I _E = 0			-100	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -2mA	120		260	
	:BCW29		215		500	
	BCW30					
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -10mA, I _B = -0.5mA			-0.3	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = -5V, I _C = -2mA	-0.6		-0.75	V
Output Capacitance	C _{OB}	V _{CB} = -10V, I _E = 0 f = 1MHz			7	pF
Noise Figures	N _F	I _C = -0.2mA, V _{CE} = -5V R _G = 2KΩ, f = 1KHz			10	dB

MARKING CODE

TYPE	BCW29	BCW30
MARK.	C1	C2

Marking



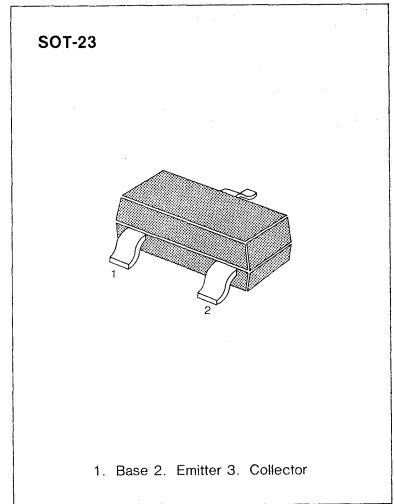
3

GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	20	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT5088 for graphs



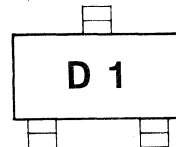
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 10μA, I _E = 0	30			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 2mA, I _B = 0	20			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 10μA, I _C = 0	5			V
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 2.0mA				
	:BCW31		110		220	
	BCW32		200		450	
	BCW33		420		800	
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = 10mA, I _B = 0.5mA			0.25	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = 5V, I _C = 2mA	0.55		0.7	V
Output Capacitance	C _{OB}	V _{CB} = 10V, I _E = 0 f = 1MHz			4	pF
Noise Figure	N _F	V _{CE} = 5V, I _C = 0.2mA R _S = 2KΩ, f = 1KHz			10	dB

MARKING CODE

TYPE	BCW31	BCW32	BCW33
MARK.	D1	D2	D3

Marking

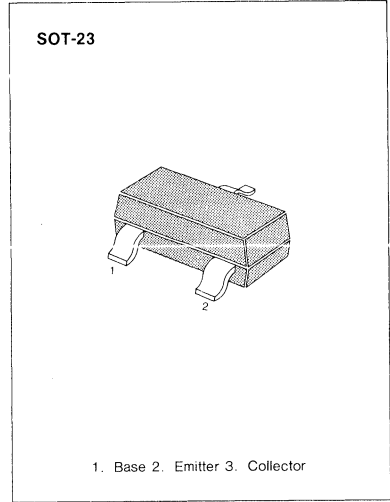


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	32	V
Collector-Emitter Voltage	V _{CEO}	32	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT3904 for graphs



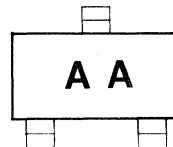
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CBO}	I _C = 2mA, I _B = 0	32		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 1μA, I _C = 0	5		V
Collector Cut-off Current	I _{CES}	V _{CB} = 32V, V _{BE} = 0		20	nA
Emitter Cut-off Current	I _{EBO}	V _{EB} = 4V, I _C = 0		20	nA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 10μA	20		
	:BCW60B		40		
	BCW60C		100		
	BCW60D		100		
	:BCW60A	V _{CE} = 5V, I _C = 2mA	120	220	
	BCW60B		180	310	
	BCW60C		250	460	
	BCW60D		380	630	
	:BCW60A	V _{CE} = 1V, I _C = 50mA	60		
	BCW60B		70		
	BCW60C		90		
	BCW60D		100		
Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C = 50mA, I _B = 1.25mA		0.55	V
		I _C = 10mA, I _B = 0.25mA		0.35	V
Base-Emitter Saturation Voltage	V _{BE} (sat)	I _C = 50mA, I _B = 1.25mA	0.7	1.05	V
		I _C = 10mA, I _B = 0.25mA	0.6	0.85	V
Base-Emitter On Voltage	V _{BE} (on)	V _{CE} = 5V, I _C = 2mA	0.55	0.75	V
Output Capacitance	C _{OB}	V _{CB} = 10V, I _E = 0 f = 1MHz		4.5	pF
Current Gain-Bandwidth Product	f _T	I _C = 10mA, V _{CE} = 5V f = 100MHz	125		MHz
Noise Figure	N _F	I _C = 0.2mA, V _{CE} = 5V R _G = 2KΩ, f = 1KHz		6	dB
Turn On Time	t _{ON}	I _C = 10mA, I _{B1} = 1mA		150	ns
Turn Off Time	t _{OFF}	V _{BB} = 3.6V, I _{B2} = 1mA R1 = R2 = 5KΩ, R _L = 990Ω		800	ns

MARKING CODE

TYPE	BCW60A	BCW60B	BCW60C	BCW60D
MARK.	AA	AB	AC	AD

Marking

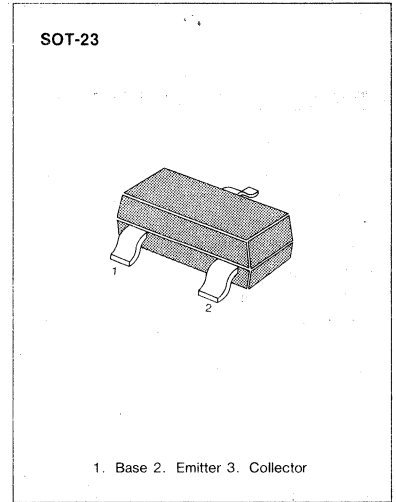


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-32	V
Collector-Emitter Voltage	V _{CEO}	-32	V
Emitter-Base Voltage	V _{EBO}	-5.0	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT5086 for graphs



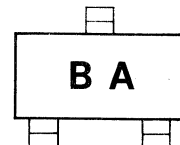
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CBO}	I _C = -2mA, I _B = 0	-32		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -1μA, I _C = 0	-5		V
Collector Cut-off Current	I _{CES}	V _{CB} = -32V, V _{BE} = 0		-20	μA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -10μA	20		
	:BCW61B		40		
	BCW61C		100		
	BCW61D		120	220	
	:BCW61A	V _{CE} = -5V, I _C = -2mA	140	310	
	BCW61B		250	460	
	BCW61C		380	630	
	BCW61D		60		
	:BCW61A	V _{CE} = -5V, I _C = -50mA	80		
	BCW61B		100		
	BCW61C		100		
	BCW61D		100		
Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C = -50mA, I _B = -1.25mA I _C = -10mA, I _B = -0.25mA		-0.55 -0.25	V
Base-Emitter Saturation Voltage	V _{BE} (sat)	I _C = -50mA, I _B = -1.25mA I _C = -10mA, I _B = -0.25mA	0.68 0.6	1.05 0.85	V
Base-Emitter On Voltage	V _{BE} (on)	V _{CE} = -5V, I _C = -2mA	0.6	0.75	V
Output Capacitance	C _{OB}	V _{CB} = -10V, I _E = 0 f = 1MHz		6	pF
Noise Figure	N _F	I _C = -0.2mA, V _{CE} = -5V R _G = 2KΩ, f = 1KHz		6	dB
Turn On Time	t _{ON}	I _C = -10mA, I _{B1} = -1mA		150	ns
Turn Off Time	t _{OFF}	V _{BB} = -3.6V, I _{B2} = -1mA R ₁ = R ₂ = 5KΩ, R _L = 990Ω		800	ns

MARKING CODE

TYPE	BCW61A	BCW61B	BCW61C	BCW61D
MARK.	BA	BB	BC	BD

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V _{CE0}	-45	V
Emitter-Base Voltage	V _{EB0}	-5	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT5086 for graphs

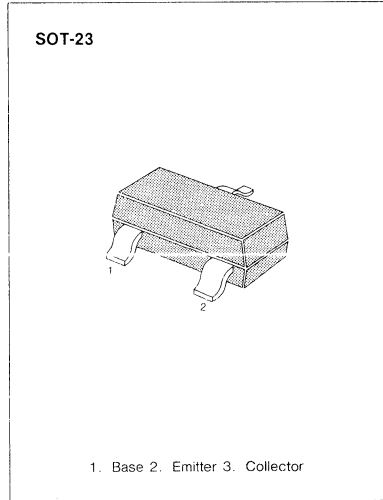
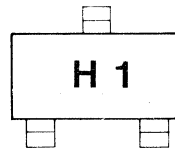
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -2mA, I _B = 0	-45		V
Collector-Emitter Breakdown Voltage	BV _{CES}	I _C = -100μA, V _{EB} = 0	-50		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5		V
Collector Cut-off Current	I _{CBO}	V _{CB} = -20V, I _E = 0		-100	nA
DC Current Gain	h _{FE}				
	:BCW69	V _{CE} = -5V, I _C = -2mA	120	260	
	BCW70		215	500	
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -10mA, I _B = -0.5mA		-0.3	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = -5V, I _C = -2mA	-0.6	-0.75	V
Output Capacitance	C _{OB}	V _{CB} = -10V, I _E = 0 f = 1MHz		7	pF
Noise Figure	N _F	I _C = -0.2mA, V _{CE} = -5V R _G = 2KΩ, f = 1KHz		10	dB

MARKING CODE

TYPE	BCW69	BCW70
MARK.	H1	H2

Marking



1. Base 2. Emitter 3. Collector

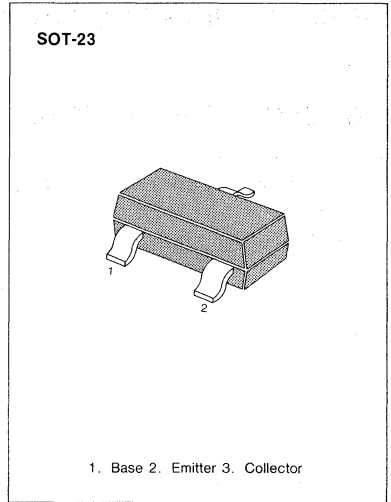


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	50	V
Collector-Emitter Voltage	V_{CE0}	45	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

• Refer to MMBT5088 for graphs



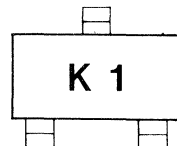
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 10\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 2\text{mA}, I_B = 0$	45			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 2\text{mA}, V_{EB} = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 2\text{mA}$	110		220	
	:BCW71		200		450	
	BCW72				0.25	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$		0.21		V
		$I_C = 50\text{mA}, I_B = 2.5\text{mA}$		0.85		V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 50\text{mA}, I_B = 2.5\text{mA}$				V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 5\text{V}, I_C = 2\text{mA}$	0.6		0.75	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$		300		MHz
		$f = 35\text{MHz}$				
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$			4	pF
		$f = 1\text{MHz}$				
Noise Figure	N_F	$I_C = 2.0\text{mA}, V_{CE} = 5\text{V}$			10	dB
		$R_S = 2\text{K}\Omega, f = 1\text{KHz}$				

MARKING CODE

TYPE	BCW71	BCW72
MARK.	K1	K2

Marking

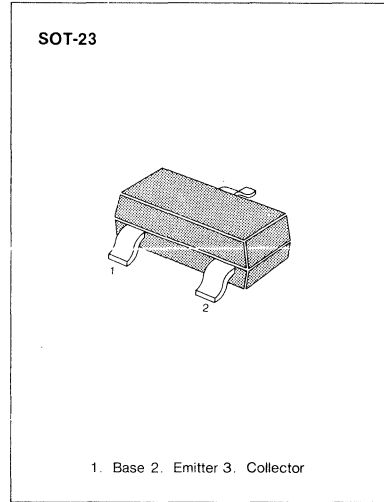


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

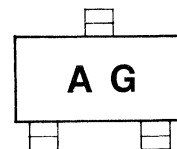
• Refer to MMBT5088 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 2\text{mA}, I_B = 0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE} = 32\text{V}, V_{BE} = 0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$		20	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 2\text{mA}$	120	220	
		$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	60		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$		0.35	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$	0.6	0.85	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$	0.7	1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 2\text{mA}, V_{CE} = 5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$	125		MHz
		$f = 100\text{MHz}$			
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$		4.5	pF
		$f = 1\text{MHz}$			
Noise Figure	NF	$I_C = 0.2\text{mA}, V_{CE} = 5\text{V}$		6	dB
		$f = 1\text{KHz}, R_S = 2\text{K}\Omega$			
Turn On Time	t_{on}	$I_C = 10\text{mA}, I_{B1} = 1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2} = 1\text{mA}, V_{BB} = 3.6\text{V}$		800	ns
		$R_L = 990\Omega, R_1 = R_2 = 5\text{K}\Omega$			

Marking



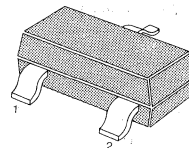
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

• Refer to MMBT3904 for graphs

SOT-23

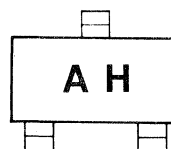


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 2.0\text{mA}, I_B = 0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1.0\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE} = 32\text{V}, V_{BE} = 0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$		20	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 10\mu\text{A}$	20		
		$V_{CE} = 5\text{V}, I_C = 2.0\text{mA}$	180	310	
		$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	70		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$		0.35	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$	0.6	0.85	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$	0.7	1.05	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 2.0\text{mA}, V_{CE} = 5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5\text{V}$	125		MHz
		$f = 100\text{MHz}$			
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$		4.5	pF
		$f = 1\text{MHz}$			
Noise Figure	NF	$V_{CE} = 5\text{V}, I_C = 0.2\text{mA}$		6	dB
		$R_S = 2\text{K}\Omega, f = 1\text{KHz}$			
Turn On Time	t_{ON}	$I_C = 10\text{mA}, I_{B1} = 1.0\text{mA}$		150	ns
Turn Off Time	t_{OFF}	$V_{BB} = 3.6\text{V}, I_{B2} = 1.0\text{mA}$		800	ns
		$R_1 = R_2 = 5\text{K}\Omega, R_L = 990\Omega$			

Marking

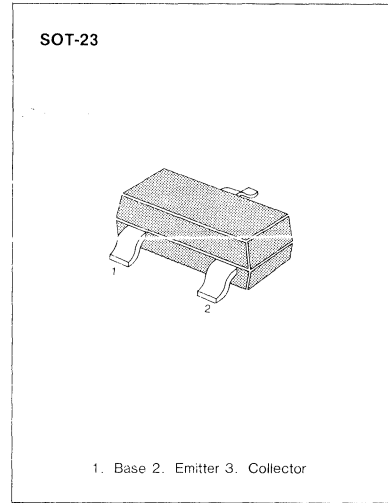


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	Tstg	150	$^{\circ}\text{C}$

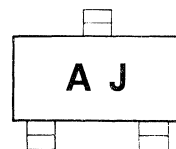
• Refer to MMBT3904 for graphs



ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1.0\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$	40		
		$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	250	460	
		$V_{CE}=1\text{V}, I_C=50\text{mA}$	90		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=0.25\text{mA}$		0.35	V
		$I_C=50\text{mA}, I_B=1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=10\text{mA}, I_B=0.25\text{mA}$	0.6	0.85	V
		$I_C=50\text{mA}, I_B=1.25\text{mA}$	0.7	1.05	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$	125		MHz
		$f=100\text{MHz}$			
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$		4.5	pF
		$f=1\text{MHz}$			
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=0.2\text{mA}$		6	dB
		$R_S=2\text{K}\Omega, f=1\text{KHz}$			
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1.0\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1.0\text{mA}$		800	ns
		$R_1=R_2=5\text{K}\Omega, R_L=990\Omega$			

Marking

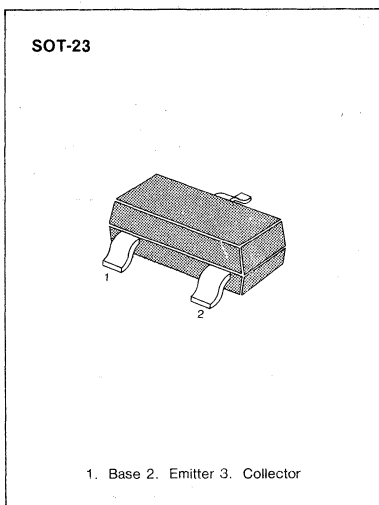


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

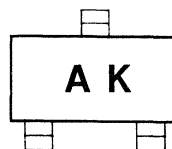
- Refer to MMBT3904 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 2.0\text{mA}, I_E = 0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 1.0\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE} = 32\text{V}, V_{BE} = 0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$		20	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 10\mu\text{A}$	100		
		$V_{CE} = 5\text{V}, I_C = 2.0\text{mA}$	380	630	
		$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	100		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$		0.35	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$	0.6	0.85	V
		$I_C = 50\text{mA}, I_B = 1.25\text{mA}$	0.7	1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 2.0\text{mA}, V_{CE} = 5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5\text{V}$ $f = 100\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		4.5	pF
Noise Figure	NF	$V_{CE} = 5\text{V}, I_C = 0.2\text{mA}$ $R_S = 2\text{K}\Omega, f = 1\text{KHz}$		6	dB
Turn On Time	t_{on}	$I_C = 10\text{mA}, I_{B1} = 1.0\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB} = 3.6\text{V}, I_{B2} = 1.0\text{mA}$ $R_1 = R_2 = 5\text{K}\Omega, R_L = 990\Omega$		800	ns

Marking

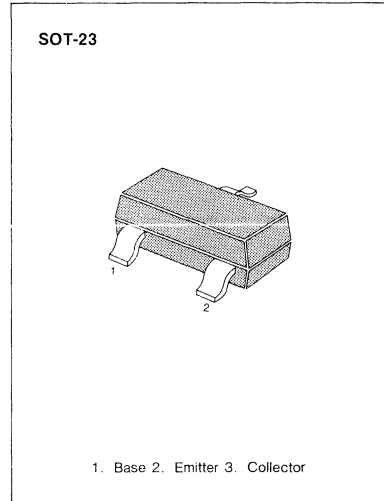


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	-45	V
Collector-Emitter Voltage	V _{CEO}	-45	V
Emitter-Base Voltage	V _{EBO}	-5.0	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

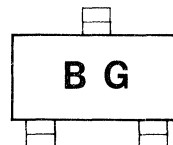
• Refer to MMBT5086 for graphs



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -2mA, I _B = 0	-45		V
Emitter-Base Saturation Voltage	BV _{EBO}	I _E = -1μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CES}	V _{CE} = -32V, V _{BE} = 0		-20	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -2mA	120	220	
		V _{CE} = -1V, I _C = -50mA	60		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -0.25mA		-0.25	V
		I _C = -50mA, I _B = -1.25mA		-0.55	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = -10mA, I _B = -0.25mA	-0.6	-0.85	V
		I _C = -50mA, I _B = -1.25mA	-0.68	-1.05	V
Base-Emitter On Voltage	V _{BE(on)}	I _C = -2mA, V _{CE} = -5V	-0.6	-0.75	V
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz		6	pF
Noise Figure	NF	I _C = 0.2mA, V _{CE} = 5V R _S = 2KΩ, f = 1KHz		6	dB
Turn On Time	ton	I _C = -10mA, I _{B1} = -1mA		150	ns
Turn Off Time	toff	I _{B2} = -1mA, V _{BB} = 3.6V R _L = 990Ω		800	ns

Marking



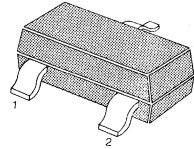
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-45	V
Collector-Emitter Voltage	V _{CEO}	-45	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

- Refer to MMBT5086 for graphs

SOT-23

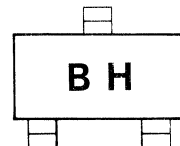


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -2mA, I _B = 0	-45		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -1μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CES}	V _{CE} = -32V, V _{BE} = 0		-20	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -10μA	30		
		V _{CE} = -5V, I _C = -2mA	140	310	
		V _{CE} = -1V, I _C = -50mA	80		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -0.25mA		-0.25	V
		I _C = -50mA, I _B = -1.25mA		-0.55	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = -10mA, I _B = -0.25mA	-0.6	-0.85	V
		I _C = -50mA, I _B = -1.25mA	-0.68	-1.05	V
Base-Emitter On Voltage	V _{BE(on)}	I _C = -2mA, V _{CE} = -5V	-0.6	-0.75	V
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz		6	pF
Noise Figure	NF	I _C = -0.2mA, V _{CE} = -5V f = 1KHz, R _S = 2KΩ		6	dB
Turn On Time	t _{on}	I _C = -10mA, I _{B1} = -1mA		150	ns
Turn Off Time	t _{off}	I _{B2} = -1mA, V _{BB} = -3.6V R _L = 990Ω		800	ns

Marking

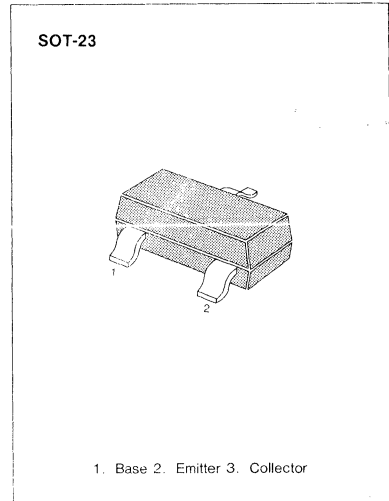


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-45	V
Collector-Emitter Voltage	V_{CEO}	-45	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

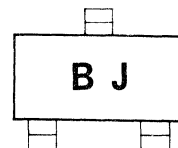
• Refer to MMBT5086 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -2\text{mA}, I_B = 0$	-45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CES}	$V_{CE} = -32\text{V}, V_{BE} = 0$		-20	nA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -10\mu\text{A}$	40		
		$V_{CE} = -5\text{V}, I_C = -2\text{mA}$	250	460	
		$V_{CE} = -1\text{V}, I_C = -50\text{mA}$	100		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}, I_B = -0.25\text{mA}$		-0.25	V
		$I_C = -50\text{mA}, I_B = -1.25\text{mA}$		-0.55	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10\text{mA}, I_B = -0.25\text{mA}$	-0.6	-0.85	V
		$I_C = -50\text{mA}, I_B = -1.25\text{mA}$	-0.68	-1.05	V
Base-Emitter On Voltage	$V_{DE(on)}$	$I_C = -2\text{mA}, V_{CE} = -5\text{V}$	-0.6	-0.75	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$		6	pF
Noise Figure	NF	$I_C = -0.2\text{mA}, V_{CE} = -5\text{V}$ $f = 1\text{kHz}, R_S = 2\text{K}\Omega$		6	dB
Turn On Time	t_{on}	$I_C = -10\text{mA}, I_{B1} = -1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2} = -1\text{mA}, V_{BB} = -3.6\text{V}$ $R_L = 990\Omega$		800	ns

Marking



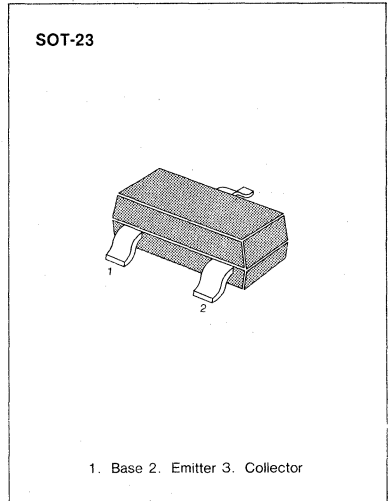
3

GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-45	V
Collector-Emitter Voltage	V _{CEO}	-45	V
Emitter-Base Voltage	V _{EBO}	-5.0	V
Collector Current	I _C	-100	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

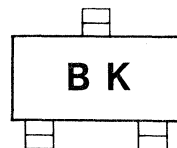
• Refer to MMBT5086 for graphs



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -2mA, I _B = 0	-45		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -1μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CES}	V _{CE} = -32V, V _{BE} = 0		-20	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -10μA	100		
		V _{CE} = -5V, I _C = -2mA	380	630	
		V _{CE} = -1V, I _C = -50mA	110		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -0.25mA		-0.25	V
		I _C = -50mA, I _B = -1.25mA		-0.55	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = -10mA, I _B = -0.25mA	-0.6	-0.85	V
		I _C = -50mA, I _B = -1.25mA	-0.68	-1.05	V
Base-Emitter On Voltage	V _{BE(on)}	I _C = -2mA, V _{CE} = -5V	-0.6	-0.75	V
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1MHz		6	pF
Noise Figure	NF	I _C = -0.2mA, V _{CE} = -5V R _S = 2KΩ, f = 1KHz		6	dB
Turn On Time	ton	I _C = -10mA, I _{B1} = -1mA		150	ns
Turn Off Time	toff	I _{B2} = -1mA, V _{BB} = -3.6V R _L = 990Ω		800	ns

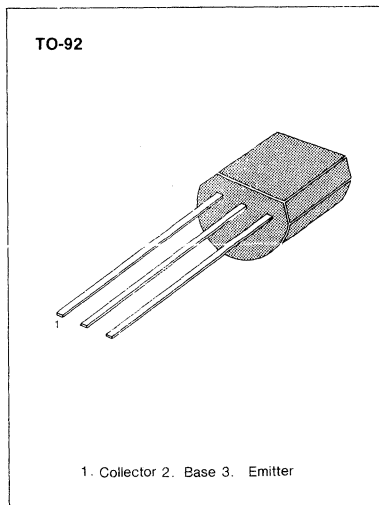
Marking



AM/FM IF AMPLIFIER, INPUT STAGES

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEU}	20	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	30	mA
Collector Dissipation	P _C	220	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C

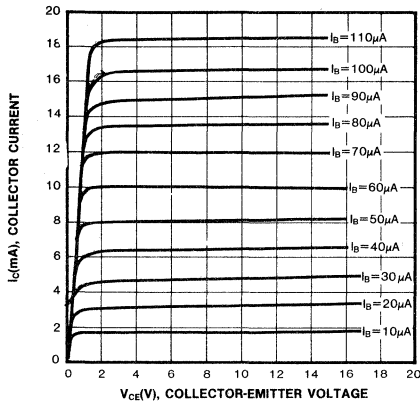


ELECTRICAL CHARACTERISTICS (T_a = 25°C)

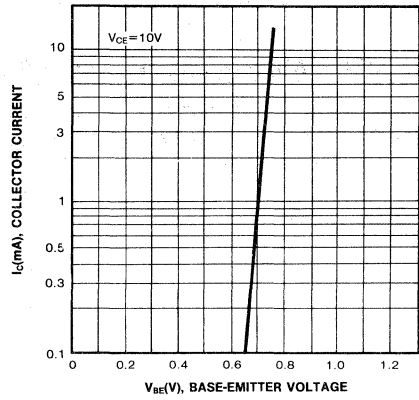
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Base Breakdown Voltage	BV _{CBO}	I _C = 10 μA, I _E = 0	30			V
Collector Emitter Breakdown Voltage	BV _{CEO}	I _C = 1 mA, I _B = 0	20			V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = 10 μA, I _C = 0	5			V
DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 1mA	67	115	222	
Base Emitter On Voltage	V _{BE(on)}	V _{CE} = 10V, I _C = 1mA		0.68		V
Current Gain Bandwidth Product	f _T	V _{CE} = 10V, I _C = 1mA		260		MHz
Noise Figure	NF	V _{CE} = 10V, I _C = 1mA f = 200KHz, g _s = 2mS		1.5		dB
	NF	V _{CE} = 10V, I _C = 1mA f = 1MHz, g _s = 1.5mS		1.2		dB
Feedback Capacitance	C _{re}	V _{CE} = 10V, I _C = 1mA, f = 450KHz		0.85		pF

3

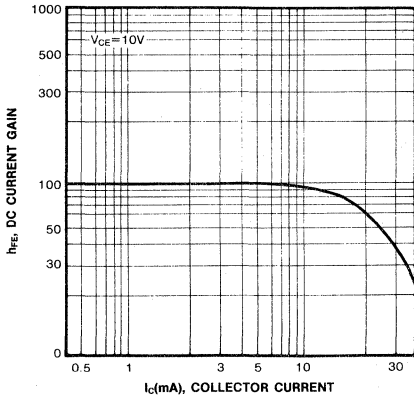
STATIC CHARACTERISTIC



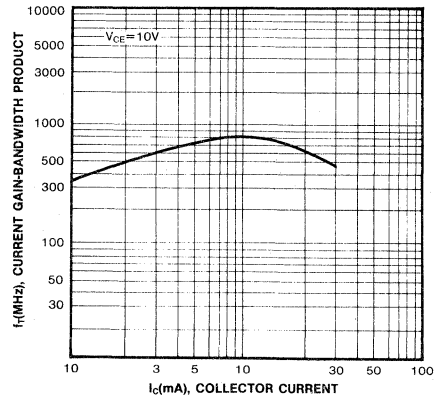
BASE-EMITTER ON VOLTAGE



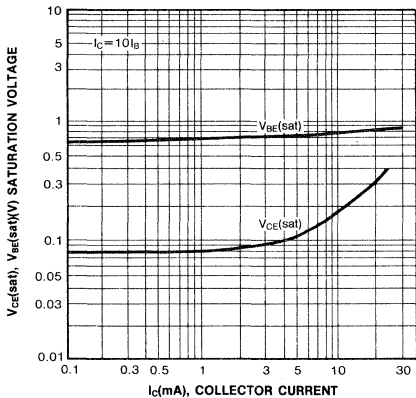
DC CURRENT GAIN



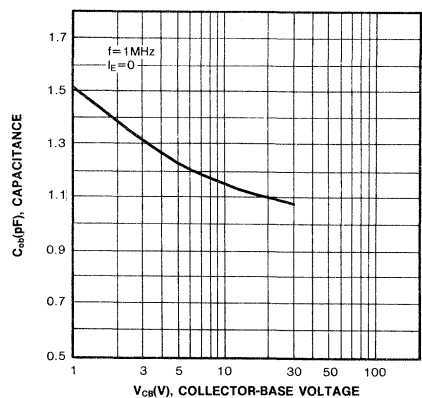
CURRENT GAIN-BANDWIDTH PRODUCT

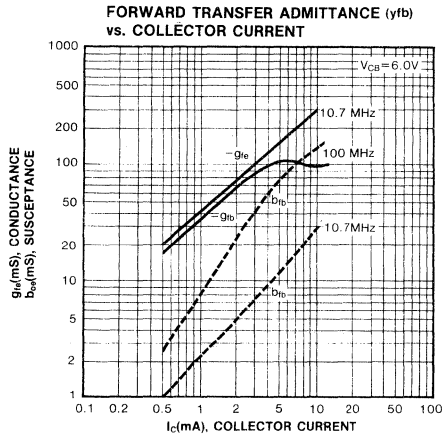
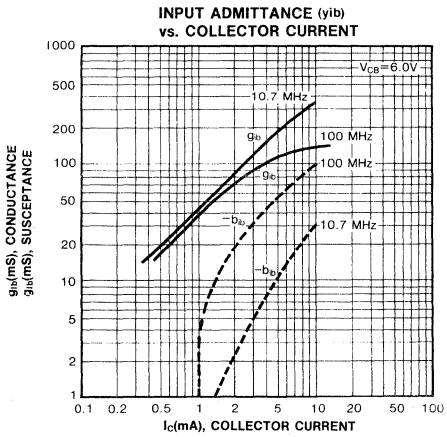
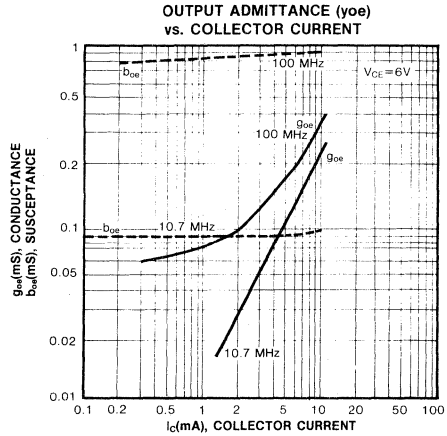
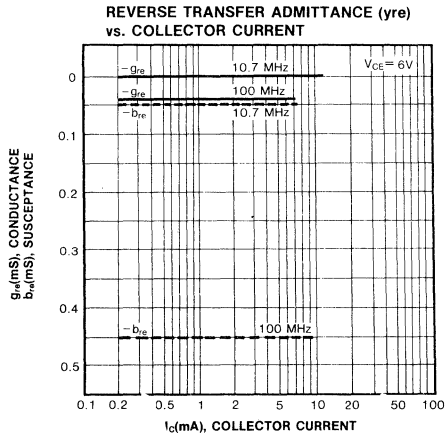
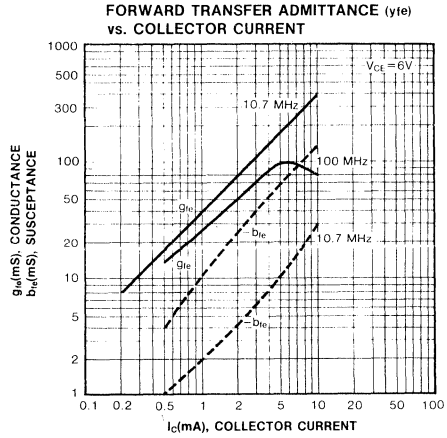
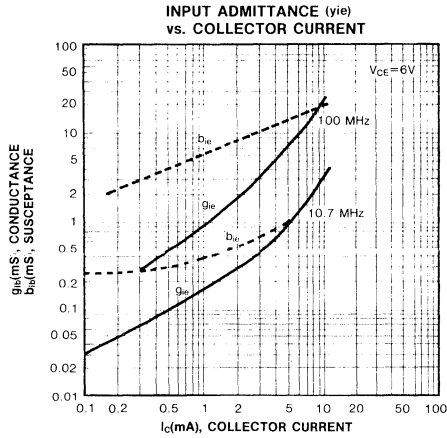


BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



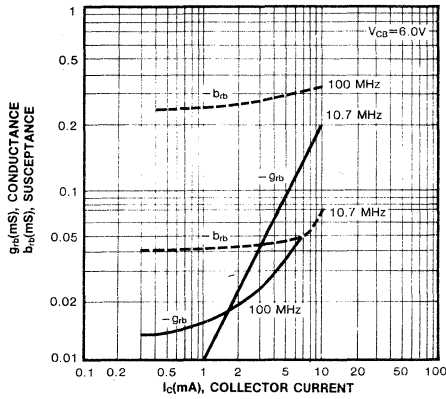
COLLECTOR OUTPUT CAPACITANCE



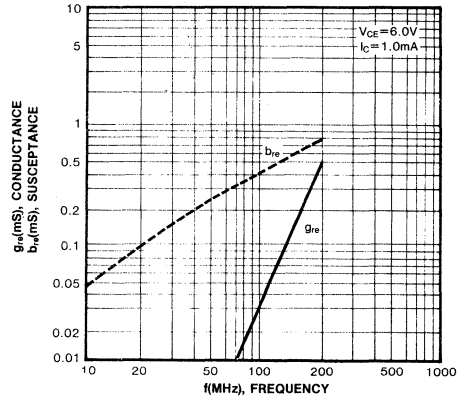


3

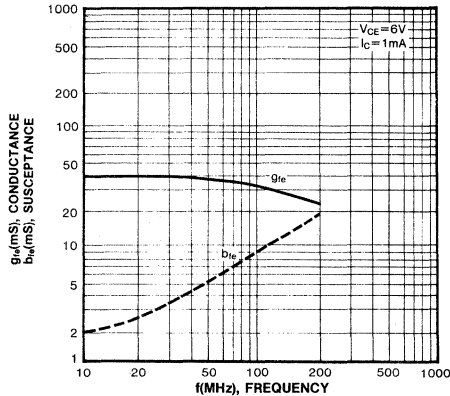
REVERSE TRANSFER ADMITTANCE (yrb) vs. COLLECTOR CURRENT



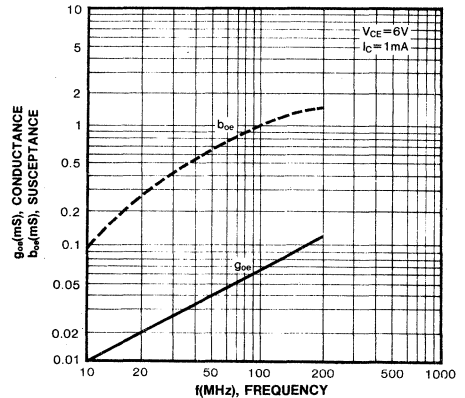
REVERS TRANSFER ADMITTANCE (yre) vs. FREQUENCY



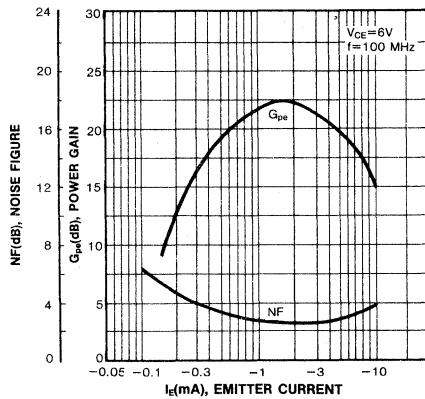
FORWARD TRANSFER ADMITTANCE (yfe) vs. FREQUENCY



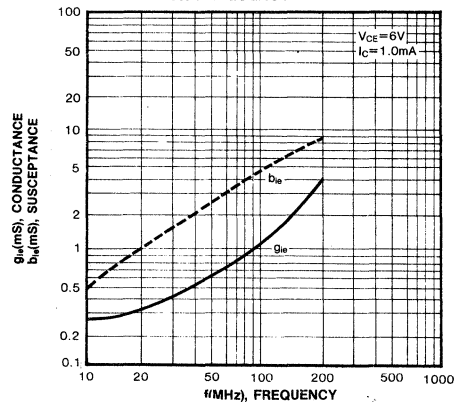
OUTPUT ADMITTANCE (yoe) vs. FREQUENCY



POWER GAIN AND NOISE FIGURE vs. EMITTER CURRENT



INPUT ADMITTANCE (yle) vs. FREQUENCY

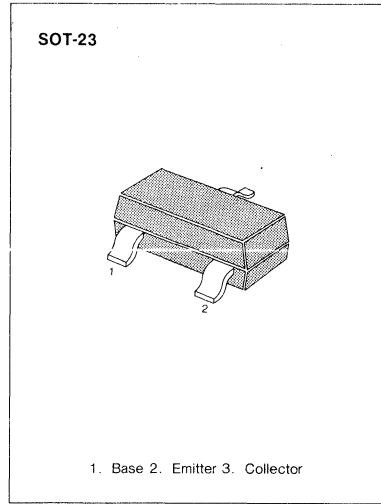


DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-50	V
Collector-Emitter Voltage	V_{CE0}	-45	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current	I_C	-50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

• Refer to MMBT5086 for graphs



1. Base 2. Emitter 3. Collector

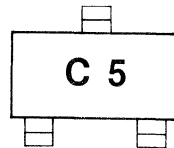
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CB0}	$I_C = -100\mu\text{A}, I_E = 0$	-50		V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1\text{mA}, I_B = 0$	-45		V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40\text{V}, I_E = 0$		-50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$		-50	nA
DC Current Gain	h_{FE}	$V_{CE} = -3\text{V}, I_C = -0.1\text{mA}$	150		
		$V_{CE} = -3\text{V}, I_C = -0.5\text{mA}$	135	270	
	MMBA811C5		200	400	
	MMBA811C6		300	600	
	MMBA811C7		450	900	
	MMBA811C8				
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$ $f = 100\text{MHz}$	75		MHz

MARKING CODE

TYPE	MMBA811C5	MMBA811C6	MMBA811C7	MMBA811C8
MARK.	C5	C6	C7	C8

Marking

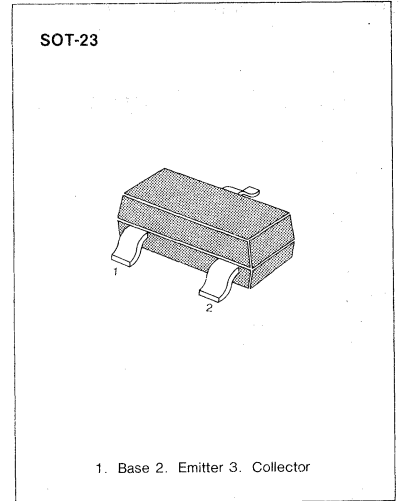


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

• Refer to MMBT5086 for graphs



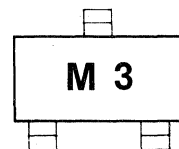
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40\text{V}, I_E = 0$		-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$		-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$	60	120	
	MMBA812M3		90	180	
	MMBA812M4		135	270	
	MMBA812M5		200	400	
	MMBA812M6		300	600	
	MMBA812M7				
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -30\text{mA}, I_B = -3\text{mA}$		-0.5	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6\text{V}, I_C = -1\text{mA}$		-0.8	V

MARKING CODE

TYPE	MMBA812M3	MMBA812M4	MMBA812M5	MMBA812M6	MMBA812M7
MARK.	M3	M4	M5	M6	M7

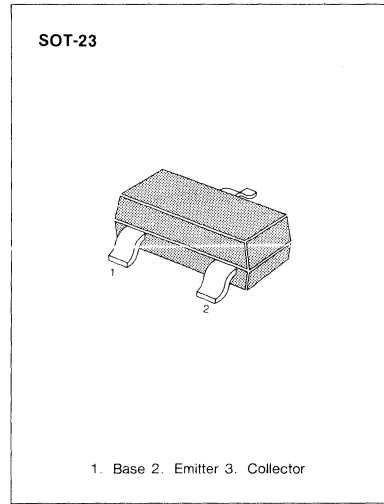
Marking



AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	50	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	50	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C



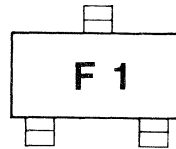
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cut-off Current	I _{CBO}	V _{CB} =15V, I _E =0			100	nA
DC Current Gain	h _{FE}	V _{CE} =3V, I _C =0.5mA				
			30		60	
			40		80	
			60		120	
			90		180	
			135		270	
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C =10mA, I _B =1mA			0.3	V
Current Gain-Bandwidth Product	f _T	I _C =1mA, V _{CE} =6V f=100MHz	150			MHz
Output Capacitance	C _{OB}	V _{CB} =6V, I _E =0 f=1MHz		2		pF
Noise Figure	N _F	V _{CE} =6V, I _C =0.5mA f=1MHz, R _G =500Ω		2.5		dB

MARKING CODE

TYPE	MMBC1009F1	MMBC1009F2	MMBC1009F3	MMBC1009F4	MMBC1009F5
MARK.	F1	F2	F3	F4	F5

Marking



3

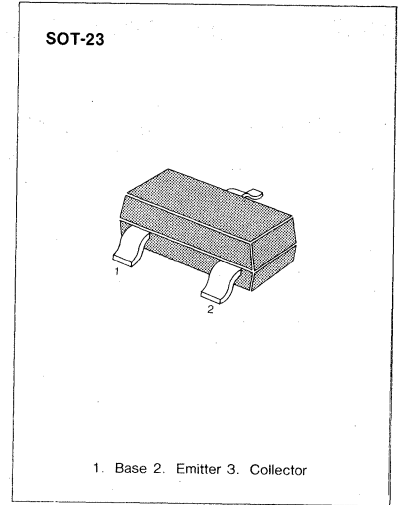
MMBC1622D6/D7/D8

NPN EPITAXIAL SILICON TRANSISTOR

AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	40	V
Collector-Emitter Voltage	V_{CEO}	35	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$



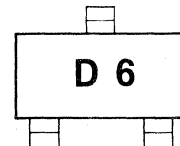
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$		50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$		50	nA
DC Current Gain	h_{FE}	$V_{CE} = 3\text{V}, I_C = 0.1\text{mA}$	150		
			200	400	
			300	600	
			450	900	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100\text{mA}, I_B = 10\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 3\text{V}, I_C = 0.5\text{mA}$	0.55	0.65	V
Current Gain-Bandwidth Product	f_T	$I_C = 1\text{mA}, V_{CE} = 6\text{V}$ $f = 100\text{MHz}$	100		MHz

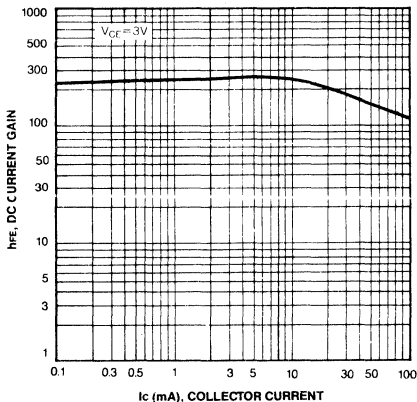
MARKING CODE

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MARK.	D6	D7	D8

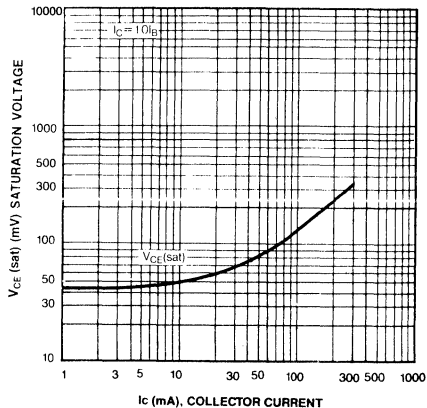
Marking



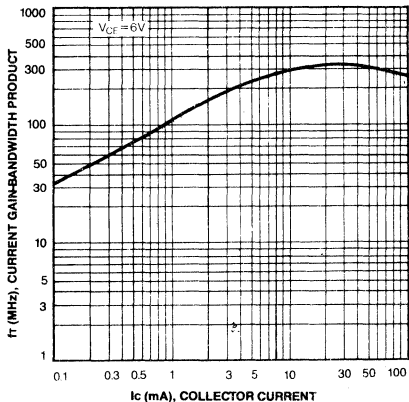
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN BANDWIDTH PRODUCT



3

MMBC1623L3/L4/L5/L6/L7

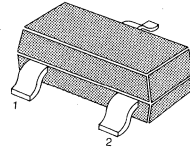
NPN EPITAXIAL SILICON TRANSISTOR

AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

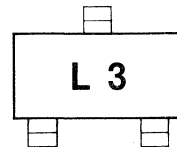
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector Cut-off Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}, I_C=1.0\text{mA}$			
	:MMBC1623L3		60	120	
	MMBC1623L4		90	180	
	MMBC1623L5		135	270	
	MMBC1623L6		200	400	
	MMBC1623L7		300	600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=100\text{mA}, I_B=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=100\text{mA}, I_B=10\text{mA}$		1.0	V
Base-Emitter on Voltage	$V_{BE(on)}$	$V_{CE}=6\text{V}, I_C=1.0\text{mA}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CED}=6\text{V}$ $f=100\text{MHz}$	200		MHz

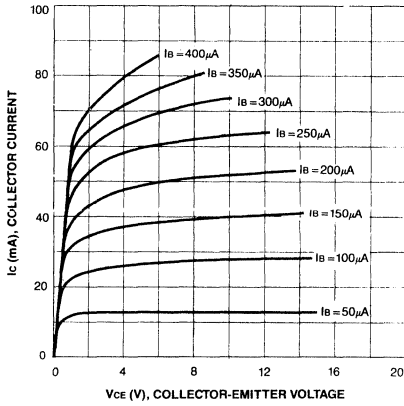
MARKING CODE

TYPE	MMBC1623L3	MMBC1623L4	MMBC1623L5	MMBC1623L6	MMBC1623L7
MARK.	L3	L4	L5	L6	L7

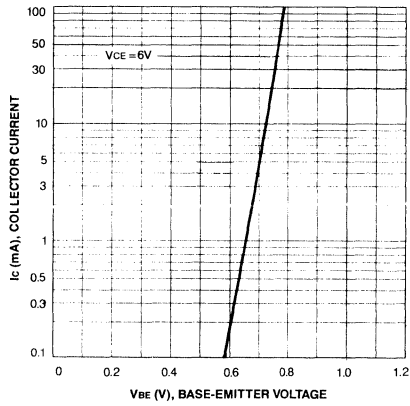
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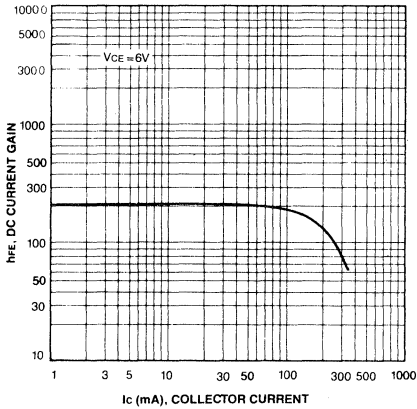
STATIC CHARACTERISTIC



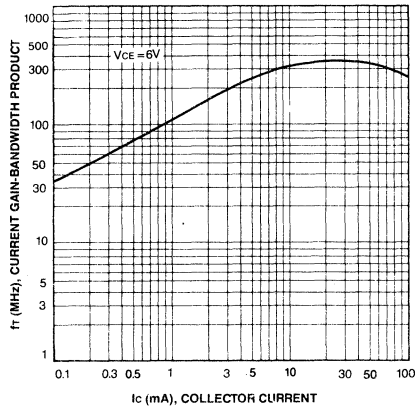
TRANSFER CHARACTERISTIC



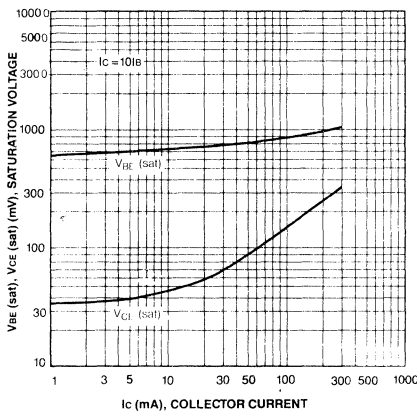
DC CURRENT GAIN



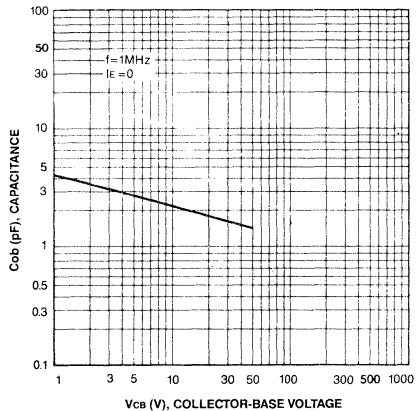
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

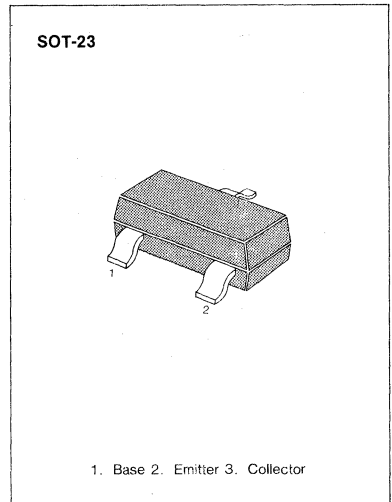


3

RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25 °C)

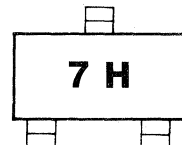
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	20	V
Collector-Emitter Voltage	V _{CEO}	12	V
Emitter-Base Voltage	V _{EBO}	2.5	V
Collector Current	I _C	50	mA
Collector Dissipation (T _a = 25 °C)	P _C	350	mW
Derate above 25 °C		2.8	mW/°C
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



ELECTRICAL CHARACTERISTICS (T_a = 25 °C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 0.01 mA, I _E = 0	20		V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 3 mA, I _B = 0	12		V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = 0.01 mA, I _C = 0	2.5		V
Collector Cutoff Current	I _{CBO}	V _{CB} = 15 V, I _E = 0		0.02	μA
DC Current Gain	h _{FE}	V _{CE} = 1 V, I _C = 3 mA	25		
Collector Emitter Saturation Voltage	V _{CE (sat)}	I _C = 10 mA, I _B = 1 mA		0.4	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = 10 mA, I _B = 1 mA		1	V
Current Gain Bandwidth Product	f _T	V _{CE} = 6 V, I _C = 5 mA, f = 100 MHz	900		MHz
Collector Base Capacitance	C _{cb}	V _{CB} = 10 V, I _E = 0, f = 0.1 MHz to 1 MHz		1	pF
Small Signal Current Gain	h _{fe}	V _{CE} = 6 V, I _C = 2 mA, f = 1 KHz	25		
Noise Figure	NF	V _{CE} = 6 V, I _C = 1.5 mA, f = 200 MHz R _S = 50 Ω		4.5	dB
Common Emitter Amplifier Power Gain	G _{pe}	V _{CE} = 6 V, I _C = 5 mA, f = 200 MHz	15		dB

Marking

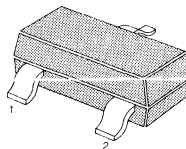


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



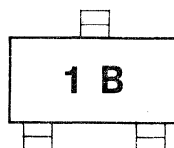
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

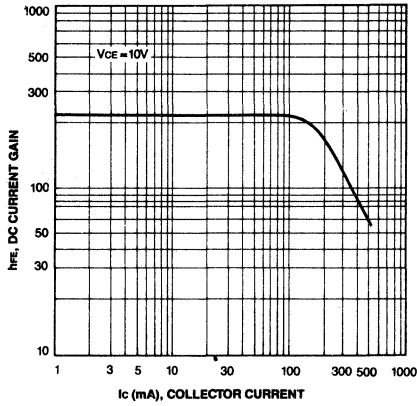
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CEX}	$V_{CE} = 60\text{V}, V_{BE} = 3\text{V}$		10	nA
Collector Cutoff Current	I_{CBO}	$V_{CB} = 50\text{V}, I_E = 0$		0.01	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 0.1\text{mA}$	35		
		$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}$	50		
		$V_{CE} = 10\text{V}, I_C = 10\text{mA}$	75		
		* $V_{CE} = 10\text{V}, I_C = 150\text{mA}$	100	300	
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	* $V_{CE} = 10\text{V}, I_C = 500\text{mA}$	30		
		$I_C = 150\text{mA}, I_B = 15\text{mA}$		0.4	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 500\text{mA}, I_B = 50\text{mA}$		1.6	V
		$I_C = 150\text{mA}, I_B = 15\text{mA}$		1.3	V
Current Gain-Bandwidth Product	f_T	$I_C = 500\text{mA}, I_B = 50\text{mA}$		2.6	V
		$I_C = 20\text{mA}, V_{CE} = 20\text{V}$	250		MHz
Output Capacitance	C_{ob}	$f = 100\text{MHz}$			
		$V_{CB} = 10\text{V}, I_E = 0$		8.0	pF
Turn On Time	t_{on}	$f = 1.0\text{MHz}$			
		$V_{CC} = 30\text{V}, V_{BE} = 0.5\text{V}$		35	ns
Turn Off Time	t_{off}	$I_C = 150\text{mA}, I_{B1} = 15\text{mA}$			
		$V_{CC} = 30\text{V}, I_C = 150\text{mA}$		285	ns
		$I_{B1} = I_{B2} = 15\text{mA}$			

*Pulse test: Pulse Width=300 μs , Duty Cycle=2%

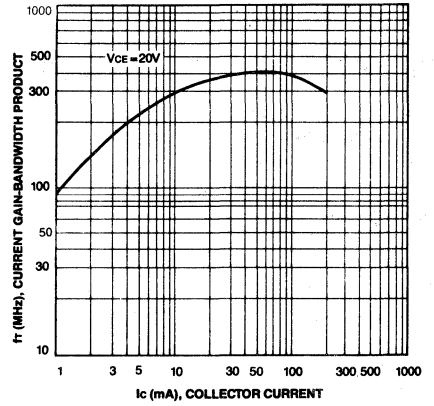
Marking



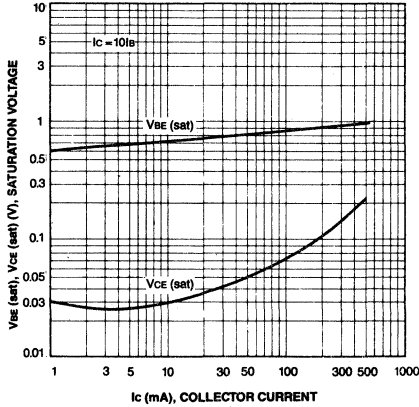
DC CURRENT GAIN



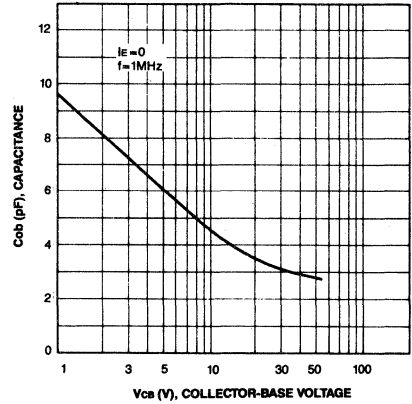
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

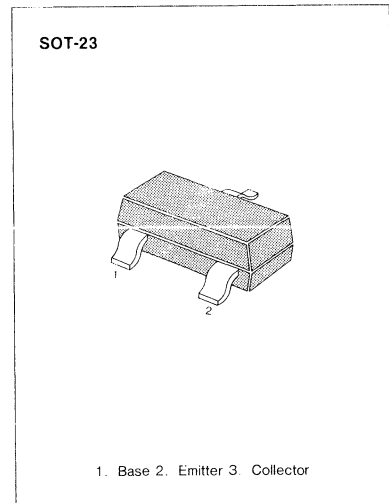


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V_{CB0}	75	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

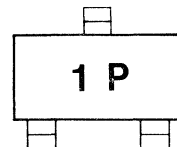
• Refer to MMBT2222 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	75		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 60\text{V}, I_E = 0$		0.01	μA
*DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 0.1\text{mA}$	35		
		$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	50		
		$V_{CE} = 10\text{V}, I_C = 10\text{mA}$	75		
		$V_{CE} = 10\text{V}, I_C = 150\text{mA}$	100	300	
		$V_{CE} = 10\text{V}, I_C = 500\text{mA}$	40		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 150\text{mA}, I_B = 15\text{mA}$		0.3	V
		$I_C = 500\text{mA}, I_B = 50\text{mA}$		1.0	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 150\text{mA}, I_B = 15\text{mA}$	0.6	1.2	V
		$I_C = 500\text{mA}, I_B = 50\text{mA}$		2.0	V
Current Gain-Bandwidth Product	f_T	$I_C = 20\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	300		MHz
Collector-Base Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		8	pF
Noise Figure	NF	$I_C = 100\mu\text{A}, V_{CE} = 10\text{V}$ $R_S = 1\text{K}\Omega, f = 1\text{KHz}$	4	4	dB
Turn On Time	t_{on}	$V_{CC} = 30\text{V}, I_C = 150\text{mA}$ $V_{BE} = 0.5\text{V}, I_{B1} = 15\text{mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC} = 30\text{V}, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$		285	ns

*Pulse test: Pulse Width=300 μs , Duty Cycle=2%

Marking

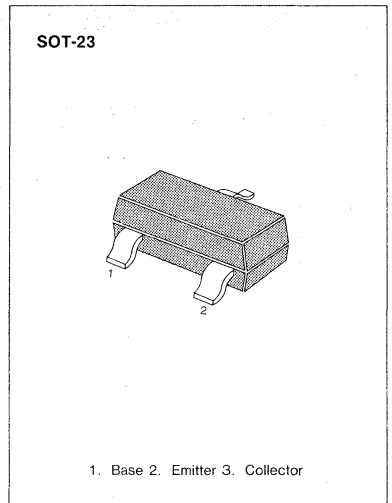


LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	60	V
Collector-Emitter Voltage	V _{CEO}	60	V
Emitter-Base Voltage	V _{EBO}	6	V
Collector Current	I _C	50	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

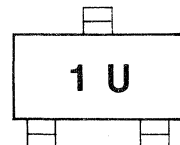
• Refer to MMBT5088 for graphs



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 10μA, I _E = 0	60		V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 10mA, I _B = 0	60		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 10μA, I _C = 0	5		V
Collector Cutoff Current	I _{CBO}	V _{CB} = 45V, I _E = 0		10	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = 5V, I _C = 0		10	nA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 1mA	250		
		V _{CE} = 5V, I _C = 10μA		800	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C = 1mA, I _B = 0.1mA		0.35	V
Base-Emitter On Voltage	V _{BE} (on)	I _C = 1mA, V _{CE} = 5V		0.95	V
Output Capacitance	C _{ob}	V _{CB} = 5.0V, I _E = 0 f = 1MHz		6	pF
Noise Figure	NF	I _C = 10μA, V _{CE} = 5V R _S = 10KΩ, f = 1KHz		3	dB

Marking

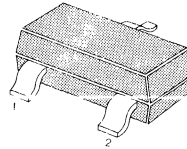


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-60	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



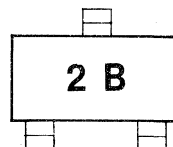
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

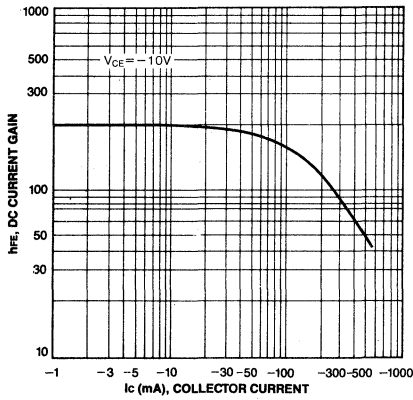
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -10\mu\text{A}, I_E = 0$	-60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CEX}	$V_{CE} = -30\text{V}, V_{BE} = -0.5\text{V}$		-50	nA
Collector Cutoff Current	I_{CBO}	$V_{CB} = -50\text{V}, I_E = 0$		-0.02	μA
DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -0.1\text{mA}$	35		
		$V_{CE} = -10\text{V}, I_C = -1.0\text{mA}$	50		
		$V_{CE} = -10\text{V}, I_C = -10\text{mA}$	75		
		* $V_{CE} = -10\text{V}, I_C = -150\text{mA}$	100	300	
		* $V_{CE} = -10\text{V}, I_C = -500\text{mA}$	30		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$		-0.4	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-1.6	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$		-1.3	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-2.6	V
Current Gain-Bandwidth Product	f_T	$I_C = -50\text{mA}, V_{CE} = -20\text{V}$ $f = 100\text{MHz}$	200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		8.0	pF
Turn On Time	t_{on}	$V_{CC} = -30\text{V}, I_C = -150\text{mA}$ $I_{B1} = -15\text{mA}$		45	ns
Turn Off Time	t_{off}	$V_{CC} = -6\text{V}, I_C = -150\text{mA}$ $I_{B1} = I_{B2} = -15\text{mA}$		100	ns

*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

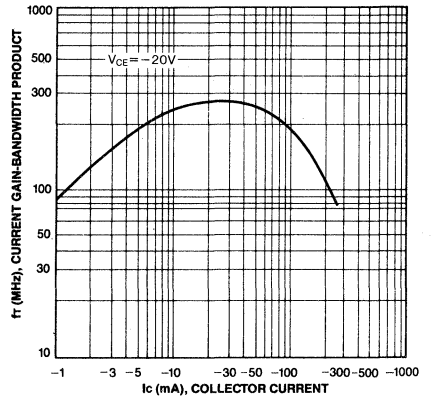
Marking



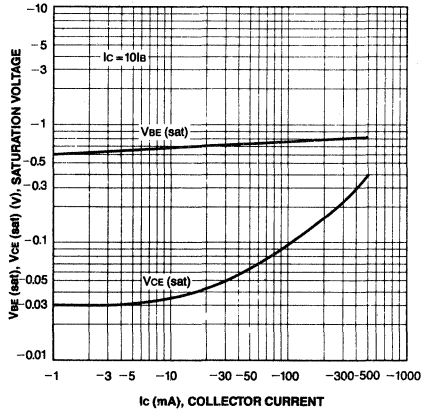
DC CURRENT GAIN



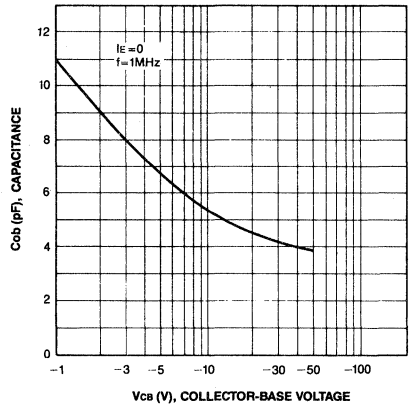
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



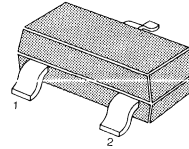
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-60	V
Collector-Emitter Voltage	V_{CEO}	-60	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

*Refer to MMBT2907 for graphs

SOT-23



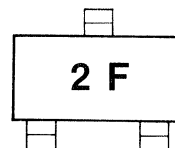
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -10\mu\text{A}, I_E = 0$	-60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-60		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -50\text{V}, I_E = 0$		-0.01	μA
DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_E = -0.1\text{mA}$	75		
		$V_{CE} = -10\text{V}, I_C = -1.0\text{mA}$	100		
		$V_{CE} = -10\text{V}, I_C = -10\text{mA}$	100		
		* $V_{CE} = -10\text{V}, I_C = -150\text{mA}$	100	300	
		* $V_{CE} = -10\text{V}, I_C = -500\text{mA}$	50		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$		-0.4	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-1.6	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$		-1.3	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-2.6	V
Current Gain-Bandwidth Product	f_T	$I_C = -50\text{mA}, V_{CE} = -20\text{V}$ $f = 100\text{MHz}$	200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		8	pF
Turn On Time	t_{on}	$V_{CC} = -30\text{V}, I_C = -150\text{mA}$ $I_{B1} = -15\text{mA}$		50	ns
Turn Off Time	t_{off}	$V_{CC} = -6\text{V}, I_C = -150\text{mA}$ $I_{B1} = I_{B2} = -15\text{mA}$		110	ns

*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

Marking

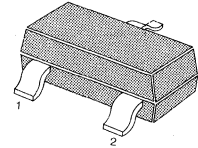


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-60	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-6	V
Collector Current	I _C	-200	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a=25°C)

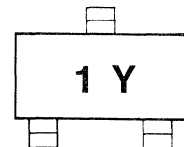
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C =10μA, I _E =0	60		V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C =1mA, I _B =0	40		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =10μA, I _C =0	6		V
Collector Cut-off Current	I _{CEX}	V _{CE} =30V, V _{EB} =3V		50	nA
DC Current Gain	h _{FE}	V _{CE} =1V, I _C =0.1mA	20		
	:MMBT3903		40		
	MMBT3904		35		
	MMBT3903	V _{CE} =1V, I _C =1mA	70		
	MMBT3904		50	150	
	MMBT3903	V _{CE} =1V, I _C =10mA	100	300	
	MMBT3904		30		
	MMBT3903	V _{CE} =1V, I _C =50mA	60		
	MMBT3904		15		
	MMBT3903	V _{CE} =1V, I _C =100mA	30		
	MMBT3904				
*Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C =10mA, I _B =1mA		0.2	V
		I _C =50mA, I _B =5mA		0.3	V
*Base-Emitter Saturation Voltage	V _{BE} (sat)	I _C =10mA, I _B =1mA	0.65	0.85	V
		I _C =50mA, I _B =5mA		0.95	V
Output Capacitance	C _{OB}	V _{CB} =5V, I _E =0		4	pF
		f=1MHz			
Current Gain Bandwidth Product	f _T	V _{CE} =20V, I _C =10mA			
	:MMBT3903	f=100MHz	250		MHz
	MMBT3904		300		MHz
Noise Figures	N _F	I _C 100μA, V _{CE} =5V			
		R _S =1KΩ			
		f=10Hz to 15.7KHz		6	dB
	:MMBT3903			5	dB
	MMBT3904			70	ns
Turn On Time	t _{ON}	V _{CC} =3V, V _{BE} =0.5V			
		I _C =10mA, I _B 1=1mA			
Turn Off Time	t _{OFF}	V _{CC} =3V, I _C =10mA			
	:MMBT3903	I _B 1=I _B 2=1mA		225	ns
	MMBT3904			250	ns

*Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

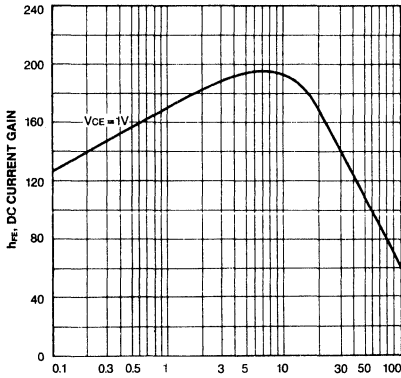
Marking

MARKING CODE

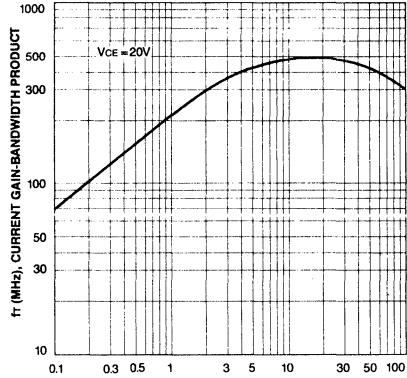
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MARK.	1Y	1A



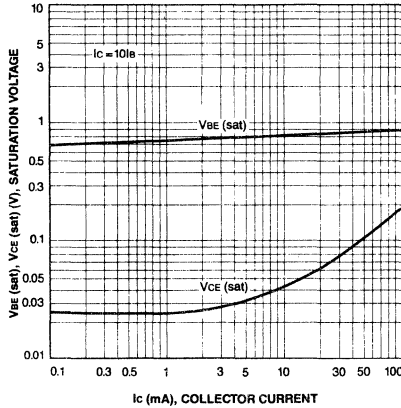
DC CURRENT GAIN



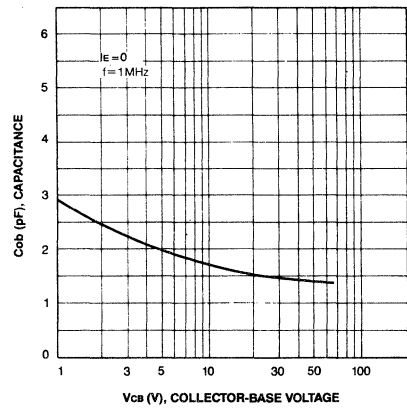
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



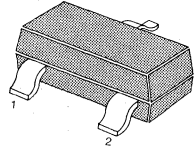
3

GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-40	V
Collector-Emitter Voltage	V_{CE0}	-40	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current	I_C	-200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



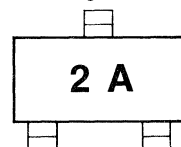
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

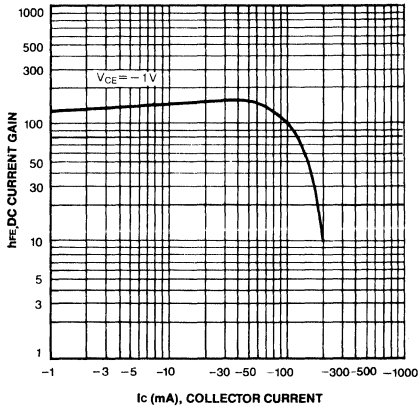
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -10\mu\text{A}, I_E = 0$	-40		V
*Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1.0\text{mA}, I_B = 0$	-40		V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CEX}	$V_{CE} = -30\text{V}, V_{EB} = -3\text{V}$		-50	nA
*DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -0.1\text{mA}$	60		
		$V_{CE} = -1\text{V}, I_C = -1\text{mA}$	80		
		$V_{CE} = -1\text{V}, I_C = -10\text{mA}$	100	300	
		$V_{CE} = -1\text{V}, I_C = -50\text{mA}$	60		
		$V_{CE} = -1\text{V}, I_C = -100\text{mA}$	30		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}, I_B = -1\text{mA}$		-0.25	V
		$I_C = -50\text{mA}, I_B = -5.0\text{mA}$		-0.4	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10\text{mA}, I_B = -1.0\text{mA}$	-0.65	-0.85	V
		$I_C = -50\text{mA}, I_B = -5.0\text{mA}$		-0.95	V
Current Gain-Bandwidth Product	f_T	$I_C = -10\text{mA}, V_{CE} = -20\text{V}$ $f = 100\text{MHz}$	250		MHz
Output Capacitance	C_{ob}	$V_{CB} = -5\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		4.5	pF
Noise Figure	NF	$I_C = -100\mu\text{A}, V_{CE} = -5\text{V}$ $R_S = 1\text{K}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$		4	dB
Turn On Time	t_{on}	$V_{CC} = -3\text{V}, V_{BE} = -0.5\text{V}$ $I_C = -10\text{mA}, I_{B1} = -1\text{mA}$		70	ns
Turn Off Time	t_{off}	$V_{CC} = -3\text{V}, I_C = -10\text{mA}$ $I_{B1} = I_{B2} = -1\text{mA}$		300	ns

* Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

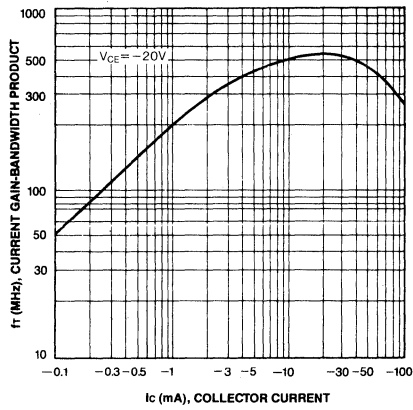
Marking



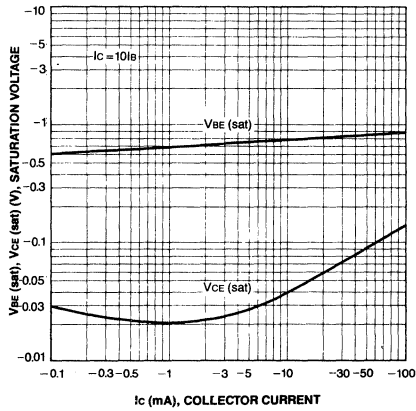
DC CURRENT GAIN



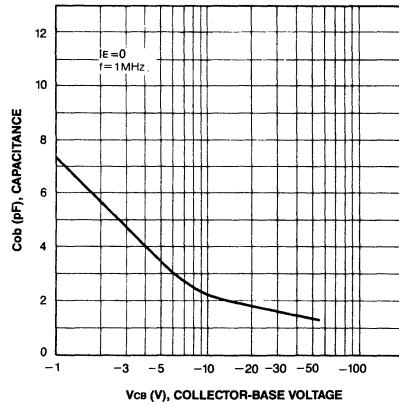
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



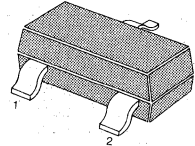
3

GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	40	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

SOT-23



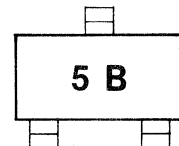
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 10\mu\text{A}, I_E = 0$	40		V
* Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_E = 0$	30		V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CB0}	$V_{CB} = 20\text{V}, I_E = 0$		50	nA
Emitter Cutoff Current	I_{EB0}	$V_{BE} = 3\text{V}, I_C = 0$		50	nA
* DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 2\text{mA}$ $V_{CE} = 1\text{V}, I_C = 50\text{mA}$	50 25	150	
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 50\text{mA}, I_B = 5\text{mA}$		0.3	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 50\text{mA}, I_B = 5\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 20\text{V}, I_C = 10\text{mA}, f = 100\text{MHz}$	250		MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 5\text{V}, I_E = 0, f = 100\text{MHz}$		4	pF
Collector Input Capacitance	C_{ib}	$V_{BE} = 0.5\text{V}, I_C = 0, f = 100\text{KHz}$		8	pF
Collector-Base Capacitance	C_{cb}	$V_{CB} = 5\text{V}, I_E = 0, f = 100\text{KHz}$		4	pF
Noise Figure	NF	$V_{CE} = 5\text{V}, I_C = 100\mu\text{A}, R_s = 1\text{k}\Omega$ Noise Bandwidth = 10Hz to 15.7KHz		6	dB

* Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

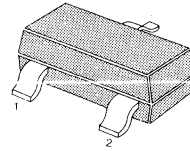
• Refer to MMBT3904 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1.0\text{mA}, I_B = 0$	25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$		50	nA
* DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 2\text{mA}$	120	360	
		$V_{CE} = 1\text{V}, I_C = 50\text{mA}$	60		
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5.0\text{mA}$		0.3	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5.0\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 5\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		4	pF
Noise Figure	NF	$I_C = 100\mu\text{A}, V_{CE} = 5\text{V}$ $R_S = 1\text{K}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$		5	dB

* Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

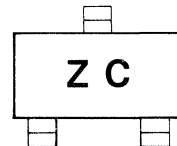
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-30	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

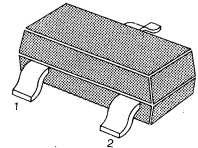
- Refer to MMBT 3906 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}$, $I_E = 0$	-30		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}$, $I_E = 0$	-30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}$, $I_C = 0$	-4		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -20\text{V}$, $I_E = 0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -3\text{V}$, $I_C = 0$		-50	nA
*DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}$, $I_C = -2.0\text{mA}$	50	150	
		$V_{CE} = -1\text{V}$, $I_C = -50\text{mA}$	25		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -50\text{mA}$, $I_B = -5.0\text{mA}$		-0.4	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -50\text{mA}$, $I_B = -5.0\text{mA}$		-0.95	V
Current Gain-Bandwidth Product	f_T	$I_C = -10\text{mA}$, $V_{CE} = -20\text{V}$ $f = 100\text{MHz}$	200		MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = -5\text{V}$, $I_E = 0$ $f = 100\text{KHz}$		4.5	pF
Noise Figure	NF	$I_C = -100\mu\text{A}$, $V_{CE} = -5\text{V}$ $R_S = 1\text{K}\Omega$, $f = 10\text{Hz to } 15.7\text{KHz}$		5	dB

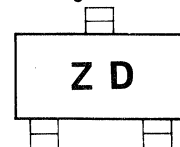
* Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

SOT-23



1. Base 2. Emitter 3. Collector

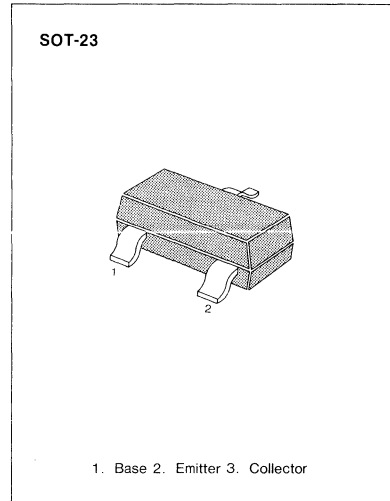
Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-25	V
Collector-Emitter Voltage	V _{CEO}	-25	V
Emitter-Base Voltage	V _{EBO}	-4	V
Collector Current	I _C	-200	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C
Thermal Resistance Junction to Ambient	R _{th(j-a)}	357	°C/W

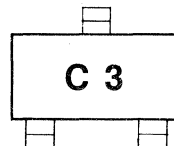


ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -10μA, I _E = 0	-25		V
* Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _E = 0	-25		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-4		V
Collector Cutoff Current	I _{CBO}	V _{CB} = -20V, I _E = 0		-50	nA
Emitter Cutoff Current	I _{EBO}	V _{BE} = -3V, I _C = 0		-50	nA
* DC Current Gain	h _{FE}	V _{CE} = -1V, I _C = -2mA	120	360	
		V _{CE} = -1V, I _C = -50mA	60		
* Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -50mA, I _B = -5mA		-0.4	V
* Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = -50mA, I _B = -5mA		-0.95	V
Current Gain-Bandwidth Product	f _T	V _{CE} = -20V, I _C = -10mA, f = 100MHz	250		MHz
Collector Input Capacitance	C _{ib}	V _{BE} = -0.5V, I _C = 0, f = 1MHz		10	pF
Collector-Base Capacitance	C _{cb}	V _{CB} = -5V, I _E = 0, f = 1MHz		4.5	pF
Noise Figure	NF	V _{CE} = -5V, I _C = -100μA, R _S = 1kΩ Noise Bandwidth = 10Hz to 15.7KHz		4	dB

* Pulse Test: PW = 300μs, Duty Cycle = 2%

Marking



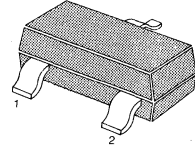
3

SWITCHING TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	60	V
Collector-Emitter Voltage	V _{CE0}	40	V
Emitter-Base Voltage	V _{EBO}	6	V
Collector Current	I _C	600	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

SOT-23



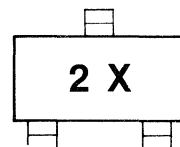
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a=25°C)

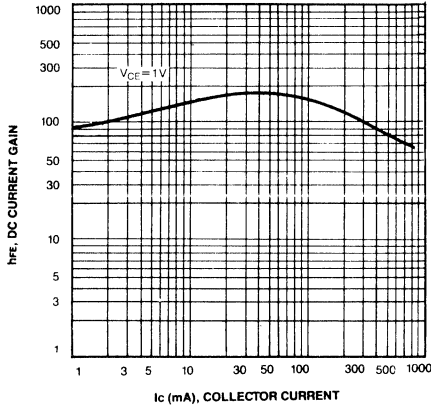
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CB0}	I _C =100μA, I _E =0	60		V
* Collector-Emitter Breakdown Voltage	BV _{CE0}	I _C =1.0mA, I _B =0	40		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =100μA, I _C =0	6		V
Base Cutoff Current	I _{BEV}	V _{CE} =35V, V _{EB} =0.4V		100	nA
Collector Cutoff Current	I _{CEX}	V _{CE} =35V, V _{BE} =0.4V		100	nA
*DC Current Gain	h _{FE}	V _{CE} =1V, I _C =0.1mA	20		
		V _{CE} =1V, I _C =1mA	40		
		V _{CE} =1V, I _C =10mA	80		
		V _{CE} =1V, I _C =150mA	100	300	
		V _{CE} =2V, I _C =500mA	40		
* Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C =150mA, I _B =15mA		0.4	V
		I _C =500mA, I _B =50mA		0.75	V
* Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C =150mA, I _B =15mA	0.75	0.95	V
		I _C =500mA, I _B =50mA		1.2	V
Current Gain-Bandwidth Product	f _T	I _C =20mA, V _{CE} =10V f=100MHz	250		MHz
Collector Base Capacitance	C _{cb}	V _{CB} =5V, I _E =0 f=100K Hz		6.5	pF
Turn On Time	t _{on}	V _{CC} =30V, V _{BE} =2V I _C =150mA, I _{B1} =15mA		35	ns
Turn Off Time	t _{off}	V _{CC} =30V, I _C =150mA I _{B1} =I _{B2} =15mA		255	ns

*Pulse Test: Pulse Width=300μs, Duty Cycle=2%

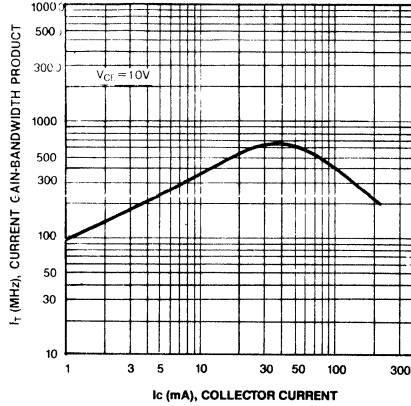
Marking



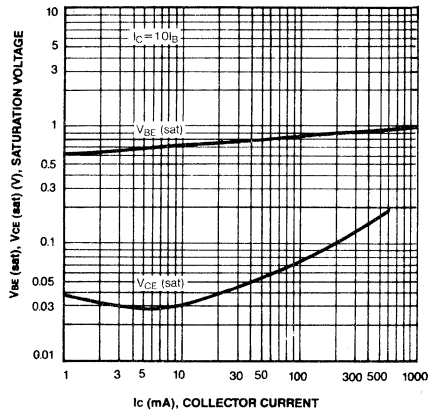
DC CURRENT GAIN



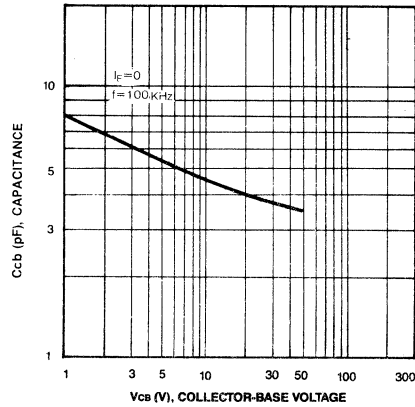
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



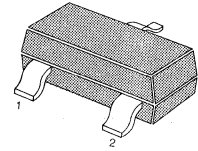
3

SWITCHING TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



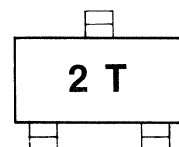
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

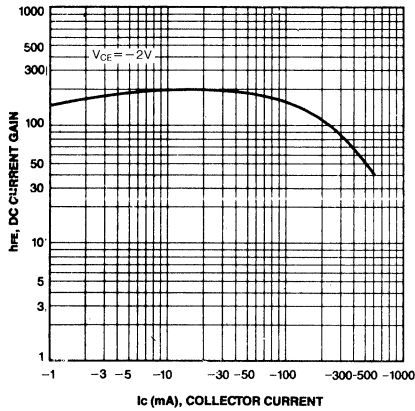
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -0.1\text{mA}, I_E = 0$	-40		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1.0\text{mA}, I_B = 0$	-40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -0.1\text{mA}, I_C = 0$	-5		V
Base Cutoff Current	I_{BEV}	$V_{CE} = -35\text{V}, V_{BE} = -0.4\text{V}$		-0.1	μA
Collector Cutoff Current	I_{CEX}	$V_{CE} = -35\text{V}, V_{BE} = -0.4\text{V}$		-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -0.1\text{mA}$	30		
		$V_{CE} = -1\text{V}, I_C = -1.0\text{mA}$	60		
		$V_{CE} = -1\text{V}, I_C = -10\text{mA}$	100		
		* $V_{CE} = -2\text{V}, I_C = -150\text{mA}$	100	300	
		* $V_{CE} = -2\text{V}, I_C = -500\text{mA}$	20		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$		-0.4	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-0.75	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -150\text{mA}, I_B = -15\text{mA}$	-0.75	-0.95	V
		$I_C = -500\text{mA}, I_B = -50\text{mA}$		-1.3	V
Current Gain-Bandwidth Product	f_T	$I_C = -20\text{mA}, V_{CE} = -10\text{V}$ $f = 100\text{MHz}$	200		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 140\text{kHz}$		8.5	pF
Turn On Time	t_{on}	$V_{CC} = -30\text{V}, V_{BE} = -2\text{V}$ $I_C = -150\text{mA}, I_{B1} = -15\text{mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC} = -30\text{V}, I_C = -150\text{mA}$ $I_{B1} = I_{B2} = -15\text{mA}$		255	ns

*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

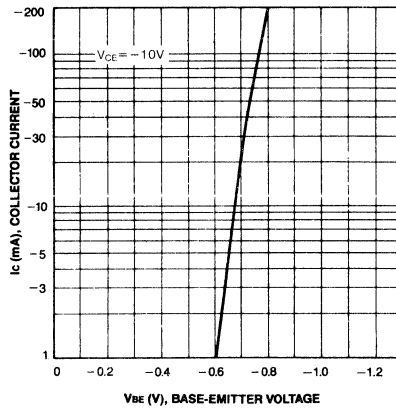
Marking



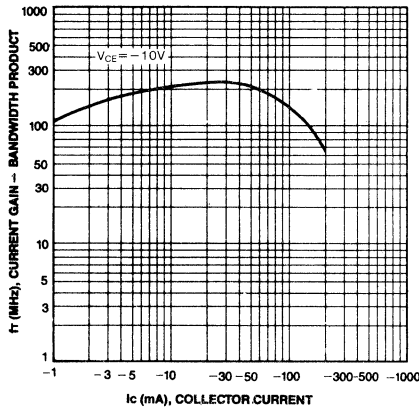
DC CURRENT GAIN



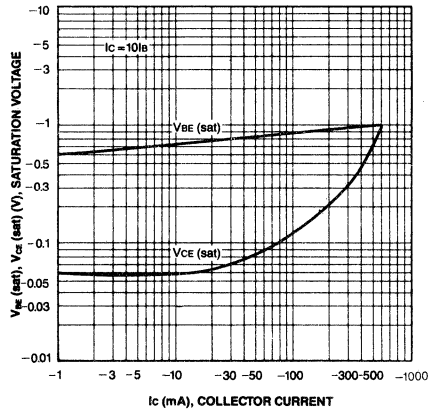
BASE-EMITTER ON VOLTAGE



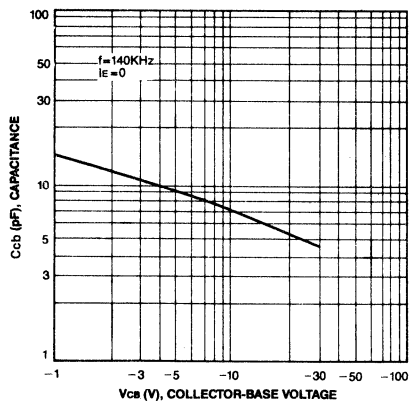
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE

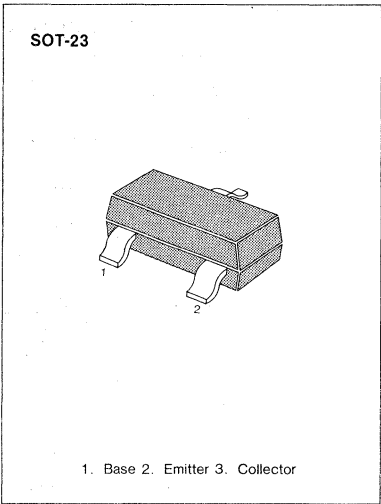


3

LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-50	V
Collector-Emitter Voltage	V _{CEO}	-50	V
Emitter-Base Voltage	V _{EBO}	-3	V
Collector Current	I _C	-50	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C



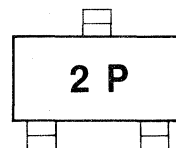
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -100μA, I _E = 0	-50		V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -1mA, I _B = 0	-50		V
Collector Cut-off Current	I _{CBO}	V _{CB} = -20V, I _E = 0		-50	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -100μA	150	500	
	:MMBT5086		250	800	
	MMBT5087		150		
	MMBT5086	V _{CE} = -5V, I _C = -1mA	250		
	MMBT5087		150		
	MMBT5086	V _{CE} = -5V, I _C = -10mA	250		
	MMBT5087		150		
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -10mA, I _B = -1mA		-0.3	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = -10mA, I _B = -1mA		-0.85	V
Current Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -500μA f = 20MHz	40		MHz
Collector Output Capacitance	C _{OB}	V _{CB} = -5V, I _E = 0 f = 100KHz		4	pF
Noise Figure	N _F	I _C = -100μA, V _{CE} = -5V R _G = 3KΩ, f = 1KHz		3	dB
	:MMBT5086			2	dB
	MMBT5087			2	dB
	MMBT5087	V _{CE} = -5V, I _C = -20mA R _S = 10KΩ f = 10Hz to 15.7KHz			dB

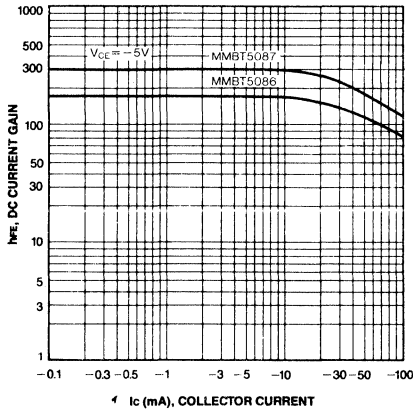
MARKING CODE

TYPE	MMBT5086	MMBT5087
MARK.	2P	2Q

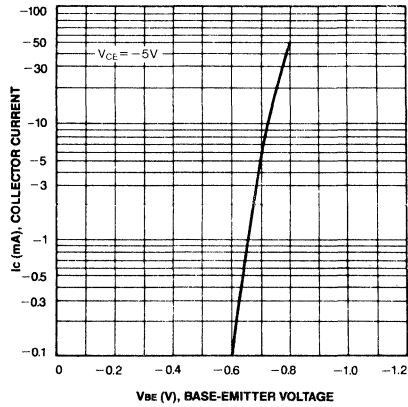
Marking



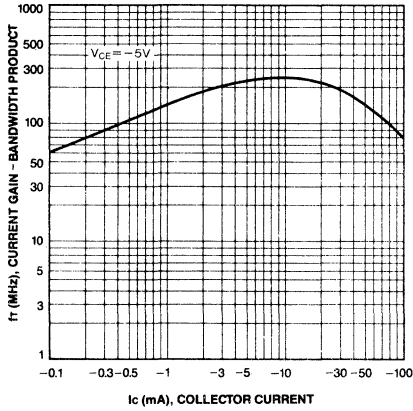
DC CURRENT GAIN



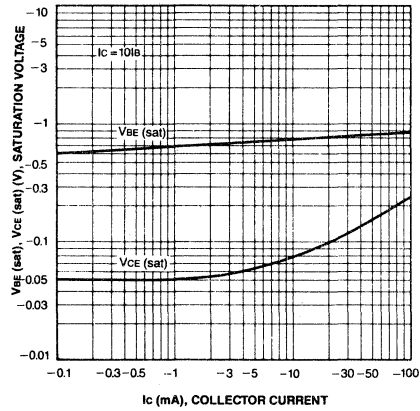
BASE-EMITTER ON VOLTAGE



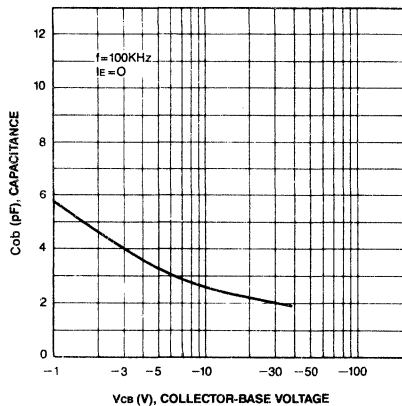
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



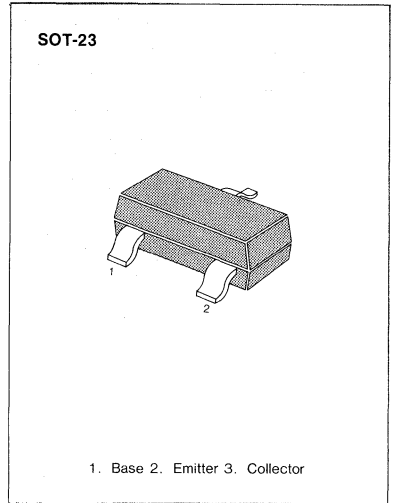
OUTPUT CAPACITANCE



LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	35	V
:MMBT5088		30	V
MMBT5089			
Collector-Emitter Voltage	V _{CEO}	30	V
:MMBT5088		25	V
:MMBT5089			
Emitter-Base Voltage	V _{EBO}	4.5	V
Collector Current	I _C	50	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{STG}	150	°C



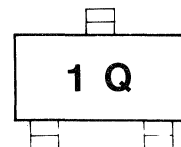
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CB0}	I _C = 100μA, I _E = 0	35		V
:MMBT5088			30		V
MMBT5089					
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 1mA, I _B = 0	30		V
:MMBT5088			25		V
MMBT5089					
Collector Cut-off Current	I _{CB0}	V _{CB} = 20V, I _E = 0		50	nA
:MMBT5088		V _{CB} = 15V, I _E = 0		50	nA
MMBT5089		V _{BE} = 3V, I _C = 0		50	nA
Emitter Cut-off Current	I _{EBO}				
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 100μA	300	900	
:MMBT5088			400	1,200	
MMBT5089		V _{CE} = 5V, I _C = 1mA	350		
MMBT5088			450		
MMBT5089		V _{CE} = 5V, I _C = 10mA	300		
MMBT5088			400		
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = 10mA, I _B = 1mA		0.5	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = 10mA, I _B = 1mA		0.8	V
Current Gain Bandwidth Product	f _T	V _{CE} = 5V, I _C = 500μA f = 20MHz	50		MHz
Collector-Base Capacitance	C _{CB}	V _{CB} = 5V, I _E = 0 f = 100KHz		4	pF
Noise Figure	N _F	I _C = 100μA, V _{CE} = 5V R _G = 10KΩ f = 10Hz to 15.7KHz		3	dB
:MMBT5088				2	dB
MMBT5089					

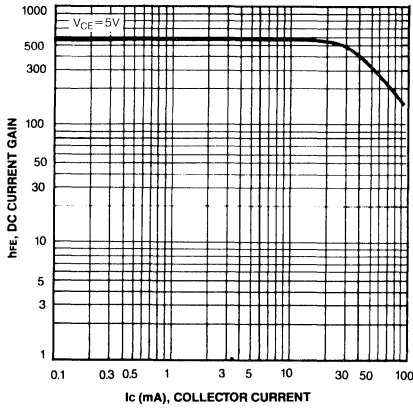
MARKING CODE

TYPE	MMBT5088	MMBT5089
MARK.	1Q	1R

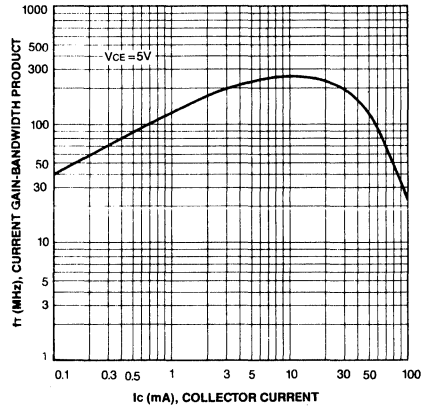
Marking



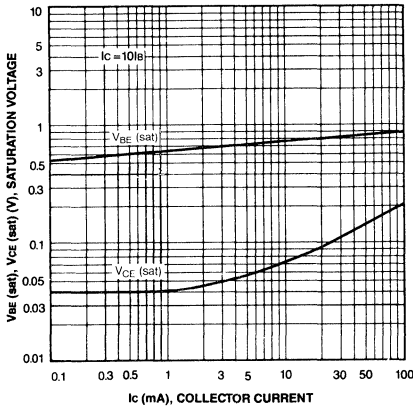
DC CURRENT GAIN



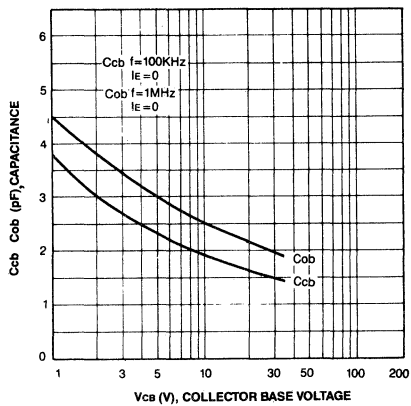
CURRENT GAIN BANDWIDTH PRODUCT



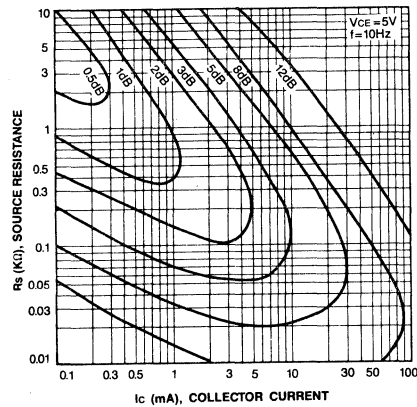
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE
COLLECTOR-BASE CAPACITANCE



NOISE FIGURE



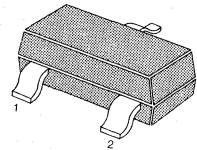
3

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-160	V
Collector-Emitter Voltage	V _{CEO}	-150	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-500	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

SOT-23

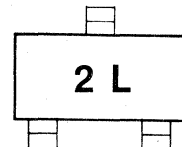


1. Base 2. Emitter 3. Collector

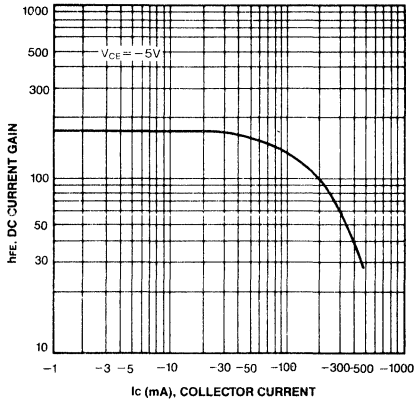
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = -100μA, I _E = 0	-160		V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = -1.0mA, I _B = 0	-150		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = -10μA, I _C = 0	-5		V
Collector Cutoff Current	I _{CBO}	V _{CB} = -100V, I _E = 0		-50	nA
DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -1.0mA	50		
		V _{CE} = -5V, I _C = -10mA	60	240	
		V _{CE} = -5V, I _C = -50mA	50		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -10mA, I _B = -1.0mA		-0.2	V
		I _C = -50mA, I _B = -5mA		-0.5	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = -10mA, I _B = -1.0mA		-1.0	V
		I _C = -50mA, I _B = -5mA		-1.0	V
Current Gain-Bandwidth Product	f _T	I _C = -10mA, V _{CE} = -10V f = 100MHz	100	300	MHz
Output Capacitance	C _{ob}	V _{CB} = -10V, I _E = 0 f = 1.0MHz		6.0	pF
Noise Figure	NF	V _{CE} = -5V, I _C = -200μA R _S = 10KΩ f = 10Hz to 15.7KHz		8.0	dB

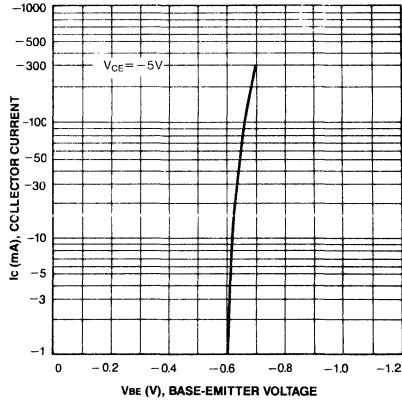
Marking



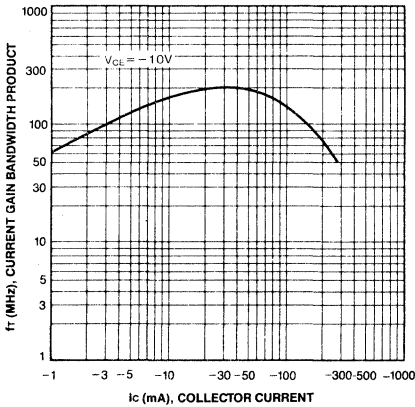
DC CURRENT GAIN



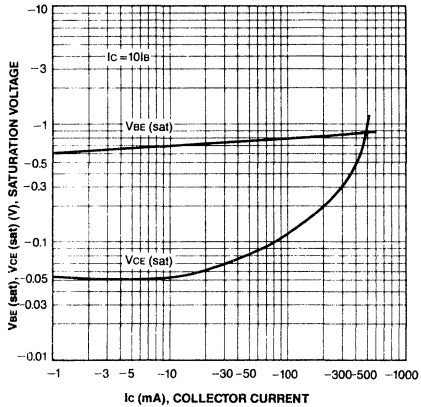
BASE-EMITTER ON VOLTAGE



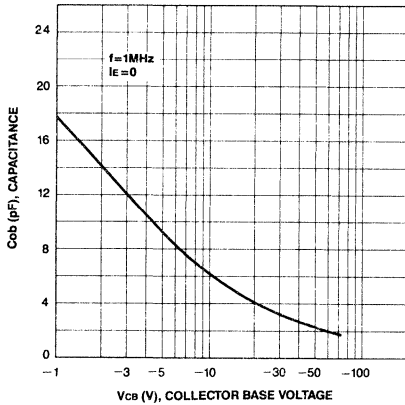
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

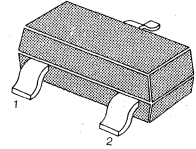


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	160	V
Collector-Emitter Voltage	V_{CE0}	140	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23

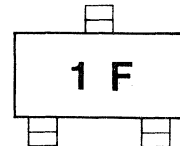


1. Base 2. Emitter 3. Collector

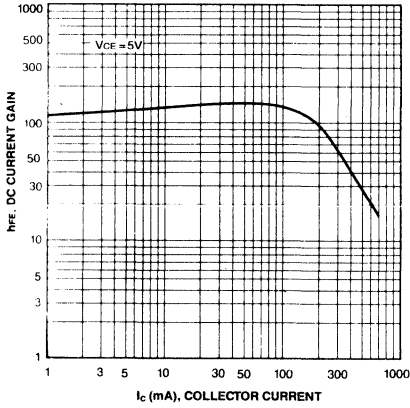
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 10\mu\text{A}$, $I_E = 0$	160		V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}$, $I_B = 0$	140		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}$, $I_C = 0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 100\text{V}$, $I_E = 0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4\text{V}$, $I_C = 0$		50	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}$, $I_C = 1.0\text{mA}$	60		
		$V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$	60	250	
		$V_{CE} = 5\text{V}$, $I_C = 50\text{mA}$	20		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$		0.15	V
		$I_C = 50\text{mA}$, $I_B = 5\text{mA}$		0.25	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$		1.0	V
		$I_C = 50\text{mA}$, $I_B = 5\text{mA}$		1.2	V
Current Gain-Bandwidth Product	f_T	$I_C = 10\text{mA}$, $V_{CE} = 10\text{V}$ $f = 100\text{MHz}$	100	300	MHz
Output Capacitance	Cob	$V_{CB} = 10\text{V}$, $I_E = 0$ $f = 1.0\text{MHz}$		6.0	pF

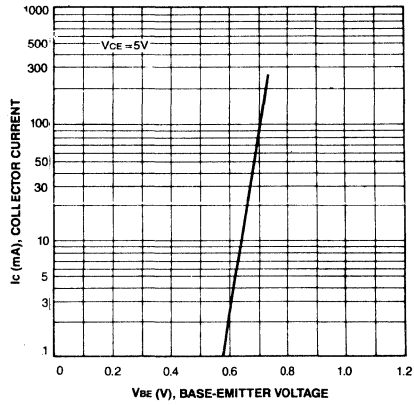
Marking



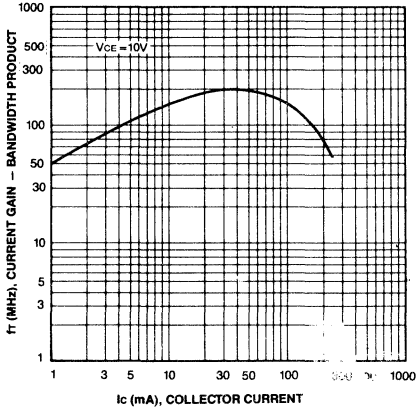
DC CURRENT GAIN



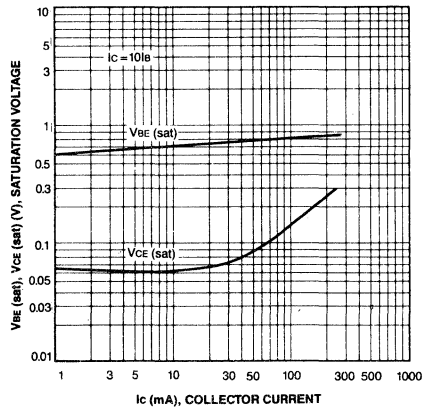
BASE-EMITTER ON VOLTAGE



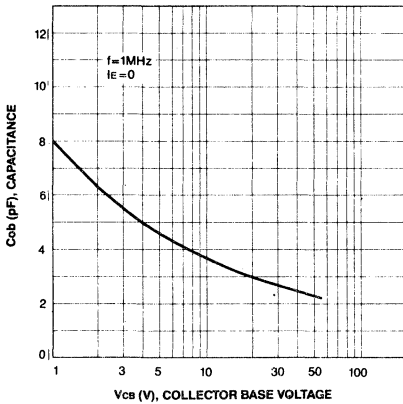
CURRENT GAIN-BANDWIDTH PRODUCT



**BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE**



OUTPUT CAPACITANCE



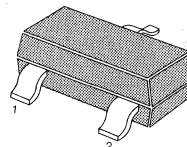
3

DARLINGTON TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	12	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23

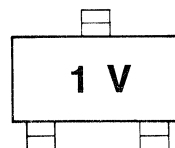


1. Base 2. Emitter 3. Collector

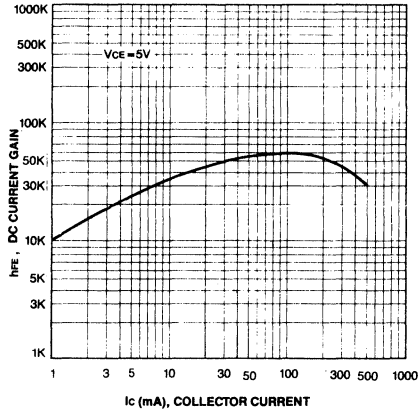
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	12		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$		50	nA
Collector Cutoff Current	I_{CEO}	$V_{CE} = 25\text{V}, I_B = 0$		1	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = 10\text{V}, I_C = 0$		50	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$	10,000	100,000	
		$V_{CE} = 5\text{V}, I_C = 100\text{mA}$	20,000	200,000	
		$V_{CE} = 5\text{V}, I_C = 500\text{mA}$	14,000	140,000	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 50\text{mA}, I_B = 0.5\text{mA}$		1.2	V
		$I_C = 500\text{mA}, I_B = 0.5\text{mA}$		1.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 500\text{mA}, I_B = 0.5\text{mA}$		2.0	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 50\text{mA}, V_{CE} = 5\text{V}$		1.75	V
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		7	pF
Noise Figure	NF	$I_C = 1\text{mA}, V_{CE} = 5\text{V}$ $R_S = 100\text{K}\Omega$ $f = 1\text{KHz to } 15.7\text{KHz}$		10	dB

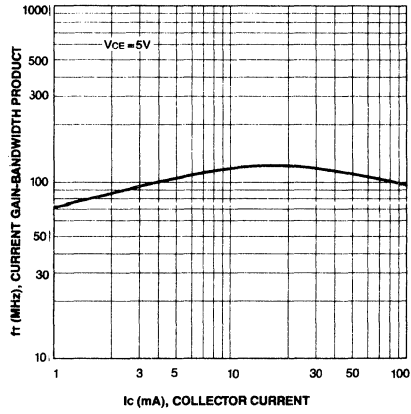
Marking



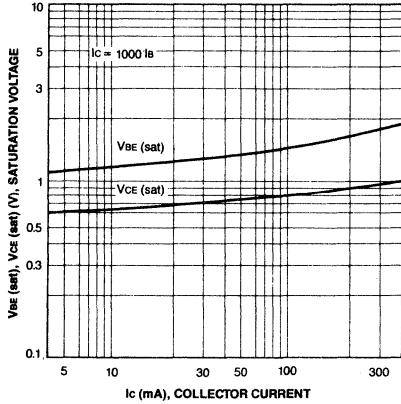
DC CURRENT GAIN



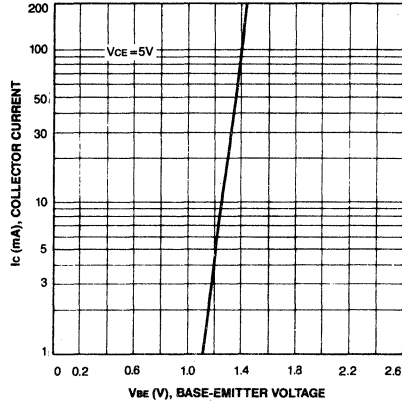
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



BASE-EMITTER ON VOLTAGE



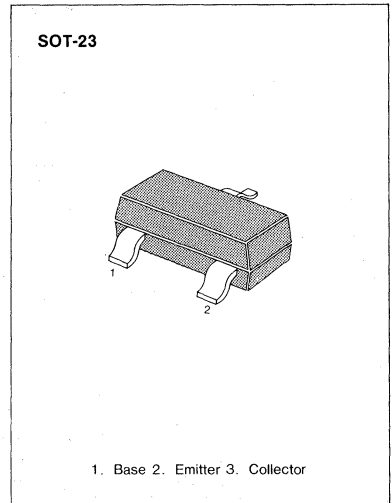
3

AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	60	V
:MMBT6428		55	V
MMBT6429			
Collector-Emitter Voltage	V _{CE0}	50	V
:MMBT6428		45	V
MMBT6429			
Emitter-Base Voltage	V _{EBO}	6	V
Collector Current	I _C	200	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{STG}	150	°C

• Refer to MMBT5088 for graphs



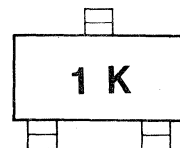
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CB0}	I _C = 100μA, I _E = 0	60		V
:MMBT6428			55		V
MMBT6429					
Collector-Emitter Breakdown Voltage	BV _{CE0}	I _C = 1mA, I _B = 0	50		V
:MMBT6428			45		V
MMBT6429					V
Collector Cut-off Current	I _{CB0}	V _{CE} = 30V, I _E = 0		0.01	μA
Collector Cut-off Current	I _{CE0}	V _{CE} = 30V, I _B = 0		0.1	μA
Emitter Cut-off Current	I _{EBO}	V _{CE} = 5V, I _C = 0		0.01	μA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 0.01mA	250		
:MMBT6428			500		
MMBT6429		V _{CE} = 5V, I _C = 0.1mA	250	650	
MMBT6428			500	1,250	
MMBT6429		V _{CE} = 5V, I _C = 1.0mA	250		
MMBT6428			500		
MMBT6429		V _{CE} = 5V, I _C = 10mA	250		
MMBT6428			500		
MMBT6429					
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = 10mA, I _B = 0.5mA		0.2	V
		I _C = 100mA, I _B = 5mA		0.6	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = 5V, I _C = 1mA	0.56	0.66	V
Output Capacitance	C _{OB}	V _{CB} = 10V, I _E = 0		3	pF
		F = 1MHz			
Current Gain Bandwidth Product	f _T	V _{CE} = 5V, I _C = 1mA	100	700	MHz
		f = 100MHz			

MARKING CODE

TYPE	MMBT6428	MMBT6429
MARK.	1K	1L

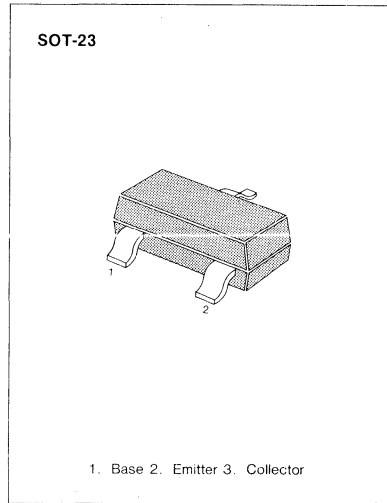
Marking



DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	60	V
:MMBTA05		80	V
MMBTA06			
Collector-Emitter Voltage	V_{CE0}	60	V
:MMBTA05		80	V
MMBTA06			
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	500	mA
Collector-Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{TH(j-a)}$	357	$^\circ\text{C/W}$



• Refer to MPSA05 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

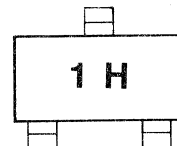
Characteristic	Symbol	Test Conditions	Min	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_B = 0$	60		V
:MMBTA05			80		V
MMBTA06			4		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60\text{V}, I_E = 0$		0.1	μA
:MMBTA05		$V_{CB} = 80\text{V}, I_E = 0$		0.1	μA
MMBTA06		$V_{CE} = 60\text{V}, I_B = 0$		0.1	μA
Collector Cut-off Current	I_{CEO}	$V_{CE} = 1\text{V}, I_C = 10\text{mA}$	50		
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100\text{mA}, I_B = 10\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$		1.2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 2\text{V}, I_C = 10\text{mA}$ $f = 100\text{MHz}$	100		MHz

*Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

MARKING CODE

TYPE	MMBTA05	MMBTA06
MARK.	1H	1G

Marking

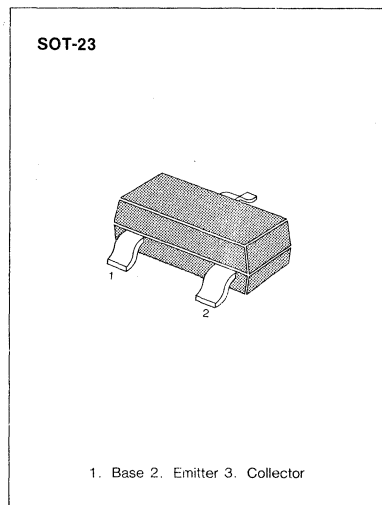


DARLINGTON AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	30	V
Collector-Emitter Voltage	V _{CES}	30	V
Emitter-Base Voltage	V _{EBO}	10	V
Collector Current	I _C	300	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C

• Refer to MMBT6427 for graphs



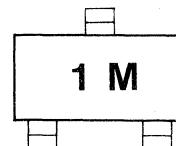
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CES}	I _C = 100μA, I _B = 0	30		V
Collector Cut-off Current	I _{CBO}	V _{CB} = 30V, I _E = 0		100	nA
Emitter Cut-off Current	I _{EBO}	V _{BE} = 10V, I _C = 0		100	nA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 10mA	5,000		
	:MMBTA13	V _{CE} = 5V, I _C = 100mA	10,000		
	MMBTA14		10,000		
	MMBTA13		20,000		
	MMBTA14				
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = 100mA, I _B = 0.1mA		1.5	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = 5V, I _C = 100mA		2.0	V
Current Gain Bandwidth Product	f _T	V _{CE} = 5V, I _C = 10mA f = 100MHz	125		MHz

MARKING CODE

TYPE	MMBTA13	MMBTA14
MARK.	1M	1N

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

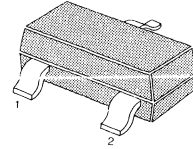
Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

• Refer to MMBT3904 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

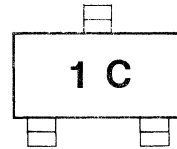
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C=1.0\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=5\text{mA}$	40	400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.25	V
Current Gain-Bandwidth Product	f_T	$I_C=5.0\text{mA}, V_{CE}=10\text{V}$ $f=100\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=100\text{KHz}$		4	pF

SOT-23



1. Base 2. Emitter 3. Collector

Marking

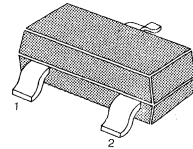


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	300	V
		200	V
Collector-Emitter Voltage	V _{CEO}	300	V
		200	V
Emitter-Base Voltage	V _{EBO}	6	V
		500	mA
Collector Current	I _C	350	mW
Collector Dissipation	P _C	150	°C
Storage Temperature	T _{STG}	357	°C/W
Thermal Temperature Junction to Ambient	R _{TH (j-a)}		

SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 100μA, I _E = 0	300		V
			200		V
*Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 1mA, I _B = 0	300		V
			200		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 100μA, I _C = 0	6		V
Collector Cut-off Current	I _{CBO}	V _{CE} = 200V, I _E = 0		0.1	μA
Emitter Cut-off Current	I _{EBO}	V _{CE} = 5V, I _C = 0		0.1	μA
*DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 1mA	25		
		V _{CE} = 10V, I _C = 10mA	40		
		V _{CE} = 10V, I _C = 30mA	40		
*Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = 20mA, I _B = 2mA		0.5	V
*Base-Emitter Saturation Voltage	V _{BE (sat)}	I _C = 20mA, I _B = 2mA		0.9	V
Collector-Base Capacitance	C _{CB}	V _{CB} = 20V, I _E = 0 f = 1MHz		3	pF
				4	pF
Current Gain bandwidth Product	f _T	V _{CE} = 20V, I _C = 10mA f = 100MHz	50		MHz

*Pulse Etst: PW=300μs, Duty Cycle=2%

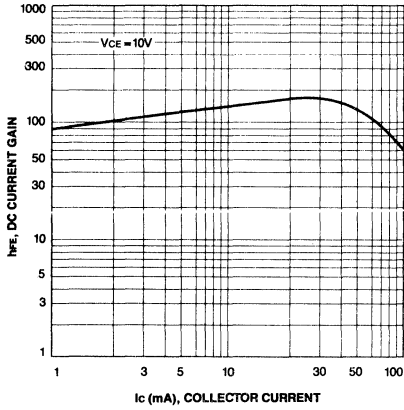
MARKING CODE

TYPE	MMBTA42	MMBTA43
MARK.	1D	1E

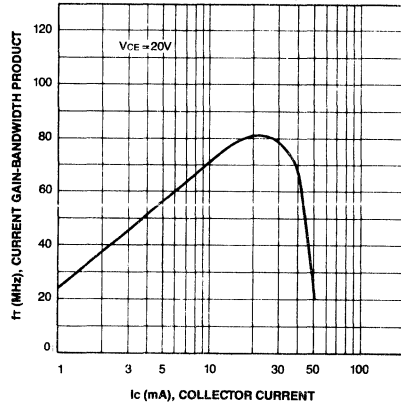
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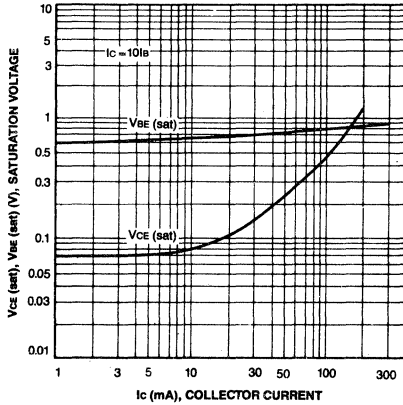
DC CURRENT GAIN



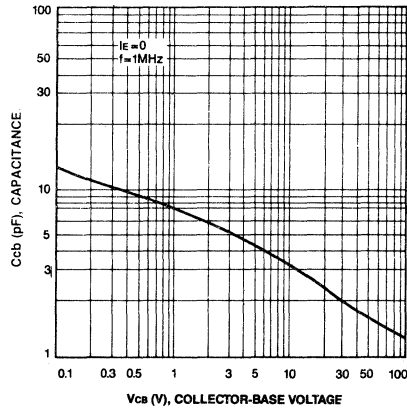
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



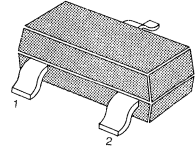
3

DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-60	V
:MMBTA55		-80	V
MMBTA56			
Collector-Emitter Voltage	V_{CE0}	-60	V
:MMBTA05		-80	V
MMBTA06			
Emitter-Base Voltage	V_{EB0}	-4	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{TH} (j-a)$	357	$^\circ\text{C/W}$

SOT-23



1. Base 2. Emitter 3. Collector

- Refer to MPSA55 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

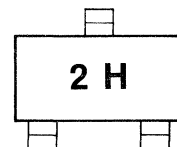
Characteristic	Symbol	Test Conditions	Min	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1\text{mA}, I_B = 0$	-60		V
:MMBTA55			-80		
MMBTA56					
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = -100\mu\text{A}, I_C = 0$	-4		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60\text{V}, I_E = 0$		-0.1	μA
Collector Cut-off Current	I_{CEO}	$V_{CE} = -60\text{V}, I_B = 0$		-0.1	μA
:MMBTA55		$V_{CE} = -80\text{V}, I_B = 0$		-0.1	μA
MMBTA56		$V_{CE} = -1\text{V}, I_C = -10\text{mA}$	50		
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -100\text{mA}, I_B = -10\text{mA}$		-0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$		-1.2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$ $f = 100\text{MHz}$	50		MHz

*Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

MARKING CODE

TYPE	MMBTA55	MMBTA56
MARK.	2H	2G

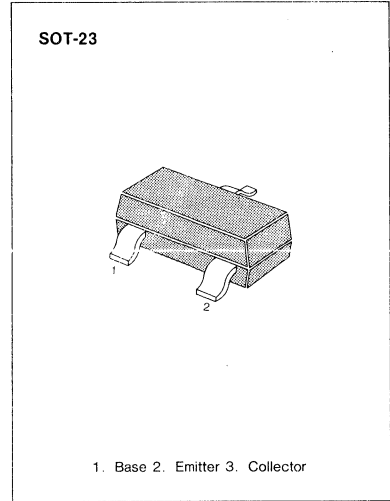
Marking



DARLINGTON TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-30	V
Collector-Emitter Voltage	V _{CES}	-30	V
Emitter-Base Voltage	V _{EBO}	-10	V
Collector Current	I _C	-500	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{stg}	150	°C



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

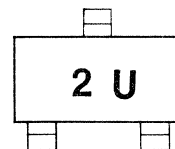
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CES}	I _C = -100μA, I _B = 0	-30		V
Collector Cut-off Current	I _{CBO}	V _{CB} = -30V, I _E = 0		-100	nA
Emitter Cut-off Current	I _{EBO}	V _{BE} = -10V, I _C = 0		-100	nA
*DC Current Gain	h _{FE}	V _{CE} = -5V, I _C = -10mA	5,000		
	MMBTA63	V _{CE} = -5V, I _C = -100mA	10,000		
	MMBTA64	V _{CE} = -5V, I _C = -100mA	10,000		
	MMBTA63	V _{CE} = -5V, I _C = -100mA	20,000		
	MMBTA64	V _{CE} = -5V, I _C = -100mA	20,000		
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _C = -100mA, I _B = -0.1mA		-1.5	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} = -5V, I _C = -100mA		-2.0	V
Current Gain Bandwidth Product	f _T	V _{CE} = -5V, I _C = -10mA f = 100MHz	125		MHz

*Pulse Test: Pulse Width=300μs, Duty Cycle=2%

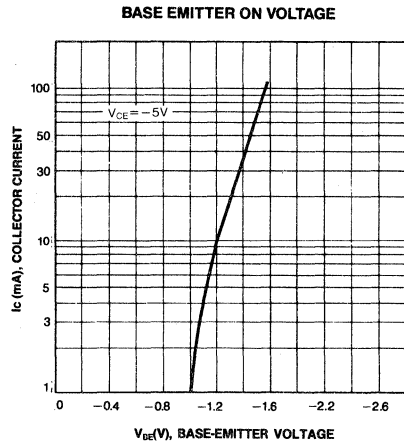
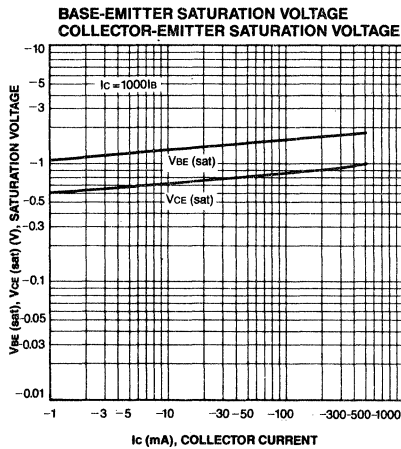
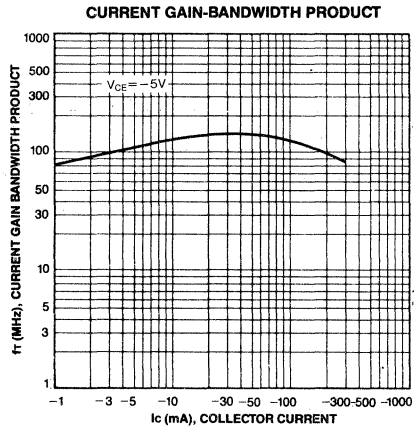
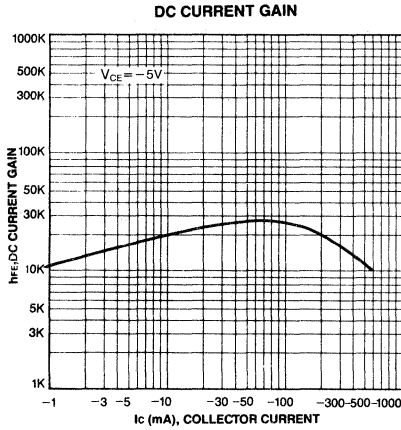
MARKING CODE

TYPE	MMBTA63	MMBTA64
MARK.	2U	2V

Marking



3

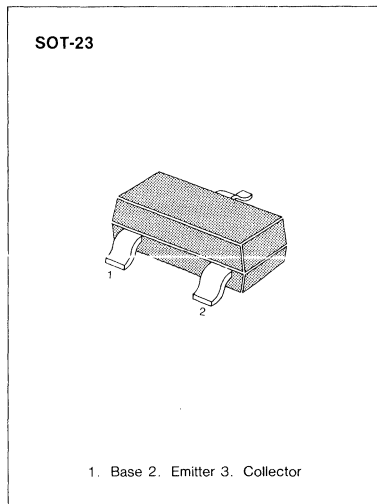


AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	-40	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	Tstg	150	$^\circ\text{C}$

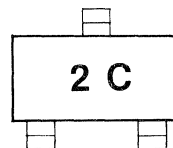
• Refer to MMBT5086 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1.0\text{mA}, I_B = 0$	-40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-4		V
Collector Cutoff Current	I_{CBO}	$V_{CE} = -30\text{V}, I_E = 0$		-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -5.0\text{mA}$	40	400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10\text{mA}, I_B = -1.0\text{mA}$		-0.25	V
Current Gain-Bandwidth Product	f_T	$I_C = -5.0\text{mA}, V_{CE} = -10\text{V}$ $f = 100\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 100\text{KHz}$		4.0	pF

Marking

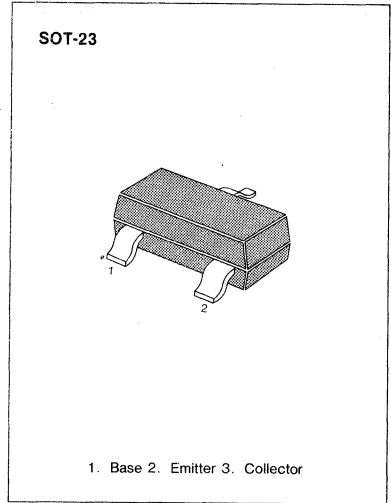


3

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CB0}	-300	V
		-200	V
Collector-Emitter Voltage	V _{CE0}	-300	V
		-200	V
Emitter-Base Voltage	V _{EBO}	-5	V
		-5	V
Collector Current	I _C	-500	mA
Collector Dissipation	P _C	350	mW
Storage Temperature	T _{STG}	150	°C
Thermal Temperature Junction to Ambient	R _{TH} (j-a)	357	°C/W



• Refer to MPSA92/93 for graphs

ELECTRICAL CHARACTERISTICS (T_a=25°C)

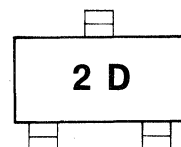
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV _{CB0}	I _C =-100μA, I _E =0	-300		V
			-200		V
*Collector-Emitter Breakdown Voltage	BV _{CE0}	I _C =-1mA, I _B =0	-300		V
			-200		V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =-100μA, I _C =0	-5		V
			-5		V
Collector Cut-off Current	I _{CBO}	V _{CB} =-200V, I _E =0 V _{CB} =-160V, I _E =0	-0.25		mA
			-0.25		μA
Emitter Cut-off Current	I _{EBO}	V _{CE} =-3V, I _C =0	-0.1		μA
			-0.1		μA
*DC Current Gain	h _{FE}	V _{CE} =-10V, I _C =-1mA V _{CE} =-10V, I _C =-10mA V _{CE} =-10V, I _C =-30mA	25		
			40		
*Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C =-20mA, I _B =-2mA	-0.5		V
			-0.5		V
*Base-Emitter Saturation Voltage	V _{BE} (sat)	I _C =-20mA, I _B =-2mA	-0.9		V
			-0.9		V
Collector-Base Capacitance	C _{CB}	V _{CB} =-20V, I _E =0 f=1MHz		6	pF
				8	pF
Current Gain Bandwidth Product	f _T	V _{CE} =-20V, I _C =-10mA f=100MHz	50		MHz

*Pulse Test: PW=300μs, Duty Cycle=2%

MARKING CODE

TYPE	MMBTA92	MMBTA93
MARK.	2D	2E

Marking



VHF/UHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

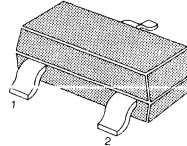
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	30	V
Collector-Emitter Voltage	V_{CE0}	25	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Dissipation	P_C	350	mW
Storage Temperature	Tstg	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

- Refer to MPSH10/11 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_B = 0$	25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	3		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = 2\text{V}, I_C = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$	60		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 4\text{mA}, I_B = 0.4\text{mA}$		0.5	V
Base-Emitter On Voltage	V_{BE}	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 4\text{mA}, f = 100\text{MHz}$	650		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.7	pF
Common-Base Feedback Capacitance	C_{rb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.65	pF
Collector Base Time Constant	$C_C \cdot r_{bb}$	$V_{CB} = 10\text{V}, I_C = 4\text{mA}, f = 31.8\text{MHz}$		9	ps

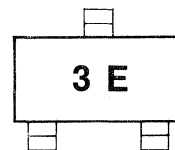
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



VHF MIXER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	40	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EB0}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

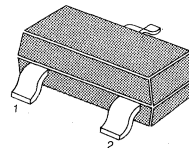
- Refer to MPSH24 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C=1\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=15\text{V}, I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=8\text{mA}$	30			
* Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=8\text{mA}$ $f=100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		0.25	0.36	pF
Conversion Gain (213MHz to 45MHz)	C_G	$I_C=8\text{mA}, V_{CC}=20\text{V}$ Oscillator Injection=150mV	19	24		dB
(60MHz to 45MHz)			24	29		dB

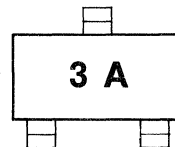
- * Pulse Test: $PW=300\mu\text{s}$, Duty Cycle=2%

SOT-23



1. Base 2. Emitter 3. Collector

Marking



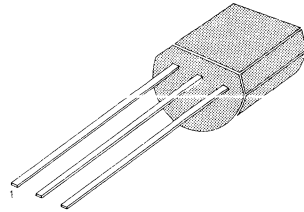
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 30V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

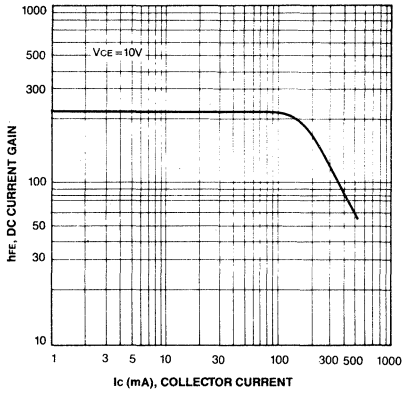
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			10	nA
DC Current Gain	h_{FE}	$I_C = 0.1mA, V_{CE} = 10V$	35			
		$I_C = 1mA, V_{CE} = 10V$	50			
		$I_C = 10mA, V_{CE} = 10V$	75			
		* $I_C = 150mA, V_{CE} = 10V$	100		300	
		* $I_C = 500mA, V_{CE} = 10V$	30			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$			0.4	V
		$I_C = 500mA, I_B = 50mA$			1.6	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$			1.3	V
		$I_C = 500mA, I_B = 50mA$			2.6	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1MHz$			8	pF
Current Gain Bandwidth Product	f_T	$I_C = 20mA, V_{CE} = 20V$ $f = 100MHz$	250			MHz
Turn On Time	t_{on}	$V_{CC} = 30V, V_{BE} = 0.5V$ $I_C = 150mA, I_{B1} = 15mA$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_C = 150mA$ $I_{B1} = I_{B2} = 15mA$			285	ns

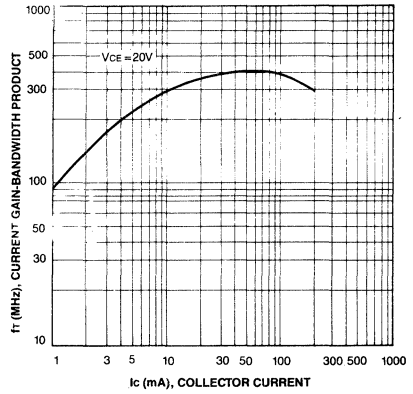
* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

Also available as a PN2222

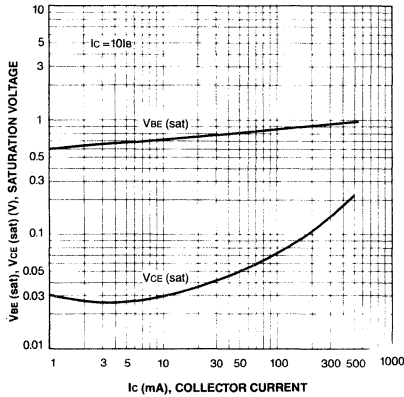
DC CURRENT GAIN



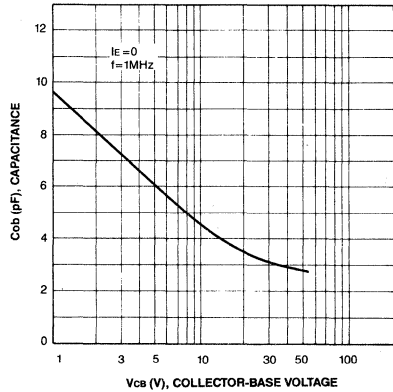
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



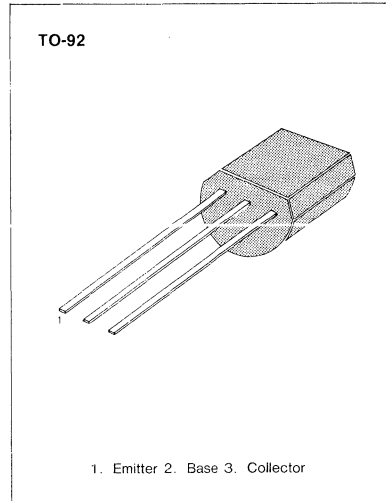
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	75	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

*Refer to MPS2222 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	75			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60V, I_E = 0$			0.01	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			10	nA
DC Current Gain	h_{FE}	$I_C = 0.1mA, V_{CE} = 10V$	35			
		$I_C = 1mA, V_{CE} = 10V$	50			
		$I_C = 10mA, V_{CE} = 10V$	75			
		* $I_C = 150mA, V_{CE} = 10V$	100		300	
		* $I_C = 500mA, V_{CE} = 10V$	40			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$			0.3	V
		$I_C = 500mA, I_B = 50mA$			1	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$		0.6	1.2	V
		$I_C = 500mA, I_B = 50mA$			2	V
Current Gain Bandwidth Product	f_T	$I_C = 20mA, V_{CE} = 20V$ $f = 100MHz$	300			MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1MHz$			8	pF
Turn On Time	t_{on}	$V_{CC} = 30V, I_C = 150mA$ $I_{B1} = 15mA, V_{BE} (\text{off}) = 0.5V$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_C = 150mA$ $I_{B1} = I_{B2} = 15mA$			285	ns
Noise Figure	NF	$I_C = 100\mu A, V_{CE} = 10V$ $R_S = 1K\Omega, f = 1KHz$			4	dB

* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%
Also available as a PN2222A

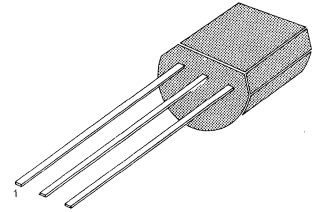
GENERAL PURPOSE TRANSISITOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

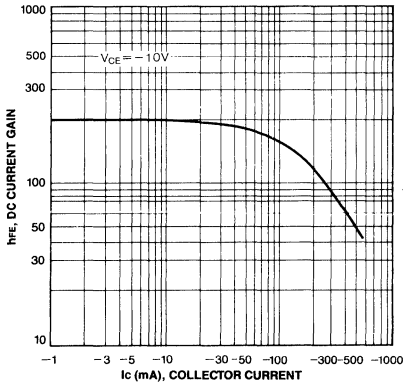
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-60			V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -50V, I_E = 0$			-20	nA
DC Current Gain	h_{FE}	$I_C = -0.1mA, V_{CE} = -10V$	35			
		$I_C = -1mA, V_{CE} = -10V$	50			
		$I_C = -10mA, V_{CE} = -10V$	75			
		* $I_C = -150mA, V_{CE} = -10V$	100		300	
		* $I_C = -500mA, V_{CE} = -10V$	30			
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -150mA, I_B = -15mA$			-0.4	V
		$I_C = -500mA, I_B = -50mA$			-1.6	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -150mA, I_B = -15mA$			-1.3	V
		$I_C = -500mA, I_B = -50mA$			-2.6	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			8	pF
* Current Gain Bandwidth Product	f_T	$I_C = -50mA, V_{CE} = -20V$ $f = 100MHz$	200			MHz
Turn On Time	t_{on}	$V_{CC} = -30V, I_C = -150mA$ $I_{B1} = -15mA$			45	ns
Turn Off Time	t_{off}	$V_{CC} = -6V, I_C = -150mA$ $I_{B1} = I_{B2} = -15mA$			100	ns

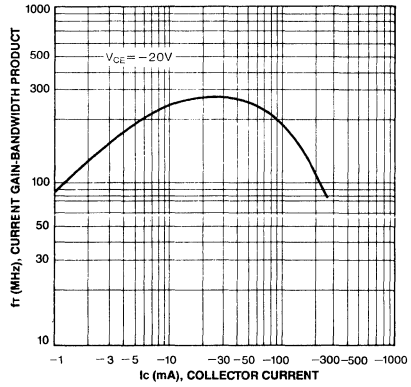
*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

Also available as a PN2907

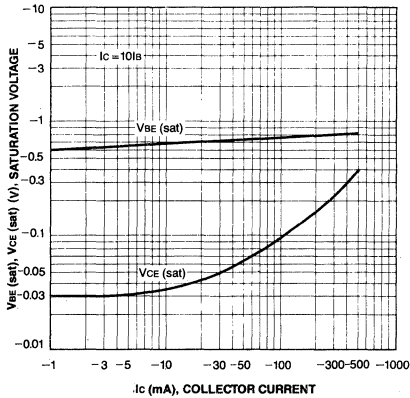
DC CURRENT GAIN



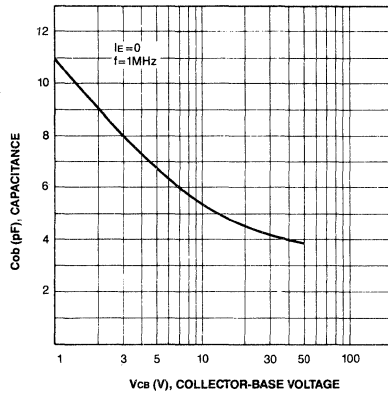
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



3

GENERAL PURPOSE TRANSISTOR

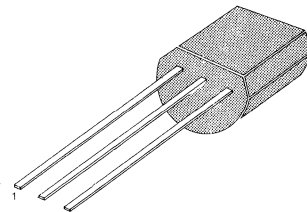
- Collector-Emitter Voltage: $V_{CE0} = 60V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-60	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to MPS2907 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -50V, I_E = 0$			-10	nA
DC Current Gain	h_{FE}	$I_C = -0.1mA, V_{CE} = -10V$	75			
		$I_C = -1mA, V_{CE} = -10V$	100			
		$I_C = -10mA, V_{CE} = -10V$	100			
		* $I_C = -150mA, V_{CE} = -10V$	100		300	
		* $I_C = -500mA, V_{CE} = -10V$	50			
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -150mA, I_B = -15mA$			-0.4	V
		$I_C = -500mA, I_B = -50mA$			-1.6	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -150mA, I_B = -15mA$			-1.3	V
		$I_C = -500mA, I_B = -50mA$			-2.6	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			8	pF
*Current Gain Bandwidth Product	f_T	$I_C = -50mA, V_{CE} = -20V$ $f = 100MHz$	200			MHz
Turn On Time	t_{on}	$V_{CC} = -30V, I_C = -150mA$ $I_{B1} = -15mA$			45	ns
Turn Off Time	t_{off}	$V_{CC} = -6V, I_C = -150mA$ $I_{B1} = I_{B2} = -15mA$			100	ns

* Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

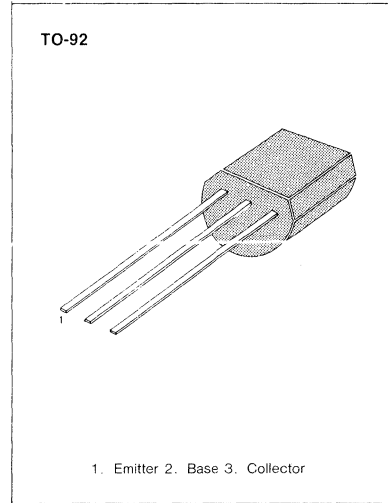
Also available as a PN2907A

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: V_{CEO} = MPS 3702: 25V
MPS3703: 30V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
		-50	V
Collector-Emitter Voltage	V_{CEO}	-25	V
		-30	V
Emitter-Base Voltage	V_{EBC}	-5	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$



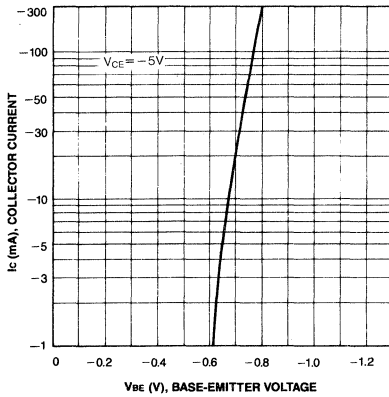
3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

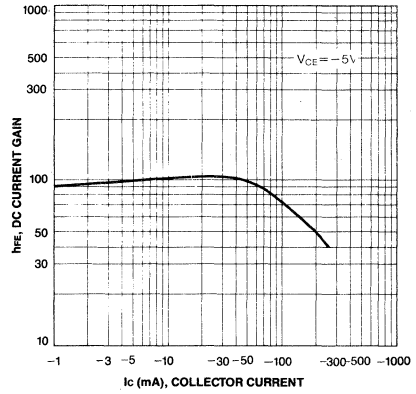
Characteristic	Symbol	Test Conditions	Min	Max	Unit
*Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-40		V
			-50		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-25		V
			-30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -20\text{V}, I_E = 0$		-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = -3\text{V}, I_C = 0$		-100	nA
*DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -50\text{mA}$	60	300	
			30	150	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -50\text{mA}, I_B = -5\text{mA}$		-0.25	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -5\text{V}, I_C = -50\text{mA}$	-0.6	-1	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -50\text{mA}$ $f = 20\text{MHz}$	100		MHz
Output Capacitance	C_{OB}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$		12	pF

*Pulse Test: $PW=300\mu\text{s}$, Duty Cycle=2%

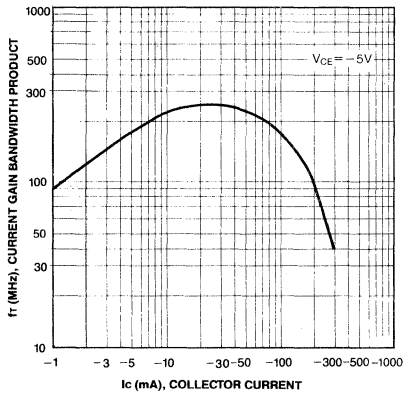
BASE-EMITTER ON VOLTAGE



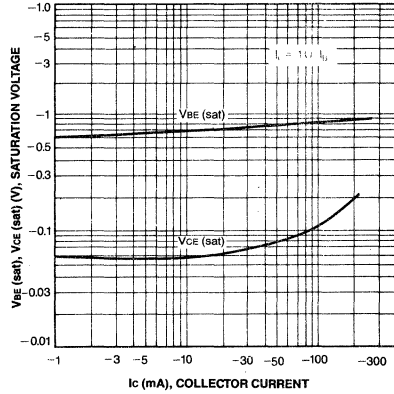
DC CURRENT GAIN



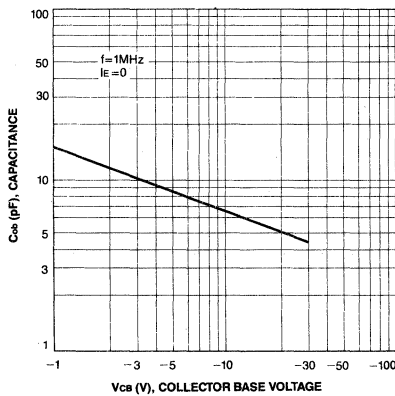
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



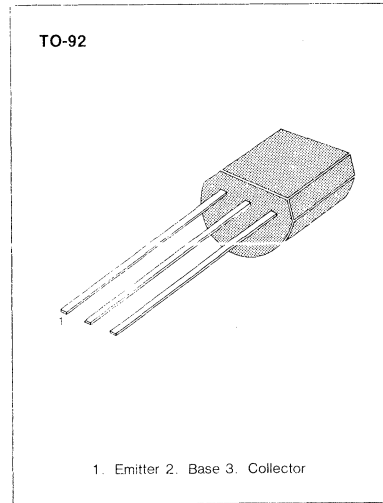
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 30V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N4400 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$V_{CE} = 2V, I_C = 50mA$				
	:MPS3704		100		300	
	:MPS3705		50		150	
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100mA, I_B = 5mA$			0.6	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			12	pF
Current Gain Bandwidth Product	f_T	$I_C = 50mA, V_{CE} = 2V$ $f = 200MHz$	100			Mhz
*Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 100mA, V_{CE} = 2V$	0.5		1	V

*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

GENERAL PURPOSE TRANSISTOR

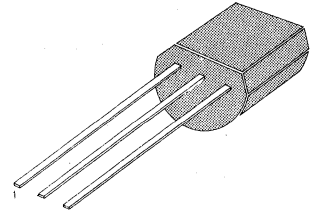
- Collector-Emitter Voltage: $V_{CE0} = 20V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N4400 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 50mA, V_{CE} = 2V$	30		600	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 100mA, I_B = 5mA$			1	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			12	pF
Current Gain Bandwidth Product	f_T	$I_C = 50mA, V_{CE} = 2V$ $f = 20MHz$	100			MHz
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 100mA, V_{CE} = 2V$	0.5		1	V

- * Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

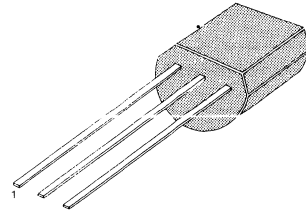
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 60V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-60	V
Collector-Emitter Voltage	V_{CE0}	-60	V
Collector-Emitter Voltage	V_{CES}	-60	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -10\mu A, I_E = 0$	-60			V
*Collector-Emitter Sustaining Voltage	$BV_{CE0(SUS)}$	$I_C = -5mA, I_B = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = -10\mu A, V_{BE} = 0$	-60			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-10	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = -3V, I_C = 0$			-20	nA
DC Current Gain	h_{FE}	$I_C = -100\mu A, V_{CE} = -5V$	100		300	
		$I_C = -1mA, V_{CE} = -5V$	100			
		$I_C = -10mA, V_{CE} = -5V$	100			
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.25	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.9	V
Output Capacitance	C_{ob}	$V_{CB} = -5V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = -20\mu A, V_{CE} = -5V$ $R_S = 10K\Omega, f = 1KHz$			3	dB
		$I_C = -250\mu A, V_{CE} = -5V$ $R_S = 1K\Omega, f = 1KHz$			3	dB

* Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

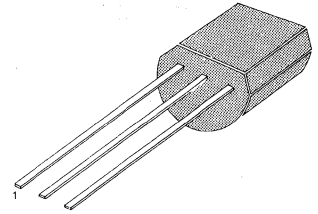
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Collector-Emitter Voltage	V_{CES}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-40			V
* Collector-Emitter Sustaining Voltage	$BV_{CEO(sus)}$	$I_C = -5mA, I_B = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = -5mA, V_{BE} = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -50V, I_E = 0$			-10	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = -3V, I_C = 0$			-20	nA
DC Current Gain	h_{FE}	$I_C = -100\mu A, V_{CE} = -5V$	250		700	
		$I_C = -1mA, V_{CE} = -5V$	250			
		$I_C = -10mA, V_{CE} = -5V$	250			
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.25	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.9	V
Output Capacitance	C_{ob}	$V_{CB} = -5V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = -20\mu A, V_{CE} = -5V$ $R_S = 10K\Omega, f = 1KHz$ $I_C = -250\mu A, V_{CE} = -5V$ $R_S = 1K\Omega, f = 1KHz$			2	dB
					2	dB

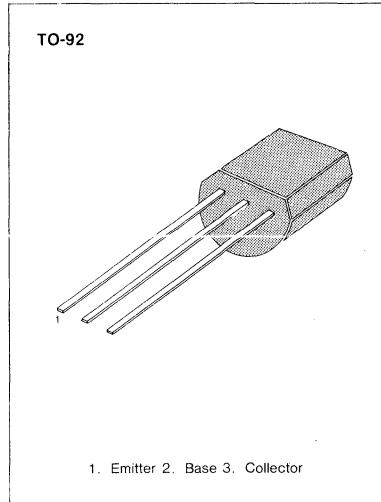
*Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 60V$
- Collector Dissipation: $P_c (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-60	V
Collector-Emitter Voltage	V_{CES}	-60	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu A, I_E = 0$	-60			V
*Collector-Emitter Sustaining Voltage	$BV_{CEO(sus)}$	$I_C = -5mA, I_B = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = -5mA, V_{BE} = 0$	-60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10mA, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-10	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = -3V, I_C = 0$			-20	nA
DC Current Gain	h_{FE}	$I_C = -100\mu A, V_{CE} = -5V$	250		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.25	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -0.5mA$			-0.9	V
Output Capacitance	C_{ob}	$V_{CB} = -5V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = -20\mu A, V_{CE} = -5V$ $R_S = 10K\Omega, f = 1KHz$ $I_C = 250\mu A, V_{CE} = -5V$ $R_S = 1K\Omega, f = 1KHz$			2	dB

*Pulse Test: Pulse Width=300 μ S, Duty Cycle=2%



AMPLIFIER TRANSISTOR

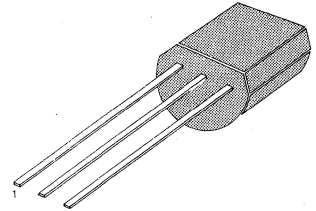
- Collector-Emitter Voltage: $V_{CE0} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to MPSA10 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

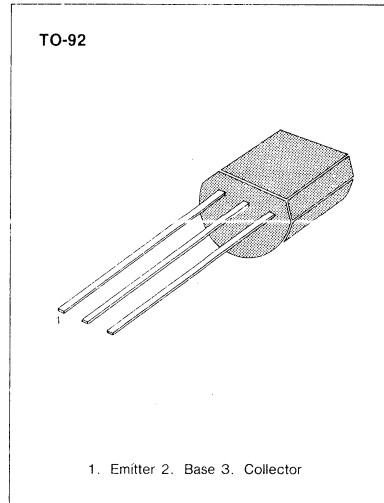
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	25			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25V, I_E = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 25V, V_{BE} = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 10V$	100		500	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.25	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$		0.75		V
Current Gain Bandwidth Product	f_T	$I_C = 2mA, V_{CE} = 5V$		120		MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10mA, V_{CE} = 10V$	0.5		1.2	V

- * Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

HIGH FREQUENCY TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V _{CB0}	20	V
Collector-Emitter Voltage	V _{CEO}	12	V
Emitter-Base Voltage	V _{EBO}	2.5	V
Collector Current	I _c	50	mA
Collector Dissipation (T _a = 25°C)	P _c	200	mW
Derate above 25°C		1.14	mW/°C
Collector Dissipation (T _c = 25°C)	P _c	300	mW
Derate above 25°C		1.71	mW/°C
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Emitter Sustaining Voltage	V _{CEO (sus)}	I _c = 3mA, I _b = 0	12		V
Collector Base Breakdown Voltage	BV _{CB0}	I _c = 0.001mA, I _E = 0	20		V
Emitter Base Breakdown Voltage	BV _{EBO}	I _E = 0.01mA, I _c = 0	2.5		V
Collector Cutoff Current	I _{CB0}	V _{CB} = 15V, I _E = 0		0.02	μA
		V _{CB} = 15V, I _E = 0, T _a = 150°C		1	μA
DC Current Gain	h _{FE}	V _{CE} = 1V, I _c = 3mA	25	250	
Collector-Emitter Saturation Voltage	V _{CE (sat)}	I _c = 10mA, I _b = 1mA		0.4	V
Base-Emitter Saturation Voltage	V _{BE (sat)}	I _c = 10mA, I _b = 1mA		1	V
Current Gain Bandwidth Product	f _T	V _{CE} = 6V, I _c = 5mA, f = 100MHz	900	2000	MHz
Collector Base Capacitance	C _{cb}	V _{CB} = 10V, I _E = 0, f = 0.1 to 1MHz		1	pF
Small Signal Current Gain	h _{fe}	V _{CE} = 6V, I _c = 2mA, f = 1KHz	25	300	
Collector Base Time Constant	C _c τ _{bb}	V _{CB} = 6V, I _E = 2mA, f = 31.9MHz	3	14	ps
Noise Figure	NF	V _{CE} = 6V, I _c = 1.5mA, f = 200MHz R _S = 50Ω		4.5	dB
Common Emitter Amplifier Power Gain	G _{pe}	V _{CE} = 6V, I _c = 5mA, f = 200MHz	15		dB

AMPLIFIER TRANSISTOR

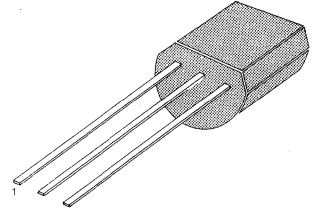
- Collector-Emitter Voltage: $V_{CE0} = 30V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	30	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N3904 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 500\mu A, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 2mA, V_{CE} = 10V$	90		180	
		$*I_C = 100mA, V_{CE} = 10V$	60			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100KHz$			3.5	pF

*Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

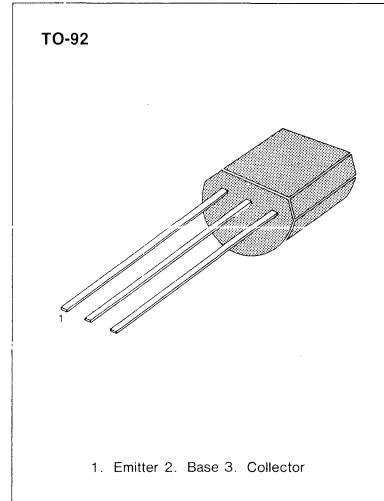
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_c (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	-40	V
Collector-Base Voltage	V_{CBO}	-40	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N3906 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -500\mu A, I_B = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{EBO}	$V_{CB} = -30V, I_E = 0$			-50	nA
DC Current Gain	h_{FE}	$I_C = -2mA, V_{CE} = -10V$ * $I_C = -100mA, V_{CE} = -10V$	90 60		180	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -50mA, I_B = -5mA$			0.5	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 100KHz$			3.5	pF

*Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

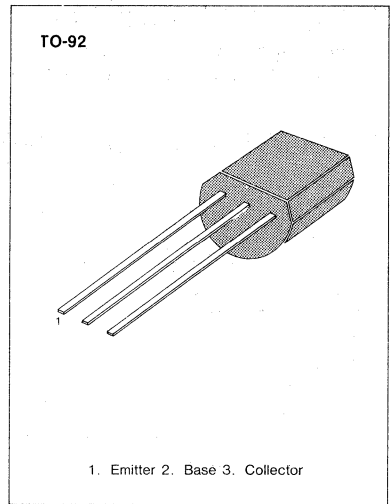
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0}=25V$
- Collector Dissipation: $P_c (max)=625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^{\circ}C$
Storage Temperature	T_{stg}	-55 ~ 150	$^{\circ}C$

* Refer to 2N3904 for graphs



ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=0.5mA, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu A, I_C=0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30V, I_E=0$			50	nA
		$V_{CB}=20V, I_E=0$			50	nA
DC Current Gain	h_{FE}	$I_c=100\mu A, V_{CE}=10V$	100			
:MPS6520			150			
:MPS6521			200		400	
:MPS6520		$I_c=2mA, V_{CE}=10V$	300		600	
:MPS6521						
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c=50mA, I_B=5mA$			0.5	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=100KHz$			3.5	pF
Noise Figure	NF	$I_c=10\mu A, V_{CE}=5V$ $R_S=10K\Omega$ $f=10Hz$ to $10KHz$			3	dB

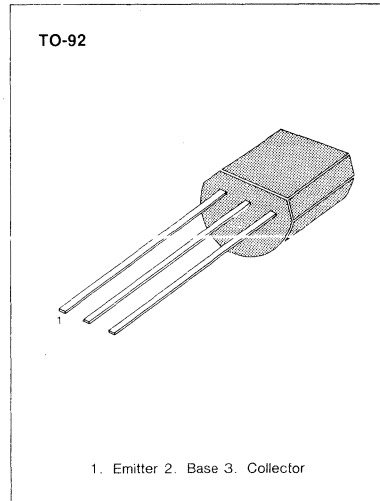
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 25V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-25	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to 2N3906 for graphs



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -0.5mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-50	nA
		$V_{CB} = -20V, I_E = 0$			-50	nA
DC Current Gain	h_{FE}					
	:MPS6522	$I_C = -100mA, V_{CE} = -10V$	100			
	:MPS6523		150			
	:MPS6522	$I_C = -2mA, V_{CE} = -10V$	200		400	
	:MPS6523		300		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -50mA, I_B = -5mA$			-0.5	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0, f = 100KHz$			3.5	pF
Noise Figure	NF	$I_C = -10\mu A, V_{CE} = -5V$ $R_S = 10K\Omega$ $f = 10Hz \text{ to } 10KHz$			3	dB

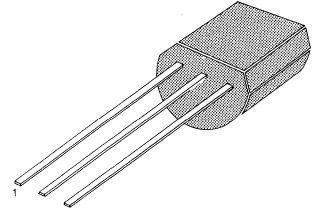
AUDIO TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 25V, I_B = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 1V$	35			
		$I_C = 100mA, V_{CE} = 1V$	50			
		$I_C = 500mA, V_{CE} = 1V$	50		200	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 500mA, I_B = 50mA$			0.5	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$ $f = 30MHz$	60			MHz
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 500mA, V_{CE} = 1V$			1.2	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100KHz$			30	pF

* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

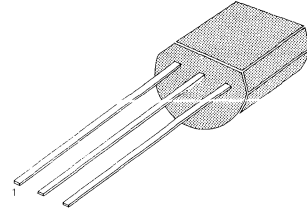
AUDIO TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$
- Complement to MPS6560

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-25	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = -25V, I_B = 0$			-100	nA
Collector Cut-off Current	I_{CBO}	$V_{EB} = -20V, I_C = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -4V, I_C = 0$			-100	nA
* DC Current Gain	h_{FE}	$I_C = -10mA, V_{CE} = -1V$	35			
		$I_C = -100mA, V_{CE} = -1V$	50			
		$I_C = -500mA, V_{CE} = -1V$	50		200	
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -500mA, I_B = -50mA$			-0.5	V
Current Gain Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -10V$ $f = 30MHz$	60			MHz
* Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = -500mA, V_{CE} = -1V$			-1.2	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 100KHz$			30	pF

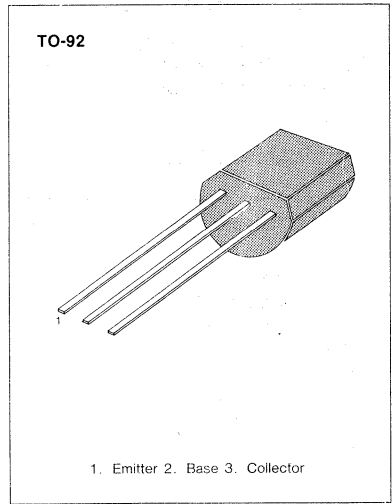
* Pulse Test: Width = 300 μs , Duty Cycle = 2%

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = \text{MPS6601: 25V}$
 MPS6602: 40V
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

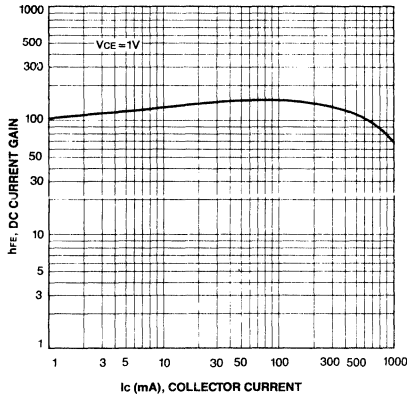
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	25	V
		40	V
Collector-Emitter Voltage	V_{CE0}	25	V
		40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	1,000	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$



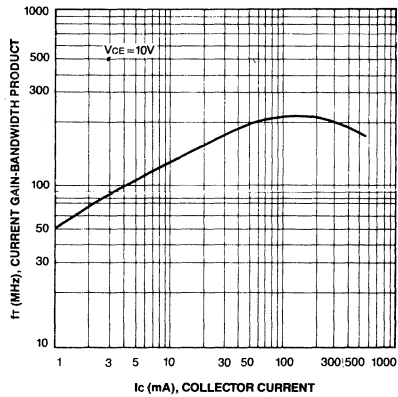
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	25		V
			40		V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_B = 0$	25		V
			40		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$ $V_{CB} = 30\text{V}, I_E = 0$		100	nA
				100	nA
Collector Cut-off Current	I_{EBO}	$V_{CB} = 25\text{V}, I_E = 0$ $V_{CB} = 30\text{V}, I_E = 0$		100	nA
				100	nA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$ $V_{CE} = 5\text{V}, I_C = 500\text{mA}$ $V_{CE} = 5\text{V}, I_C = 1000\text{mA}$	50		
			50		
			30		
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 1000\text{mA}, I_B = 100\text{mA}$		0.6	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 50\text{mA}$ $f = 30\text{MHz}$	100		MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 100\text{KHz}$		30	pF

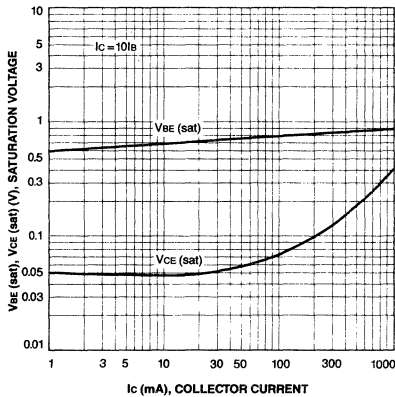
DC CURRENT GAIN



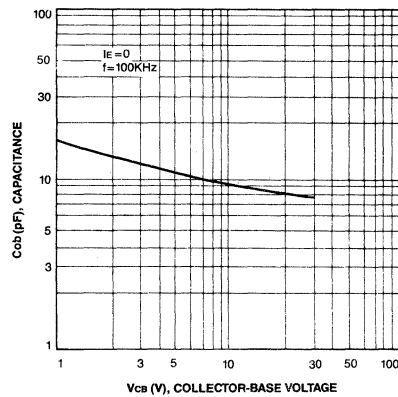
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



3

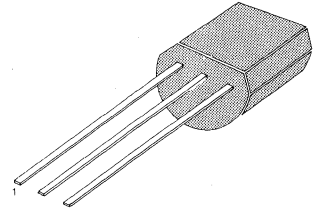
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	-25	V
Collector-Base Voltage	V_{CBO}	-25	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-1	A
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92

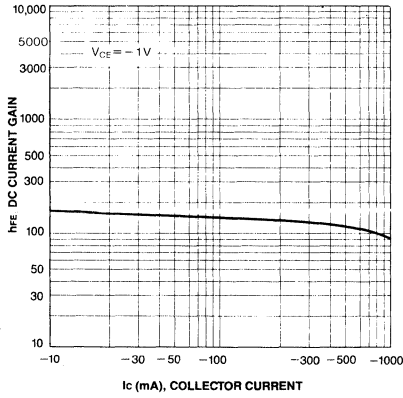


1. Emitter 2. Base 3. Collector

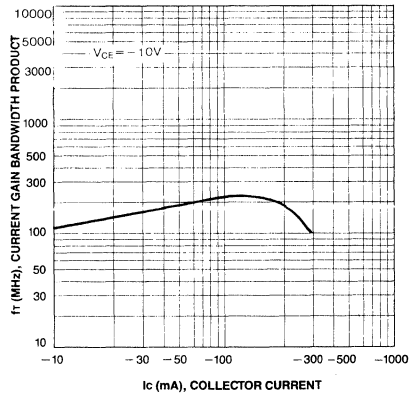
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1mA, I_B = 0$	-25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25V, I_E = 0$			-100	nA
Collector Cut-off Current	I_{CEO}	$V_{CE} = -25V, I_B = 0$			-100	nA
DC Current Gain	h_{FE}	$I_C = -100mA, V_{CE} = -1V$	50			
		$I_C = -500mA, V_{CE} = -1V$	50			
		$I_C = -1A, V_{CE} = -1V$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1A, I_B = -100mA$			-0.6	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 100KHz$			30	pF
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = -500mA, V_{CE} = -1V$			-1.2	V
Current Gain Bandwidth Product	f_T	$I_C = -50mA, V_{CE} = -10V$ $f = 30MHz$	100			MHz
Turn On Time	t_{on}	$V_{CC} = -40V, I_C = -500mA$ $I_{B1} = -50mA$			55	ns
Turn Off Time	t_{off}	$V_{CC} = -40V, I_C = -500mA$ $I_{B1} = 50mA$			300	ns

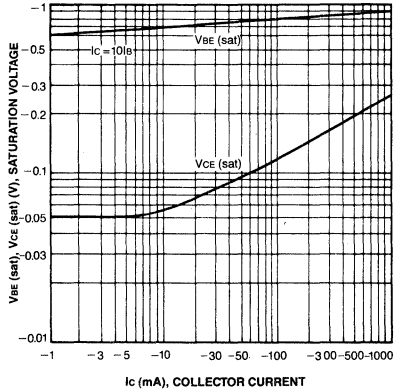
DC CURRENT GAIN



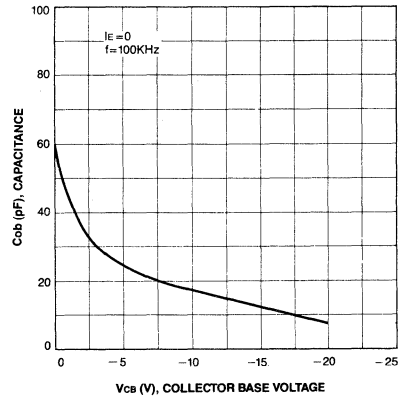
CURRENT GAIN BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



3

AMPLIFIER TRANSISTOR

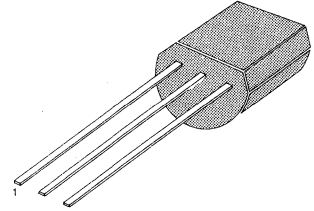
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to 2N5088 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	40			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$ $V_{CB} = 60V, I_E = 0$			30 10	nA μA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 6V, I_C = 0$			20	nA
*DC Current Gain	h_{FE}	$I_C = 100\mu A, V_{CE} = 5V$	250		700	
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1MHz$	1		4	pF
*Base-Emitter On Voltage	$V_{BE} (on)$	$I_C = 100\mu A, V_{CE} = 5V$	0.45		0.65	V
Noise Figure	NF	$I_C = 100\mu A, V_{CE} = 5V$ $R_S = 10K\Omega, f = 10Hz$			2	dB

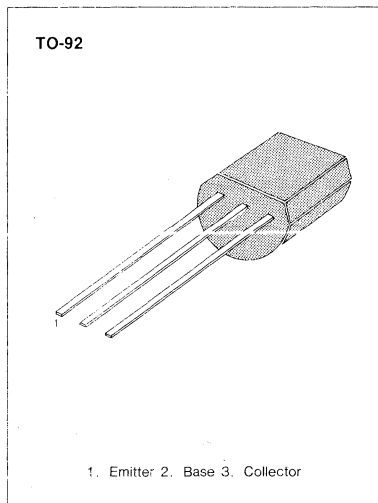
* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: V_{CEO} = MPS8098: 60V
MPS8099: 80V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
		80	V
Collector-Emitter Voltage	V_{CEO}	60	V
		80	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

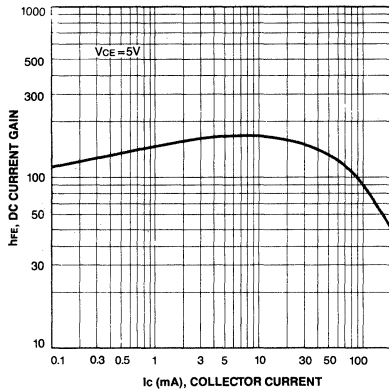


ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

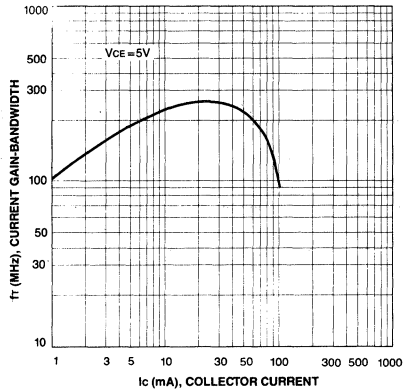
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	60		V
			80		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	60		V
			80		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cut-off Current	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$		100	nA
			$V_{CB}=80\text{V}, I_E=0$		100
Collector Cut-off Current	I_{CEO}	$V_{CE}=60\text{V}, I_B=0$		100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=6\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100	300	
		$V_{CE}=5\text{V}, I_C=10\text{mA}$	100		
		$V_{CE}=5\text{V}, I_C=100\text{mA}$	75		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}, I_B=5\text{mA}$		0.4	V
		$I_C=100\text{mA}, I_B=10\text{mA}$		0.3	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}, I_C=1\text{mA}$	0.5	0.7	V
		$V_{CE}=5\text{V}, I_C=10\text{mA}$	0.6	0.8	V
Current Gain Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=10\text{mA}$ $f=100\text{MHz}$	150		MHz
Output Capacitance	C_{OB}	$V_{CB}=5\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF

*Pulse Test: $PW=300\mu\text{s}$, Duty Cycle=2%

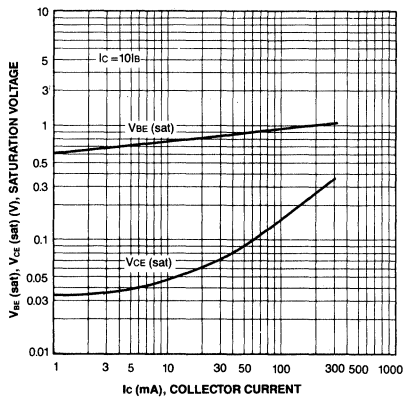
DC CURRENT GAIN



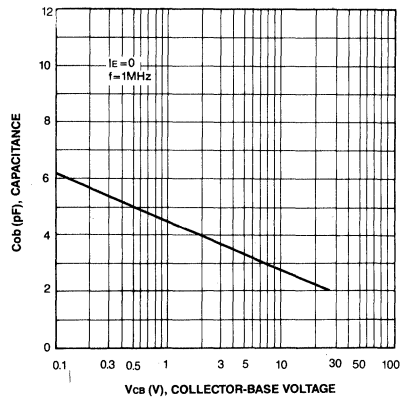
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

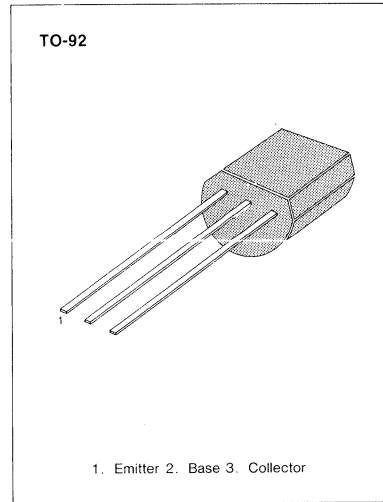


AMPLIFIER TRANSISTOR

- **Collector-Emitter Voltage:** V_{CEO} =MPS8598: 60V
MPS8599: 80V
- **Collector Dissipation:** P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
:MPS8598		-80	V
MPS8599			
Collector-Emitter Voltage	V_{CEO}	-60	V
:MPS8598		-80	V
MPS8599			
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

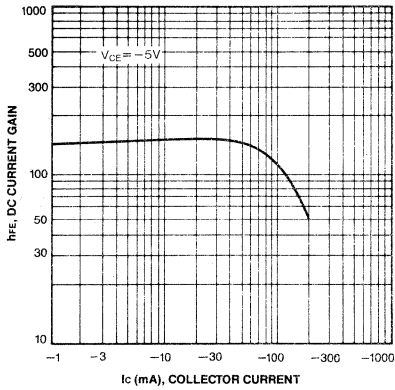


ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

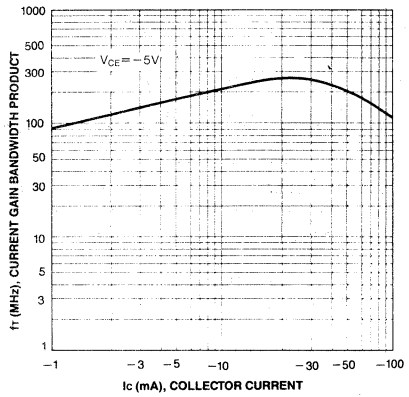
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-60		V
:MPS8598			-80		V
MPS8599					
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-60		V
:MPS8598			-80		V
MPS8599					
Emitter-Base Breakdown Voltage	BE_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60\text{V}, I_E = 0$		-100	nA
:MPS8598		$V_{CB} = -80\text{V}, I_E = 0$		-100	nA
MPS8599		$V_{CE} = -60\text{V}, I_B = 0$		-100	nA
Collector Cut-off Current	I_{CEO}	$V_{EB} = -4\text{V}, I_C = 0$		-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{CE} = -5\text{V}, I_C = -1\text{mA}$	100	300	
* DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	100		
		$V_{CE} = -5\text{V}, I_C = -100\text{mA}$	75		
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -100\text{mA}, I_B = -5\text{mA}$		-0.4	V
		$I_C = -100\text{mA}, I_B = -10\text{mA}$		-0.3	V
* Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -5\text{V}, I_C = -1\text{mA}$	-0.5	-0.7	V
:MPS8598		$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	-0.6	-0.8	V
MPS8599		$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	150		MHz
Current Gain Bandwidth Product	f_T	$f = 100\text{MHz}$			
Output Capacitance	C_{OB}	$V_{CB} = -5\text{V}, I_E = 0$		8	pF
		$f = 1\text{MHz}$			

* Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

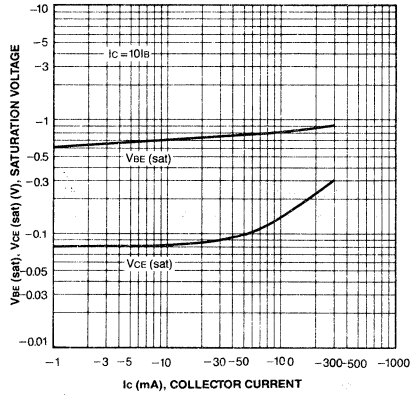
DC CURRENT GAIN



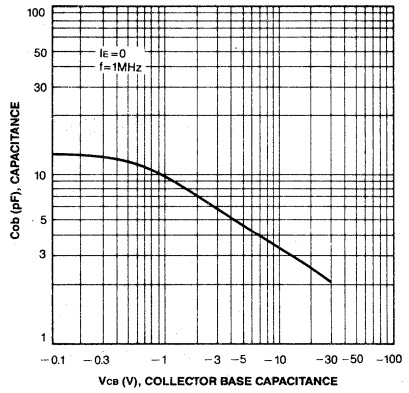
CURRENT GAIN BANDWIDTH PRODUCT



COLLECTOR EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

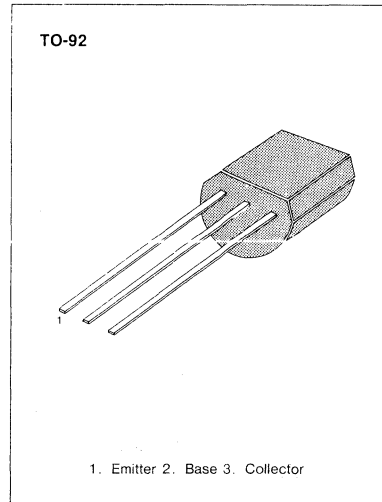


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = \text{MPSA05: } 60\text{V}$
 $\text{MPSA06: } 80\text{V}$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit	
Collector-Base Voltage	V_{CBO}	MPSA05	60	V
		MPSA06	80	V
Collector-Emitter Voltage	V_{CE0}	MPSA05	60	V
		MPSA06	80	V
Emitter-Base Voltage	V_{EBO}	4	V	
Collector Current	I_C	500	mA	
Collector Dissipation	P_C	625	mW	
Junction Temperature	T_J	150	$^\circ\text{C}$	
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$	



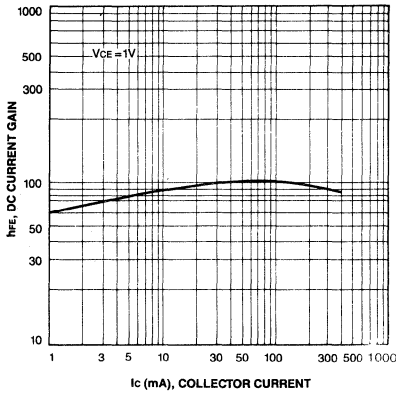
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

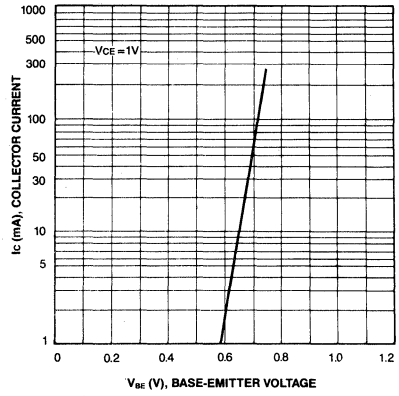
Characteristic	Symbol	Test Conditions	Min	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_B = 0$	60		V
:MPSA05			80		
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	4		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60\text{V}, I_E = 0$		0.1	μA
:MPSA05				0.1	
Collector Cut-off Current	I_{CEO}	$V_{CB} = 80\text{V}, I_E = 0$		0.1	μA
:MPSA06				0.1	
DC Current Gain	h_{FE}	$V_{CE} = 60\text{V}, I_B = 0$	50		
			50		
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, I_B = 10\text{mA}$		1.2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 1\text{V}, I_C = 100\text{mA}$	100		MHz
		$V_{CE} = 2\text{V}, I_C = 10\text{mA}$			
		$f = 100\text{MHz}$			

*Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

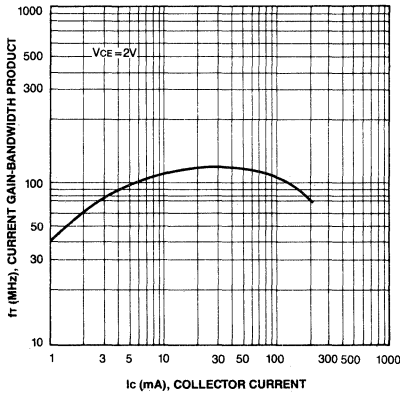
DC CURRENT GAIN



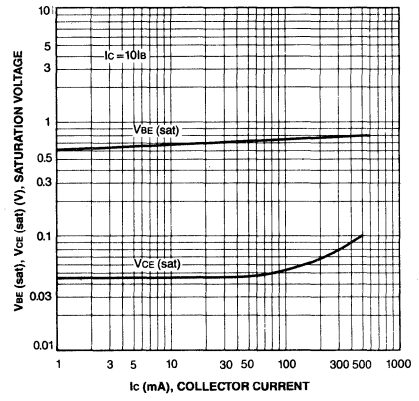
BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

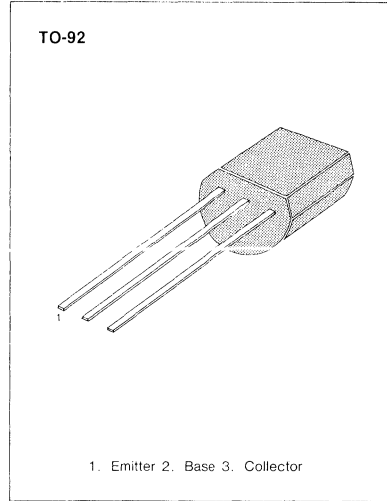


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

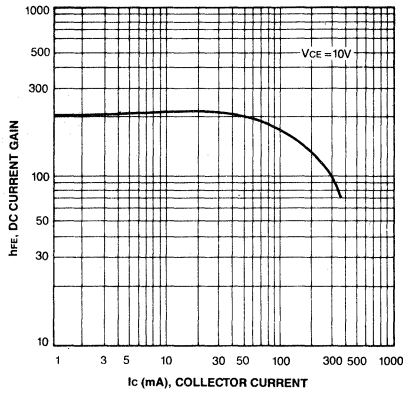
Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



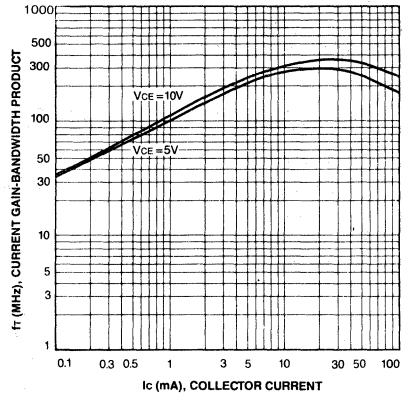
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1mA, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$I_C = 5mA, V_{CE} = 10V$	40		400	
Current Gain Bandwidth Product	f_T	$I_C = 5mA, V_{CE} = 10V$ $f = 100MHz$	125			MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100KHz$			4	pF

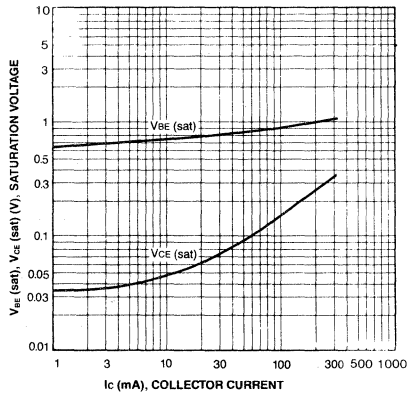
DC CURRENT GAIN



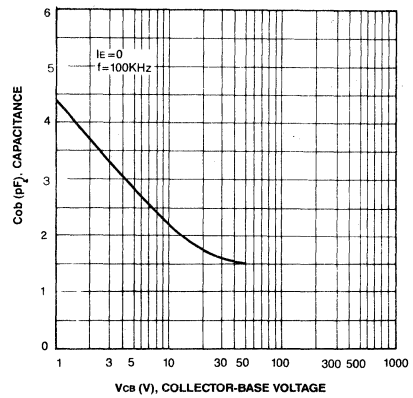
CURRENT GAIN-BANDWIDTH



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE



DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 20V$
- Collector Dissipation: $P_c (max) = 625mW$

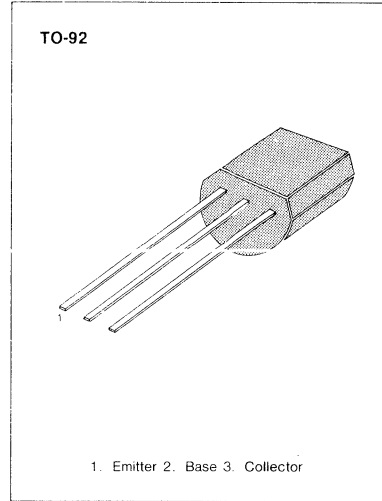
ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	20	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N6427 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c = 100\mu A, I_B = 0$	20			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 15V, I_E = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 15V, I_B = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$I_c = 10mA, V_{CE} = 5V$	20K			
Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_c = 10mA, I_B = 0.01mA$			1	V
Base-Emitter On Voltage	$V_{BE (on)}$	$I_c = 10mA, V_{CE} = 5V$			1.4	V



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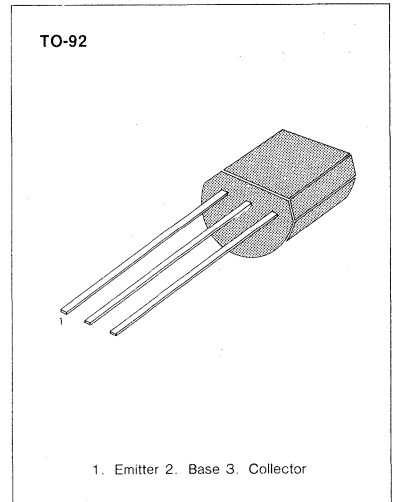
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 30V$
- Collector Dissipation: $P_c (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N6427 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu A, I_B = 0$	30		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$		100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$		100	nA
*DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 10mA$	5,000		
	MPSA13		10,000		
	MPSA14	$V_{CE} = 5V, I_C = 100mA$	10,000		
	MPSA13		20,000		
	MPSA14				
*Collector-Emitter Saturation Voltage	$V_{CE (sat)}$	$I_C = 100mA, I_B = 0.1mA$		1.5	V
*Base-Emitter On Voltage	$V_{BE (on)}$	$V_{CE} = 5V, I_C = 100mA$		2.0	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 5V, I_C = 10mA$ $f = 100MHz$	125		MHz

* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

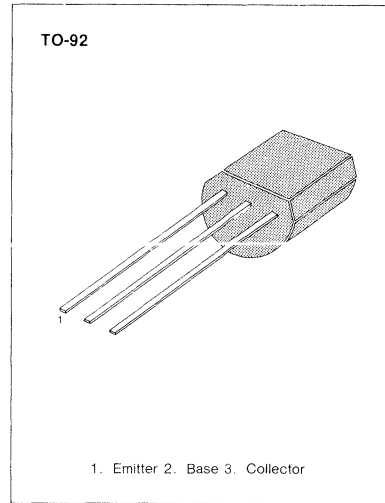
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to MPSA10 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1mA, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 5mA, V_{CE} = 10V$	40		400	
*Current Gain Bandwidth Product	f_T	$I_C = 5mA, V_{CE} = 10V$ $f = 100MHz$	125			MHz
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.25	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100KHz$			4	pF

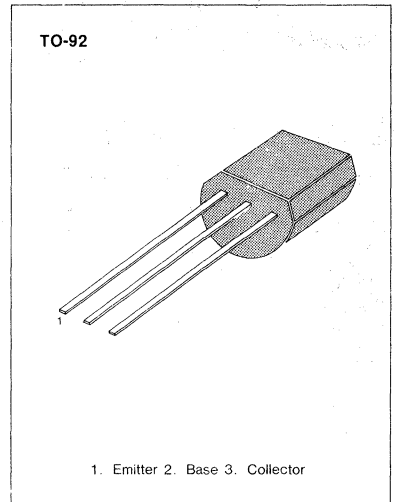
* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: V_{CES} = MPSA25: 40V
MPSA26: 50V
MPSA27: 60V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CES}	MPSA25	40 V
		MPSA26	50 V
		MPSA27	60 V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

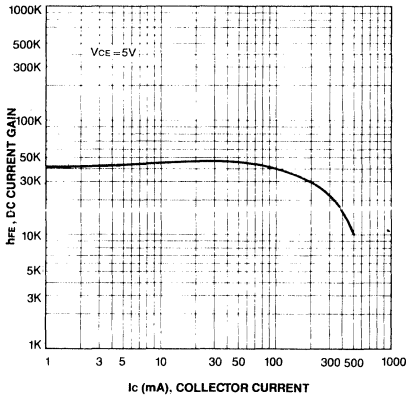


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

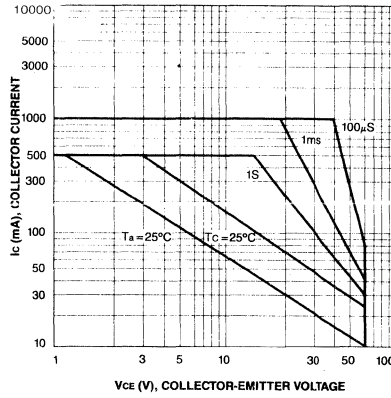
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, I_E = 0$	40		V
			50		V
			60		V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40		V
			50		V
			60		V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 30\text{V}, I_E = 0$ $V_{CE} = 40\text{V}, I_E = 0$ $V_{CE} = 50\text{V}, I_E = 0$		100	nA
				100	nA
				100	nA
Emitter Cut-off Current	I_{EBO}	$V_{CE} = 10\text{V}, I_B = 0$		100	nA
* DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$ $V_{CE} = 5\text{V}, I_C = 100\text{mA}$	10K		
			10K		
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 100\text{mA}, I_B = 0.1\text{mA}$		1.5	V
* Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 5\text{V}, I_C = 100\text{mA}$		2	V

*Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

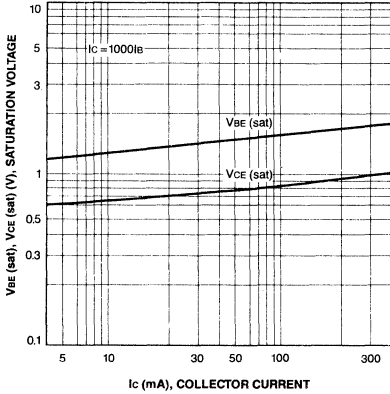
DC CURRENT GAIN



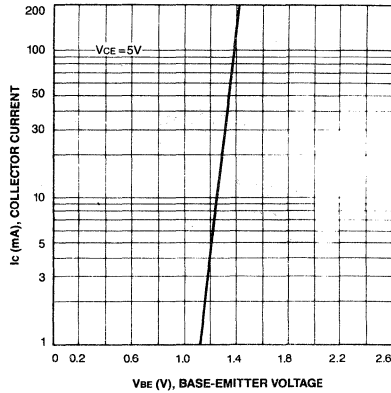
SAFE OPERATING AREA



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



BASE-EMITTER ON VOLTAGE



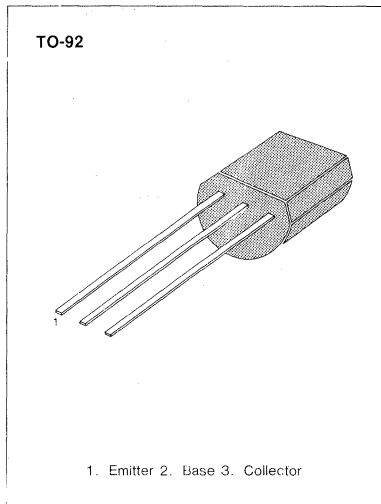
3

HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: V_{CEO} = MPSA42: 300V
MPSA43: 200V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	MPSA42	300 V
		MPSA43	200 V
Collector-Emitter Voltage	V_{CEO}	MPSA42	300 V
		MPSA43	200 V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

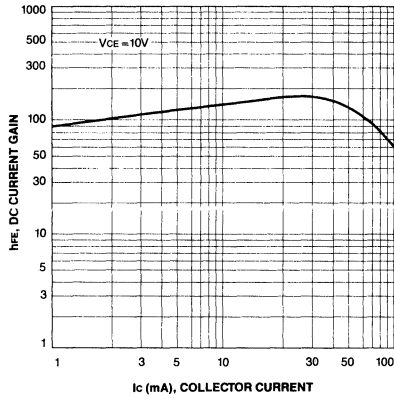


ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

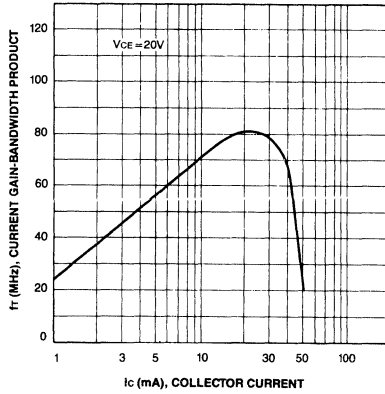
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_B=0$	MPSA42	300	V
			MPSA43	200	V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	MPSA42	300	V
			MPSA43	200	V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	6		V
Collector Cut-off Current	I_{CBO}	$V_{CB}=200\text{V}, I_E=0$ $V_{CB}=160\text{V}, I_E=0$		100	nA
			MPSA43	100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=6\text{V}, I_C=0$ $V_{BE}=4\text{V}, I_C=0$		100	nA
			MPSA43	100	nA
* DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=1\text{mA}$ $V_{CE}=10\text{V}, I_C=10\text{mA}$ $V_{CE}=10\text{V}, I_C=30\text{mA}$	25		
			40		
			40		
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=20\text{mA}, I_B=2\text{mA}$		0.5	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=20\text{mA}, I_B=2\text{mA}$		0.9	V
Collector-Base Capacitance	C_{CB}	$V_{CB}=20\text{V}, I_E=0$ $f=1\text{MHz}$		3	pF
			MPSA43	4	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=20\text{V}, I_C=10\text{mA}$ $f=100\text{MHz}$	50		MHz

*Pulse Test: $PW=300\mu\text{s}$, Duty Cycle=2%

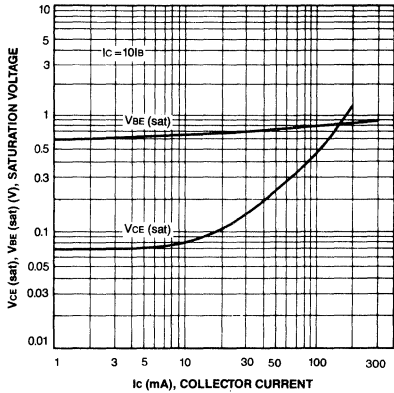
DC CURRENT GAIN



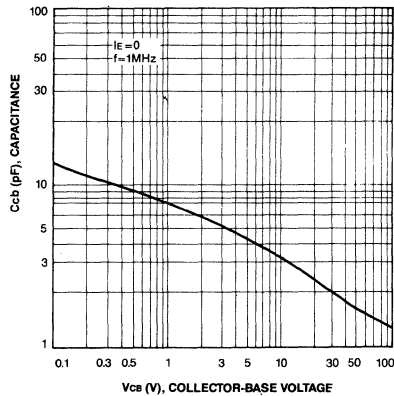
CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE

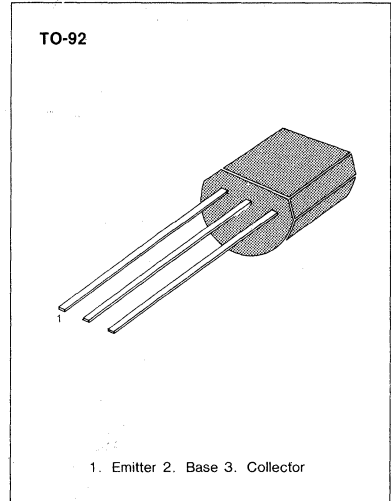


HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = \text{MPSA44: } 400\text{V}$
 $\text{MPSA45: } 350\text{V}$
- Collector Dissipation: $P_c(\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	MPSA44	500 V
		MPSA45	400 V
Collector-Emitter Voltage	V_{CEO}	MPSA44	400 V
		MPSA45	350 V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	300	mA
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	625	mW
Collector Dissipation ($T_C = 25^\circ\text{C}$)	P_C	1.5	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

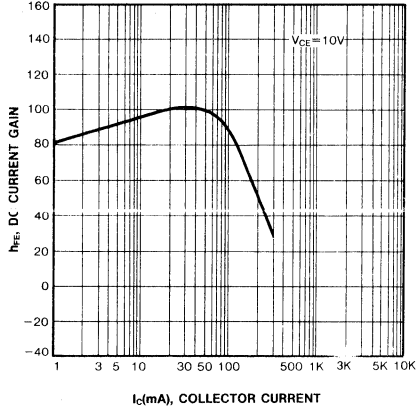


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

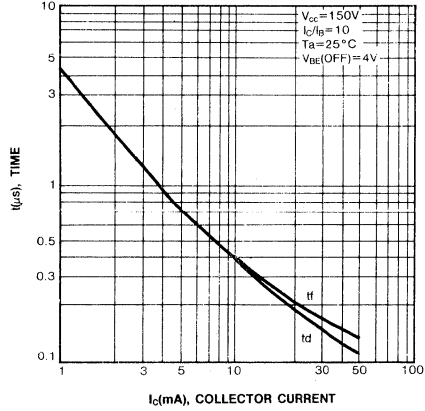
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	MPSA44	500	V
			MPSA45	400	V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	MPSA44	400	V
			MPSA45	350	V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	6	V	
Collector Cut-off Current	I_{CBO}	$V_{CB} = 400\text{V}, I_E = 0$ $V_{CB} = 320\text{V}, I_E = 0$		0.1	μA
			MPSA45	0.1	μA
Collector Cut-off Current	I_{CES}	$V_{CE} = 400\text{V}, I_B = 0$ $V_{CE} = 320\text{V}, I_B = 0$		0.5	μA
			MPSA45	0.5	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$		0.1	μA
*DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$ $V_{CE} = 10\text{V}, I_C = 10\text{mA}$ $V_{CE} = 10\text{V}, I_C = 50\text{mA}$ $V_{CE} = 10\text{V}, I_C = 100\text{mA}$		40	
				50	200
				45	
				40	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 1\text{mA}, I_B = 0.1\text{mA}$ $I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$		0.4	V
				0.5	V
				0.75	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.75	V
Output Capacitance	C_{OB}	$V_{CB} = 20\text{V}, I_E = 0$ $f = 1\text{MHz}$		7	pF

*Pulse Test: $PW = 300\mu\text{s}$. Duty Cycle = 2%

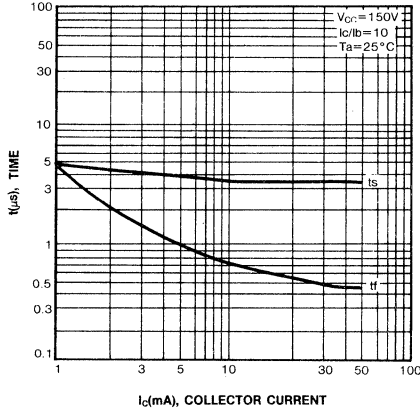
DC CURRENT GAIN



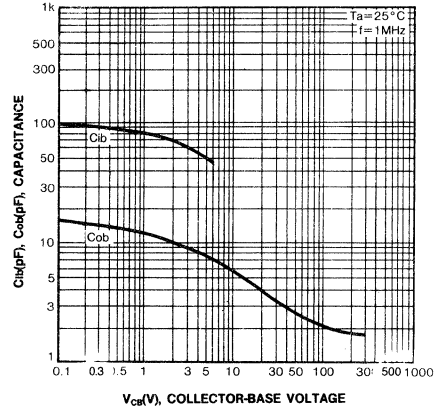
TURN-ON SWITCHING TIMES



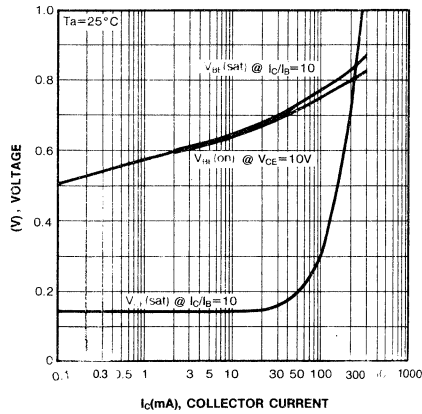
TURN-OFF SWITCHING TIMES



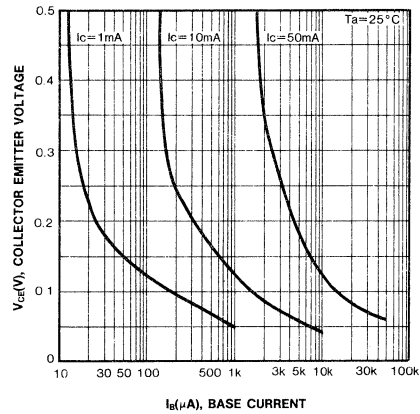
CAPACITANCE



ON VOLTAGE

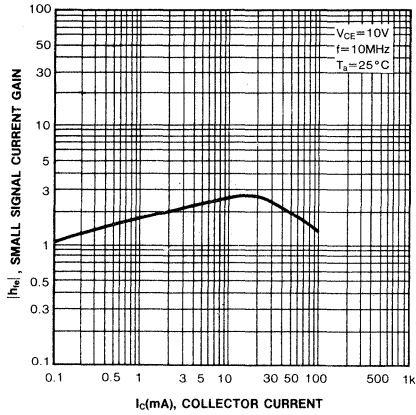


COLLECTOR SATURATION REGION

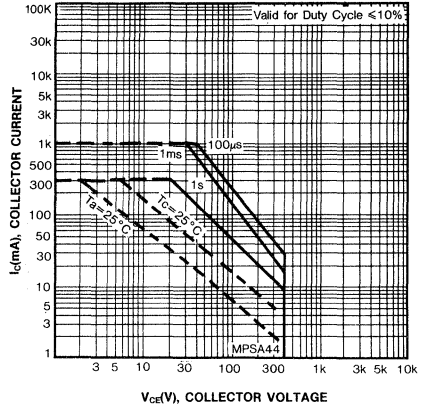


3

HIGH FREQUENCY CURRENT GAIN



SAFE OPERATING AREA

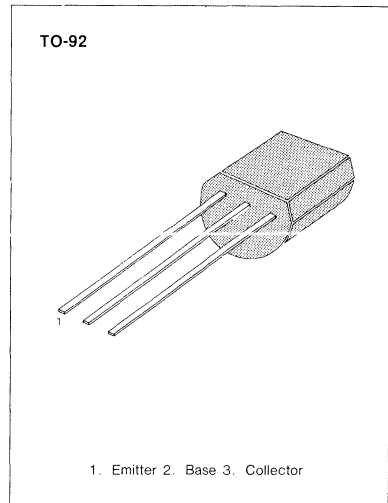


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: V_{CEO} = MPSA55: 60V
MPSA56: 80V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
	:MPSA55	-80	V
	MPSA56		
Collector-Emitter Voltage	V_{CEO}	-60	V
	:MPSA55	-80	V
	MPSA56		
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

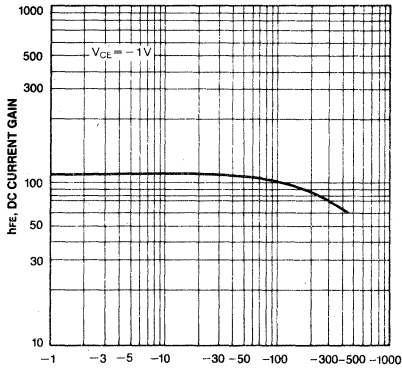


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

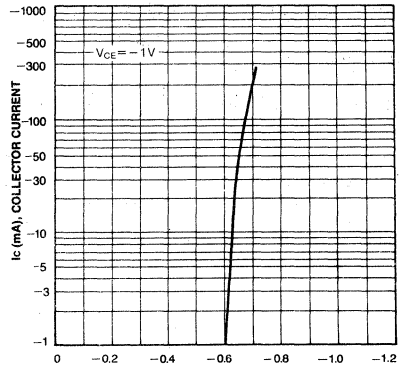
Characteristic	Symbol	Test Conditions	Min	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-60		V
	:MPSA55		-80		V
	MPSA56				
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-4		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60\text{V}, I_E = 0$		-0.1	μA
	:MPSA55	$V_{CB} = -80\text{V}, I_E = 0$		-0.1	μA
	MPSA56	$V_{CE} = -60\text{V}, I_B = 0$		-0.1	μA
Collector Cut-off Current	I_{CEO}	$V_{CE} = -1\text{V}, I_C = -10\text{mA}$	50		
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -100\text{mA}, I_B = -10\text{mA}$		-0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$		-1.2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -2\text{V}, I_C = -10\text{mA}$ $f = 100\text{MHz}$	50		MHz

*Pulse Test: PW=300 μs , Duty Cycle=2%

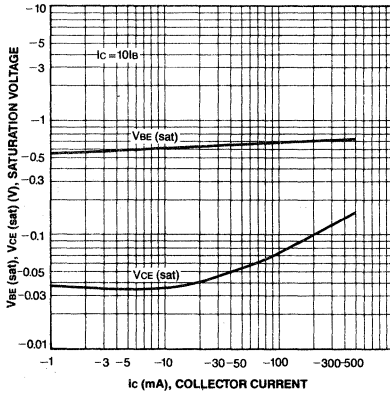
DC CURRENT GAIN



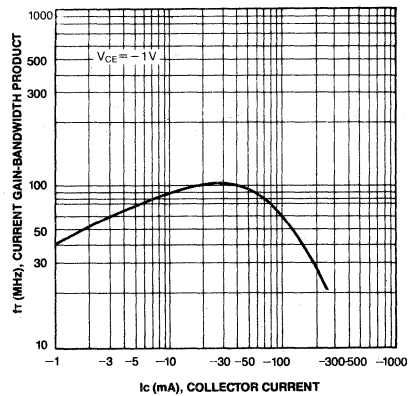
BASE-EMITTER ON VOLTAGE



COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

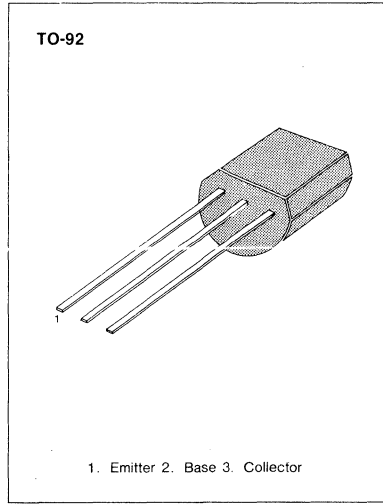


DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = \text{MPSA62: } 20\text{V}$
 $\text{MPSA63/64: } 30\text{V}$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}		
:MPSA62		-20	V
MPSA63/MPSA64		-30	V
Collector-Base Voltage	V_{CBO}		
:MPSA62		-20	V
MPSA63/MPSA64		-30	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

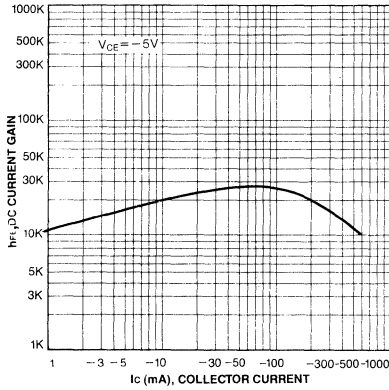


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

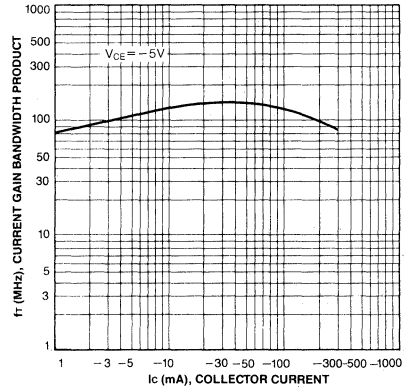
Characteristic	Symbol	Test Conditions	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = -100\mu\text{A}, I_B = 0$			
:MPSA62			-20		V
MPSA63/MPSA64			-30		V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -15\text{V}, I_E = 0$ $V_{CR} = -30\text{V}, I_F = 0$			
:MPSA62				-100	nA
MPSA63/MPSA64				-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = -10\text{V}, I_C = 0$			
*DC Current Gain	h_{FE}				
:MPSA62		$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	20K		
MPSA63			5K		
MPSA64			10K		
MPSA63		$V_{CE} = -5\text{V}, I_C = -100\text{mA}$	10K		
MPSA64			20K		
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$				
:MPSA62		$I_C = -10\text{mA}, I_B = -0.01\text{mA}$		-1.0	V
MPSA63/MPSA64		$I_C = -100\text{mA}, I_B = -0.1\text{mA}$		-1.5	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$				
:MPSA62		$V_{CE} = -5\text{V}, I_C = -10\text{mA}$		-1.4	V
MPSA63/MPSA64		$V_{CE} = -5\text{V}, I_C = -100\text{mA}$		-2	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -100\text{mA}$ $f = 100\text{MHz}$	125		MHz
:MPSA63/MPSA64					

*Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

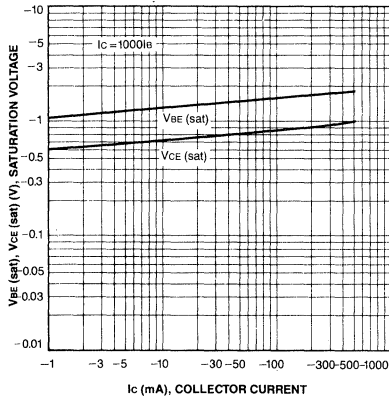
DC CURRENT GAIN



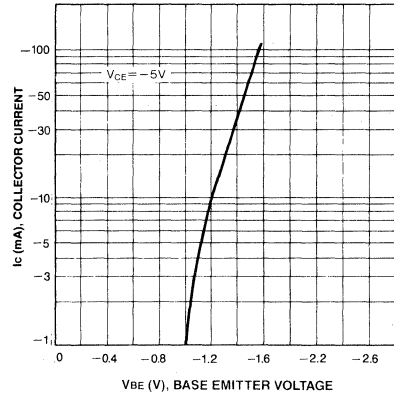
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



BASE EMITTER ON VOLTAGE

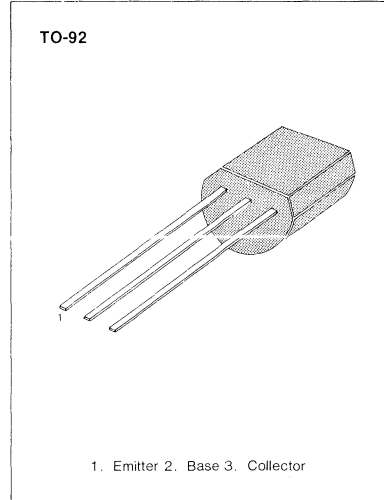


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CE0}	-40	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ C$

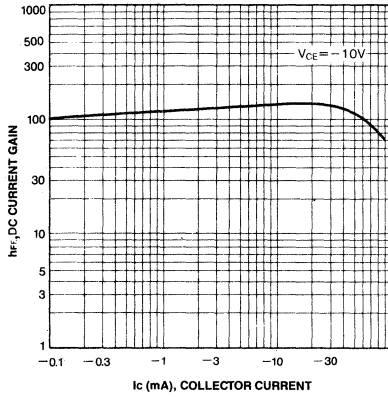


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

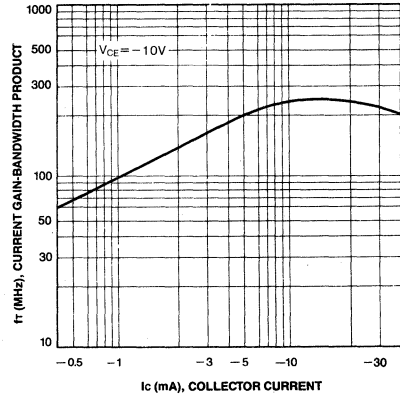
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1mA, I_B = 0$	-40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-100	nA
DC Current Gain	h_{FE}	$I_C = -5mA, V_{CE} = -10V$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = -10mA, I_B = -1mA$			-0.25	V
Current Gain Bandwidth Product	f_T	$I_C = -5mA, V_{CE} = -10V$ $f = 100MHz$	125			MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 100KHz$			4	pF

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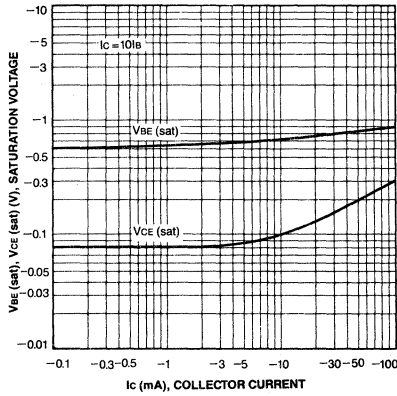
DC CURRENT GAIN



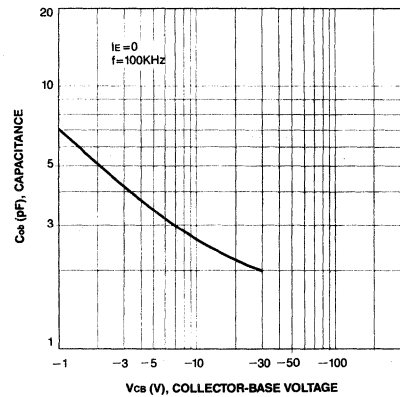
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

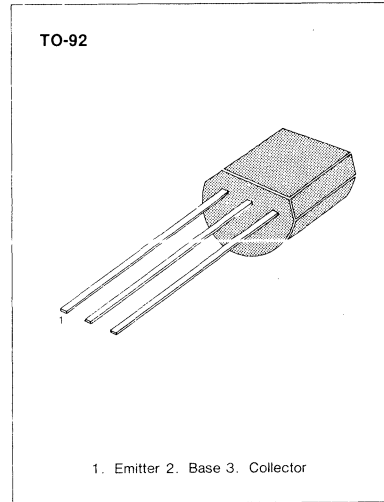


DARLINGTON TRANSISTOR

- **Collector-Emitter Voltage:** V_{CES} = MPSA75: 40V
MPSA76: 50V
MPSA77: 60V
- **Collector Dissipation:** P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CES}	-40	V
		-50	V
		-60	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

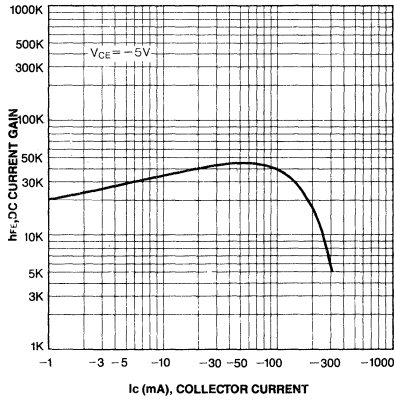


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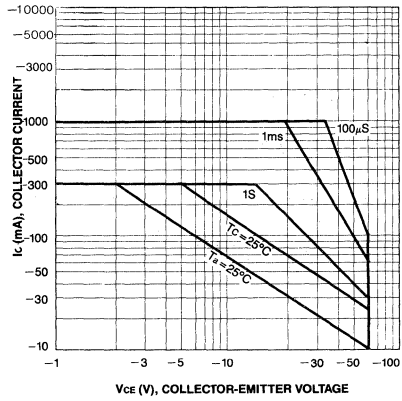
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Max	Unit	
Collector-Base Breakdown Voltage	BV_{CEO}	$I_c = -100\mu\text{A}, I_B = 0$	-40		V	
			-50		V	
			-60		V	
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -100\mu\text{A}, I_E = 0$	-40		V	
			-50		V	
			-60		V	
Collector Cut-off Current	I_{CBO}	$V_{CE} = -30\text{V}, I_E = 0$ $V_{CE} = -40\text{V}, I_E = 0$ $V_{CE} = -50\text{V}, I_E = 0$		-100	nA	
				-100	nA	
				-100	nA	
Emitter Cut-off Current	I_{EBO}	$V_{CE} = -10\text{V}, I_B = 0$		-100	nA	
Collector Cut-off Current			I_{CES}	$V_{CE} = -30\text{V}, I_E = 0$ $V_{CE} = -40\text{V}, I_E = 0$ $V_{CE} = -50\text{V}, I_E = 0$	-500	nA
					-500	nA
	-500	nA				
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_c = -10\text{mA}$ $V_{CE} = -5\text{V}, I_c = -100\text{mA}$	10K 10K			
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = -100\text{mA}, I_B = -0.1\text{mA}$		-1.5	V	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -5\text{V}, I_c = -100\text{mA}$		-2	V	

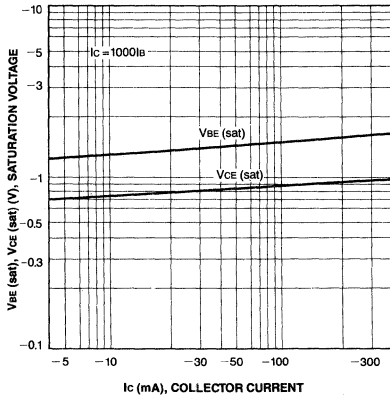
DC CURRENT GAIN



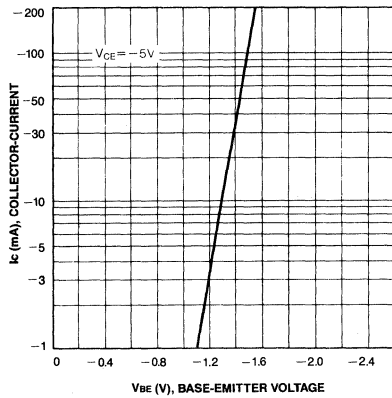
SAFE OPERATING AREA



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



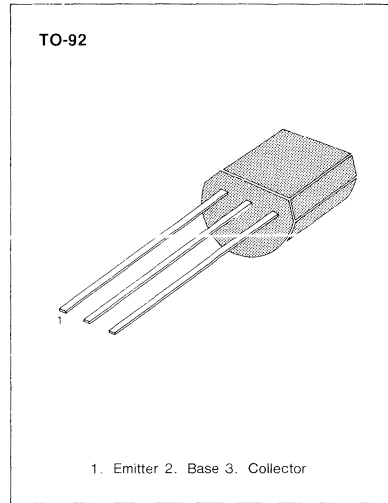
BASE-EMITTER ON VOLTAGE



HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : MPSA92	V_{CBO}	-300	V
: MPSA93		-200	V
Collector-Emitter Voltage: MPSA92	V_{CEO}	-300	V
: MPSA93		-200	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	625	mW
Derate above 25°C		5	mW/ $^\circ\text{C}$
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_C	1.5	W
Derate above 25°C		12	mW/ $^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

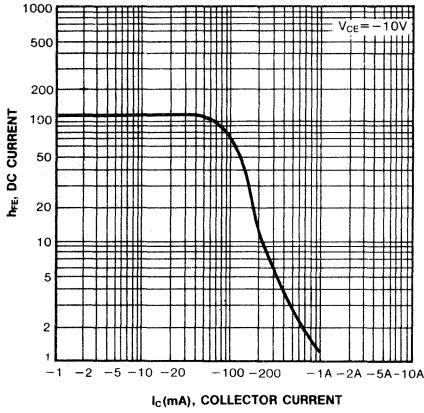


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

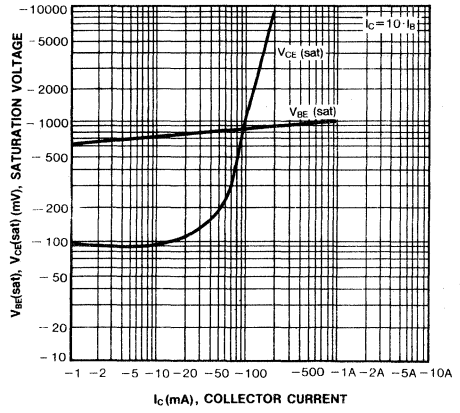
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage : MPSA92	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-300		V
: MPSA93			-200		V
*Collector Emitter Breakdown Voltage : MPSA92	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-300		V
: MPSA93			-200		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current : MPSA92	I_{CBO}	$V_{CB} = -200\text{V}, I_E = 0$		-0.25	μA
: MPSA93		$V_{CB} = -160\text{V}, I_E = 0$		-0.25	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$		-0.10	μA
*DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -1\text{mA}$	25		
		$V_{CE} = -10\text{V}, I_C = -10\text{mA}$	40		
		$V_{CE} = -10\text{V}, I_C = -30\text{mA}$	25		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.50	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.90	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -20\text{V}, I_C = -10\text{mA}$ $f = 100\text{MHz}$	50		MHz
Collector Base Capacitance : MPSA92	C_{cb}	$V_{CB} = -20\text{V}, I_E = 0$		6	pF
: MPSA93		$f = 1\text{MHz}$		8	pF

* Pulse Test: $PW = 300\mu\text{s}$, Duty Cycle = 2%

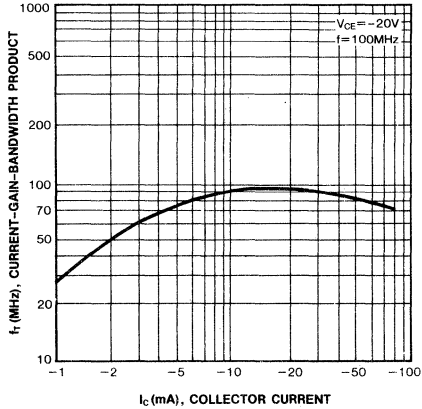
DC CURRENT GAIN



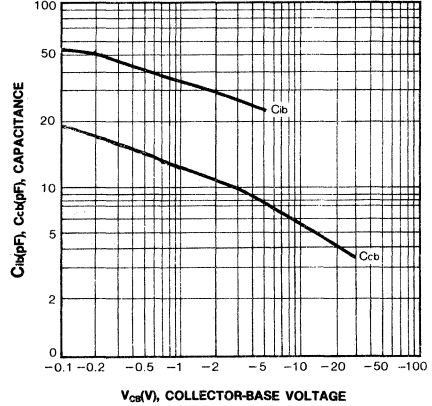
SATURATION VOLTAGES



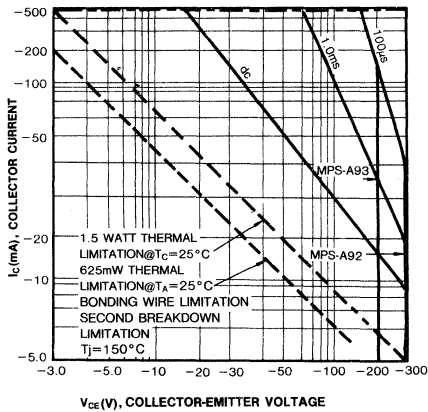
CURRENT-GAIN-BANDWIDTH PRODUCT



CAPACITANCE



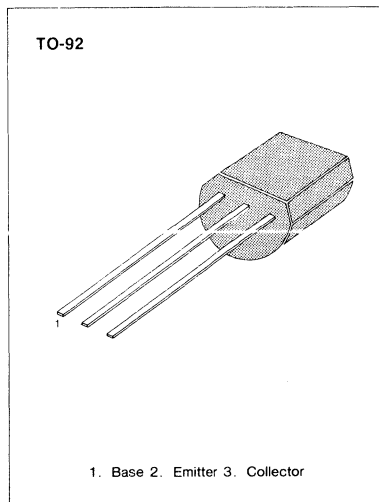
ACTIVE-REGION SAFE OPERATING AREA



VHF/UHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V_{CB0}	30	V
Collector-Emitter Voltage	V_{CE0}	25	V
Emitter-Base Voltage	V_{EB0}	3.0	V
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	350	mW
Derate above 25°C		2.8	mW/ $^\circ\text{C}$
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_C	1.0	W
Derate above 25°C		8.0	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$
Thermal Resistance, Junction to Case	$R_{th(j-c)}$	125	$^\circ\text{C/W}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$



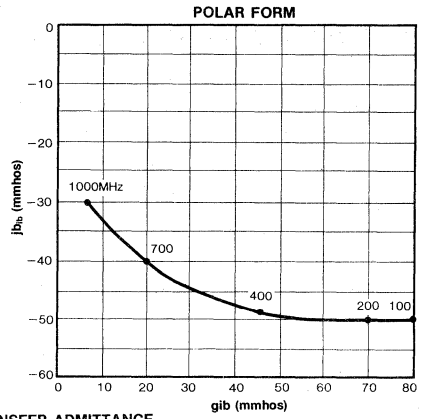
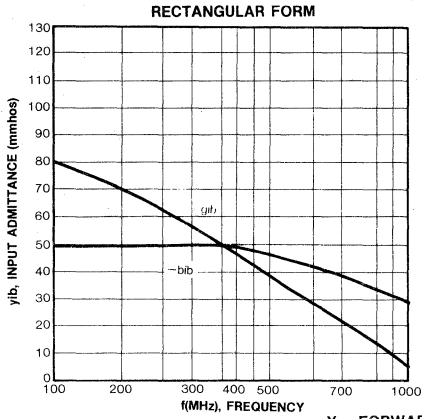
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

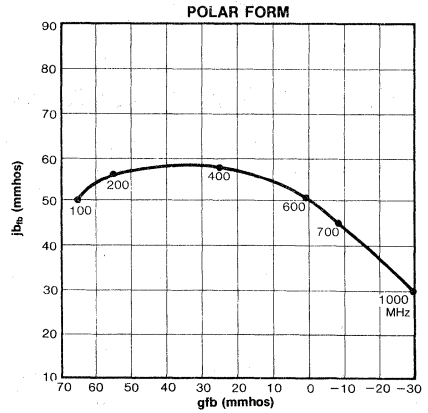
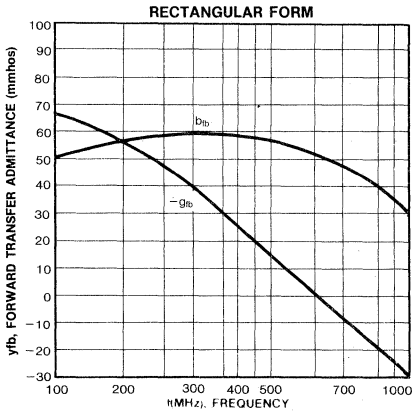
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = 100\mu\text{A}, I_E = 0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = 1\text{mA}, I_B = 0$	25		V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = 10\mu\text{A}, I_C = 0$	3.0		V
Collector Cutoff Current	I_{CB0}	$V_{CB} = 25\text{V}, I_E = 0$		100	nA
Emitter Cutoff Current	I_{EB0}	$V_{EB} = 2\text{V}, I_C = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$	60		
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 4\text{mA}, I_B = 0.4\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$		0.95	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 4\text{mA}, f = 100\text{MHz}$	650		MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.7	pF
Collector Base Feedback Capacitance	C_{rb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$			
MPSH10			0.35	0.65	pF
MPSH11			0.6	0.9	pF
Collector Base Time Constant	$C_c \cdot r_{bb'}$	$V_{CB} = 10\text{V}, I_C = 4\text{mA}, f = 31.8\text{MHz}$		9.0	ps

COMMON-BASE y PARAMETERS vs FREQUENCY
 ($V_{CB} = 10V$, $I_C = 4mA$, $T_a = 25^\circ C$)

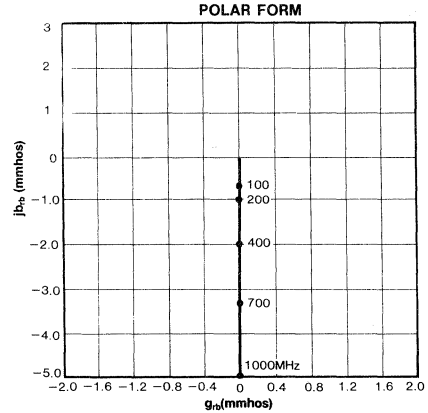
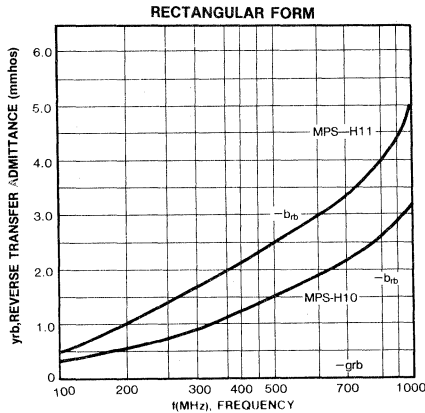
Y_{ib} , INPUT ADMITTANCE



Y_{fb} , FORWARD TRANSFER ADMITTANCE

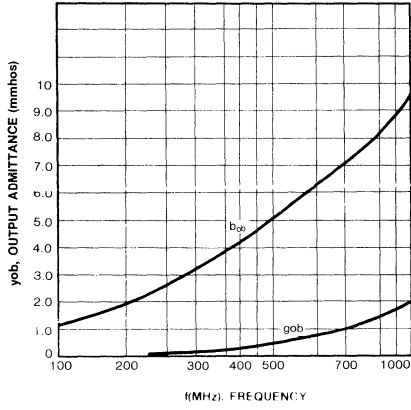


Y_{rb} , REVERSE TRANSFER ADMITTANCE

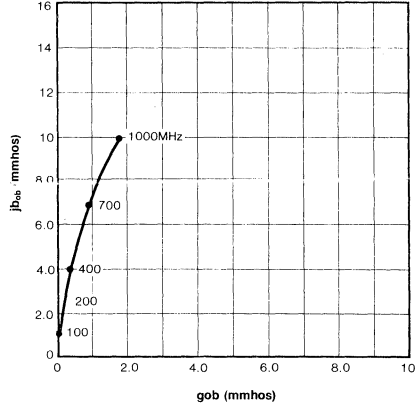


Y_{ob} , OUTPUT ADMITTANCE

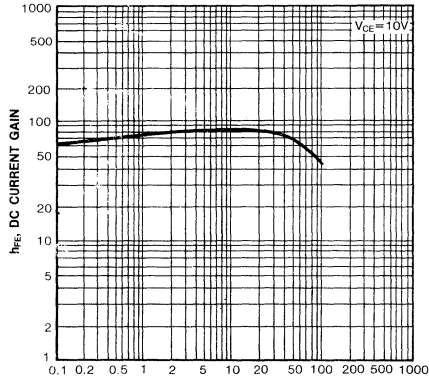
RECTANGULAR FORM



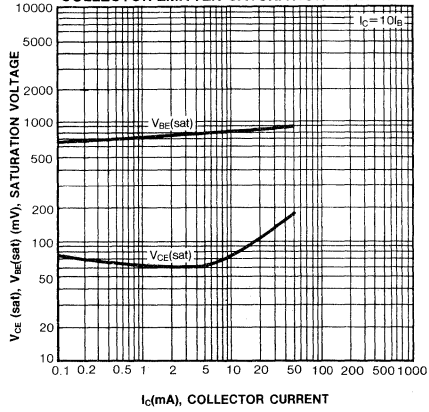
POLAR FORM



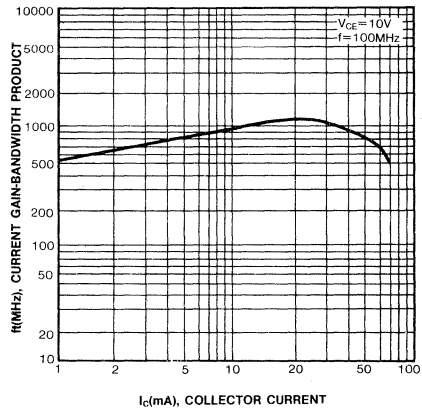
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN BANDWIDTH PRODUCT

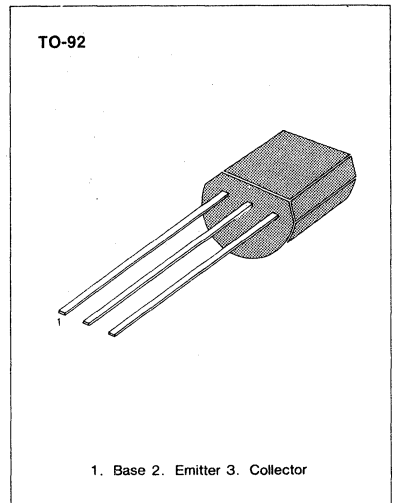


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CATV TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

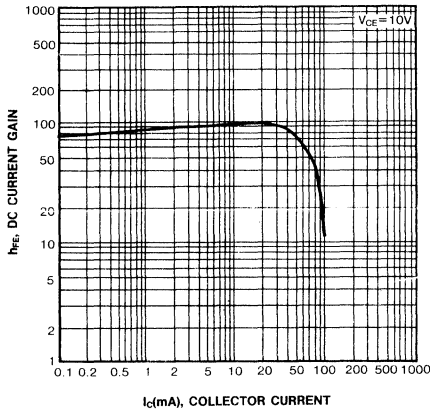
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	3.0	V
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_C	625	mW
Derate above 25°C		5.0	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	200	$^\circ\text{C/W}$



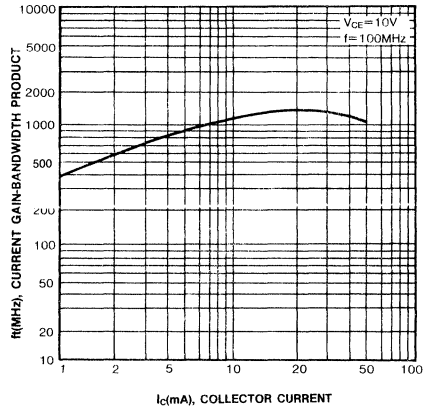
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	20			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	3.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=5\text{mA}$	25		250	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$ $f=100\text{MHz}$	800			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$	0.3		0.9	pF
Small Signal Current Gain	h_{fe}	$V_{CE}=10\text{V}, I_C=5\text{mA}$ $f=1\text{KHz}$	30			
Noise Figure	NF	$V_{CC}=12\text{V}, I_C=5\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$			6.0	dB
Amplifier Power Gain	G_{pe}	$V_{CC}=12\text{V}, I_C=5\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$		24		dB

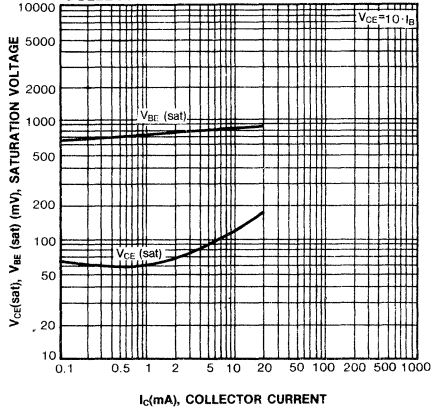
DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT



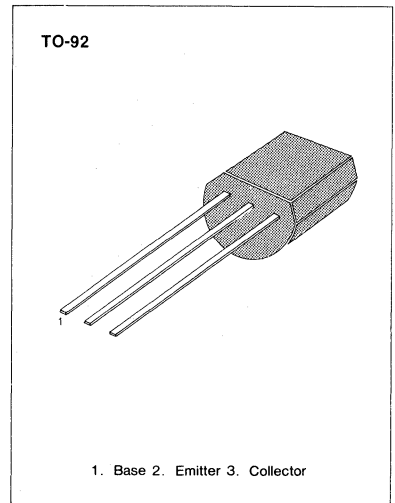
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



VHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

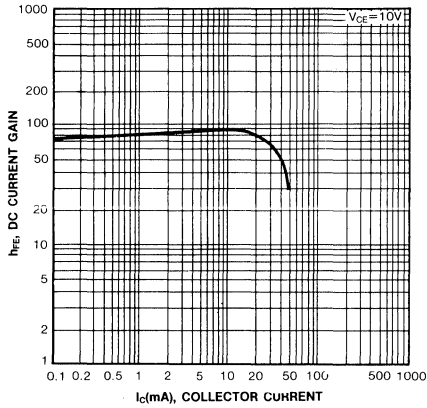
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.0	V
Collector Current	I_C	100	mA
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_C	350	mW
Derate above 25°C		2.81	mW/ $^\circ\text{C}$
Collector Dissipation ($T_c=25^\circ\text{C}$)	P_C	1.0	W
Derate above 25°C		8.0	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	$-55\sim 150$	$^\circ\text{C}$
Thermal Resistance, Junction to Case	$R_{th(j-c)}$	83.3	$^\circ\text{C/W}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$



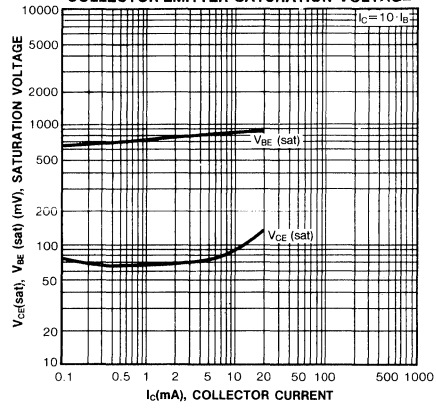
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=4\text{mA}$	25			
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=4\text{mA}$ $f=100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		0.5	0.65	pF
Collector Base Time Constant	$C_c \cdot r_{bb'}$	$V_{CB}=10\text{V}, I_E=4\text{mA}$ $f=31.8\text{MHz}$		10		ps
Conversion Gain (213 to 45 MHz)	G_{CE}	$V_{CE}=10\text{V}, I_C=4\text{mA}$ Oscillator injection=200mV	18	23		dB

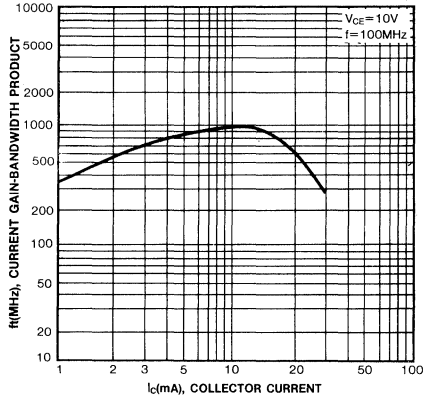
DC CURRENT GAIN



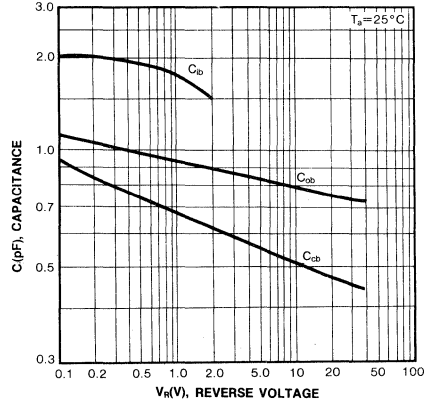
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



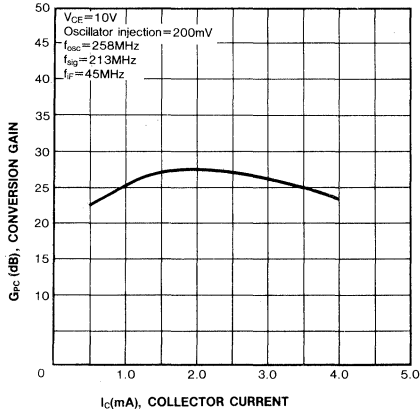
CURRENT GAIN BANDWIDTH PRODUCT



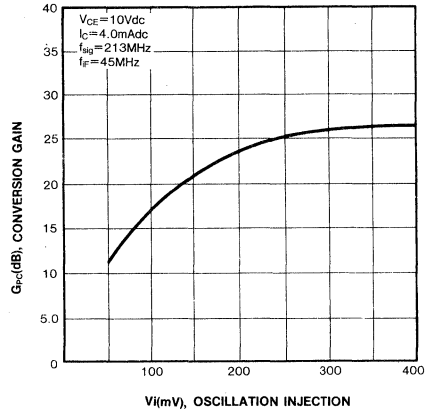
CAPACITANCES



CONVERSION GAIN CHARACTERISTICS
VARIATION WITH COLLECTOR CURRENT

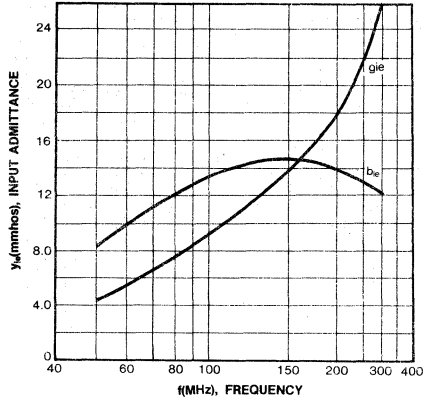


CONVERSION GAIN CHARACTERISTICS
VARIATION WITH INJECTION LEVEL

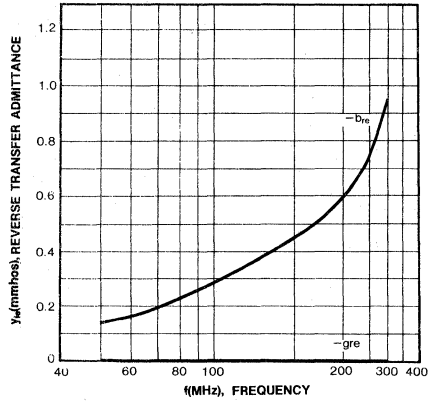


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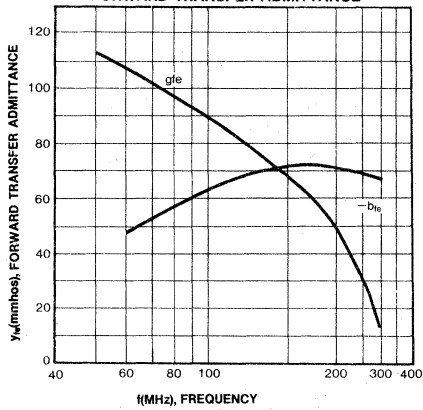
COMMON-EMITTER y PARAMETERS
 ($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
 INPUT ADMITTANCE



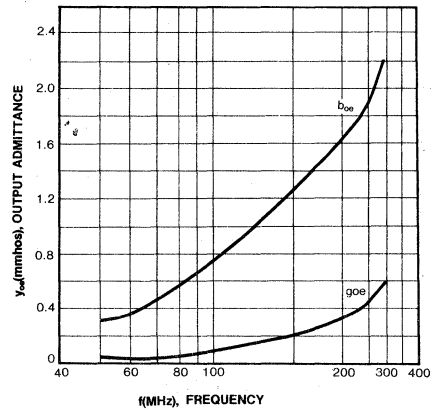
COMMON-EMITTER y PARAMETERS
 ($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
 REVERSE TRANSFER ADMITTANCE



COMMON-EMITTER y PARAMETERS
 ($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
 FORWARD TRANSFER ADMITTANCE



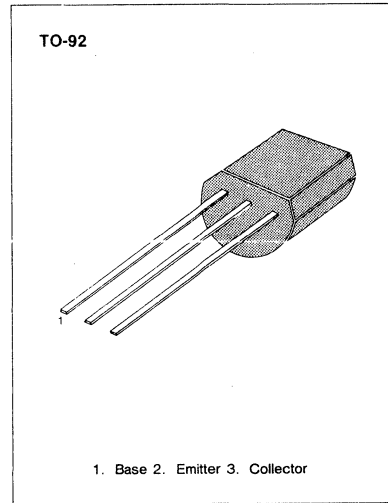
COMMON-EMITTER y PARAMETERS
 ($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)



VHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBC}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.0	V
Collector Current	I_C	100	mA
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	350	mW
Derate above 25°C		2.8	mW/ $^\circ\text{C}$
Junction Temperature	T_j	135	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 135	$^\circ\text{C}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

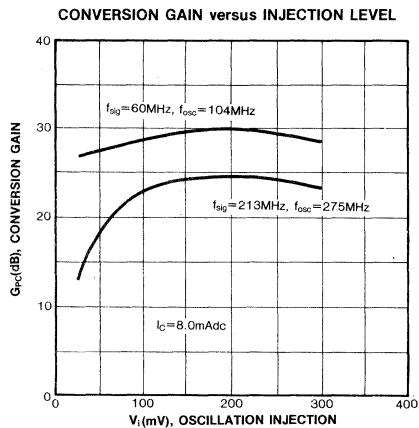
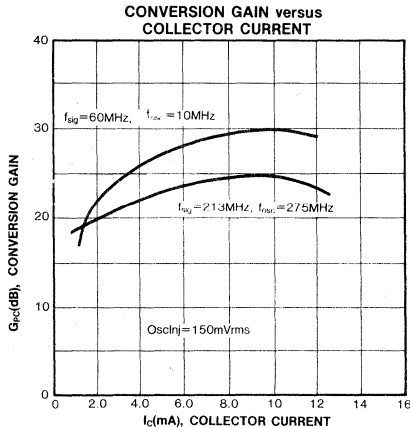


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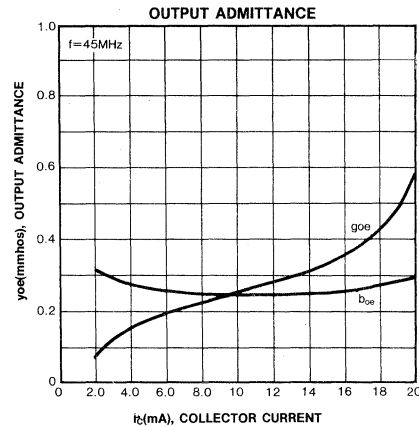
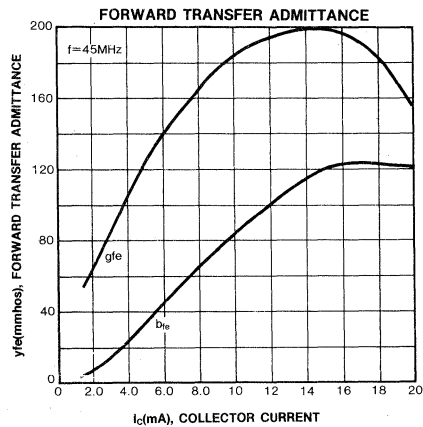
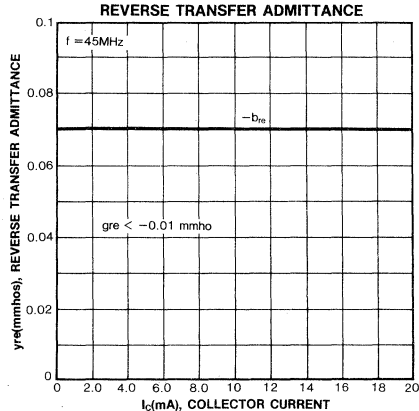
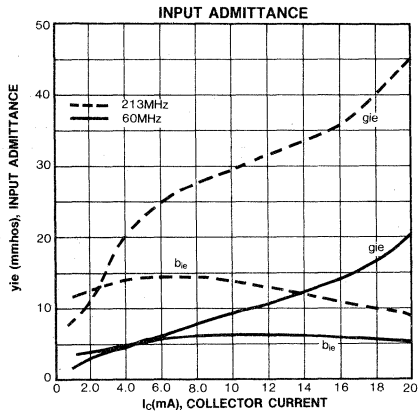
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 15\text{V}, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 8\text{mA}$	30			
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 8\text{mA}$ $f = 100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.25	0.36	pF
Conversion Gain (213 to 45 MHz)	G_{CE}	$V_{CC} = 20\text{V}, I_C = 8\text{mA}$ Oscillator injection = 150mV	19	24		dB
Conversion Gain (60 to 45 MHz)	G_{CE}	$V_{CC} = 20\text{V}, I_C = 8\text{mA}$ Oscillator injection = 150mV	24	29		dB

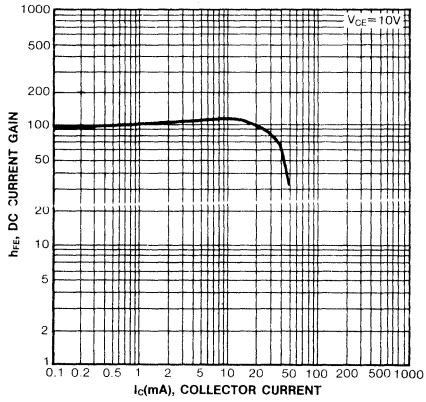
CONVERSION GAIN CHARACTERISTICS
($V_{CC} = 20V$, $R_s = R_L = 50\Omega$, $f_{in} = 44MHz$, B.W = 6MHz)



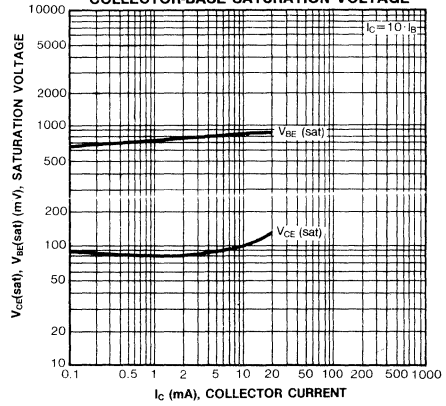
COMMON-BASE γ PARAMETERS
($V_{CE} = 15V$, $T_A = 25^\circ C$)



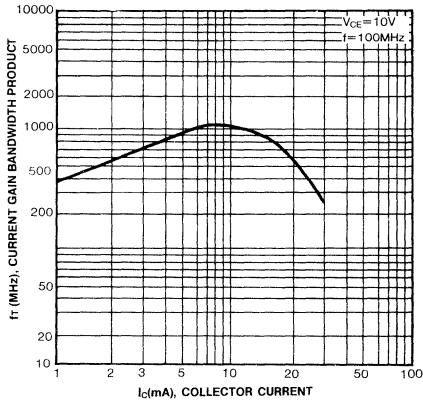
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-BASE SATURATION VOLTAGE



CURRENT GAIN BANDWIDTH PRODUCT



3

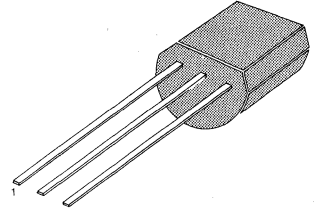
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 120V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	140	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

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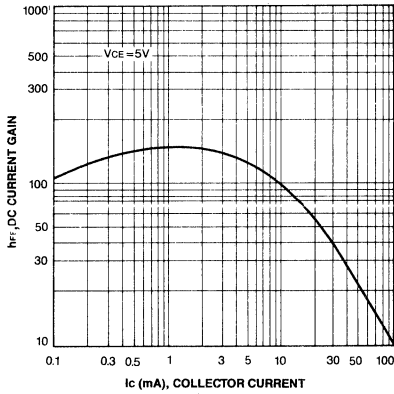
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

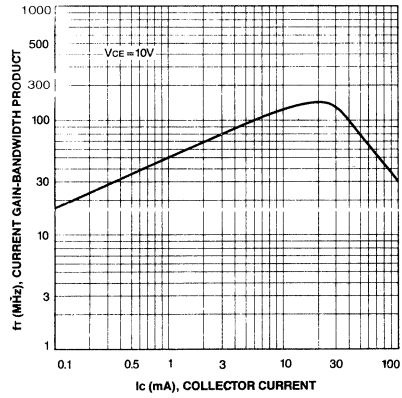
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	120			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 75V, I_E = 0$			1	μA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	50		300	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$ $I_C = 50mA, I_B = 5mA$			0.2 0.3	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$ * $I_C = 50mA, I_B = 5mA$			1.2 1.4	V
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			8	pF
*Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$ $f = 100MHz$	60			MHz

* Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%

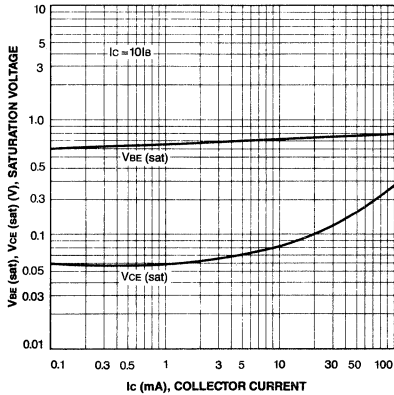
DC CURRENT GAIN



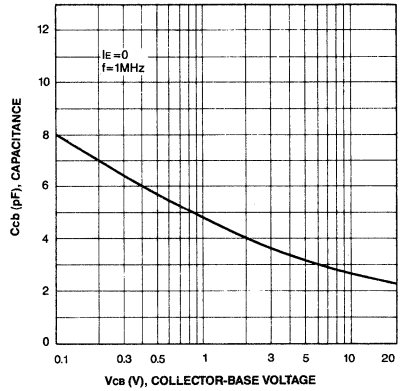
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



3

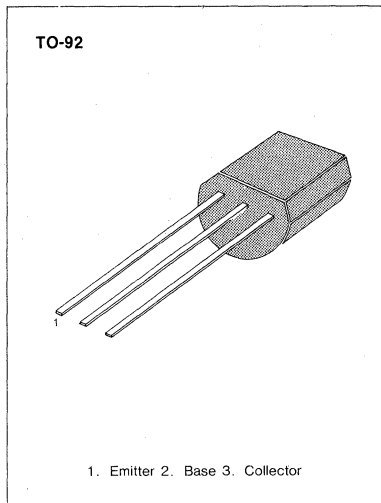
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 100V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-100	V
Collector-Emitter Voltage	V_{CEO}	-100	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N5401 for graphs



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1mA, I_B = 0$	-100			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-100			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -50V, I_E = 0$			-1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			-100	nA
* DC Current Gain	h_{FE}	$I_C = -50mA, V_{CE} = -5V$	40		250	
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$			-0.25	V
		$I_C = -50mA, I_B = -5mA$			-0.3	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -10mA, I_B = -1mA$			-1.2	V
		$I_C = -50mA, I_B = -5mA$			-1.2	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			8	pF
Current Gain Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -10V$ $f = 100MHz$	60			MHz

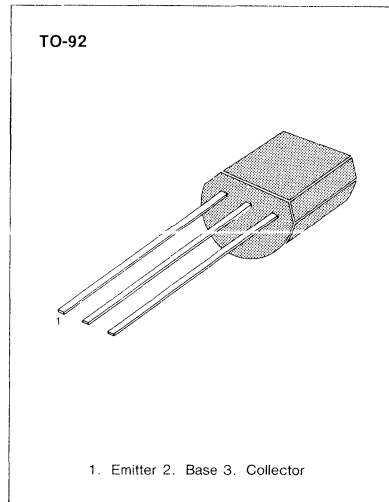
- Pulse Test: Pulse Width=300 μs , Duty Cycle=2%

**2W OUTPUT AMPLIFIER OF PORTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- Complimentary to SS8550
- Collector Current $I_C=1.5A$
- Collector Dissipation $P_C=2W$ ($T_C=25^\circ C$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	1.5	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-65~150	$^\circ C$



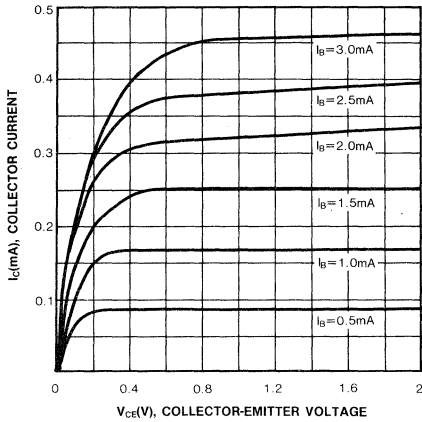
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2mA, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	6			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=35V, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6V, I_C=0$			100	nA
DC Current Gain	h_{FE1}	$V_{CE}=1V, I_C=5mA$	45	135		
	h_{FE2}	$V_{CE}=1V, I_C=100mA$	85	160	300	
	h_{FE3}	$V_{CE}=1V, I_C=800mA$	40	110		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=800mA, I_B=80mA$		0.28	0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=800mA, I_B=80mA$		0.98	1.2	V
Base-Emitter Voltage	V_{BE}	$V_{CE}=1V, I_C=10mA$		0.66	1	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$		9.0		pF
		$f=1MHz$				
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=50mA$	100	190		MHz

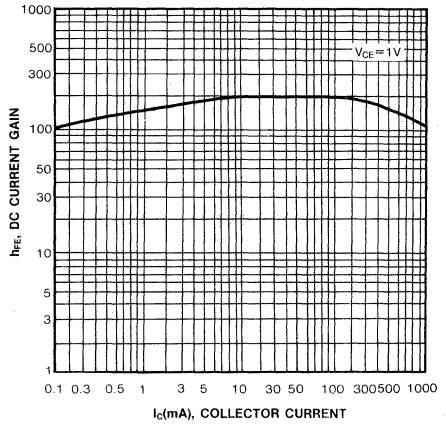
h_{FE} (2) CLASSIFICATION

Classification	B	C	D
h_{FE} (2)	85-160	120-200	160-300

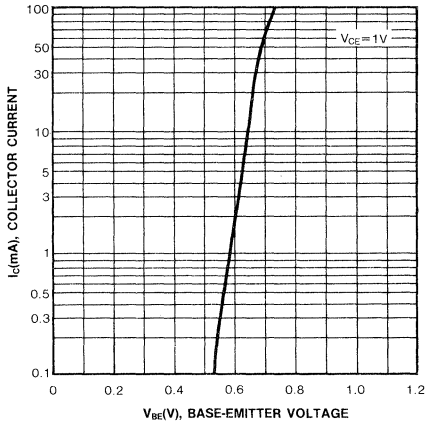
STATIC CHARACTERISTIC



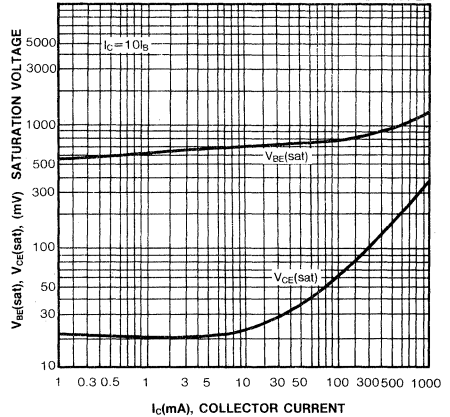
DC CURRENT GAIN



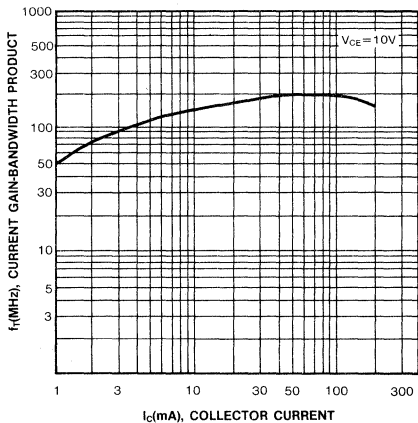
BASE-EMITTER ON VOLTAGE



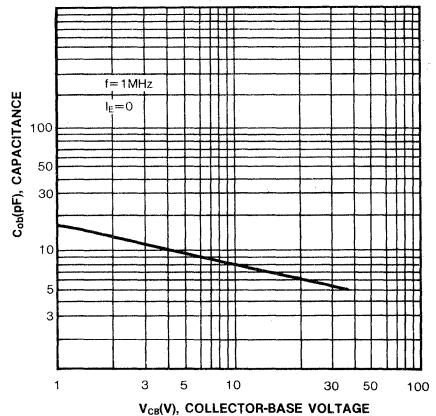
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE

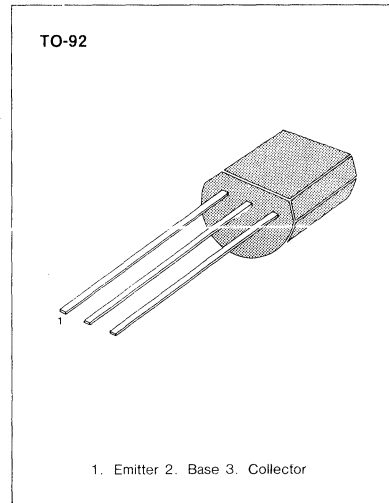


**2W OUTPUT AMPLIFIER OF PORTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- Complimentary to SS8050
- Collector Current $I_C = -1.5A$
- Collector Dissipation $P_C = 2W$ ($T_C = 25^\circ C$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-6	V
Collector Current	I_C	-1.5	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-65~150	$^\circ C$



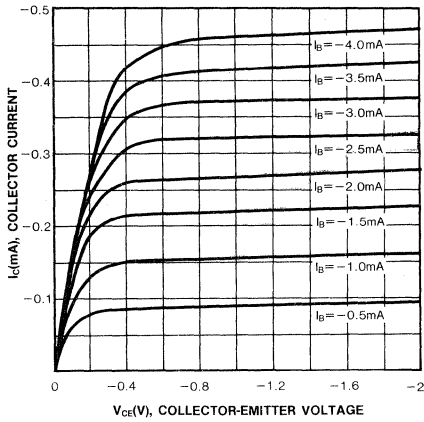
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -2mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-6			V
Collector Cutoff Current	I_{CBO}	$V_{CE} = -35V, I_E = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -6V, I_C = 0$			-100	nA
DC Current Gain	h_{FE1}	$V_{CE} = -1V, I_C = -5mA$	45	170		
	h_{FE2}	$V_{CE} = -1V, I_C = -100mA$	85	160	300	
	h_{FE3}	$V_{CE} = -1V, I_C = -800mA$	40	80		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -800mA, I_B = -80mA$		-0.28	-0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -800mA, I_B = -80mA$		-0.98	-1.2	V
Base Emitter Voltage	V_{BE}	$V_{CE} = -1V, I_C = -10mA$		-0.66	-1.0	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		15		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$	100	200		MHz

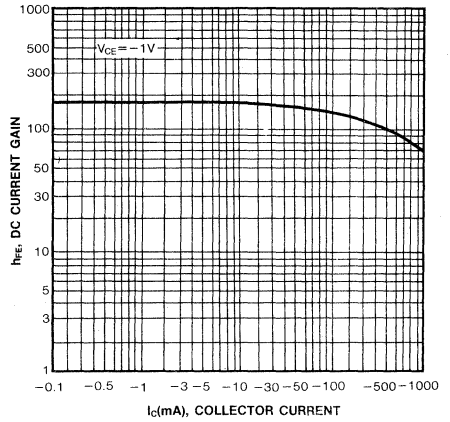
h_{FE} (2) CLASSIFICATION

Classification	B	C	D
h_{FE} (2)	85-160	120-200	160-300

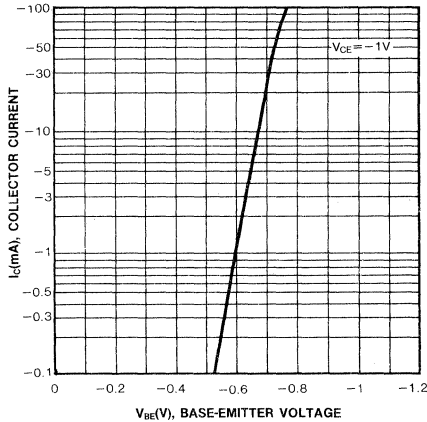
STATIC CHARACTERISTIC



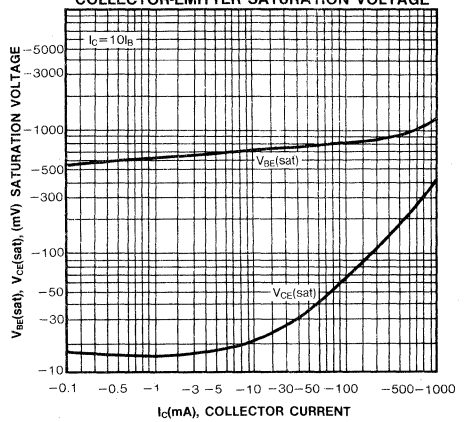
DC CURRENT GAIN



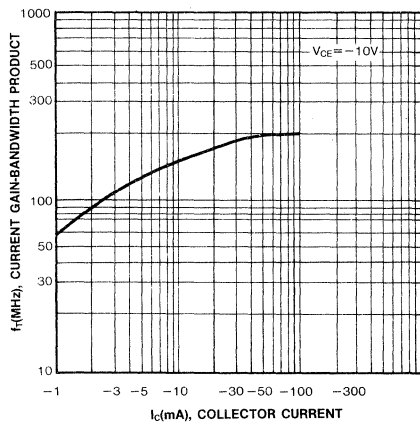
BASE-EMITTER ON VOLTAGE



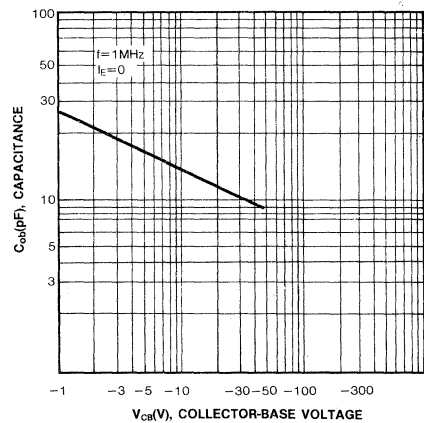
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



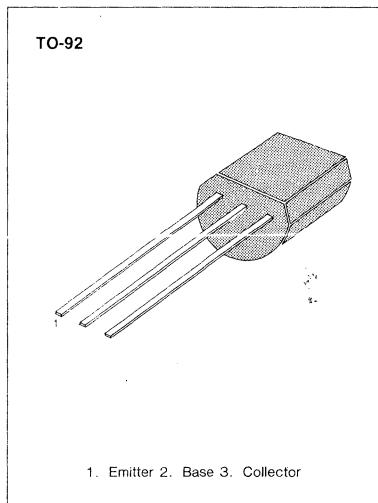
COLLECTOR OUTPUT CAPACITANCE



AM CONVERTER, AM/FM IF AMPLIFIER
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS (T_a = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	50	V
Collector-Emitter Voltage	V _{CEO}	30	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _C	30	mA
Collector Dissipation	P _C	400	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



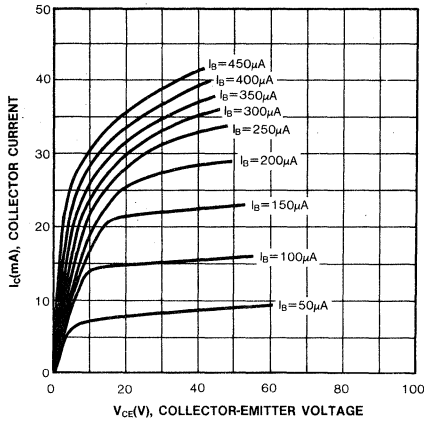
ELECTRICAL CHARACTERISTICS (T_a = 25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 100μA, I _E = 0	50			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 1mA, I _B = 0	30			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 100μA, I _C = 0	5			V
Collector Cutoff Current	I _{CBO}	V _{CB} = 50V, I _E = 0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = 5V, I _C = 0			100	nA
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 1mA	28	90	198	
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = 10mA, I _B = 1mA		0.08	0.3	V
Base-Emitter Voltage	V _{BE}	V _{CE} = 5V, I _C = 1mA	0.65	0.7	0.75	V
Output Capacitance	C _{ob}	V _{CB} = 10V, I _E = 0 f = 1MHz		1.5		pF
Current Gain-Bandwidth Product	f _T	V _{CE} = 5V, I _C = 1mA	150	370		MHz
Noise Figure	NF	V _{CE} = 5V, I _C = 1.0mA f = 1MHz, R _s = 500Ω		2.0	4.0	dB

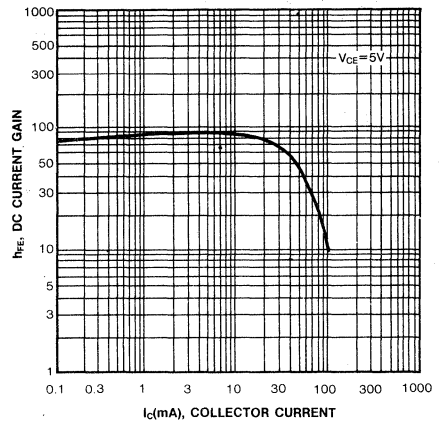
h_{FE} CLASSIFICATION

Classification	D	E	F	G	H	I
h _{FE}	28-45	39-60	54-80	72-108	97-146	132-198

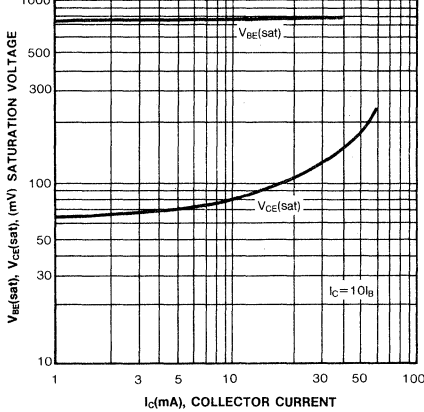
STATIC CHARACTERISTIC



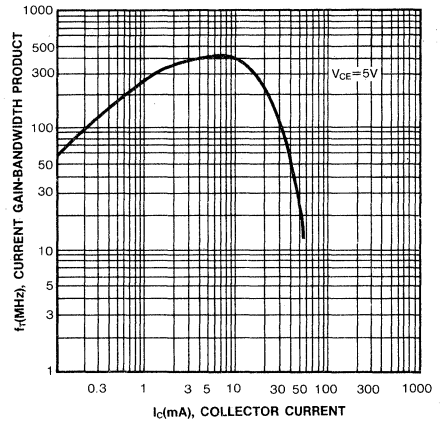
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

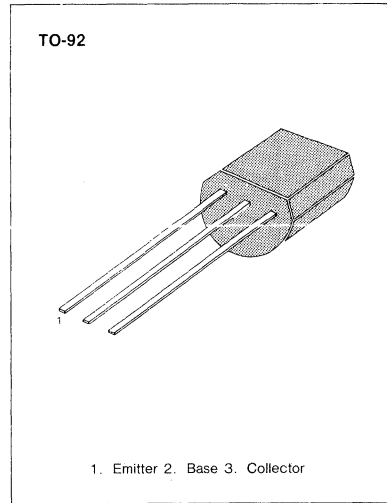


**1W OUTPUT AMPLIFIER OF POTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- High total power dissipation. (PT=625mW)
- High Collector Current. (I_C=-500mA)
- Complementary to SS9013
- Excellent h_{FE} linearity.

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-40	V
Collector-Emitter Voltage	V _{CEO}	-20	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-500	mA
Collector Dissipation	P _C	625	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



3

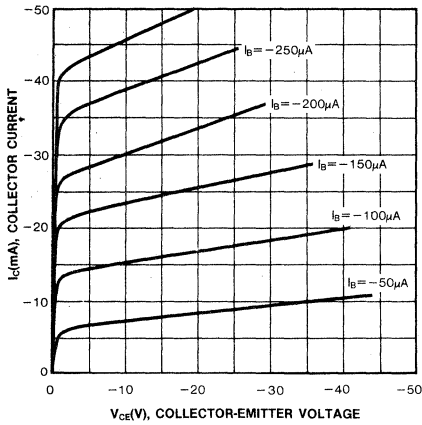
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C =-100μA, I _E =0	-40			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C =-1mA, I _B =0	-20			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =-100μA, I _C =0	-5			V
Collector Cutoff Current	I _{CBO}	V _{CB} =-25V, I _E =0			-100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =-3V, I _C =0			-100	nA
DC Current Gain	h _{FE1}	V _{CE} =-1V, I _C =-50mA	64	120	202	
	h _{FE2}	V _{CE} =-1V, I _C =-500mA	40	90		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C =-500mA, I _B =-50mA		-0.18	-0.6	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C =-500mA, I _B =-50mA		-0.95	-1.2	V
Base-Emitter On Voltage	V _{BE(on)}	V _{CE} =-1V, I _C =-10mA	-0.6	-0.67	-0.7	V

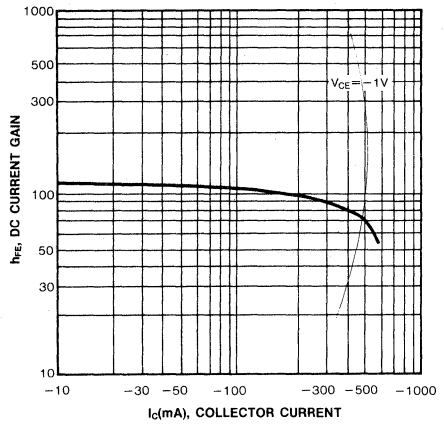
h_{FE} (1) CLASSIFICATION

Classification	D	E	F	G	H
h _{FE} (1)	64-91	78-112	96-135	112-166	144-202

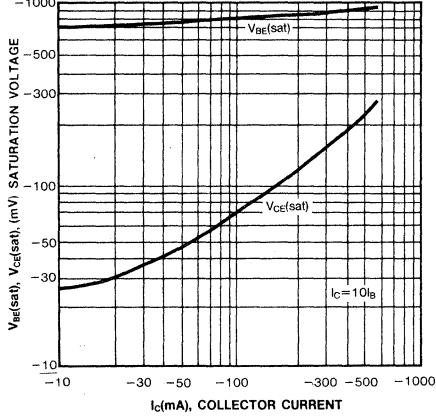
STATIC CHARACTERISTIC



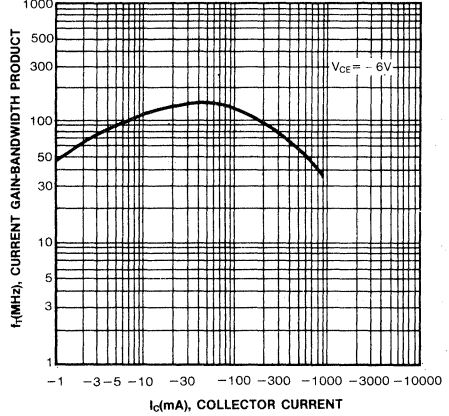
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

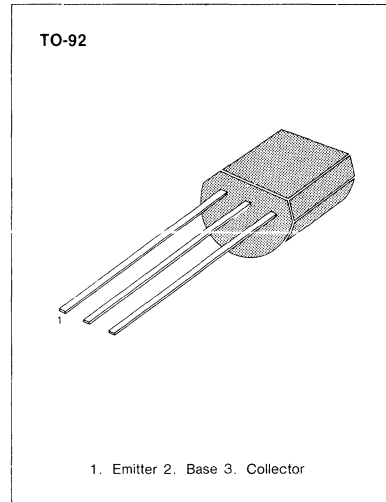


**1W OUTPUT AMPLIFIER OF POTABLE
RADIO IN CLASS
B PUSH-PULL OPERATION.**

- High total power dissipation. (PT=625mW)
- High Collector Current. (Ic=500mA)
- Complementary to SS9012
- Excellent h_{FE} linearity.

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	40	V
Collector-Emitter Voltage	V _{CEO}	20	V
Emitter-Base Voltage	V _{EBO}	5	V
Collector Current	I _c	500	mA
Collector Dissipation	P _C	625	mW
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55~150	°C



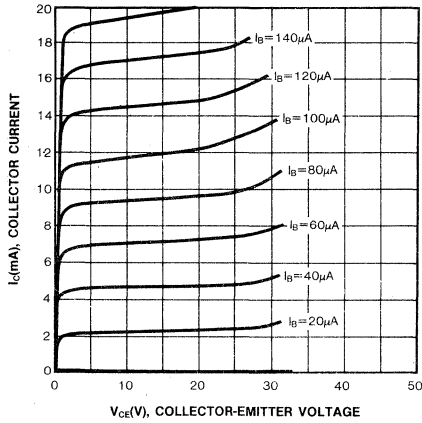
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _c =100μA, I _E =0	40			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _c =1mA, I _B =0	20			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =100μA, I _C =0	5			V
Collector Cutoff Current	I _{CBO}	V _{CB} =25V, I _E =0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =3V, I _C =0			100	nA
DC Current Gain	h _{FE1}	V _{CE} =1V, I _C =50mA	64	120	202	
	h _{FE2}	V _{CE} =1V, I _C =500mA	40	120		
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C =500mA, I _B =50mA		0.16	0.6	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C =500mA, I _B =50mA		0.91	1.2	V
Base-Emitter On Voltage	V _{BE(on)}	V _{CE} =1V, I _C =10mA	0.6	0.67	0.7	V

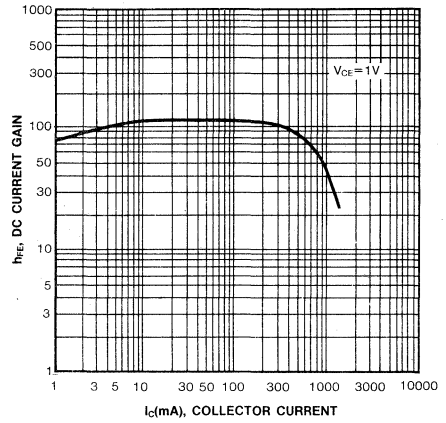
h_{FE} (1) CLASSIFICATION

Classification	D	E	F	G	H
h _{FE} (1)	64-91	78-112	96-135	112-166	144-202

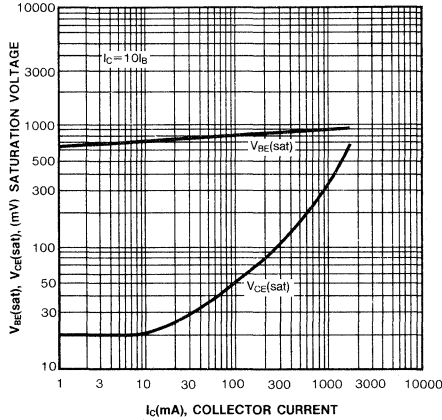
STATIC CHARACTERISTIC



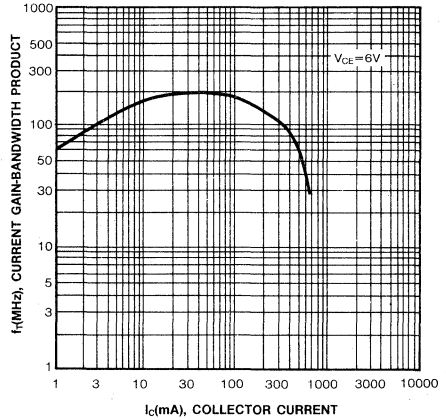
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

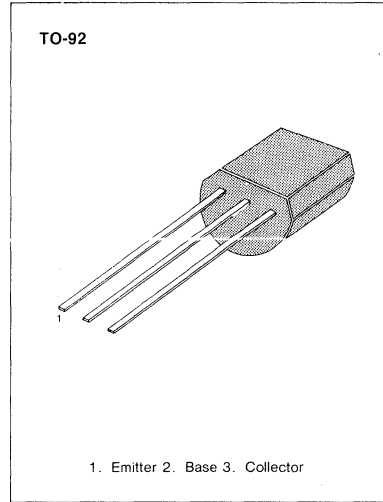


PRE-AMPLIFIER, LOW LEVEL & LOW NOISE

- High total power dissipation. (PT=450mW)
- High h_{FE} and good linearity
- Complementary to SS9015

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	450	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



3

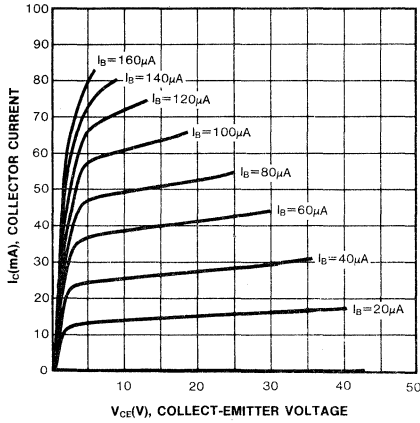
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 50\text{V}, I_E = 0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			50	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$	60	280	1000	
Collector-Base Saturation Voltage	$V_{CE(sat)}$	$I_C = 100\text{mA}, I_B = 5\text{mA}$		0.14	0.3	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 100\text{mA}, I_B = 5\text{mA}$		0.84	1.0	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 5\text{V}, I_C = 2\text{mA}$	0.58	0.63	0.7	V
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.2	3.5	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$	150	270		MHz
Noise Figure	NF	$V_{CE} = 5\text{V}, I_C = 0.2\text{mA}$ $f = 1\text{KHz}, R_s = 2\text{K}\Omega$		0.9	10	dB

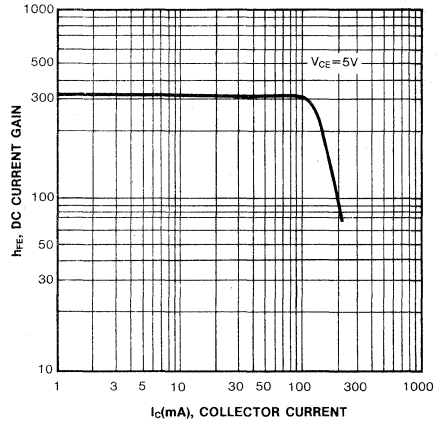
h_{FE} CLASSIFICATION

Classification	A	B	C	D
h_{FE}	60-150	100-300	200-600	400-1000

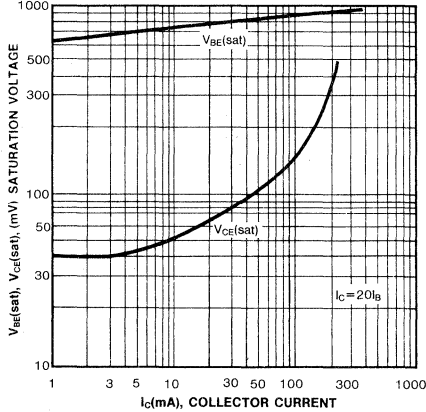
STATIC CHARACTERISTIC



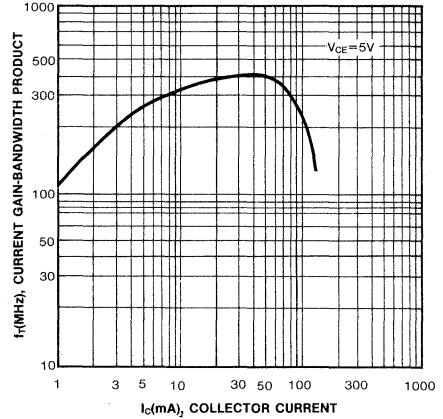
DC CURRENT GAIN



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

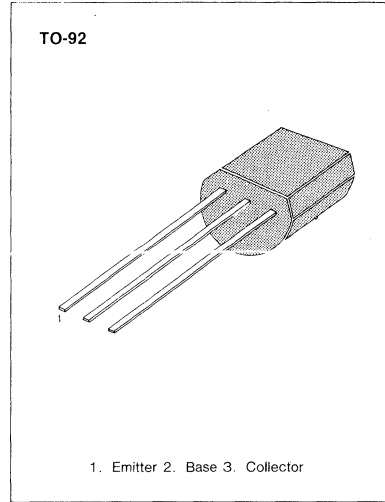


LOW FREQUENCY, LOW NOISE AMPLIFIER

• Complement to SS9014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	-50	V
Collector-Emitter Voltage	V_{CE0}	-45	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	450	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

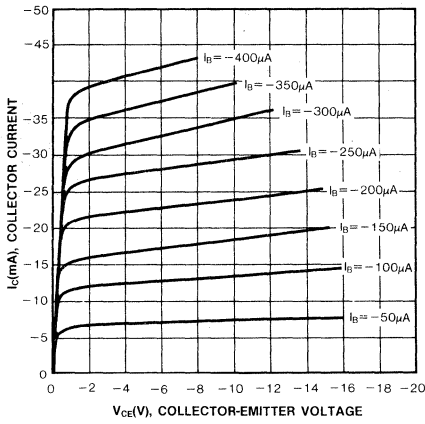
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -100\mu\text{A}, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C = -1\text{mA}, I_B = 0$	-45			V
Emitter-Base Breakdown Voltage	BV_{EB0}	$I_E = -100\mu\text{A}, I_C = 0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -50\text{V}, I_E = 0$			-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-50	nA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -1\text{mA}$	60	200	600	
Collector-Base Saturation Voltage	$V_{CE(sat)}$	$I_C = -100\text{mA}, I_B = -5\text{mA}$		-0.2	-0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -100\text{mA}, I_B = -5\text{mA}$		-0.82	-1.0	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -5\text{V}, I_C = -2\text{mA}$	-0.6	-0.65	-0.75	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$		4.5	7.0	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	100	190		MHz
Noise Figure	NF	$V_{CE} = -5\text{V}, I_C = -0.2\text{mA}$ $f = 1\text{KHz}, R_s = 1\text{K}\Omega$		0.7	10	dB

h_{FE} CLASSIFICATION

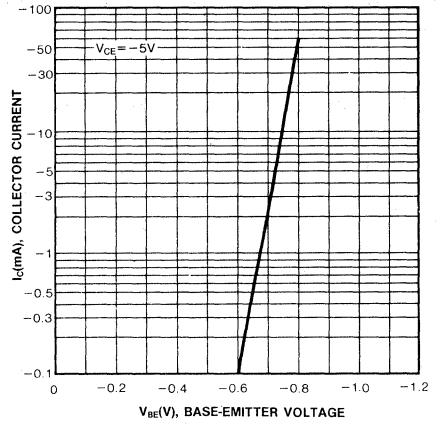
Classification	A	B	C
h_{FE}	60-150	100-300	200-600

3

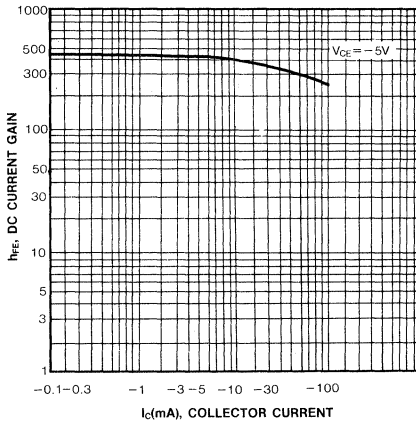
STATIC CHARACTERISTIC



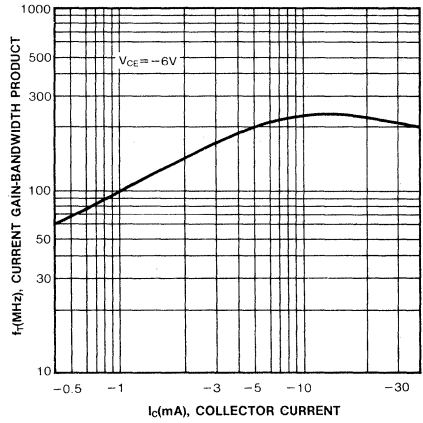
BASE-EMITTER ON VOLTAGE



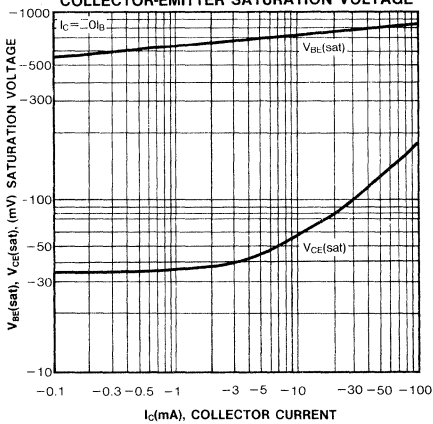
DC CURRENT GAIN



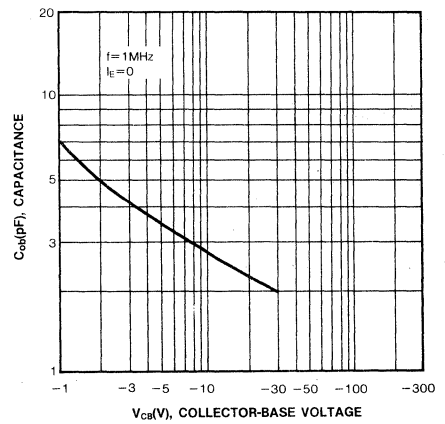
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

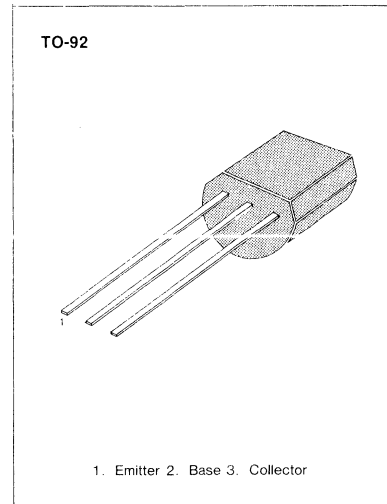


AM CONVERTER, FM/RF AMPLIFIER OF LOW NOISE.

- High total power dissipation. (PT=400mW)

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	20	V
Emitter-Base Voltage	V _{EBO}	4	V
Collector Current	I _C	25	mA
Collector Dissipation	P _C	400	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55~150	°C



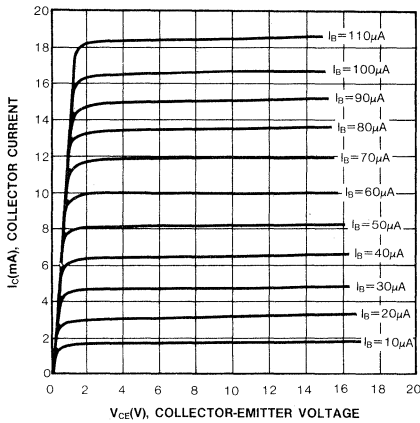
ELECTRICAL CHARACTERISTICS (T_a=25°C)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV _{CBO}	I _C =100μA, I _E =0	30			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C =1mA, I _B =0	20			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =100μA, I _C =0	4			V
Collector Cutoff Current	I _{CBO}	V _{CB} =30V, I _E =0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} =3V, I _C =0			100	nA
DC Current Gain	h _{FE}	V _{CE} =5V, I _C =1mA	28	90	198	
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C =10mA, I _B =1mA		0.1	0.3	V
Base-Emitter On Voltage	V _{BE (on)}	V _{CE} =5V, I _C =1mA		0.72		V
Output Capacitance	C _{ob}	V _{CB} =10V, I _E =0 f=1MHz		1.2	1.6	pF
Current Gain-Bandwidth Product	f _T	V _{CE} =5V, I _C =1mA	400	620		MHz
Noise Figure	NF	V _{CE} =5V, I _C =1.0mA f=100MHz, R _S =50Ω		3.0	5.0	dB

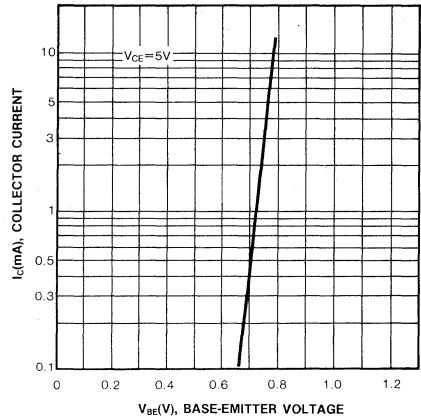
h_{FE} CLASSIFICATION

Classification	D	E	F	G	H	I
h _{FE}	28-45	39-60	54-80	72-108	97-146	132-198

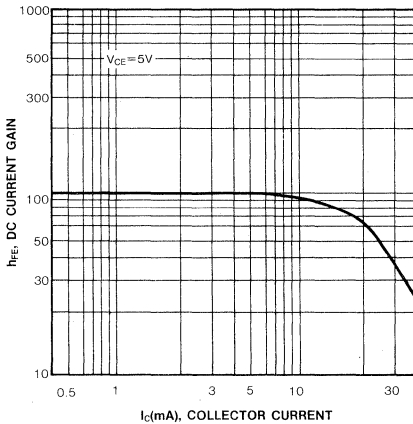
STATIC CHARACTERISTIC



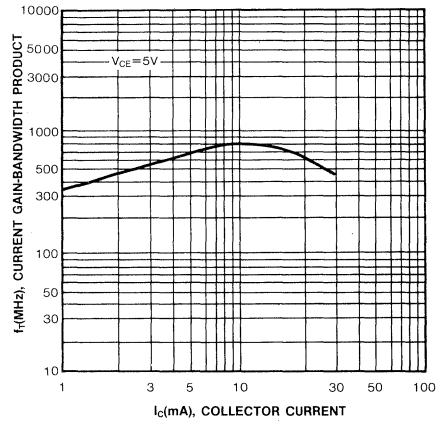
BASE-EMITTER ON VOLTAGE



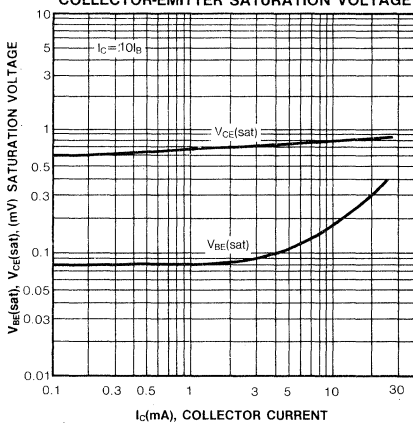
DC CURRENT GAIN



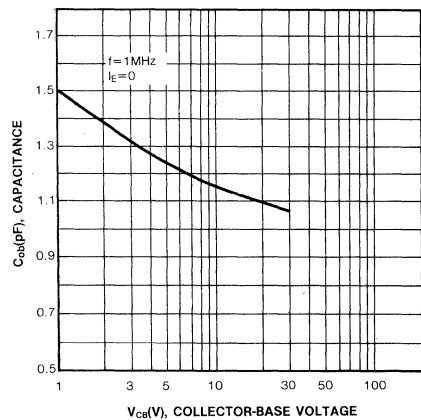
CURRENT GAIN-BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE

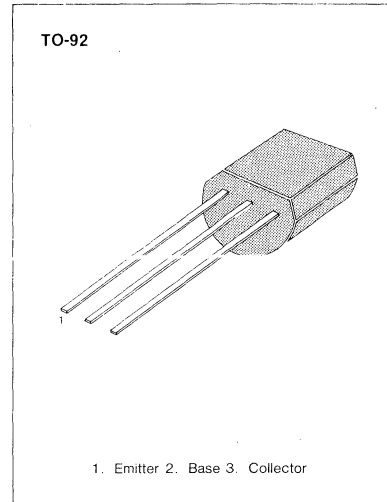


AM/FM IF AMPLIFIER, LOCAL OSCILLATOR OF FM/VHF TUNER

- High Current Gain Bandwidth Product $f_T=1,100$ MHz (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



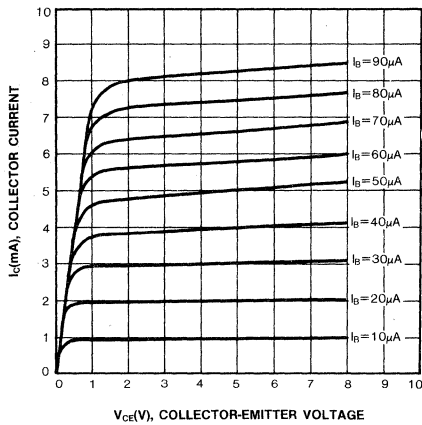
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}$, $I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}$, $I_B=0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}$, $I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=12\text{V}$, $I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=1.0\text{mA}$	28	100	198	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=1\text{mA}$			0.5	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1\text{MHz}$		1.3	1.7	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	700	1100		MHz

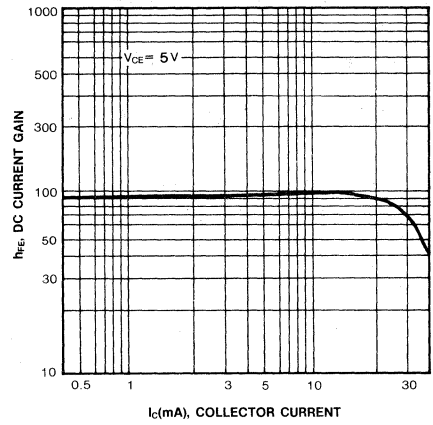
h_{FE} CLASSIFICATION

Classification	D	E	F	G	H	I
h_{FE}	28-45	39-60	54-80	72-108	97-146	132-198

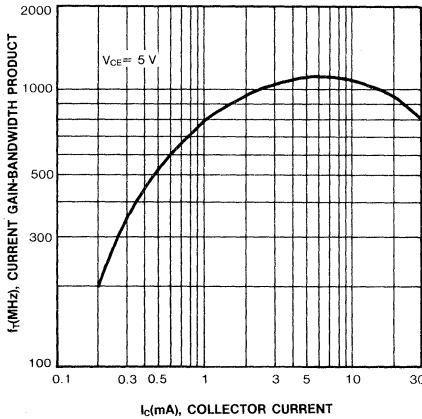
STATIC CHARACTERISTIC



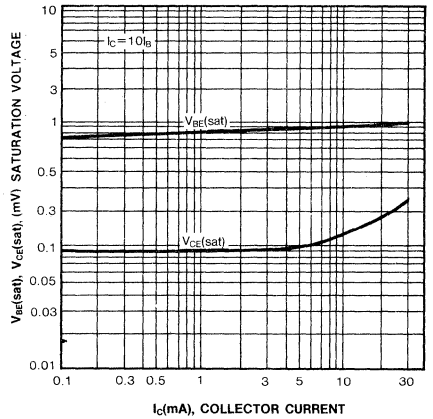
DC CURRENT GAIN



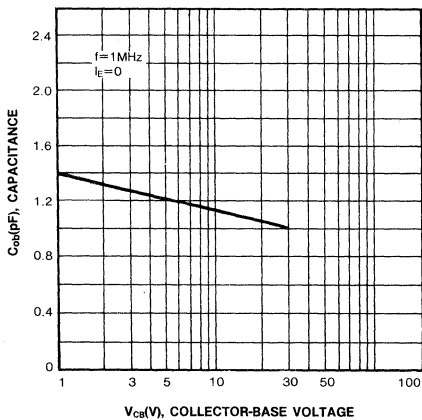
CURRENT GAIN-BANDWIDTH PRODUCT



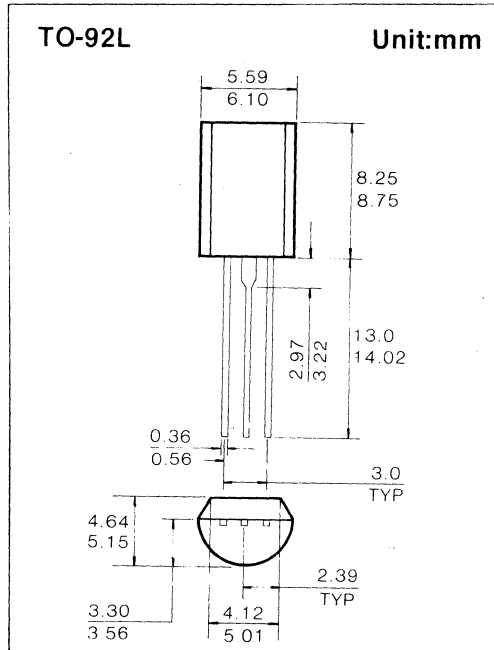
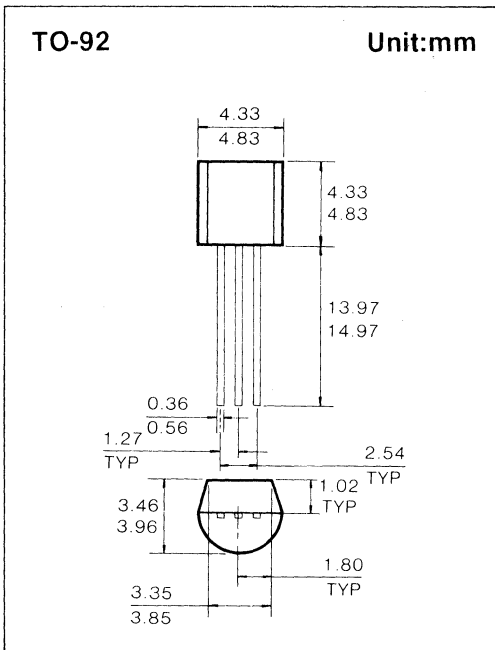
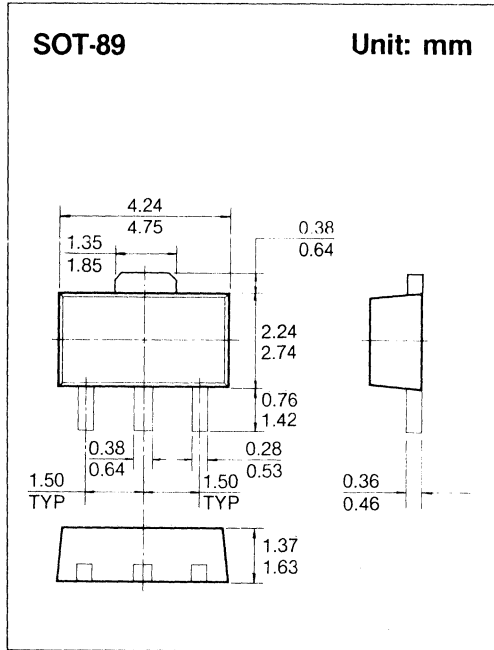
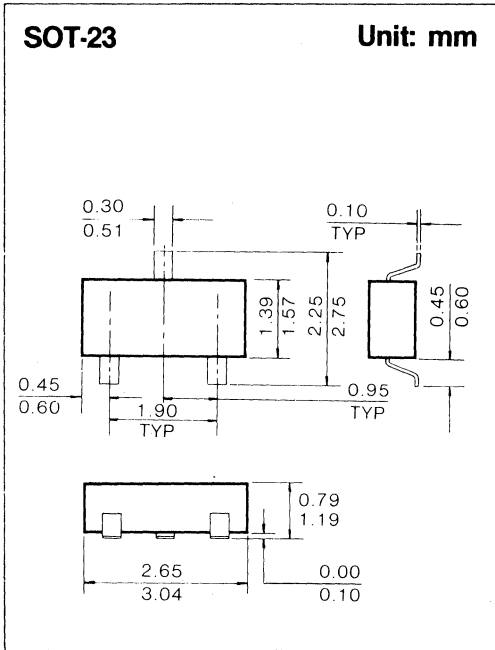
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



OUTPUT CAPACITANCE

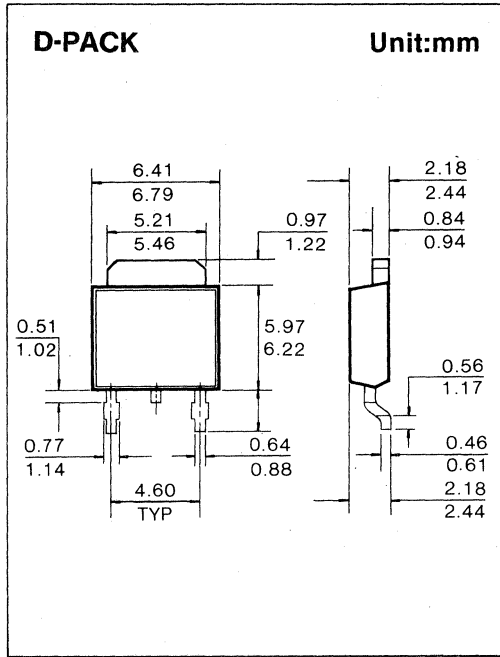


PACKAGE DIMENSIONS



4

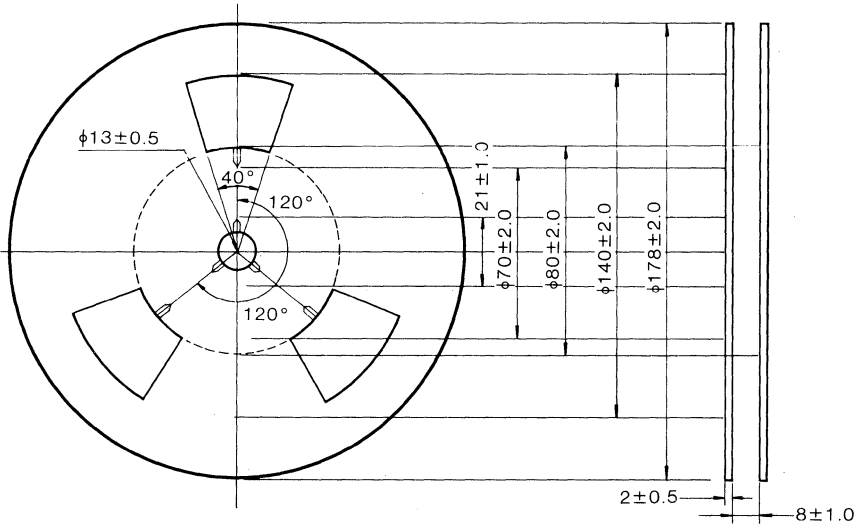
PACKAGE DIMENSIONS



PACKAGE DIMENSIONS

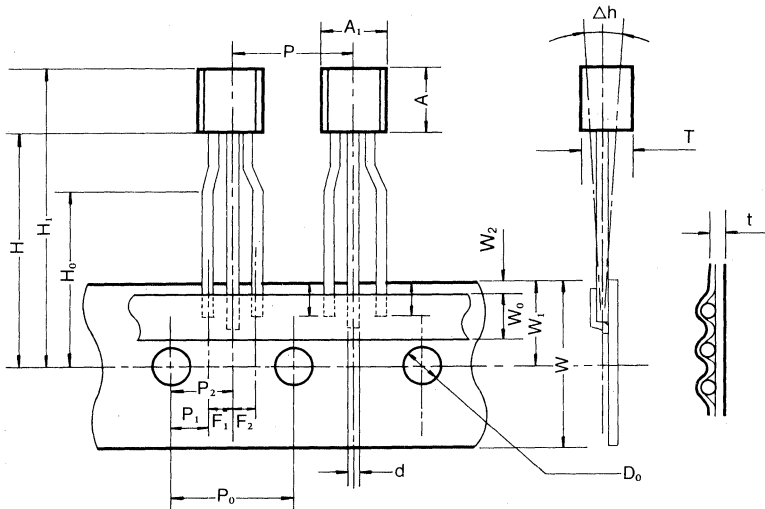
CARRIER TAPE REELS

Unit: mm



TO-92/TO-92S/TO-92L TAPING SPECIFICATION

Unit: mm

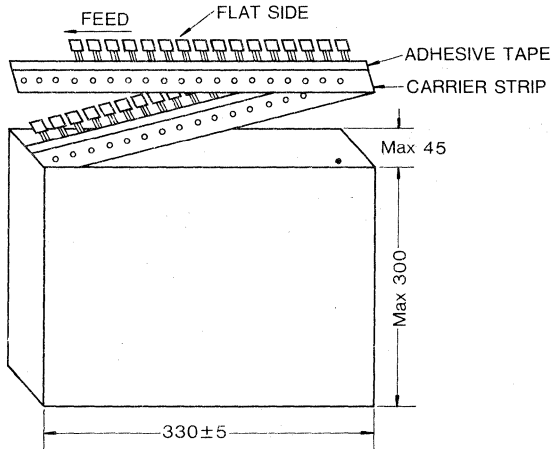


P	12.7 ± 0.5
P ₀	12.7 ± 0.2
P ₁	3.85 ± 0.5
P ₂	6.35 ± 0.5
W	18 ^{+0.05}
W ₀	6 ± 0.5
W ₁	9 ± 0.5
W ₂	Max. 1.0
H	Max. 21
H ₁	Max. 27
H ₀	16 ± 0.5
D ₀	4 ± 0.2
t	0.65 ± 0.2
Δh	C ± 1
d	0.46
T	3.56
L ₁	Min. 2.5
A ₁	4.53 ^{+0.03}
A	4.53 ^{+0.03}
F ₁	2.5 ^{+0.04}
F ₂	2.5 ^{+0.04}

PACKAGE DIMENSIONS

TO-92 AMMO PACK

Unit: mm

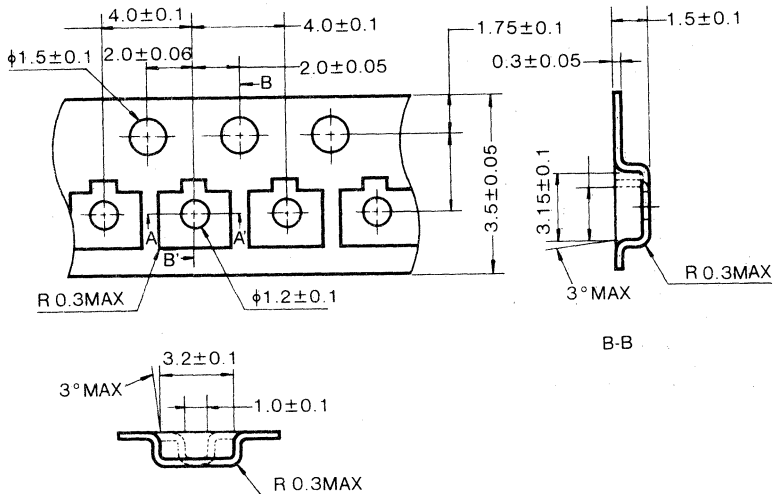


FLAT SIDE OF TRANSISTOR and ADHESIVE TAPE VISIBLE

SAMSUNG's AMMO PACK is equivalent to styles A,B,C,D of reel pack depending on which box-flat is opened and which end of the box the devices are fed from.
 1 AMMO PACK contains 2000 pcs Transistors.

EMBOSED CARRIER Specification for SOT-23

Unit: mm



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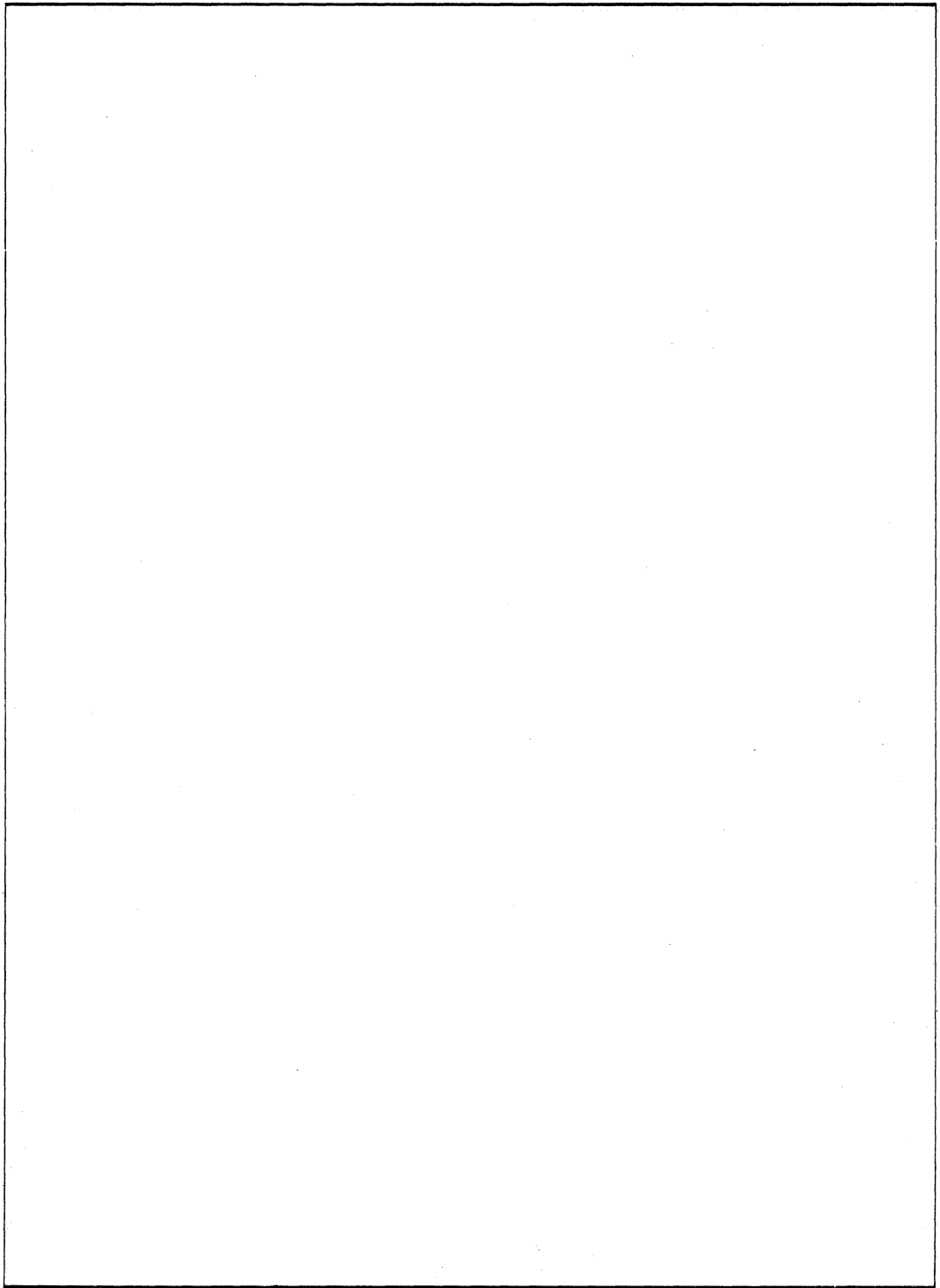
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PRINTED IN KOREA
AUGUST, 1991